

electronic measuring instruments and systems 1984





The cover shows the new

Sweep Generator SWP for 0.1 to 2500 MHz, an R&S precision instrument combining three essential measurement capabilities: SWEEP GENERATOR, SIGNAL GENERATOR with modulation capability and SYNTHESIZER. Fields of application: general laboratory measurements, automatic measurements, component measurements, directional radio links and radar, and satellite television IF. The SWP is IEC-bus compatible and programmable in all its functions. More details on page 126.

MEASURING INSTRUMENTS MEASURING SYSTEMS

from Rohde & Schwarz are the subject of this catalog. The amount of information contained for each unit of equipment or system is approximately the same as in the separately available data sheets. For instructions on how to request these and other brochures, etc. please refer to the reader-service information on page 376.

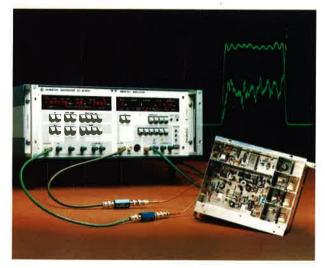
The company's offices and representatives are always ready to deal with your enquiries. The experienced staff at the head office in Munich will gladly advise you on all measurement problems.

This catalog has a relatively long period of validity, so please ask for confirmation of all data when ordering or considering a purchase.

OTHER PRODUCTS

Sound/TV broadcasting

Details of R&S measuring instruments and equipment for sound and television broadcasting are given in a separate, 280-page catalog. If you would like to receive a copy, please use on of the reader-service cards (page 376). Examples of equipment from this division (2F) are presented in Appendix A1.





This identifies newly introduced products.

(IEC 625 Bus)

This identifies equipment compatible with the IEC bus (IEEE 488, GPIB, etc.), the worldwide standardized interface for automated instrumentation. More details in section 1.

Explanations of the symbols used in the tables and text and of the ordering information are to be found on page 375.

Publisher: Rohde & Schwarz GmbH & Co. KG, dept. 5ZW Editor: G. Strohbach

Translators: E. Märkl, C. Neumann, U. Renner, G. Koranyi Printed in the Federal Republic of Germany

Radiocommunications

The R&S line of radio equipment – for shortwave, airtraffic control, radiomonitoring and radiocommunications – is described in system data sheets and specialized catalogs which will be supplied on request. For examples of equipment from these divisions (4F and 4P) see Appendix A1.



contents

1	Automated testing IEC bus · Test systems	JUU	6 to 33
2	AF and RF signal generators	G	34 to 75
3	Radiotelephone test assemblies		76 to 119
4	Sweep generators · Sweep testers Network analyzers		120 to 153
5	Standard-frequency and standard-time systems	X	154 to 171
6	Voltmeters Power meters		172 to 217
7	Test receivers · Field-strenght meters Wave analyzers · Modulation analyzers		218 to 259
8	Recorders		260 to 267
9	Acoustic test equipment Sound-level meters · Noise meters	») Ю—	268 to 283
10	Terminations Attenuators	「」	284 to 295
11	Logic test equipment		296 to 319
12	Power supplies	~_=	320 to 333
Appendix			
A1	Related equipment from broadcasting, radiocommunications and radiomonitoring of	divisions	334 to 363
A2	Cabinets · Addresses · Type index		364 to 376

1

Electronic precision

has been the Rohde & Schwarz hallmark during 50 years of developing and manufacturing electronic measuring and communications equipment. R&S is an independent concern, established as a physical and technical development laboratory in Munich in 1933 by the two physicists **Dr. Lothar Rohde** and **Dr. Hermann Schwarz.** Both are still active in the management of the company, and were joined in 1971 by **Friedrich Schwarz, Dipl.-Ing.**, representing the second generation of owners.

The company employs 4000 people worldwide and its sales network covers a total of 80 countries. R&S has manufacturing plants in Munich, Memmingen and Teisnach and two subsidiary operations Messgeraetebau GmbH and Rohde & Schwarz Vertriebs-GmbH. The company group has an annual turnover of DM 500 million with exports making up 50% of the total.

Rohde & Schwarz operates with four product- and thus userdefined divisions:

- measuring equipment and systems
- sound/television broadcasting
- radiomonitoring, radiolocation
- radiocommunications

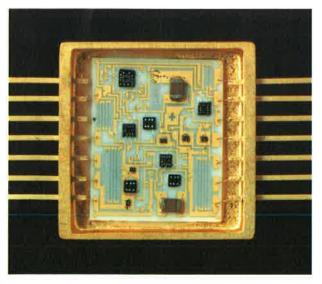
Each of these financially autonomous divisions is responsible for its own product planning, development, construction and sales and is thus able to respond quickly to what is happening on the market.

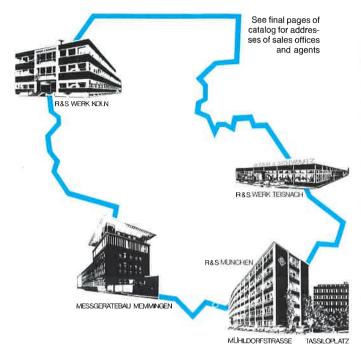
Assured quality

Advanced equipment design calls for modern circuit technology. R&S develops and manufactures microcircuits inhouse, using the latest computer aids to generate films for printed circuit boards to be assembled automatically.

In all stages of the creation of an R&S product there is close cooperation with quality assurance, which reports directly to the company management and is responsible for quality planning, reliability, environmental testing, component test-

30 of these thin-film, high-speed pulse amplifiers from the R&S microelectronics department will fly in the NASA space probe Galileo to the planet Jupiter 600 million kilometers from the earth





Rohde & Schwarz development and production facilities and the R&S Cologne service centre

ing, incoming inspection and, at production level, for preproduction control, finish control, assembly control, final acceptance and manufacturing equipment studies. If requested, certificates are issued to document the compliance of equipment with its published technical data.

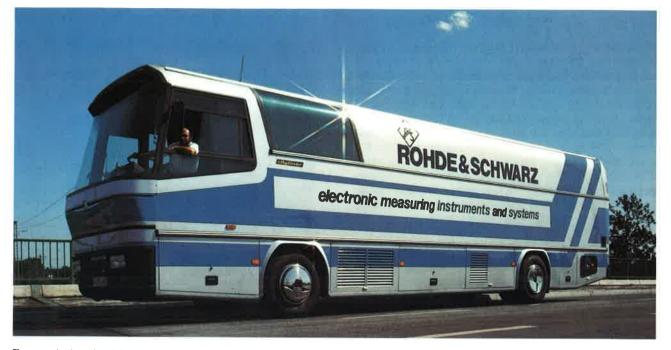
All phases from incoming inspection through production control and burn-in to servicing are watched over by a computerbased fault-acquisition system. The R&S quality-assurance system is approved by government authorities and civil organizations and complies with the NATO requirements to AQAP-1.

Reliable service

Well-equipped facilities in Munich, Cologne and at domestic and foreign agencies provide the after-sales service for R&S products: preventive maintenance to keep equipment working properly and scrupulous repair if anything should go wrong. Our extensive, central spares depot with high availability and fast turn-around plus decentralized stocks, optimized on the basis of equipment statistics, help our personnel to repair fast and with minimal delay.

The detailed servicing instructions in our equipment manuals or in the handbooks that our documentation department produces at customer request in line with national and international standards provide the basis for successful equipment maintenance and repair by the user.

The Rohde & Schwarz Cologne works, being the largest industrial service centre in West Germany for electronic measuring and communications equipment with a qualified staff of more than 300 and a useful area of 12,000 m², offers a wide range of services:



The conveniently equipped demonstration bus for Europe of the measuring equipment and systems division is 12 m long and subdivided into a show room of 17 m² and a small conference room accommodating six persons

- maintenance and repair of electronic equipment and systems
- calibration and inspection on behalf of the Federal German Calibration Service (DKD)
- training in Germany and abroad
- equipment manuals and illustrated parts catalogs to TDV, GAF T.O., PANAVIA and customer specifications in German and English
- development, design and production of stationary and mobile electronic workshops and calibration laboratories
- system servicing of radio, radar and sonar

Training is given priority both in the R&S training centre Cologne and in the Munich divisions: presentation of new equipment, fundamental technical training, service courses, system briefing



Continuous flow of information

55,000 copies of the magazine News from Rohde & Schwarz are published quarterly in English, French and German and distributed free of charge to qualified readers. Besides interesting articles on new products, the magazine contains applications reports, test hints and refresher courses.

For every item of equipment produced by Rohde & Schwarz there is of course a data sheet available, in part with large, poster-like illustrations. Certain test assemblies, test systems and fields of measurement – and also families of communications equipment – are additionally dealt with in special **brochures** (infos), containing extra information and examples of applications.

Both R&S Munich and the R&S service centre in Cologne hold regular <u>seminars</u>, <u>training sessions and courses</u>. These keep people informed about what is new in the company's equipment range, impart the principles of maintenance and repair and provide instruction in the use of systems or even basic technical training.

Rohde & Schwarz shows its products annually at some 40 to 50 trade fairs and exhibitions all over the world. These are opportunities for demonstrating the latest developments and advising users, and also provide a forum for exchanging ideas and directly comparing one's products with those of the competition. The company's own specially equipped vans carry selections of both new and older products for demonstration on the customer's door-step.

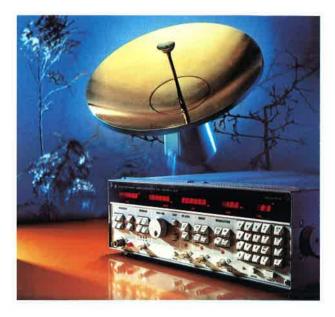
A continuous flow of information between R&S central sales and field sales produces highly accurate forecasts for the development of products that are exactly right for the market, true to the company's motto of quality rather than quantity.

Measuring equipment and systems

The world-wide reputation of Rohde & Schwarz was established in the thirties with the development of measuring instruments. At a time when there was no such a thing as RF measurements in Europe, R&S came out with a precision heterodyne wavemeter, a capacitor sorter and a dissipationfactor meter for frequencies up to 10 MHz, as well as frequency standards and time measuring equipment. Other **pioneer efforts** were field-strength meters and the first series-produced power signal generator (1942). A considerable proportion (12% on average) of the annual turnover goes into the development of new promising products such as logic testers and highly convenient automatic test systems for components, modules and cables.

The use of microprocessors has become a routine: the first microcomputer-based, intelligent radio-set test assembly with standard IEEE 488/IEC 625 bus interface was already introduced in 1974. Since then the development of new, system-compatible measuring instruments which can be combined in computer-controlled test assemblies for the widest range of applications has been continued. A process controller specially developed by R&S for measurements optimizes the product line.

The major product categories of this division are: signal generators for AF through to microwaves, sweep testers and network analyzers, radio-set test assemblies, test receivers for interference and field-strength measurements, wave and modulation analyzers, logic testers, standard-frequency systems, voltmeters and power meters, and IEC-bus-compatible



Sweeper, signal generator and synthesizer all in one unit: Sweep Generator SWP for 100 kHz to 2.5 GHz

system components. The measuring equipment division has great experience in the field of hybrid test systems for automatic testing of all kinds of electronic modules. In-house services include suitable adapters and software programs as well as system engineering, training and maintenance.

Sound/television broadcasting

The sound/television broadcasting division serves a very specialized kind of customer who looks for technically advanced and at the same time economic solutions to his needs. Here Rohde & Schwarz is able to offer broadcasting technology and the related measurement engineering from a single source: from solid-state, "plug-in-and-go"



VHF FM sound broadcasting transmitter system for three VHF programs, 10 kW power each, plus 1 kW standby

VHF transmitters through to turn-key, 20-kW TV transmitting systems (band IV/V) with standby transmitter, measuring

equipment and antenna – if required, with customized horizontal and vertical patterns for optimal coverage of any shape of service area. Also available are transposers, relay receivers, combiners and the entire measuring and monitoring equipment needed for maintaining AF, VF and RF quality in all transmission devices.

Rohde & Schwarz supplied Europe's first VHF soundbroadcast transmitter in 1949, and in 1980 adapted the world's first TV transmitter for dual-carrier/dual-sound operation. The highly precise and internationally successful TV demodulator AMF first appeared in 1955, the first vision-transmitter test assembly in 1956 and at the beginning of the 70s the first test-line inserters and analyzers were marketed. Today the entire TVbroadcast network of the Federal German Postal Authority is automatically monitored by computer-controlled test equipment of the type UPKF from Rohde & Schwarz. VHF-UHF omnidirectional antennas with phase-rotation feeding were brought out in 1956, and the multiplex-polarizing VHF FM broadcast antennas introduced in 1975 have made a large contribution to improving car-radio reception.

Radiomonitoring, radiolocation

As early as 1941 Rohde & Schwarz built the radar detection receiver Samos for AM and, for the first time, FM with an almost unheard-of frequency range extending to 1.6 GHz. Today the radiomonitoring and radiolocation division produces automatic receivers that can check a thousand frequency channels for occupancy in the space of one second, short microcomputer-controlled vehicle antennas, logarithmic-periodic short-wave antennas that can transmit up to 1000 kW rms power and remotely controlled triangulation DF networks with large-scale displays.

Radiomonitoring and radiolocation work concerns the four areas receivers, direction finders, antennas and software plus systems engineering from the design concept through to turn-key projects. The applications here are those of PTT radiomonitoring, military communications intelligence and security services, as well as traffic control and – in as much as antennas are concerned – radiocommunications and radiomonitoring from 10 kHz up to 40 GHz.

A DF network from Rohde & Schwarz for military airtraffic control covers the whole of West Germany, and Doppler direction finders from R&S are in use at all domestic and many foreign airports. Radiomonitoring systems from R&S are working in North and South America, Africa, the Near and Middle East, in most countries of Europe and, of course, are also operated by many civilian and military services in the Federal Republic of Germany.



VHF-UHF Broadband Doppler Direction Finder PA 005 for radiomonitoring systems covering 20 through 1000 MHz

Radiocommunications

Over several decades the radiocommunications division can offer an almost complete line of equipment for radiocommunication in the RF, VHF and UHF range for stationary, land-mobile, shipboard and airborne use.

R&S radio systems are installed at all West German and innumerable foreign airports. Many airborne weapon sys-

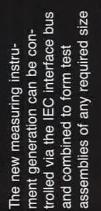


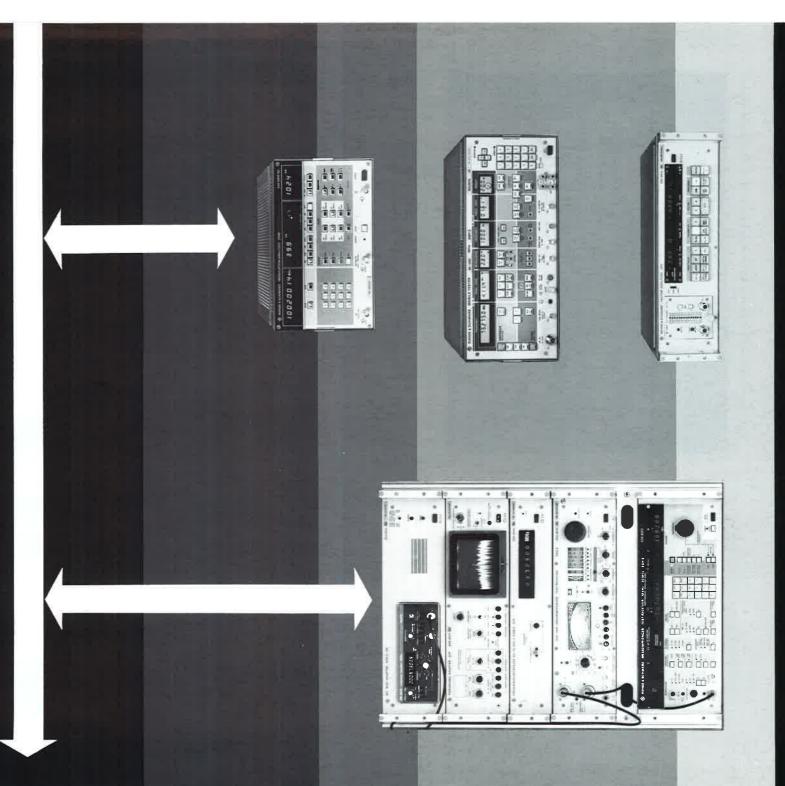
Remotely controllable VLF-HF receiving system made up of the Receivers EK070 and EK071

tems use communications equipment from Rohde & Schwarz. Today the number of computer-controlled radio systems in use is steadily increasing. Multifunction keyboards simplify the operation and relieve the personnel on board ship and in aircraft from routine work. High reliability and microprocessor-controlled test equipment for fault location ensure a high availability and low lifecycle costs.

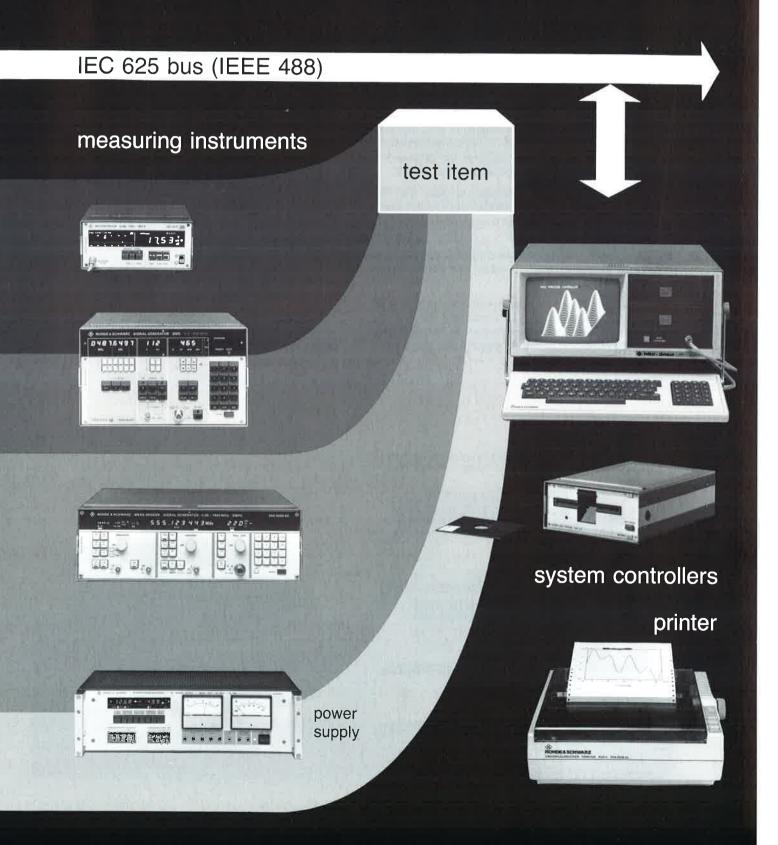
> Modern command systems fully depend on a well-functioning communications system ensuring full mobility of the forces. The radio transmission of information therefore remains absolutely indispensable, but does of course not exclude any future transmission methods as being developed by the radiocommunications division. This division plans and produces complete radio systems for use on board ship, at civil and military airports, as well as mobile radio equipment and embassy networks.

> The EK 070 is an ultra-modern HF receiver and is furthermore entirely remotely controllable. It is used in high-grade communication systems, for radio surveillance and in shortwave DF systems. It can be found increasingly with computer support even in smaller radio installations.





automated testing IEC bus test systems



1 IEC BUS

automated testing

The development of favourably priced control computers and itelligent measuring instruments has opened the way – both at the control and the measuring ends – for the implementation of automated measurements on a broad front. The application of automated instrumentation is no longer restricted to a few large-scale users – as it was before for financial reasons – but has become a cost-effective method available to all users of measuring instruments in development, production and quality control.

Exploitation of the full potential of this intelligent instrumentation is made possible by the IEC bus.

IEC bus or IEEE 488 or GPIB?

The IEC bus is a worldwide standardized data bus for use in test systems, permitting measuring instruments from different manufacturers to be combined at will with freely selectable computers without requiring an instrument-compatible interface or special data couplers.

Rohde & Schwarz measuring instruments with IEC-bus capability are generally designated as IEC-bus-compatible and marked by the symbol (IEC Bus) in the catalog, the term "IEC bus" being based on the standard IEC 66.22.

In the USA the corresponding standard is IEEE 488; the acronym GPIB (general purpose interface bus) is also used. All these names designate the same bus system except for the connectors (see right).

Having become the international standard, IEC 625-1 applies for this bus system all over the world; this results in the designation: **IEC 625 bus**.

The IEC bus constitutes a teletype line between the individual units of a test system, enabling data transfer in either direction. The controllers both send commands to the measuring instruments and receive data from them via the IEC bus. The IEC bus is designed such that combining the instruments into a system requires no **special knowledge** and is achieved by simply linking up the IEC bus connectors of the individual units. All other functions, such as monitoring the usually different data transfer rates of the individual instruments, are performed automatically. The code used for transmitting information via the IEC bus is ASCII (ISO 7-bit code), which normally also provides the communication between computers and their peripherals and delivers characters which can be written and read directly.

Small computing systems such as desktop models and process controllers featuring a favourable price/performance ratio are ideal for controlling IEC-bus-compatible equipment. In general they are smart enough to meet all usual requirements. Computers using standard programming languages such as BASIC are of special advantage since changing the computer then presents no problems. Even the speed of these models is generally sufficient for analog test systems.

IEC-bus connectors (differences)

The development of the IEC bus has brought about two different connector systems:

24-way connector (Amphenol), original type, in accordance with US standard, at present most frequently used;

25-way connector (Cannon), included in the IEC standard.

Rohde & Schwarz instruments basically use the 24-way connector; they are thus compatible with the majority of the equipment on the market.



Application of IEC bus: automatic test assembly for s-parameter measurement (ZPV with S-parameter Test Adapter, XPC and Process Controller PUC)

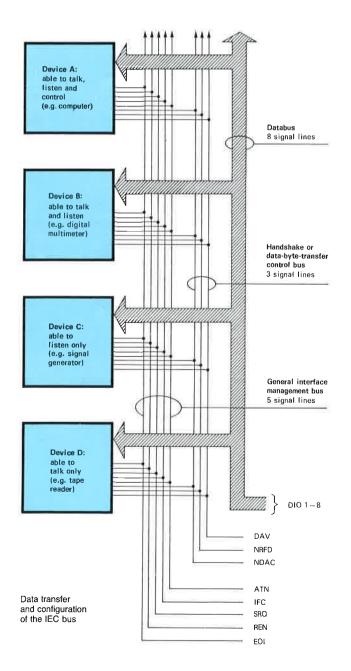
IEC BUS 1

How does the IEC bus function?

The IEC bus consists of three parts: the data lines, the control lines for the timing of what occurs and the control lines necessary for the management of the system.

The actual data transfer is made over eight data lines **DIO** (data input/output) which carry all information and also addresses. The data bus is bidirectional, the data flowing in both directions.

As mentioned, the characters are in ISO 7-bit code (ASCII code), one complete character per clock being transferred over the data bus. The control line **ATN** (attention) serves for identifying whether instrument addresses, commands or data are being transferred.



The other lines for system control are: **IFC** (interface clear) for resetting the system to a defined initial state, **SRQ** (service request) for interrupt control, which enables the instrument to request the attention of the control computer for delivering a test result or signalling an error, **REN** (remote enable) for putting the measuring devices into programmed operation and **EOI** (end or identify) for identifying the last character sent.

The timing of data transfer is controlled via the lines DAV (data valid), NDAC (not data accepted) and NRFD (not ready for data) by the handshake process, that is to say, the slowest device determines the speed of operation. Although this method is not the best from the point of view of speed, it ensures that the user does not have to worry about timing the data transfer. Any combination of IEC-bus-compatible instrumentation can be assembled and automatically adjusts to its own speed of data flow. In general the minimum data flow rate of Rohde & Schwarz instruments is very high, so that normally no noticeable delay of the programming speed is entailed. Since, moreover, in analog measurements the instruments need quite some time to settle to steady state, it can be assumed that even desktop-computer control does not reduce the physically feasible maximum test speed significantly.

The IEC bus is consequently a self-driving and self-controlling data bus enabling measuring instruments and computers to be put together easily.

How is an IEC-bus-compatible test system set up?

The most important criterion is the selection of suitable **measuring instruments**. Thus the configuration of an IECbus-compatible test assembly does not differ from that of a setup consisting of manually operated devices. The measuring instruments are selected for their specific technical characteristics to meet all the requirements involved. Next the necessary interconnections are made. Now the user is able to check in the **manual mode** whether the test assembly complies with his idea. All measuring functions and accuracy specifications are verified.

The step towards automation is taken by linking up the IECbus connectors located on the rear of the instruments and by connecting them to a control computer. Criteria for selecting this computer are the programming language, storage capacity, computing speed and operating convenience. The test assembly obtained in this way performs all test routines that are possible in the manual mode in fully automatic operation.

Thus in the **first stage** the IEC-bus-compatible test equipment is a configuration of instruments which are operated from a computer.

IFC BUS 1

automated testing

page

Set up of test system (cont'd)

In the second stage, efficient use of the computer capabilities permits optimizing the instrument characteristics. This can be achieved by suitable programs for error correction and self-calibration in accordance with standard curves. In this way, the accuracy can be increased considerably in most cases.

In the third stage, measurement evaluation can be expanded from simple test result logging to error statistics, error diagnosis, nominal-to-actual comparison and graphic display.

In practice, the configuration of IEC-bus systems is so easy that the user himself can take care of the assembly. However, Rohde & Schwarz naturally also offers comprehensive system consultancy and assistance for any questions or problems that may arise. Finally, ready-to-use systems are available on request.

For frequent standard applications, the Rohde & Schwarz line includes complete IEC-bus systems with data sheet specifications. The delivery comprises problem-oriented software enabling the user to operate these systems without any extra programming.

Instruments used in IEC-bus systems

The configuration of IEC-bus test systems requires not only measuring instruments but also different system devices to perform control and auxiliary functions. For the measuring instruments see the corresponding sections of this catalog; the system devices (and the temperature-measuring units) are described on the following pages.

IEC 625 Bus

IEC-bus compatible instruments

Signal generators, compact test assemblies

page

Generator SPN, 1 Hz to 1.3 MHz	44
Signal Generator SMS, 0.1 to 520 (0.1 to 1040) MHz	50
Signal Generator SMK, 10 Hz to 140 MHz	46
Signal Generator SMPC, 5 kHz to 1360 MHz	54
Synthesizer Generator XPC, 5 kHz to 1360 MHz	58
Mobile Tester (transceiver test set) SMFP 2,	80
400 kHz to 1000 MHz	
Sweep Generator SWP, 0.1 to 2500 MHz	126
Polyskop SWOB 5 with	132
Digital Display Store BDS	

Impedance measuring instruments

Vector Analyzer ZPV, 10 Hz to 2 GHz	142
S-parameter Test Adapter ZPV-Z5, 5 MHz to 2 GHz	145

۷	0	lt	m	e	te	rs

Digital Multimeter UDS 5, 31/2, 41/2, 51/2 digits	182
measurement of V, I (DC and AC) and R	
RMS Voltmeter URE; V DC, 10 Hz to 20 MHz	202
System Voltmeter UDS 6, 61/2 digits,	188
measurement of V DC, V AC and R; 10 programs	
Millivoltmeter URV 4, 10 kHz to 2 GHz,	210
700 μV to 1000 V, -50 to +73 dBm	

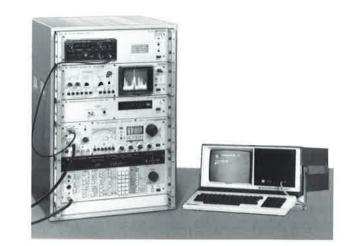
1.1

Test receivers	
Test Receiver ESH 3, 9 kHz to 30 MHz Test Receiver ESVP, 20 to 1300 MHz Progr. VHF-UHF Test Equipment MSUP,	226 238 248
25 to 1000 MHz HF-VHF-UHF test assembly with ESH 3 and MSUP,	249
9 kHz to 1000 MHz Modulation Analyzer FAM, 55 kHz to 1360 MHz	256
Step attenuators	
RF Step Attenuator DPSP, 0 to 2700 MHz	292
Logic instruments	
Logic Generator IGA, 32 data channels	302
Logic Analyzer IMAT, sampling rate 100 MHz	308 314
Logic State Analyzer IMAS, 48 data channels	314
Power supplies	
Programmable Power Supplies NGPV, 8 V/10 A to 300 V/0.6 A	332
Programmable Power Supplies NGPU, 70 V/10 A and 70 V/20 A	331
Programmable Voltage Source NGPS, 2×40 V/±16.38 V; max. 100 mA	330
Temperature-measuring and controlling units	
Digital Thermometer PTM, -100 to $+300$ °C Temperature Controller PTC, -100 to $+300$ °C	24 25
Matrices, auxiliary devices	
Pneumatic Interface PIF, 16 actuating cylinders	22
AF Relay Matrix PSN, DC and AF	23
RF Relay Matrix PSU, DC to 6 GHz	23
Adaptable via Code Converter PCW	
Power Signal Generator SMLU, 25 MHz to 1 GHz	70
Programmable Attenuator Set DPVP, 0 to 1000 MHz	293
VHF-UHF Test Receiver ESU 2, 25 to 1000 MHz	242
System devices	
-	14
Process Controller PUC, 32 kbyte	14

- Universal Printer PUD 2 20
- Code Converter PCW 21

IEC-bus-compatible measuring instruments for sound- and TV-broadcasting equipment are described in a separate catalog; see note on inside front cover.

Selection of the right controller to suit the task



IFC BUS

Example of computer control: automatic VHF-UHF test assembly for wanted- and unwanted-signal measurements using Process Controller PUC

Desktop computer control

The desktop computer (process controller) provides an excellent means for controlling IEC-bus systems. It offers a particularly economic solution for small, decentralized automatic test systems.

Essential advantages are:

Low price. In addition to the actual computing system, the process controller combines in one unit the most important peripherals such as keyboard, magnetic store and display. In this way an especially favourable price/performance ratio is achieved.

High reliability. Integrating the computer and the peripherals in one cabinet ensures an extremely high reliability. Putting the system into operation presents no difficulties since there are no interface problems to be solved. The IECbus connector is fitted as standard.

Easy operation. The process controller is convenient and easy to operate. Program editing in particular is very easy.

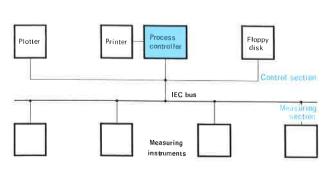
The high storage capacity and computing speed are sufficient for practically all analog testing applications.

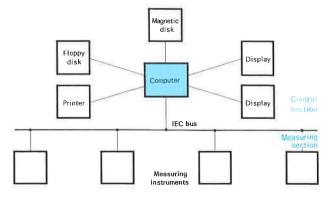
Minicomputer control

If a higher-capability control computer is required, a minicomputer can be used instead of the desktop computer or process controller. Any computer with IEC-bus connector is suitable for this purpose.

The advantages of this configuration are the higher data processing speed and the shorter access time to larger data stores such as the magnetic disk. Thus it is convenient to use minicomputers if, in addition to the actual measurement task, comprehensive data processing is required, for instance selection of test-item-dependent measuring parameters and collection of large amounts of data for statistical evaluation.

Rohde & Schwarz automatic test systems are controlled from the Process Controller PUC. In specific cases standard programs for other types of computers are also available.





Block diagram of test assembly with computer control

Block diagram of automatic test assembly



Programming

The programming effort required for an automatic test system is an essential criterion for its economic efficiency. Therefore a complete, technical ATS solution comprises both the realization of the hardware and the corresponding software.

Two different solutions are to be distinguished:

- a) for users with higher programming knowledge wishing to make exhaustive use of their ATS capabilities, and
- b) for users who have to change their programs very frequently and are not ready to accept a high programming effort.

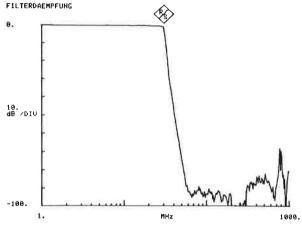
Consequently there are two different modes of programming:

The direct mode using a programming language. The most universal method is to address the instruments directly. Setting and measuring commands are communicated to the instruments in a programming language and combined into test programs using logic functions. The basis is BASIC, the widely used programming language; it permits IEC-bus-controlled instruments to be directly addressed. With modern R&S measuring instruments of high intelligence it is even possible to enter the settings in ordinary language and to read the test results in the correct mathematical form. This means: instrument intelligence considerably simplifies individual test programs.

Using preprogrammed test routines (basic software).

Programming becomes very easy when preprogrammed test routines are used. In this case virtually no programming knowledge is required and the user is able to realize comprehensive test programs within a very short time. For this purpose, Rohde & Schwarz offers **basic software packages** containing ready preprogrammed test routines. These routines are linked in such a way that wrong programming is practically impossible. Basic software packages are available for instance for all test programs required in RT technology for measuring AM, ϕ M and FM equipment. Moreover, another software package available for the Process Controller PUC contains graphics routines which permit complex diagrams, such as the Smith chart, to be represented within a very short time. These software packages have proved valuable in many cases, their number being constantly extended with the appearance of new R&S measuring instruments. It is also of advantage that the packages can be expanded by individual test programs and that no loss in flexibility occurs.

The programming example below to the left shows the procedure executed when measuring a transceiver with the Mobile Tester SMFP 2, while the example to the right, relating to the Vector Analyzer ZPV, illustrates the programming required for graphic display of complex quantities.





Programming examples

Transceiver measurement using SMFPZ



Measurement of complex quantities using ZPV

100 INIT 110 Y=1	
120 GOSUB 1	program start
130 Y=10 140 GOSUB 9	sweep start frequency
150 Y=900	Sweep stop frequency
160 GOSUB 10 170 Y=10	
189 GOSUB 11	sweep step width
190 GOSUB 78	Iransmission factor
200 Y1=-60 210 Y2=0	measurement
220 S\$="DB"	cartesian diagram
230 T\$="KOPPELDAEMP, RICHTK." 240 GOSUB 90	with scaling
250 GOSUB 97	display magnitude
260 Y1=-200 270 Y2=400	
280 Y\$="GR"	additional scaling
290 GOSUB 92	
300 GOSUB 98-310 END	display phase

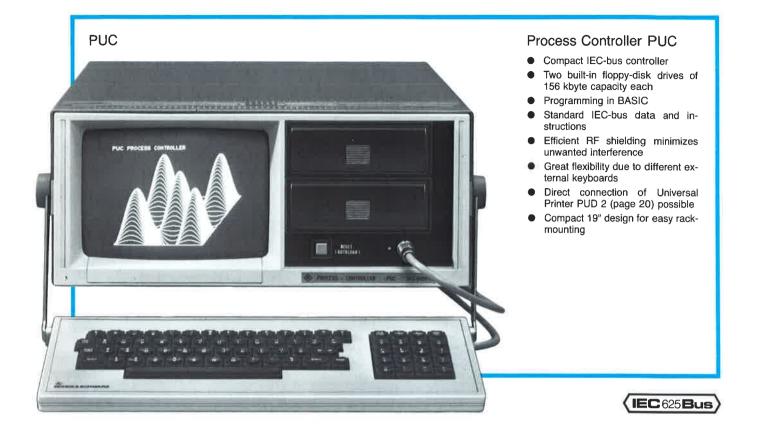
IEC BUS 1

Example for easy programming with preprogrammed test routines Code numbers of Basic Software ZPV-K 10

1 program start						
i program start			Ve	ctor measurement		Physical unit
Y = 1 generator SMPU	Y = 4 generator	SMS	55	voltage ratio measure-	linear	no dimension,
Y = 2 generator SMLU				ment, channel B/A		degrees
Y = 3 generator SPN	Y = 6 generator		57	voltage ratio measure-	linear,	no dimension,
· · · · · · · · · · · · · · · · · · ·	, o gonorator			ment, channel B/A	relative	degrees
Input data		Physical unit	58	voltage ratio measure-	log	dB, degrees
2 test frequency		MHz		ment, channel B/A	.09	ub, acgrees
3 test level		dBm	50	voltage ratio measure-	log	dB dogroop
				ment, channel B/A	log,	dB, degrees
6 shift of reference plane		cm		ment, channel B/A	relative	
7 relative dielectric constan	t e _r		_			
9 sweep start frequency		MHz		rameter measurement		
10 sweep stop frequency		MHz	62	reflection coefficient	linear by magni-	no dimension,
11 sweep step width		MHz		measurement	tude and phase	degrees
13 number of markers			63	reflection coefficient	linear with real	no dimension
14 frequency deviation for gr	oup-delay			measurement	and imaginary	
measurement	· · ·	kHz			components	
			65	reflection coefficient	log by magnitude	dB. dearees
Operational settings				measurement	and phase	,,,
17 impedance of test setup 5	50 Ω		66	VSWR measurement		no dimension,
18 impedance of test setup 7	75 Ω					degrees
19 parameter measurement u	using directional cou	plers	67	impedance measurement		· · · · · · · · · · · · · · · · · · ·
21 parameter measurement v			0,	by magnitude and phase		Ω, degrees
22 filter on		eapiere	60			~
23 filter off			69	impedance measurement		Ω
25 electrical length compens	otion on			in terms of resistance		
				and reactance		
26 electrical length compens	auon on		73	admittance measurement		mS, degrees
Calibration/reference value	e			by magnitude and phase		
27 store magnitude (real com	-	o value	74	admittance measurement		mS
29 store phase (imaginary co				in terms of conductance		
	mponent), group de	elay as reference value		and susceptance		
30 calibrate parameter			75	transmission factor	linear by magni-	no dimension,
31 calibrate for dynamic group	o delay measureme	nt		measurement	tude and phase	degrees
Output of single-shot meas	uromonte		77	transmission factor	linear with real	•
33 nominal/actual value		-1		measurement		no dimension
	H1 = upper limit			measurement	and imaginary	
comparison, output on	magnitude (real c				components	
display	H2 = upper limit		78	transmission factor	log by magnitude	dB, degrees
	phase (imaginary			measurement	and phase	
	L1 = lower limit of	of				
	magnitude (real c	component)	Gr	oup-delay measurement		
	LO - loures limits		00	static group-delay		
	L2 = lower limit of	וע	02	static group-delay		us
			82	measurement		μs
34 nominal/actual value	phase (imaginary			measurement		
34 nominal/actual value	phase (imaginary limit input same			measurement dynamic group-delay		μs μs
comparison, output	phase (imaginary			measurement		
	phase (imaginary limit input same		83	measurement dynamic group-delay measurement		
comparison, output	phase (imaginary limit input same as under 33		83 DC	measurement dynamic group-delay measurement voltage measurement		μs
comparison, output on printer	phase (imaginary limit input same as under 33 measurements		83 DC	measurement dynamic group-delay measurement voltage measurement voltage measurement		
comparison, output on printer Output of swept-frequency 35 nominal/actual value	phase (imaginary limit input same as under 33 measurements limit input same		83 DC	measurement dynamic group-delay measurement voltage measurement		μs
comparison, output on printer Output of swept-frequency 35 nominal/actual value comparison, output on	phase (imaginary limit input same as under 33 measurements		83 DC	measurement dynamic group-delay measurement voltage measurement voltage measurement		μs
comparison, output on printer Output of swept-frequency 35 nominal/actual value comparison, output on display	phase (imaginary limit input same as under 33 measurements limit input same as under 33		83 DC	measurement dynamic group-delay measurement voltage measurement voltage measurement		μs
comparison, output on printer Output of swept-frequency 35 nominal/actual value comparison, output on display 37 nominal/actual value	phase (imaginary limit input same as under 33 measurements limit input same as under 33 limit input same		83 DC 84	measurement dynamic group-delay measurement voltage measurement at ADC input		μs
comparison, output on printer Output of swept-frequency 35 nominal/actual value comparison, output on display 37 nominal/actual value comparison, output	phase (imaginary limit input same as under 33 measurements limit input same as under 33		83 DC 84	measurement dynamic group-delay measurement voltage measurement voltage measurement		μs
comparison, output on printer Output of swept-frequency 35 nominal/actual value comparison, output on display 37 nominal/actual value	phase (imaginary limit input same as under 33 measurements limit input same as under 33 limit input same		83 DC 84	measurement dynamic group-delay measurement voltage measurement at ADC input		μs
comparison, output on printer Output of swept-frequency 35 nominal/actual value comparison, output on display 37 nominal/actual value comparison, output on printer	phase (imaginary limit input same as under 33 measurements limit input same as under 33 limit input same		83 DC 84 Gr	measurement dynamic group-delay measurement voltage measurement at ADC input		μs
comparison, output on printer Output of swept-frequency 35 nominal/actual value comparison, output on display 37 nominal/actual value comparison, output on printer Program execution	phase (imaginary limit input same as under 33 measurements limit input same as under 33 limit input same		83 DC 84 Gr	measurement dynamic group-delay measurement voltage measurement at ADC input	T\$ = "(title, max.	μs
comparison, output on printer Output of swept-frequency 35 nominal/actual value comparison, output on display 37 nominal/actual value comparison, output on printer Program execution 39 wait loop 1 s	phase (imaginary limit input same as under 33 measurements limit input same as under 33 limit input same		83 DC 84 Gr	measurement dynamic group-delay measurement voltage measurement at ADC input		μs
comparison, output on printer Output of swept-frequency 35 nominal/actual value comparison, output on display 37 nominal/actual value comparison, output on printer Program execution 39 wait loop 1 s 41 wait loop 0.1 s	phase (imaginary limit input same as under 33 measurements limit input same as under 33 limit input same		83 DC 84 Gr Chi 85	measurement dynamic group-delay measurement voltage measurement at ADC input	20 characters)"	μs
comparison, output on printer Output of swept-frequency 35 nominal/actual value comparison, output on display 37 nominal/actual value comparison, output on printer Program execution 39 wait loop 1 s 41 wait loop 0.1 s 42 halt	phase (imaginary limit input same as under 33 measurements limit input same as under 33 limit input same		83 DC 84 Gr Chi 85	measurement dynamic group-delay measurement voltage measurement at ADC input	20 characters)" T\$ = "(title, max.	μs
comparison, output on printer Output of swept-frequency 35 nominal/actual value comparison, output on display 37 nominal/actual value comparison, output on printer Program execution 39 wait loop 1 s 41 wait loop 0.1 s	phase (imaginary limit input same as under 33 measurements limit input same as under 33 limit input same		83 DC 84 Gr Chi 85 86	measurement dynamic group-delay measurement voltage measurement at ADC input raphic display arts Smith chart Smith chart +10 dB	20 characters)" T\$ = "(title, max. 20 characters)"	μs
comparison, output on printer Output of swept-frequency 35 nominal/actual value comparison, output on display 37 nominal/actual value comparison, output on printer Program execution 39 wait loop 1 s 41 wait loop 0.1 s 42 halt 43 print program	phase (imaginary limit input same as under 33 measurements limit input same as under 33 limit input same as under 33		83 DC 84 Gr Chi 85 86	measurement dynamic group-delay measurement voltage measurement at ADC input	20 characters)" T\$ = "(title, max. 20 characters)" T\$ = "(title, max.	μs
comparison, output on printer Output of swept-frequency 35 nominal/actual value comparison, output on display 37 nominal/actual value comparison, output on printer Program execution 39 wait loop 1 s 41 wait loop 0.1 s 42 halt	phase (imaginary limit input same as under 33 measurements limit input same as under 33 limit input same as under 33		83 DC 84 Gr 65 85 86 87	measurement dynamic group-delay measurement voltage measurement at ADC input aphic display arts Smith chart Smith chart +10 dB Smith chart -10 dB	20 characters)" T\$ = "(title, max. 20 characters)" T\$ = "(title, max. 20 characters)"	μs
comparison, output on printer Output of swept-frequency 35 nominal/actual value comparison, output on display 37 nominal/actual value comparison, output on printer Program execution 39 wait loop 1 s 41 wait loop 0.1 s 42 halt 43 print program	phase (imaginary limit input same as under 33 measurements limit input same as under 33 limit input same as under 33	component)	83 DC 84 Gr 65 85 86 87	measurement dynamic group-delay measurement voltage measurement at ADC input raphic display arts Smith chart Smith chart +10 dB	20 characters)" T\$ = "(title, max. 20 characters)" T\$ = "(title, max. 20 characters)" Y = outer circle	μs
comparison, output on printer Output of swept-frequency 35 nominal/actual value comparison, output on display 37 nominal/actual value comparison, output on printer Program execution 39 wait loop 1 s 41 wait loop 0.1 s 42 halt 43 print program Individual measuremet	phase (imaginary limit input same as under 33 measurements limit input same as under 33 limit input same as under 33	component) Physical unit	83 DC 84 Gr 65 85 86 87	measurement dynamic group-delay measurement voltage measurement at ADC input aphic display arts Smith chart Smith chart +10 dB Smith chart -10 dB	20 characters)" T\$ = "(title, max. 20 characters)" T = "(title, max. 20 characters)" Y = outer circle T$ = "(title, max.$	μs
comparison, output on printer Output of swept-frequency 35 nominal/actual value comparison, output on display 37 nominal/actual value comparison, output on printer Program execution 39 wait loop 1 s 41 wait loop 0.1 s 42 halt 43 print program Individual measurement 45 voltage measurement	phase (imaginary limit input same as under 33 measurements limit input same as under 33 limit input same as under 33	component)	83 DC 84 Gr Ch: 85 86 87 88	measurement dynamic group-delay measurement voltage measurement at ADC input aphic display arts Smith chart Smith chart +10 dB Smith chart -10 dB polar diagram	20 characters)" T\$ = "(title, max. 20 characters)" T = "(title, max. 20 characters)" Y = outer circle T$ = "(title, max. 20 characters)"$	μs
comparison, output on printer Output of swept-frequency 35 nominal/actual value comparison, output on display 37 nominal/actual value comparison, output on printer Program execution 39 wait loop 1 s 41 wait loop 0.1 s 42 halt 43 print program Individual measurement 45 voltage measurement channel A	phase (imaginary limit input same as under 33 measurements limit input same as under 33 limit input same as under 33	component) Physical unit mV, degrees	83 DC 84 Gr Chi 85 86 87 88 88	measurement dynamic group-delay measurement voltage measurement at ADC input caphic display arts Smith chart Smith chart +10 dB Smith chart -10 dB polar diagram additional scaling, polar	20 characters)" T\$ = "(title, max. 20 characters)" T = "(title, max. 20 characters)" Y = outer circle T$ = "(title, max. 20 characters)" Y = outer circle$	μs V
comparison, output on printer Output of swept-frequency 35 nominal/actual value comparison, output on display 37 nominal/actual value comparison, output on printer Program execution 39 wait loop 1 s 41 wait loop 0.1 s 42 halt 43 print program Individual measurement Vector measurement 45 voltage measurement channel A	phase (imaginary limit input same as under 33 measurements limit input same as under 33 limit input same as under 33 nts linear	component) Physical unit mV, degrees no dimension,	83 DC 84 Gr Chi 85 86 87 88 88	measurement dynamic group-delay measurement voltage measurement at ADC input caphic display arts Smith chart Smith chart +10 dB Smith chart -10 dB polar diagram additional scaling, polar Cartesian diagram,	20 characters)" T\$ = "(title, max. 20 characters)" T = "(title, max. 20 characters)" Y = outer circle T$ = "(title, max. 20 characters)"$	μs V
comparison, output on printer Output of swept-frequency 35 nominal/actual value comparison, output on display 37 nominal/actual value comparison, output on printer Program execution 39 wait loop 1 s 41 wait loop 0.1 s 42 halt 43 print program Individual measurement Vector measurement channel A 46 voltage measurement channel A	phase (imaginary limit input same as under 33 measurements limit input same as under 33 limit input same as under 33	component) Physical unit mV, degrees	83 DC 84 Gr Chi 85 86 87 88 88	measurement dynamic group-delay measurement voltage measurement at ADC input caphic display arts Smith chart Smith chart +10 dB Smith chart -10 dB polar diagram additional scaling, polar	20 characters)" T\$ = "(title, max. 20 characters)" T = "(title, max. 20 characters)" Y = outer circle T$ = "(title, max. 20 characters)" Y = outer circle$	μs V
comparison, output on printer Output of swept-frequency 35 nominal/actual value comparison, output on display 37 nominal/actual value comparison, output on printer Program execution 39 wait loop 1 s 41 wait loop 0.1 s 42 halt 43 print program Individual measurement Vector measurement 45 voltage measurement channel A 46 voltage measurement	phase (imaginary limit input same as under 33 measurements limit input same as under 33 limit input same as under 33 nts linear	component) Physical unit mV, degrees no dimension,	83 DC 84 Gr Chi 85 86 87 88 88	measurement dynamic group-delay measurement voltage measurement at ADC input caphic display arts Smith chart Smith chart +10 dB Smith chart -10 dB polar diagram additional scaling, polar Cartesian diagram,	20 characters)" T\$ = "(title, max. 20 characters)" T = "(title, max. 20 characters)" T$ = "(title, max. 20 characters)" Y = outer circle T$ = "(title, max. 20 characters)" Y = outer circle Y1 = minimum ve Y2 = maximum ve$	μs V
comparison, output on printer Output of swept-frequency 35 nominal/actual value comparison, output on display 37 nominal/actual value comparison, output on printer Program execution 39 wait loop 1 s 41 wait loop 0.1 s 42 halt 43 print program Individual measurement vector measurement channel A 46 voltage measurement channel A	phase (imaginary limit input same as under 33 measurements limit input same as under 33 limit input same as under 33 nts linear linear, relative	component) Physical unit mV, degrees no dimension, degrees	83 DC 84 Gr Chi 85 86 87 88 88	measurement dynamic group-delay measurement voltage measurement at ADC input caphic display arts Smith chart Smith chart +10 dB Smith chart -10 dB polar diagram additional scaling, polar Cartesian diagram,	20 characters)" T\$ = "(title, max. 20 characters)" T\$ = "(title, max. 20 characters)" Y = outer circle T\$ = "(title, max. 20 characters)" Y = outer circle Y1 = minimum ve Y2 = maximum ve S\$ =v "(unit, max	rtical axis rtical axis rtical axis . 3 characters)"
comparison, output on printer Output of swept-frequency 35 nominal/actual value comparison, output on display 37 nominal/actual value comparison, output on printer Program execution 39 wait loop 1 s 41 wait loop 0.1 s 42 halt 43 print program Individual measurement channel A 46 voltage measurement channel A 47 voltage measurement	phase (imaginary limit input same as under 33 measurements limit input same as under 33 limit input same as under 33 nts linear linear, relative log	component) Physical unit mV, degrees no dimension, degrees dBm, degrees	83 DC 84 Gr Chi 85 86 87 88 88 89 90	measurement dynamic group-delay measurement voltage measurement voltage measurement at ADC input aphic display arts Smith chart Smith chart + 10 dB Smith chart - 10 dB polar diagram additional scaling, polar Cartesian diagram, linear frequency axis	20 characters)" T\$ = "(title, max. 20 characters)" T\$ = "(title, max. 20 characters)" Y = outer circle T\$ = "(title, max. 20 characters)" Y = outer circle Y1 = outer circle Y1 = outer circle Y1 = minimum ve Y2 = maximum ve S\$ =v "(unit, max. T\$ = "(title, max.)	rtical axis prtical axis srtical axis . 3 characters)" 20 characters)"
comparison, output on printer Output of swept-frequency 35 nominal/actual value comparison, output on display 37 nominal/actual value comparison, output on printer Program execution 39 wait loop 1 s 41 wait loop 0.1 s 42 halt 43 print program Individual measurement channel A 45 voltage measurement channel A 47 voltage measurement channel A	phase (imaginary limit input same as under 33 measurements limit input same as under 33 limit input same as under 33 nts linear linear, relative	component) Physical unit mV, degrees no dimension, degrees	83 DC 84 Gr Chi 85 86 87 88 88 89 90	measurement dynamic group-delay measurement voltage measurement voltage measurement at ADC input aphic display arts Smith chart Smith chart + 10 dB Smith chart - 10 dB polar diagram additional scaling, polar Cartesian diagram, linear frequency axis	20 characters)" T\$ = "(title, max. 20 characters)" T\$ = "(title, max. 20 characters)" Y = outer circle T\$ = "(title, max. 20 characters)" Y = outer circle Y1 = minimum ve Y2 = maximum ve S\$ =v "(unit, max	rtical axis prtical axis srtical axis . 3 characters)" 20 characters)"
comparison, output on printer Output of swept-frequency 35 nominal/actual value comparison, output on display 37 nominal/actual value comparison, output on printer Program execution 39 wait loop 1 s 41 wait loop 0.1 s 42 halt 43 print program Individual measurement channel A 46 voltage measurement channel A 47 voltage measurement channel A 49 voltage measurement channel A	phase (imaginary limit input same as under 33 measurements limit input same as under 33 limit input same as under 33 nts linear linear, relative log log, relative	component) Physical unit mV, degrees no dimension, degrees dBm, degrees dB, degreees	83 DC 84 Gr Chi 85 86 87 88 89 90 90	measurement dynamic group-delay measurement voltage measurement voltage measurement at ADC input raphic display arts Smith chart Smith chart + 10 dB Smith chart - 10 dB polar diagram additional scaling, polar Cartesian diagram, linear frequency axis	20 characters)" T\$ = "(title, max. 20 characters)" T\$ = "(title, max. 20 characters)" Y = outer circle Y1 = minimum ve Y2 = maximum ve S\$ =v "(unit, max. T\$ = "(title, max. T\$	rtical axis v rtical axis .3 characters)" 20 characters)" ler 90
comparison, output on printer Output of swept-frequency 35 nominal/actual value comparison, output on display 37 nominal/actual value comparison, output on printer Program execution 39 wait loop 1 s 41 wait loop 0.1 s 42 halt 43 print program Individual measurement channel A 45 voltage measurement channel A 47 voltage measurement channel A 49 voltage measurement channel A 45 voltage measurement channel A 45 voltage measurement channel A	phase (imaginary limit input same as under 33 measurements limit input same as under 33 limit input same as under 33 nts linear linear, relative log	component) Physical unit mV, degrees no dimension, degrees dBm, degrees	83 DC 84 Gr Chi 85 86 87 88 89 90 90	measurement dynamic group-delay measurement voltage measurement voltage measurement at ADC input raphic display arts Smith chart Smith chart +10 dB Smith chart -10 dB polar diagram additional scaling, polar Cartesian diagram, linear frequency axis additional scaling,	20 characters)" T\$ = "(title, max. 20 characters)" T\$ = "(title, max. 20 characters)" Y = outer circle T\$ = "(title, max. 20 characters)" Y = outer circle Y1 = outer circle Y1 = outer circle Y1 = minimum ve Y2 = maximum ve S\$ =v "(unit, max. T\$ = "(title, max.)	rtical axis v rtical axis .3 characters)" 20 characters)" ler 90
comparison, output on printer Output of swept-frequency 35 nominal/actual value comparison, output on display 37 nominal/actual value comparison, output on printer Program execution 39 wait loop 1 s 41 wait loop 0.1 s 42 halt 43 print program Individual measurement channel A 46 voltage measurement channel A 47 voltage measurement channel A 49 voltage measurement channel A 45 voltage measurement channel A 50 voltage measurement channel B	phase (imaginary limit input same as under 33 Imit input same as under 33 limit input same as under 33 limit input same as under 33 limear linear, relative log log, relative linear	component) Physical unit mV, degrees no dimension, degrees dBm, degrees dB, degreees mV, degrees	83 DC 84 Gr Chi 85 86 87 88 89 90 90	measurement dynamic group-delay measurement voltage measurement voltage measurement at ADC input raphic display arts Smith chart Smith chart + 10 dB Smith chart - 10 dB polar diagram additional scaling, polar Cartesian diagram, linear frequency axis	20 characters)" T\$ = "(title, max. 20 characters)" T\$ = "(title, max. 20 characters)" Y = outer circle Y1 = minimum ve Y2 = maximum ve S\$ =v "(unit, max. T\$ = "(title, max. T\$	rtical axis v rtical axis .3 characters)" 20 characters)" ler 90
comparison, output on printer Output of swept-frequency 35 nominal/actual value comparison, output on display 37 nominal/actual value comparison, output on printer Program execution 39 wait loop 1 s 41 wait loop 0.1 s 42 halt 43 print program Individual measurement channel A 46 voltage measurement channel A 47 voltage measurement channel A 49 voltage measurement channel A 50 voltage measurement channel A 50 voltage measurement channel B 51 voltage measurement	phase (imaginary limit input same as under 33 measurements limit input same as under 33 limit input same as under 33 linear linear, relative linear linear, relative linear	component) Physical unit mV, degrees no dimension, degrees dBm, degrees dB, degrees mV, degrees mV, degrees no dimension,	83 DC 84 Gr 85 86 87 88 89 90 90 91 92	measurement dynamic group-delay measurement voltage measurement voltage measurement at ADC input aphic display arts Smith chart Smith chart + 10 dB Smith chart - 10 dB polar diagram additional scaling, polar Cartesian diagram, linear frequency axis additional scaling, Cartesian diagram,	20 characters)" T\$ = "(title, max. 20 characters)" T\$ = "(title, max. 20 characters)" Y = outer circle Y1 = minimum ve Y2 = maximum ve S\$ =v "(unit, max. T\$ = "(title, max. T\$	rtical axis v rtical axis .3 characters)" 20 characters)" ler 90
comparison, output on printer Output of swept-frequency 35 nominal/actual value comparison, output on display 37 nominal/actual value comparison, output on printer Program execution 39 wait loop 1 s 41 wait loop 0.1 s 42 halt 43 print program Individual measurement channel A 45 voltage measurement channel A 47 voltage measurement channel A 49 voltage measurement channel A 49 voltage measurement channel A 50 voltage measurement channel B 51 voltage measurement channel B	phase (imaginary limit input same as under 33 measurements limit input same as under 33 limit input same as under 33 nts linear linear, relative log log, relative linear, relative linear, relative	component) Physical unit mV, degrees no dimension, degrees dBm, degrees dB, degrees mV, degrees mV, degrees no dimension, degrees	83 DC 84 Gr 85 86 87 88 88 90 90 91 92 Grz	measurement dynamic group-delay measurement voltage measurement voltage measurement at ADC input aphic display arts Smith chart Smith chart + 10 dB Smith chart - 10 dB polar diagram additional scaling, polar Cartesian diagram, linear frequency axis additional scaling, Cartesian diagram, log frequency axis additional scaling, Cartesian diagram,	20 characters)" T\$ = "(title, max. 20 characters)" T\$ = "(title, max. 20 characters)" Y = outer circle T\$ = "(title, max. 20 characters)" Y = outer circle Y1 = minimum ver Y2 = maximum ver Y2 = maximum ver S\$ =v "(unit, max. T\$ = "(title, max. input same as und input same as und	rtical axis v rtical axis .3 characters)" 20 characters)" ler 90
comparison, output on printer Output of swept-frequency 35 nominal/actual value comparison, output on display 37 nominal/actual value comparison, output on printer Program execution 39 wait loop 1 s 41 wait loop 0.1 s 42 halt 43 print program Individual measurement channel A 45 voltage measurement channel A 47 voltage measurement channel A 49 voltage measurement channel A 49 voltage measurement channel B 51 voltage measurement channel B 51 voltage measurement channel B	phase (imaginary limit input same as under 33 measurements limit input same as under 33 limit input same as under 33 linear linear, relative linear linear, relative linear	component) Physical unit mV, degrees no dimension, degrees dBm, degrees dB, degrees mV, degrees mV, degrees no dimension,	83 DC 84 Gr Chi 85 86 87 88 89 90 91 92 91	measurement dynamic group-delay measurement voltage measurement voltage measurement at ADC input caphic display arts Smith chart Smith chart + 10 dB Smith chart - 10 dB polar diagram additional scaling, polar Cartesian diagram, linear frequency axis additional scaling, Cartesian diagram, log frequency axis additional scaling, Cartesian	20 characters)" T\$ = "(title, max. 20 characters)" T\$ = "(title, max. 20 characters)" Y = outer circle T\$ = "(title, max. 20 characters)" Y = outer circle Y1 = minimum ve Y2 = maximum ve S\$ =v "(unit, max. input same as und input same as und rdinates	rtical axis V rtical axis strtical axis 3 characters)" 20 characters)" ler 90 der 90
comparison, output on printer Output of swept-frequency 35 nominal/actual value comparison, output on display 37 nominal/actual value comparison, output on printer Program execution 39 wait loop 1 s 41 wait loop 0.1 s 42 halt 43 print program Individual measurement channel A 45 voltage measurement channel A 47 voltage measurement channel A 49 voltage measurement channel A 45 voltage measurement channel A 45 voltage measurement channel A 45 voltage measurement channel B 51 voltage measurement channel B 53 voltage measurement channel B	phase (imaginary limit input same as under 33 Imit input same as under 33 limit input same as under 33 limit input same as under 33 limear linear, relative log log, relative linear, relative linear, relative log	component) Physical unit mV, degrees no dimension, degrees dB, degreess dB, degreess mV, degrees mV, degrees no dimension, degrees dBm, degrees	83 DC 84 Gr 85 86 87 88 89 90 91 92 91 92 672 96	measurement dynamic group-delay measurement voltage measurement voltage measurement at ADC input aphic display arts Smith chart Smith chart + 10 dB Smith chart - 10 dB polar diagram additional scaling, polar Cartesian diagram, linear frequency axis additional scaling, Cartesian diagram, log frequency axis additional scaling, Cartesian diagram, log frequency axis additional scaling, Cartesian in Smith chart or polar coo magnitude (real componer	20 characters)" T\$ = "(title, max. 20 characters)" T\$ = "(title, max. 20 characters)" T\$ = outer circle T\$ = "(title, max. 20 characters)" Y = outer circle Y1 = minimum ve Y2 = maximum ve S\$ =v "(unit, max. T\$ = "(title, max. input same as und input same as und rdinates th) in Cartesian cool	rtical axis V rtical axis strtical axis 3 characters)" 20 characters)" ler 90 der 90
comparison, output on printer Output of swept-frequency 35 nominal/actual value comparison, output on display 37 nominal/actual value comparison, output on printer Program execution 39 wait loop 1 s 41 wait loop 0.1 s 42 halt 43 print program Individual measurement channel A 45 voltage measurement channel A 47 voltage measurement channel A 49 voltage measurement channel A 50 voltage measurement channel B 51 voltage measurement channel B 53 voltage measurement channel B 53 voltage measurement channel B 54 voltage measurement channel B 53 voltage measurement channel B	phase (imaginary limit input same as under 33 Imit input same as under 33 limit input same as under 33 limit input same as under 33 limear linear, relative log log, relative linear, relative log log, log, glog,	component) Physical unit mV, degrees no dimension, degrees dBm, degrees dB, degrees mV, degrees mV, degrees no dimension, degrees	83 DC 84 Gr 85 86 87 88 89 90 91 92 91 92 672 96	measurement dynamic group-delay measurement voltage measurement voltage measurement at ADC input aphic display arts Smith chart Smith chart + 10 dB Smith chart - 10 dB polar diagram additional scaling, polar Cartesian diagram, linear frequency axis additional scaling, Cartesian diagram, log frequency axis additional scaling, Cartesian	20 characters)" T\$ = "(title, max. 20 characters)" T\$ = "(title, max. 20 characters)" T\$ = outer circle T\$ = "(title, max. 20 characters)" Y = outer circle Y1 = minimum ve Y2 = maximum ve S\$ =v "(unit, max. T\$ = "(title, max. input same as und input same as und rdinates th) in Cartesian cool	rtical axis V rtical axis strtical axis 3 characters)" 20 characters)" ler 90 der 90
comparison, output on printer Output of swept-frequency 35 nominal/actual value comparison, output on display 37 nominal/actual value comparison, output on printer Program execution 39 wait loop 1 s 41 wait loop 0.1 s 42 halt 43 print program Individual measurement channel A 45 voltage measurement channel A 47 voltage measurement channel A 49 voltage measurement channel A 40 voltage measurement channel B 51 voltage measurement channel B 53 voltage measurement channel B	phase (imaginary limit input same as under 33 Imit input same as under 33 limit input same as under 33 limit input same as under 33 limear linear, relative log log, relative linear, relative linear, relative log	component) Physical unit mV, degrees no dimension, degrees dB, degreess dB, degreess mV, degrees mV, degrees no dimension, degrees dBm, degrees	83 DC 84 Gr 85 86 87 88 89 90 91 92 91 92 672 96	measurement dynamic group-delay measurement voltage measurement voltage measurement at ADC input aphic display arts Smith chart Smith chart + 10 dB Smith chart - 10 dB polar diagram additional scaling, polar Cartesian diagram, linear frequency axis additional scaling, Cartesian diagram, log frequency axis additional scaling, Cartesian diagram, log frequency axis additional scaling, Cartesian in Smith chart or polar coo magnitude (real componer	20 characters)" T\$ = "(title, max. 20 characters)" T\$ = "(title, max. 20 characters)" T\$ = outer circle T\$ = "(title, max. 20 characters)" Y = outer circle Y1 = minimum ve Y2 = maximum ve S\$ =v "(unit, max. T\$ = "(title, max. input same as und input same as und rdinates th) in Cartesian cool	rtical axis V rtical axis strtical axis 3 characters)" 20 characters)" ler 90 der 90

1 IEC BUS CONTROLLERS

automated testing



The **Process Controller PUC** is an economic control computer for the automatic measurement and control of IEC-bus operated systems. The PUC possesses numerous interfaces and functions. Modern **measuring techniques** make special demands on process controllers. Compact and reliable design, powerful interfaces and **low RF leakage** make the PUC outstanding for use in RF test systems. The main unit is accommodated in a 19" cabinet which may easily be fitted into a 19" rack (see illustration page 15, top).

Equipment configuration

Basic unit Even in its basic version (main unit with one floppy-disk drive, display of characters and symbols, no keyboard), the PUC fitted with no operating controls finds application in automatic production cycles, in the test department, incoming goods inspection and communications services. For the large majority of other applications the PUC can be supplied with a **standard keyboard**, **user keyboard** and a **footswitch**. From the simple responses to Yes-No prompts during program run to the writing of programs, all problems may thus be solved (see page 17).

Options Based on a series of retrofit options the performance of the PUC can be enhanced easily and cost-effectively for the special problem on hand.

The storage capacity can be enlarged with a **second floppydisk drive** whereas a **serial interface** (RS 232 C) and an I/ **O interface** are available in addition to the standard IEC and printer interfaces. The **Real-time Clock Option** allows the measurement of time, real-time reference and time-related control. The **High-resolution Graphics Option** provides the PUC with every possible graphic display. The option is indispensable in reproducing test curves (e.g. Smith charts) and in many other tasks. More details on options on pp. 17 and 18.

Characteristics

Memory The storage capacity of the PUC is 64 kbytes, half of which is available to the user as RAM space. The 32-kbyte memory is large enough even for very long BASIC programs. To produce machine language programs, the PUC allows direct addressing of the entire memory range. Program parts in machine code may easily be inserted into BASIC programs. There is a further 156-kbyte memory available from the built-in 5¼" floppy-disk drive. A second floppy drive is supplied as an option or may be retrofitted. The floppy-disk drives access programs and data within seconds. The operating system of the PUC stores and loads programs also under program control. With the directory system, an overview of the floppy content can e obtained at any time. The operating system manages up to four floppy-disk drives making up a total storage capacity of 624 kbytes.

Interference immunity Due to the fast logic, computers generate interfering voltages and RF interference. The latter not only "pollutes" the environment but also leads to erroneous results of measurements. As a result of proper shielding the PUC has an extremely low interfering effect on power supply and environment. On the other hand, shielding makes the PUC also insensitive to strong external fields or interference from power lines. To prevent low-frequency interference, the monitor screen can be switched on and off within seconds on the entry of a command.

VDU

The 9" screen serves for the purpose of writing programs as well as for the display of results of measurements and calculations. The bright flicker-free display made up of 25 lines with 40 characters in each guarantees a relaxed working with the PUC. Program lines with more than 40 characters are displayed in two lines. In the operating mode GPH, upper-case characters and, together with the SHIFT key, graphic symbols are selected, whereas in the LTS mode both upper and lower case characters are enabled. Cursor shifts can be made also under program control.

Instruction set

PRINT SPC	TAB GPH	LTS	HOME CLEAR HOME	$\begin{array}{l} CURSOR \uparrow \downarrow \\ CURSOR \leftarrow \rightarrow \end{array}$
--------------	------------	-----	--------------------	--

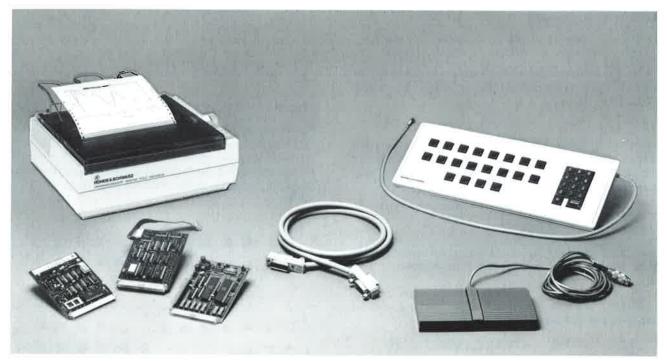
For High-resolution Graphics Option see page 17.

IEC BUS CONTROLLERS 1



Process Controller PUC with user keyboard in 19" rack

Accessoires to the Process Controller PUC: Universal Printer PUD 2, user keyboard, footswitch, IEC-bus cable plus options (plug-in cards): RS 232 C Interface, High-resolution Graphics and I/O Interface



1 IEC BUS CONTROLLERS

automated testing

PUC – BASIC operating system

The program language of the PUC (BASIC) is simple to learn yet powerfull so that complex test programs can be set up. The BASIC in use is significantly extended and has a comprehensive set of editor commands. Program writing is therefore very much simplified. Important aids for program writing are:

Cursor controlled editing with repeat function

- Autonumbering of lines
- Renumbering of program lines

Searching and changing of single characters or texts in $\ensuremath{\mathsf{BASIC}}$

The PUC can of course calculate directly or under program control. Execution times for the basic functions are listed in the following table. The functions contain elements of Boolean algebra so that complex flow charts and control of individual bits can be realized.

Functions	Execution time (ms)	Functions	Execution time (ms)
+	4.6	SQR	52.7
_	4.6	SIN	26.9
*	5.4	cos	27.2
%	6.8	TAN	52.1
> ==		ATN	46.5
< =		LOG	22.6
AND	3.2	EXP	29.2
OR	3.25	aîb	56.6
NOT	0.86	RND	3.68
SGN	0.45	DEF FN	
INT	0.9	FN	
ABS	0.13		

Program run Instructions to do with the running of the program are made up of the Start, Stop, and Wait commands. In addition, the BEEP command generates a tone signal of variable period.

REM	CONT	LET	STOP	WAIT
RUN	GOTO	END	HOLD	BEEP

Data The computer is capable of storing or changing program data (e.g. limit values or texts) which may be arranged in data lines or arrays.

DATA READ RESTORE DIM CLR

Jumps and Loops Particular program blocks in frequent use are easily and clearly brought under a subprogram. The aids to the writing of subprograms are the jump and loop commands.

GOTO	ON GOSUB	FOR TO STEP
ON GOTO	RETURN	NEXT
GOSUB	IF THEN	

String manipulation String commands are used to handle texts or text variables (e.g. use in IEC-bus transfer).

LEN	ASC	STR\$	MID\$
VAL	CHR\$	RIGHT\$	LEFT\$

Input/output commands

OPEN	CLOSE	PRINT	INPUT	GET
CMD				

Editor commands Editor commands are designed to help to write programs rapidly and easily and to carry out changes and testing of programs.

NEW	Delete program
OFF	Delete program with switch-on reset
LIST	List program on VDU
SEQ	Automatic line numbering
DEL	Delete lines
RES	Renumber lines
SEA	Search text or command
REP	Replace text or command

Special cursor keys and keys with delete and insert functions make way for comfortable change of characters or complete program lines. All keys of the standard keyboard are provided with the repeat funciton.

Machine programming

The PUC is directly programmable in machine language. Simple memory and input/output instructions are executed by orders of magnitude faster than those in BASIC. The shortest execution time is 2 μ s. Machine programs may be called up in BASIC and subsequently executed. Hung-up machine programs can be interrupted with the RESET key without the BASIC program being deleted. A RAM block is available for the writing of machine programs; this block is not being used by BASIC. An efficient memory monitor facilitates program writing and testing. Machine programs can also be loaded into the memory from a floppy disk.

Machine commands

POKE	Write in memory
PEEK	Read contents of memory
BSE	Set limit of memory
BPS	Set start of BASIC
BPE	Set end of BASIC
SYS	Call machine program
USR	Call up with variable transfer
ΠМ	Monitor memory

Graphics

Numerous graphic characters (see below) which are part of the basic configuration of the PUC allow clear display. Highresolution graphics display for the presentation of curves of measurements (e.g. Smith charts) is possible using the Highresolution Graphics Option PUC-B6 (see page 17) as a retrofit.

1	ļ						A					Į,	ļ	ł
	-			- 44	鑈				骝				giga	
1	!			ļ	!	ļ	1		-	-	-			
1	Ž	X	35	г	-	٦	-	L	نہ	Ŧ	ł	ŀ	$+^{2}$	+
ተ	÷	*	+†++	\$	雧	۵	ø			F	18	我 海		8
4		F	A .	Г	٦	_!	L	\$\$	×:	\mathcal{U}	8	*	8	899

IEC BUS CONTROLLERS

Kevboards

There are three keyboards available. The standard keyboard (PUC-Z1) has 75 alphanumeric and special keys for the input, processing and testing of programs. All characters and symbols can be entered for normal (bright) or reverse (dark on bright background) display. All keys have repeat capability.

The user keyboard (PUC-Z2) has been designed especially for automatic test assemblies used in production and in the test department. The advantage of the keyboard is that computer experience is not a prerequisite to operate the system. The user keyboard consists of function keys and a numeric keypad (0 to 9, decimal point, minus sign plus DELETE and RETURN). The 20 function keys permit the assignment of arbitrary functions to programs. The replaceable overlays can be marked with the function chosen for a particular key.

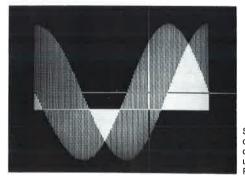
The footswitch (PUC-Z3) serves to answer Yes-No program prompts or to start and stop programs. Hands remain therefore free to be used for adjustments and repairs. The footswitch can be hooked up together with one of the other keyboards.

For applications where manual control is unnecessary as in communications services and fully automatic testing, the PUC can be operated without a keyboard. The first program of the floppy disk is in this case loaded and started on switchon or on pressing the RESET key. Further programs may be fetched under program control, if required.

Basic keyboard commands

INPUT GET

Enter via keyboard Read character from keyboard



Sinewave function displayed on PUC using graphics adapter PUC-B6

A graphics display may then be stored on a floppy disk and be fetched when required. For hardcopies of test results, the Universal Printer PUD 2 outputs the graphics displays.

Graphics commands

G. DOT	Draw dot
G. MOVE	Move graphics cursor
G. LINE	Draw line
G. WIDTH	Draw dotted line
G. PAGE	Clear graphics display
G. INVERT	Invert graphics
G. S, OFF	OFF: dark mode
G: S, INVERT	INVERT: reverse drawing mode
G. S, ON	ON: bright mode
G. WINDOW	Specify range of display coordinates
G. VIEWPORT	Specify detail of display
G: TAKE	Transfer from display memory to graphics
	memory
G. G. COPY	Print hardcopy
G. SAVE	Store graphics display on floppy
G. LOAD	Load graphics display from floppy

Floppy-disk Drive Option PUC-B2 The standard built-in and the retrofit optional floppy drives are identical. The mass storage medium used is the 51/4" floppy disk which provides access to data and programs within seconds. The floppies are of single-density type written on both sides. Each floppy has a storage capacity of 156 kbytes and is divided into 305 areas/side, 256 bytes/area.

Rohde & Schwarz supplies formatted and tested floppy disks, although floppies can be formatted by the user with the supplied motherdisk.

A comprehensive set of instructions enables the control of the floppy drives.

Floppy commands

SEL	Select drive
SET	Set write/read head
INIT	Set write/read head to track 0
LOAD	Load program
CHAIN	Load new program and delete variables
DIR	Call disk directory
APP	Append program
ADD	Add program before another one
SECU	Load and start secured program
SAVE	Store program
VERIFY	Compare new program with that of floppy
IN	Load data
PR	Store data

Options

High-resolution Graphics Option PUC-B6 For the clear presentation of results of automatic measurements, for mathematical functions and diagrams a resolution which is higher than that offered by the graphic characters of the basic model is called for.

The High-resolution Graphics Option has the capability to drive each of the 320×200 points singly. An easy-to-use set of commands enables the drawing of bright or dark lines, or the transfer of graphic characters entered via the keyboard to the display memory of the option. Since this memory is independent of the graphics memory of the PUC, two different displays may at the same time be shown on the screen.

Real-time Clock Option PUC-B10 The option has a battery backed-up clock which outputs information on date and time. The resolution is 100 ms. Accurate time measurements can therefore be carried out, and date and time are entered on test records. Program branching via a command can be made at a given time of day.

RTC commands

RTC TO	Output date and time
RTC SET	Set date and time
RTC IRQ GOTO	Branching at a given time

17

1 IEC BUS CONTROLLERS

automated testing

PUC - Interfaces, Options

IEC-bus Interface The standardized interface (also conforming to IEEE 488) can simultaneously accommodate up to a maximum of 14 devices (including other controllers). The IEC bus is used to set up automatic runs in testing and control optimally and easily. The majority of Rohde & Schwarz measuring instruments are fitted with the IEC interface. The PUC can drive all commercial instruments compatible with the IEC bus. A set of simple and easy-to-handle instructions does away with the need to dwell on the details of the functioning of the IEC-bus system.

IEC-bus commands

Addressed commands

IECOUT IECIN IECTERM IECDEV	Send data or instructions Read in data Define delimiter Define symbolic addresses
IECSDC	Selected device clear
IECGTL	Go to local
IECGXT	Group execute trigger
IECTCT	Take control
IECSRQ GOTO	Jump for SRQ
IECRET SRQ	Return jump out of SRQ
IECLAD	Send listener address
IECTAD	Send talker address
IECSAD	Send secondary address
IECUNL	Send unlisten
IECSPL	Serial poll

Universal commands

IECDCL	Device clear
IECLLO	Local lockout
IECSPE	Serial poll enable
IECSPD	Serial poll disable
IECPPE	Parallel poll enable
IECPPL	Status word
IECPPU	Parallel poll unconfigure
IECPPD	Parallel poll disable
IECTIME	Set time monitor
IEC←ERR	Error disable
IECERR	Error enable
IECREN	REN active
IEC←REN	REN passive
IECCLEAR	IFC active
IEC←CLEAR	IFC passive
IECATT	ATN active
IEC←ATT	ATN passive
IECEOI	EOI active
IEC←EOI	EOI passive

RS 232 C Interface Option PUC-B5 The serial interface enables the transfer of data to or the reception of data from all devices equipped with a serial interface, such as EPROM programming unit, tape reader, tape punch and printer. In addition, the PUC can be hooked up to a computer.

The interface complies with specifications laid down by the RS 232 C I/O Standards, CCITT Recommendations V.24 as well as the DIN 66020 Standard. The RS 232 C Option can be changed to a current-loop interface (20 mA) with the aid of plug-in links. Data transfer is asynchronous with handshaking. The transfer rate is selectable in steps between 50 and 9600 bauds. Data formats between 5 and 8 bits as well as parity and stop bits can be processed.

RS 232 C commands

V24INIT	Initialize required data format
V24TERM	Define delimiter
OPEN a, 232	Open file to operate serial interface
PRINT #	Output data to external device
IN #	Input data from external device
V24ECHO	Switch echo mode on
V24←ECHO	Switch echo mode off

I/O Interface Option PUC-B7 (User port) A great variety of measurement and control tasks, otherwise requiring extra equipment, can be carried out from the computer with the aid of the I/O Interface. The option is made up of a p.c.b. which is plugged into one of the vacant spaces of the PUC. The interface consists of

32 TTL lines arranged in groups of 8 lines programmable either as output (max. sink current of 24 mA) or as input; controlling test items and devices without standard interface; also applying and reading of bit patterns,

7 relays for supply voltages of up to 50 V and 5 A as well as for any DC and AF signals; they can be selected individually or in groups,

1 A/D converter (0 to +2.55 V), for DC and AF measurements with 8 bit resolution (0.4%), referenced to ground potential; apart from DC measurements, AF signals can be analyzed with the use of machine language,

1 D/A converter (0 to +2.55 V), DC voltages and functions can be generated with 8 bit resolution corresponding to 0.4%.

Service Kit PUC-Z7 Accessory which contains circuit diagrams, test boards and disk with test programs for rapid troubleshooting.

Rear connectors

IEC-bus connector _
 Printer connector _
 Connector for 2nd keyboard (e.g. footswitch) _



Printer connection A printer can be connected via a Centronics-compatible interface on the rear of the PUC leaving the IEC-bus connector free for other equipment. Without any extra work involved for the user, the printer (e.g. PUD 2 from R&S) produces printouts of test reports, measurement results and program listings. Commands for the control of the printer are part of the operating system of the PUC. A complete ASCII upper- and lower-case character set for printing texts and figures is available together with the choice of four character styles. With the individual pin-control, the

Specifications

opecifications	
CPU	6502
CPU Clock	• 1 MHz
Available RAM space Number range	31743 bytes
Programming languages	extensions, machine language
VDU Display Cursor Character set	9", non-reflecting, non-flicker
Display	25 lines, 40 characters/line
Cursor	4 keys plus indirect addressing
Cildracter set	ASCIL and utappin symbols
	(normal or inverse display)
Keyboards	
noybourdo	2.5 m long connecting cable
Standard keyboard	75 keys, full ASCII
	character set with double
	functions, separate numerical pad
the second s	and special keys for editor as well as RETURN and REVERS
User keyboard	20 assigned keys and numerical nad
	with DELETE and RETURN two keys (connectable with one of the
Footswitch	two keys (connectable with one of the
	keyboards or on its own)
Floppy-disk drives	E1/." otendord
Mini-floppy drive	2nd drive as ontion
Writing density/type	single density/double-sided
Storage capacity	156 kbytes
Disk organization (soft-sectored)	305 areas/side, 256 bytes/area
IEC-bus interface	IEC 625-1 and IEEE 488 SH1, AH1, T1, L1, PP1, DC1, DT1, C1 to 4, C10
Functions	SH1, AH1, T1, L1, PP1, DC1, DT1,
	shielded 24-pole Amphenol female
Printer connection	Centronics-compatible interface with data strobe and busy signal
Permissible output current	ο I _L <16 mA I _H > -100 μA
Permissible output current Required input level	$V_L < 0.4 V$ $V_H > 2.4 V$
Specifications of options	
Floppy-disk Drive PUC-B2	see above
Floppy-disk Drive PUC-B2 RS 232 C Interface (V.24)	bidirectional with additional
Floppy-disk Drive PUC-B2 RS 232 C Interface (V.24) PUC-B5	bidirectional with additional
Floppy-disk Drive PUC-B2 RS 232 C Interface (V.24) PUC-B5	bidirectional with additional
Floppy-disk Drive PUC-B2 RS 232 C Interface (V.24) PUC-B5	bidirectional with additional
Floppy-disk Drive PUC-B2 RS 232 C Interface (V.24) PUC-B5 Data transfer Transfer rate Connector	bidirectional with additional 20-mA current-loop interface asynchronous 50 to 9600 bauds 25-pole Cannon female
Floppy-disk Drive PUC-B2 RS 232 C Interface (V.24) PUC-B5 Data transfer Transfer rate Connector I/O Interface PUC-B7	 bidirectional with additional 20-mA current-loop interface asynchronous 50 to 9600 bauds 25-pole Cannon female four times 8 TTL inputs-outputs, 7 relays
Floppy-disk Drive PUC-B2 RS 232 C Interface (V.24) PUC-B5 Data transfer Transfer rate Connector I/O Interface PUC-B7	 bidirectional with additional 20-mA current-loop interface asynchronous 50 to 9600 bauds 25-pole Cannon female four times 8 TTL inputs-outputs, 7 relays
Floppy-disk Drive PUC-B2 RS 232 C Interface (V.24) PUC-B5 Data transfer Transfer rate Connector I/O Interface PUC-B7	 bidirectional with additional 20-mA current-loop interface asynchronous 50 to 9600 bauds 25-pole Cannon female four times 8 TTL inputs-outputs, 7 relays
Floppy-disk Drive PUC-B2 RS 232 C Interface (V.24) PUC-B5 Data transfer Transfer rate Connector I/O Interface PUC-B7	 bidirectional with additional 20-mA current-loop interface asynchronous 50 to 9600 bauds 25-pole Cannon female four times 8 TTL inputs-outputs, 7 relays
Floppy-disk Drive PUC-B2 RS 232 C Interface (V.24) PUC-B5 Data transfer	bidirectional with additional 20-mA current-loop interface asynchronous 50 to 9600 bauds 25-pole Cannon female four times 8 TTL inputs-outputs, 7 relays $\mu_{P} = -15 \text{ mA}$ $l_{L} < 24 \text{ mA}$ $V_{H} > 2 \text{ V}$ $V_{L} < 0.8 \text{ V}$ Imax < < 50 V A/D D/A
Floppy-disk Drive PUC-B2 RS 232 C Interface (V.24) PUC-B5 Data transfer	bidirectional with additional 20-mA current-loop interface asynchronous 50 to 9600 bauds 25-pole Cannon female four times 8 TTL inputs-outputs, 7 relays $\mu_{P} = -15 \text{ mA}$ $l_{L} < 24 \text{ mA}$ $V_{H} > 2 \text{ V}$ $V_{L} < 0.8 \text{ V}$ Imax < < 50 V A/D D/A
Floppy-disk Drive PUC-B2 RS 232 C Interface (V.24) PUC-B5 Data transfer	bidirectional with additional 20-mA current-loop interface asynchronous 50 to 9600 bauds 25-pole Cannon female four times 8 TTL inputs-outputs, 7 relays $\mu_{P} = -15 \text{ mA}$ $l_{L} < 24 \text{ mA}$ $V_{H} > 2 \text{ V}$ $V_{L} < 0.8 \text{ V}$ Imax < < 50 V A/D D/A
Floppy-disk Drive PUC-B2 RS 232 C Interface (V.24) PUC-B5 Data transfer	bidirectional with additional 20-mA current-loop interface asynchronous 50 to 9600 bauds 25-pole Cannon female four times 8 TTL inputs-outputs, 7 relays $\mu_{P} = -15 \text{ mA}$ $l_{L} < 24 \text{ mA}$ $V_{H} > 2 \text{ V}$ $V_{L} < 0.8 \text{ V}$ Imax < < 50 V A/D D/A
Floppy-disk Drive PUC-B2 RS 232 C Interface (V.24) PUC-B5 Data transfer	bidirectional with additional 20-mA current-loop interface asynchronous 50 to 9600 bauds 25-pole Cannon female four times 8 TTL inputs-outputs, 7 relays $\mu_{P} = -15 \text{ mA}$ $l_{L} < 24 \text{ mA}$ $V_{H} > 2 \text{ V}$ $V_{L} < 0.8 \text{ V}$ Imax < < 50 V A/D D/A
Floppy-disk Drive PUC-B2 RS 232 C Interface (V.24) PUC-B5 Data transfer Transfer rate Connector I/O Interface PUC-B7 Permissible output current Required input level Relay rating Converters Number of bits Input/output voltage range Resolution Limit values for V _{in} Offset Non-linearity Conversion time	bidirectional with additional 20-mA current-loop interface asynchronous 50 to 9600 bauds 25-pole Cannon female four times 8 TTL inputs-outputs, 7 relays $J_{H} \geq -15$ mA $I_{L} < 24$ mA $V_{H} \geq 2$ V $V_{L} < 0.8$ V $J_{max} < 0.5$ A V _{max} < 50 V A/D D/A 8 8 V _{In} /V _{out} 0 to +2.55 V 10 mV/digit 10 mV/digit -0.5 and 3.5 V 1 digit 1 digit 2 digits 2 digits
Floppy-disk Drive PUC-B2 RS 232 C Interface (V.24) PUC-B5 Data transfer Transfer rate Connector I/O Interface PUC-B7 Permissible output current Required input level Relay rating Converters Number of bits Input/output voltage range Resolution Limit values for V _{in} Offset Non-linearity Conversion time	bidirectional with additional 20-mA current-loop interface asynchronous 50 to 9600 bauds 25-pole Cannon female four times 8 TTL inputs-outputs, 7 relays $J_{H} \geq -15$ mA $I_{L} < 24$ mA $V_{H} \geq 2$ V $V_{L} < 0.8$ V $J_{max} < 0.5$ A V _{max} < 50 V A/D D/A 8 8 V _{In} /V _{out} 0 to +2.55 V 10 mV/digit 10 mV/digit -0.5 and 3.5 V 1 digit 1 digit 2 digits 2 digits
Floppy-disk Drive PUC-B2 RS 232 C Interface (V.24) PUC-B5 Data transfer	bidirectional with additional 20-mA current-loop interface asynchronous 50 to 9600 bauds 25-pole Cannon female four times 8 TTL inputs-outputs, 7 relays $J_{H} \geq -15$ mA $I_{L} < 24$ mA $V_{H} \geq 2$ V $V_{L} < 0.8$ V $J_{max} < 0.5$ A V _{max} < 50 V A/D D/A 8 8 V _{In} /V _{out} 0 to +2.55 V 10 mV/digit 10 mV/digit -0.5 and 3.5 V 1 digit 1 digit 2 digits 2 digits
Floppy-disk Drive PUC-B2 RS 232 C Interface (V.24) PUC-B5 Data transfer Transfer rate Connector I/O Interface PUC-B7 Permissible output current Required input level Relay rating Converters Number of bits Input/output voltage range Resolution Offset Non-linearity Conversion time Input/load impedance Connector High-resolution Graphics PUC-B6	bidirectional with additional 20-mA current-loop interface asynchronous 50 to 9600 bauds 25-pole Cannon female four times 8 TTL inputs-outputs, 7 relays $l_{\rm H} > -15$ mA $l_{\rm L} < 24$ mA $V_{\rm H} > 2$ V VL <0.8 V $l_{\rm max} < 0.5$ A Vmax <50 V A/D D/A 8 8 Vm/Vout 0 to +2.55 V 10 mV/digit 10 mV/digit -0.5 and 3.5 V - 1 digit 2 digits 2 digits max. 15 μ s - 100 kQ 100 Q min 50-pole Amphenol female
Floppy-disk Drive PUC-B2 RS 232 C Interface (V.24) PUC-B5 Data transfer Transfer rate Connector I/O Interface PUC-B7 Permissible output current Relay rating Converters Number of bits Input/output voltage range Resolution Limit values for Vin Offset Non-linearity Conversion time Input/load impedance Connector	bidirectional with additional 20-mA current-loop interface asynchronous 50 to 9600 bauds 25-pole Cannon female four times 8 TTL inputs-outputs, 7 relays $ \mu > -15 \text{ mA}$ $ _L < 24 \text{ mA}$ $\forall \mu > 2 \text{ V}$ $\forall V_L < 0.8 \text{ V}$ $ _{\text{max}} < 0.5 \text{ A}$ $\forall \text{max} < 50 \text{ V}$ A/D $D/A8 8 8\forall \text{m}/V_{\text{out}} \text{ 0 to } +2.55 \text{ V}10 mV/digit 1 digit-0.5 and 3.5 V$ — 1 digit 2 digits max. 15 μ s — 100 k Ω 100 Ω min 50-pole Amphenol female
Floppy-disk Drive PUC-B2 RS 232 C Interface (V.24) PUC-B5 Data transfer Transfer rate Connector I/O Interface PUC-B7 Permissible output current Required input level Relay rating Converters Number of bits Input/output voltage range Resolution Limit values for V _{In} Offset Non-linearity Conversion time Input/load impedance Connector	bidirectional with additional 20-mA current-loop interface asynchronous 50 to 9600 bauds 25-pole Cannon female four times 8 TTL inputs-outputs, 7 relays μ > -15 mA L <24 mA V _H > 2 V VL <0.8 V Imax. <0.5 A Vmax. <50 V A/D D/A 8 8 Vm/Vout 0 to +2.55 V 10 mV/digit 10 mV/digit -0.5 and 3.5 V — 1 digit 2 digits max. 15 μs — 100 kΩ 100 Ω min 50-pole Amphenol female 64.000 points 320 points

PUD 2 (see page 20) reproduces all graphic symbols including the graphics display of the highresolution graphics option.

Program lines made up of more than 40 characters and therefore displayed in two lines on the screen are automatically listed in one line by the printer.

Printer commands:

SHIFT P	List on printer
CMD	Transfer output display on printer
SHIFT H	Hardcopy (text and graphic symbols)

Real-time Clock PUC-B10

output of time and date;
branching at given time
100 ms
<1 × 10 ⁻⁵
700 hours

General data

Rated temperature range	0 to +45°C
Storage temperature range	-40 to +70°C ¹)
Relative humidity	
Power supply	
	47 to 63 Hz; safety class I
Power rating of basic unit	
with options	
RF leakage	
Unwanted voltage	satisfies VDE 0875 (RFI-level K) and
•	requirements of MIL-STD 461B
	regarding noise on lines
RF interference	satisfies VDE 0871.
	Meets specifications according to
	MIL-STD 461B, over the total fre-
	quency range with VDU switched off,
	from 1 MHz with VDU on
Mechanical stress capacity	shock and vibration tested to parts 7
	and 8 of DIN 40046, corresponding to
	IEC Publ. 68-2-27 and 68-2-6)
Dimensions, weight	
Basic unit	470 mm×198 mm×491 mm, 19 kg

Ordering information

-
Ordering designation Process Controller PUC
PUC without keyboard
Standard Keyboard PUC-Z1 345.2011.04
User Keyboard PUC-Z2 345.2111.06
Footswitch
Accessories supplied 1 mother disk with programs to format
and copy floppies, power cable
Options Options
2nd Floppy-disk
Drive PUC-B2 345.2711.02
RS 232 C Interface PUC-B5 343.6103.02
High-resolution
- ign recordion

Drive	 PUC-B2	345.2711.02	
RS 232 C Interface	 PUC-B5	343.6103.02	
High-resolution			
Graphics			
I/O Interface	 PUC-B7	345.2811.02	
Real-time Clock		345.3418.02	
19" Rack Adapter	 PUC-Z9	345 2611.02	
Service Kit	PUC.77	245 2511 02	

Recommended extras

10 formatted		
floppy disks	PPC-Z2	343.7900.02
IEC-bus cable 0.5 m .	PCK	292.2013.05
1 m	PCK	292.2013.10
2 m	PCK	292.2013.20
	PCK	
Universal Printer		
Print paper for PUD2		079.7107.00

1) +5 to +55°C for Floppy-disk PPC-Z2

IEC BUS DEVICES 1



Universal Printer PUD 2

- Complete ASCII character set (upper and lower case) plus character set for graphic symbols
- Diagrams using single-dot graphics
- 8-bit parallel interface (Centronics compatible)
- IEC-bus compatible with option



The Universal Printer PUD 2 is used to output tables, text, programs, test results and diagrams. It operates on the matrix method and allows bidirectional output at high speed.

PUD 2 is a low-priced, cost-effective unit for small and medium-size computing systems, offering printing capabilities for text and graphics equalling those of much more expensive hardcopy units.

Control The PUD 2 can be controlled from different units or systems; it is optimally adapted to the Process Controller PUC. Via its Centronics-compatible 8-bit parallel interface provided in the standard model it easily accepts complex BASIC-like commands from the PUC.

The 2-kbyte character buffer permits outputs of text and graphics using a minimum of computer time. While the PUD 2 is printing the computer can continue to process. Printing is bidirectional and route-optimized.

Three character sets (examples on right) permit the printing of normal texts as well as of various types of graphics.

1. ASCII upper- and lower-case character set for printing texts and figures; four character styles including condensed and elongated characters can be selected. A separate line of dots can be activated for underline.

2. Character set for graphic symbols. It enables the printout of graphics identical to the screen display, for example, of Process Controller PUC.

3. Single-dot control permits curve printout with a resolution of 581 dots across the paper width - the printing capacity in the longitudinal direction is not limited.

The paper feed can be programmed for line and half line, forward and reverse and for single dot steps.

Types of paper The tractor drive with friction rollers permits the use of perforated fan-fold paper as well as roll paper and single sheets. The drive is continously adjustable over a wide range, facilitating paper installation and use of different paper widths.

Paper quality Paper of any quality may be used.

Character styles

Sample program for the R&S Process Controller

290 OPEN 1, 230 300 PRINT #1, CHR\$(27); CHR\$(19) 31Ø PRINT# 1, "ABCDEFGHIJKLMNOPQRSTUVWXYZ" 320 CLOSE 1

10 CPI

ABCDEFGHIJKLMNOPQRSTUVWXYZ abcdefghijklmnopqrstuvwxyz 12345678900!#\$%'&\()[]^<>,; -1, -1, |₩} =/ \+1, 00-_| | /┐[7, ** ♠♥~_| | └└└→+→-X|/∖ ** %-*=_1] | | └┬┤ /┐

IEC BUS DEVICES 1

Text-and-figure printout (scale ~1:2)

Universal Frinter FUD
Universal Printer PUD
Universal Printer PUD from R&S
Universal Printer
P _R ^{≈P} v ^{*(S} 11) ²

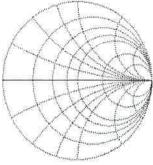
Graphics printout (scale <1:2)

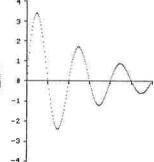


graphics

normal printing underline narrow printing elongated printing half linefeed forward/reverse

Diagram printout (scale 1:2)





Specifications

Principle	matrix print
Printing rate	80 characters/s
Print structure	0×0 for observatore
Characterist	n×9 or n×8 for graphics
Character set	200 upper- and lower-case charac-
	ters and graphic block
Character styles	6 printing widths,
	40 to 132 characters/line,
	240 to 792 dots/line
Character input buffer	2 kbytes
Paper movement	a) tractor drive for endless
 A state of the sta	form with edge perforation
	b) friction drive for single
	sheets and rolls
Paper widths	
· upor mound	
Noise level	b) 100 to 216 mm
Noise level	<60 dB(A)
HFI	class B of VDE 871 (corresponding to
	N-12) and FCC 79-555 (U.S.A.)
Safety	VDE 806 = IEC 380 for office
	machines and BDE 805 = IEC 435
	for DP equipment in Europe; UL 114
	and 11 478 (11 S A)
Interfaces	8-bit parallel (Centronics compatible),
	36-way Amphenol female connector
	oo way Amphonor Ichiale connector
Generell data	
Rated temperature range	+5 to LAE°C
Storage temperature range	10 10 140 U
AC events	-25 10 +/0°C
AC supply	11//220 V +10/-15%, 50/60 Hz,
	20 VA in standby condition,
	55 VA during operation
Dimensions, weight	410 mm×310 mm×140 mm, 7.5 kg
Ordering information	
-	
Order designation	Universal Impact Printer PUD2
	359.5018.02
	Universal Ink-jet Printer PUD3
	359.5501.02
Onthese	
Option	
IEC-bus Interface PUD 2-B4	
(24-way Amphenol female connector)

Code Converter PCW

- Permits IEC-bus programming of parallel-controlled equipment
- Usable for all instruments programmed with TTL levels
- Excellent noise immunity thanks to output buffers
- High transmission speed, bipolar logic

(IEC 625 Eus)



The **Code Converter PCW** is necessary if instruments designed for parallel remote control are to be programmed via the IEC bus. The PCW receives serial ASCII signals and delivers TTL levels at 44 parallel data outputs.

The PCW is addressable; 26 different addresses can be selected. Instructions are allocated to the data outputs by means of an exchangeable code converter board. This permits the PCW to be adapted to individual instruments. Besides ready-wired, code converter boards for Rohde & Schwarz standard instruments, a universal board is available which can be coded by the user himself for any particular instrument.

Specifications	
Input Connector Transfer time per character	24-way, Amphenol
Output (50-pole) Power supply Dimensions, weight	115/125/220/235 V ±10%, 47 to 440 Hz (10 VA)
Order designations 19" cabinet model 19" rackmount . Code Converter Boards for DPVP SMLU Test-item control Not wired	244.8015.92 244.8015.91 245.2510.02 245.2610.02 245.2762.02

21

IEC BUS DEVICES 1

automated testing



- Electropneumatic control unit for programmed measurement of devices and subassemblies with manually operated switches, keys, potentiometers, etc.
- Drives actuating cylinders for linear motion and stepping mechanisms for rotation
- IEC-bus compatible



In fully automatic test systems the Pneumatic Interface PIF permits automatic control even of those measurements which require mechanical setting, such as range switchover, on the test item.

During final inspection of car radios for instance, programmable adapters press the band and mode buttons for mono/ stereo, cassette start and eject. Rationalization can be taken another step forward if the RF, AF and DC connections between the test item and the measuring equipment can also be made fullly automatically.

The Pneumatic Interface PIF can be programmed to perform all these functions via compressed-air cylinders.

Description

Connection. The PIF is connected via a standard quickaction coupling for one-handed operation to the compressedair supply generally available in industrial plants. The pressure can be up to 8 bar.

Control. The air is taken to the actuating cylinders via electrically controlled solenoid valves (compressed-air relays). 16 valves of this type are provided; they are controlled with the aid of the keys on the PIF front panel or from a calculator via the built-in IEC-bus interface.

The actuating cylinders - connected to the PIF via flexible compressed-air hoses - are fixed to the test item, see photo below.

For linear movements three standard cylinder types are available featuring different piston diameters (depending on the force and pressure required) and lengths of travel. The working pressure can be set on the internal reducer from 0 to 7 bar.



For rotary movements a stepping mechanism is available; its hollow shaft with an internal diameter of 8 mm accepts axles up to this size. One step covers 30° (please enquire for other values between 6 and 36°).

Specifications	
Mechanical settings on	
test item	strokes (push and pull) and rotary movements via
	compressed-air cylinders and
	stepping mechanism, controlled via compressed-air relays
Compressed-air relays	16, response time 10 ms,
Working pressure, max. Pressure range	life 30×10^6 switching actions 8 bar, reducer and filter built in
Pressure range Normal rated flow volume	0 to 7 bar 50 l/min per actuated relay.
	total: 200 I/min max.
Connector for actuating cylinders Compressed-air supply	
	(one-handed operation) NW6 on rear
Operation Manual	via keyboard on front panel (16 keys)
Remote-controlled	via IEC bus (IEC 625-1/IEEE 488), 24-way Amphenol connector
Fittings for various motions (to be For linear movements	types of compressed-air cylinder:
	Single single single double (push) (push) (push/pull) 6 mm 16 mm 6 mm 16 mm 16 mm 12 mm 120 N 12 N 120 N 120 N 90 N
Line diameter	6 mm 16 mm 16 mm
Travel length Pushing force at 6 bar	25 mm 25 mm 40 mm 12 N 120 N 120 N
Pulling force at 6 bar	— — 90 N
For rotary movements	etopping mochanism
Angle	30° (6 to 36° please enquire)
	30° (6 to 36°, please enquire) sense: left/right
Angle	30° (6 to 36°, please enquire) sense: left/right 70 N cm
Torque	30° (6 to 36°, please enquire) sense: left/right 70 N cm 8 mm
Torque . Diameter of hollow shaft . General data Rated temperature range .	30° (6 to 36°, please enquire) sense: left/right 70 N cm 8 mm +5 to +45°C
Torque	30° (6 to 36°, please enquire) sense: left/right 70 N cm 8 mm +5 to +45°C -20 to +75°C 115/125/220/235 V ±10%,
Torque	30° (6 to 36°, please enquire) sense: left/right 70 N cm 8 mm +5 to +45°C -20 to +75°C
Torque Diameter of hollow shaft Diameter of hollow shaft General data Rated temperature range Storage temperature range AC supply Dimensions, weight	30° (6 to 36°, please enquire) sense: left/right 70 N cm 8 mm +5 to +45°C -20 to +75°C 115/125/220/235 V ±10%,
Torque Diameter of hollow shaft General data Rated temperature range Storage temperature range AC supply Dimensions, weight Ordering information	30° (6 to 36°, please enquire) sense: left/right 70 N cm 8 mm +5 to +45°C -20 to +75°C 115/125/220/235 V ±10%, 47 to 420 Hz (80 VA) 492 mm×161 mm×392 mm, 11 kg
Torque. Diameter of hollow shaft General data Rated temperature range Storage temperature range AC supply Dimensions, weight Ordering information Order designation	30° (6 to 36°, please enquire) sense: left/right 70 N cm 8 mm +5 to +45°C -20 to +75°C 115/125/220/235 V ±10%, 47 to 420 Hz (80 VA) 492 mm×161 mm×392 mm, 11 kg ▶ Pneumatic Interface PIF 264.9017.02
Torque. Diameter of hollow shaft General data Rated temperature range Storage temperature range AC supply Dimensions, weight Ordering information Order designation	30° (6 to 36°, please enquire) sense: left/right 70 N cm 8 mm +5 to +45°C -20 to +75°C 115/125/220/235 V ±10%, 47 to 420 Hz (80 VA) 492 mm×161 mm×392 mm, 11 kg ► Pneumatic Interface PIF 264.9017.02 16-way Compressed-air Connector
Torque. Diameter of hollow shaft General data Rated temperature range Storage temperature range AC supply Dimensions, weight Ordering information Order designation	30° (6 to 36°, please enquire) sense: left/right 70 N cm 8 mm +5 to +45°C -20 to +75°C 115/125/220/235 V ±10%, 47 to 420 Hz (80 VA) 492 mm×161 mm×392 mm, 11 kg ▶ Pneumatic Interface PIF 264.9017.02 16-way Compressed-air Connector PIF-Z5; 20 m compressed-air hose, 3 mm dia., plug-in socket for quick-
Torque. Diameter of hollow shaft General data Rated temperature range Storage temperature range AC supply Dimensions, weight Ordering information Order designation	30° (6 to 36°, please enquire) sense: left/right 70 N cm 8 mm +5 to +45°C -20 to +75°C 115/125/220/235 V ±10%, 47 to 420 Hz (80 VA) 492 mm×161 mm×392 mm, 11 kg ▶ Pneumatic Interface PIF 264.9017.02 16-way Compressed-air Connector PIF-Z5; 20 m compressed-air hose,
Torque Diameter of hollow shaft General data Rated temperature range Storage temperature range AC supply Dimensions, weight Ordering information Order designation Accessories supplied Additional fittings required for operation	30° (6 to 36°, please enquire) sense: left/right 70 N cm 8 mm +5 to +45° C -20 to +75° C 115/125/220/235 V ±10%, 47 to 420 Hz (80 VA) 492 mm×161 mm×392 mm, 11 kg ▶ Pneumatic Interface PIF 264.9017.02 16-way Compressed-air Connector PIF-25; 20 m compressed-air hose, 3 mm dia., plug-in socket for quick- action coupling (one-handed opera- tion) NW 6 for ¾" hose; power cord tion (optional):
Torque Diameter of hollow shaft Diameter of hollow shaft General data Rated temperature range Storage temperature range Storage temperature range Storage temperature range AC supply Dimensions, weight Dimensions, weight Ordering information Order designation Accessories supplied	30° (6 to 36°, please enquire) sense: left/right 70 N cm 8 mm +5 to +45°C -20 to +75°C 115/125/220/235 V ±10%, 47 to 420 Hz (80 VA) 492 mm×161 mm×392 mm, 11 kg ▶ Pneumatic Interface PIF 264.9017.02 16-way Compressed-air Connector PIF-Z5; 20 m compressed-air Connector PIF-Z5; 20 m compressed-air nose, 3 mm dia., plug-in socket for quick- action coupling (one-handed opera- tion) NW6 for %" hose; power cord tion (optional): ▶ Pneumatic Cylinder
Torque Diameter of hollow shaft General data Rated temperature range Storage temperature range AC supply Dimensions, weight Ordering information Order designation Accessories supplied Additional fittings required for operation	30° (6 to 36°, please enquire) sense: left/right 70 N cm 8 mm +5 to +45°C -20 to +75°C 115/125/220/235 V ±10%, 47 to 420 Hz (80 VA) 492 mm×161 mm×392 mm, 11 kg ▶ Pneumatic Interface PIF 264.9017.02 16-way Compressed-air Connector PIF-Z5; 20 m compressed-air hose, 3 mm dia., plug-in socket for quick- action coupling (one-handed opera- tion) NW 6 for %" hose; power cord tion (optional): ▶ Pneumatic Cylinder PIF-Z1 265.0813.02 PIF-Z1 265.0813.02 PIF-Z2 265.086.02
Torque Diameter of hollow shaft Diameter of hollow shaft General data Rated temperature range Storage temperature range Storage temperature range Ac supply Dimensions, weight Dimensions, weight Ordering information Order designation Accessories supplied Accessories supplied Additional fittings required for operation Compressed-air cylinder	30° (6 to 36°, please enquire) sense: left/right 70 N cm 8 mm +5 to +45°C -20 to +75°C 115/125/220/235 V ±10%, 47 to 420 Hz (80 VA) 492 mm×161 mm×392 mm, 11 kg ▶ Pneumatic Interface PIF 264.9017.02 16-way Compressed-air Connector PIF-Z5; 20 m compressed-air hose, 3 mm dia, plug-in socket for quick- action coupling (one-handed opera- tion) NW6 for %" hose; power cord tion (optional): ▶ Pneumatic Cylinder PIF-Z1 265.0813.02 PIF-Z3 265.0859.02 ▶ Pneumatic Stepping Mechanism
Torque Diameter of hollow shaft Diameter of hollow shaft General data Rated temperature range Storage temperature range Storage temperature range Ac supply Dimensions, weight Dimensions, weight Ordering information Order designation Accessories supplied Accessories supplied Additional fittings required for operation Compressed-air cylinder	30° (6 to 36°, please enquire) sense: left/right 70 N cm 8 mm +5 to +45°C -20 to +75°C 115/125/220/235 V ±10%, 47 to 420 Hz (80 VA) 492 mm×161 mm×392 mm, 11 kg ▶ Pneumatic Interface PIF 264.9017.02 16-way Compressed-air Connector PIF-Z5; 20 m compressed-air hose, 3 mm dia., plug-in socket for quick- action coupling (one-handed opera- tion) NW6 for %" hose; power cord tion (optional): ▶ Pneumatic Cylinder PIF-Z1 265.0813.02 PIF-Z2 265.0836.02 PIF-Z3 265.0859.02

IEC BUS DEVICES 1

PSN

AF Relay Matrix PSN for IEC-bus programming

- DC and AF
- Six quick-action reed relays and two power relays
- Af and control applications, high loadability
- Easy to operate, LED indication

(IEC 625 Bus)

The **AF Relay Matrix PSN** contains eight independent, isolated relays for manual and automatic switchover of control of supply voltages and AF signals for instance in IEC-buscontrolled AF test assemblies, for checkpoint selection and in control engineering. Thus either eight separate switches or max. two 1-out-of-4 switches with the remaining relays as individual switches are available.

Six components are quick-action reed relays featuring highgrade characteristics, while two are power relays which handle currents up to 5 A. All relays are brought out via telephone jacks on the rear panel of the PSN.

Pushbuttons are provided for manual operation with LEDs indicating the switching state. Remote control is performed via the IEC-bus connector. The combined mode permits remote-controlled and manual operation of the relays during program generation and checking.

🚯 eltan - naren	PSR 293 9210 @			
123656	43405 5	TROOM DE		
	D9 14	10 M	april 1	
	7			

Specifications

	Relays 1 to 6	Relays 7 and 8
Connectors	telephone jacks of	rear panel
Contact/insulation resistance		
Max. power handling capacity	30 VA; 20 W	1 kVA; 100 W
	(max. 1 A, 110 V)	(max. 5 A, 250 V)
Switching	1 ms	5 ms
General data		
Life time		itions;
Rated temperature range	+10 to +45°C	
AC supply		
	47 to 420 Hz (ma	x. 20 VA)
Dimensions, weight	211 mm×112 mm	n×346 mm, 4.0 kg
Order de la contra		
Order designation		X PSN
	290.9210.02	
Recommended extras		
IEC-bus Cable PCK	see Page 19	
19"-Adapter ZZA-2		
(for incorporation of max, two PSNs		ahinets)

RF Relay Matrix PSU for IEC-bus programming • DC to 6 GHz

- Six independent 50-Ω coaxial relays, low reflection
- RF and pulse applications
- Easy to operate, LED indication

(IEC 625 Bus)

Six independent, isolated coaxial relays ensure the high flexibility of the **RF Relay Matrix PSU:** six separate coaxial switches or one 1-out-of-4 switch plus three separate switches or two separate 1-out-of-4 switches are possible. The main application is manual and automatic high-precision routing of RF signals in IEC-bus test systems (switching of generators, counters, indicators, attenuators, etc.)

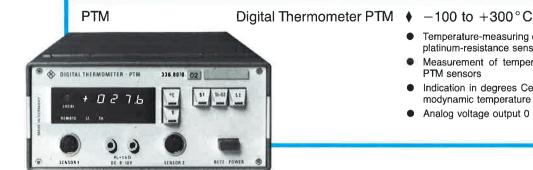
Relays 1 to 3 with 50- Ω N sockets on the front panel of the matrix feature excellent RF characteristics for frequencies up to 6 GHz. Relays 4 to 6 with 50- Ω BNC sockets on the rear panel are suitable for frequencies up to 500 MHz. Pushbuttons are provided for manual operation, with LEDs indicating the switching state Remote control is performed via the IEC-bus connector; the combined mode is the same as for the PSN.



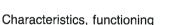
Specifications

	Relays 1 to 3	Relays 4 to 6
Connectors		50-Ω BNC female
	on front panel	on real panel
Frequency range	DC to 6 GHz	DC to 500 MHz
VSWR	<1.22 bis 1 GHz	<1.1 up to 100 MHz
Transmission loss	0.3 dB up to 1 GHz	0.2 dB up to 100 MHz
Crosstalk attenuation		
		100 MHz
Max. power handling capacity .	100 W at 0.1 GHz	1 A at 28 V
	50 W at 1 GHz	
Switching time	<25 ms	<7.5 ms
General data		
Life time	>1.000.000 operation	ns:
Rated temperature range		
Power supply		±10%.
	47 to 420 Hz (max. 2	
Dimensions, weight		
Order designation	► BE Belay Matrix P	SU
	290.8014.02	
Recommended extras		
IEC-bus Cable PCK	see page 19	
19" Adapter ZZA-2		
19 Auapter ZZA-Z	070.0174.00	

THERMOMETERS 1



- Temperature-measuring device of highest precision with platinum-resistance sensors in four-wire circuit
- Measurement of temperature difference between two
- Indication in degrees Celsius (°C) or indication of thermodynamic temperature (K)
- Analog voltage output 0 to 10 V; IEC-bus compatible



The Digital Thermometer PTM ist suitable for highest-accuracy temperature measurement from -100 to +300°C or 173.2 to 573.2 K in different media; it has an IEC-bus connector and can thus be used in automatic test systems.

Temperature is measured via exchangeable test sensors (depending on the measurement task), two of which can be connected simultaneously to the two five-pole sockets.

The following three sensor types are available as standard:

- 1. contact sensors suitable for manual measurements,
- 2. adhesive sensors suitable for sticking to critical temperature points (in the form of wafers 6 mm×18 mm×1.5 mm),
- 3. Immersion sensors for gases and liquids or for incorporation into solids (dimensions: 4 mm \emptyset ×50 mm).

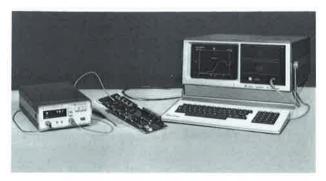
Accuracy. Using these platinum sensors, the maximum error is only 0.2°C over the entire temperature measurement range. The PTM can be used with one or with two sensing probes (for instance for differential temperature measurement). The resolution is 0.1 °C or 0.1 K over the entire range.

Indication. The PTM displays the temperature (switched when using two sensors) in °C or K. The proportional DC voltage is available at the analog voltage output.

Uses

The PTM finds wide use in the electronic industry and in other fields. Thus the effect of temperature on components or subassemblies when varying the ambient temperature (for instance with the Temperature Controller PTC, see next

Automatic measurement of temperature effect on subassembly



page) can be checked automatically via the IEC bus. Troubleshooting in case of temperature effects can also be automated.

IEC 625 Bus



Specifications			
Temperature measurement range . Indication	(173.2 to 57	(3.2 K)	
	(owitchable	when uning two persons)	
Resolution	0.1°C or 0.	1 K	
Basic error Additional sensor error (PT 100)	≦0.1°C witl ≦0.3°C wit	h adjustment hout adjustment at 0°C	
	(tolerance in with DIN 43	accordance	
Nonlinearity	<0.1°C		
Effect of ambient temperature	<0.1°C at ((23 ±5) °C	
	temperature	range	
Test current	3.3 mA ±59	%	
Rate	20 to 50 me	asurements/s	
	in four-wire circuit		
Input for sensors	in four-wire circuit two 5-way female connectors		
Analog voltage output		49 mV/0 1°C	
Programming			
	(IEC 625-1/IEEE 488), 24-way Amphenol		
Interface functions	T6, TE6	talker functions with sec. address, serial polling and auto adressing when receiving listener address	
	L4	listener function	
	RL1 DC1	remote/local device clear	
General data		detteo olota	
Rated temperature range			
Storage temperature range AC supply	115/125/22	20/235 V ±10%.	
Dimensione weight	47 to 440 H	iz (30 VA)	
	mensions, weight		
Accessories supplied		1.02	
Recommended extras	ponor colu		
Contact Sensor PTC-Z1	336.7914.0	2	
Adhesive Sensor PTC-Z2 . Immension Sensor PTC-Z3	336.7937.0 336.7950.0	2	

TEMPERATURE CONTROLLERS 1

Temperature Controller PTC

- ◆ -100 to +300°C
- Temperature controller driven via IEC bus; rated temperature entered in °C or K via keyboard
- Precision measurement using platinum-resistance thermometer in four-wire circuit
- Temperature indication in °C or K; status indication
- 10 A/220 V contactor and control relay incorporated

(IEC 625 Bus)

Characteristics, functions

The **Temperature Controller PTC** is used as a precision measuring and setting device for temperature-control circuits (also for measurements alone) in the range from -100 to +300 °C or 173.2 to 573.2 K. Thanks to its **IEC-bus connector**, it is system-compatible and suitable for use in automatic test and control systems.

Sensors. Like the PTM, the PTC measures temperature via a platinum-resistance sensor in a four-wire circuit. The types of sensor available are the same as for the Digital Thermometer PTM (see previous page). The connections for temperature measurement and the procedure itself are also the same.

Temperature control. The temperature picked up by the sensor is compared with a set rated value. The control signal derived is used for switching a load relay (e. g. for controlling an oven) and a control relay provided for simultaneous connection of heating and cooling systems. Thus a programmable temperature control system can be set up with only a few system components, such as a calculator, an oven and the PTC.

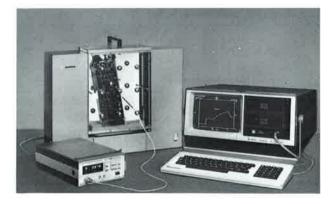
Accuracy. The platinum sensors used with the PTC ensure high accuracy. For temperature measurement and ratedvalue setting, the resolution is 0.1° C over the entire range (measurement error < 0.2° C or K). Entry is possible in °C or in K with four stepping buttons.

Recording. A voltage porportional to the indication (0 to 10 V) is continuously available at the analog output.

Uses

The programmable Temperature Controller PTC finds a wide range of application, in particular in the development, produc-

Automatic temperature test on subassemblies using PTC



tion and quality control of electronic equipment but also in other fields of industry.

The programmability of the PTC permits not only accurate point-by-point determination of the temperature response but also automatic sweeping of complete temperature cycles along with protocolling via the calculator and printer.

Specifications	
Temperature measurement range	-99.9 to +299.9 °C
Indication	
Resolution	when using two sensors)
Measurement error	
Additional sensor error (PT 100)	0.1°C over entire range
Additional sensor entit (FT 100)	≦0.1°C with adjustment ≦0.3°C wilhout adjustment at 0°C
	(tolerance in accordance with
Nonlinearity	DIN 43 760) <0.1°C
Effect of ambient temperature	<0.1°C at (23 ±5) °C
Test current	<0.5°C in rated temperature range
Rate	
Sensors	
Inputs for sensors	in four-wire circuit
Input impedance	100 kΩ
Temperature control range	-99.9 to +299.9 °C
Rated temperature setting	with stepping buttons (coarse and fine)
Resolution .	0.1°C
Switching status indication	lamps for load relay on,
	measured value > or < rated value
Control characteristics	response threshold ±0.15°C about
	rated value (hysteresis variable via
Outputs	IEC bus with 0.1 °C resolution)
AC supply voltage	
(via int. load relay)	
	A-way AC-supply female connector
Control relay (switch)	max, switching current 1 A,
	max. switching voltage 50 V, max. switching power 20 W/30 VA
	telephone jacks
Supply voltage Analog voltage output	±15 V/100 mA via telephone jacks
Programming	
	(IEC 625-1/IEEE 488),
Interface functions	24-way Amphenol
General data	came de l' l'm, see previous page
Rated temperature range	+5 to +45°C
Storage temperature range	-45 to +70°C
AC supply	115/125/220/235 V ±10%, 47 to 440 Hz (30 VA)
Dimensions, weight	211 mm×112 mm×346 mm, 4 kg
Order designation	Temperature Controller PTC
Accessories supplied	336.7014.02
Accessories supplied	power cable; power connector for heating/cooling
Recommended extras	
Contact Sensor PTC-Z1	336.7914.02
Immersion Sensor PTC-Z2	336.7950.02



1 TEST SYSTEMS

automated testing

The main fields of application for analog test systems are

impedance measurements from 10 Hz to 2 GHz

radio receiver measurements

short familiarization period.

transceiver testing for AM, FM, ϕ M and SSB equipment

fieldstrength and EMI/EMC measurements from 9 kHz

Each R&S Standard System for these applications is sup-

plied with a sophisticated, modular Basic Software Package

in BASIC, which allows the full use of the system after a very

More efficient measurements with automatic test systems

R&S offers a choice of automatic test systems for all fields of electronics: for development laboratories, final test, quality control and service departments. The system size ranges from small systems to processor-controlled distributed test systems.

Examples of **computer-controlled test systems** with programming capabilities and software tailored to BASIC are presented on the following pages.

The last two pages of this chapter include also digital and hybrid test systems using the higher programming language ATLAS.

TRANSCEIVER TEST SYSTEM

Problem

Precise and cost-effective measurement of FM and AM transceivers – even of small batches – during production and for incoming and outgoing inspection in small to medium-size service workshops.

Transmitter tests

RF power and frequency useful and spurious modulation modulation distortion modulation sensitivity side tone current drain options: adjacent channel power, selective calling

Receiver tests

sensitivity acc. to S/N or SINAD S/N and SINAD ratio bandwidth mid-frequency shift squelch hysteresis AF level AF frequency response AF distortion image frequency and IF rejection desensitisation current drain options: relay measurement, intermodulation, dyn. adj. channel selectivity, selective calling

Apart from measurements on the transceiver the test system should also be able to check radio subassemblies.

Solution

to 1 GHz

The heart of the system is the highly intelligent Mobile Tester SMFP 2 which performs all these measurements fully automatically. This is accomplished by using the Process Controller PUC running the sophisticated, modular standard software package SMFP 2-K1.

The results are available as graphics or in alpha-numerical form from the Universal Printer PUD 2. The Programmable Power Supply NGPU 70/10 provides for the required voltages at programmable current limits. As the NGPU 70/10 is equipped with automatically switched shunt resistors, the DC voltmeter of the SMFP 2 can do current drain measurements at optimal accuracy within the 3 current ranges.

Furthermore the SMFP 2 can control programmable transceivers for channel selection (3 digits) and for 9 single functions per program. The test system may be extended by the Signal Generator SMS for relay measurement or for intermodulation and blocking measurements according to the CEPT recommendations. Using a Signal Generator SMPC as second signal source, other parameters such as adjacentchannel selectivity and common-channel rejection can be measured according to CEPT.

If required the test system is available built into a 19" rack or into a test desk completely cabled and checked out.



Automatic test system for AM, FM and φM transceivers

TEST SYSTEMS

TEST SYSTEM TO CEPT T/R 17

Problem

All measurements on FM and ϕ M transceivers for land mobile and fixed radio services in the frequency range 30 to 500 MHz as required by CEPT Recommendation T/R 17; also measurements on SSB radio equipment.

Solution

The heart of the system is the Mobile Tester SMFP 2; it is extended by the Modulation Analyzer FAM (also for SINAD measurements), the Adjacent-channel Power Meter NKS (for measurements of nonharmonic spurious signals and oscillator reradiation), the Programmable Power Supply NGPU and many auxiliary devices such as attenuator set, buffer, relay matrix, etc. The system is controlled from the Process Controller PUC completed with the Universal Printer PUD 2.

Two-signal measurements are performed using the Signal Generator SMPC; this also serves as the local oscillator for the Adjacent-channel Power Meter and the Precision Sideband Mixer ATS-SM. Sideband analyses on SSB equipment up to 30 MHz are performed by the Programmable Test Receiver ESH 3.

Basic software developed by Rohde & Schwarz for this test system relieves the user from the measurements proper even where the task is complex, e.g. with two-signal measurements.

REFERENCE SYSTEM FOR TRANSCEIVER TEST

Problem

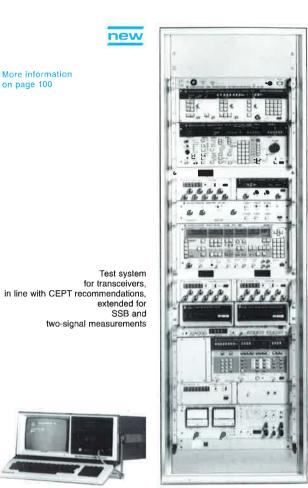
For transceiver measurements affording greater testing depth and higher accuracy than those offered by the test systems built up around the Mobile Tester SMFP 2, R&S can propose a configuration of instruments of highest precision. The basic equipment of the transceiver test system copes with the following tasks: all measurements in the useful channel on simplex and duplex equipment, relay stations equipment with acknowledgement and data transmission radio equipment.

Solution

The following instruments from the comprehensive R&S line are combined into a high-quality measuring system:

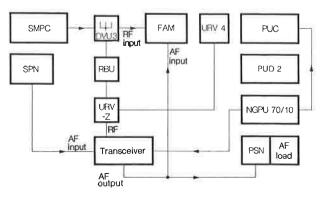
Signal Generator SMPC (Synthesizer); Generator SPN for the microphone voltage; Modulation Analyzer FAM for modulation measurement and determination of AF level, distortion factor and SINAD; Millivoltmeter URV 4 with 100-V insertion unit (for 200 W) for RF power measurement ahead of Highpower Attenuator RBU; AF Relay Matrix PSN for switchover of AF loads and Power Supply NGPU 70/10.

The system is controlled from the Process Controller PUC equipped with the Selective Call Encoder/Decoder for Data





The basic software packet dedicated to this system is compatible with Basic Software SMFP 2-K1, so the system can easily be used as a reference for one or more SMFP 2 test systems. By adding further measuring instruments in stages test system complying with CEPT T/R 17 can be configured.



Block diagram of reference system for transceiver test



new

1 TEST SYSTEMS

automated testing

The test assembly outlined in the block diagram affords a

time saving of about 45% in measurements on stereo car

radios against the measurement times of conventional semi-

automatic systems. The use of a video processor for checking the digital displays, especially the search tuning indicator,

further cuts down on measurement time. The test data for the

display figures, letters and symbols between the process controller and the video processor is transferred in compres-

STEREO-CAR-RADIO TESTER

Problem

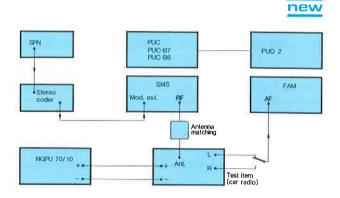
Measurements on stereo car radios for final testing and goods-inwards inspection, for example:

sensitivity	weighted and u
tuning error	S/N ratio: ta
image-frequency rejection	distortion: tape
weighted and	muting
unweighted S/N ratio	muting treshold
mono/stereo with FM	AM suppressio
distortion mono/stereo	AF frequency r
crosstalk attenuation	tone control
pilot-tone suppression	right

veighted and unweighted S/N ratio: tape listortion: tape nuting nuting treshold M suppression AF frequency response with tone control left, centre, right Solution

sed form.

Video processor for computer-controlled display recognition and evaluation in car-radio test (example)



Block diagram of automatic test system for stereo car radios consisting of Generator SPN 1 Hz to 1.3 MHz, Signal Generator SMS 0.1 to 520 MHz, Modulation Analyzer FAM, Power Supply NGPU 70/10, Process Controller PUC and Universal Printer PUD 2

S-PARAMETER TEST SYSTEM

Problem

Semicconductor testing and s-parameter measurement on RF small-signal transistors or other active and passive twoport networks in the range 5 MHz to 2 GHz:

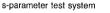
- Measurement of the four s-parameters
- Testing of bipolar RF transistors, junction FETs and MOS-FETs
- Measurement of diode RF characteristics
- Frequency-response measurement in range 5 MHz to 2 GHz
- Determination of s-parameters as functions of transistor DC operating point

Solution

The Process Controller PUC uses the system software (dialog mode) to control the Vector Analyzer ZPV with sparameter Test Adapter ZPV-Z5 and Sweep Generator SWP. The result is output on Universal Printer PUD 2.

If the test item connected to the ZPV-Z5 requires a power supply, the DC Feed Unit ZPV-Z6 serves the purpose. Two Programmable Power supplies of the NGPV series can be used to set the desired DC operating point (not shown in the illustration). The system is handed over on a turnkey basis except for testitem adaption, ready-wired in the rack and checked out, documentation inclusive. The instruments are built into a test cabinet or desk as required.

new





TEST SYSTEMS 1

AUTOMATIC TEST SYSTEM FOR USEFUL AND INTERFERING SIGNALS

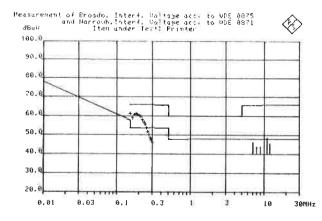
Problem

Detection, (graphic) display and measurement (recording with printer) of useful and interfering signals in the frequency range 9 kHz to 1 GHz:

- Selective voltage measurement in laboratories and test departments for generator, twoport and linearity measurements
- Field-strength measurement using test antennas for the determination of radiation patterns, propagation characteristics and coverage
- Radiomonitoring (field-strength and remote frequency measurements with different types of demodulation for aural monitoring)
- Radio-interference measurements according to CISPR, VDE and FCC and EMI measurements to MIL specifications and VG regulations
- Automatic measurement of directional patterns of ship antennas

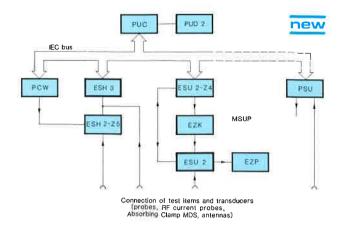
Solution

In the presence of pulse spectra adequate measurement accuracy is obtainable only with selective receivers or measuring equipment because of the wide dynamic range involved.



Radio-Interference measurement according to VDE, CISPR and FCC: rapid peak and average measurements permit distinction of wideband and narrowband interference. Only wideband interference near limit value is measured to CISPR to reduce overall measurement time (approx. 8 min for one phase of power lead); limit curves to VDE 0875 (grade N) and VDE 0871 (class B)

The VHF-UHF Test Equipment MSUP combining the Test Receiver ESU 2 with the Frequency Controller EZK, the Panoramic Adapter EZP and the IEC-bus Adapter ESU 2-Z4 is augmented by the automatic Test Receiver ESH 3 for 9 kHz to 30 MHz to form an IEC-bus programmable test system for 9 kHz to 1 GHz. The ESH 3 takes a lot of load off the IEC-bus controller (Process Controller PUC, on right in the photo) thanks to its total automatic calibration, autoranging, and automatic scanning with constant linear or logarithmic step size.



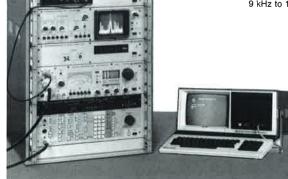
Block diagram of automatic HF-VHF-UHF system consisting of Test Receiver ESH 3, VHF-UHF TEST Equipment MSUP, Code Converter PCW, Artificial Mains Network (LISN) ESH 2-Z5, Process Controller PUC and Universal Printer PUD 2

Software Applications software is available for the controller; it consists of

- a) the MSUP basic software
- b) a dialog program for preparing a graphics data set that can be stored on tape or floppy disk for use in the individual test programs. One or more graphics data sets are produced before a test run for each program and stored in one or more data files.



Automatic test system for selective measurement of useful and interference voltages in the frequency range 9 kHz to 1 GHz



1 TEST SYSTEMS

automated testing

RF COMPONENT TESTER ATS-COM

Problems

Measurements

on RF coils and RF chokes to determine inductance, selfresonant frequency, Q at a particular frequency, and internal capacitance

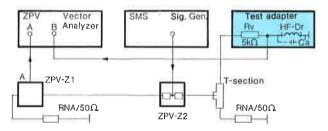
new

- on capacitors of all types and specifically chip capacitors to determine capacitance, Q and tanδ at high frequencies
- on materials to determine dielectric constant ϵ_r and relative permeability μ_r

Solution

TO CHOKE MEASUREMENT

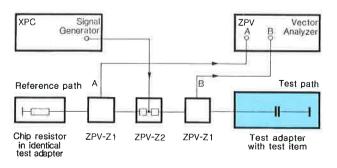
The measurement philosphy of the RF-choke test system is based on the analysis of parallel resonant circuits, the inductance and Q of the test item being determined from the measured resonance frequency and resonance peak. The test item is connected in prallel with a known capacitance, which is part of the test adapter. A second test adapter without a parallel capacitance is necessary for measuring the self-resonant frequency of the RF choke. The system software contains test routines as well as calibration routines for determining the specific test-adapter constants, including those of user-made adapter employing the same measurement technique.



Block diagram of RF-choke test system

TO CAPACITOR MEASUREMENT

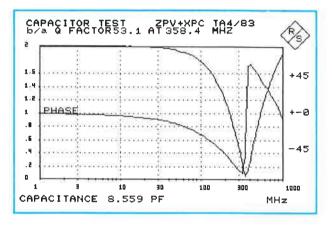
The measurement is based on the analysis of series resonant circuits formed by the test adapter and the test item; see block diagram below. The Q of the unknown capacitor can be calculated from the circuit Q of the resonant circuit.



Block diagram of RF-component tester for capacitors



RF-component tester with test adapters for Q and capacitance measurements on chip capacitors



Printout of chip-capacitor measurement

TO MATERIAL-CHARACTERISTICS MEASUREMENT

The methods described above for capacitor and coil measurements are employed to determine dielectric and magnetic material constants respectively. The parameters of interest are calculated from the measured results.

Specifications
(Shortform; typical values when using test-item optimized test adapter)
Frequency range of test signal 0.1 to 1000 MHz,
down to 10 Hz with option Indudctance range $\ldots \ldots \ldots 0.1 \mu$ H to >1 mH,
up to >1 H with option
Measurement range for RF chokes
Q 10 to 50 Εποτ ΔQ ≦10%
Self-resonant frequency up to 500 MHz
Capacitance range 0.5 pF to 100 nF, up to 10 µF with option
Measurement range for chip capacitors
Q (1/tanδ) up to ≈10,000 Error ΔQ< <15% at 10,000
Capacitance error ∆C
Test frequency at $C = 1 \text{ pF} \dots 800 \text{ MHz}$ typ.
tanô measurement on tantalum electrolytic capacitors and blocking capaci- tors (>100 nF)
Frequenca range 1 to 400 MHz
down to 200 kHz with option Loss resistance
Error ∆R 5%

TEST SYSTEMS

R&S SYSTEM RESPONSIBILITY

The standard test systems presented on the preceding pages have been designed for the most frequent applications in the respective fields.

The scope of delivery and support provided for R&S test systems is explained below by some important items.

System Planning

Additional measurements can be embodied in a standard system configuration by integration of appropriate instruments or by modification of the software packet. The system project worked out in close consultation with the customer is laid down in a binding system proposal.

Hardware Integration

Depending on their size, the test systems are built into castered 19" cabinet racks or 19" desktop cabinets. Each cabinet rack contains besides the measuring instruments at least one blower providing adequate ventilation and an EMI filter suppressing electromagnetic interference from the power line. High-quality, usually double-shielded, cables are used for system-related signal cabling.

Drawers for accessories, connector panels and flangemounted 19" working tops are available on request.

The photo below shows a system version for mobile use wherein the inner 19" frame is connected to the outer shell through shock-absorbing rubber buffers. - Rohde & Schwarz also equips test vehicles and shelters for mobile use in any climatic zone of the earth.

Software

The software for the standard test systems is always designed in the form of a modular basic software packet. which allows fast and reliable preparation of test programs. On request we develop dialog software packets for particular measurement tasks and self-test software for a given svstem.

Documentation

In addition to the handbooks for the individual system instruments R&S supplies documentation for complete systems including hardware configuration and software.

System Training

On request, R&S provides system training for operating staff. Courses last one to five days and are conducted preferably at the head office in Munich. Courses on the maintenance of the system units are also offered.

System Acceptance

Following the system training, the acceptance test is performed on one or more items proposed by the customer and system performance is documented in a test report. After delivery and installation of the system, an identical acceptance test is made on the same test items and laid down in the acceptance test report.

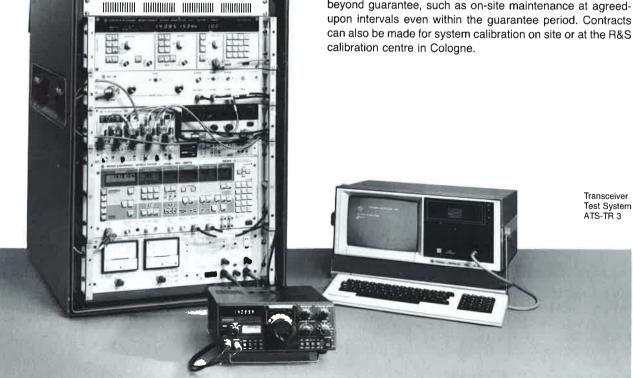
System Installation

The test systems delivered are installed on site by R&S staff. Power line stabilizers can be provided on request.

System Guarantee

The guarantee stipulated in the R&S conditions of sales normally covers the repair of any defective unit free of charge in an R&S service shop within the guarantee period.

R&S offers maintenance contracts for support services going beyond guarantee, such as on-site maintenance at agreedupon intervals even within the guarantee period. Contracts can also be made for system calibration on site or at the R&S



1 TEST SYSTEMS

automated testing

Digital Station TSR 6061

AUTOMATIC TEST SYSTEM TSR 6060

Functional testing capability • • Diagnosis at component level • 10-MHz logic test unit П TT . Programmable adapter interface . Universal switch panel up to 25 MHz • Programming in ATLAS . Comprehensive software Digital simulator new लेलिल

Uses

Today **automatic testing** of electronic subassemblies and modules for quality assurance in batch production, performance checking and fault diagnosis in large repair shops is indispensable.

The **test system TSR 6060** from Rohde & Schwarz forms a flexible system family with modular system components tailored to the specific tasks.

Test system selection and functions

Function-oriented systems. The following functionoriented assemblies can be set up for different fields of application of main interest:

- Digital Station TSR 6061
- Hybrid Station TSR 6062
- RF Station TSR 6063

A wide line of hardware and software system components permits the devices unter test to be given the checks required accurately yet inexpensively.

Test-item connection. The test items are connected to the test-item interface via standardized adapters. The interface is a junction panel with approximately 400 test-item connections.

The programming language (test language) for the test systems is ATLAS (Abbreviated Test Language for All Systems) which has become the international standard for formulating test instructions.

Hardware configuration of a test system

System elements. The test system hardware comprises the following groups:

- computer and peripherals
- interfacing
- measuring instruments and signal generators (instrumentation)
- switch panels
 adapters

Computer and peripherals. The central controller is a powerful 32-bit processor with 16 registers, a 1-Mbyte central memory (extensible to 5 Mbytes) and an address capacity of 4 Gbytes.

The standard set of peripherals comprises a VDU (24 lines, 80 characters each or 14 lines, 132 characters each), control unit (9 user-definable keys), operator console (typewriter keyboard, separate numeric keys, floppy-disk unit (2×0.5 Mbyte), disk drive (fixed disk 121 Mbyte, removeable disk 10 Mbyte) and line printer (132 characters/line; 180 characters/s).

Interfacing. The measuring instruments and signal generators are controlled via the IEC bus (IEC 625-1; IEEE 488); due to its high data processing speed, the digital test unit alone has direct access to the central memory via the DMA version of the IEC bus. The I/O devices are driven via the peripheral bus.

Measuring instruments and signal generators. Basically there are three signal groups which require different processing: digital, hybrid and high-frequency signals. Depending on the measuring instruments selected, the corresponding function-oriented type of test system is obtained.

Digital signals are handled by the digital station which can be extended in steps of 16 bidirectional channels up to a total of 256. The channels can be switched from transmit to receive or to tristate mode at full data rate (3 to 10 MHz). Each channel has five auxiliary stores of 1 kbit each for manifold functional modes. The digital station meets all requirements for digital signals in accordance with IEEE 416-ATLAS. It generates logic signals with freely programmable levels (-20 to +20 V/100 mA) and processes signals with levels between -25 and +25 V.

TEST SYSTEMS 1

Low-frequency signals are produced by power supplies, AF signal or waveform generators and measured with the aid of digital multimeters, distortion meters and analyzers.

Pulse-shaped signals are produced by pulse and waveform generators and measured with the aid of waveform analyzers, timers/counters and spectrum analyzers.

High-frequency signals. The whole line of R&S measuring instruments, including special test assemblies for communication and navigation devices, dealt with in the following chapters, is available for signal processing.

Switch panels. Three different types of switch panel are available corresponding to the signals to be handled:

Hybrid switch panel. It is of modular design and switches either certain channels of the digital test unit or generators and instruments to the test-item connectors. Up to 48 instrument connections can be switched as required to 256 test-item connections. The hybrid switch panel is a 50- Ω system handling all AF and pulse signals up to 25 MHz and 1 A.

Power switch panel. It connects the test item to the power supplies. Voltages up to 500 V and currents up to 15 A can be handled. Modular design permits the use of up to 9 power supplies via 9 switching modules.

RF switch panel. This panel consists of four relay matrix boards each comprising six RF switching relays. The connectors are accessible from the front panel; frequency range 0 to 6 GHz; see also the RF Relay Matrix PSU, page 23,

Adapters. The modules can be connected to the central system interface through an RF adapter or an AF adapter. All signals of the test system up to a frequency of 25 MHz are available – freely programmable – at this junction panel. No further mechanical adaption is required for digital, analog and hybrid modules. The shortest way of linking RF signals is through the RF switch panel.

Software configuration of a test system

The programming language and the available software are of great importance for an automatic test system. The R&S test system uses the internationally standardized test language ATLAS as defined in IEEE standard 416.

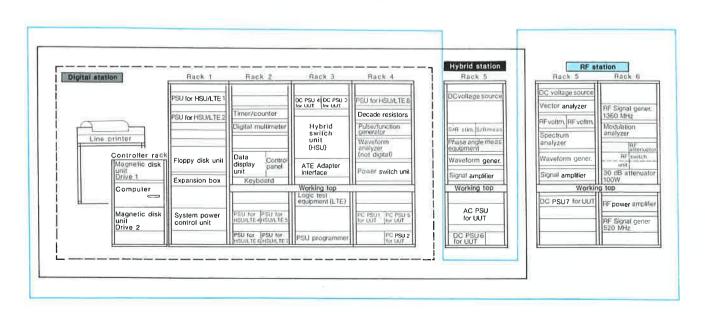
Reaching beyond other programming languages, ATLAS contains instructions which describe all signals required for the test in an easily unterstood signal-oriented form.

s					
С	Anlegen	der Versorgun	d	Programmir	na example
ŝ					
001100		CC STGRAL USIN	G 'de osu',	in the test la	anguage
		AGE 5. V ,		ATLAS	
	CURR	ENT MAX 400. N	à ,	AILAU	
	CMX				
	нт	11-1			
	10	11-2 s			
c	Frueten	der Suschnust	regunoz		
s					
001200	VERIEY.	(FREG 14PB Tay	usgangs(reg'),AC	SIGNAL USING	"frequess"
		.95 KHZ UL 1.05		or a state of the	TTEGRESS
		RANCE 0.5 KHZ			
		U 1.5 KHZ .			
		AGE RANGE 1. Y			
		01.4V,			
	CNX				
		12-l			
		12-2 6			
	μU	12-c p			
1.					

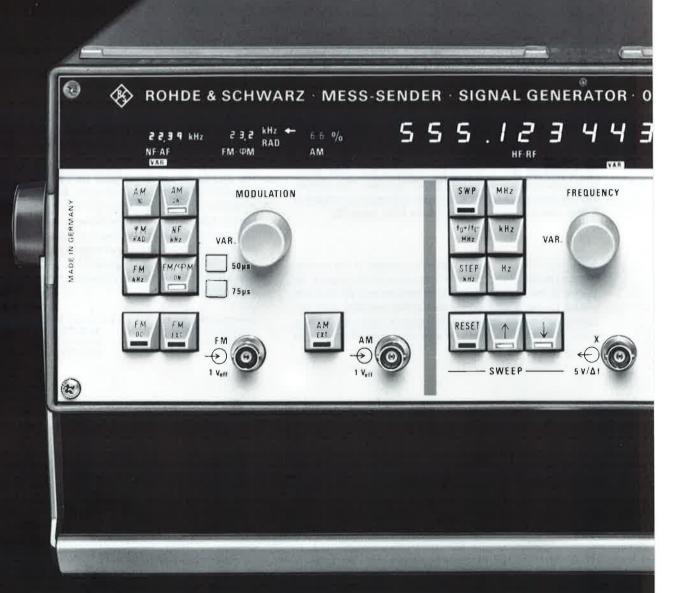
The ATLAS test programs are fully checked, also during entry, through an incremental ATLAS compiler. Alterations can be made at any time to a test program without renewed compilation of the whole program.

The display unit of the system shows the number of the instruction being processed at each moment, the last value measured and the limit values in the case of a comparison. Special modes such as repetition of measurement, stop at fault, stop at each test, printout of all values, manual test, i.e. direct control by means of instructions entered, are possible during the program run. A powerful digital simulator system with automatic test program generation completes the software concept.

Order designa	tion		Automatic Test System
Digital Station	TSR 6061	1.1.1.4.4.4.4.4.4	360.0116.02
Hybrid Station	TSR 6062	3934 - 6334 ST	360.0216.02
RF Station	TSR 6063	$\{(x,y),(y,$	360.0316.02



Signal Generator SMPC for 5 kHz to 1360 MHz, IEC-bus-compatible; details on page 54



AF and RF signal generators



signal generators

Signal generators

Rohde & Schwarz offers a complete line of signal generators for the **AF to SHF ranges covering 1 Hz to 12.5 GHz.** The line comprises solid-state mechanically tuned signal sources with synchronization capability, synthesized generators of finest frequency resolution and highest stability as well as klystron generators for the highest frequencies.

All R&S signal generators feature

- an easy-to-read and fine frequency adjustment,
- an extremely accurate and easy-to-vary output level and
- versatile modulation characteristics.

R&S signal generators have all the characteristics which are required for use in development, production (test department) and servicing over the entire range of low- and highfrequency technology, permitting the performance of the most diversified measurements and simulation of all signals which are necessary for testing components, circuits, receivers and instruments of various types. The possibilities include, for example, receiver tests for sensitivity, selectivity and adjacent-channel characteristics. The comprehensive modulation characteristics include stereo of highest quality. Signal generators with high power output permit special measurements such as intermodulation and crossmodulation at high levels, driving of power stages and frequency multipliers, etc.

Characteristics of RF signal

The application of a signal generator depends on criteria such as

- frequency range and resolution,
- frequency stability,
- level range and resolution,
- harmonic content and
- modulation characteristics.

Another essential criterion is the signal quality with respect to phase noise and

nonharmonic spuria.

A common way of **phase noise** evaluation is to indicate the ratio of the SSB noise power per 1-Hz bandwidth to the total signal power in dBc. A graphical representation of the noise sideband shows especially well the corresponding characteristic as a function of the spacing from the carrier.

The term **nonharmonic spuria** designates all the discrete signals which occur at the output in addition to the carrier and its harmonics. These spurious levels are indicated as relative levels in dBc, i.e. referred to the carrier level.

The spurious FM yields further information on the spectral purity. The **spurious FM**, i.e. the frequency deviation measured at a demodulator with a fixed bandwidth, is directly related to the phase noise and the nonharmonic spuria. The lower the phase noise and the spuria level, the lower is the residual FM.

The requirements on spectral purity are especially stringent for measuring the **adjacent-channel characteristics** on receivers since the noise frequency spectrum falling within the adjacent channel must not invalidate the measurement. If, for instance, an adjacent-channel selectivity (S/N ratio) of 80 dB is to be measured, the SSB phase noise of the noise source must be below -135 dBc at the channel spacing.

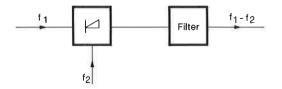
Synthesized generators

These are signal generators whose adjustable output frequency is derived from a single, crystal-referenced control frequency. Generally, they differ from free-running generators in their considerably higher frequency accuracy.

Basically synthesized generators can be digitally controlled. Hence, they are particularly suitable for modems, keyboardoriented designs with microprocessor control and for use in automated test systems, e.g. with IEC-bus control.

Regarding AM/FM modulation characteristics and outputlevel adjustment and regulation they do not differ from freerunning signal generators. Several basic techniques of frequency synthesis are possible:

1. Frequency generation by mixing

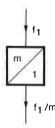


The advantages of this method are the extremely short frequency switching time and the lack of problems when the signal is modulated (FM, AM and SSB).



2. Frequency division

The frequency division method stands out as requiring minimum circuitry in the lower and medium frequency range. With this method the spectral purity of the divided signal is improved by the amount of the division factor so that in this way particularly low-noise signals can be generated mainly in medium frequency ranges.



Low-noise synthesized generators 5 kHz to 1360 MHz: SMPC and XPC

The SMPC is a high-grade modern synthesized signal generator featuring high spectral purity, outstanding modulation characteristics and a wide frequency range with a resolution of 0.1 Hz. The low phase noise (-143 dBc at 100 MHz and 20 kHz from the carrier) and the low level of discrete spurious signals (-90 dBc) permit all receiver measurements including exacting adjacent-channel measurements even with narrow channel spacing.

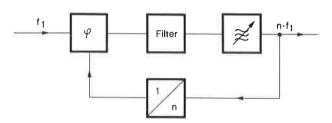
Signal Generator SMPC



For the first time a synthesized generator with this high degree of spectral purity features also AM, FM and ϕ M characteristics of maximum quality. The FM distortion of less than 0.1% and an adjacent-channel crosstalk which is down more than 56 dB permit measurements even on high-grade stereo receivers to be performed.

For frequency response measurements, digital sweeping is possible in the linear or logarithmic mode. The short frequency setting time of 18 ms enables relatively high sweep speeds and high test speeds in automatic test assemblies.

3. PLL technique



Phase-locked loops have the advantage that they are largely free from spurious responses since these are filtered out by an AF filter in the control voltage path. When using suitable dividers any integral frequencies can be selected, so the PLL technique is ideal for generating the main frequency range of synthesizers. With a control response that is fast enough and a suitable reference frequency particularly low-noise output signals can be produced. Frequency modulation can be transferred.

The disadvantages of the phase-locked loop lie in the limitation of its transient response, in its unusability with amplitude modulation and in the complex circuitry that is required if frequencies are to be selected with high resolution.

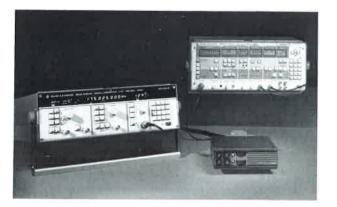
4. Computer synthesis



With this method a high-speed computer calculates at crystal-referenced time intervals the amplitude the desired output signal should have at the respective time. The numercial values are converted into an analog curve via a D/A converter.

The advantages of this method are the extremely fast phasecoherent frequency switching, the high frequency resolutions that are possible and the relatively simple circuit design.

For synthesized signal generators a **combination of these methods**, depending on the particular application, is used.



SMPC used as interference source in two-source measurements on RT unit

signal generators

Synthesized generators

The Synthesizer Generator XPC is a high-quality source for unmodulated RF signals. All the characteristics of the CW signal as well as the operation and remote control of the instrument are identical with those of the SMPC. The XPC is an economy-priced alternative to the SMPC for all the applications which require an accurate crystal-controlled frequency, high spectral purity and precise level adjustment of the unmodulated signal. The XPC can be generally used for instance as a low-noise local oscillator (LO) or as a reference source in noise test assemblies.



Program-controlled frequency measurement with Signal Generator SMS, Process Controller PUC and Millivoltmeter URV4

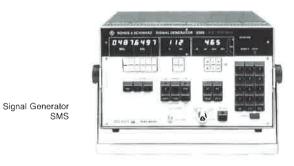
short setting time of 40 ms enables comprehensive measurement tasks to be solved quickly by computer control via the IEC bus.



Synthesizer Generator XPC

Economy-priced synthesized generator 0.1 to 520 MHz (0.1 to 1040 MHz)

The basic model of the Signal Generator SMS uses the synthesizer principle to produce a signal in the range from 0.1 to 520 or 1040 MHz with 100-Hz resolution. The level-controlled output signal can be universally modulated and adjusted between +13 and -137 dBm in 0.1-dB steps.



The good signal quality (phase noise – 120 dBc at 20 kHz from carrier with 1-Hz test bandwidth, wideband noise – 145 dBc at 1 MHz from carrier) permits all receiver measurements to be performed in the receive channel such as sensitivity, modulation characteristics, selectivity, overload capacity, etc. Most out-of-channel measurements, e.g. desensitization and intermodulation suppression are also possible with the aid of the SMS. Moreover the SMS is suitable for a multitude of measurements on components and modules and for use as a precise signal source in twoport and impedance measurements. Complex impedance and group delay can be measured in the frequency range from 0.1 to 1040 MHz in conjunction with the Vector Analyzer ZPV. The settings are made rapidly and easily through the key arrays, each setting can be varied quasi-continuously. The

Signal Generator SMK 10 Hz to 140 MHz

The SMK combines the characteristics of a conventional AM-FM signal generator of highest quality with the advantages of a state-of-the-art synthesizer.

The crystal-controlled frequency stability and accuracy with a resolution of 1 Hz, an extremely small spurious FM (<1 Hz), low SSB phase noise (-135 dBc at 20 kHz from carrier), a high S/N ratio and excellent RF shielding are characteristics which qualify the SMK for all the measurements required on radio direction finders, RTs, shortwave receivers including SSB equipment and sound broadcasting receivers. The SSB test input of the SMK is of special advantage for intermodulation measurements on SSB receivers. When applying fixed-frequency signals, the SMK delivers an SSB spectrum covering the desired frequency range.

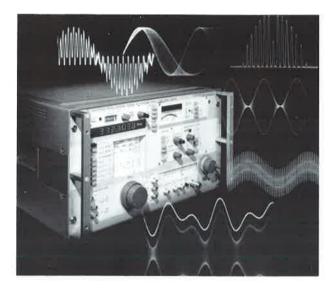


The low FM distortion (0.02%) and stereo crosstalk (down 60 dB) make the SMK ideal for measurements on top-class stereo receivers. DC coupling for external modulation sources enables FSK modulation. FM and AM can be selected independently at the same time. With FM and AM, two-tone modulation is possible for intermodulation measurements. Moreover, the SMK is suitable for swept-frequency measurements with a sweep width of up to 500 kHz (like with FM).

RF GENERATORS 2

Mechanically tuned generators

A well-proven universal signal generator from R&S in this category is the Signal Generator SMDU, covering the frequency range from 15 Hz to 1.05 GHz. Most information transmissions fall into this range: broadcasting from LW to VHF, radiotelephony from SW to UHF, air navigation and communication plus important IF bands for transmissions above 1 GHz.



Signal Generator SMDU (see page 66)

The SMDU carrier frequency is indicated on a seven-digit frequency meter with a resolution of 1 Hz or 10 Hz, which also permits measurement of external signals from 15 Hz to 525 MHz – up to 1 GHz using the frequency range extension. The synchronizer option makes the instrument a synthesized signal generator with a stability of 10^{-8} /month. Thanks to the good control action of the phase-locked loop, the high spectral purity is maintained in addition to the synthesizer stability.

This option permits checking of high-quality receivers which require instruments of outstanding performance for testing characteristics such as the dynamic adjacent-channel selectivity, desensitization, crossmodulation and intermodulation rejection. Further advantages are electronic fine tuning and synchronized frequency settings corresponding to the standard channel spacings. When synchronized, any frequency can be adjusted and any common channel spacing covered in steps starting with any frequency.

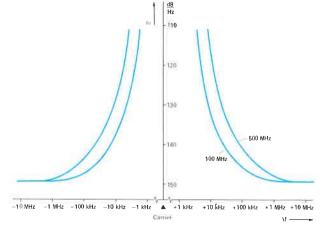
The level range of the Signal Generator SMDU starts at 0.1 μV EMF – the sensitivity limit of modern receivers – and reaches up to 2 V EMF – the maximum test voltage for components or the overdrive limit of receivers. The accuracy of the RF output voltage, which is ± 0.5 dB typ. over the full level and frequency ranges, corresponds virtually to that of a standard. Any form of modulation (AM, FM or ϕM) may be applied to the output signal, the harmonic distortion remaining negligible even at large deviations and modulation depths. The universal model 04 of this signal generator family also permits testing of hifi studio and stereo receivers.

The SMDU is no conventional signal generator; it is also a substitute for a digital frequency meter (15 Hz to 1.05 GHz), an AF generator and an AF voltmeter. Several different models and options permit an optimum solution to be found for each application (see overview on page 64).

The Adjacent-channel Power Meter NKS completes the RT Test Assemblies SMDU. It measures the adjacent-channel radiation of RT transmitters in compliance with national and international standard specifications.

For measurements on receivers from LF to VHF – in particular on high-quality sound broadcasting receivers – the AM/ FM Signal Generator SMUV supplies test signals of the highest precision and spectral purity.

The SMUV covers the frequency range from 10 kHz to 130 MHz and is ideal for measurements on SSB receivers.



Signal-to-noise ratio of SMDU carriers 100 MHz and 500 MHz at 1-Hz test bandwidth

Swept-frequency measurement on a bandpass filter using the SMUV with option Sweep Oscillator SMUV-B5 and Sweep Unit SMLU-Z5



The SMUV specifications regarding the frequency stability and accuracy, the spectral purity and the spurious deviation, the modulation characteristics, the level range and the level setting accuracy are better than those of even very expensive comparable units. Moreover, the SMUV is very easy to operate: it offers rapid frequency selection, a single-range attenuator with tuning knob and a counter that can be used for external measurements.

Three models and five options permit matching the SMUV to any specific application. In addition to the excellent characteristics as a signal generator for receiver measurements, it also qualifies for a great number of other tasks.

A high-performance sweep tester can be assembled using the option **Sweep Oscillator** SMUV-B5 and the Sweep Unit SMLU-Z, which permits swept-frequency measurements both on narrowband test items (filters, bandpass filters, etc.) and on broadband amplifiers.

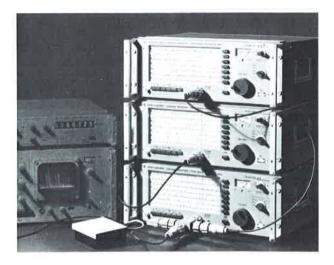
The **2-W-Amplifier** extends the SMUV to form a power signal generator which is particularly suitable for interference measurements. The Synchronizer SMUV-B9 and the Crystal Oscillator SMUV-B1 raise the frequency stability and accuracy of the SMUV to synthesizer standard.

signal generators

generators and for checking out DME, ATC and TACAN equipment. Steep edges and carrier suppression by at least 80 dB ensure accurate simulation of radar pulses. FM and AM are also possible.

Power signal generators

From VLF to SHF, R&S power signal generators provide continuous coverage for the range between 10 kHz and 2.7 GHz.

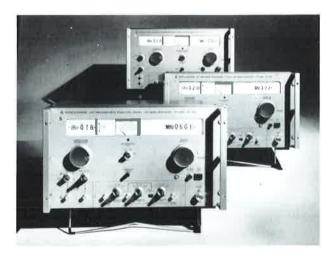


Power Signal Generator SMLU (see page 70) used in test setup for crossmodulation measurement

Klystron signal generators from UHF to SHF

A family of general-purpose signal generators delivering high-stability signals is available for the microwave region. The three instruments SMAI, SMBI, SMCI together span the frequency range from 0.5 to 12.5 GHz. The output level can be accurately adjusted from -130 dBm to +10 dBm; it is also electronically levelled.

Their outstanding pulse-modulation characteristics make these signal generators well suited for use a radar test Together, the SMUV and SMLU cover the range from 10 kHz to 1 GHz, delivering a levelled output power of 2 W (1 W). The SLRD, covering 280 MHz to 2.75 GHz, is a power signal generator for applications which require high levels and stable frequencies; its maximum output level is 35 W. Versatile modulation characteristics (AM, FM, pulse modulation) and sweep operation permit universal use for a large variety of measurements.



Signal Generators SMAI, SMBI, SMCI (see page 68)

Signal generators for low frequencies

AF generators are used in many fields of instrumentation. Various designs exist depending on the applications. The most important criteria are frequency accuracy, output level, level accuracy, distortion, switching speed and transient response after frequency changing.

In broadcasting – particularly for hifi – signal generators with low distortion and a relatively high output level are normally required.

AF GENERATORS 2

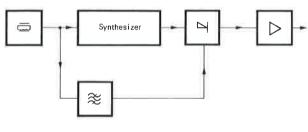
The new Generator SPN is an optimum combination of modern synthesizer and time-proven BFO techniques.



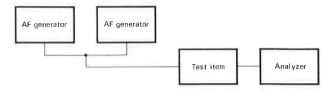
Generator SPN

The SPN design guarantees equally good performance in different respects: high frequency stability, low distortion, high spectral purity and flat frequency response of the output signal.

The SPN can be remote-controlled via the IEC bus; this makes it especially suitable for use in automatic test systems – e.g. for AF distortion measurements using the difference-frequency method.



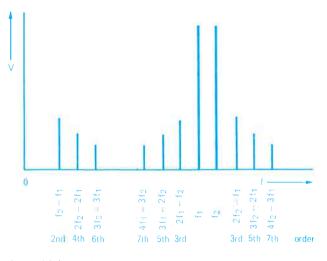
Principle of Generator SPN



AF distortion measurement by the difference-frequency method

Example: Difference-frequency measurement using an LF generator

Due to its linear output impedance, the SPN is ideal for difference-frequency measurements (see above). Distortion occuring in AF modules can be reliably detected. The method has the advantage over conventional distortion measurements that the available dynamic range is much greater when an analyzer is used. The high frequency stability of the SPN ensures good reproducibility and easy evaluation of the measurements. The test item, e.g. an amplifier, is fed with two signal of different frequencies (f1 and f2) and equal amplitude at a frequency spacing $\Delta f = f2-f1$. The non-linear characteristic of the test item gives rise to additional frequencies at the output. The 2nd- and 3rd-order difference frequencies are generally used for the measurement, the values being $\Delta f = f2-f1$ for the former, $f2+\Delta f = 2f2-f1$ and $f1-\Delta f = 2f1-f2$ for the latter.



Intermodulation spectrum

Difference-frequency method

Although distortion measurements can be performed with low-distortion Wien-bridge oscillators, the difference-frequency method is preferable, since the judging of non-linear distortion depends on the response of the human ear. The pitch and masking effects play an important part, besides the sound pressure. Harmonics are less annoying than nonharmonic difference and sum tones whicch are preceived more intensely. Similarly, distortion at the upper end of the audible frequency range irritates the listener although the corresponding harmonics are imperceptible. Difference requency measurements are technically preferable because the inherent distortion of the two signal generators does not affect the result, provided the test frequencies are selected appropriately.

Higher-order difference frequencies appear as further spectral lines at distances of Δf .

Second-order intermodulation distortion is

 $d_{z}=\frac{V_{\Delta f}}{V_{out}\sqrt{2}}$, where $V_{\Delta f}$ is an rms voltage component and

 V_{out} the rms value of the total voltage at the output.

Third-order intermodulation distortion is:

$$d_3 = \frac{V_{(f1-\Delta f)} + V_{(f2+\Delta f)}}{V_{out}\sqrt{2}}$$



AF generators

Frequency range	Designation	Туре	Order No. (complete No. see text)	Frequency error	Frequency resolution/ indication	Output level EMF
1 Hz to 1.3 MHz	Generator	SPN	336.3019.02	1 × 10 ⁻⁵ /month 1 × 10 ⁻⁶ /°C	0.1 Hz, 4-digit display	Sine: 1 mV to 10 V Square: TTL level Z _{oul} : 600/50/≈5 Ω

RF generators

Frequency range	Designation	Туре	Order No. (complete No. see text)	Frequency error	Frequency resolution/ indication	Output level EMF
the second se						

Synthesized generators

10 Hz to 140 MHz	Signal Generator	SMK	348.0010.02	(crystal; synthesizer)	1 Hz, 9-digit display	0.025 μV to 2 V into 50 Ω (-138.9 to +19 dBm)
0.1 to 1040 MHz	Signal Generator	SMS	302 4012	(crystal; synthesizer)	100 Hz, 8-digit display	0.03 μV to 1 V into 50 Ω (-137 to +13 dBm)
5 kHz to 1360 MHz	Signal Generator	SMPC	300,1000.52	(crystal; synthesizer, 1 × 10−8/day	0₊1 Hz, 10-digit display	0.016 μV to 1 V into 50 Ω (-143 to +13 dBm)
5 kHz to 1360 MHz	Synthesizer Generator	XPC	337.8014.52	(crystal; synthesizer, 10 MHz; 1 × 10 ^{_8} /day)	0-1 Hz, 10-digit display	0.016 μV to 1 V into 50 Ω (-143 to +13 dBm)
0.1 to 2500 MHz	Sweep Generator	SWP	339.0010	(crystal)	1 kHz, 6-digit display	0.7 μV to 707 mV (−110 to +10 dBm)

Mechanically tuned and synchronized generators

0.01 to 130 MHz	AM/FM Signal Generator	SMUV	301.0120	(10-MHz crystal with option: 1 × 10 ⁻⁸ /month	7-digit display	0.05 μV to 0.5 V (10 V) into 50 Ω
0.14 to 1050 MHz	Signal Generator	SMDU	249.3011	(10-MHz crystal: 1 × 10 ⁻⁸ /month)	7-digit display	0.05 μV to 2 V EMF (-138 to +13 dBm) 50 Ω
0.5 to 1.8 GHz	UHF Signal Generator	SMAI	100.4594.13	±0.5% ext. freq. sync possible model with ALC	100 kHz/div	-130 to ± 10 dBm 50 Ω constant level ± 1 (1.75) dB
1.7 to 5.0 GHz	SHF Signal Generator	SMBI	100.4607.13	±0.5% ext. freq. sync possible model with ALC	1 MHz/div.	-130 to $+5$ dBm 50 Ω constant level ±1 (2) dB
4.8 to 12.5 GHz	SHF Signal Generator	SMCI	100.4613.13	±0.5% ext. freq. sync possible model with ALC	1 MHz/div.	-130 to 0 dBm 50 Ω constant level ±1 (2.5) dB

Power signal generators

10 kHz to 130 (40) MHz	AM/FM Signal Generator + Option SMLH-B3	SMUV	301 0120 284 4210 50	(10-MHz crystal; 1 × 10 ⁻⁵ /month)	1/10/100 Hz	0.5 to 10 V (10 kHz to 40 MHz) into 50 Ω
25 to 1000 MHz	Power Signal Generator	SMLU	200.1009-03	±2%	0.2 to 5 MHz/div.	 −13 to +33 dBm (2 W) const. level; 50 Ω
0.280 to 2.75 GHz	UHF Power Signal Generator	SLRD	100 4194 02	±2% ext. freq. sync possible	5 to 50 MHz/div	-50 to +45 dBm (P _{max} = 35 W)

Noise generators

20 Hz to 50 MHz	Noise Generator	SUF2	282.8819,03		=	$ \leq 1 V_{rms} \text{ into } 75 \Omega; \\ 0.775/0.7 V_{rms} \\ link-selected $
1 to 1000 MHz	Noise Generator	SKTU	100.4688	-		0 to 6.5/33 kT _O , 50 Ω 0 to 6.4/32 kT _O , 75 Ω



AF generators

Output level error	Harmonic distortion	Switching time	Dimensions in mm (W×H×D)	Remarks	Text on page
±0.2/10 dB	>70 dB (1 Hz to 100 kHz) >54 dB (100 kHz to 1.3 MHz)	15 ms	245×154× 349	synthesizer, IEC-bus-compatible; swept-freq. op. possible	44

RF generators

Output level Type of modulation Modulation frequency range internal external error AM = amplitude mod. FM = frequency mod.; φM = phase mod. FM = frequency mod.; φM = phase mod.	Dimensions in mm (W×H×D)	Text on page
--	--------------------------------	--------------------

Synthesized generators

±1.5 dB	AM: 0 to 100% FM: 0 to 500 kHz Sweep: 0 to 500 kHz	5 frequencies 5 frequencies 3 frequencies	20 Hz (DC) to 20 kHz 20 Hz (DC) to 100 kHz DC to 3 kHz	349×206× 462	AM-FM signal generator, 2-tone AM, 2-tone FM, stereo- compatible, SSB test signals	46
±1.5 dB	AM: 0 to 95% FM: 0 to 125 kHz φM: —	400 Hz/1 kHz 400 Hz/1 kHz —	20 Hz to 20 kHz 20 Hz to 20 kHz 20 Hz to 8 kHz	345×206× 370	synthesizer, system-compatible, IEC-bus-compatible, extremely low-priced	50
±1.7 dB	AM: 0 to 99% FM: 0 to 1600 kHz φM: 0 to 200 rad	10 Hz to 50 kHz 10 Hz to 100 kHz 10 Hz to 3 kHz	10 Hz (DC) to 50 kHz 10 Hz (DC) to 125 kHz 10 Hz to 8 kHz	470×162× 469	particularly low-noise synthesizer with excellent modulation characteristics	54
±1.7 dB				470×16.?× 469	synthesizer, IEC-bus-compatible, digital sweeping, data retention in case of AC supply failure	58
±2 dB	AM: 0 to 80% FM: 0 to 10 MHz Pulse:	1 kHz squarewave	0 to 10 kHz 0 to 100 kHz 10 μs	470×162× 483	sweep generator with excellent narrowband sweep characteristics	126

Mechanically tuned and synchronized generators

±1 dB	AM: 0 to 98% FM: 0 to 100 kHz	1 kHz/400 Hz	0 to 100 kHz	492×205× 514	with options: synchron. with 1-kHz steps, sweep oscillator, 2 W output power, suitable for stered	60 5
±1 (2) dB	AM: 0 to 98% FM: 0 to 1 MHz φM: preemph. 50/75 μs	0 to 150 kHz	0 to 150 kHz	492×296× 434	six models available: general RF measurements, RT testing, avionics	64
±(0.1 dB ±0.005 dB/1-dB step)	pulse: 100% FM: 0 to >100 kHz AM: 0 to 70%	1 kHz square- wave	up to 200 kHz 1 Hz to 10 MHz 2 Hz to 100 kHz	484×283× 512		68
±(0.1 dB ±0.01 dB/1-dB step)	pulse: 100% FM: 0 to >500 kHz AM: 0 to 70%	1 kHz square- wave	up to 250 kHz 1 Hz to 10 MHz 2 Hz to 100 kHz	484×283× 512	extension of frequency and pulse modulation characteristics using modulation unit	
±(0.1 dB ±0.015 dB/1-dB step)	pulse: 100% FM: 0 to >8 MHz AM: 0 to 70%	1 kHz square- wave	up to 1 MHz 1 Hz to 10 MHz 2 Hz to 100 kHz	484×283× 512		

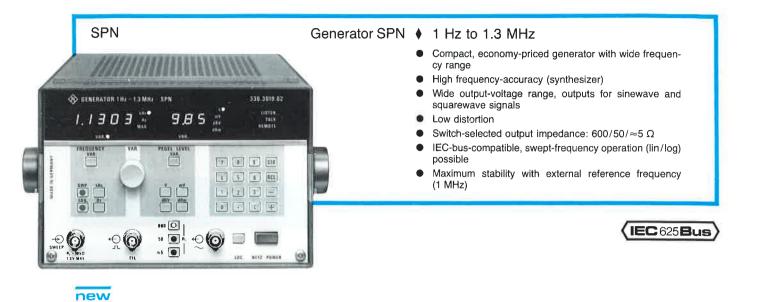
Power signal generators

±1 dB	AM: 0 to 98% FM: 0 to 50 kHz	1 kHz 1 kHz	30 Hz to 20 kHz 30 Hz to 20 kHz	492×205× 514		60
±0.12 dB/5 dB	AM: 0 to 90% FM: 1 subrange	1 kHz (70%)	10 Hz to 8 kHz 0 to 8 kHz	484×194× 436	remote control via IEC bus using Code Converter PCW; sweeping possible	70
±(1 dB ±0.05 dB/dB)	pulse	1 kHz square- wave	0 to 100 kHz	484×328× 512		74

Noise generators

±0.5 dB			<u></u>	210×118× 349	generator for white, pink, triangular noise and program replacement signal	338 (App.)
±0.5 dB		 ,		470×195× 260	skale calibration in terms of noise figure F and F _{dB}	75

2 AF GENERATORS



An optimum combination of time-proven BFO and modern synthesizer techniques, the **Generator SPN** offers at once high frequency stability, extremely low distortion, high spectral purity and flat frequency response of the output signal.

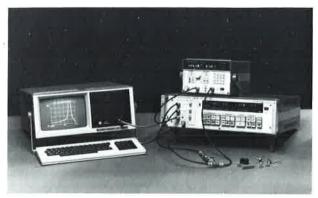
Applications

The Generator SPN can be operated manually as well as via the IEC bus, so it finds wide-spread use in many fields such as

acoustics hifi technology development and production research and training servicing of AF equipment automatic test assemblies

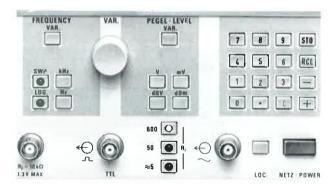
There is also a large number of other fields in which accurate frequencies are required, for instance in telemetry and physics or in mechanical control processes. In addition, the outputs of two SPN generators can be connected in parallel for measuring non-linear distortions.

Test assembly using SPN for computer-controlled measurement of components



Characteristics

Ease of operation. The built-in microprocessor makes the generator an intelligent unit which is easy to operate and to program. Manual settings are made by pressing the keys first for the numerical value and then for the unit. Quasi-continuous settings are possible with the rotary knob.



Keyboard of SPN affording great ease of operation

Storage capability. The SPN is able to store five complete setups (memory addresses: 1 to 5). The RCL key permits both complete setups and individual frequency or level settings to be recalled.

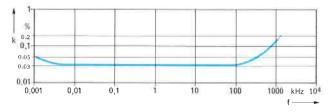
Frequency, State-of-the-art synthesizer technology ensures crystal-referenced output frequencies from 1 Hz to 1.3 MHz with a frequency setting time of only 15 ms. The short setting time is important in computer-controlled test systems with a high measuring rate or for the generation of tone sequences such as those required for measurements on selective calling equipment. The frequency entered via the keyboard is read out on the display in five digits (smallest resolution: 0.1 Hz) with a floating decimal point. The frequency can be varied quasi-continuously using a rotary knob. The SPN offers another convenient way of frequency variation by frequency jumps with selectable step size and by calling up the standard octave and third-octave sequences. Logarithmic frequency variation is possible by entering a multiplication or division factor between 1.00 and 2.00.

AF GENERATORS 2

Output level (sinewave output). Adjustable between 0.1 mV and 10 V with smallest resolution of 0.01 mV (depending on output impedance selected). The output level is read out in three digits with a floating decimal point on the level display (in V, mV, dBV or dBm). The output level entered can also be varied quasi-continuously or in steps and it can be converted from one unit into another simply at the push of a button. The maximum output EMF is 10 V_{rms}.

Distortion is as low as 0.03% in the frequency range from 50 Hz to 100 kHz, so that the SPN fulfils the most demanding requirements of the audio-frequency range.

Output level on/off. The level is switched off by pressing the illuminated R_i key and switched on by pressing one of the dark R_i keys.



Guaranteed distortion limits for maximum output EMF of 10 V_{rms} (k=distortion)

Output impedance. The impedance of the sinewave output can be selected between 600, 50 and approximately 5 Ω at the push of a button and thus be matched to the standard system impedances. The output impedance is linear and real, allowing the sinewave outputs of two SPN generators to be connected in parallel.

Squarewave output. In addition to the sinewave output, an output with a squarewave signal of the same frequency is available for driving digital circuits as well as for other measuring tasks; output level: TTL, positive.

External sweeping. The generator frequency can be swept in linear or logarithmic mode over the entire frequency range or certain subranges – required sweep voltage 0 to 1.3 V. The logarithmic conversion is done internally. The sweep range is from 1 Hz up to the upper range limit which can be selected and is indicated on the display.

Range 1 1 Hz to 1.3000 kHz 3 1 Hz to 130.00 kHz 2 1 Hz to 13.000 kHz 4 1 Hz to 1300.0 kHz

Remote control. All settings of the Generator SPN can be made remotely. The short programming time makes the SPN suitable for use in automatic measuring assemblies and test systems.

Balun (option). Used for feeding balanced line systems or amplifiers and for eliminating hum pickup in test setups. Stepdown transformation, so low internal impedance (\approx 15 Ω).

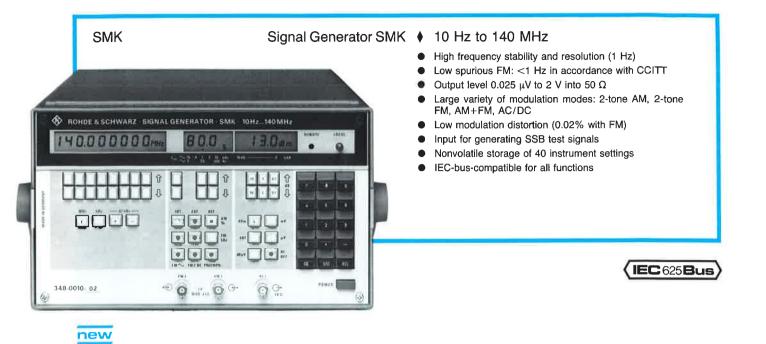


Specifications	
Frequency range	
Frequency setting Display	
Resolution	
at 1 Hz to 1.3 kHz 1.3 to 13 kHz	
13 to 130 kHz	10 Hz
130 to 1300 kHz	
Crystal aging	
Temperature effect	≦1 × 10 ⁻⁶ / °C
Outputs	separate outputs for sine and square-
Sine output	wave signals
Level setting	keyboard entry
Display Resolution	3 digits with unit V, mV, dBV, dBm
Output EMF, rms	1 mV to 10 V ($Z_{out} = 600$ and 50 Ω)
	0.1 mV to 1 V (Z _{out} ≈5 Ω)
Output impedance, switch-selected	600, 50, ≈5 Ω
Connector	BNC female
Level off	by pressing Hi keys
1 to 50 Hz, 10 V	<0.05%
50 Hz to 100 kHz, 10 V 0.1 to 1.3 MHz, 10 V	<0.03%
Harmonics	
1 Hz to 100 kHz 0.1 to 1.3 MHz	
Error of output EMF	>54 dB down
at 300 mV to 10 V	<±2%
10 to 300 mV 1 to 10 mV	< <u>±3%</u> < <u>+5%</u>
Frequency response flatness of outp	ut EMF
at 1 Hz to 9,999 kHz 10 kHz to 1 3 MHz	$<\pm 0.5\%$ corresp. to ± 0.05 dB
1 Hz to 1.3 MHz	$<\pm1\%$ corresp. to ±0.1 dB
Spurious signals	>70 dB down from 1 Hz to 700 kHz >65 dB down from 700 kHz to
	1300 kHz
Squarewave output	TTL levels, positive
Connector	10 BNC female
Ref. output/input	1 MHz, TTL signal, 0.2 to 2 V, $>500 \Omega$
Sweep operation	
Linear sweep range	logarithmic mode, switch-selected
1 Hz to	1.3 kHz/13 kHz/130 kHz/1.3 MHz
Sweep voltage	
Sweep frequency	0 10 10 KM2
Programming System	IEC 625-1/IEEE 488
Connector	24-way Amphenol
Interface functions	T6 talker L4 listener
	RL1 remote/local
	DC1 device clear
General data	SR1 service request
Rated temperature range	+5 to +45°C
Storage temperature range	-40 to +70°C
AC supply	100/120/220/240 V ±10%, 47 to 63 Hz (55 VA)
Dimensions, weight	47 to 63 Hz (55 VA) 245 mm×154 mm×349 mm, 6.5 kg
Ordering information	
Order designation	Generator SPN 336.3019.02
Accessories supplied	
	perter outpro
Recommended extras	
Options: Balun SPN-Z1	265.4319.02
Balun SPN-Z1 19" Adapter ZZA-23	078.8397.00

Specifications of Balun SPN-Z1

Input connector BN	C male with coaxial cable
Output connector 4 n	nm knurled terminal
Frequency range	Hz to 100 kHz
Open-circuit turns ratio 3.1	$6:1 = -10 \text{ dB} (\pm 0.1 \text{ dB})$
Impedance 15	
Permissible load impedance	0 Ω up to open circuit
Distortion	
an	$d Z_{out} = 50 \Omega$
Dimensions, weight 83	mm×130 mm×105 mm, 1.5 kg
	· · · · · · · · · · · · · · · · · · ·

signal generators

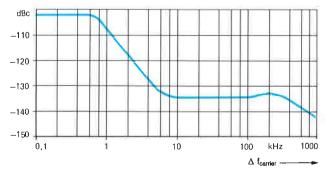


Characteristics, uses

The **Signal Generator SMK** is a fully programmable AM-FM synthesized generator covering continuously the frequency range from 10 Hz to 140 MHz. It contains AF sources for internal modulation and frequency sweeping.

These features as well as its frequency resolution, signal quality and modulation capability qualify the Signal Generator SMK for all measurements on **shortwave receivers** – including SSB equipment – and on AM and **hifi FM sound broadcasting receivers.** Stereo crosstalk for instance is down 60 dB.

The SMK is extremely convenient to operate and protected against incorrect settings, see righthand column. Levels can be set in μ V, mV, dB μ V and dBm as well as in dBf (reference: femto watt = 10^{-15} W). Moreover, a comprehensive **self-test** of the synthesizer functions is possible; any errors are read out on the display.





Thanks to the **programmability** of all functions via the IEC bus (IEC 625-1 and IEEE 488), the SMK can be used in semi-automatic or fully automatic test assemblies.

Ease of operation

- Clear arrangement of the front panel by splitting up the keyboard and display into sections for frequency, modulation and level.
- Keyboard entries in the normal order numerical value plus unit.
- Direct digital readout, high resolution and automatic shift of decimal point.
- Easy variation of all settings; frequency, modulation and level can be varied with the and keys. The settings are changed either in single steps or rapidly by holding the key down.
- Upward or downward change of frequency in steps of any size using the Δf kHz keys.
- The level can be read out in any of five units.
- Stored settings: Whenever the modulation, the level (RF OFF) or the instrument itself is switched off, the settings remain stored and are read out automatically upon power up. Independently 40 instrument settings can be stored in the nonvolative memory.
- Incorrect entries are not accepted by the instrument; the display section involved blinks to signal an erroneous setting.

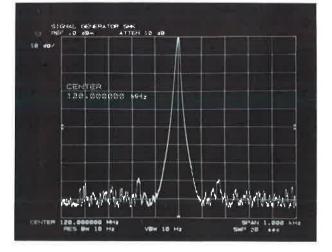
RF GENERATORS

Technical data

Frequency. The frequency range covers 10 Hz to 140 MHz. The high resolution of 1 Hz permits measurements on SSB receivers and narrowband test items. Instead of the internal frequency standard, an external control frequency of 1, 5 or 10 MHz can be used.

Level. The output level, which can be set in 0.1-dB steps from -138.9 to +19 dBm, is read out in four digits in μ V, mV, dB μ V, dBm or dBf. The level can be varied in steps of 10 dB, 1 dB and 0.1 dB. The 0.1-dB level variation is carried out without interruption of the RF level over a range of 20 dB, a characteristic that is indispensable for squelch measurements.

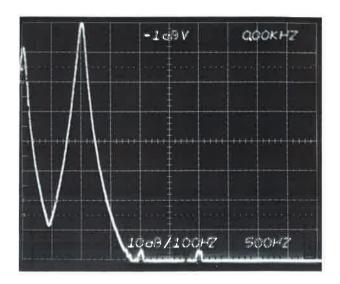
Spectral purity. The output signal is of high spectral purity. The nonharmonic spurious signals (including power-related and microphonic spuria) are typically down more than 75 dB from the carrier level. The SSB phase noise at 20 kHz from the carrier is 135 dBc down for a bandwidth of 1 Hz. Thus the spurious FM remains extremely low, being <3 Hz for a test bandwidth of 30 Hz to 20 kHz. Thanks to this high spectral purity, the SMK can be used for all critical adjacent-channel measurements and measurements on SSB receivers.



Signal quality close to carrier (suppression of hum and microphonic sidebands); resolution: 100 Hz/div., 10 dB/div.

Modulation. The Signal Generator SMK provides low-distortion, broadband AM and FM, both modes being adjustable in fine steps. The versatile modulation capability includes 2tone AM, 2-tone FM, simultaneous AM and FM, sweeping with internal or external deflection signal as well as AC and DC coupling for all modulation modes.

To connect external modulation sources, the SMK is fitted with two inputs for AM and for FM. For 2-tone modulation and simulteneous AM and FM, either the internal and an external or two external modulation sources can be used. AM and FM can be adjusted independently even with simulteneous AM and FM.



Typical FM harmonic distortion at 100 kHz deviation and $f_{mod}{=}1$ kHz; resolution: 500 Hz/div., 10 dB/div.

(Internal) modulation generators. The internal SMK modulation sources are provided by

- a generator producing low-distortion sinewave signals of 150/400 Hz, 1/3/15 kHz and
- a generator producing linear triangular sweep signals of 3/30/100 Hz.

External modulation/coupling. One modulation input each for AM and FM (AM1 and FM1) is equipped with automatic level control. This level control facility ensures that the frequency deviation and modulation depth remain within the specified tolerances over a wide range of the modulation rms voltage (between 0.5 and 2 V).

The AM modulation input AM2 is DC-coupled, the FM modulation input FM2 can be switched to AC or DC coupling.

Pilot tone input FM3. A separate pilot tone input permits variation of the stereo signal deviation while holding the pilot tone constant.

AM DC. The AM DC mode permits voltage-controlled variation of the signal amplitude. It is used when the signal generator is to be operated in an ALC loop with an external probe.

FM DC. DC coupling is required for FSK modulation. A further application in conjunction with the Vector Analyzer ZPV is the determination of crystal resonances in a test assembly which is self-tuning with the aid of a phase-locked loop. DC coupling permits sweep operation with an external triangular or sawtooth voltage. With FM DC an internal frequency counter ensures correct frequency indication; the frequency can be read out via the IEC bus.

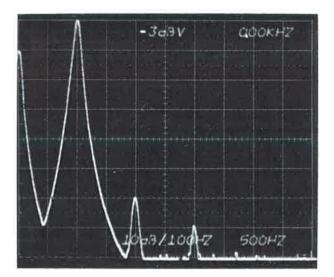


SMK 🚍 Signal Generator

Sweep. Sweeping can be controlled either by the internal triangular signal source or by an external signal via the FM2 input with DC coupling enabled. In both cases, the sweep width (max. ±500 kHz) can be selected from the keyboard.

Uses. Thanks to the extremely low spurious FM of the SMK and its high frequency stability, sweeping of crystal and ceramic filters with extremely steep skirt selectivity is possible in addition to sweeping of tuned circuits, FM demodulators, IF amplifiers or IF filters.

FM and AM characteristics. The wide FM range up to 100 kHz with small phase rotation permits high-quality stereo modulation plus transmission of the 57-kHz auxiliary carrier for traffic radio identification. With an inherent distortion factor of less than 0.1%, the SMK is ideal for all distortion measurements on VHF receivers. Amplitude modulation is possible without restriction down to the lowest carrier frequency. Thus measurements in the low-frequency and AM-IF ranges can also be performed with full capability. The extremely low AM distortion of typically only 0.2% permits measurements on high-quality AM receivers.



Typical AM distortion with m = 80% and f_{mod} = 1 kHz

SSE test input. A –20-dBm signal of 40 MHz $\pm f_{AF}$ applied to the test input is converted to the set output level and the set carrier frequency $f_{carrier} \pm f_{AF}$. Intermodulation measurements on SSB receivers, which normally require two complete signal generators, can be carried out with a single SMK by applying two signals in the vicinity of 40 MHz to the test input.

Self-test. The most important functions of the frequency synthesis are continuously monitored during operation. Errors are signalled on the display and an error message is output via the IEC bus.

Specifications	
Frequency	
Range	
Setting	stepwise or continuous variation (see
Display	"Ease of operation", page 46) 9-digit readout (LCD),
Error	resolution 1 Hz
	(±1 digit for FM DC)
Setting time (after receiving last character via IEC bus)	<40 ms (to within 100 Hz from final
Reference frequency	frequency)
	external source
Internal reference oscillator	standard option SMS-B1
Temperature effect	<2 × 10 ⁻⁸ /day <2 × 10 ⁻⁹ /day <1 × 10 ⁻⁶ /°C <2 × 10 ⁻⁹ /°C 30 min 15 min
Warmup time Output/input for int./ext.	30 min 15 min
Output/input for int./ext. reference frequency	common female connector, fret 1 MHz/5 MHz/10 MHz
	(internally selected)
Output voltage with internal reference	TTL level
Input voltage with external	>100 mV, sinewave or TTL level
	2100 mv, sinewave of TTL level
Output level	
Level range for CW and EM	138.9 to +19 dBm
for AM	(0.025 μV to 2 V into 50 Ω)
	(0.025 μV to 1 V)
Level units displayed	mV, μV, dBμV, dBm, dBf 0.1 dB
hange of variation without	10 dB (20 dB with special function)
Total error of RF level	
(including frequency response) Frequency response flatness	<1 dB
Output impedance	50 Ω (BNC female connector)
Level switchoff (RF OFF)	switchover to minimum output level:
	output impedance remains unchanged
Level at RF output 2	50 mV ¹) (for CW and FM)
Spectral purity	
Harmonics	down >30 dBc, typ. >36 dBc down >65 dBc, typ. >75 dBc
Microphonic and power-related spuria	
Noise referred to 1-Hz bandwith	
(see also diagram on page 46) SSB phase noise	
20 kHz from carrier 5 kHz from carrier	down >130 dBc, typ. 135 dBc down >125 dBc, typ. 130 dBc
Wideband noise	
Spurious FM (rms)	dow >140 dBc ¹) (for CW and FM) <1 Hz (CCITT)
	<3 Hz (30 Hz to 20 kHz)

1) When level VAR readout is 0 dB.

RF GENERATORS 2

Modulation		Sweeping	
Modulation modes in	tomoly AM EM and awaan	Internal frequencies	2/20/100
	with triongular signal	Sweep width	0.05 to 50
e)	demal: AM AC/DC EM AC/DC	Resolution	
exectione AM	MINT + AM EXT (AM2 connector)	Swept output signal	±5 V, tria
10			at female
2	× AM EXT (AM 1 and AM 2		
00	nnectors)	Input for SSB test signals	
-tone FM	M INT + FM EXT (FM2 connector)	Frequency	40 MHz -
10		Level	-20 dBm
	× FM EXT (FM1 and FM2		lower leve
	onnectors)		lower out
+ FM un man course ar	ny combination of AM, FM, ext., int.	Third-order intermodulation	_
al modulation si	newave 150 Hz, 400 Hz, 1 kHz,	products with two input signals d ₃ in sideband with J3E	
	kHz, 15 kHz;	d ₃ in sideband with J3E	down >6
SV	veep 3 Hz, 30 Hz, 100 Hz	d ₃ /∆f ≧30 kHz	down >6
quency error			
npuis Al	ME: 1 V einewere +5 V eweene		
	MF: 1 V sinewave, ± 5 V sweep; $_{\text{rot}} = 600 \Omega$	Programming and data output	
mal modulation 40	$u_1 = 000.02$		IEC COL
nal modulation uts	M1 EM1 on front panel	System Connector	24 1020-
	M1, FM1 on front panel, M2, FM2, FM3 on rear panel; puts AM1 and FM1 provided with	Interface functions	
in	puts AM 1 and FM 1 provided with	menace functions	16 bas
			L4 bas
put impedance	00 Ω (AM1, FM1), 10 kΩ (AM2, FM2,		L4 Das
	101		SR1 ser
put level (V _{ms}) ²)0.	5 < V < 2 V for AM1 FM1.		CON CON
1	V for AM2, FM2, FM3		RL1 rem
			con
			DC1 dev
plitude modulation			com
dulation frequency range			
M EXT) Hz (DC) to 20 kHz		
ation frequency response	1 dB two 0.0 dB	General data	
ness for 20 Hz to 10 kHz <	E to 100%		
ulation depth setting0. solution0.	5%	Rated temperature range	
or up to $m = 80\%$	5% of set value ¹)	Storage temperature range	-40 to +
tion for $m = 80\%$ and $f_{mod} = 1$ kl		AC supply	
to 2 MHz <	0.5% typ 0.2%		47 to 420
ove 2 MHz <	1%, IVD, 0.4%	RF leakage	safety cla
Jrious AM (rms)		пг накаде	In accord
<	0.02% (30 Hz to 20 kHz)		(spurious on conne
lental oM for m = 30%			(limit valu
f _{mod} = 1 kHz <	0.1 rad		grade K)
		Shock and vibration resistance	shock-tee
		energy and the diot roold and the second	DIN 40.04
aquency modulation			vibration-
equency modulation			DIN 40 04
odulation frequency range			correspor
or FM EXT AC	Hz to 100 kHz		68-2-27 a
or FM EXT DC D	C to 3 kHz	Dimensions, weight	
dulation frequency response			
	0.2 dB (20 Hz to 100 kHz) ³)		
quency deviation setting 0.			
Resolution up to 10 kHz dev. 0.			
up to 100 kHz dev. 0.		Ordering information	
up to 500 kHz dev. 2		ordening information	
Deviation error	3 % OF Set Value OF 10 HZ	Order designation	N Cinnel
	0.05% hm 0.02% ³		
or $f_{mod} = 1 \text{ kHz} \dots < 0$ or $f_{mod} = 100 \text{ Hz}$ to 20 kHz \dots	2.03 /0, typ. 0.02 /0 ⁻)		
tortion for stereo	J. £ 70	Accessories supplied	power co
viation = 40 kHz)			
reo crosstalk			
eo crosstaik riation = 40 kHz)do	31	Options	
	$300 > 45 \text{ dB at} = 40 \text{ Hz} \text{ to} 15 \text{ kHz}^{-3}$ $300 \text{ Hz} \text{ to} 10 \text{ kHz}^{-3}$		000 001
eighted S/N ratio		Reference Oscillator SMS-B1	
ereo (40 kHz deviation, 50 µs)	70 dB (CCIR unweighted S (M ratio3)	Overvoltage Protection SMK-B3	335.0716
fre	m 30 Hz to 20 kHz)		
ono (40 kHz deviation, 50 μs) >	76 dB (CCIR upweighted S (Miretic ³)		
(10 (12 ασγιατιστί, συ μs)	m 30 Hz to 20 kHz)		
emphasis (switch-selected)			
	or 750 µs can be link-selected		
idental AM on FM	or roo po can be intreselected		
	0.2% at carrier frequency >10 MHz ³)		
	, , , , , , , , , , , , , , , , , , , ,		

When level VAR readout is 0 dB.
 Input level required for specified accuracy.
 With FM AC.

00 Hz 500 kHz s for FM riangular le connector FM1

: ±Δf (Δf ≦500 kHz) im for set output level; vel values yield correspondingly utput level values

60 dB 60 dB

- 5-1 (IEEE 488) , Amphenol asic talker, serial poll, naddress if MLA asic listener, naddress if MTA ervice request function, omplete capability evice clear function, omplete capability

	⊦5 to +45°C -40 to +70°C
AC supply 1	00/120/220/240 V ±10%,
S	7 to 420 Hz (110 VA, 95 W), afety class I to VDE 0411
(1	n accordance with VDE 0871 spurious radiation and interference
(1	on connecting cables) and VDE 0875 limit values of radio interference grade K)
C	hock-tested in accordance with DIN 40046, Part 7 (30 g, 11 ms), and
Ċ	ibration-tested in accordance with DIN 40 046, Part 8 (11 to 55 Hz, 2 g);
6	corresponding to IEC Publications 88-2-27 and 68-2-6
Dimensions, weight	047 mm×206 mm×462 mm, 20.5 kg

Order designation	Signal Generator SMK 348.0010.02
Accessories supplied	power cord

8.02

ROHDE & SCHWARZ SIGNAL GENERATOR SMS 01-1040 MH

100

130



10400000

302.4012 28

- Universal, programmable signal generator using synthesizer technology; low-noise instrument with excellent modulation characteristics for AM, FM and phase modulation
- Compact, favourably priced instrument for use in development, production and servicing
- Ease of operation: keyboard entry, digital readout quasi-continuous variation of frequency, modulation and level
- Wide output voltage range, accurate level setting in dBm, dBμV, μV or mV

Improved characteristics

- 40 instrument settings retainable in nonvolatile memory
 - Conversion of level units possible



Characteristics, uses

With its excellent characteristics the **Signal Generator SMS** meets all the exacting demands that can be made on a general-purpose signal generator of the latest state-of-theart. The **synthesizer technology** ensures crystal-controlled and stable output frequencies with 100-Hz resolution and negligible spurious modulation. At 20 kHz from the carrier the signal-to-noise ratio is about 120 dB (1-Hz bandwidth).

The compact SMS is easy to carry and also suitable for mobile use. Thanks to a number of option, inexpensive adaptation to various applications is possible.

Stable output signal of high accuracy

Frequency. The wide frequency range from 100 kHz to 520 MHz covers all sound broadcasting ranges from MF up to VHF as well as the frequencies of the most important RT bands and radio services up to UHF. The range can be extended up to 1040 MHz with the aid of the Frequency-range Extension Option SMS-B2.

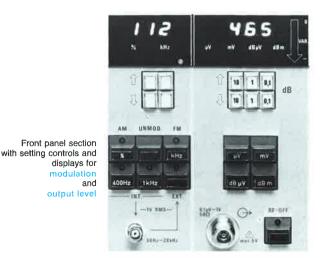
The frequency is read out with a resolution of 100 Hz. The Reference Oscillator Option SMS-B1 (aging $<1 \times 10^{-6}$ /year) further enhances the accuracy. A reference frequency input is provided on the rear panel of the signal generator. The Δf keys permit easy channel stepping with any desired step size. The output signal features low spurious deviation, only 3 Hz (CCITT) or 15 Hz (30 Hz to 20 kHz). The S/N ratio 20 kHz from the carrier is greater than 120 dB at a test bandwidth of 1 Hz, and typically 145 dB at 1 MHz from the carrier.

Modulation. The SMS features excellent modulation characteristics. AM up to 95% and FM up to 125 kHz deviation are possible with the aid of the internal modulation generator (400 or 1000 Hz) or with an external signal. The modulation frequency and modulation depth or deviation can be accurately set from the smaller keyboard and are read out with a resolution of 0.05/0.5% or 50 Hz/500 Hz/1kHz.

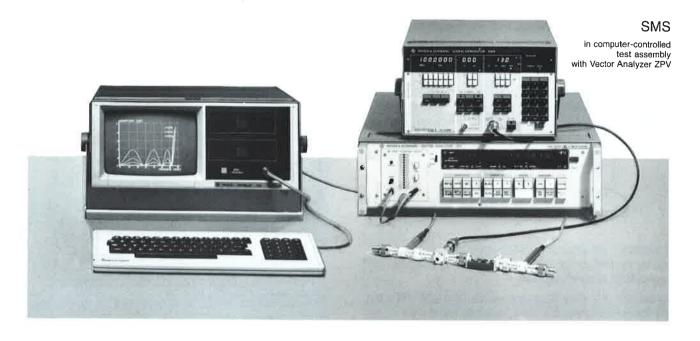
The maximum frequency deviation of 125 kHz is available over the entire frequency range. The high resolution of the frequency deviation of 50 Hz is helpful when testing transceivers. In addition to AM and FM, the SMS offers the following types of modulation:

- AM+FM together
- phase modulation (φM)
- frequency-shift keying for data transmission (FSK)
- external level control (ALC)
- stereo modulation (with model 26)

The output level is adjustable from +13 to -137 dBm with a resolution of 0.1 dB, the error being typically 0.8 dB. Entry is in μ V, mV, dB μ V and dBm via keyboards. Its minimum output voltage of 0.03 μ V makes the SMS also suitable for measurements on future, extremely sensitive receivers. Noninterrupting level variation over 10 dB in 0.1-dB steps is indispensable for squelch measurements. The output level can switched off by means of the <code>FF-OFF</code> button so zero adjustment of measuring instruments is very convenient. RF leakage of the SMS is minimal, i.e. even receivers with a sensitivity of 0.2 μ V (e.g. paging receivers) will not respond at a distance of 10 cm from the front panel.



RF GENERATORS 2



IEC-bus programming

The Signal Generator SMS can also be put to use in computer-controlled test assemblies via the IEC-bus interface. Its extremely short setting time of only 40 ms makes it capable of high-speed computer-controlled frequency response measurements - even with high resolution. The control instructions are in accordance with IEC standard 625-1. Each instruction consists of a header, the numerical value and a comma as the delimiter. The numerical value is entered in unformatted form with or without sign and with or without decimal point.

Level: -23 dBm

Programming instruction Frequency: 122.19 MHz A122.19, S-23, Modulation: AM, 30% B30,

Options

A number of options permit flexible, low-cost adaptation of the SMS to various or special requirements. All options listed below can be included in the SMS prior to delivery or incorporated later.

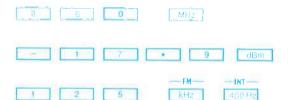
Temperature-controlled Reference Oscillator SMS-B1 improves the frequency stability of the signal generator. By means of temperature control the frequency drift of ${<}{\pm}1{\times}10^{-6}{/}^{\circ}C$ is reduced to merely ${<}{\pm}1{\times}10^{-7}$ over the operating temperature range, the aging of the crystal is less than 5×10^{-8} /month.

1.04-GHz Frequency Range Extension SMS-B2 doubles the SMS frequency range (i.e. to 1.04 GHz), the full setting range of the output level being maintained. The harmonics and subharmonics ($\frac{1}{2}f, \frac{3}{2}f...$) are typically 20 dB down. For applications up to 1000 MHz another version of the option SMS-B2 with the same characteristics but a different order number is available: see options and recommended extras on page 53.

Ease of operation

Simple keyboard entry. The function keys and the associated displays for frequency, modulation and level are arranged in three sections on the front panel for useroriented operation. The parameters are entered in ordinary notation, first the numerical value and next the unit.

Example: For entry of a frequency of 360 MHz, a level of -17.9 dBm, and frequency modulation with 125 kHz frequency deviation and 400 Hz internal modulation frequency simply press the following keys:



Storage of device settings. Up to 40 device settings can be stored in a nonvolatile memory using the STO key and recalled with the RCL key.

Example: Storage of complete device setting at memory location 3:

Keys pressed Recalling

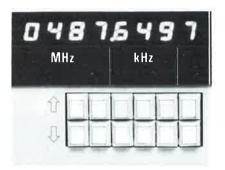
When switching off the modulation and the level (RF OFF) and upon powering down, the setup remains stored.

Example: The frequency modulation setting is switched off by means of the key **LINKOD** and switched back on again by means of the key kHż

Easy variation of all settings. Frequency, level and modulation can be varied by means of the keys 11 and which are associated with the various digits of the displays. The selected digit is varied in unit steps with automatic carry to the next digit either by one step per keystroke or (if the key is held down) continuously. Rapid coarse tuning in 10-MHz steps as well as fine tuning in 100-Hz steps is possible.

signal generators

SMS E Operation



Keys associated with the various digits permit stepwise or continuous variation of numerical values entered (e.g. frequency as here displayed)

Frequency variation with channel stepping. The Δf kHz keys (see photograph below) permit channel stepping with any desired channel step size.

Example: For entry of a frequency step of +12.5 kHz press the following keys on the large, main keyboard:



For each additional step in the positive or negative direction all there is to do is to press the + or - $\Delta t \text{ kHz}$ key. The selected step size is preserved until it is overwritten by a new entry.



Keys for freely selectable frequency steps in positive or negative direction

Noninterrupting fine level adjustment. The keys in and (0.1 dB) permit noninterrupting electronic adjustment of the level in 0.1-dB steps over a range of 10 dB (indispensable for squelch measurements), the corrected value being read out on the level display. The state of the electronic level variation can be seen from an LED array (see photograph below).





The 0.1-dB keys are used for noninterrupting electronic fine level adjustment. The state of the electronic level variation can be seen at a glance from the LED array

Specification of SMS

Frequency range	. 0.1 to 520 MHz, with Option SMS-B2 up to 1040 MHz
Frequency setting	from keyboard
Readout	. 8-digit display
Resolution	. 100 Hz
	. depending on reference frequency
Reference oscillator	
Crystal aging	$<\pm1\times10^{-6}/\text{month}$ $<\pm5\times10^{-8}/\text{month}$
Temperature effect	. <±1×10 ⁻⁶ /°C <±1×10 ⁻⁷ within operating
	temperature range
Warm up time	
Output/input for internal/externa	l referenz frequency, 10 MHz
(single connector)	
Output	. >0.5 V (sinewave) or TTL levels
Output level with CW/FM	137 to +13 dBm
with AM	(0.03 μV to 1 V into 50 Ω) -137 to +7 dBm
	(0.03 uV to 0.5 V into 50.0)
Setting Readout	from keyboard
Headout	in μV, mV, dBμV or dBm
Resolution	- 0.1 dB
	. 0 to -10 dB with 0.1 dB resolution,
Error of output level	without interruption of RF level $\leq \pm 1$ dB + frequency-response error ¹)
Frequency response flatness	$\leq \pm 1$ dB + frequency-response error) $\leq \pm 0.5$ dB from 8 to 520 MHz
	≦±1 dB at <8 MHz
Level reduction with RF OFF	. >80 dB
Output Output impedance	50 Ω. N female connector
VSWR	≤ 1.2 (for level ≤ -3 dBm) ¹)
Overvoltage protection	protects the RF output from externally
	applied RF (1 to 1000 MHz) or DC voltage
Max. input power	30 W
Max. input DC voltage	. 35 V
Spectral purity	
Harmonics	$d_{OWD} \ge 30 dBc^2$
Nonharmonic spurious signals	down $\ge 60 \text{ dBc}^2$) ($\ge 5 \text{ kHz from carrier}$)
Sourious deviation rms	
0.3 to 3 kHz	≦4 Hz (weighted in accordance with CCITT)
0.03 to 20 kHz	
Courieus AAA	
Spurious AM, rms	
0.03 to 20 kHz	
	typ. down 120 dBc ²)
0.03 to 20 kHz	typ. down 120 dBc ²) (test bandwidth 1 Hz, 20 kHz from car-
0.03 to 20 kHz Single-sideband phase noise (see also diagram below)	typ. down 120 dBc ²)
0.03 to 20 kHz Single-sideband phase noise (see also diagram below) Single-sideband broadband	typ. down 120 dBc ²) (test bandwidth 1 Hz, 20 kHz from car- rier)
0.03 to 20 kHz Single-sideband phase noise (see also diagram below) Single-sideband broadband	typ. down 120 dBc ²) (test bandwidth 1 Hz, 20 kHz from car-
0.03 to 20 kHz Single-sideband phase noise (see also diagram below) Single-sideband broadband	typ. down 120 dBc ²) (test bandwidth 1 Hz, 20 kHz from car- rier) typ. down 145 dBc ²) (test bandwidth
0.03 to 20 kHz Single-sideband phase noise (see also diagram below) Single-sideband broadband noise	typ. down 120 dBc ²) (test bandwidth 1 Hz, 20 kHz from car- rier) typ. down 145 dBc ²) (test bandwidth
0.03 to 20 kHz Single-sideband phase noise (see also diagram below) Single-sideband broadband noise	typ. down 120 dBc ²) (test bandwidth 1 Hz, 20 kHz from car- rier) typ. down 145 dBc ²) (test bandwidth
0.03 to 20 kHz Single-sideband phase noise (see also diagram below) Single-sideband broadband noise	typ. down 120 dBc ²) (test bandwidth 1 Hz, 20 kHz from car- rier) typ. down 145 dBc ²) (test bandwidth
0.03 to 20 kHz Single-sideband phase noise (see also diagram below) Single-sideband broadband noise	typ. down 120 dBc ²) (test bandwidth 1 Hz, 20 kHz from car- rier) typ. down 145 dBc ²) (test bandwidth
0.03 to 20 kHz Single-sideband phase noise (see also diagram below) Single-sideband broadband noise	typ. down 120 dBc ²) (test bandwidth 1 Hz, 20 kHz from car- rier) typ. down 145 dBc ²) (test bandwidth
0.03 to 20 kHz Single-sideband phase noise (see also diagram below) Single-sideband broadband noise	typ. down 120 dBc ²) (test bandwidth 1 Hz, 20 kHz from car- rier) typ. down 145 dBc ²) (test bandwidth
0.03 to 20 kHz Single-sideband phase noise (see also diagram below) Single-sideband broadband noise	typ. down 120 dBc ²) (test bandwidth 1 Hz, 20 kHz from car- rier) typ. down 145 dBc ²) (test bandwidth
0.03 to 20 kHz Single-sideband phase noise (see also diagram below) Single-sideband broadband noise	typ. down 120 dBc ²) (test bandwidth 1 Hz, 20 kHz from car- rier) typ. down 145 dBc ²) (test bandwidth
0.03 to 20 kHz Single-sideband phase noise (see also diagram below) Single-sideband broadband noise	typ. down 120 dBc ²) (test bandwidth 1 Hz, 20 kHz from car- rier) typ. down 145 dBc ²) (test bandwidth
0.03 to 20 kHz Single-sideband phase noise (see also diagram below) Single-sideband broadband noise	typ. down 120 dBc ²) (test bandwidth 1 Hz, 20 kHz from car- rier) typ. down 145 dBc ²) (test bandwidth
0.03 to 20 kHz Single-sideband phase noise (see also diagram below) Single-sideband broadband noise	typ. down 120 dBc ²) (test bandwidth 1 Hz, 20 kHz from car- rier) typ. down 145 dBc ²) (test bandwidth
0.03 to 20 kHz Single-sideband phase noise (see also diagram below) Single-sideband broadband noise	typ. down 120 dBc ²) (test bandwidth 1 Hz, 20 kHz from car- rier) typ. down 145 dBc ²) (test bandwidth
0.03 to 20 kHz Single-sideband phase noise (see also diagram below), Single-sideband broadband noise	typ. down 120 dBc ²) (test bandwidth 1 Hz, 20 kHz from car- rier) typ. down 145 dBc ²) (test bandwidth
0.03 to 20 kHz Single-sideband phase noise (see also diagram below) Single-sideband broadband noise	typ. down 120 dBc ²) (test bandwidth 1 Hz, 20 kHz from car- ner) typ. down 145 dBc ²) (test bandwidth 1 Hz, 2 MHz from carrier)
0.03 to 20 kHz Single-sideband phase noise (see also diagram below), Single-sideband broadband noise	typ. down 120 dBc ²) (test bandwidth 1 Hz, 20 kHz from car- ner) typ. down 145 dBc ²) (test bandwidth 1 Hz, 2 MHz from carrier)
0.03 to 20 kHz Single-sideband phase noise (see also diagram below) Single-sideband broadband noise	typ. down 120 dBc ²) (test bandwidth 1 Hz, 20 kHz from car- ner) typ. down 145 dBc ²) (test bandwidth 1 Hz, 2 MHz from carrier)
0.03 to 20 kHz Single-sideband phase noise (see also diagram below) Single-sideband broadband noise	typ. down 120 dBc ²) (test bandwidth 1 Hz, 20 kHz from car- ner) typ. down 145 dBc ²) (test bandwidth 1 Hz, 2 MHz from carrier)
0.03 to 20 kHz Single-sideband phase noise (see also diagram below) Single-sideband broadband noise	typ. down 120 dBc ²) (test bandwidth 1 Hz, 20 kHz from car- rier) typ. down 145 dBc ²) (test bandwidth 1 Hz, 2 MHz from carrier)
0.03 to 20 kHz Single-sideband phase noise (see also diagram below) Single-sideband broadband noise	typ. down 120 dBc ²) (test bandwidth 1 Hz, 20 kHz from car- rier) typ. down 145 dBc ²) (test bandwidth 1 Hz, 2 MHz from carrier)
0.03 to 20 kHz Single-sideband phase noise (see also diagram below) Single-sideband broadband noise	typ. down 120 dBc ²) (test bandwidth 1 Hz, 20 kHz from car- rier) typ. down 145 dBc ²) (test bandwidth 1 Hz, 2 MHz from carrier)
0.03 to 20 kHz Single-sideband phase noise (see also diagram below) Single-sideband broadband noise	typ. down 120 dBc ²) (test bandwidth 1 Hz, 20 kHz from car- rier) typ. down 145 dBc ²) (test bandwidth 1 Hz, 2 MHz from carrier)
0.03 to 20 kHz Single-sideband phase noise (see also diagram below) Single-sideband broadband noise	typ. down 120 dBc ²) (test bandwidth 1 Hz, 20 kHz from car- rier) typ. down 145 dBc ²) (test bandwidth 1 Hz, 2 MHz from carrier)
0.03 to 20 kHz Single-sideband phase noise (see also diagram below) Single-sideband broadband noise	typ. down 120 dBc ²) (test bandwidth 1 Hz, 20 kHz from car- rier) typ. down 145 dBc ²) (test bandwidth 1 Hz, 2 MHz from carrier)

With fine level adjustment = 0 dB.
 dBc = relative level referred to carrier amplitude.

RF GENERATORS 2

Modulation
AM internal fmod: 400 Hz or 1 kHz
external from 8 to 520 MHz from 20 Hz to 20 kHz from 0.1 to 8 MHz from 20 Hz to 2 kHz
Modulation depth 0 to 95%
Setting from keyboard
Readout
0.5% from 10 to 95%
Error of AM≦4% of modulation-depth setting ¹)
from 8 to 520 MHz, ≦7% at <8 MHz
Modulation distortion
at m = 80%≦1.5%
at m = 90% \leq 3% Input requirement 1 V _{ms} ±1% into 600 Ω
Spurious ofM
(peak value at 30% AM) <0.1 rad
FM internal fmod: 400 Hz or 1 kHz
external
Frequency deviation 0 to 125 kHz; ≦(f _{carrier} 100 kHz) Setting from keyboard
Readout 3-digit display
Resolution
500 Hz from 10 to 99.5 kHz,
1 kHz from 100 to 125 kHz
deviation≦5%
Modulation distortion
(f _{mod} 0.4/1 kHz, deviation 75 kHz)≦1%
Distortion with stereo mod.
(10.7 and 87 to 108 MHz:
f _{mod} 50 Hz to 10 kHz;
deviation 40 kHz) <0.4%, typ. 0.2% Stereo crosstalk model 26
Stereo crosstalk model 26 (10.7 and 87 to 108 MHz;
f _{mod} 50 Hz/1/10 kHz) down typ. 40/45/45 dB
S/N ratio, referred to
40 kHz deviation (filter 31.5 to 16 kHz) typ. 65 dB
Input voltage
requirement 1 V into 600 Ω (V _{ms})
Spurious AM (20 kHz devia-
tion, FM INT.)
AM and FM \ldots 1 V into 600 Ω (V _{ms})
Additional modulation input at rear of SMS for phase modulation
(φM), 20 Hz to 8 kHz; FM, 20 Hz to 20 kHz (internally selectable) or ALC
(AM), DC to 20 kHz. Required input voltage into 600 Ω:
ALC (AM), DC-coupled 0 to +2.83 V for 0 to -40 dB
φM (V _{ms}) 1 V for 5 rad
FM (Vms) I V for 100 kHz deviation
Data of options
Option: Reference Oscillator SMS-B1 see page 52
Option: 1.04-GHz-Frequency Range Extension SMS-B2
Frequency range
Data of SMS with option SMS-B2, from 520 to 1040 MHz:
Resolution of the frequency
indication
Harmonics and sub- harmonics typ. 20 dBc ²) down
(aubharmonica 14f 34f)
Non harmonic signals >200 kHz from carrier
>200 kHz from carrier down >60 dBc ²) >5 kHz from carrier down >55 dBc ²)
Spurious deviation rms
0.3 to 3 kHzto tota ≦8 Hz (weighted in apporticiped with CCITT)
(weighted in accordance with CCITT) 0.03 to 20 kHz≦32 Hz
Single-sideband phase noise 20 kHz from carrier
20 kHz from carrier down typ. 115 dBc ²)
1 MHz from carrier
(test bandwidth 1 Hz)
(test bandwidth 1 Hz) Error of output level
error') Frequency response of level
Error of mudulation-depth
indication with AM (m <90%) $\approx 1\%$ $\leq 7\%$ +1% ¹) of reading
AM distortion (f _{mod} = 0.4/1 kHz, m = 80%)≦5%
Other specifications same as for basic unit.
¹) With fine level adjustment = 0 dB

With fine level adjustment = 0 dB.
 dBc = relative level referred to carrier amplitude.

Option: 1-GHz Frequency Range Frequency range All other specifications same as for 1 Option SMS-B2.	
IEC-bus-control	
Interface in accordance with IEC 623 operating modes and for data trans	fer in listener operation
Interface functions	AH 1 acceptor handshake
	RL 1 remote/local DC 1 device clear
Setting time	40 ms for all functions (typ. frequency error after 40 ms:
	<100 Hz)
Models	
Model 24	
Model 26Stereo capability	. see under "Modulation" (FM),
Model 28	lefthand column . 0.1 to 1040 MHz
All models fitted as standard with o	vervoltage protection
General Data	
RF-leakage	conforms to VDE 0871 and MIL STD 461 A
	in accordance with method CE 03 and RE 02 concerning spurious radiation
	and interference on the connecting cables. The SMS also complies with
	the requirements of VDE 0875 (limit values of radio interference grade K)
Stock and vibration resistance	
163/3/2/100	shock-proofed in accordance with DIN 40046, Part 7 (30 g, 11 ms);
	vibration-tested in accordance with DIN 40046, Part 8 (11 to 55 Hz, 2 g);
Deted to many the second	corresponds to IEC Publications 8-2-27 and 68-2-6
Rated temperature range	-40 to +70°C
AC supply	47 to 420 Hz;
Power consumption	safety class I to VDE 0411 60 W (80 W when fitted
Dimensions, weight	with all options) 347 mm×206 mm×370 mm, 14.6 kg
Ordering information	
Order designation . Model 24 (0.1 to 520 MHz)	► Signal Generator SMS 302.4012.24
Model 26 (0.1 to 520 MHz, stereo-compatible)	302.4012.26
Model 28 (0.1 to 1040 MHz)	

Options			
Reference Oscillator	SMS-B1	**********	302.8918.02
1.04-GHz Frequency Extension	SMS-B2		335.0016.02
1.0-GHz Frequency Extension	SMS-B2		335.0016.04
Recommended extras			

signal generators



Characteristics, uses

Front panel section

with setting controls and display for frequency

The **Signal Generator SMPC** is outstanding for its characteristics, such as high spectral purity, low spurious FM, excellent modulation quality and wide frequency range combined with high resolution. For the first time a generalpurpose synthesizer featuring such a wide frequency range and the specified signal purity offers modulation capabilities of maximum quality.

The SMPC meets all the requirements specified for **receiver measurements** – from critical adjacent-channel measurements through to distortion measurements on high-quality AM and FM sound broadcasting receivers. The SMPC can be used both as a low-noise local oscillator and a reference source in noise test assemblies.

-	MHz	FREQUENCY
tu*/tr MHz	kHz	
STEP kHz	Hz	

Thanks to its excellent frequency stability, high resolution and the digital **sweep capability**, the Signal Generator SMPC can also be used for **measurements on narrowband filters and crystals**.

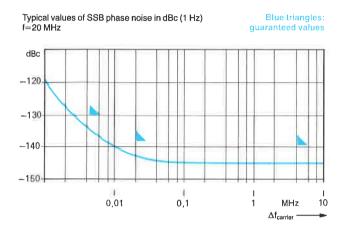
Ease of operation

- The minimum of front panel controls plus optimum layout ensures an excellent overview and the great ease of operation of the SMPC.
- Keyboard entries in the normal order numerical value and unit with direct display of the numerical value entered (above the numerics keyboard).
- Direct readout on separate digital displays with high resolution and floating decimal point.
- Quasi-continuous variation of the values selected for frequency, modulation and level using three rotary knobs leaving no room for operating errors.
- Frequency and level variations possible either in linear or logarithmic mode.
- All settings can be increased or reduced by any amount.
- Level readout can be selected either in V or dBm.

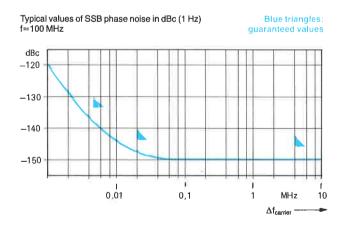
RF GENERATORS 2

Technical data

Frequency. With a slightly extended level tolerance, frequencies down to 5 kHz can be selected beyond the specified range from 50 kHz to 1360 MHz. The resolution is 0.1 Hz between 5 kHz and 1000 MHz, and 1 Hz above 1000 MHz. Up to 1360 MHz, the output signal is produced directly and not by doubling. Thus subharmonics do not exist.



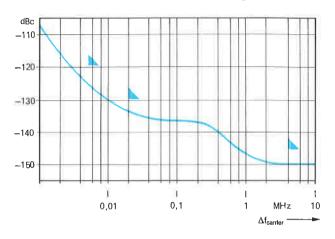
Level. The wide output level range from -143 to +13 dBm plus a resolution of 0.1 dB, the high level accuracy and the excellent frequency response flatness are especially important for measurements on receivers and wideband subassemblies. A level variation in 0.1 dB steps over the range of 10 dB without interrupting the RF signal permits also squelch measurements on radio equipment.



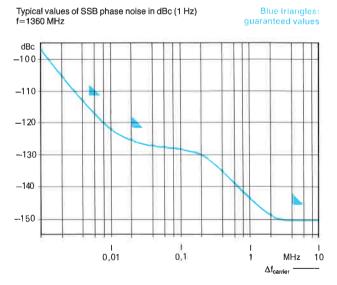
Spectral purity. Nonharmonic spurious signals are down more than 80 dB from 0.05 to 21.25 MHz, more than 90 dB between 21.25 and 680 MHz and more than 84 dB above 680 MHz. The SSB phase noise 20 kHz from a 500-MHz carrier at a bandwidth of 1 Hz is typically down 134 dBc, see the diagrams. At the lower frequencies these values even improve until the minimum wideband noise level typically –150 dBc is reached. The typical value for residual FM to CCITT is below 1 Hz at 500 MHz and below 0.2 Hz at 100 MHz. Thanks to its high spectral purity, the SMPC is an ideal noise source for all two-source measurements on RT equipment to FTZ or CEPT specifications.

Typical values of SSB phase noise in dBc (1 Hz) f=500 MHz

Blue triangles: uaranteed values



Modulation (wideband and low-noise). The Signal Generator SMPC provides AM, FM and ϕ M modulation capabilities. The modulation modes can be selected separately at the same time. The outstanding modulation characteristics (FM distortion 0.1%, AM distortion 0.5%, stereo FM crosstalk down 56 dB) permit all measurements required on AM and stereo sound broadcasting receivers. For the frequency range of wideband-modulated radio services, deviations up to 800 kHz can be set on the SMPC. The modulation generator is an AF synthesizer for 10 Hz to 100 kHz.



Digital sweep. The digital sweep capability facilitates frequency response measurements, Q-factor determination and similar tasks. The sweep limits, step widths and dwell time per step can be freely selected.

Storage. Up to 40 device settings can be stored. Even with the device switched off, the memory contents are retained for about three weeks.

Remote control. All device functions can be remote-controlled via the IEC-bus interface.

signal generators

SMPC - Signal Generator

IEC-bus commands

Satting commande consist of data (optional) and of a twocharacter combination designating the unit and/or function and serving also as a delimiter. Storage commands and special functions are terminated with numerics.

All characters can be used as separators except numerics, the decimal point, polarity signs and the letters used in the commands. Places in the data block which exceed the resolution of the SMPC are ignored.

List of most important commands

Function	Data	Command Delimiter
Set carrier frequency in MHz in kHz in Hz	up to 10 places, decimal point	МН КН НZ
Set level in dBm in mV in μV	up to 4 places, decimal point	DB MV UV
Switch RF output off on		F0 F1
Program sweep: upper limit frequency MHz lower limit frequency MHz step width kHz single sweep upwards downwards periodic sweep	up to 10 places, decimal point	FU FL SK SU SD SP
Set AF generator in kHz	up to 4 places, decimal point	NK
Frequency/phase modulation: set deviation in kHz in rad switch on FM/φM switch off FM/φM select internal FM/φM select external FM/φM FM AC FM DC	up to 4 places, decimal point	FK PR P1 P0 P1 PE FA FD
Amplitude modulation: set modulation index in % AM on AM off internal AM external AM external level control	up to 2 places, decimal point	AP A1 A0 A1 AE LC
Storage functions Complete device setup: store recall Frequency setting: store recall Level setting: store recall	n: memory location 1 to 5	ST n RC n ST MH n RC MH n ST DB n RC DB n

Specifications

Frequency	
Range	5 kHz to 1360 MHz,
	(specifications for level and harmonics valid from 50 kHz on)
Setting/resolution	a) keyboard entry with least incre-
	ments of 0.1 Hz for f _{carrier} up to 1000 MHz
(Fragueneu veriation)	1 Hz for f _{carrier} >1000 MHz
(Frequency variation)	b) quasi-continuous with rotary knob in steps of
	0.1 kHz } at f _{carrier} ≦1000 MHz 0.1 MHz }
	1 Hz]
	1 kHz } at f _{carrier} >1000 MHz 1 MHz
Frequency readout	. 10-digit display
Error referred to	$<5 \times 10^{-12}$ at f _{carrier} >21.25 MHz
	<0.8 mHz at f
Setting time (after receiving last character via IEC bus)	< 18 ms to within 2×10^{-6}
	at Icarrier >21.25 WHZ
	to within 300 Hz at f _{carrier} ≦21.25 MHz
	<43 ms to within 2 × 10 ⁻⁸
	at f _{carrier} >21.25 MHz to within 3 Hz
Defense (mark	at f _{carrier} ≦21.25 MHz
	from internal temperature-controlled crystal oscillator or external
Internal crystal oscillator	10 MHz, output: >0.2 V into 50 O
	<1 × 10 ⁻⁸ /day (after 100 days of operation)
Temperature effect	. <1 × 10 ⁻⁹ /°C
Warmup time	10 MHz ±100 Hz,
	0.2 to 2 V V _{rms} into 500 Ω,
	sine or squarewave signal or TTL level
Output level	
Range	
Resolution	(0.016 μV to 1 V into 50 Ω) 0.1 dB
Error (including frequency response) ¹)	
response)')	 <±1.7 dB (f_{carrier} ≦600 MHz) <±2.2 dB (f_{carrier} >600 MHz)
Frequency response flatness	
up to 600 MHz up to 1360 MHz	
Source impedance	50 Ω
Output level ≦ –2 dBm >–2 dBm	0.05 to 680 MHz 680 to 1360 MHz <1.2 <1.35
>-2 dBm	<1.4 <1.6 switchover to minimum output level:
	source impedance remains
Switching time for level	unchanged
	<20 ms
Spectral purity	
Harmonics for output ≦10 dBm	
12 dBm	. >25 dBc (typ. 30 dBc) down . none
Nonharmonic spurious signals	. Horig
(at ≧1 kHz from carrier) at f _{carrier} ≦21.25 MHz	>80 dBc down
>21.25 MHz	. >90 dBc (typ. 100 dBc) down
>680 MHz	
Signal-to-noise ratio, referred to 1-	
Carrier Carrier spacing 20	r frequency 100 500 1360 MHz
SSB phase 5 kHz >130	>134 >120 >111 dBc down
noise 20 kHz >138	>143 >130 >121 dBc down
Wideband noise 4 kHz >140	>145 >145 >145 dBc down
1 A 1 A 1 A 1 A 1 A 1 A 1 A 1 A 1 A 1 A	
Modulation generator Frequency range	10 Hz to 100 kHz
Resolution up to 10 kHz	1 Hz
above 10 kHz	. 10 Hz
Frequency response flatness	. <0.1 dB
Level at rear output	. 1 V _{rms} into 600 Ω , Z _{out} = 10 Ω . <0.1%
Harmonics	. typ. >65 dBc down
Nonharmonics Phase-coherent frequency switchin	
Switching time (after receiving	
last character via IEC bus)	. <10 ms
 Applies only if special function RC disabled. 	L 94, noninterrupting level variation, is
uisabicu.	

RF GENERATORS 2

Amplitude modulation	
Modes	internal, external, external DC-coupled for level
Modulation frequency, internal	control with external probe
	DC oder 10 Hz to 50 kHz
flatness up to 10 kHz	<0.4.40
up to 50 kHz	<1.0 dB
Modulation depth	
Setting error at 1 kHz/≦80% up to 500 MHz	<3%) of set
above 500/1000 MHz Incidental φM, peak value	<6%/<10%) value <0.1 rad (at 1 kHz and m = 50%)
Modulation distortion	 see diagram for m = 80%, output ≦6 dBm
	(typical values, triangles: guaranteed values)
å 10 t	
3	
	4
u 1	
0,3	
0,1	
10 100 Hz	10 kHz 100
	(mod
Frequency modulation	
Modes	internal, external, AC, DC; preemphasis 50 µs, 75 µs
Modulation frequency, internal	10 Hz to 100 kHz DC or 10 Hz to 125 kHz
Modulation frequency response flatness	
internal, 10 Hz to 100 kHz	
40 Hz to 15 kHz external, 10 Hz to 125 kHz	<0.1 dB
40 Hz to 53 kHz	₀ <0.2 dB ₀ see diagram
kHz	
1600	
B00	
400	
200	
100	
50	
0,05 21,25 42,5 8	35 170 340 680 MHz 1360
	f _{carrier}
Resolution of deviation setting	<1% of set value or 10 Hz
Deviation error (at fmod = 1 kHz) Modulation distortion	
at 50% maximum deviation	<0.1% bei 1 kHz <0.3% at 20 kHz
with stereo (40 kHz deviation, f _{carrier} <21.25 MHz or 85 to 170	
	<0.1% at 1 kHz >45 dB down at 40 Hz to 15 kHz
Unweighted signal-to-noise ratio	56 dB at 500 Hz to 10 kHz
Stereo (40 kHz deviation, 50 µs) f _{carrier} <21.25 MHz or 85 to 170	
MHz	>76 dB
Preemphasis (switch-selected)	50 µs, 75 µs
Additional deviation error Incidental AM at fmod = 1 kHz and	<2%
40 kHz deviation Carrier frequency error when	
switching to FM DC	<1 × 10 ⁻⁶ for f _{carrier} >21.25 MHz <155 Hz for I _{carrier} ≦21.25 MHz
Recalibration occurs each time FM A	AC or FM OFF is selected.
Phase modulation Modes	internal and external
Modulation range	10 Hz to 8 kHz
	ooo aayram

200	
100	
50-	
25.	
12.5	
6.25	
0,05 21,25 42,5	85 170 340 680 MHz 1360
0,00 21,20 42,0	85 170 340 680 MHz 1360
Error of deviation setting	 <0.05 dB up to 3 kHz, <0.1 dB up to 8 kHz <0.2% <0.1%
Dwell time	 normally 18 ms per step, progra
Voltage swing at X-output	5 V (BNC female)
Max. permissible RF power Max. permissible DC voltage	ternally applied RF or DC voltages
General Data	and the second
2200 N.C.	15 to 145%
Rated temperature range Storage temperature range AC supply	 −40 to +70 °C 115/125/220/235 V ±10%, 47 to 420 Hz, 220 VA, 150 W,
	safety class I to VDE 0411 conforming to VDE 0871 (spurio radiation and interference on co
RF leakage	necting cables) and VDE 0875 (limit values of radio interference
	necting cables) and VDE 0875 (limit values of radio interference grade K)
RF leakage	necting cables) and VDE 0875 (limit values of radio interferenc grade K) - shock test to DIN 40060, Part 7 (30 g, 11 ms) and vibratio to DIN 40046, Part 8 (11 to 55 H g) corresponding to IEC Publica 68-2-27 and 68-2-6
RF leakage	necting cables) and VDE 0875 (limit values of radio interference grade K) - shock test to DIN 40 060, Part 7 (30 g, 11 ms) and vibratio to DIN 40046, Part 8 (11 to 55 H g) corresponding to IEC Publica 68-2-27 and 68-2-6
RF leakage	necting cables) and VDE 0875 (limit values of radio interference, grade K) shock test to DIN 40 060, Part 7 (30 g, 11 ms) and vibratio to DIN 40046, Part 8 (11 to 55 H g) corresponding to IEC Publica 68-2-27 and 68-2-6 470 mm×162 mm×485 mm, 2
RF leakage Mechanical stress capacity Dimensions, weight	 necting cables) and VDE 0875 (limit values of radio interference, grade K) shock test to DIN 40 060, Part 7 (30 g, 11 ms) and vibratio to DIN 40046, Part 8 (11 to 55 H g) corresponding to IEC Publica 68-2-27 and 68-2-6 470 mm×162 mm×485 mm, 2 Signal Generator SMPC 300.1000.52

2 SYNTHESIZERS

signal generators



Characteristics, uses

The **Synthesizer Generator XPC** largely corresponds to the SMPC described in the preceding pages – this relationship is not limited to the outer appearance and is evident at the first glance but it also applies to the characteristics of the XPC, such as high stability and spectral purity of the signal, wide frequency and level range together with short setting times, are identical with those of the SMPC except for the fact that the XPC cannot be modulated.

The range of <u>applications</u> for a generator which cannot be modulated is so varied that, due to its considerable price advantage, the XPC holds an important position as against generators with modulation capability, in particular when setting up automatic test assemblies:

- Especially stable and low-noise oscillator (LO)
- Reference source in noise test assemblies
- Signal source in RF test assemblies for determining twoport parameters (e.g. with the ZPV)
- Use in calibration laboratories
- Generator for measurements on steep-edged filters and on crystals

XPC used as precision signal source in test assembly for s parameters

Digital sweep. The digital sweep capability enables measurement and display of frequency response characteristics, selectivity curves, etc.

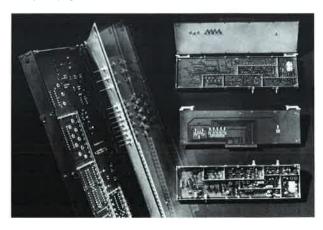
Remote control. All settings can be remote-controlled via the IEC-bus interface (IEC 625-1) which is fitted as standard. Thanks to the short setting times (18 ms for frequency) the XPC is ideally suited for use in automatic test assemblies.

Design

All RF subassemblies, except for the attenuator and output amplifier, are designed as plug-in, RF-leakage-proof boards. The new screening technique used affords easy access of the PC boards for servicing. The power supply and data bus lines as well as noncritical signal lines are routed via a motherboard, thus cable harnesses becoming a thing of the past.



Example of plug-in RF boards in new technique as used in XPC



SYNTHESIZERS 2

Specifications Frequency

 Frequency
 5 kHz to 1360 MHz, (Specifications for level and harmonics valid from 50 kHz on)

 Frequency setting
 a) keyboard entry with least increments of 0.1 Hz for fourter

 <1000 MHz 1 Hz for f_{carter} ≥1000 MHz
 b) quasi-continuously with rotary knob in steps of (Frequency variation) 0.1 Hz 0.1 kHz 0.1 MHz at f_{carrier} <1000 MHz Hz at f_{carrier} ≧1000 MHz kHz MHz and logarithmic with variable step size of 0.01 to 50% Error referred to reference frequency <0.8 mHz for $f_{carrier} \leq 21.25$ MHz <5 × 10⁻¹² for $f_{carrier} > 21.25$ MHz Setting time (incl. 15 ms for computer) fcarrier ≤21.25 MHz <18 ms to 300 Hz <43 ms to 3 Hz <18 ms to 2 × 10⁻⁶ <43 ms to 2 × 10⁻⁸ fcarrier >21.25 MHz Reference frequency from built-in crystal oscillator or external 10 MHz, output >0.2 V_{ms} into 50 Ω <1 × 10⁻⁸/day (after 100 days of operation) <1 × 10⁻⁹/°C 15 min Built-in crystal oscillator Crystal aging Temperature effect Warmup period External control ... 10 MHz \pm 100 Hz, 0.2 to 2 V ms into 500 Ω , sine or squarewave signal, TTL levels possible **Output level** $\begin{array}{l} -143 \mbox{ to } +13 \mbox{ dBm} \\ (0.016 \mbox{ } \mu V \mbox{ to } 1 \mbox{ V into } 50 \mbox{ } \Omega) \\ from keyboard in \mbox{ dBm, } mV \mbox{ and } \mu V \\ 0.1 \mbox{ dB} \mbox{ (four digits)} \\ in \mbox{ dBm, } mV \mbox{ and } \mu V, \\ four \mbox{ digits with floating decimal point} \\ < \pm 1.7 \mbox{ dB} \mbox{ (fcamter} $ \le 600 \mbox{ MHz}) \\ < \pm 2.2 \mbox{ dB} \mbox{ (fcamter} > 600 \mbox{ MHz}) \end{array}$ Range Setting Resolution Readout Error (incl. frequency response)1) Frequency response flatness up to 600 MHz up to 1360 MHz <1 dB <2 dB Source Impedance . 50 Ω VSWR)¹) Output level <-2 dBm 0.05 to 680 MHz 680 to 1360 MHz <1.2 <1.4 <1.35 <1.6 >-2 dBm Level switchoff (RF OFF) switchover to minimum output level: source impedance remains unchanged Switching time for level variations <20 ms Spectral purity of output signal (dBc: relative level referred to carrier amplitude) Interfering signals: Harmonics for output ≦10 dBm >30 dBc (typ. 35 dBc) down Signal-to-noise ratio (referred to 1-Hz bandwidth): Carrier frequency 500 1360 Carrier spacing 20 100 MHz SSB phase noise 5 kHz >130 >138 >134 >143 >120 >111 >121 dBc dBc 20 kHz Wideband nolse >4 MHz >140 >145 >145 >145 dBc Typical values of SSB phase noise are given in the diagrams under SMPC on page 55.

 Applies only if special function RCL 94, noninterrupting level variation, is disabled.

Digital sweep	
Modes	single sweep upwards and down-
Surger width	wards, periodic sweep (triangular)
Sweep width	frequency range
Step size	frequency range
	logarithmic 0.01 to 50% per sten
Voltage swing at X output	5 V (BNC female)
Programming and data output	
System	IEC 625-1 (IEEE 499)
Connector	24-way Amphenol
Connector Interface functions	T6 basic talker, serial poll,
	unaddress if MLA
	L4 basic listener,
	unaddress If MTA SR1 service request function,
	complete capability
	RL1 remote/local function,
	complete capability
	DC1 device clear function,
	complete capability
Option Overload Protection	
SMPC-B2	protects the RF output against exter-
Max. permissible RF power	nally applied RF and DC voltages
Max. permissible DC	30 W
voltage	35 V
Response indication	LED in RF OFF key
General data	
Rated temperature range	+5 to +45°C
Storage temperature range	-40 to +70°C
AC supply	115/125/220/235 V ±10%
	47 to 420 Hz (120 VA), safety class I
RF leakage	to VDE 0411
	radiation and interference
	on connecting cables)
	and VDE 0875 (limit values of radio
Mechanical stress capacity	interference grade K) shock test to DIN 40046
inventation of eas capabily	Part 7 (30 o. 11 ms) and vibration test
	to DIN 40046, Part 8 (11 to 55 Hz,
	2 g); corresponding IEC Publications
Dimensions walsh	68-2-27 and 68-2-6
Dimensions weight	470 mm×162 mm×485 mm, 21.5 kg
Ordering information	
Ordering information	
Order designation	Synthesizer Generator VDC
	337.8014.52
Accessories supplied	
	poner cable
Recommended extras	
Optioner Orienteed Destaution	

Hecommended extras	
Options: Overload Protection	
SMPC-B2	346.1019.02
RF output at rear	
XPC-B5	338.2010.02
Service Kit XPC-Z1	337.9810.02
19" Back Adapter SMPC-70	346 1210 02

signal generators



- 10 kHz to 130 MHz
- High frequency stability and spectral purity of the output signal
- Frequency counter with 1-Hz resolution
- Wide level range with negligible attenuator error, single range outputlevel setting
- Low AM and FM distortion, stereocompatible
- Frequency synchronization in 1kHz steps (with option)

Characteristics, uses

The **AM/FM Signal Generator SMUV** is an attractively priced and extremely versatile signal source for use in the laboratory, production and servicing.

Three models and five options – see page after next – make it possible to match the SMUV exactly to the application on hand.

The possibilities of **sweep operation** up to 130 MHz, of **frequency synchronization** with 1-kHz steps and of expansion into a **power signal generator**, together with stereo compatibility, make the SMUV into a general-purpose signal generator which meets all requirements up to the VHF range.

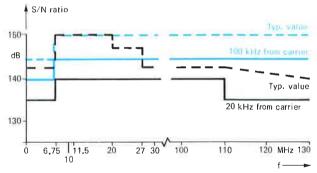
Special features such as

high frequency stability and accuracy, high spectral purity, extremely low spurious FM, very low narrowband and broadband noise, high spurious suppression and excellent RF shielding

make the SMUV ideal for precise measurements on active and passive components, subassemblies and equipment of all types such as direction finders, radiotelephones, shortwave receivers, including SSB sets, and sound broadcasting receivers. Its excellent performance data allow its use where extreme requirements for stability, spurious FM, signal-tonoise ratio and spuria rejection are to be met. Receiver measurements, in particular, require – in addition to highquality modulation characteristics – a high spectral purity of the output signal such as that of the SMUV.

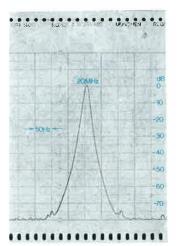
Thus it is possible to carry out all measurements such as dynamic adjacent-channel selectivity, intermodulation and crossmodulation ratios and blocking without difficulty. Thanks to the excellent signal-to-noise ratio (narrow and broadband) both close to and far off from the carrier, and to the high frequency stability – reaching synthesizer stability when the synchronizer option is used – the SMUV can be used as the

interfering source for measurements on receivers of even the highest selectivity.



Signal-to-noise ratio referred to 1 Hz as a function of carrier frequency and offset from carrier

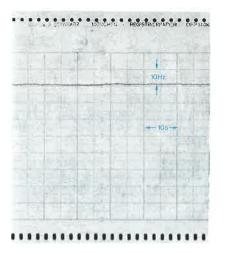
With its high rejection of spurious signals and extremely low spurious FM the SMUV is an ideal local oscillator or reference oscillator and permits signal-to-noise ratio measurements to be performed without introducing an error.



Quality of SMUV signal: sideband suppression close to carrier (hum suppression)



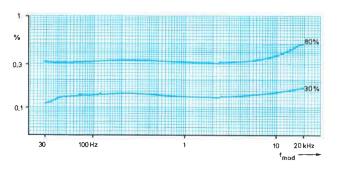
Frequency setting, frequency counter. Pushbuttons for the range selection and a tuning knob with coarse/fine drive without stop provide for rapid and reliable frequency setting, the electronic fine tuning permitting an accuracy of 1 Hz. The frequency counter reads out the output frequency of the SMUV in seven digits with a selectable resolution of 1, 10 or 100 Hz. External frequencies of 10 Hz to 130 MHz can be measured with the same resolution, the sensitivity being typically 10 mV.



Quality of SMUV signal at 20 MHz: short-term carrier stability (unsynchronized)

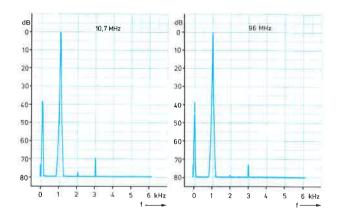
Even shortly after switch-on or selection of a new frequency range the frequency of the SMUV is so stable that measurements can be made on steep-edged filters or receivers with a narrow channel spacing. The sturdy construction of the oscillators, particularly the solid, cast frame, makes the SMUV exceptionally insensitive to mechanical vibration or acoustic interference. The long thermal time constant of the cast frame ensures that changes in the invironmental temperature have virtually no effect on the short-term stability of the frequency.

Modulation, sweeping; amplitude modulation. The very low distortion that is almost independent of carrier and modulation frequency permits measurements even on high-grade AM receivers. The low intermodulation products with multitone AM are very important when testing SSB receivers.



Typical AM distortion of the SMUV at modulation depths of 30% and 80%

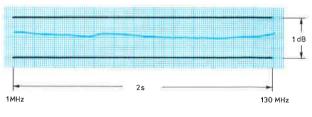
Frequency modulation is possible down to 10 kHz carrier frequency with large deviation and very little distortion. Thanks to the very low modulation distortion in the VHF and VHF-IF (see diagram) the SMUV in conjunction with a stereocoder can be used for all measurements, even on first-class stereo receivers.



Typical FM distortion at 75 kHz deviation, left: $f_{carrier} = 10.7$ MHz, right: $f_{carrier} = 96$ MHz

Narrowband sweeping – e.g. of tuned circuits, IF amplifiers, FM demodulators and filters with high skirt selectivity – is enabled by DC coupling with external FM.

Wideband sweeping. The sweep oscillator option covers the total frequency range from 0.1 to 130 MHz in three subranges which can be electronically switched over with TTL levels so that the entire range can be swept. The Sweep Unit SMLU-Z is tailored to this specific application (see next page).



Typical frequency response of Sweep Oscillator SMUV-B5

Output level. The output voltage of the SMUV of 0.05 μ V to 0.5 V into 50 Ω is continuously adjustable with a single-range attenuator, thus permitting sensitivity measurements on receivers as will as measurements on components. In conjunction with the 2-W amplifier option the SMUV delivers up to 10 V into 50 Ω in the frequency range 10 kHz to 40 MHz. The high output voltage makes good decoupling possible between the signal sources in multi-signal measurements, e.g. of intermodulation and crossmodulation. It is also indispensable when the immunity to overdriving is to be checked of amplifiers, receivers or active antennas, as well as in determining the radiation efficiency and directivity of antennas.



SMUV models

SMUV basic unit. Options may be retrofitted or incorporated in the factory prior to delivery

- SMUV model 55 with standard options Synchronizer (SMUV-B9) and Crystal Oscillator (temperature-compensated, SMUV-B1)
- SMUV model 57 with standard option 2-W Amplifier (SMLH-B3)

Models 55 and 57 can be equipped with additional options at the factory prior to delivery or retrofitted after delivery.

Options

The options are independent of one another and can be incorporated at the factory or added later to all models, following the mounting instructions supplied with them and without requiring any trimming.

Crystal Oscillator SMUV-B1. The temperature-compensated Crystal Oscillator SMUV-B1 improves the accuracy of the built-in frequency counter and moreover – in conjunction with the Synchronizer – the stability of the signal generator to 5×10^{-8} /month.

Overload Protection SMLH-B7. The overload protection option protects the RF attenuator and the output stage, should the external RF or DC voltage applied to the RF output be too high.

Synchronizer SMUV-B9. The synchronizer option brings the frequency stability of the SMUV up to the level of a synthesizer. The SMUV combines the capabilities of a highstability precision signal generator with that of a free-running signal generator of extremely low noise and with universal modulation characteristics.

SMUV as sweep signal generator

In conjunction with Sweep Oscillator SMUV-B5 and Sweep Unit SMLU-Z, the AM /FM Signal Generator SMUV constitutes a wideband sweep generator for the frequency range from 400 kHz to 130 MHz.

Free selection of sweep subranges. Through electronic switching of the three SMUV sweep frequency subranges of 0.4 to 43.5 MHz, 43.5 to 87 MHz and 87 to 130 MHz by the Sweep Unit SMLU-Z, it is possible to sweep the entire frequency range from 400 kHz to 130 MHz.



2-W Amplifier SMLH-B3. This amplifier raises the output power to 2 W (10 V into 50 Ω) in the frequency range **0.01 to 40 MHz.** The maximum permissible modulation depth is 98% up to an output signal of 4 V. For higher output signals it decreases linearly to 0% at 10 V.

Sweep Oscillator SMUV-B5. The sweep Oscillator SMUV-B5 covers the entire frequency range from 0.4 to 130 MHz in three subranges. These subranges are electronically switched so that the overall range can be continuously swept with an appropriate sawtooth generator; for instance, the Sweep Unit SMLU-Z.

Any desired subrange can be swept by setting the corresponding start and stop frequencies with two potentiometers. Another potentiometer is used to set a marker within the sweep range, its frequency being read out on the SMUV frequency counter. The marker can be displayed simultaneously as a bright spot on an external VDU. If the start or stop button is pressed, the corresponding frequency is displayed on the SMUV.

Sweep times. The sweep time is adjustable from 10 to 1000 ms; single sweeps of 2 to 200 s or manual scan from start to stop frequency are also possible.

RF GENERATORS 2

The curve display. Any standard oscilloscope with X-Y input as well as ordinary VDUs are suitable for showing the measured curves. Operation in conjunction with XY or YT recorders is also possible; the SMLU-Z is provided with outputs for the X-deflection voltage and the marker pulse.

Display driving. The SMLU-Z has an X output and a pulse output for blanking during flyback of the sawtooth.

Specifications	
SMUV basic unit	
Frequency range	
Readout Control crystal	in 7 digits 10 MHz, aging 1×10^{-5} /month option SMUV-B1: 5×10^{-8} /month
Frequency meter for ext_test frequencies	10 Hz to 130 MHz, V _{in} = 30 mV (typ. 10 mV) to 3 V
Input impedance f <10 MHz f >10 MHz Frequency tuning	5 kΩ
mechanical	coarse/fine drive ca. 100 to 500 Hz, depending on
Frequency drift unsynchronized at f ≦40 MHz	range after 2 h after 10 min after 2 h <1 kHz/5 min
at f >40 MHz	<2 kHz/5 min <1 kHz/5 min see option Synchronizer SMUV-B9
RF output Output voltage	$Z_{out} = 50 \Omega$, BNC female
Error limits	continuous $<\pm 1$ dB with V _{out} ≤ 0.2 V $<\pm 2$ dB with V > 0.2 V
Frequency response flatness	<±0.5 dB
Spectral purity S/N ratio, referred to 1-Hz bandwidth	140 (135) dB at 20 kHz from carrier
Harmonics	>30 dB typ 36 dB down
	carrier <2 Hz, typ. 0.5 Hz <7 Hz, typ. 3 Hz 10 MHz) 550 dB
Modulation	,
AM internal	fmod: 400 Hz/1 kHz
	modulation depth up to 98%, adjustable
	Voltage requirement to -1/10/
Input impedance Indicating range	10/30/100%
at m = 80%	± (5% of rdg +1,5% of fsd) 100 Hz to 10 kHz 30 Hz to 20 kHz <1%, typ. 0.3% <2%, typ. 1%
Suppression of inter-	>40 (46) dB from 100 Hz to 10 kHz <0.01%/<0.03%
	in subrange (10 to 11.5 MHz) typical values
FM internal	f _{mod} : 400 Hz/1 kHz (distortion same as with external FM)
	f _{mod} distor- tion (typ.) ∆f
external AC 0.01 to 40 MHz	
10 to 11.5 MHz	30 Hz to 100 kHz <1 0.5 \leq 100 30 Hz to 100 kHz <0.1 0.05 \leq 75
87 to 108 MHz external DC 0 01 to 40 MHz 40 to 130 MHz	30 Hz to 100 kHz <0.15 0.08 ≦75 0 to 20 kHz 0 to 100 kHz
10 to 11.5 MHz	
Frequency deviation	10 mV _p /kHz
0.01 to 40 MHz	adjustable up to 100 kHz
Modulation indicating ranges Indicating error (f _{mod} >30 Hz) Incidental AM	±(5% of rdg +1.5% of fsd)
(f = 10 kHz, f _{mod} = 1 kHz) Stereo crosstalk (10 to 11.5; 87 to 108 MHz)	
50 Hz/1 kHz/15 kHz	>40/46/46 dB, typ. 50 dB down

SMUV options

SMUV options
Crystal Oscillator SMUV-B1 10 MHz, temperature-compensated (fitted as standard in SMUV model 55)
Crystal aging 5×10 ⁻⁸ /month Frequency drift 5×10 ⁻⁸ /10 min after 15 min warmup and at constant ambient temperature
2-W Amplifier SMLH-B3 (fitted as standard in SMUV model 57)
Frequency range 10 kHz to 40 MHz Output voltage 0.5 to 10 V into 50 Ω Setting, resolution same as for basic model Error limits ±2 dB, typ. ±1 dB + error of basic unit
Harmonics with V _{out} between 0.5 and 5 V
S/N ratio referred to 1 Hz
form carrier with V _{out} between 0.5 and 2 V typ. 135 dB typ. 140 dB between 2 and 10 V. typ. 140 dB typ. 150 dB
with V _{out} between 0.5 and 4 V adjustable up to 98% between 4 and 10 V linear reduction from 98% at 4 V to
0% at 10 V Envelope distortion at m = 80% f _{carrier} = 30 MHz, V _{out} < 4 V
$ \begin{cases} f_{carrier} = 30 \text{ MHz}, V_{out} < 4 \text{ V} & < 2\%, \text{ typ. 1\%} \\ f_{carrier} = 40 \text{ MHz}, V_{out} < 3 \text{ V} & < 4\%, \text{ typ. 2\%} \end{cases} + \text{error of basic unit} \\ Indicating error at m \approx 80\% \\ f_{carrier} = 30 \text{ MHz}, V_{vac} < 4 \text{ V} & < \pm 10\% \end{cases} $
Sweep Oscillator SMUV-B5
Frequency ranges 400 kHz to 43.5 MHz
43.5 to 87 MHz 87 to 130 MHz Range switching via 36-pole female connector on rear
panel with TTL levels Sweep frequency 0 to 100 Hz,
control voltage 0 to +10 V Harmonics (1 to 130 MHz) >30 dB, typ. 40 dB down
Harmonics (1 to 130 MHz)
Overload Protection SMLH-B7
Max permissible RF power
Synchronization SMUV-B9 synchronizes the output frequency with that of the built-in crystal oscillator, disconnectible (fitted as standard in SMUV model 55)
Frequency error error of control crystal +5 Hz Frequency steps 1 kHz Max. FM modulation index approx. 10 (f _{mod} >100 Hz,
$\Delta f < 10 \text{ kHz}$
General data
Rated temperature range
Storage temperature range -40 to +70 °C Power supply 115/125/220/235 V ±10%, 47 to 420 Hz (40 to 60 VA depending
on model) Dimensions, weight
Ordering information
Order designation ► AM/FM Signal Generator SMUV (description of various models see preceding page)
SMUV, basic unit
SMUV, model 57
Accessories supplied
Recommended extras and accessories
Options: Crystal Oscillator SMUV-B1
(5 × 10 ⁻⁸)



Signal generator family SMDU – models and options

general RF m	easurements	airnav
Models* Final Structure of the second source in intermodulation and similar measurements. All SMDU models (04 to 09) are partic generator in 2- or 3-source test methods.		ents from 15 Hz to 525 MHz (1 GHz); all Iz. Specially suited for AF and RF signal
AF generator with two fixed frequen- cies: 400 and 1000 Hz	Broadcast FM quality (stereo-compatible; AF voltmeter for 15 Hz to 150 kHz. / indication. FM deviation ±500 kHz.	
page 66		110

Options 🕨

Synchronizer SMDU-B1

All models of the SMDU can be fitted with the mutually independent options. The options can be ordered together with the signal generator or - with the exception of options B8 and B9 - added later as required.

Common features

- Extremely wide frequency range and high frequency stability (drift <5×10⁻⁸/month)
- High spectral purity in respect of harmonics, spuria and noise
- Accurate output level (0.05 µV to 2 V EMF) with single-knob setting
- Precise AM, FM and φM modulation characteristics

Overload Protection SMDU-B2

1.05-GHz Frequency Range Extension SMDU-B3

> 1-GHz Frequency Meter SMDU-B4

1.05-GHz Frequency Doubler SMDU-B5

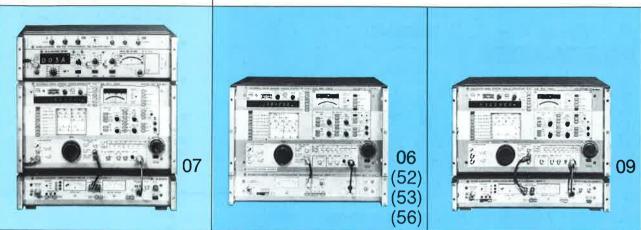
Amplitude Modulation 525 to 1050 MHz SMDU-B8

> S/N Ratio Improvement SMDU-B9

^{*)} The numerical designation of the different models (04, etc.) refers to the last two digits of the order number.

and aircoms

radiotelephones



When used with the AM Unit SMDU-Z1 or the Power Test Adapter SMDU-Z2, these models form complete AM/FM radiotelephone test sets, ideally suited for the full range of transmitter and receiver measurements. At the receiver: S/N or SINAD sensitivity, squelch performance, bandwidth, AF distortion and (using a second signal generator to feed the main channel) adjacent-channel selectivity and desensitization. At the transmitter: frequency, power, modulation (FM and, with SMDU-Z1, AM), modulation frequency (e.g. call tone) and modulation distortion. High accuracy in both simple and complex test routines. Time savings when testing multichannel units thanks to semi-automatic deviation meter and channel-to-channel tuning.

In combination with VOR-ILS unit: as for SMDU 08 plus measurements on AM/FM transmitters.

Testing of mobile hifi and stereo broadcast receivers with built-in Citizens' Band radio.

External semi-automatic deviation meter for wanted and unwanted modulation (5 Hz to 50 kHz), SINAD meter (6 to 46 dB), CCITT filter, 1-kHz distortion meter (0.5 to 50%), AF generator (30 Hz to 30 kHz and six standard test frequencies), AF rms voltmeter, autoranging. Automatic switching from receiver to transmitter measurements when used with AM Units SMDU-Z1. Complete test assembly featuring con-

tinuous monitoring of the output values of the VOR-ILS signals and built-in self-check of the most important parameters. 110 104 SMDU 06 and option B1+Z1/30 W: (52) or +Z1/60 W: (53) or +Z2/30 W: (56)

Frequency stability is improved to that of a synthesizer while the high spectral purity of a free-running oscillator is maintained. Operation is greatly simplified by the possibility of synchronized fine tuning and the channel facility.

The RF output of the SMDU is protected against externally applied power of up to 50 W. This option is fitted as standard in models 06, 07 and 09.

Extends the frequency of the RF generator to 1.05 GHz without affecting the other characteristics. Digital display of internal frequency up to 1.05 GHz; option SMDU-B4 is not required.

Extends the range of the counter to 1 GHz for external signals (high sensitivity).

Low-cost option for doubling the RF generator range to 1.05 GHz. Subharmonics and harmonics at least 20 dB below carrier level. Frequency displayed digitally.

Option B8 permits AM up to 1050 MHz when the frequency range of the SMDU is extended beyond 525 MHz (when ordering a new SMDU, B8 is already incorporated).

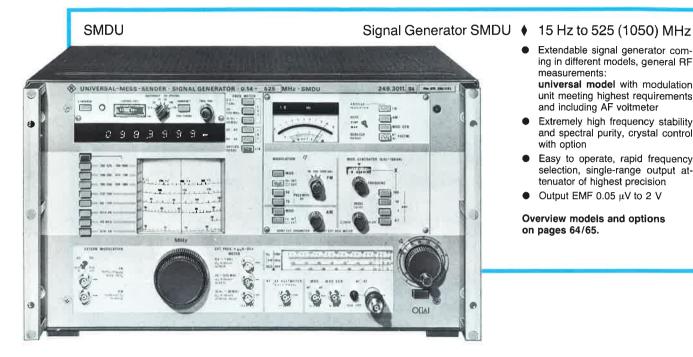
Option B9 improves the signals-to-noise ratio. e.g. for measuring the adjacentchannel selectivity far beyond 80 dB.

UNIVERSAL-MESS-SENDER - SIGNAL GENERATOR

SMDU with option SMDU-B1

SMDU with option SMDU-B2





- Extendable signal generator coming in different models, general RF measurements
- universal model with modulation unit meeting highest requirements and including AF voltmeter
- Extremely high frequency stability and spectral purity, crystal control with option
- Easy to operate, rapid frequency selection, single-range output attenuator of highest precision
- Output EMF 0.05 µV to 2 V

Overview models and options on pages 64/65.

The SMDU family of signal generators can be used for all kinds of measurements on active and passive components, modules and units. These generators are

of precise electrical performance, economical thanks to available options and versatile in application.

They comply with all national and international standard specifications for measurements on receivers and RT equipment (including aeronautical communication). Other useroriented features are:

- suitable for stereo operation at carrier and intermediate frequencies (very low modulation distortion even with multiplex signals),
- frequency locking with selectable channel spacing (radiotelephony channels) using synchronizer option,
- DC coupled FM input for narrowband sweeping.

The SMDU family comprises models for

general RF measurements, air navigation and communication. **RT** measurements

Overview on pages 64/65

In addition to these different models several options can easily be added, permitting an optimum, user-oriented system configuration.

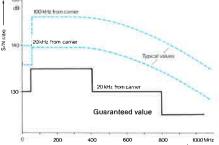
Details on the application of the SMDU for air-navigation and RT measurements are included in the discription of the corresponding test assembly.

SMDU model for general RF measurements

Universal model with AM/FM capability meeting highest requirements, internal modulation frequencies 15 Hz to 150 kHz, AF voltmeter with autoranging facility.

The SMDU includes an RF generator 0.14 to 525 MHz and a frequency meter up to 525 MHz. Any of the options available (see pages 64/65) can be incorporated. For power measurements, the power test adapter or the AM unit (which also measures modulation depth) can be used.

Frequency adjustment by pushbuttons (ranges) and continuous in-between ranges. Frequency indication: coarse on analog scale, fine by seven-digit readout. High frequency stability reached shortly after switching on permits measurements on steep-edged filters and receivers with narrow channel spacing. The SMDU reaches synthesizer stability using the synchronizer option. By means of synchronization, frequency locking is possible at the standard channel spacings. Electronic fine tuning permits the adjustment of intermediate values to an accuracy of a few hertz. Using option SMDU-B3 extends the range up to 1.05 GHz without sacrificing performance. Option SMDU-B5 also permits range extension up to 1.05 GHz, however, with reduced harmonics suppression. When adding any of the two frequency extension options, it is recommendable to order also the option SMDU-B8 (for AM up to 1050 MHz); this option is already incorporated when ordering a new SMDU with frequency extension.



Signal-to-noise ratio as a function of carrier frequency and offset from carrier at 1-Hz test bandwidth: for frequency deviations >100 kHz 6 dB less

option SMDU-B9)

Modulation (internal and external). For the universal model, AM up to 98% and FM with maximum deviation 1000 kHz (also AM+FM) with very low distortion (<0.15% at 100 kHz deviation). Switch-selected preemphasis of 50 or 75 μ s for FM. The typical distortion factor of the modulation generator (15 Hz to 150 kHz) in the AF range is 0.1%. Automatic range selection (can be switched off) and automatic selection of units (kHz, mV, %) for modulation indication. The output voltage of the modulation generator is adjustable between 5 mV and 1 V. Narrowband sweeping via the DC coupled FM input is possible.

RF output signal. Flat frequency response (output levelling) over entire level range and high-accuracy level adjustment. The high output voltage (2 V EMF) can be reduced accurately to as low as 0.05 μ V EMF by means of a singlerange attenuator with large attenuation range. The carrier can be suppressed without affecting the impedance (pushbutton). The high spectral purity of the output signal permits the SMDU to be used as interfering-signal source in multisignal measurements.

Frequency measurement. The seven-digit frequency meter of the SMDU measures all internally produced and externally applied signals from 15 Hz to 525 MHz with a maximum resolution of 1 Hz or 10 Hz. The option SMDU-B4 extends the range to 1000 MHz for external signals, the resolution then being 10 Hz. The measured frequency is available at a data output in BCD code.

AF voltage measurement. The AF voltmeter of the universal model also measures external AF voltages (averageresponsive rectification) in addition to modulation generator voltages and forms together with the modulation generator an AF level measuring assembly.

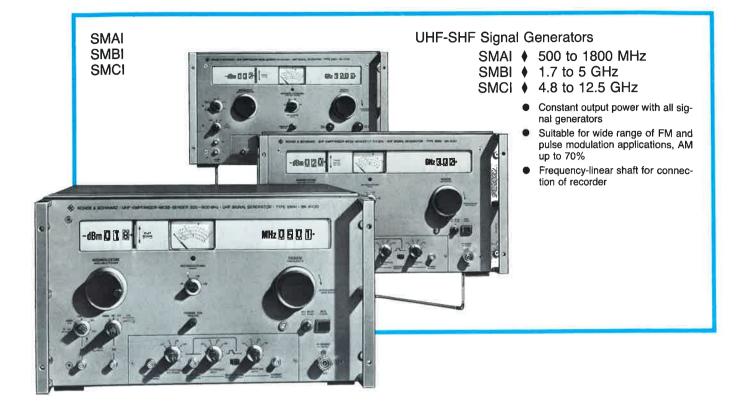
Overload protection. The option SMDU-B2 automatically prevents excessive external RF and DC voltages from affecting the output of the SMDU.

Specifications (options included)			
With 1.05 GHz 1	requency	0.14 to 525 MHz (8	
Control crystal		0.14 to 1050 MHz (7-digit readout and a 10 MHz (external: T	analog ocolo
Error limits and resolution of indication:			
	to 50 MHz 50	to 800 MHz 8	00 to 1050 MHz
Digital 1 or 10 Hz 10 or 100 Hz 0.1 oder 1 kHz Analog ±5% +300 kHz ±1% ±1%			
Frequency variation	on (within 10 min m	easuring time):	
	free-running	with synchro locked	nizer option +fine running
Warmup time	3 h	15 min	15 min
0.14 to 200 MHz 200 to 525 MHz 525 to 1050 MHz	<3 kHz	<5×10 ⁻⁸ +10 Hz	<100 Hz <5×10-7
Spacing of locking points (with synchronizar)			
	free-running	with electroni	c fine tuning
0.14 to 64 MHz 64 to 525 MHz 525 to 1050 MHz	} approx.100 Hz	<5/ to/<20 Hz <10/ to /<25 Hz <20/ to /<50 Hz	depending on spacing of
Harmonics (dB)			
Spurious responses, if any 525 to 1050 MHz: >26, typ. 30 down Incidental AM with f _{mod} = 1 kHz <1%, typ. 0.5% at 100 kHz deviation			
(for t >1 MHz) with option SMDU-B9			
	(for f >20 MHz)	

RF output N female connector (adaptable); N female connector (adaptable $Z_{out} = 50 \Omega$ $0.05 \mu V to 2 V EMF/$ -139 to +13 dBmV EMF/dBm/dBV/V into 50 Ω Output EMF or level Scale calibration (linear) Attenuator error 0.4 to 525 MHz down to 140 kHz 0.7 mm/dB or 16 mm/dB 0.25 dB ±1 dB and up to 1050 MHz $<\pm 2 dB$ pushbutton on front panel <525 MHz: <1.2; >525 MHz: <1.4 RF output (on rear panel) N female (adaptable) $\geq 20 \text{ mV}$ into 50 Ω Frequency meter (7 digits) Resol. (Hz) | Input (ext. max. 10 V) Int. 15 Hz to 50 MHz 1/10 50 to 800 MHz 10/100 50 to 800 MHz 10/100 800 to 1050 MHz 100/100 Ext. 15 Hz to 30 MHz 1/10 20 to 1000 MHz 10/100 10/100 100/1000 matched | >10 mV into 10 kΩ || 20 pF | >10 (>525 MHz: >30) mV into 50 Ω Recorder output BCD (TTL-level) Modulation AM, FM, AM + FM Mod. Generator . . . 15 Hz to 150 kHz Indication analog and digital, resolution 1 Hz Distortion factor 50 Hz to 53 kHz: <0.2%, other ranges: <0.5%V_{out} (Z_{out} = 200 Ω) . 5 mV to 1 V into 600 Ω Indication ranges 10/30/ ... /3000 mV ±(3% of rdg +1.5% of fsd) <2%, typ. 1% Error limits <2%, typ. 170 internal and external for V_{out} \leq 1 V EMF: up to 98% for V_{out} up to 2 V EMF: decreasing linearly to 30% 0.14 to 0.45 0.45 to 8 8 to 525 0.03 to 4 0.03 to 10 0.03 to 100 0.03 to 4 0.03 to 10 0.03 to 100 0.03 to 4 0.03 to 10 0.03 to 100 0.03 to 4 0.03 to 10 0.03 to 100 0.03 to 4 0.03 to 10 0.03 to 100 0.03 to 4 0.03 to 10 0.03 to 100 0.03 to 4 0.03 to 10 0.03 to 100 0.03 to 4 0.03 to 10 0.03 to 100 0.03 to 4 0.03 to 10 0.03 to 100 0.03 to 4 0.03 to 10 0.03 to 100 0.03 to 4 0.03 to 10 0. Modulation depth ... Ranges: fcarrier (MHz) f_{mod} (kHz) Distortion factor 140 to 450 kH2: <3% 3/10/30/100% 0.45 to 525 MHz: <±3% 140 to 450 kHz: <±5% 15 mV/% **Idicating ranges** Error (≦1 V EMF) V_{In} for ext. AM $f_{mod} < 4 \text{ kHz},$ m = 80% FM . internal and external Frequency deviation f_{carrier} (MHz) Deviation (kHz) ... <525 >525 0 to 500 0 to 1000 (ranges.: 10/100/1000) 15 Hz to 150 kHz if AC-coupled 0 to 150 kHz if DC-coupled 100 Hz to 150 kHz with synchronizer option fmod Distortion factor broadcast range: <0.15% Crosstalk with stereo fmod 50 Hz: >40 dB down 1 kHz: >46 dB down 15 kHz: >46 dB down Preemphasis . 50/75 μs 3/10/30/100/300/1000 Ind. ranges (kHz) Error \pm (5% of rdg +1.5% of fsd) Δ f 100 kHz: <50 mV/kHz Vin for ext. FM $(\Delta f > 100 \text{ kHz}: < 10 \text{ mV})$ AF-Voltmeter ... 15 Hz to 150 kHz 1 mV to 3 V >100 kΩ || 10 pF; BNC 10/30/ ... /3000 mV Input . Indicating ranges Error limits 15 Hz to 53 kHz 15 Hz to 53 kHz ±(2% of rdg +1.5% of fsd) 53 to 150 kHz ±(5% of rdg +1.5% of fsd) Overload protection (option) responds automatically if excessive RF power or DC voltage is applied to the RF output 50 W, 50 V Max. perm. level LED **General Data** AC supply 115/125/220/235 V ±10% Universal model Universal model with option B1 249.3011.04 249.3011.34 249.3011.08 Air-navigation model Air-navigation with option B1 249.3011.38 Accessories supplied power cable Options Options SMDU-B1: Synchronizer SMDU-B2: Overload Protection SMDU-B3: 1.05-GHz Frequency Range Extension SMDU-B3: 1.50-GHz Frequency Meter SMDU-B5: 1.50-GHz Frequency Doubler SMDU-B5: 1.50-GHz Frequency Doubler SMDU-B9: S/N Ratio Improvement 249.6340.02 249.7346.02 249,9484.02 250.0012.02 275.1312.02 295.2150.02 295,2189.02

RF GENERATORS 2

signal generators



Signal generators for UHF and SHF

Types **SMAI, SMBI and SMCI** form a family of modern signal generators which span the entire frequency range from 500 MHz to 12.5 GHz.

The signal generators are suitable for applications such as:

Measurements on receivers:	Measurements on two-port networks:
Noise figure	Reflection coefficient
Dynamic range	(using directional coupler
Control characteristics	or impedance-match bridge)
Selectivity	Attenuation constant
Conversion loss	(passband characteristic,
Image rejection	point-by-point or swept)

Uses in radar systems. Sensitivity measurement, simulation of echo pulses for checking the indication. Due to its high modulation quality, the SMAI is particularly well suited for measurements on DME and ATC equipment.

The synchronization facility makes possible measurements requiring extreme frequency stability: on narrowband AM and FM transmission systems, filters with sharp cutoffs, Doppler radar systems. Advantages of ALC. The ALC also permits amplitude modulation up to 70%. To obtain the full output power, the ALC can be switched off.

The ALC facility leads to new applications.

Attenuation measurement and recording is possible using the signal generators with ALC since the power input to the two-port network remains constant and the attenuation characteristic can immediately be seen from the output power.

Operation

Frequency setting with digital indication on roller counters. A friction drive with high gear reduction ensures both rapid tuning and high resolution. A frequency-linear shaft, accessible through the side wall, permits the connection of a recorder or control unit. Attenuation or selectivity curves can thus be plotted automatically.

The frequency stability is sufficient even for narrowband test items. Most stringent requirements – e.g. in the field of microwave spectroscopy – are met when the signal generator is synchronized with the harmonic of a crystal oscillator (second RF output) by means of suitable equipment.

RF GENERATORS 2

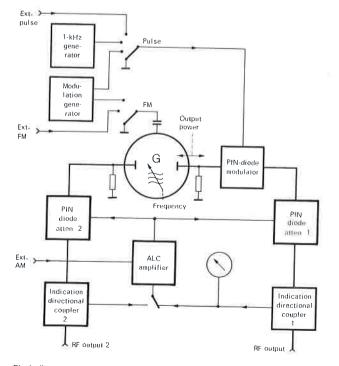
Versatile modulation characteristics are obtained when the plug-in modulation unit (to be ordered separately) or a pulse generator is employed. Simultaneous FM and pulse modulation are possible.

A PIN-diode modulator in the output circuit generates the pulse modulation with a carrier suppression of greater than 80 dB. The signal generator is designed for internal and external pulse modulation. Owing to the built-in modulation amplifier, an input voltage of 2 V is sufficient for full modulation. The signal for internal pulse modulation is delivered either by the built-in 1-kHz generator or by the plugged-in modulation unit. The latter permits adjustment of the repetition frequency, pulse width and delay and can therefore produce all commonly used radar pulses.

External frequency modulation is possible with all versions. If the modulation unit is being used, it delivers a sawtooth voltage with adjustable repetition frequency for internal FM.

The RF energy is coupled out by a piston attenuator. The available output power is indicated by the meter (large values) or can be read from the attenuator (smaller values down to -130 dBm). Constant output level is achieved by two PIN diodes. At the same time, the diodes are used for the amplitude modulation of the output signal.

During pulse modulation, an unmodulated signal is available at the second RF output; it can be applied to a frequency meter or used for frequency synchronization in the pulse mode.



Block diagram of the SMAI	with modulation unit
---------------------------	----------------------

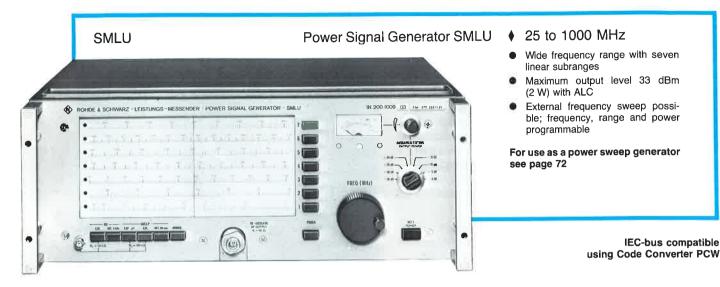
Specifications

	Specifications	;		
		SMAI	SMBI	SMCI
	Frequency range	0.5 to 1.8 GH	tz 1.7 to 5.0 GH	
	Frequency setting . Frequency indication	Irequency-lin	ear single-knob t	uning in one range
	Scale resolution	±0.5% 100 kHz/div.	+0.5%	±0.5% 1 MHz/div.
	Frequency drift due change of temperat. Residual FM	≤7 × 10-5/°C	C ≦7 × 10~5/°(≦1.5 kHz	C ≦4 × 10-5/°C ≦1.5 × 10-6
	Output level	≧+10 dBm	≧+5 dBm	≧0 dBm
	Adjustment range	(≥+8 dBm)	(≧0 dBm) +5 to	0 to -130 dBm
	Smallest readable attenuator increment	0.1 dB	-130 dBm 0.1 dB	0.1 dB
	Residual AM Amplitude variation due to ±10% AC		3 down ≧60 dB	down ≧60 dB
	supply change Output impedance . Connector	≦0.02 dB 50 Ω	≦0.02 dB 50 Ω	≦0.02 dB 50 Ω
	(adaptable)	N female	N female	N female
	Hesidual amplitude		≦2.5	≦2.5
	variation	≦ ±1 dB (≦ ±1.75 dB	≦ ±1 dB (≤ +2 dB	$\leq \pm 1 dB$
	Residual AM with AL	+att.error)		(≦ ±2.5 dB +att.error) ≦1%
	Second RF output on rear panel for frequency meter			
	Output power	or synchronize ≥−15 dBm	er ≧−20 dBm	≧-15 dBm
	Output impedance	50 Ω	50 Ω	50 Ω
	Modulation Pulse – internal			
	Repetition frequency	= 1000 Hz	1000 Hz	1000 Hz
	Pulse width Rise/fall time	0.5 ms	0.5 ms	0.5 ms
			≦100 ns	≦50 ns
	Puise – external Repetition frequency	0 to 200 kHz	0 to 200 kHz	0 to 1 MHz
	Pulse width Rise/fall time	⇔min 03 us	min. 0.3 μs	100 ns to 5 ms
	FM – external		≦100 ns	≦50 ns
	Sensitivity	500 kHz 30 (50) kHz/V	10 Hz to 500 kHz 50 kHz/V	1 Hz to 10 MHz for max. dev.:
	AM – external	$Z_{in} = 180 \Omega$	$Z_{ln} = 180 \Omega$	2 V _{pp}
	All Oxternal	100 kHz, 0 to >70%	10 Hz to 100 kHz, 0 to >70%	10 Hz to 100 kHz, 0 to >70%
	With modulation uni	t .		
	Pulse - internal			
	Repetition time	200 mc	0.02 to 200 ms	0.02 to
	Pulse width	. 0.3 to	0.3 to	200 ms 0.1 to
1	FM internal (sawtoo	1000 μs th)	1000 µs	1000 μs
	Modulation frequency	50 Hz to 50 kHz	50 Hz to 50 kHz	5 Hz to 50 kHz
	Trigger output	pos., delayed 0.1 to 1000 μs	pos., delayed 0.1 to 1000 μs	pos., delayed 0.1 to 1000 μs
1	Trigger Input	negative	negative	negative
	Synchronization			
١	Funing range	0.25 × 10 ⁻³ max. 20 V	0.25×10^{-3} max. 20 V	0.5 × 10 ⁻³ max. 20 V
(General data			
Rated temperature range				
	range: -20 to +75°C) Power supply 115/125/220/235 V ±10%, 47 to 63 Hz			
Dimensions, weight 484 mm×283 mm×512 mm, 31 kg				
Ordering information Order designations .				
J	der designations .		ator	
		SMAI 100.4594.13	SMBI 100.4607.13	SMCI 100.4613.03
M	lodulation Unit	SMAI-E	SMBI-E	SMCI-E
		100.4636.02		100.4636.02

Accessories supplied 1 power cord, 1 shortcircuit N plug

2 POWER SIGNAL GENERATORS

signal generators



The **Power Signal Generator SMLU** offers the perfect solution to all measurement problems where the output level of conventional signal generators is insufficient. Thanks to its wide frequency range, ALC and sweep facility as well as its **capability to be extended to form a system** (see page 72), the SMLU is particularly suitable for measurements

on power stages and transistors, frequency multipliers, of antenna directional patterns and impedances, of intermodulation and crossmodulation at high levels,

of attenuation, reflection coefficient and transfer

impedance of cables.

The Sweep Unit SMLU-Z extends the SMLU to a wideband power sweep generator for 25 to 1000 MHz while the Frequency Controller SMLU-Z3 permits measurement of the SMLU output frequency, synchronization, measurement of the marker frequency during swept-frequency operation and frequency programming.

Characteristics and function

For each frequency subrange, the SMLU has a separate voltage-controlled oscillator, operating at the output frequency. A diode network ensures extremely good linearization of the tuning characteristic.

The provision of ALC and a well-defined 50- Ω output open up a number of new possibilities.

Frequency selection. Pushbutton selection of frequency range, fine adjustment accurate to $\leq 1 \times 10^{-4}$ on linear scale with 0.2 to 5 MHz resolution. Manual tuning, programming and sweeping possible.

Sweeping. Either single internal sweep of one frequency subrange lasting 20 s - e.g. when using a chart recorder – or external sweep with $f_{sw} = 0$ to 50 Hz and max. sweep width = 1 subrange. The deflection voltage (sawtooth) of any oscilloscope is suitable as the sweep voltage. Frequency modulation is possible with manual or programmed adjustment of the centre frequency.

For wideband sweeping over any subrange or the total range using the sweep unit see page 72.

Modulation characteristics. In addition to FM (see under "Sweeping"), internal and external amplitude modulation of the SMLU output signal is possible. Amplitude modulation is performed via the ALC amplifier, ensuring a very linear modulation characteristic even at large depths of modulation. Internal AM: 1 kHz, m = 70%. External AM: 10 Hz to 8 kHz, m = 90% (6.5 V_{pp} for 80%).

The output power is extracted via a broadband directional coupler and kept constant by means of an ALC amplifier. The output power can be reduced continuously by 10 dB through variation of the reference level and also attenuated in 5-dB steps up to a maximum of 35 dB with a variable attenuator. Panel meter indication of level. An internal protection circuit prevents overloading of the power stages when the signal generator is mismatched.

Frequency and output-level programming

Frequency, range and output level can be programmed in parallel in BCD code, the level in steps of 0.5 dB. Via the Code Converter PCW, the SMLU can be combined with any IEC-bus-compatible measuring instruments and computers, thus forming any desired computer-controlled test assemblies.



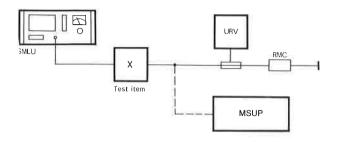
signal generators

POWER SIGNAL GENERATORS 2

Applications of SMLU

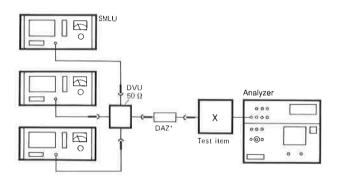
Test setup for transmission measurements

In conjunction with a broadband voltmeter (e.g. the URV 4) a dynamic range of up to 80 dB is obtained. Measurements up to 130 dB are possible using selective test equipment such as the MSUP.



Test setup for intermodulation and crossmodulation measurements

The Power Signal Generator SMLU is ideal for this purpose. Its hight output power of 2 W (1 W) enables good isolation of the three signal generators, minimizing intermodulation and crossmodulation products. The wide frequency range from 25 to 1000 MHz covers all TV bands, permitting easy measurements. Programmability makes for further simplification of the measurement; see photo on page 70.



*Matching pad if required

The three SMLUs are connected via the Four-port Junction Box DVU4 (201.4018.03). The output impedance ist 50 Ω . For measurements on 6- Ω or 75- Ω test items a matching pad (DAZ) can be used.

Matching pad 50 \rightarrow 60 $\Omega;$ 242.1013.02 (attenuation 0.79 dB)

Matching pad 50 \rightarrow 75 Ω : 242.1513.02 (attenuation 1.76 dB)

Interaction of the three signal generators is precluded by setting the output attenuator of each signal generator to an adequate value. A fine control is provided on the SMLU for fine level adjustment. If the input level at the test item is to be varied, it is best to insert an adjustable attenuator (RF Step Attenuator DPSP 334.6010.02) between the fourport junction box and the matching pad or test item.

Automatic rest setups for

intermodulation and crossmodulation measurement

RF cable measurements

see under RF test asemblies, section 3.

Specifications				
Frequency range				
119 to 210/200 to 352/337 to 595/ 570 to 1000 MHz Error of frequency indication				
Residual FM	(10 Hz to	100 kHz		
operation) . Effect of load		$100 \times 10^{-6}/10$ min 230 × 10^{-6} (between short- and		
Frequency s	ynchroniza	open-circuit) tion via 2nd RF output and frequency control output		
Output pow		LC		
7 (565 to 100 With AM: 1 to	595 MḦ́z))0 MHz) . 0 6	$ \begin{array}{c} \geqq +33 \text{ dBm} (2 \text{ W}, 10 \text{ V into } 50 \Omega) \\ \geqq +30 \text{ dBm} (1 \text{ W}, 7 \text{ V into } 50 \Omega) \\ \geqq +33 \text{ dBm} \\ \end{Bmatrix} +30 \text{ dBm} \end{array} \right\} \text{PEP} $		
Attenuation fine		-10 dB (progr. in 0.5-dB steps)		
coarse Attenuator er	rror	-35 dB in 5-dB steps ≤ ±0.12 dB per 5-dB step		
Meter Reflection co	efficient	+22 to +33 dBm (3 to 10 V)		
Connector.		N female, adaptable range 1: ≧30 dB down,		
namonica		for all other ranges see diagram		
dB	f L			
50-		Typ characteristic		
40-	1			
30-	1	Min. harmonics suppression		
20-	Overlap of fre-			
10-	quimey rang	115		
0-	fi	te .		
RF output II	(rear)			
Output powe	r	30 dB below meter indication		
Source impe	dance; cor	nector 50 Ω; BNC female		
Modulation		modulation frequency 1 kHz,		
		modulation frequency 1 kHz, modulation depth 70% 10 Hz to 8 kHz, max 80%;		
Awrexternar.		V _{in} : 2 to 12 V for 80% modulation		
Sweeping				
Internal		single sweep of one frequency subrange within 20 s		
External		0 to 50 Hz (sawtooth), max. 1 subrange,		
External swe	en Af	input requirement 0 to +10 V FM with centre frequency set by		
	ор <u>д</u> г	nanual or programmed adjustment; 0 to 8 kHz		
Output for fre	equency-	0 to +40 V, on rear,		
proportional (Shago	$Z_{out} = 10 \text{ k}\Omega$		
Remote con		•.		
Logic function Programming	n of contro) input	l inputs negative logic, TTL-compatible BCD code in parallel for frequency, range and level		
General data	Ð			
		le		
AC supply		nge -20 to +70°C 115/125/220/235 V ±10%,		
AC supply 115/125/220/235 V ±10%, 47 to 440 Hz (100 VA) Dimensions, weight				
Ordering	Ordering information			
Order designation Power Signal Generator SMLU 200.1009.03				
Recommend				
For remote conver	ter PCW (s	section 1) 244.8015.92		
Sweep Unit S	SMLU-Z (pa	or SMLÚ 245.2610.02 age 73) 243.3010.92		
Frequency Co	ontroller S	MLU-Z3 242,5019.92		

71

2 SMLU SYSTEM

signal generators



SMLU alone and with accessory units (blue): Sweep Unit SMLU-Z (centre) and Frequency Controller SMLU-Z3 (top)

SMLU System

The **Power Signal Generator SMLU** – a standard instrument for a variety of measurement tasks in the range 25 to 1000 MHz (see page 70) – is system-compatible and can be adapted with great flexibility to the particular task at hand by simply connecting the accessory units

Sweep Unit SMLU-Z,

Frequency Controller SMLU-Z3

and/or Code Converter PCW (for serial programming, see section 1).

This combination constitutes an extremely wideband sweep generator of high output level which permits very rational and time-saving execution of all broadband measurements.

The following diagram gives an overall picture of the different combinations possible and their outstanding features.

Fixed frequency

Sweep operation

SMLU • Wide frequency range Subrange sweeping High output power Frequency response \bigcirc flatness ±0.5 dB FREQUENCY SWEEP UNIT CONTROLLER Sweep width Very accurate 25 to 1000 MHz max. frequency Automatic Excellent fre-quency stability Ο range switchover . SMELL thanks to Two continuously Ο synchronization adjustable fre-External frequency quency markers FREQUENCY measurements CONTROLLER Accurate measure-Frequency and - PCW ment of the level program-• SWEEP adjustable marker mable in ASCII-UNIT • frequency \bigcirc • C SMEL Ο . SMLU Frequency pro-PCW gramming with FREQUENCY CONTROLLER high accuracy and stability SMLU system combinations • Setting time and their outstanding features • <100 ms Ο SMLU

signal generators

POWER SWEEP GENERATORS 2

Power Sweep Generator (SMLU+SMLU-Z)

The **Power Signal Generator SMLU** and the **Sweep Unit SMLU-Z** constitute a wideband power sweep generator for the range 25 to 1000 MHz.

The whole frequency range or any part thereof can be swept through. Switchover between the seven subranges is made automatically by the sweep unit during the sweep process. The start and stop frequencies can be set independently over the whole frequency range. The sweep is logarithmic so that the frequencies at the beginning of the range can be adjusted with the same relative accuracy as those at the end.

The sweep time can be varied over a wide range, enabling optimum conditions for each test item. A lamp signals unsuitable settings.

Single sweep for recorder operation and manual scan are also possible. The necessary contacts for driving the recorder are provided.

Two electronic frequency markers can be shifted independently over the whole frequency range; they appear as bright spots on the display, for instance an oscilloscope. The marker frequency is indicated on the SMLU scale with the reading accuracy of the SMLU or can be measured with an external digital frequency counter. A counter output is provided. The start or stop frequency can also be indicated by pressing a pushbutton.

The measured curve can be represented on a simple oscilloscope or an inexpensive VDU.



SMLU + sweep unit = power sweep generator

Specifications of SMLU + SMLU-Z

Sweepable frequency range Sweep width	25 to 1000 MHz or any part thereof max; total range
	min.: 0.75 × 10 ⁻³ of centre fre-
	quency
Sweep time, adjustable	
	single sweep 2 to 200 s
Output power, stability,	
harmonics content	
Frequency markers	
Marker output	
X output voltage Blanking output, switch-selected	
Switching contact for	+ 15 vp, bive lemale connector
recorder control	max 20 V/1 A
AC supply	
	47 to 440 Hz (100 + 12 VA)
Rated temperature range	
Dimensions, weight	
(SMLU + SMLU-Ž)	484 mm×260 mm×436 mm, 24 kg
Order designations	Power Sween Generator
(order units separately)	SMLU + SMLU-Z
SMLU with programming unit	
Sweep Unit SMLU-Z	243.3010.92

Frequency Controller SMLU-Z3 ♦ 10 to 1000 MHz

In addition to the Sweep Unit SMLU-Z another add-on unit to the Power Signal Generator SMLU for 25 to 1000 MHz is available in the **Frequency Controller SMLU-Z3**.

This unit gives a 6-digit frequency readout in the range of 100 Hz to 1000 MHz and is ideal for the following four tasks:

- 1. Measuring the SMLU output frequency with a resolution of 1 kHz or 10 kHz.
- Synchronization, meaning that any frequency adjusted on the SMLU can be maintained with crystal stability by pressing a button.
- 3. Accurate measurement of the marker frequency in operation with the sweep unit; sweep width is adjustable from 25 to 1000 MHz.
- 4. Programming the SMLU frequency rapidly (<100 ms) and accurately (10 kHz).

External signal frequencies from 100 Hz to 1000 MHz can also be measured; sensitivity 10 mV, resolution 10 Hz. The Frequency Controller SMLU-Z3 is driven via the second RF output of the SMLU; the frequency is indicated on a 6-digit readout.



SMLU-Z3

Specifications of SMLU-Z3

Frequency range Indication Measurement error Input 1 Frequency range Resolution	$\begin{array}{l} \mbox{6 digits (7-segment LEDs)} \\ \pm 1 \ \mbox{digit} + \ \mbox{error of timebase} \\ \mbox{Z}_{in} = 100 \ \mbox{k}\Omega \ \ \mbox{ } \ \ \mbox{30 pf (BNC)} \\ 100 \ \ \mbox{Hz to 30 MHz} \\ \ \ \ \mbox{10 Hz or 100 Hz, pushbutton-} \end{array}$
Input voltage Input 2 Frequency range Resolution Input voltage Internal timebase	$\begin{array}{l} Z_{in}=50\ \Omega\ (BNC)\\ 10\ to\ 1000\ MHz\\ 1\ kHz\ or\ 10\ kHz, pushbutton-selected\\ 10\ mV\ to\ 2\ V\ (AGC) \end{array}$
Synchronization with SMLU Deviation of centre frequency Capture and hold range Programming Rated temperature range AC supply Dimensions, weight	≧2%; setting time ≦100 (400) ms TTL level, negative, BCD +10 to +40°C 115/125/220/235 V ±10%, 47 to 440 Hz (37 VA)
Order designation	Frequency Controller SMLU-Z3 242.5019.92

2 POWER SIGNAL GENERATORS

signal generators



UHF Power Signal Generator SLRD ♦ 0.28 to 2.75 GHz



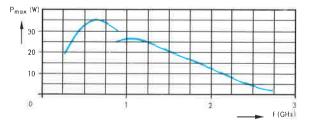
Single-stage UHF Power Signal Generator SLRD using a disc-seal triode oscillator and tunable coaxial resonantline circuits for anode and cathode. Both circuits have separate scales calibrated in MHz. The scale drives can be ganged (single-knob tuning). The whole frequency range is covered in two bands.

Single-knob manual tuning permit accurate adjustment of small frequency increments and rapid tuning through the whole range.

The SLRD model that is suitable for synchronization incorporates two diode tuning units providing signals of crystal accuracy and spectral purity. The tuning units may also be added later.

Modulation characteristics. Internal 1-kHz squarewave modulation of high stability; external pulse modulation possible with rise and fall times of 0.08 to 2 μs and repetition frequencies up to 100 kHz.

The output power can be adjusted from maximum down to -50 dBm in accurate intervals, direct reading being provided by a directional coupler and a meter for levels from +47 to +9 dBm. A piston attenuator calibrated in dB permits the adjustment of low levels.



Typical values of maximum output power

Measurement of stopband and passband charac-Uses. teristics of filters and other two- and four-terminal networks of high attenuation, feeding of impedance meters (slotted lines, reflectometers), determination of propagation conditions and of transmission loss.

- Output power up to 35 W, adjustable down to $1{\times}10^{-8}~\text{W}$
- Model suitable for synchronization can be supplied
- External pulse modulation, internal squarewave modulation 1000 Hz

Specifications

Frequency range	280 to 2750 MHz
Error limits of indication	±2%
Frequency change due to	
temperature variation	≦7×10 ⁻⁵ /°C
Harmonics	typ. 20 dB down 1 to 10 kHz, depending on frequency
Residual AM	\geq 40 dB down
Synchronization	
Maximum tuning range	1 × 10 ⁻⁴ for 280 to 950 MHz
Control voltage requirement	2 × 10 ⁻⁵ for 850 to 2750 MHz
Control voltage requirement	±20 V for max. tuning range
Modulation	
Pulse modulation (squarewave), inte	mal
Modulation depth	100%
Repetition frequency	1 kHz
Rise/fall time	0.08 to 2 μs
Pulse modulation, external	
Repetition frequency	0 to 10/0 to 100 kHz
Pulse width	4 µs to 1 ms
Voltage requirement	
Output power	
1st RF output (front panel)	Dezifix B, 50 Ω; adaptable
Max. output power	
Min. adjustable power	see diagram on left
Indication for powers	
> +9 dBm	on panel meter
< +9 dBm	on meter and dB scale of piston at-
	tenuator
Adjustment range of attenuator	0 to 70 dB
Attenuator error	
2nd RF output (rear panel)	Dezifix A, 50 Ω; adaptable
Output power	10 µW to 100 mW, depending on
	frequency; not adjustable
General data	
Rated temperature range	+10 to +35°C
AC supply	47 to 63 Hz (175 VA)
Dimensions weight	484 mm×328 mm×512 mm, 38 kg
Binonalono, weight	404 mm x 320 mm x 312 mm, 30 kg
Ordering information	
Ordering information	
Order designations	► LIHE Power Signal Generator
	SLRD
	100.4194.02 (no synchronization)
Tuning units required for synchroniza	tion (on request, the SLRD is supplied
with one or two tuning units which c	T T T T T T T T
Range 280 to 950 MHz	Tuning Unit SLRD-Z 100.4207.02
Range 850 to 2750 MHz	
	100.4213.02

signal generators

NOISE GENERATORS 2

Noise Generator SKTU ♦ 1 to 1000 MHz

- Easy determination of noise figure over a wide frequency range
- Scale calibration in F (noise factor) and noise figure (F_{dB})



Noise Generator SUF 2 on page 338 (20 Hz to 50 kHz – for white, pink, triangular noise and program replacement signal

The **Noise Generator SKTU** supplies a measurable and adjustable continuous white noise spectrum for the rapid and easy determination of the noise figure of amplifiers or receivers. The noise power is generated using a temperature-limited diode.

The receiver input voltage that gives the signal-to-noise ratio 1 with the measured noise figure and the given receiver bandwidth can be read in microvolts on the nomogram engraved on the left side of the front panel.

Specifications

Frequency range	1 to 1000 MH	lz	
Source impedance	50 or 75 Ω,		
	depending or		9 r
Noise power			
Indicating ranges	50 Ω	60 Ω	75 Ω
Noise factor, 1 to	6.5/33	8/40	6.4/32
Noise figure in dB, 0 to	8/15	9/16	9/15
Error of indication	0.5 (1) dB		
AC supply	115/125/220	/235 V	
Dimensions, weight			m, 9 kg
Order designation			
50-Ω model 75-Ω model			

Theory of noise measurements

The **noise figure** of four-terminal networks is readily determined with the help of a generator producing white noise in the frequency range concerned. Such generators permit rapid measurements to be made without calculation. The results allow the comparison in sensitivity of different types of receivers or amplifiers.

Definition of noise factor

The **noise factor** F is the ratio of the signal-to-noise power ratio at the input to that at the output of a four-terminal network.

$F = \frac{S_1/P_1}{S_2/P_2} = \frac{P_2}{G_0 P_1}$	where S_1 $S_2 = S_1 G_0$ P_1 P_2	signal power noise power	at the input at the output at the input at the output
	12		at the output

The noise factor is by definition a dimensionless quantity.

 $P_1=kT_0\Delta f$ is the noise power due to the source impedance under the assumption that the temperature of the generator source impedance equals the standard noise temperature $T_0.$ Then

$F = \frac{P_2}{kT_0 \Delta f G_0}$	P₂ k T₀ ⅃ſ G₀ kT₀	output noise power in W Boltzmann's constant in Ws/K absolute ambient temperature in Kelvin effective noise bandwidth in Hz power gain 4×10^{-21} Ws
	KI0	4×10 ⁻²¹ Ws

The total noise power at the output is referred to the amplified reference power of 1 kT₀ Δf . P₂ is composed of this amplified

reference power and the component produced by the noisy four-terminal network. Thus the noise factor can be split up

$$F = \frac{G_0 P_1 + P_2}{G_0 P_1} = 1 + \frac{P_2}{G_0 P_1} = 1 + F_Z$$

where F_z represents the contribution of the noisy four-terminal network.

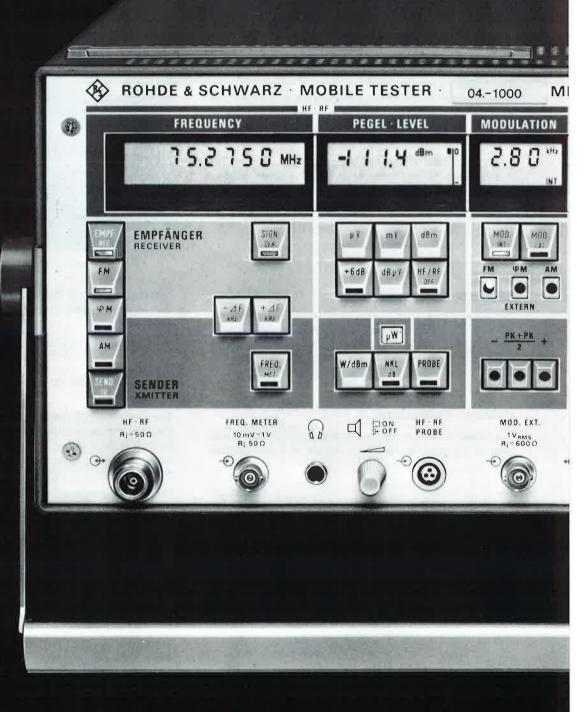
The definition of the noise factor is based on the assumption that only the linear transmission range of the four-terminal network is used in the measurement. Non-linearity would seriously alter the noise spectrum and thus lead to measurement errors.

The **noise figure in dB** is obtained as $F_{dB} = 10 \log F$.

Measurement of noise factor

The definition of the noise factor does not specify the way in which the signal power is generated. It is possible to compare the signal power from a signal generator operating on a discrete frequency with the power of the noise spectrum which, dependent on the passband, appears at the output. To calculate this noise power it is necessary to determine the effective bandwidth. An easier way is to derive the signal power from a noise source. The signal of this noise source is subjected to the same bandwidths which act upon the noise spectrum applied to the input. The effect of bandwidth is thus eliminated. Generators delivering white noise (continuous spectrum with frequency-independent rms value) are therefore used for measurement. Automatic radiotelephone testing: Mobile Tester SMFP2 0.4 to 1000 MHz; details on page 80

.



radiotelephone test assemblies



ų,

3 OVERVIEW

test assemblies

Radiotelephone test assemblies

Signal generators play an important role in checking out receivers during development, production and servicing. By complementing the signal generator with power, frequency and modulation meters as well as AF test equipment, a test assembly for checking transceivers is obtained.

For ten years Rohde & Schwarz has been combining measuring instruments to form transceiver test assemblies.

The latest generation of test assemblies, consisting of models SMFS2 and SMFP2, embodies a novel instrument concept for testing transceivers; automatic routines afford particularly great ease of operation.



Mobile Tester SMFS2 with Analog Display SMFS-B9

The Niobile Tester SMFS2 is a portable, manually operated unit with semi-automatic measurement routines for AM, FM and ϕ M transceivers. It is primarily a maintenance test set for workshops and field service but thanks to its ease of operation and semi-automatic measurement routines it is also suitable for use in laboratories and production departments. When a transmitter signal is applied, its frequency, power and modulation are measured and indicated on separate displays. The test set adjusts the AF signal level at a standard audio frequency until the transceiver operates at its nominal modulation. Then the operator switches off the transmitter and the tests are performed on the receiver section. Again the SMFS2 automatically selects the standard parameters and indicates the RF level required to obtain the desired S/N ratio. The front panel of the tester is divided into areas for receiver or transmitter tests. Keys are provided for the selection of special functions such as RF level +6 dB or RF level off, external modulation and SINAD or S/N ratio.

The frequency of the built-in synthesizer can be varied via the keyboard in steps of any size, for example to match the channel spacing or to change between the upper and lower sidebands. Sensitive counters and deviation meters enable remote measurements to be performed on radio signals. A DC voltmeter/ammeter measures the DC voltages and currents of the transceiver. The SMF2 can be operated from a car battery.

An adjacent-channel power meter can be incorporated in the SMFS2 as an option. Also available are a reference oscillator of high stability, an AF synthesizer, a selective-call encoder, a selective-call decoder, a 60-W power meter, an RF millivolt-meter and a control interface.

The Mobile Tester SMFP2 is a programmable model, identical in operation and measuring capability with the SMFS2 and likewise suitable for all service applications. Programmability via the IEC bus makes this tester ideal for use in automatic test systems. A fully automatic transceiver test assembly for small-batch and large-scale production testing can be obtained by adding the Process Controller PUC. The extremely low price - you pay no more for the SMFP2 than for a conventional manually operated test assembly - makes it possible to set up value-for-money automatic and semiautomatic configurations for all repetitive measurements occurring in laboratories, production and servicing departments. In addition to the IEC-bus interface, the SMFP2 has 12 control lines (TTL levels and relays) for the control of the test item (transceiver) or auxiliary equipment such as relay matrices and switching units. In conjunction with an IEC-bus compatible printer, the SMFP2/PUC combination permits records of all measurements to be obtained.



Mobile Tester SMFP2 with Process Controller PUC

In the Automatic RX/TX Tester SMAT a go/nogo tester for transceivers is available for the first time with which, by means of an extremely fast performance test, the major parameters governing the performance of transceivers can be checked within seconds, the measured data compared to stored ratings and adherence to tolerance simply shown by green and red indicators.



The SMAT can store a variety of test programs for as many as 75 different transceivers and, in addition to controlling the entire test sequence, automatically matches the connected transceiver for the next measurement that is to be carried out on it.



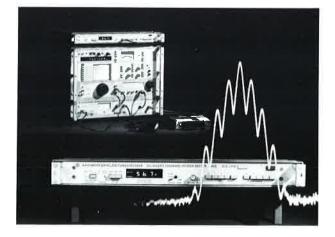
Automatic RX/TX Tester SMAT

As for manually operated test assemblies, the SMDU models 06, 07 and 09 in conjunction with the AM Unit SMDU-Z1 or the Power Test Adapter SMDU-Z2, feature obsolescenceproof design combined with optimum operating convenience. Compact test assemblies with integrated accessories are available under the designations SMDU 52, 53 and 56; see page 109. The SMDU concept meets the requirements of national and international standards, such as CEPT, FTZ, GPO or EIA, with the same ease with which it permits semiautomatic operation of the individual measuring instruments and simultaneous display of the most important test parameters.

The SMDU options permit custom-tailored optimization of the test assembly. Measurements in the 900-MHz band are also possible and the requirements existing for measurements on radio sets equipped for reply call are met.

The Adjacent-channel Power Meter NKS rounds off the line of radio test equipment. In conjunction with the SMDU it measures the adjacent-channel power of radio transmitters in line with national and international standards (CEPT). The NKS tunes automatically to the selected adjacent channel (details on page 115).

RT Test Assembly SMDU with Adjacent-channel Power Meter NKS



Air-navigation test assemblies

In civil aviation, **VOR/ILS** navigation receivers determine the position and direction of planes. Amplitude-modulated signals in the VHF and UHF ranges are required for testing these receivers. These signals should exhibit a constant group delay between 9 and 11 kHz, very low distortion at 30 and 9960 Hz and a flat frequency reesponse at the modulation frequencies of 90 and 150 Hz.

Models 07 and 08 of the Signal Generator SMDU meet these requirements. In conjunction with the Rohde & Schwarz VOR/ILS Unit, these versions constitute a complete test assembly for VOR/ILS receivers of one make. The special advantages of this combination are the continuous monitoring of the modulated RF signals and the built-in self-check of the most important operating parameters.

Automatic RF test assemblies

Test assemblies whose routine is controlled from a desktop computer via the standard IEC bus permit rationalization of RF measurements up to 1000 MHz. Rohde & Schwarz offers two complete test assemblies for different measuring tasks, together with software for the Rohde & Schwarz Process Controller PUC.

The automatic test assembly for intermodulation and crossmodulation measurements determines nonlinear distortion of antenna and cable-TV amplifiers as well as of semiconductors. Depending on the method used, two or three Power Signal Generators SMLU are included in the test setup.

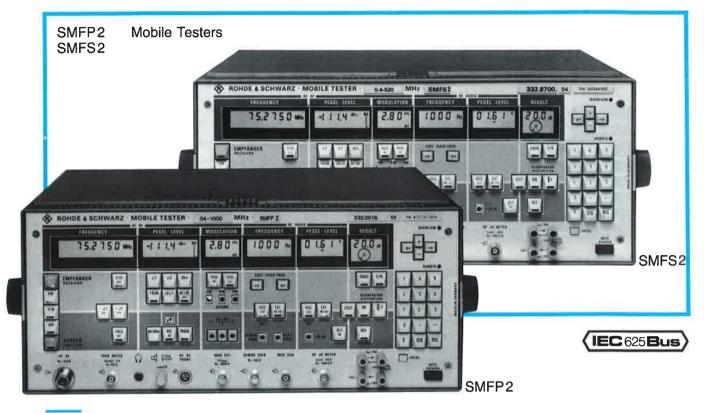
The programmable VHF-UHF Test Receiver ESU 2 permits selective measurement of interference products. Operator errors are excluded since the whole test sequence is controlled from the computer. The intermodulation or crossmodulation suppression is printed out directly in dB.



Automatic test assembly for intermodulation and crossmodulation measurements (see page 116)

The test assembly for RF cables automatically measures the average characteristic impedance and attenuation of RF cables in accordance with the specifications of IEC 96-1 or DIN 47250. It consists of the programmable Power Signal Generator SMLU, an RF voltmeter and an analog/digital converter and can be extended by the Vector Analyzer ZPV. The resonance method is used for measuring. In addition to controlling the test routine, the desktop computer furnishes the test results, the characteristic impedance being printed out in Ω or the attenuation in dB.

3 RADIO TEST ASSEMBLIES



new

Mobile Testers SMFP2 and SMFS2 ♦ 0.4 to 1000 MHz Successors to the successful Mobile Testers SMFS and SMFP with extended measurement and setting capabilities and new options

SMFP2/SMFS2 features

- Compact testers for AM, FM and @M transceivers
- Manual operation and semi-automatic or fully automatic measurements, depending on type and configuration

Both test sets contain all measurement capabilities required for transceiver testing; see next page.

Other common features:

- High measurement accuracy and high test rate
- Use in servicing, production and development
- Easy-to-grasp front-panel configuration and microprocessor-controlled key interlocking together with
- Semi-automatic measurement routines for easy operation
- Many automatic settings and test routines e.g. 6-dB bandwidth, reply call
- Compact, handy unit requiring little bench space and suitable for battery operation
- Options available to extend the range of applications

Additional SMFP2 features

Basic unit for the following test systems:

- Self-contained semi-automatic transceiver test set for servicing in the field as well as in the lab
- Extended test assembly for servicing and batch testing fully automatic, flexible and easy to operate thanks to the Process Controller PUC
- Test system for large-scale production testing, backed by controller and minicomputer (and data bank)

Differences between SMFP2 and SMFS 2

The two test sets embody the same basic design and offer the same measurement capabilities; they differ only in

- a) measuring convenience SMFP2: IEC-bus compatible, can be built into fully automatic computer-controlled test assemblies SMFS2: manual operation with semi-automatic measurement routines
- b) modulation generator

SMFP2: continuous tuning from 10 Hz to 25 kHz, crystal reference, synthesizer; 7 fixed frequencies; built-in selective-call encoder

SMFS2: 12 fixed frequencies from 0.1 to 10 kHz, with options same as SMFP2

RADIO TEST ASSEMBLIES 3

Characteristics, uses, configurations

With the Mobile Testers SMFP2 and SMFS2, single test systems for all transceiver measurements are available for the first time. Manual and automatic operation, mobile and stationary use, universal measuring capabilities and high measuring speed together with high technical performance are just some of the advantages of these versatile systems for use in development, test departments, final test and servicing. Both testers contain all the facilities required for precision measurements on transceivers (see listing below). While the SMFS 2 is exclusively designed for manual operation, all test parameters and measurements can be programmed for the SMFP2 with the aid of a controller, simple IEC-bus instructions and basic software ensuring fast programming.

Measuring and control devices	in SMFP 2 and SMFS 2	Receiver test	Transmitter test
RF GENERATOR MODULATION GENERATOF	0.4 to 520 MHz (to 1000 MHz with option)	•	•
 SMFP2: continuous tunir 			
	ncies (continuous tuning with option)	1.00	
RF FREQUENCY METER POWER METER	1 to 520 MHz (to 1000 MHz with option) up 30 W (to 60 W with option)		•
SINAD-METER	switch-selected CCITT weighting filter	•	10000000
S/N METER	switch-selected CCITT weighting filter		• • • •
MODULATION METER	for AM, FM and φM		\$
 Switch selection of positi 	ve, negative or average peak value		
	switch-selected CCITT weighting filter		
SPURIOUS-MODULATION M – true rms meter			19
AF VOLTMETER	switch-selected CCITT weighting filter switch-selected CCITT weighting filter		
DISTORTION METER	switch-selected CCITT weighting (additional)		•
AF FREQUENCY METER	20 Hz to 1 MHz	•	•
BEAT-FREQUENCY METER			•
- with loudspeaker and co			
DC VOLTMETER and AMME			
ADJACENT-CHANNEL POW SELECTIVE-CALL ENCODE			
SELECTIVE-CALL DECODE			•
RF MILLIVOLTMETER	(option)	•	•
CONTROL DEVICE	for transceiver (optional with SMFS2)	•	Ŭ
- 12 TTL control lines and			
AURAL MONITORING	with loudspeaker and headphones	•	•
ANALOG DISPLAY (option)			•
- with oscilloscope and an	alog indicators		

Operation, measurement routines, indication

The controls of the SMFP2 and SMFS2 are arranged in different sections of different colours according to the measurement mode (transmitter or receiver) and the setting or the parameter to be measured. This logical organization of the front panel ensures error-free operation without any training and fast access to the automatic routines. Moreover, illuminated keys for data setting and the readout of measurements in progress prevent erroneous interpretation of the measured values. By switching to receiver test or transmitter test the SMFP2 or SMFS2 is completely preset for the particular measurement.

Measurement routines. The possibility of choosing manual operation or calling up automatic measurement routines makes for versatile use of the test set on the one hand and speedy and error-free measurement of repetitive standard values on the other.

Indication. Six LCD's **simultaneously** read out virtually **all the test results**, eliminating reading errors and enabling the interdependence of individual parameters to be determined. A **quasi-analog readout**, which can be assigned to any desired digit, simplifies adjustments and indicates tendencies.

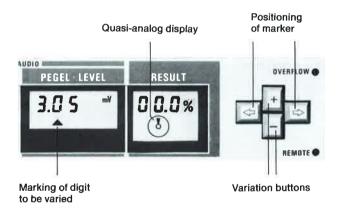


SMFP2/SMFS2 - Function

Parameter setting

Automatic settings and automatic routines in both the SMFP2 and the SMFS2, assigned to particualr modes for receiver and transmitter testing, spare the user the repetitive settings which are otherwise needed over and over again in day-to-day measurements. Special buttons and the keyboard further permit all the additional measurements required for a complete check of a transceiver.

Parameters that differ from the automatic test routines can be altered with the keyboard. With the four buttons arranged to the right of the displays any frequency or level value of the AF and RF generators as well as the modulation can also be varied continuously (illustration below). Two buttons designated with arrows shift a marker beneath the display until it indicates the digit columen to be varied. The other two buttons ("+" and "-") then permit this digit to be varied in steps or, if kept depressed, in a fast sequence. Since the carry of the digit varied is also considered automatically, the test set offers the user, besides the digital entry via the keyboard, quasi-analog tuning with selectable resolution. It is also possible to vary the frequency of the RF generator in steps of any desired size (e.g. from channel to channel) with the two keys "+ Δf " and "- Δf ".



Buttons on mobile tester for varying any desired digit of level and frequency of RF and AF generators as well as modulation section

exceeded (see illustration). The keys RF OFF and +6 dB permit fast variation of the RF level.

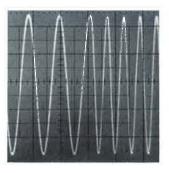


SMFP2/SMFS2 output-level display combined with readout of electronic-attenuator setting plus keys for entry and conversion of physical units

AF generator

Seven (SMFP2) to twelve (SMFS2) standard frequencies of the modulation generator can be called up at the push of a button and varied proceeding in either direction. These cover all of the important modulation frequencies for transceiver testing. It is possible to increase the outputlevel setting by 20 dB with the aid of a special key, thus simplifying overmodulation measurements, which are an absolute necessity when testing modulation limiters for instance.

Using the SMFP2 – or the SMFS2 with AF synthesizer/ selective-call encoder option – all other frequencies in the AF range can be set with crystal accuracy and high resolution via the keyboard or the variation buttons. With extremely short frequency and amplitude switching times and phase continuity when changing the frequency all the requirements of tone sequence generation (selective calling) are met.



Frequency change

The AF Synthesizer/Selective Call Encoder produces tone sequences with one to eight single tones according to ZVEI and CCIR standards. The setting of the test set to the particular standard and the entry of the desired call is keyboard-controlled from the front panel. If the same code number is entered successively the repeat tone is sent automatically. The entered tone sequence can be sent singly or repeatedly.

With the SMFP2 it is also possible to use simple IEC-bus instructions to call up tone sequences or to vary the parameters of the tone sequences. For example, the first tone may be lengthened, pauses may be introduced and the frequency of the single tones may be varied for tolerance investigations. Moreover, completely different tone sequences, such as European radio-paging signals, can be produced.

RF generator

The output voltage of the RF generator is entered in μ V, mV, dB μ V or dBm. Conversion from one physical unit to another is initiated at the push of a button without cutting off or changing the RF level. The output voltage can also be reduced by up to 10 dB with an electronic attenuator without cutting off the level, as is necessary, for example, for an exact determination of squelch hysteresis. The setting of the attenuator is read out on the RF-level display and is a reliable indication of whether the range of variation is likely to be

RADIO TEST ASSEMBLIES 3

Transmitter test/receiver test selection

The two main modes of operation – **transmitter test** and **receiver test** – are engaged automatically according to the power arriving from the transceiver. The switchover can moreover be performed or inhibited by pressing a button so that parts of each test may be combined. For example, the SINAD ratio of a receiver can be checked during a transmitter test to determine the useful-signal transfer in duplex operation.

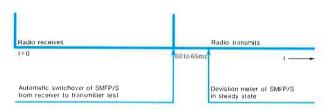
On switching from transmitter to receiver test, the **frequency** of the RF generator is set automatically either

- to a frequency entered over the keypad or
- to the transmit frequency of the transceiver measured or

to the duplex pair frequency in the upper or lower band.

When the main mode is switched over, **all test parameters** are **stored** and – provided the operator does not alter them in the meantime – automatically reset upon recalling. So no new entries are required even with repeated switchover.

When the transmit frequency of the transceiver is entered via the keypad and the deviation meter is on, the mobile tester switches within 70 ms from receiver to transmitter test. This makes it possible to measure transceivers that send an acknowledgement signal.



Timing sequence for testing transceivers that send an acknowledgement signal

Transmitter test

In transmitter testing the SMFP2/SMFS2 measures automatically

- the **transmit frequency** of the transceiver with 10 Hz resolution,
- the transmitter power in W or dBm and
- the **modulation** with high resolution (using the self-tuning demodulators).

At the push of a key the test set increases or decreases the level of the modulation generator until the modulation entered over the keypad is reached. If no modulation has been entered, the test set adjusts to the modulaton value last entered for the receiver test. The level of the modulation generator then represents

the modulation sensitivity

for the given modulation, which is read out as a true measured value on the MODULATION display.

By simply selecting the modulation-generator frequencies one after the other,

the modulation frequency response of the transceiver

can be determined rapidly. A relative value in dB – referred to any measured or keyed-in value – can be displayed in addition to the absolute value.

Also at the push of a key the test set determines

the modulation distortion

at all frequencies prescribed by CEPT – 300 Hz, 500 Hz and 1 kHz – or, by switching the modulation voltage cyclically on and off,

the signal-to-noise ratio

of the transceiver; the result is read out in % or dB on the RESULT display.

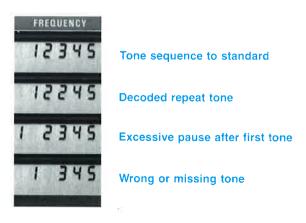
The additional AF generator with 1-kHz fixed frequency in conjunction with the modulation generator permits **doubletone modulation of a transceiver.** Resulting intermodulation products that lie in the adjacent channel can be measured directly with the adjacent-channel power meter.

If the modulation is switched off during transmitter measurement, the tester indicates the spurious modulation of the transceiver, broadband or CCITT weighting being selectable. After attenuation by 30 dB the decoupled transmitter signal is available on the rear panel of the test set for checking by means of an oscilloscope or a spectrum analyzer.

For measurements on **selective calling equipment** the test sets can be preset to ensure quick response of the demodulators. The tone sequence can be applied from a front-panel output to a selective-call evaluation unit, or, when the selective call decoder option is fitted, decoded and displayed directly by the SMFS2/P2.

Selective Call Decoder SMFS2B6. The SMFS2B6 Option permits decoding of tone sequences to ZVEI or CCIR standard (1 to 7 single tones) demodulated in the basic unit or applied to the AF voltmeter input. The decoded code numbers are read out on the display. Repeat tones are automatically decoded. Excessive pauses or tones that deviate from the chosen standard can be readily recognized as can be seen from the examples of displayed decoded tone sequences.

Examples of displayed decoded tone sequences



3 RADIO TEST ASSEMBLIES

test assemblies

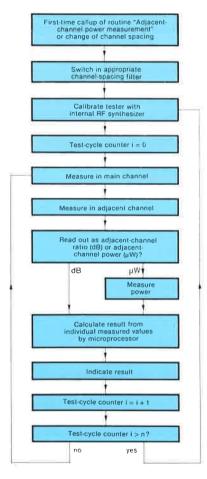
SMFP2/SMFS2 - Measurement capabilities

Transmitter test

Fitted with the optional

Adjacent-channel Power Meter (SMFPB6)

the SMFP2 or SMFS2 measures the power radiated in the adjacent channels. For this the nominal transmit frequency of the transceiver must simply be entered over the keyboard and the channel in which the adjacent-channel power is to be measured selected. Readout of the adjacent-channel power ratio in dB relative to the carrier power or direct readout of the absolute value of the adjacent-channel power in μW can be selected.



Comprehensive automactic internal test routines offer extreme operating ease combined with high accuracy: simplified flow chart for automatic test routine for adjacent-channel power measurement

External attenuators are automatically taken into account in all settings and readouts of measured values by entering their attenuation values. This permits the SMFP/S 2 to be used for error-free testing of transceivers of any transmitting power without sacrificing ease of operation.

Receiver test

In receiver testing, the test parameters such as

frequency, RF level, modulation and modulation frequency

are preset and the SMFP2/SMFS2 measures, in addition to the level of the transceiver AF output signal, either

the SINAD ratio

or, with the modulation cyclically switched on and off,

the signal-to-noise ratio

with or without CCITT weighting. If a certain SINAD or S/N ratio is entered over the keypad, the test set will automatically increase or decrease the RF level until the entered value is obtained. The RF level obtained represents

the sensitivity of the transceiver

and is indicated on the LEVEL display; the corresponding SINAD or S/N ratio appears on the RESULT display as a true measured value.

In addition to the two automatic routines for determining sensitivity according to the S/N and SINAD method in receiver testing, the SMFP2/S 2 now offers a third capability – **quieting measurement.** Furthermore, the averaging time of the two test assemblies can be extended in automatic S/N and SINAD measurement, thus narrowing down measurement tolerances in the case of impulse noise and further enhancing accuracy.

The RF OFF key facilitates rapid testing of the squelch function and electronic level fine adjustment without interruption of the level permits an accurate determination of

squelch hysteresis.

The SMFP2/SMFS2 measures

the 6-dB bandwidth

with a single keystroke and indicates either bandwidth or bandwidth plus frequency offset. By varying the modulation frequency or selecting several one after the other,

the AF frequency response of the receiver

can readily be determined. As in transmitter measurement, it is possible to read out the absolute level or the relative value in dB referred to any measured or keyed-in value.

The built-in distortion meter permits checking

the AF distortion

of the transceiver, as in transmitter measurement, at all frequencies prescribed by CEPT.

The 1-kHz fixed-frequency oscillator allows simultaneous frequency and amplitude modulation of the carrier for

checking AM suppression.

If the 1-kHz singal is used for the FM, the built-in distortion meter can be used for this test.

Main automatic settings

Transmitter test	Measurement of frequency, power and modulation	
Receiver test	Measurement of AF level	
Transmitter test/receiver test selection	Switchover controlled by arriving/missing radio transmitter power with automatic setup of the tester	
Receiver test frequency	Use of the transmitter frequency as receiver test frequency (in the case of duplex operation with $+$ or $-$ offset)	
Fast deviation measurement	With preset ${\rm f}_{\rm transmit}$ $-200~\rm kHz$ output of the demodulated signal immediately upon transmitter switch-on	
Acknowledgement signal test	Switchover from receiver to transmitter test within 70 ms (transient time of deviation meter) after transmitter switch-on	
SINAD ratio measurement	Setting of 1-kHz modulation frequency	
Distortion measurement	Setting of appropriate AF frequency	
Tone sequence	Automatic setting and evaluation of repeat tone, tone sequence generation followed or not by useful modulation	
External attenuators	Setting of parameters and display of results taking into account external attenuators	

Main automatic test routines

Routine Function		Display	
Sensitivity, SINAD or S/N ratio	Variation of RF level until entered value is reached	SINAD or S/N ratio and corresponding RF level	
Frequency response	Measurement with instantaneous measured value or programmable value as reference value	+dB or −dB	
6-dB bandwidth	Determination by variation of RF level and RF frequency	Bandwidth and centre-frequency error	
Modulation sensitivity	Variation of modulation level until entered modulation is reached	Modulation and AF level	
Adjacent-channel power ratio	Determination or power in upper or lower adjacent channel	Relative in dB or absolute value in μW	

Two-signal measurements

For receiver measurements requiring two signal generators, the SMFP2/SMFS2 has a rear RF input/output isolated by 30 dB from the main RF input/output on the front panel. All two-signal measurements, e.g. of

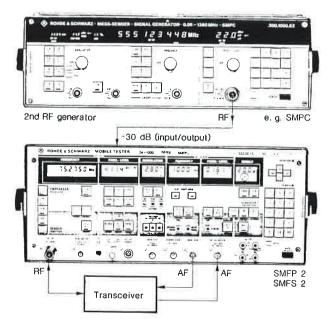
adjacent-channel selectivity,

- intermodulation and cross-modulation,
- desensitization,

can thus be performed without further accessories (attenuators, prescalers, etc.).

For very exacting two-signal measurements – e.g. for determining adjacent-channel selectivity – the second signal source should be an extremely low-noise type. The R&S model SMPC is very well suited.

To perform **measurements on repeaters,** a second signal can again be fed into the RF path via the RF input/output on the rear to drive the repeater while the test set measures the transmit signal from the repeater.



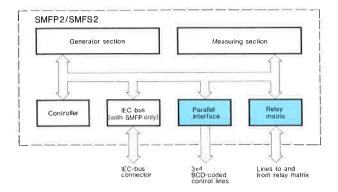
Test setup for two-signal measurements and measurements on repeaters

BADIO TEST ASSEMBLIES 3

test assemblies

SMFP2/S 2 - Configuration/control

Interface for Remote Control SMFS-B5 (option with SMFS2)



Basic diagram of SMFP2 and SMFS2 subdivided into generator, measuring and control sections: blue: standard with SMFP2, optional with SMFS2

3×4 programmable BCD-coded control lines and an AF relay matrix (standard with SMFP2, optional with SMFS2) permit automatic setting of the transceiver from the computer (SMFP2 only) or over the keypad both prior to and during the measurement. For example,

channel selection, transmitter/receiver switchover, loudspeaker on/off, squelch on/off

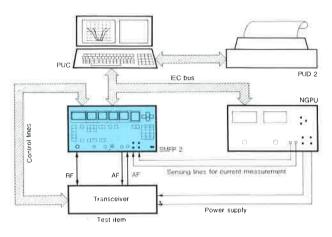
and the control of non-IEC-bus-compatible accessory equipment can be programmed. The relay matrix can also be used as a singal scanner. An additional relay is coupled with the transmitter/receiver switchover, so the transceiver mode can be switched simultaneously when the mode is switched on the front panel of the test set.



Extension possibilities

In conjunction with a controller the SMFP2 forms a fully automatic transceiver test assembly. The control section contained in the SMFP2 (see diagram left) takes charge of setting the transceiver during the test, so no additional interfaces are required.

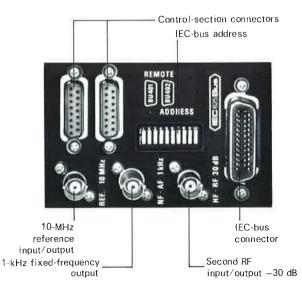
Simple IEC-bus instructions combinable with internal test routines and an elaborate basic software (SMFP2-K1) facilitate rapid program writing.



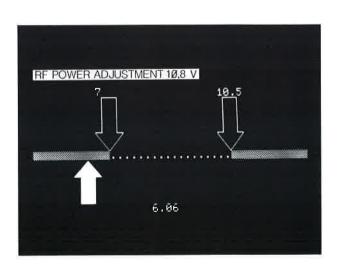
Fully automatic transceiver test assembly with Mobile Tester SMFP2, Process Controller PUC, Universal Printer PUD2 and Programmable Power Supply NGPU

Controller. For extending the SMFP2 to form a fully automatic transceiver test assembly (illustration above), use of the Process Controller PUC with built-in floppy-disk drive is recommended, permitting program and data output in seconds and providing a large screen for good readability and neat display of program and measured data.

Printer. The new, low-priced Universal Printer PUD2 available for the PUC, which can be connected to a separate socket on the PUC without loading the IEC bus, provides hardcopy program records and test printouts.



Rear panel of SMFP2/SMFS2



Example of display of transceiver adjustment on screen of Process Controller PUC (power adjustment with tolerance limits and actual value) using basicsoftware routine 86

RADIO TEST ASSEMBLIES 3

SMFP2 - Software

Basic Software for SMFP2. The computer-controlled, automatic transceiver test system SMFP2 facilitates the rapid and accurate execution of measurement sequences without any setting errors.

Before operating such a system, however, it is necessary to prepare a test program, or **software**, which will cause the system to execute all the necessary settings and measurements. The preparation of such a program generally calls for pertinent knowledge and experience on the part of the programmer and requires a long time. In contrast, the use of the

Basic software SMFP2-K1,

made available by Rohde & Schwarz in the form of a floppy disk for the SMFP2, brings many advantages: programming using the basic software involves nothing more than preparation of a user program in which the required test routines are called up, no programming knowledge being required. In this way even complex measurement procedures can be programmed in a very short time.

Test routines. More than 80 routines contain all the steps necessary for the execution of the measurement: setting the measuring instrument, input and output of data, changing of settings on the test item, computation of final results from several measured values. Output routines display the result on the screen of the computer or generate a printout on a printer connected to the computer. The results are also compared with preset nominal values and an indication is given if the tolerance limits are exceeded.

The user can, of course, extend the basic software by the addition of special routines. This permits non-standard problems to be solved.

Example of a complete transceiver test program using the Basic Software SMFP2-K1

Black: program

Blue: explanation of settings or measurements executed

$\frac{10}{12}$	R=40:60SUB9000	START ROUTINE XMTR TEST YPE OF MODULATION FM
4000040 44430000	Ř≃⊼:GOSUB9000 R≕42:GOSUB9000 MEASU	JREMENT RF FREQUENCY
0214 2222	R=41.60SUB9888 M	EASUREMENT RF POWER
12002	R=17:605089888 R=43:605089888 MOD	SETTING DULATION MEASUREMENT
00014000 10000004	PRINTŮPOSIMODULATION:'" INPUT"EMPFANGSFREQUENZ R=62:GOSUB9000 V=2	ÉMÁZĴ ^W /X(1) RECEIVER TEST 2 µV BE LEVEL
42 44	R≕9:60SUB9080 Y≕1 R≈15:60SUB9006	SETTING RF LEVEL 1 kHz AF FREQUENCY AF FREQUENCY SETTING
1681814 1441515	Y≃2.8 R≈12.60SU29090 R≈28:60SU29090	2.8 kHz FM INTERNAL MODULATION SETTING AF LEVEL MEASUREMENT

Routine No.		Routine
1 2 3 Input 4 data 6 7	t	Start RF = receive freq. Channel spacing Upper band/lower band spacing IF ± Modulation: AM, FM, φM Max. modulation
8 9 10 11 13 14 17 18 18 20 21 22 23 24		RF frequency RF level RF off/on RF level contin. variation ±0.1 dB Mod. int. %, kHz or rad Mod. ext. Mod. int. off/on AF frequency setting AF level setting CCITT filter off/on Tone sequence to ZVEI or CCIR Control lines off/on BCD output setting Radio channel setting NGPU current-limit level setting NGPU voltage setting
27 28 30 31 Rece 32 and 33 trans 34 mitte 35 mea 36 men 39	s- er sure-	AF frequency measurement ext. AF level measurement ext. Distortion 300 Hz, 500 Hz, 1 kHz in % RF voltage AF frequency response Tone-sequence generation Tone-sequence evaluation DC voltage measurement DC current measurement NGPU current measurement using SMFP 2 voltmeter Universal adjustment
40 41 42 43 44 47 48 Tran 49 mitte 51 mea 53 men 54 55 56 58 59	er sure-	Transmitter test RF power RF frequency error Pos. modulation Neg. modulation Mod. sensitivity at 1 kHz Mod. frequency response referred to 1 kHz with test-frequency input Mod. distortion 300 Hz, 500 Hz, 1 kHz S/N transmitter Freq. meter/RF input selection Frequency of demod. signal Beat frequency Adjchannel power ratio in dB Adjchannel power in µW
	eiver sure- ts	Receiver test + sig. gen. frequency setting S/N measurement at 1 kHz SINAD measurement at 1 kHz Sensitivity for given S/N Sensitivity for given SINAD Quieting sensitivity 6-dB bandwidth + centre-frequency offset Modulation acceptance bandwidth Squelch upper and lower thresholds and hysteresis AF frequency responce ref. to 1 kHz with test-frequency input Signal transfer at diplexer Image-frequency rejection
86 87 88 89 Outp 90 91 92 93	out	Adjustment with analog display + call of routine Text (instruction on screen) Print out text on printer Print out result on printer Printer output with nominal/actual comparison Screen output with nominal/actual comparison Frequency chart Hardcopy
100		Internal: error

SMFP2/SMFS2 - Options

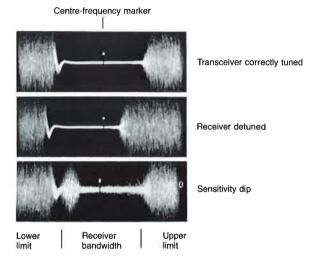
Analog Display SMFS-B9. The Analog Display option for the Mobile Testers SMFP2 and SMFS2 consists of an AF oscilloscope and two bar displays that can be assigned to any of the variety of measurements, thus offering additional checking capabilities and detectors with analog screen display, designed to match the specific requirements of production testing and servicing. With its automatic setting feature for the oscilloscope and the bar displays and the AUTO LEVEL button which does away with the need for readjustment during the tests, this option integrates easily with automatic test systems. When operating in the internal mode, the oscilloscope displays the signal demodulated by the SMFP2 or SMFS2 in a transmitter test or the AF singal delivered by the transceiver in a receiver test, with switchselected time and amplitude resolution. The vertical deflection calibrated in V for AF, in kHz for FM, in % for AM and in rad for ϕ M ensures precise signal evaluation. By pressing a button, all signals can be displayed with constant amplitude, i.e. no adjustment on the oscilloscope is then required when test parameters such as modulation, modulation voltage and modulation freqency vary. When operating in the external mode, the oscilloscope displays the signal that is applied through the BNC cable or measured by means of a probe, with switch-selected time and amplitude resolution. At the push of a button, AC or DC coupling can be selected.

The X-axis signal is available at a rear socket and can be applied to the MOD. EXT. input of the basic unit for **sweep-ing.** Its level matches the input sensitivity so that the sweep width can be entered directly in kHz via the keypad.

The frequency response curve is displayed directly on the screen of the SMFS-B9 with the aid of a demodulator probe.

A marker can be added at the centre frequency at the push of a button. This cuts off automatic triggering. Using the parameter variation keys on the basic unit the centre sweep frequency can be shifted to find resonance frequencies, attenuation peaks or cutoff frequencies; the corresponding frequency can then be read directly on the RF frequency display on the basic unit. Input and output stages, IF amplifiers, filters, duplexers and resonant circuits can thus be measured with the aid of a demodulator probe (available as an accessory; can be completed with an adapter to form an insertion unit with or without 50- Ω termination).

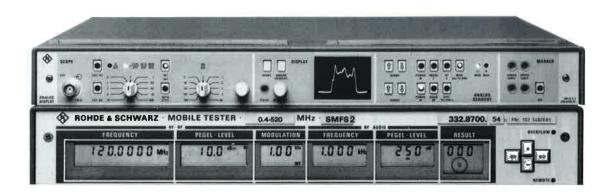
Overall sweeping – from the RF input of the receiver to the AF output – offers a quick overview of bandwidth, centre frequency tuning and sensitivity within the receiver range. The switch-selected CCITT filter built into the basic unit ensures suppression of build-up or dying out transients in the transceiver.



Swept-frequency measurement on a transceiver from the RF input to the AF output

The superimposed centre-frequency marker also permits points of interest, such as the lower or upper band limit as well as dips to be checked; the corresponding frequency can then be read directly on the RF frequency display on the basic unit.

The simultaneous display of both band limits simplifies centre-frequency tuning of the receiver. All there is to do is to see to it that the upper and the lower band limit are at the same distance from the centre-frequency marker.



Swept-frequency measurement on a

response display and centre-frequency

marker on screen

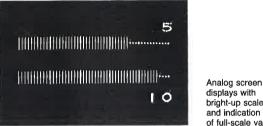
of Analog Display

filter with frequency-

SMFS-B9 on SMFP2

Two analog screen displays are provided in the form of bars with bright-up scales. The scales, measurement ranges and time constants of the test points have been designed to suit the specific requirements of transceiver measurements.

The exact assignment of each scale division to a measured value, the different scales displayed depending on the measurement to be made, and the full-scale values displayed on the screen ensure unambiguous determination of the measured values and make for maximum clarity of presentation.



bright-up scales and indication of full-scale value

Interdependence of the test parameters is easily discernible since both displays can be observed at the same time.

The bars automatically display	/
SINAD ratio and	
AF level	in receiver testing.
Power and	
positive or negative	
modulation,	
whichever is greater,	
with additional	
LED display	
as an aid for symmetry	
adjustment	in transmitter testing.

In addition, the following measured values can be displayed at the push of a button

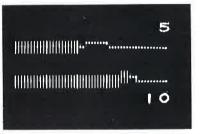
Distortion of AF output	
signal	in receiver testing.
Modulation distortion	in transmitter testing.

Measurement capabilities with analog display	Measurement ranges
AF	12.5/5/2.5/0.5 V
FM	25/10/5/1 kHz
AM	125/50/25/5%
φM	12.5/5/2.5/0.5 rad
SINAD ratio	50/25 dB
Distortion	50/5%
Power	50/10/2.5/0.5 W

BADIO TEST ASSEMBLIES 3

The measurement capabilities can be combined with one another, for example simultaneous display of measured power and SINAD ratio when adjusting duplexers.

For adjustment to given nominal values it is also possible to display tolerances separately for each bar. Maximum and minimum values can be set by means of potentiometers.



Bars with displayed tolerances

Reference Oscillator SMS-B1 (SMFP2 only, incorporated in SMFS2) improves the frequency accuracy of the RF and AF generators and of the counter (aging $\leq 5 \times 10^{-8}$ /month, temperature effect $\leq \pm 1 \times 10^{-7}$).

1-GHz Frequency Extension SMFP-B2 extends the frequency range of the RF generator, the RF counter, the deviation meter and the adjacent-channel power meter to 1 GHz.

60-W Power Meter SMFP2 B3. The SMFP2 B3 Option extends the measurement range of the power meter built into SMFP2 and SMFS2 from 30 W to 60 W. The measurement range extension has been achieved by the inclusion of an internal 3-dB power attenuator.

Adjacent-channel Power Meter SMFP-B61) measures the power components of the transmitter in the adjacent channel. The channel spacing and nominal transmitter frequency are entered via the keypad. The indication can be either in dB relative to the power in the main channel or absolute in µW.

Selective Call Decoder SMFS2 B6²) The SMFS2 B6 Option permits decoding of tone sequences to ZVEI or CCIR standard (1 to 7 single tones) demodulated in the basic unit or applied to the AF voltmeter input. The decoded code numbers are read out on the display. Repeat tones are automatically decoded. Excessive pauses or tones that deviate from the chosen standard can be readily recognized as can be seen from the examples of displayed decoded tone sequences (see also page 83).

RF Millivoltmeter SMFS2 B. In conjunction with suitable probes the SMFS2 B8 Option permit RF voltage measurements from 1 mV to 100 V over the range 10 kHz to 1 GHz. Suitable probes are any of the probes and insertion units available for the RF Millivoltmeter URV. Operating controls and display of the measured result are fully integrated into the RF level section of the Mobile Testers, the original operational convenience being preserved. In addition to digital display in mV, V or dBm the RF signal can also be displayed on the Analog Display Option SMFS-B9, if fitted, in four selectable ranges. In the SMFP2, the RF Millivoltmeter can of course also be used via the IEC/IEEE bus.

1) Because of the necessary frequency accuracy it is recommended to fit SMS-B1 together with SMFP-B6

²) For SMFS2 only with SMFS2 B7.

3 RADIO TEST ASSEMBLIES

test assemblies

SMFP2/SMFS2 - Options

Options for SMFS2

(integrated in SMFP2)

AF Synthesizer/Selective Call Encoder SMFS2 B7 extends the frequency range of the modulation generator and permits crystal-referenced frequency setting throughout the AF range from 10 Hz to 25 kHz with high resolution. It produces tone sequences (selective calling) with 1 to 8 single tones in accordance with ZVEI and CCIR standards.

Interface for Remote Control SMFS-B5 consists of 3×4 BCD-coded programmable control lines and a 9-relay matrix which permits the transceiver to be set from the front-panel keypad during the test.

Options for SMFS and SMFP

AF Synthesizer SMFS-B7 extends the frequency range of the modulation generator of the SMFS and permits crystalreferenced frequency setting throughout the AF range from 10 Hz to 25 kHz with high resolution.

Reference Oscillator SMS-B1, 1-GHz Frequency Extension SMFP-B2, Adjacent-channel Power Meter SMFP-B6, Interface for Remote Control SMFS-B5 and Analog Display SMFS-B9 can also be retrofitted in the SMFS and SMFP (see tabel below). Recommended extras for SMFP2 and SMFS2

Protective Covers SMFP-Z8 for front and rear panels of the SMFP2 or SMFS2 without Analog Display SMFS-B9.

19" Adapter SMFS Z10 permits incorporation of the SMFP2 or SMFS2 together with Analog Display SMFS-B9 into 19" systems.

19" Adapter SMFP-Z9 permits incorporation of the SMFP2 or SMFS2 without Analog Display SMFS-B9 into 19" systems.

Oscilloscope Probe SMFS-Z1. This probe features switched attenuation (1:1/10:1/Ground) and may be used for displaying external AC and DC signals on the Analog Display SMFS-B9.

Demodulator Probe SMFS-Z2. This probe may be used for displaying frequency response curves in the frequency range 100 kHz to 500 MHz during sweep measurements on duplexers, IF filters, tuned circuits and demodulators. It may be used with the Analog Display SMFS-B or with any other oscilloscope.

RF Probe URV-Z7 and **RF Insertion Units URV-Z2** and **URV-Z4** in conjunction with the RF Millivoltmeter SMFS 2-B8 permit the measurement of RF voltages and RF levels in the wide frequency range 10 kHz to 1 GHz and with the wide dynamic range 1 mV to 100 V (depending on model).

Table of options and extras

× Option can be fitted – Option cannot be fitted		• 9	 Standard equipment 		¹) Only with SMFS2B7	
Options			SMFP2	SMFS2	SMFP	Γ
Reference Oscillator	SMS-B1		×		×	t

Options		SMFP2	SMFS2	SMFP	SMFS
Reference Oscillator	SMS-B1	×		×	×
1-GHz Frequency Extension	SMFP-B2	×	×	×	×
60-Watt Power Meter	SMFP2B3	×	×		
Adjacent-channel Power Meter	SMFP-B6	×	×	×	×
Control Interface	SMFS-B5	•	×		×
AF Synthesizer	SMFS-B7	-	777 8		×
AF Synthesizer/Selective Call Encoder	SMFS2 B7	•	×		-
Selective Call Decoder	SMFS2 B6	×	×1)		
RF Millivoltmeter	SMFS2 B8	×	×		223
Analog Display	SMFS-B9	×	×	×	×
Extras					
Protective Cover	SMFP-Z8	×	×	×	X
19" Adapter	SMFP-Z9	×	×	×	×
19" Adapter	SMFS Z10	×	x	×	x
For Analog Display SMFS-B9:					
Oscilloscope Probe	SMFS-Z1	×	×	x	×
Demodulator Probe	SMFS-Z2	×	x	×	×
For RF Millivoltmeter SMFS2 B8:					
RF Probe	URV-Z7	×	×	121	
RF Insertion Unit	URV-Z2	×	×	2 4 3	_
RF Insertion Unit	URV-Z4	×	×		

RADIO TEST ASSEMBLIES 3

Specifications of SMFP 2	and SMFS 2	2
Receiver measurement		
– Test signals –		
	0.4 to 520 MH-	
Signal-generator frequency range	(to 1000 MHz with	n option)
Frequency setting	via keyboard 8-digit display	
Resolution	100 Hz	rence frequency
Accuracy and drift	(crystal)	active aequeticy
Reference oscillator	Standard	Option SMS-B1
Aging	month	month
Effect of temperature	<±1 × 10 ⁻⁶ /°C	<±1 × 10 ⁻⁷ over
		specified tempera- ture range after
Output level CW and FM	-137 to +13 dP	15 min warmup
	(0.032 JV to 1.V	into 50 O)
AM	(0.032 uV to 0.5 ¹	V into 50 Ω)
Setting Fine level setting	via keyboard	
	without intomatic	n of output signal
Indication	31/2-digit display	oraBm
Resolution	0.1.dB	ncy-response
	error ¹)	
Frequency response	flat +1 dB (0.4 to	9 MHz)
Output impedance	50 Ω, VSWR ≦1.2 connector: N fem	$2 (\text{level} \leq -3 \text{dBm})^1)$
Spectral purity		
Harmonics	≥30 dBc down ²)	
Non-harmonics spurious signals	≧60 dBc down²) (carrier)	S KHZ IIOM
Spurious FM, rms 0.3 to 3 kHz	. ≦4 Hz (weighted	in accordance with
	CCITT)	accordance mul
Spurious AM, rms 0.03 to 20 kHz Single-sideband phase noise	. ≧70 dBc down²)	
Single-sideband phase noise	typ. 120 dBc dow 1 Hz, 20 kHz fror	n²) (test bandwidth n carrier)
Single-sideband broadband		
nuise	1 Hz, 2 MHz from	n carrier)
Modulation generator	SMFP 2	SMFS 2
	AF synthesizer (continuous adj.	with option as for SMFP 2, otherwise
	Selective Call	fixed frequencies
Frequency range Resolution f < 1 kHz	Encoder) 10 Hz to 25 kHz	only —
Resolution f < 1 kHz <10 kHz	0.1 Hz 1 Hz	Ξ.
>10 kHz Selectable fixed frequencies	10 Hz	
Coloradio integradicios com	1.25/2.7/3/	1/1.25/2.7/3/4/
Indication	6 kHz 4 digits	6/8/10 kHz 4 digits
Frequency error	as for reference	±1%
Distortion	.≦1%	≦1%
Output EMF Resolution V <100 mV V <1 V	0.1 mV to 4.995 0.1 mV	0.1 mV
V <1 V V <5 V	1 mV 5 mV	1 mV 5 mV
Error of output voltage		
V >1 mV V <1 mV Source impedance	±(2%+0.1 mV) typ. 2%	±(2%+0.1 mV) typ. 2%
Source impedance Minimum load impedance	approx. 1 Ω	50 Ω
V <100 mV V >100 mV	$R_L \ge 1 \Omega$	any
Selective Call Encoder		any
Standard tone sequences	tones 0 to 9 + re tone in accordance	peat e with ZVEI and
Number of single tones	CCIR	
Amplitude modulation	1100	
Frequency range:		
internal, external	50 Hz to 5 kHz	(f >8 MHz) (f <8 MHz)
Modulation depth	0 to 95%	
Indication . Resolution (0 to 9.95%)	0.05%	
(10 to 95%)	. 0.5% . ≤7% of rda¹) ±1	%
(8 to 520 MHz) Modulation distortion at 80%	<4% of rdg ¹) ±1	%
NUMBER OF A DESCRIPTION OF A DESCRIPTION		
modulation	≦1.5% for f _{mod} ≦ ≦5% for f _{mod} >3	3 kHz1)

Input voltage requirement (rms) at AM ext
Frequency modulation
Frequency range;
internal, external
>30 kHz typ.) Frequency deviation 0 to 125 kHz Indication 3 digits
Resolution 0 to 9.95 kHz 50 Hz
10 to 99.5 kHz 500 Hz 100 to 125 kHz 1 kHz
Error≦5% Modulation distortion
(5 kHz deviation)
Input voltage requirement (rms)
at FM ext 1 V ±1% (into 600 Ω)
Phase modulation Frequency range;
internal, external 100 Hz to 6 kHz
Phase deviation 0 to 10 rad Indication 3 digits
Resolution 0.1 rad Error ≦±5%
Input voltage requirement (rms) at ϕM ext
Double modulation possible combinations AM int.+ FM
or φM ext., FM or φM int + AM ext.
Receiver measurement
- Signal evaluation -
Audio frequency meter
Frequency range
Input level
Resolution f <10 kHz 1 Hz <100 kHz 10 Hz
<1 MHz 100 Hz Erroras for reference oscillator
AF level meter Frequency range
Measurement range 0.1 mV to 10 V
Indication
at V _{in} <1 V 1 mV at V _{in} >1 V 10 mV
at V _{in} >1 V 10 mV Error limits (f >100 Hz) ±(3% +1 digit) (f <100 Hz)
Input impedance ≧100 kΩ
Distortion meter
Measurement frequencies
Minimum input level 100 mV Indication range
3 digits, resolution 0.1% Intrinsic distortion, $V_m > 200 \text{ mV} = < 0.3\%$, 0.1% typ.
V _{in} <200 mV
d <10% ± (5% +1 digit) + intrinsic distortion
d >10% ±10% + intrinsic distortion
SINAD-ratio meter Indication range
3 digits, resolution 0.1 dB
Error limits ±1 dB Minimum input level 100 mV
S/N meter determines the S/N ratio by
switching the modulation on/off Error limits
Transmitter measurement
Transmitter measurement
RF frequency meter
Frequency range 1 to 520 MHz (to 999.99 MHz with option SMFP-B2)
Input level range at transceiver connector 50 mW to 30 W
at FREQ. METER input
Erroras for reference oscillator
Input impedance 50 Ω

With fine level adjustment = 0 dB.
 dBc = relative level referred to carrier amplitude.

3 RADIO TEST ASSEMBLIES

SMFP 2/SMFS 2 - Specifications, continued

Power meter	
Frequency range	1 MHz to 1 GHz
Measurement range Error limits for P >100 mW	10 mW to 30 W (10 to 45 dBm)
20 to 500 MHz	± (5% +1 digit) + frequency-
500 to 1000 MHz	recomes error
	response error
1 to 1000 MHz	±10% (typ.) + frequency-response error
Error limits for P <100 mW	as above, but typ.
Frequency-response flatness	
Frequency deviation meter	positive, negative or mean deviation
Frequency range	option SMFP-B2)
Deviation measurement range	100 Hz to 20 kHz
peak weighting	1 Hz to 100 Hz
Modulation-frequency range for display	
	weighting
output for demod. signal	<5 Hz to 10 kHz (3 dB)
at transceiver connector	100 mW to 30 W
at FREQ. Meter input Indication, resolution	10 mV to 1 V
Error limits	\pm (3% of rda \pm 1 digit) \pm residual EM
Spurious FM up to 500 MHz	<5 Hz (CCITT weighting), typ. 2 Hz
	<10 Hz (CCITT weighting), typ. 4 Hz
Phase deviation meter	
Frequency and input level Phase deviation measurement	as for frequency deviation meter
range	
peak weighting	0.1 to 5 rad
Indication, resolution	3 digits, 0.001/0.01 rad
Modulation-frequency range	300 Hz to 3 kHz
Additional variation with frequency	
Modulation generator	see receiver measurement
Amplitude modulation meter	
Frequency range	10 to 1000 MHz
AF trequency range	100 Hz to 10 kHz
Indication, resolution	3 digits, 0.1%
(modulation depth <80%)	
$300~\text{Hz} < f_{mod} < 3~\text{kHz}$. 100 Hz $< f_{mod} < 10~\text{kHz}$	± (5% +1 digit)
	$\pm (10\% + 1 \text{ aigit})$
DC voltmeter	2-000
Input resistance Voltage range	≧100 kΩ 1 mV to 30 V
Hesolution V < 0.3 V	1 mV
V <1 V. V <3 V.	3 mV
V <10 V	30 mV
V<30 V	100 mV
Error limits	\pm (2% + 2 digits)
DC ammeter	
Current range, resolution I	0.2 to 10.4 10 mA
	1 to 200 mA, 0.1 mA/1 mA
Indication	$3\frac{1}{2}$ digits $\pm (3\% \pm 3)$ digits)
Overvoltage protection	
Response thresholds	<1 W at RF, <5 V at DC 30 W
Remote control (SMFP 2 only) Interface	
	(Amphenol 24-way connector)
Functions	AH1, SH1, L2, T2, SB1, BL1, DC1
Parallel outputs	(via IEC-bus commands)
	12 outputs, TTL open-collector
	9 relays 100 V or 0.5 A (one relay coupled with transmitter/receiver
	switchover)
Options	
1-GHz Frequency Extension SMFP-	
Frequency range	
1000 MHz:	and antition inequency range 520 to
Resolution of frequency	200 Hz

 1000 MHZ:

 Resolution of frequency
 200 Hz

 Spurious FM
 ≦8 Hz (0.3 to 3 kHz, CCITT weighting)

test assemblies

Ourses in the	
Suppression of subharmonics and harmonics	tvp. 20 dB
Suppression of non-harmonic	
spurious signais	≧60 dB at >200 kHz from carrier ¹) ≧55 dB at >5 kHz from carrier ¹)
Error of output level	≦±1 dB + frequency-response
Frequency response of output	error ¹)
level	flat ±1 dB
Amplitude modulation Modulation distortion at 60% AM	≤5% for 1 _{mod} 100 Hz to 10 kHz ¹)
AM indication error	≦10% for I _{mod} 10 to 20 kHz ¹)
Frequency range of	and a service of the
frequency meter	1 to 999.9 MHz
adjacent-channel	
power meter (SMFP-B6)	10 to 999.0 MHz
Reference Oscillator SMS-B1	see page 91 (fitted as standard in
	SMFS 2)
60-W Power Meter SMFP 2 B3 Increases all RF power limits specifi	od obovo by 2 dP
Power measurement range	
Additional error	
for f <500 MHz f <800 MHz	
f ≧800 MHz	typ. 5%
VSWR for f <500 MHz	≤1.2
f ≧500 MHz	≦1.3
Output level of RF signal generator for CW and FM	-137 to +10 dBm
AM	-137 to +4 dBm
Overload protection Maximum safe input	60 W
Interface for Remote Control SMF (SMFS 2 only; incorporated in SMFF	
Parallel outputs	
·	3 decades BCD TTL (open collector)
	9 relays 100 V or 0.5 A (one relay coupled with T/R switchover)
Adjacent-channel Power Meter SM	IFP-86 ²)
Frequency range	10 to 519 MHz (to 999.0 MHz with
Chapter and a se	option SMFP-B2)
Channel spacings Input power range Measurement range f <520 MHz	0.1 to 30 W
Measurement range f <520 MHz	down to 72 dB below carrier down to 66 dB below carrier
Indication	dB or uW mW W 3 digite
Resolution, error limits Indication in dB	
in μW, mW, W	0.1 dB, ± 3 dB 0.001 μ W \pm (3 dB + relative error of
	power meter)
AF Synthesizer SMFS 2 B7	
(SMFS2 only; incorporated	
	see page 91 (modulation generator)
AF Synthesizer SMFS-B7	
Specifications	same as SMFS 2 B7, but without selective call encoder and with Z =
	50Ω
Selective Call Decoder SMFS2B6	
(can be fitted to SMFS 2 only in conj	unction with SMFS2B7)
Standard tone sequences	tones 0 to 9 + repeat tone in accord-
Number of single tones	ance with ZVEI and CCIR 1 to 7
Decoding range	
AF voltmeter FM meter	200 Hz to 20 kHz
φM meter	0.1 to 10 rad
AM meter Decoding probability P for relative of	fset from nominal frequency
P ≧0.995	±1% (CCIR)
P ≦0,03	±2% (ZVEI) ±3% (CCIR)
	±4.5% (ZVEI)
Response time Tone recognition	typ. 25 ms
Pause recognition	typ. 20 ms
Wrong-tone recognition	IVD. ZU MS
	ijp zo no
	, jp 20 mo
	, jp = 0 110

 With fine level adjustment at 0 dB.
 Fitting SMS-B1 together with SMFP-B6 is recommended because of the required frequency accuracy.

RADIO TEST ASSEMBLIES 3

RF Millivoltmeter	SMFS 2 884)		
Frequency range		10 kHz to 1 GHz	
Magguremont	je	depends on prot	
		depends on prot	ne)
Display	mV	31/2 digits in mV,	V or dBm
V <300	mv	1 m V	
V <1 V		3 mV 10 mV	
V < 3 V V <10 V	,	30 mV	
		nherent error + 1	Irequency
Inherent error ()/>		response error	
innerent error (V >	10 mV, V <10 mV		manurament
+ 20 to 05 10	Voltage measur		I measurement
+20 to 25°C +15 to 30°C	3% + 6 digits 4% + 6 digits		1B +1 digit 1B +1 digit
+5 to 40°C	5% + 8 digits		0.5 dB
Frequency response			
depends on probe Probes	; see UHV 3	BE Probe LIBV/-7	7
		10-V Insertion Ur	
		100-V Insertion L	Init URV-Z4
Analog Display S	MFS-B9		
Oscilloscope			
Screen size Frequency range		3×4 cm	
DC coupling .			
AC coupling .		5 Hz to 50 kHz	
Timebase		0.05 to 100 ms/d	liv
		with 1-2-5 stepp	ing
Y deflection			
EXT. mode			
INT. mode		with 1-2-5 stepp FM: 10 Hz/div to	ng 20 kHz/div
		AM: 0.05 to 100°	%/div
		pM: 0.005 to 10 AF: 5 mV/div to	
		with 1-2-5 stepp	ing
INT. AUTO LE	VEL mode		h constant tually entire level
¥		range	tadity of the level
X output (sawtoo Output voltage	olh) •	1.41 V. into 600	0
o super voltage		(matched to MOD	. EXT. input on
Analog displays		SMEP 2/SMES 2)	
analog displays		scales and superi	mposed full-scale
		values; 6-dB, 12-dB and	
		of 25-dB SINAD r	
Test parameters		brightened	
Test parameters in receiver testing	a	SINAD ratio and	AF level
pushbutton-se	lected	distortion of AF o	utput level, power
Test parameters in transmitter tes	ting	power and positiv	e or negative
		modulation, which	never is greater,
pushbutton-se	lected	with additional +.	I = LED display tion. SINAD ratio
		of demodulated s	ignal
Measurement ra	nges	0 5/2 5/5/12 5 V	
FM		1/5/10/25 kHz	
AM		5/25/50/125%	ad
SINAD ratio .		25/50 dB	
Distortion	30 W)	5/EO0/	
Resolution	30 vv)	2% of FS	
		same as basic ur	
		only tendency in for power <0.5 V	
General data			
Rated temperature	range	+5 to +45°C	
Storage temperature Mechanical resistant	nce	shockproof in acc	ordance with DIN
		40 046, Part 7 (30	0 g, 11 ms);
	2	vibration test in ac	cordance with 8 (11 to 55 Hz, 2 g);
		corresponds to IE	EC Publications
Power supply, AC		68-2-27 and 68-2 115 to 125 V/220	
site supply, no t		±10% (125 VA),	
batte	ery	safety class I 11 to 33 V (95 W)
Dimensions; weigh	nt		/
SMEP 2/SMES 2	A SHORE AND A S	(1) mm > 206 mm	n V / 85 mm 9/ kg

Imensions; weight SMFP2/SMFS2 470 mm×206 mm×485 mm, 24 kg with SMFS-B9 470 mm×254 mm×485 mm, 28 kg

	for Analog Display SMFS-B9
(Oscilloscope Probe SMFS-Z1
1	Attenuation/bandwidth 10:1/approx. 100 MI
	1:1/approx. 10 MHz Ground
I	Aaximum permissible voltage . 400 Vp
(C compensation range up to 60 pF
ļ	Connector BNC
I	Demodulator Probe SMFS-Z2
	Frequency range 100 kHz to 500 MHz
	nput capacitanceapprox. 4 pF Maximum permissible voltage
i	Polarity
(Connector BNC
1	ofor RF Millivoltmeter SMFS2B8
1	F Probe URV-Z7
•	RF Probe URV-Z7 10-V Insertion Unit URV-Z2 See page 207
ľ	00-V Insertion Unit URV-Z4
(Ordering information
	Order designation
;	SMFP2
\$	SMFP 2
1	Accessories supplied
	0-Ω termination, adapter board, power cable
(Options
	Reference Oscillator SMS-B1 302.8918.02
Ì	I-GHz Frequency Extension SMFP-B2
1	20-W Power Meter SMFP 2 B3 357.8610.02
1	Adjacent-channel
	Power Meter
1	AF Synthesizer SMFS-B5 ⁻) 332.9506.02
1	AF Synthesizer/
į	Selective Call Encoder SMFS 2 B7 ²) 346.6810.02 Selective Call Decoder SMFS 2 B6 ³) 346.7000.02
Ì	RF Millivoltmeter SMFS 2 B8 ⁴) 332.9306.02
,	RF Millivoltmeter SMFS 2 B8 ⁴) 332.9306.02 Analog Display SMFS-B9 346.5008.02
	Recommended extras
ļ	Basic Software SMFP 2 K1 358.2015.02
ļ	Process Controller PUC
į	EC-bus Cable (1 m) PCK
l	Protective Covers SMFP-Z8 ⁵) 332.7890.02
1	19" Adapter for SMFP 2/SMFS 2
	without SMFS-B9 SMFP-Z9 332.7978.02
	for SMFP 2/SMFS 2
1	with SMFS-B9 SMFS Z10 346.6710.02
	Power attenuators; see page 286
	Recommended extras for Analog Display SMFS-B9
Ì	Dscilloscope Probe SMFS-Z1 358.0312.02 Demodulator Probe SMFS-Z2 358.0412.02
I	Demodulator Probe SWOB 3-Z
l	BNC Adapter URV-Z
	Termination RMF (BNC) 100.2927.50 (50 Ω)
	Recommended extras for RF Millivoltmeter SMFS 2B8
1	RF Probe
	50 Ω/N connector
	50 Ω/Dezifix B connector

Fitting SMS-B1 together with SMFP-B6 is recommended because of the required frequency accuracy.
 Only for SMFS and SMFS2; fitted as standard in SMFP and SMFP2.
 For SMFS 2 only together with AF Synthesizer/Selective Call Encoder SMFS2B7.
 Without probe; for probes see recommended extras.
 Not together with Analog Display SMFS-B9.
 For SMFS only, not for SMFS2.
 Fitted as standard in SMFS2.
 Fitted as standard in SMFS2.
 Without SMFS2B6 P_{max} = 30 W.

3 RADIO TEST ASSEMBLIES

test assemblies



With the **Automatic RX/TX Tester SMAT** a go/nogo tester for transceivers is now available which permits extremely fast performance testing. Within seconds it

- checks the major transceiver performance parameters
- compares the measured values with the stored limit values
- indicates the in-tolerance and out-of-tolerance states by green and red LEDs.

The SMAT can **store** a variety of test programs for as many as **75 different transceiver types;** it controls the test sequence and automatically sets the connected transceiver for the measurement to be carried out.

The SMAT is based on the concept of the worldwide successful Mobile Testers SMFP and SMFS (SMFP2 and SMFS2).

Measuring facilities in the SMAT

Generator section	Measuring section (* = option)
RF synthesizer AF synthesizer Pilot-tone generator Selective call encoder (option)	RF frequency meter AF frequency meter Demodulators for AM, FM, φM RF power meter AF voltmeter S/N ratio meter SINAD ratio meter
Control section	Distortion meter
4 relays 3 control lines	150-Hz notch filter 300-Hz high-pass filter Selective call decoder

Applications

The SMAT is used to advantage not only by transceiver manufacturers (e.g. for final checkout before the transceivers are packed or for checking subcontracted units) but wherever the proper functioning of a transceiver is of great significance and/or where **large numbers have to be checked within a very short time**, for example when transceivers are supplied from stock to users such as the police, disaster missions, various other kinds of authorities and the armed forces, either for routine daily operations or, and especially, for exercises, in crises, etc.

The different operating levels of the SMAT – fully automatic test sequence with overall evaluation, calling up of group measurements with evaluation or individual measurements – enable, in conjunction with alphanumeric display of the value measured, systematic searching and location of defective modules and make the SMAT an ideal testing and measuring instrument for the various equipment maintenance levels.

Extreme operational convenience, exclusion of operator's errors and the simplicity of the SMAT permit its use by non-technical personnel.

	Measurement	Stored limit values
тх	RF power	Minimum
T E S T	Modulation Maximum modulation Pilot-tone modulation Modulation distortion	Minimum/maximum Maximum Minimum/maximum Maximum
	RF frequency	Offset in Hz
RX	AF voltage . AF distortion	Minimum/maximum Maximum
T E S T	S/N ratio SINAD ratio Receiver function at min. RF level (tight squelch)	Minimum Minimum

Measurement capabilities and parameters

The Automatic RX/TX Tester SMAT measures and weights the major performance parameters (see table above) of AM, FM, ϕ M and SSB transceivers (no distortion and pilot-tone modulation measurements on SSB equipment). The test parameters for the individual measurements and the limit values to be adhered to can be entered separately for each transceiver type; programming is necessary only once prior to first-time operation. Later modification or extension is readily possible.

Transmitter test

The SMAT measures the **RF power** – up to 30 W or, with option, up to 60 W – of AM, FM and ϕ M transceivers with an unmodulated carrier and of SSB transceivers with a 1-kHz-modulated carrier. Higher powers can be measured using attenuators, whose attenuation settings are entered together with the transceiver-type specific test program and automatically taken into account in all measured parameters.

The SMAT measures the modulation of AM, FM and ϕ M transceivers at the modulation voltage determined by the program and at 1 kHz modulation frequency; double modulation with 1 kHz and 1.66 kHz is used to measure SSB transceivers. The filter option is used for transceivers working with pilot tones, to suppress the pilot tones and to determine the useful modulation; either a 300-Hz high-pass filter or a 150-Hz notch filter is then automatically connected in the measurement paths. The pilot-tone modulation is measured by switching off the useful-modulation voltage; frequency is determined to within ± 0.1 Hz. Modulation distortion can also be determined with the aid of the filter option.

The **RF frequency** of AM, FM and ϕ M transceivers is measured on an unmodulated carrier with 10 Hz resolution, that of SSB transceivers by modulation with a crystal-referenced 1-kHz signal with 1 Hz resolution, the frequency shift due to modulation and the selected sideband being taken into account automatically.

Receiver test

Frequency. The RF test frequency required for the receiver test can either be stored or be entered through the keypad or results from the preceding transmitter frequency measurement. The frequency is determined by different methods depending on the measurement program:

- a) calculation from the measured transmitter frequency by addition or subtraction of a programmable frequency offset
- b) determination of the nearest integral multiple of the programmable channel spacing.

The receiver measurements are performed at the exact rated receiver frequency even if the transmitter frequency is offset.

When measuring AF voltage for receiver testing the operator is prompted by + and - symbols on the display to set the volume of the AF output singal to the programmed voltage range. A choice of four **programmable load resistances** is here possible. If the filter option (SMAT-B6) is incorporated, the distortion of the AF singal is checked at the voltage set.

RADIO TEST ASSEMBLIES 3



Display of measured value: example power measurement

Sensitivity. For checking sensitivity the SMAT measures signal/noise ratio or, with the filter option incorporated, the SINAD ratio of the programmed RF level. With AM, FM and ϕ M transceivers the S/N ratio is determined switching the modulation on and off and with SSB transceivers by offsetting the RF by 1 MHz. SINAD ratio is measured using an appropriate notch filter.

To check the receiver performance at minimum RF level, the transceiver output voltage is measured; if it is not more than 20 dB below the output voltage of the AF measurement, the receiver function is considered satisfactory.

Setting the transceiver

For setting the transceiver to the particular measurement

4 relays (N/C contact), 1 switching relay and 3 programmable control lines

are provided in the SMAT. Their positions or logic states during the test are partly given by and partly linked to the transceiver-specific test program. The following functions, for example, can be performed: selection fo operating mode, on/ off switching of squelch and loudspeaker, changing of signal source.

Further applications

For industrial applications that do not involve SSB transceivers, use of the AF Synthesizer/Selective Call Encoder option and the Selective Call Decoder option is recommended instead of the incorporated two-tone generator. This makes it possible to measure and evaluate the following additional parameters:

Transmitter test:	modulation frequency response (3 fre- quencies),
	selective call decoding to ZVEI and CCIR
Receiver test:	AF frequency response (3 frequencies), selective call encoding to CCIR and ZVEI, generation of any pilot tones.

In transceivers using a tone sequence, the tone sequence is started in the transmitter test either automatically via a relay contact or a programmable control line or through the user following a prompt given on the display, and is then decoded by the SMAT. In the receiver test, the transceiver is activated either by the call derived from the transmitter test or by the user entering the call code following the corresponding prompt.

For checking **frequency response** in transmitter and receiver tests, two frequencies with the associated maxima and minima of modulation or AF voltage can be programmed for each operating mode, in addition to the values programmed at 1 kHz.

3 RADIO TEST ASSEMBLIES

test assemblies

SMAT - Operation

Operation and test sequence

The built-in intelligence makes operation of the RX/TX Tester very simple. After the transceiver has been connected using only two cables – an RF cable for the transmit and receive signal and a cable for the modulation voltage, the AF output signal of the transceiver and the control section of the SMAT – the measurement can be called up. All other operations are called up by the SMAT.

During fully automatic testing – started at the push of a button – all entered individual measurements are automatically performed one after the other. The measured values are compared with the stored limit values and the result of this comparison is indicated by coloured LEDs – green for in tolerance and red for out of tolerance. The transmitter frequency and the receiver test frequency are briefly indicated after the transmitter and receiver tests have been completed so that they can be checked if desired. Upon completion of all measurements, overall evaluation is provided by large-scale flashing light bars.



Light bars for performance assessment of the transceiver upon completion of the automatic test

In addition, all group measurements of the transmitter test – power, modulation and transmit frequency – and the receiver test – AF voltage and S/N ratio – can be called up individually at the push of a button. In this case all of the individual measurements programmed for the particular group measurement are performed and evaluated.

Furthermore, all individual measurements can be called up by entering their number and pressing the appropriate group measurement button, e.g. modulation. The measurement and evaluation are performed continuously and the measured value is read out on the alphanumeric display, thus enabling adjustments to be carried out. During individual measurements the stored limit values can be extended at the push of a button. this means that transceivers can be checked for reduced performance.

Transmitter measurements—____Receiver measurements

Automalic test sequence										
Group meas. Power	Gro Mo	up m dulat	eas ion	Group meas. Frequency	Gro AF	up m	ieas	Grou S/N	ip mea	S.
	1	to	n		1	to	n	1	to	n
1 indiv meas	n in mea	div as		1 indiv meas	n i me	ndiv as	*	n in mea		

Test sequence and operating levels of the SMAT (table on left)

- Call-up of automatic test sequence with all stored group and individual measurements and overall evaluation.
- Call-up of any group measurement with all its individual measurements and evaluation.
- Call-up of any individual measurement with alphanumeric display of the measured value.

These different operating levels enable the wide-ranging use of the SMAT, from a simple-to-operate, fully automatic tester through to a precise measuring instrument with digital display of the measured values, in all areas of transceiver testing. Besides transceiver performance checking within seconds, the SMAT also permits location of defective modules. The test sequence being determined by transceiver-specific test programs the SMAT can be set up for any applications.

In conjunction with the interface option, a printer with a Centronics interface (8-bit parallel) connected directly to the SMAT permits hardcopy output of the measured values including the stored limit values and furnishes useful information as a guide to any repairs that may be called for.

Programming

Programming the SMAT is necessary only once prior to firsttime operation. The stored data may, however, be readily modified or extended to include new transceiver types.

In the basic version, the required measurements, test parameters and limit values are entered separately for each type of transceiver directly via the keyboard and are stored in battery-backed memories. for this purpose, a **program sheet** (see next page) is supplied, showing for every entry the appropriate storage location, the required number of digits to be entered and the input units. The memory addresses are automatically advanced and indicated during entry, meaning that the entry is restricted to the numerical values previously entered in the program sheet. For corrections, modifications and additions any storage location can of course be directly accessed from the keyboard and the memory contents – test function, test parameter or limit value – altered.

In conjunction with the interface option, entry is possible in a similar manner from a computer with a V.24/RS232 interface, e.g. the Process Controller PUC.

As a third means of **programming**, EPROMs (2716) previously loaded by means of a programmer can be fitted instead of built-in memories which are programmable from the SMAT.

Program backup. A switchable programming guard prevents both inadvertent erasure or alteration and manipulation of loaded test programs. The backup battery incorporated in the SMAT for the memories has a service life of approx. 5 years. It can be exchanged while the SMAT is operating on the power line; new programming is not required.

Example of program writing

(see filled-in program sheet below)

Under program No. 1 an FM transceiver (lines 1 and 2) is to be tested; band interval between transmit and receive frequencies 8.6 MHz (lines 3, 4), channel spacing 25 kHz (line 5) The frequency of the fictitious zero channel is taken as 0 MHz (line 6), that is the minimum, indivisible frequency calculated by repeatedly subtracting the channel spacing from a random channel frequency: random channel frequency/(n × channel spacing) = zero-channel frequency + remainder. The receiver measurement is to be performed at the rated frequency (channel frequency) (line 7),

External **attenuators** are not needed with the transmitter power here assumed (line 8). The control of the transceiver is fixed under control menu 3 (line 9), contains the position of the relay and the state of the control lines at any time of the test sequence). Neither pilot-tone nor selective-calling techniques are used (line 10).

RADIO TEST ASSEMBLIES 3

Transmitter power must be more than 18 W and less than 25 W (lines 11, 12, 13). Modulation voltage should be 12.5 mV (line 14) and the deviation at this level be between 2.8 and 3.5 kHz (lines 15, 16). Maximum modulation must not exceed 4 kHz deviation (line 17) and maximum modulation distortion 3% (line 18). No modulation frequency response measurement need be performed (line 19). The departure of the transmit frequency from rating must be less than 500 Hz (line 20).

Receiver test. Modulation from internal generator (line 21), deviation setting 2.8 kHz (line 22), loading of transceiver AF output 100 k Ω (line 23). For AF measurement the **RF level** should be 500 μ V (line 24) and the output voltage be between 2.5 and 3.5 V (lines 25, 26). Distortion must be below 5% (line 27) No AF frequency response measurement need be performed (line 28)

Sensitivity or signal/noise ratio is to be measured by the S/N method (line 29) at an RF level of 1.5 μ V (line 30). The value measured must be greater than 20 dB (line 31). The squelch must respond at 0.5 μ V (line 32)

Program modification. The following slight modification of a program example shows that programming is simple and yet extremely flexible.

If the unit being tested is a **receiver only**, "1" is to be entered in line 2 A fixed **RF** for the receiver measurement is entered in line 3; if the operator is to be prompted to **enter** the frequency **via the keypad**, zeros are to be entered.

Line	ige location (first two figures program No.) Setups, test functions, test parameters, tolerance limits Input unit	Easy programming of SMAT based on a completed program sheet as example
DEVICE: 1 Q 4 001 3 Q 4 02 4 09 5 Q 4 109 5 Q 4 109 5 Q 4 109 6 Q 4 109 6 Q 4 109 6 Q 4 124 7 0 4 124 8 Q 4 124 10 0 4 222	PROGR.1, GERÄT XYZ MODULATION: FM=1, AM=2, PM=3, SSBL=4, SSBU=5 TYPE: T/R=0, R=1 TX/RX-FREQUENCY OFFSET QQB & QQ TX/RX-FREQUENCY OFFSET QQB & QQ CHANNEL SPACING ZERO-CHANNEL FREQUENCY RX-FREQUENCY ROUNDING: ON=1, OFF=0 EXTERNAL ATTENUATION CODE MENUE: NONE=0 OR 1,2,3,4	Transceiver description TX and RX test parameters
11 Q 1 23 12 Q 1 224 13 Q 1 27 14 Q 1 304 15 Q 1 37 16 Q 1 437 17 Q 1 45 19 Q 1 45 20 Q 1 46	DIMENSION OF LIMITS: 10MW=1,100MW=2,1W=3 3 TX-OUTPUT POWER UDWER LIMIT 2 1 MODULATION AF-LEVEL 2 1 MODULATION AF-LEVEL 2 1 MODULATION UPPER LIMIT 2 1 MODULATION DEFENSE 0 11X.0.1KHZ.0.1RAD MAXIMUM MODULATION 2 1 MAXIMUM DISTOTION 2 1 MOD. FREQ. RESPONSE MENUE: NONE=0 OR 1,2,3,4 2 TX-FREQUENCY PRECISION 2 5 2 2	Power TX T T Modulation E S T Frequency
212 23 244 557 444 414 4144 414	MODULATION SOURCE: INTERN=1, EXTERN=2 MODULATION AM FM OR PM AF-VOLT IMPEDANCE: R1=1,R2=2,R3=3,100KOHM=4 0.1%,0.1KHZ,0.1RAD RF-LEVEL FOR AF-MEASUREMENTS AF-VOLTAGE LOWER LIMIT AF-VOLTAGE LOWER LIMIT AF-VOLTAGE LOWER LIMIT AF-VOLTAGE LOWER LIMIT AF-VOLTAGE LOWER LIMIT G 2 5 0 100V MAXIMUM DISTORTION AF-REQUENCY RESPONSE MENUE: NONE=0 OR 1,2,3,4 0.1%,0.1KHZ,0.1RAD SIGNAL TO NOISE RATIO: S/N=1,SINAD=2 RF-LEVEL FOR S/N AND SINAD-MEASUREMENT MINIMUM RF-LEVEL FOR RX-OPERATION 100UV 0.1UV 0.1UV	RX test parameters AF T S/N ratio

BADIO TEST ASSEMBLIES 3

test assemblies

SMAT - Programming

The menu programs - control function for the transceiver during testing, code menu for setting and evaluating pilot tones and selechive calls, modulation frequency response menu and AF frequency response menu with statement of test parameters and tolerances - are in the form of subroutines. They are programmed separately and can be simply called up for integration into the running routine (lines 9; 10, 19, 28) Identical subroutines for different transceiver types need be programmed only once and any modification desired is easy to perform: only one number must be entered to call another subroutine in the running routine.

Specifications

The Automatic RX/TX Tester is designed for transmitter and receiver measurements up to 520 MHz; a model with a frequency range up to 1 GHz can be supplied (on request).

0.4 to 520 MHz

<1 × 10-7 over operating temperature range after 15 min warmup

100 Hz

R	eceive	er me	asurer	nents

RF generator

Frequency range Error same as reference oscillator

Reference oscillator

RF level

For AF and distortion measurement Resolution	
For S/N and SINAD measurement	
Resolution	
Error	$<\pm 1$ dB + frequency response error
Frequency response error	<±0.5 dB (8 to 520 MHz)
	<±1 dB (0.4 to 8 MHz)
Output	N female connector
Output impedance	
VSWR	<1.2

Spectral purity

Spurious FM	<4 Hz (0.3 to 3 kHz, CCITT
	weighting)
Spurious AM	<-70 dBc (0.3 to 3 kHz, CCITT
	weighting)
SSB phase noise	typ120 dBc (test bandwidth 1 Hz,
	20 kHz from carrier)
Broadband noise	typ -145 dBc (test bandwidth 1 Hz,
	2 MHz from carrier)

Modulation generator (standard)

Frequency. 1 kHz Frequency accuracy Distortion y same as reference oscillator

Pllot-tone generator

 Frequency
 150 Hz (can be changed)

 Frequency error
 <1%</td>

 Distortion
 <1%</td>

Amplitude modulation	
Modulation depth	0 to 95%
Resolution at 0 to 9.9%	
10 to 95%	0.5%
AM error at f ≧8 MHz	<4% of setting +1%
f <8 MHz	<7% of setting +1%
at 80% mod., fmod = 1 kHz	<1.5%
Frequency modulation	
Frequency deviation	0 to 99.5 kHz
Resolution at 0 to 9.9 kHz	
10 to 99.5 kHz	
Modulation distortion	-070
at $\Delta f = 5 \text{ kHz}$, $f_{mod} = 1 \text{ kHz}$	<1%
Disease and distantion	
Phase modulation	
Phase deviation Resolution	
φM error at 1 kHz	
the start at the start start start	
External modulation	
Input requirement	1 V ±1% across 600 Ω
Modulation frequency range	
AM, f _{carrier} ≧8 MHz <8 MHz	50 Hz to 20 kHz
 Keiner 2 FM 	
φM	100 Hz to 6 kHz
AF voltmeter	
Input impedance	4 Ω, 16 Ω, 600 Ω, 100 kΩ;
Frequency range	50 Hz to 20 kHz
Voltage range	50 THE 10 EO KITE
$Z_{in} = 4 \Omega, 16 \Omega, 100 k\Omega (\pm 5\%)$	1 mV to 10 V
$Z_{in} = 600 \Omega (\pm 10\%)$	5 mV to 50 V
Resolution	
	1 mV (V < 1 V) 10 mV (V > 1 V)
at 600 0	1 mV ($V_{in} <$ 1 V), 10 mV ($V_{in} >$ 1 V) 5 mV ($V_{in} <$ 5 V), 50 mV ($V_{in} >$ 5 V)
at 600 Ω	$5 \text{ mV} (V_{in} < 5 \text{ V}), 50 \text{ mV} (V_{in} > 5 \text{ V})$ <± (5% + resolution)
at 600 Ω	$\begin{array}{l} 5 \text{ mV } (V_{in} < \!\!\! 5 \text{ V}), \ \!\!\! 50 \text{ mV } (V_{in} > \!\!\!\! 5 \text{ V}) \\ < \!\!\! \pm (5\% \ + \ \!\!\! \text{resolution}) \\ 5 \text{ W} \end{array}$
at 600 Ω	$\begin{array}{l} 5 \text{ mV } (V_{in} < \!\!\! 5 \text{ V}), \ \!\!\! 50 \text{ mV } (V_{in} > \!\!\!\! 5 \text{ V}) \\ < \!\!\! \pm (5\% \ + \ \!\!\! \text{resolution}) \\ 5 \text{ W} \end{array}$
at 600 Ω Error Max. input power Limit programming	$\begin{array}{l} 5 \text{ mV } (V_{in} < \!\!\! 5 \text{ V}), \ \!\!\! 50 \text{ mV } (V_{in} > \!\!\!\! 5 \text{ V}) \\ < \!\!\! \pm (5\% \ + \ \!\!\! \text{resolution}) \\ 5 \text{ W} \end{array}$
at 600 Ω Error Max. input power Limit programming S/N meter	5 mV (V _{in} <5 V), 50 mV (V _{in} >5 V) <± (5% + resolution) 5 W 4 digits, resolution 10 mV
at 600 Ω Error Max. input power Limit programming	5 mV (V _{in} <5 V), 50 mV (V _{in} >5 V) <± (5% + resolution) 5 W 4 digits, resolution 10 mV 6 to 46 dB
at 600 Ω Error Max. input power Limit programming S/N meter Measurement range Resolution Error	5 mV (V _{in} <5 V), 50 mV (V _{in} >5 V) <± (5% + resolution) 5 W 4 digits, resolution 10 mV 6 to 46 dB 0.1 dB <±1 dB
at 600 Ω . Error Max. input power Limit programming S/N meter Measurement range Resolution Error Minimum input level	5 mV (V _{in} <5 V), 50 mV (V _{in} >5 V) <± (5% + resolution) 5 W 4 digits, resolution 10 mV 6 to 46 dB 0.1 dB <±1 dB 100 mV
at 600 Ω Error Max. input power Limit programming S/N meter Measurement range Resolution Error	5 mV (V _{in} <5 V), 50 mV (V _{in} >5 V) <± (5% + resolution) 5 W 4 digits, resolution 10 mV 6 to 46 dB 0.1 dB <±1 dB 100 mV
at 600 Ω . Error Max. input power Limit programming S/N meter Measurement range Resolution Error Minimum input level Limit programming	5 mV (V _{in} <5 V), 50 mV (V _{in} >5 V) <± (5% + resolution) 5 W 4 digits, resolution 10 mV 6 to 46 dB 0.1 dB <±1 dB 100 mV 2 digits, resolution 1 dB
at 600 Ω Error Max. input power Limit programming S/N meter Measurement range Resolution Error Minimum input level Limit programming SINAD meter	$\begin{array}{l} 5 \text{ mV }(V_{in} < 5 \text{ V}), 50 \text{ mV }(V_{in} > 5 \text{ V}) \\ < \pm (5\% + \text{resolution}) \\ 5 \text{ W} \\ 4 \text{ digits, resolution 10 mV} \\ \end{array}$
at 600 Ω Error Max. input power Limit programming S/N meter Measurement range Resolution Error Minimum input level Limit programming SINAD meter AF frequency meter	5 mV ($V_{in} < 5$ V), 50 mV ($V_{in} > 5$ V) < $\pm (5\% + resolution)$ 5 W 4 digits, resolution 10 mV 6 to 46 dB 0.1 dB < ± 1 dB 100 mV 2 digits, resolution 1 dB see options for transmitted pilot tones
at 600 Ω . Error	5 mV ($V_{in} < 5 V$), 50 mV ($V_{in} > 5 V$) $<\pm (5\% + resolution)$ 5 W 4 digits, resolution 10 mV 6 to 46 dB 0.1 dB $<\pm 1$ dB 100 mV 2 digits, resolution 1 dB see options for transmitted pilot tones 20.0 to 999.9 Hz
at 600 Ω . Error Max. input power Limit programming S/N meter Measurement range Resolution Error Minimum input level Limit programming SINAD meter AF frequency meter Frequency range Resolution	5 mV ($V_{in} < 5 V$), 50 mV ($V_{in} > 5 V$) $<\pm (5\% + resolution)$ 5 W 4 digits, resolution 10 mV 6 to 46 dB 0.1 dB $<\pm 1 dB$ 100 mV 2 digits, resolution 1 dB see options for transmitted pilot tones 20.0 to 999.9 Hz 0.1 Hz
at 600 Ω . Error Max. input power Limit programming S/N meter Measurement range Resolution Error Minimum input level Limit programming SINAD meter AF frequency meter Frequency range Resolution	5 mV ($V_{in} < 5 V$), 50 mV ($V_{in} > 5 V$) $<\pm (5\% + resolution)$ 5 W 4 digits, resolution 10 mV 6 to 46 dB 0.1 dB $<\pm 1 dB$ 100 mV 2 digits, resolution 1 dB see options for transmitted pilot tones 20.0 to 999.9 Hz 0.1 Hz
at 600 Ω . Error . Max. input power . Limit programming	5 mV ($V_{in} < 5 V$), 50 mV ($V_{in} > 5 V$) $<\pm (5\% + resolution)$ 5 W 4 digits, resolution 10 mV 6 to 46 dB 0.1 dB $<\pm 1$ dB 100 mV 2 digits, resolution 1 dB see options for transmitted pilot tones 20.0 to 999.9 Hz
at 600 Ω . Error . Max. input power . Limit programming	5 mV (V _{in} <5 V), 50 mV (V _{in} >5 V) $<\pm$ (5% + resolution) 5 W 4 digits, resolution 10 mV 6 to 46 dB 0.1 dB $<\pm$ 1 dB 100 mV 2 digits, resolution 1 dB see options for transmitted pilot tones 20.0 to 999.9 Hz 0.1 Hz same as reference frequency rated frequency and offset in 1 Hz or 0.1 Hz (3 digits)
at 600 Ω . Error . Max. input power . Limit programming	5 mV ($V_m < 5 V$), 50 mV ($V_m > 5 V$) $<\pm (5\% + resolution)$ 5 W 4 digits, resolution 10 mV 6 to 46 dB 0.1 dB $<\pm 1$ dB 100 mV 2 digits, resolution 1 dB see options for transmitted pilot tones 20.0 to 999.9 Hz 0.1 Hz same as reference frequency rated frequency and offset in 1 Hz or 0.1 Hz (3 digits)
at 600 Ω . Error . Max. input power . Limit programming	5 mV (V _{in} <5 V), 50 mV (V _{in} >5 V) $<\pm$ (5% + resolution) 5 W 4 digits, resolution 10 mV 6 to 46 dB 0.1 dB $<\pm$ 1 dB 100 mV 2 digits, resolution 1 dB see options for transmitted pilot tones 20.0 to 999.9 Hz 0.1 Hz same as reference frequency rated frequency and offset in 1 Hz or 0.1 Hz (3 digits)
at 600 Ω . Error . Max. input power . Limit programming	5 mV (V _{in} <5 V), 50 mV (V _{in} >5 V) $<\pm$ (5% + resolution) 5 W 4 digits, resolution 10 mV 6 to 46 dB 0.1 dB $<\pm$ 1 dB 100 mV 2 digits, resolution 1 dB see options for transmitted pilot tones 20.0 to 999.9 Hz 0.1 Hz same as reference frequency rated frequency and offset in 1 Hz or 0.1 Hz (3 digits)
at 600 Ω . Error . Max. input power . Limit programming	5 mV ($V_m < 5 V$), 50 mV ($V_m > 5 V$) $<\pm (5\% + resolution)$ 5 W 4 digits, resolution 10 mV 6 to 46 dB 0.1 dB $<\pm 1$ dB 100 mV 2 digits, resolution 1 dB see options for transmitted pilot tones 20.0 to 999.9 Hz 0.1 Hz same as reference frequency rated frequency and offset in 1 Hz or 0.1 Hz (3 digits)
at 600 Ω . Error . Max. input power . Limit programming	5 mV ($V_m < 5 V$), 50 mV ($V_m > 5 V$) $<\pm (5\% + resolution)$ 5 W 4 digits, resolution 10 mV 6 to 46 dB 0.1 dB $<\pm 1$ dB 100 mV 2 digits, resolution 1 dB see options for transmitted pilot tones 20.0 to 999.9 Hz 0.1 Hz same as reference frequency rated frequency and offset in 1 Hz or 0.1 Hz (3 digits)
at 600 Ω Error Max. input power Limit programming S/N meter Measurement range Resolution Error Minimum input level Limit programming SINAD meter AF frequency meter Frequency range Resolution Error Limit programming Selective Call Decoder	5 mV ($V_m < 5 V$), 50 mV ($V_m > 5 V$) $<\pm (5\% + resolution)$ 5 W 4 digits, resolution 10 mV 6 to 46 dB 0.1 dB $<\pm 1$ dB 100 mV 2 digits, resolution 1 dB see options for transmitted pilot tones 20.0 to 999.9 Hz 0.1 Hz same as reference frequency rated frequency and offset in 1 Hz or 0.1 Hz (3 digits)
at 600 Ω Error Max. input power Limit programming S/N meter Measurement range Resolution Error Minimum input level Limit programming SINAD meter AF frequency meter Frequency range Resolution Error Limit programming Selective Call Decoder Transmitter measurements RF frequency meter	5 mV ($V_m < 5 V$), 50 mV ($V_m > 5 V$) $<\pm (5\% + resolution)$ 5 W 4 digits, resolution 10 mV 6 to 46 dB 0.1 dB $<\pm 1$ dB 100 mV 2 digits, resolution 1 dB see options for transmitted pilot tones 20.0 to 999.9 Hz 0.1 Hz same as reference frequency rated frequency and offset in 1 Hz or 0.1 Hz (3 digits) see options
at 600 Ω Error Max. input power Limit programming S/N meter Measurement range Resolution Error Minimum input level Limit programming SINAD meter AF frequency meter Frequency range Resolution Error Limit programming Selective Call Decoder Transmitter measurements RF frequency meter Frequency range	5 mV ($V_m < 5 V$), 50 mV ($V_m > 5 V$) $<\pm (5\% + resolution)$ 5 W 4 digits, resolution 10 mV 6 to 46 dB 0.1 dB $<\pm 1$ dB 100 mV 2 digits, resolution 1 dB see options for transmitted pilot tones 20.0 to 999.9 Hz 0.1 Hz same as reference frequency rated frequency and offset in 1 Hz or 0.1 Hz (3 digits) see options 1 to 520 MHz
at 600 Ω Error Max. input power . Limit programming S/N meter Measurement range Resolution Error Minimum input level Limit programming SINAD meter AF frequency meter Frequency range Error Limit programming Selective Call Decoder Transmitter measurements RF frequency meter Frequency range Input power range Input power range	5 mV ($V_m < 5 V$), 50 mV ($V_m > 5 V$) $<\pm (5\% + resolution)$ 5 W 4 digits, resolution 10 mV 6 to 46 dB 0.1 dB $<\pm 1$ dB 100 mV 2 digits, resolution 1 dB see options for transmitted pilot tones 200 to 999.9 Hz 0.1 Hz same as reference frequency rated frequency and offset in 1 Hz or 0.1 Hz (3 digits) see options 1 to 520 MHz 50 mW to 30 W (60 W with option)
at 600 Ω Error Max. input power Limit programming S/N meter Measurement range Resolution Error . Minimum input level Limit programming SINAD meter AF frequency meter Frequency range Resolution Error Limit programming Selective Call Decoder Transmitter measurements RF frequency meter Frequency range Input power range Input power range Input power range Input power range Name	5 mV (V _{in} <5 V), 50 mV (V _{in} >5 V) < \pm (5% + resolution) 5 W 4 digits, resolution 10 mV 6 to 46 dB 0.1 dB < \pm 1 dB 100 mV 2 digits, resolution 1 dB see options for transmitted pilot tones 20.0 to 999.9 Hz 0.1 Hz same as reference frequency rated frequency and offset in 1 Hz or 0.1 Hz (3 digits) see options 1 to 520 MHz 50 mW to 30 W (60 W with option) same as reference oscillator
at 600 Ω Error Max. input power . Limit programming S/N meter Measurement range Resolution Error Minimum input level Limit programming SINAD meter AF frequency meter Frequency range Error Limit programming Selective Call Decoder Transmitter measurements RF frequency meter Frequency range Input power range Accuracy Display Resolution Presolution Presolution Resolution Presolution .	5 mV (V _{in} <5 V), 50 mV (V _{in} >5 V) < \pm (5% + resolution) 5 W 4 digits, resolution 10 mV 6 to 46 dB 0.1 dB < \pm 1 dB 100 mV 2 digits, resolution 1 dB see options for transmitted pilot tones 20.0 to 999.9 Hz 0.1 Hz same as reference frequency rated frequency and offset in 1 Hz or 0.1 Hz (3 digits) see options 1 to 520 MHz 50 mW to 30 W (60 W with option) same as reference oscillator
at 600 Ω Error Max. input power Limit programming S/N meter Measurement range Resolution Error Minimum input level Limit programming SINAD meter AF frequency meter Frequency range Resolution Error Limit programming Selective Call Decoder Transmitter measurements RF frequency meter Frequency range Input power range Accuracy Besolution Internal resolution	5 mV (V _m <5 V), 50 mV (V _m >5 V) <± (5% + resolution) 5 W 4 digits, resolution 10 mV 6 to 46 dB 0.1 dB <±1 dB 100 mV 2 digits, resolution 1 dB see options for transmitted pilot tones 20.0 to 999.9 Hz 0.1 Hz same as reference frequency rated frequency and offset in 1 Hz or 0.1 Hz (3 digits) see options 1 to 520 MHz 50 mW to 30 W (60 W with option) same as reference oscillator 8 digits 10 Hz
at 600 Ω Error Max. input power . Limit programming S/N meter Measurement range Resolution Error Minimum input level Limit programming SINAD meter AF frequency meter Frequency range Error Limit programming Selective Call Decoder Transmitter measurements RF frequency meter Frequency range Input power range Accuracy Display Resolution Presolution Presolution Resolution Presolution .	5 mV (V _m <5 V), 50 mV (V _m >5 V) $<\pm$ (5% + resolution) 5 W 4 digits, resolution 10 mV 6 to 46 dB 0.1 dB $<\pm$ 1 dB 100 mV 2 digits, resolution 1 dB see options for transmitted pilot tones 20.0 to 999.9 Hz 0.1 Hz same as reference frequency rated frequency and offset in 1 Hz or 0.1 Hz (3 digits) see options 1 to 520 MHz 50 mW to 30 W (60 W with option) same as reference oscillator 8 digits 10 Hz

RF power meter

k

E

Frequency range	
nput power range	
Resolution at P ≦10 W 10 mW	
P >10 W 100 mW	
Error at P <100 mW, f \geq 20 MHz $<\pm$ (6% + resolution) + frequency	
response error	
f <20 MHz <= ± (10% + resolution) + frequency	
response error	
P >100 mW values as above, but typical	
Frequency response flatness	

RADIO TEST ASSEMBLIES 3

 10 to 520 MHz 100 mW to 30 W (60 W with option) 200 Hz to 40 kHz deviation 0 to 200 Hz deviation 2 Hz 20 Hz 200 Hz 50 Hz to 8 kHz
200 Hz to 40 kHz deviation 0 to 200 Hz deviation 2 Hz 20 Hz 200 Hz 50 Hz to 8 kHz
0 to 200 Hz deviation 2 Hz 20 Hz , 200 Hz 50 Hz to 8 kHz
0 to 200 Hz deviation 2 Hz 20 Hz , 200 Hz 50 Hz to 8 kHz
20 Hz 200 Hz 50 Hz to 8 kHz
50 Hz to 8 kHz
50 Hz to 8 kHz
$ < \pm (5\% + resolution) + residual FM$
3 digits, resolution 100 Hz
2 to 520 MHz
100 mW to 30 W (60 W with option)
0.1 to 95%
0.1% 100 Hz to 10 MHz
$<\pm$ (5% + resolution)
3 digits, resolution 0.1% rad
a 10 to 520 MHz
100 mW to 30 W (60 W with option)
0.002 to 10 rad
0.002 rad/0.02 rad
300 Hz to 3 kHz <± (5% + resolution)
<2%
3 digits, resolution 0.1 rad
1 kHz
1 kHz + 1 66 kHz
same as reference oscillator
0.1 mV to 1 V 0.1 mV
1 mV
$<\pm (2\% \pm 0.1 \text{ mV})$
50 Ω, balanced, floating
see options
a see options
V.24-/RS 232 C interface*) for pro-
gramming the SMAT via external control computer
Centronics interface*) for direct
printer connection for transferring and
logging of measured data
contains filter for distortion and
SINAD meters and 150-Hz notch filter
(can be changed) switchable into all AF test paths or 300-Hz high-pass
filter (link programmable)
1 kHz
100 mV ($Z_{out} = 4 \Omega$, 16 Ω, 100 kΩ) 500 mV ($Z_{out} = 600 \Omega$)
1 to 50%
. 0.1%
<±5% <±10%
2 digits, resolution 1%
1 kHz
6 to 46 dB
0.1 dB <±1 dB
2 digits, resolution 1 dB
150 Hz
150 Hz 40 dB for 150 Hz ±2%
40 dB for 150 Hz ±2%
40 dB for 150 Hz ±2% <±2% - typ. 40 dB
40 dB for 150 Hz ±2% <±2% typ. 40 dB typ. 50 dB
40 dB for 150 Hz ±2% <±2% - typ. 40 dB
40 dB for 150 Hz ±2% <±2% typ. 40 dB typ. 50 dB
40 dB for 150 Hz ±2% <±2% typ. 40 dB typ. 50 dB
40 dB for 150 Hz ±2% <±2% typ. 40 dB typ. 50 dB
40 dB for 150 Hz ±2% <±2% typ. 40 dB typ. 50 dB
40 dB for 150 Hz ±2% <±2% typ. 40 dB typ. 50 dB
40 dB for 150 Hz ±2% <±2% typ. 40 dB typ. 50 dB

*) Connector: 15-way Cannon female.

60-W Power Meter SMFP2B6	
Power range	20 mW to 60 W
Power-handling capacity	
Additional orrer	
Additional error	
3-dB rise of the power range limits of f	requency deviation meter, amplitude
modulation meter, phase deviation m	eter and HF frequency meter
AF Synthesizer/Selective Call	
Encoder CMED2D7	modulation source for transmitter and
Encoder SMPP2B7	
	receiver test and selective call en-
Francisco	coder (not for SSB applications)
Frequency range	10 HZ to 25 kHz
Resolution at f <1 kHz	
f <10 kHz	
f <25 kHz	
Frequency error	
Output voltage	0.1 mV to 1 V
Resolution at ≦100 mV	
>100 mV	
Error	<± (2% + 0.1 mV)
Minimum load impedance	
at ≦100 mV	$Z_L > 1 \Omega$
>100 mV	
Output impedance	approx: 1 Ω
Selective call encoder	
	tones 0 to 9 + repeat lone to CCIR
	and ZVEI
Number of single tones	1 to 7
Selective Call Decoder SMFS2B6	
Standard tone sequences	tones 0 to 9 + repeat tone to ZVEI
	and CCIR
Number of single tones	

General data

Rated temperature range	+5 to +45°C
Storage temperature range	
Mechanical resistance	shockproof to DIN 40046,
	Part 7 (30 g, 11 ms);
	vibration proof to DIN 40046,
	Part 8 (11 to 55 Hz, 2 g);
	corresponds to IEC Publ. 68-2-27
	and 68-2-6
Power supply: AC	115 to 125/220 to 235 V ±10%,
	47 to 420 Hz (125 VA)
battery	
Dimensions, weight	470 mm×206 mm×485 mm, 24 kg

Ordering information

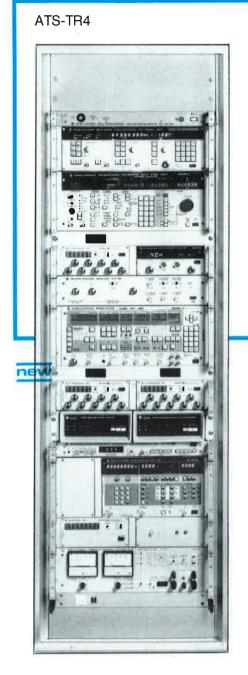
Order designation	Automatic RX/TX Tester SMAT 355.2014.52
Accessories supplied	50-Ω termination, adapter board, power cable, 1 connector for trans- ceiver (SMAT-Z1)
Options	
60-W Power Meter	SMAT-B6 355.3679.02 SMFP2B3 357.8610.02
Call Éncoder	SMFS2B7 ¹) 346.6810.02 SMFS2B6 ²) 346.7000.02
Recommended extras	
	SMAT-Z1 355.3710.00 SMFP-Z8 332.7890.02 PLIC 244.8000.10

344.8900 10 345.2011 04 359.5018 02 see page 286

Not for SSB applications.
 Only in conjunction with AF Synthesizer/Selective Call Encoder SMFS2B7.

3 RADIO TEST ASSEMBLIES

test assemblies



Increasing crowding of the radio bands requires ever higher quality of radio equipment, especially in regard of selectivity, sensitivity and large-signal behaviour.

Manual measurements in this field consume much time and tie up qualified personnel. Automatic test systems (ATS) solve simple as well as complex measurement tasks faster, more accurately, reliably and – in the long run – economically.

Automatic Radio Test System ATS-TR4 for measurements to CEPT TR17

- 30 to 500 MHz/0.4 to 520 (1000) MHz
- $\bullet\,$ Turnkey automatic test system for AM, FM, ϕM and SSB radio sets
- Made up of standard instruments controlled from process controller
- Simple operation through system software
- Acceptance-test program supplied as programming example



Automatic measurements to CEPT TR 17

Regulations. The CEPT RECOMMENDATION TR17 for stationary and land mobile radio transceivers used privately or in public services has been established, for example, in Europe with a view to unification of quality requirements and pertiment specifications. At the same time it aims at optimum utilization of the frequency band available.

Measurement ranges. The nominal area of application of CEPT TR17 covers FM und ϕM transceivers for radio services operating in the frequency range 30 to 500 MHz with channel spacings of 12.5 kHz, 20 kHz or 25 kHz. CEPTTR17 may, however, also be used as a basis for testing other radiotelephone systems, such as car radios and walkietalkies.

Automatic Radio Test System ATS-TR4

The **ATS-TR4** System here presented has been designed to perform the measurements specified in CEPT TR17 through optimum instrument configuration, easy-to-handle modular system software and cost-effective hardware integration.

Beyond the transceiver tests proposed in CEPT TR17 the ATS-TR 4 permits testing transceivers with other types of modulation (AM or SSB). Thanks to the modular structure the user can extend the system in hardware and software either on his own or with the assistance of R&S.

RADIO TEST ASSEMBLIES 3

System hardware

The Automatic Test System ATS-TR4 comprises the following units:

- 1 Mobile Tester
 SMFP 2

 transceiver test set;
 0.4 to 520 MHz

 central measuring instrument of system
- 2. Adjacent-channel Power Meter for spurious-response and oscillator-reradiation measurements
- 3. Signal Generator for use as LO and second signal generator of high spectral purity for all two-signal measurements
- 4. Programmable Power Supply for powering DUT

 Mixer Plug-in for selective measurements (BW 105 Hz) of S/N ratios and for sideband analysis

ment - P



A DESCRIPTION OF TAXABLE OF TAXABLE

Mixer Plug-in ATS-SM

Panalati be-

6. RF Attenuator for level matching to mixer input ATS-SM and NKS

DPSP 0 to 139 dB 1-dB steps

NKS

SMPC

25 to 950 MHz

NGPU 70/10

100 kHz to 1 GHz

70 V/10 A

ATS-SM

50 kHz to 1.36 GHz

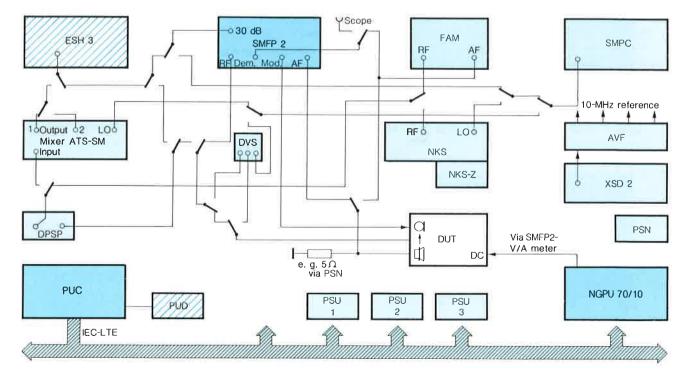
2		
7.	Power Splitter/Combiner for combining RF signals in two-signal measurements	DVS
8.	Video Distribution Amplifier for distribution of 10-MHz reference to all external reference inputs of the system	AVF
9.	RF Relay Matrix for computer-controlled switching of signal lines	PSU (3×)
10.	Relay Matrix for selection of load resistance for the receiver AF outputs	PSN
11.	Process Controller with IEC-bus Extender IEC-LTE for decoupling the IEC bus; RFI-proof	PUC 32 kbytes
12.	Printer	PUD 2
13.	10-MHz reference	XSD2+XSRM-Z ≦2×10 ^{−10} /month
14.	Test Receiver for selective level measurement with and without input mixer (ATS-SM) and for sideband analysis	ESH 3 9 kHz to 30 MHz

System description

with great operational ease

The configuration shown in the system block diagram represents the optimum CEPT test system in regard of operational convenience, measurement capability, accuracy and test rate.

The CEPT TR17 specifications can be fulfilled without the Test Receiver ESH 3. More complex software and longer measuring times may then compensate for the reduction in operational convenience and certain measurement limits are lowered.



System block diagram of Automatic Radio Test System ATS-TR4

CEPT-TR17 System ATS-TR4

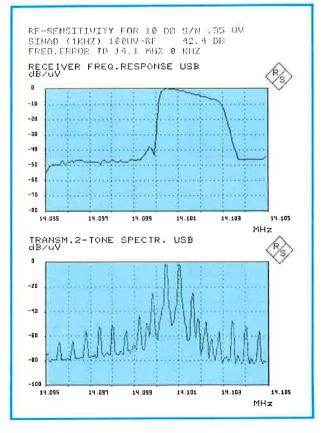
Spurious emissions per test frequency

Residual modulation

System software

The test routines specified by CEPT are listed below together with the reference numbers of the pertinent chapters of CEPT TR 17 recommendation.

CEPT test routines for FM and ϕ M transceivers	Ref. No.
General measurements	
Power supply	
Current	(3)
Voltage	
Transmitter measurements	
Frequency error of the transmitter	(4.1)
Carrier power	(4.2)
Frequency deviation per modulation frequency	(4.3)
Maximum deviation	
Modulation sensitivity per modulation frequency	
AF frequency response of the transmitter	
per modulation frequency	
Modulation distortion per modulation frequency	
Adjacent-channel power per channel	(4.4)



Test results: sensitivity measurement (top) and SSB two-tone measurement using Sideband Mixer Plug-in ATS-SM (bottom)

Receiver measurements

Output power of the receiver	
Distortion of AF signal per test frequency	
AF frequency response per test frequency	(5.2)
SINAD sensitivity	(5.1)
Co-channel rejection per test frequency	(5.3)
Adjacent-channel selectivity per channel	(5.4)
Spurious response per test frequency	(5.5)
Intermodulation rejection	(5.6)
Blocking per test frequency	(5.7)
Oscillator reradiation per test frequency	(5.8)
Limiting characteristic	
Receiver S/N ratio	
Squelch threshold	

Duplex measurements

(4.5/4.6)

Receiver sensitivity in duplex mode	(6.1)
Spurious response in duplex mode per test frequency	(6.2)

The system software for the Process Controller PUC is written as basic software which does the actual work for the user even when carrying out complex measurements, such as two-signal measurements or searching for spurious emissions. Customer-tailored test routines that are not expressly required by CEPT can be readily added to the available test routines within the scope of the system configuration. This is a decisive advantage with respect to later augmentation of the system to include SSB transceiver measurements in the HF and VHF/UHF ranges.

The software is handed over with complete source listing and documentation; the test routine for the acceptance test is included as an example. A selftest package for the system, consisting of software and cable set is available as an option.

System configuration

The standard model of Test System ATS-TR4 is accommodated in a castered 19" light-metal rack.

An EMI filter built into the rack keeps off interference coming from the AC supply line. Power distribution strips, earthing lines for the chassis and IEC-bus address labels for the integrated instruments are provided.

The signal cable set for the test system is made up of highquality double-shielded coaxial cable (RG 400) and lowreflection connectors, because simple shielding would be inadequate in two-signal measurements.

Other rack configurations are possible on request, for example use of two desktop racks or of a system front panel carrying all inputs and outputs.

Process Controller PUC and universal printer are placed on a castered table beside the test system. The DUTs may be positioned on a separate table beside the test system.

RADIO TEST ASSEMBLIES 3

System handover

Each test system is completely installed and tested in our works and is then available to the customer for 3 to 5 days for acceptance testing and system training.

R&S personnel installs the system on site and repeats the acceptance test performed at the factory. Our system specialists are available for consultation in the initial phase following the installation. Contracts for on-site maintenance are offered on request.

Other transceiver test systems

In addition to the Test System ATS-TR4 for measurements in accordance with CEPT TR 17 Rohde & Schwarz offers **three more automatic systems** for transceiver measurements; their measurement capabilities are designed to suit the requirements of authorities as well as of industry.

Test System ATS-TR1 consists of

- SMFP2
 – Mobile Tester with option as required

 NGPU
 – Programmable Power Supply for DUT

 PUC
 – Process Controller
- PUD 2 Universal Printer

Software package SMFP2-K1 for all single-signal measurements including selective-call and adjacent-channelpower measurements

Hardware integration in rack

Test System ATS-TR2

Measuring instruments as for ATS-TR1 plus

SMPC – Synthesizer Signal Generator as low-noise interference source for two-signal and duplex measurements, 50 kHz to 1360 MHz

Software package SMFP2-K1 with additional routines for all two-signal and duplex measurements

Hardware integration in castered rack or in two desktop racks

Test System ATS-TR3

Measuring instruments as for ATS-TR2 plus

- ATS-SM Sideband Mixer 1 MHz to 1 GHz
- DPSP Programmable Attenuator for signal attenuation ahead of ATS-SM
- PSU (2 off)- RF Relay Matrix for switching signal path

Software package SMFP2-K3 (as SMFP2-K2) with additional routines for spectrum analysis on transmitters and of oscillator reradiation in receivers – can be extended with special routines for sideband analysis of SSB transmitters.

Hardware integration. Castered rack or two desktop racks

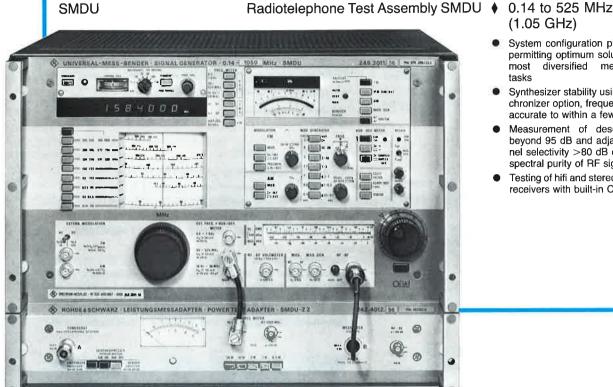
Condensed data of Test System ATS-TR4

Frequency range for useful signal . 0.4 to 520 MHz, up to 1000 MHz with option



BADIO TEST ASSEMBLIES З

test assemblies



(1.05 GHz)

- System configuration plus options permitting optimum solution of the diversified measurement most tasks
- Synthesizer stability using the synchronizer option, frequency setting accurate to within a few hertz
- Measurement of desensitization beyond 95 dB and adjacent-channel selectivity >80 dB due to high spectral purity of RF signal
- Testing of hifi and stereo broadcast receivers with built-in CB radio

The Radiotelephone Test Assembly SMDU is a test system of highest precision which contains all measuring instruments necessary for standard checkout of radiotelephone equipment and meets or even exceeds the requirements of national and international specifications.

This advanced test assembly combines precise measurement techniques with great operating convenience (e.g. automatically tuned deviation meter, channel-to-channel stepping, autoranging facility). The SMDU test setup complies with the most severe stipulations for transceiver measurements, which so far have been met only by specialized instruments.

Applications

The comprehensive instrumentation permits a standard solution to be found for all transceiver measurement tasks. The SMDU test assembly can be used to advantage in laboratories, servicing shops and production plants.

In servicing the great operating convenience of the Radiotelephone Test Assembly considerably reduces the time required for routine measurements.

For public services and in development laboratories, the high accuracy of the SMDU test assembly permits reliable conclusions in type-approval testing.

In test and production departments, the SMDU can be used to advantage for batch measurements thanks to its semi-automatic operation and the possibility of connecting recording equipment. When determining parameters which are difficult to measure, the Test Assembly is superior to any fully automatic test system, especially in regard to spectral purity.

Configuration

The heart of the Test Assembly is the radiotelephone version of the SMDU (06, 07 or 09); this basic setup is suitable for all measurements up to 1 GHz.

To obtain a complete test assembly, the following equipment is required:

- a) Power Test Adapter SMDU-Z2 or
- b) AM Unit SMDU-Z1 (power meter and modulation depth meter); see under specifications.

Thus the following configurations are possible (also available as compact asemblies in common cabinets):

Signal Generator SMDU with

RF generator, 140 kHz to 525 MHz (expandable up to 1.05 GHz), FM and AM, automatic overvoltage protection in the case of accidental transmitter keying AF generator, 30 Hz to 30 kHz frequency meter, 15 Hz to 525 MHz (1 GHz) AF voltmeter, 1 mV to 10 V (rms weighting) distortion meter, 1 to 100% fsd SINAD*) ratio meter, 6 to 46 dB psophometric weighting filter (in accordance with CCITT)

Power Test Adapter SMDU-Z2 (30 W) with RF relay switching panel; possibility of connecting analyzer and recording equipment - or

AM Unit SMDU-Z1 (30/60 W) with the same facilities as the power test adapter plus modulation depth meter and automatic mode selection (TX/RX)

For options, e.g. for frequency range extension or for frequency synchronization, see page 106.

^{*)} SINAD: signal + noise + distortion to noise + distortion.

RADIO TEST ASSEMBLIES 3

Functions (for receiver and transmitter measurements see page after next)

Signal Generator SMDU

The free-running SMDU oscillator covers the range from 140 kHz to 525 MHz. The oscillator stability is such that any measurement can be started only five minutes after switching on the Test Assembly.

The **1.05-GHz Frequency Range Extension and the 1.05-GHz Frequency Doubler options** double the range of the SMDU, its excellent characteristics being maintained. With the doubler, subharmonics are down 20 dB.

The **Synchronizer option** provides for synthesizer stability without affecting the spectral purity of the signal. In addition, this unit permits frequency settings corresponding to the standard channel spacings of the different radio services between 12.5 and 150 kHz as well as continuous fine tuning to any frequency.

The frequency meter for 30 Hz to 525 MHz has a resolution of 1 Hz below 50 MHz and 10 Hz above 50 MHz. An input amplifier provides a sensitivity of 10 mV, thereby making possible measurements of frequency and frequency deviation even with cables of up to about 50 m. The **option SMDU-B 4** extends the measurement range up to 1 GHz.

The modulation unit included in the SMDU meets the most stringent requirements so that, for instance in receiver measurements with AM and FM, the inherent distortion is negligible (e.g. model 09: 0.2% for 75 kHz deviation; stereo crosstalk down 46 dB).

With the Amplitude Modulation 525 to 1050 MHz option, AM is possible in this frequency range with a modulation depth of about 95% and with constant characteristics even if the SMDU is operated with the Frequency Range Extension or the Frequency Doubler option.

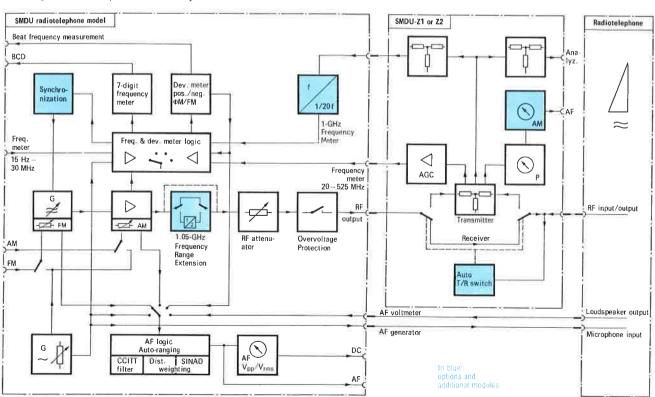
The modulation generator delivers six fixed frequencies between 0.3 and 6 kHz or any other modulation frequency which can be set at will between 30 Hz and 30 kHz (the set frequency is indicated on the seven-digit frequency meter, accurate to within 1 Hz). The AF output voltage, which can be continuously adjusted between 1 mV and 5 V, is read from the multimeter which is incorporated in the modulation unit and can be set for mV, kHz or % indication.

The AF voltmeter (30 Hz to 150 kHz, 1 mV to 10 V), which uses a true rms-responding detector, automatically switches to the correct subrange (out of a total of seven). The bandwidth of the voltmeter can be limited by connecting the psophometric CCITT filter.

The 1-kHz distortion meter (0.5 to 50%) with its autoranging facility can be used in conjunction with the AF voltmeter or the deviation meter. An LED lights up if the test level falls short of the required value.

The SINAD ratio meter (6 to 46 dB) measures the ratio of the total signal to the noise and distortion components. The standard SINAD value (6, 12 or 20 dB) of the corresponding measurement range is marked by LEDs on the scale of the meter.

Continued (deviation meter, power meter) >



Block diagram of Radiotelephone Test Assembly SMDU

SMDU Functions (continued)

Signal Generator SMDU

The deviation meter measures spurious FM between 10 and 300 Hz (rms weighting) and wanted deviations between 300 Hz and 100 kHz (peak weighting). Separate indication of positive or negative deviation is possible; an LED indicates that the deviation meter is ready for operation (counterdisplay resolution 1 Hz: the CCITT weighting filter or 1-kHz distortion meter can be connected.)

In the simplex mode the deviation meter operates on the receive frequency set on the signal generator whereas it tunes automatically to a spacing of between 4.2 and 10 MHz from the latter in the duplex mode.

Thus the deviation meter need not be retuned after channel changeover on multichannel equipment. It is also suitable for measurements on transceivers in relay operation. This saves another deviation meter and a separate tuning operation which would otherwise be required.

SMDU options and conversion kits

Synchronizer SMDU-B1

Standard equipment in the Radiotelephone Test Assembly, improves the long-term stability to that of a synthesizer. Simplifies operation by channel-stepping facility; electronic fine tuning.

Overload Protection SMDU-B2

Standard equipment in the Radiotelephone Test Assembly, protects the RF output against externally applied power of up to 50 W.

- 1.05-GHz Frequency Range Extension SMDU-B3 Extends the RF-generator range to 1.05 GHz without sacrificing performance characteristics.
- SMDU-B4 **1-GHz Frequency Meter**

Extends the range of the counter to 1 GHz for external signals.

SMDU-B5 1.05-GHz Frequency Doubler

Low-cost option for doubling the frequency range. Subharmonics and harmonics are at least 20 dB below the carrier level.

Amplitude Modulation 525 to 1050 MHz SMDU-B8 Incorporated in new deliveries of SMDU + Frequency Range Extension; allows amplitude modulation of the carrier up to 1050 MHz.

SMDU-B9 S/N-ratio Improvement Improves the S/N ratio, permitting, for example, adjacent-channel selectivity of more than 80 dB to be measured.

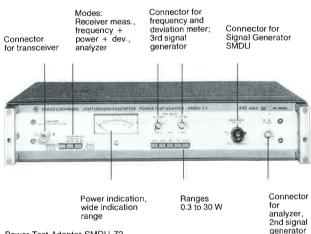
Call Acknowledgement Conversion Kit SMDU-U3 Enables measurements on transceivers that send an acknowledgement signal.

Power Test Adapter and AM Unit

These two instruments, which are both optional, permit connection and adaptation of the transceiver to the test assembly and to additional signal generators (if, for instance, the multisignal method is used) or an analyzer. They can also be used for switchover between receiver and transmitter measurements.

Power Test Adapter SMDU-Z2 (1 to 1050 MHz)

The SMDU-Z2 contains a relay switching panel and power attenuators. It distributes the RF signal to the frequency and deviation meters, the power meter and to different test outputs (e.g. for analyzer measurements).

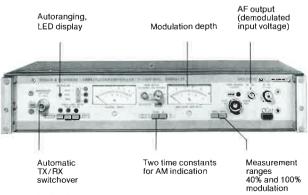


Power Test Adapter SMDU-Z2

AM Unit SMDU-Z1 (1 to 1050 MHz)

Compared with the Power Test Adapter, the more convenient SMDU-Z1 includes an additional modulation depth meter with ranges of 40 and 100%. If powers of ≧100 mW are applied, the SMDU-Z1 automatically switches over to transmitter measurement and selects the correct power measurement range.

The AM Unit comes as 30-W and 60-W models.



test assemblies

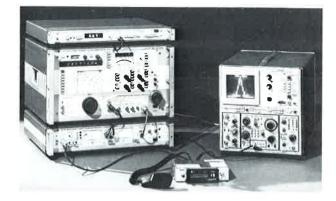
RADIO TEST ASSEMBLIES 3

Operating convenience and versatility

Setting the Radio Telephone Test Assembly for receiver and transmitter measurements requires only very little time:

- 1. RF: The RF end of the radio is connected to the Power Test Adaper or AM Unit.
- AF: a) The mike input is taken to the SMDU modulation generator output and b) the loudspeaker output is connected to the AF voltmeter input.

The measuring instruments are connected via the internal switching panels; thus all measurements can be performed without changing any connections.



Test setup comprising Adjacent-channel Power Meter NKS, Signal Generator SMDU 06 and AM Unit SMDU-Z1

Receiver measurements

After setting the test frequency, modulation type and frequency on the SMDU, the AF voltmeter indicates the voltage at the receiver output or the distortion for a modulation frequency of 1 kHz.

Receiver sensitivity. Convenient measurement is possible using one of the two conventional methods:

S/N ratio of 20 dB

SINAD ratio using the SINAD ratio meter for 6, 12 or 20 dB

Bandwidth. A marker for a 6-dB level difference (EMF and V_{out} cursor lines) on the attenuator simplifies the measurement. Digital display of the cutoff frequencies is provided.

The **squelch threshold** and the limiter action at the AF output of the receiver are determined using the attenuator and the AF voltmeter; the single-range attenuator permits rapid continuous level adjustment without reversal of direction (problemfree determination of hysteresis).

Effects of interfering transmitters, such as intermodulation, adjacent-channel modulation, desensitization or reradiation from closeby receivers, can be measured with great accuracy due to the excellent spectral purity of the generator signal (S/N ratio at 20 kHz from carrier >135 dB, 1 Hz).

Extension of test assembly

The Radiotelephone Test Assembly SMDU incorporates all the instruments required for normal servicing; see also block diagram on page 105.

In practical situations, the investigation of poor radio communications involves further measurements for checking the interference-determining items of the equipment specifications. Consideration must also be given to the possibility that working conditions alone are responsible for disturbed communication. For example, an important parameter such as **adjacent-channel selectivity** can only be measured using a two-source technique. It is therefore advantageous that test assemblies, even when used only for servicing, may be easily extended.

Thanks to the direct connections for a second signal generator and an analyzer, extension of the SMDU Radiotelephone Test Assembly is very straightforward.

Transmitter measurements (brief overview)

Parameter:	Special features:
Frequency tolerance	Immediate indication on frequency meter
Power	Simultaneous indication of power, freqeuncy and deviation
Frequency deviation	Semi-automatic tuning
Deviation limiting	Use of maximum permissible devia- tion thanks to narrow tolerances
Harmonic distortion	Direct indication at 1 kHz
Calling frequency	Resolution 1 Hz
Modulation depht (using SMDU-Z1)	Power and frequency at the same time
Harmonic distortion	Indication of frequency and distortion
Limiting	With and without weighting
Out-of-band radiation	Direct connection of analyzer
Relay operation	In-service measurement possible without auxiliary oscillators

Adjacent-channel power

For assessment of the modulation sidebands or excessive noise components emitted by the transmitter section of a transceiver, the postal authorities have now introduced the definition of adjacent-channel power. Two methods have been specified: a) Analyzer method, b) method with power test receiver.

The Adjacent-channel Power Meter NKS from Rohde & Schwarz works on method b); see pages 108 and 115.

Measurement of adjacent-channel power involves nothing more than selection of the desired channel spacing (10, 12.5, 20 or 25 kHz) and the upper or lower adjacent channel. An automatic test program determines the power of the transmitter signal and of the interference and provides digital indication of the ratio of unwanted to carrier signal in dB in compliance with the specifications. The absolute power content of the interfering signal is calculated from the carrierpower indication on the SMDU-Z1 or -Z2 and the ratio shown on the NKS.

3 RADIO TEST ASSEMBLIES

test assemblies

Extension of SMDU Test Assembly with Adjacent-channel Power Meter NKS

- Power test receiver for 25 to 950 MHz in line with standard specifications
- Measurement of all transceiver characteristics including adjacent-channel power
- Selective measurement of spurious signals



Adjacent-channel Power Meter NKS

Full description on page 115

Due to overcrowding of the radiotelephone bands, the postal authorities have introduced the definition of adjacent-channel power to ensure better-quality communications.

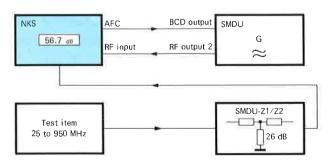
Adjacent-channel power refers to the spectral components present in the adjacent channels of a transmitter; it may be due to ineffective deviation limiting or to modulation distortion in FM transmitters or, with AM, to overmodulation, limiting or harmonic distortion in the event of overdriving.

To extend the SMDU Radiotelephone Test Assembly for the rational and accurate measurement of adjacent-channel power, Rohde & Schwarz offers the

Adjacent-channel Power Meter NKS

The power-test-receiver technique used in the NKS allows the determination of the carrier and adjacent-channel powers by means of an rms-responding rectifier. Thus all signals can be evaluated, the total power in the adjacent channel being measured continuously. The NKS fully complies with the relevant specifications for power test receivers.

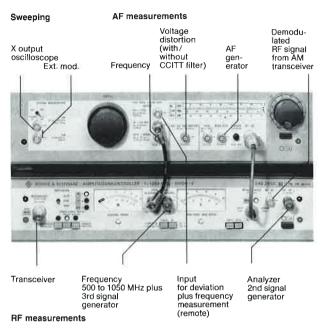
Configuration of test assembly. In conjunction with the SMDU Radiotelephone Test Assembly the Adjacent-channel Power Meter measures the interference in the adjacent channel and indicates the ratio of carrier power to unwanted power in three digits; see block diagram below. Only the desired channel spacing (10/12.5/20/25 kHz) and the upper or lower channel need be selected prior to measurement. Measurement range 0 to 89.9 dB; accuracy \pm 0.5 dB.



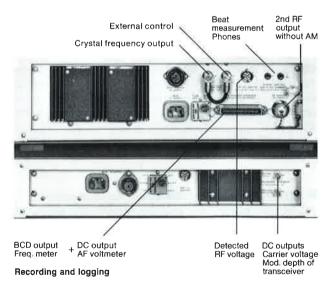
NKS in conjunction with Radiotelephone Test Assembly SMDU

Connectors

SMDU front panel



SMDU rear panel



test assemblies

RADIO TEST ASSEMBLIES 3

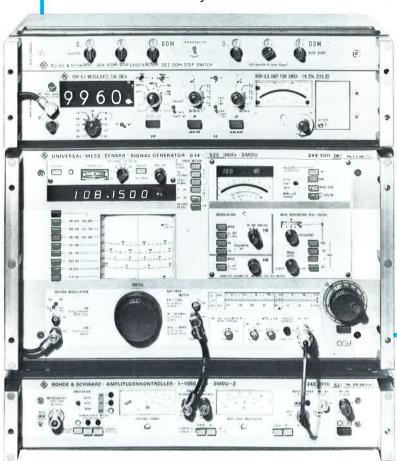
Specifications			
Frequency range	. 0.14 to 525	MHz;	
Setting, indication	0.14 to 105	0 MHz using S ale, 7-digit rea	MDU-B3 or B5
Scale resolution	(crystal 10	MHz, aging 5	× 10 ⁻⁸ /month)
	up to 800 M	/Hz: 10 or 100) Hz
Fine tuning using synchronizer of	above 800	MHz: 0.1 or 1	Kriz
Steps corresponding to channel spacing	12.5/20/25	/50/100/150	kHz
Tuning range Frequency Instability after warm	. 20 to 160 k up	Hz	
Free-running oscillator	. <1.5 to <6	+ 10 Hz (for f	to 1050 MHz ≧525 MHz)
Spectral purity Spurious frequencies			
S/N ratio at 20 kHz from	50 MHz and	d 392 to 525 N	IHz)
carrier, test band 1 Hz			
Spurious AM with FM		bove 525 MHz	, ,
at f _{mod} = 1 kHz	. <1%, typ. (for f >1 M	0.5% with 100 Hz)	kHz deviation
with SMDU-B9	. <3%, typ. 1 with 100 kH	% (for f >20 f z deviation	MHz)
RF output I			
Output EMF and power	connector -	adaptabla	-13 dBm
Frequency response, attenuator error			10 UDIT
VSWR			
RF overvoltage protection Max. permissible condition	 automatical 50 W or 50 	ly disconnects V DC	RF outputs
AF generator and modulation	unit plus me	asuring instru	Iments
Modulation frequencies Fixed			
Continuous	0.03 to 30 l	KHz	
Output voltage	1 mV to 5 \ <0.5% for	/ into 200 Ω 100 Hz to 10 k	Hz
Type of modulation			
(internal and external) Modulation range Modulation distortion	0 to 98%	0 to 100 kHz	0 to 100 rad
Measurement ranges	80% mod.	f _{max} 20 kHz	f _{max} 6 kHz
Measurement ranges	100%	30/100 kHz	30/100 rad
Modulation distortion	. <0.2% at 7	5 kHz deviatio	n
Stereo crosstalk	in the FM b >40 dB dow	roadcast range vn at 50 Hz	S
	>46 dB dov	vn at 1 kHz an	d 15 kHz
Frequency meter/with option	15 Hz to 30 MHz	20 to 525 MHz	0.5 to 1 GHz
Frequency meter/with option	10 mV 1/10 Hz	10 mV 10/100 Hz	30 mV
Deviation meter			
Measurement ranges	and phase of	leviation	equency
	300 Hz to 1/	z (rms weightir 00 kHz (peak v	ng) weighting)
Symmetry error			
AF voltmeter	+ (3% of rd	a +1.5% of fso	kHz d)
Detector/weighting filter	rms-respond	ling/CCITT	
Distortion meter	0.5 to 30% 80 mV to 3	(50%), 1 kHz V/1 to 40 kHz	
Error limits	± (10% of r	dg +1.5% of fs	sd) + 0.3%
SINAD ratio meter	6 to 46 dB,	80 mV to 3 V	- 4)
CCITT filter			
00111 liller	specification	s, usable with	
		eter and AF vo	ltmeter
Power Test Adapter			
AM Unit TX/RX switchover	manual	SMDU- automa	Z1 tic above
Frequency range		0.1 W	50 MHz
Power measurement range	50 mW to 30	0 W 50 mW	to 30 W or
Modulation depth meter	-	0 to 40	V to 60 W /0 to 100%
RF output	multisignal n	neasurements;	
		nput/output 30	
	(

High-power attenuator Attenuation RX/TX measurement with SMDU-Z1/30 W and SMDU-Z2 with SMDU-Z1/60 W.	0+0.6 dB/20±1.3 dB
RF connector (analyzer, multisignal	measurement)
Input/output attenuator/VSWR	30 ±0.8 dB/1.3
Adjacent-channel Power Meter (de Frequency range	20 to 950 MHz
RF input LO input Adjchannel power measurement	50 to 200 mV
	12.5 kHz 20 kHz
Measurement range (signal/ interference power)	25 kHz
Weighting Error limits	rms value ±1 dB
General data	o algito
Atted temperature range	-40 to +70°C
	47 to 420 Hz (100 to 120 VA depending on
Dimensions and weight of	configuration)
complete test assembly	492 mm×401 mm×436 mm, 37 kg
Ordering information	
Order designation	Radiotelephone Test Assembly
	SMDU
Single Instruments for combinatio	n as test assembly Order No.
Signal Generator SMDU Radiotelephone model Radiotelephone model	249.3011.06 or
stereo-compatible	249.3011.09 or
Radiotelephone- navigation model Power Test Adapter	249.3011.07
SMDU-Z2	242.4012.52 or
SMDU-Z1/30 W	242.2010.52 or 242.2010.53
Compact test assemblies based or	
SMDU 52 with SMDU-B1 option and	
AM Unit SMDU-Z1/30 W . SMDU 53 with SMDU-Z1/60 W	249.3011.52
SMDU-21/00 W SMDU 56 with Power Test Adapter SMDU-Z2	249.3011.53
instead of SMDU-Z1	
Accessories supplied	249.3011.56
Accessories supplied	power cable, 1 BNC-BNC connecting
	power cable,
Recommended extras Adjacent-channel Power Meter	power cable, 1 BNC-BNC connecting cable (for SMDU-Z1, -Z2)
Recommended extras Adjacent-channel Power Meter NKS	power cable, 1 BNC-BNC connecting
Recommended extras Adjacent-channel Power Meter NKS Options (description on page 106)	power cable, 1 BNC-BNC connecting cable (for SMDU-Z1, -Z2) 302.2410.02
Recommended extras Adjacent-channel Power Meter NKS Options (description on page 106) SMDU-B1: Synchronizer (standard equipment in test assembly)	power cable, 1 BNC-BNC connecting cable (for SMDU-Z1, -Z2)
Recommended extras Adjacent-channel Power Meter NKS Options (description on page 106) SMDU-B1: Synchronizer (standard equipment in test assembly) SMDU-B3: 1.05-GHz Frequency Range Extension	power cable, 1 BNC-BNC connecting cable (for SMDU-Z1, -Z2) 302.2410.02
Recommended extras Adjacent-channel Power Meter NKS Options (description on page 106) SMDU-B1: Synchronizer (standard equipment in test assembly) SMDU-B3: 1.05-GHz Frequency	power cable, 1 BNC-BNC connecting cable (for SMDU-Z1, -Z2) 302.2410.02 249.6340.02
Recommended extras Adjacent-channel Power Meter NKS Options (description on page 106) SMDU-B1: Synchronizer (standard equipment in test assembly) SMDU-B3: 1.05-GHz Frequency Range Extension SMDU-B4: 1-GHz Frequency Meter SMDU-B5: 1.05-GHz	power cable, 1 BNC-BNC connecting cable (for SMDU-Z1, -Z2) 302.2410.02 249.6340.02 249.9484.02
Recommended extras Adjacent-channel Power Meter NKS Options (description on page 106) SMDU-B1: Synchronizer (standard equipment in test assembly) SMDU-B3: 1.05-GHz Frequency Range Extension SMDU-B4: 1-GHz Frequency Meter	power cable, 1 BNC-BNC connecting cable (for SMDU-Z1, -Z2) 302.2410.02 249.6340.02 249.9484.02 250.0012.02
Recommended extras Adjacent-channel Power Meter NKS Options (description on page 106) SMDU-B1: Synchronizer (standard equipment in test assembly) SMDU-B3: 1.05-GHz Frequency Range Extension SMDU-B4: 1-GHz Frequency Meter SMDU-B5: 1.05-GHz Frequency Doubler SMDU-B6: Amplitude Modulation	power cable, 1 BNC-BNC connecting cable (for SMDU-Z1, -Z2) 302.2410.02 249.6340.02 249.9484.02 250.0012.02 275.1312.02
Recommended extras Adjacent-channel Power Meter NKS Options (description on page 106) SMDU-B1: Synchronizer (standard equipment in test assembly) SMDU-B3: 1.05-GHz Frequency Range Extension SMDU-B4: 1-GHz Frequency Meter SMDU-B5: 1.05-GHz Frequency Doubler SMDU-B5: Amplitude Modulation 525 to 1050 MHz SMDU-B9: S/N Ratio	power cable, 1 BNC-BNC connecting cable (for SMDU-Z1, -Z2) 302.2410.02 249.6340.02 249.9484.02 250.0012.02 275.1312.02 295.2150.02

3 VOR/ILS TEST ASSEMBLIES

test assemblies

VOR/ILS Test Assembly



Test Assembly for Airborne VOR/ILS and Communication Equipment

♦ 0.14 to 1050 MHz

Complete test system from a single manufacturer; guaranteed data for system as a whole:

- Signal Generator SMDU in several models, with spuria-free and lownoise output, featuring excellent modulation characteristics
- VOR/ILS Unit with modulation generator, phase, modulation-depth and DDM meter as well as self-check for VOR/ILS output signals
- AM Unit with output-power meter, modulation-depth meter and automatic TX/ RX switchover

Variants and options optimally combinable for all applications

The test assembly can be used for the development, production and servicing of airborne communication and VOR/ILS*) air navigation equipment. It offers highest reliability due to the built-in self-testing facility and thanks to the available instruments for absolute measurement of the VOR zero phase (see page 114). Thus it enables the user to strictly observe the relevant test specifications for VOR/ILS and communication equipment (e.g. ARINC 578 and 579).

The system concept allows the user to check the measurement accuracy in a simple way, which can normally be done only by the manufacturer, and thus meets the requirement of all institutions responsible for the safety of air traffic.

Moreover, the test assembly features a very favourable price/performance ratio since it is part of a modular system within the general measuring-instrument line.

The basic equipment, consisting of

Signal Generator SMDU (page 66), VOR/ILS Unit and AM Unit,

can be varied with respect to the signal generator used (see ordering information). The SMDU navigation model (08) is preferred for the VOR/ILS Test Assembly whereas the SMDU radiotelephone & navigation model (07) contains in addition all measuring instruments required for FM transceivers, permitting, for instance, determination of deviation, distortion and SINAD ratio. Several **options** are available; they can be incorporated in the signal generators upon delivery or added later without any adjustment.

Synchronizer SMDU-B1. This module improves the SMDU frequency stability to that of a synthesizer while maintaining its high spectral purity. Operation is greatly simplified thanks to the channel-to-channel stepping at the spacings 50, 100 and 150 kHz used by VOR/ILS services and to synchronized fine tuning with extremely high resolution.

1.05-GHz Frequency Range Extension SMDU-B3. This doubles the RF generator range of the SMDU while maintaining its excellent characteristics.

1-GHz Frequency Meter SMDU-B4. This module is required for external frequency measurements above 525 MHz. The overall range of the seven-digit frequency meter is then 15 Hz to 1 GHz with a resolution of 10 Hz at 1 GHz.

Overload Proteciton SMDU-B2. This module protects the RF attenuator and the output stage against inadvertent application of RF or DC voltages. This option is fitted as standard in the radiotelephone & navigation model.

^{*)} VOR: VHF Omnidirectional Range. A radio-navigation method employing phase comparison of two 30-Hz signals.

ILS: Instrument Landing System (blind approach) with azimuth and glidepath links, providing a line of intersection between two directional lobes at a 90-Hz and a 150-Hz amplitude-modulated carrier frequency.

test assemblies

The VOR/ILS Unit, which produces all signals required for VOR/ILS measurements and checks those provided by the signal generator, is available with and without decade DDM step switch. In conjunction with this switch, an extremely fine adjustment of all DDM values in steps of 0.001 is possible, permitting precise linearity measurements on ILS systems (category III).

Another variation is possible using the AM Unit which measures power and modulation depth and permits automatic switchover between transmitter and receiver measurements. If only FM transceivers are to be checked out, the simpler and less expensive Power Test Adapter SMDU-Z2 can be used.

Calibration instruments

VOR Zero-phase Meter POR with 0.01° resolution in the most sensitive range (see page 114)

Modes, modulation signals, indications

VOR/ILS TEST ASSEMBLIES 3

Characteristics of the test assembly for navigation measurements and modulation

- Suitable for all VOR and ILS test programs according to RTCA and ARINC
- VOR phase adjustable in steps and continuously from 0 to 360°
- Phase-angle indication in four digits and by indicator lamp with an accuracy of 0.05°
- DDM values separately adjustable for localizer and glide slope in standard steps of 0.001 DDM and continuously
- Expanded range for measurements around zero DDM; discrimination 0.001/scale division
- Modulation signal generation for measurements on marker receivers, radiotelephone systems and AF sections of VOR/ILS receivers (with signal tracing)
- Self-testing facility for the modulation characteristics, for modulation generator and monitor

Mode	Signal	Simullaneous checks M: meter Light C: counter signal (range)	Signal modification *) "On" signalled by flashing lamps
VOR	30 Hz (variable phase) 9960 Hz (CW) 9960 Hz freq. mod. with 30 Hz (480 Hz deviation) VOR signal Phase setting: 30° steps and continuous; 180° switch VOR sig. + communication sig. 1020 Hz	$ \begin{array}{c c} \mbox{M: } \ensuremath{\%}\ensuremath{\phi}\ensurema$	 *) 30 Hz with freq. variation by ±0.5% and ±1.5% steps *) ±25% amplitude variation of 30-Hz and 9960-Hz com- ponents Ext. AM (0 to 10 kHz, up to 80%) of mod. 9960-Hz subcarrier (interference simulation DVOR) Ext. AM (0 to 10 kHz, up to 80%) for complete VOR signal Addition of external interference signals Fine modulation-depth adjustment
ILS Localizer	$\begin{array}{c} 90 \text{ Hz} \\ 150 \text{ Hz} \end{array} \hspace{0.2cm} \text{for left/right} \\ \hline \\ \hline \\ \text{In steps: Points} DDM dB \\ \hline \\ 0 0 0 \\ \hline \\ 1.5 0.0465 2.0 \\ 3 0.093 4.0 \\ 5 0.155 6.57 \\ 10 0.310 12.39 \\ \hline \\ \text{Cont.} 0 \text{ to } 12.9 0 \text{ to } 0.4 \\ \hline \\ \text{With Decade DDM Step Switch:} \\ \text{in steps of } 0.001 \text{ from} \\ 0.000 \text{ to } 0.400 \text{ DDM} \end{array}$	M: % dev. from 20 % mod. ∆ mod. 5 % M: DDM DDM 0.02 M: DDM DDM 0.2 M: DDM DDM 0.2	 *) 90 Hz and 150 Hz with freq. variation by ±0.5% and ±1.5% steps *) Phase relation of components switchable: - 12/0/+12° (referred to 30 Hz) One component cut off (90 Hz or 150 Hz) Left/right switching (in localizer
ILS Glide slope	$ \begin{array}{c} 90 \text{ Hz} \\ 150 \text{ Hz} \end{array} \ \ \text{for up/down} \\ \hline \\ \mbox{In steps: Points} \ \ \ \ \ \ \ \ \ \ \ \ \$	M: % dev. from 40 % mod. 5 % M: DDM DDM 0.02 M: DDM DDM 0.2 M: DDM DDM 0.2	node) Up/down switching (in localizer slope mode) Addition of external interference signals Fine modulation-depth adjustment
Marker signal/ communication	All modulation frequencies continuously adjustable	Indication on modulation unit of signal generator	

3 VOR/ILS TEST ASSEMBLIES

test assemblies

Test Assembly for Airborne VOR/ILS and Communication Equipment (cont'd from page 111)



VOR/ILS Unit with Decade DDM Step Switch

Measurements on air-navigation receivers

For testing VOR/ILS receivers, the RF carrier of the Signal Generator SMDU is amplitude-modulated with the signals which have been processed in the VOR/ILS Unit.

VOR signals

Two 30-Hz signals of mutually variable phase are produced in the generator section of the VOR/ILS Unit – reference signal (30 Hz) frequency-modulated upon 9960-Hz carrier.

Possibilities of setting the phase: 30° steps, continuously variable by $>30^{\circ}$ and phase reversal (180°). The phase shift of the AF signals demodulated from the RF carrier is indicated by four numerical indicator tubes providing for a resolution of 0.03°. Controls are provided for adjusting the generation and output of the individual components allowing simultaneous measurement of the modulation depth, its variation or that of the components of the VOR signal as well as percentage variation of the modulation frequencies according to the requirements of standard specifications. Built-in modulators and adder inputs are provided for the simulation of interference.

ILS signals

The 90-Hz and 150-Hz ILS signals are derived in rigid phase relation from a 1800-Hz squareware signal (see block diagram showing signal processing) by the action of a frequency divider and a wave converter.

The various depths of modulation are automatically set by switching the modes of operation between "localizer" or "glide slope". Standard DDM values can be set in each mode, intermediate values in position "continuous".

The Decade DDM Step Switch permits accurate adjustment of DDM values in steps of 0.001, the sum of the modulation depths of the signals remaining constant.

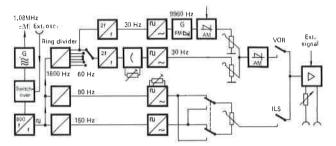
Separate controls are provided for blanking the individual components, for phase shift and changing the components in compliance with the requirements of the standard specifications.

According to the mode of operation selected, a meter displays either the modulation depth Δ mod. (0.2% per scale division, 5% fsd), the DDM zero (0.001 per scale division, 0.02 fsd) or the DDM values adjusted (0.01 per scale division, 0.2 fsd) of the demodulated RF signal.

The VOR/ILS Unit is equipped with a self-testing facility for checking its essential subassemblies.

Modulation signal processing

All modulation signals are derived from an oscillator which can be varied by $\pm 0.5\%$ and $\pm 1.5\%$. The VOR signals (30-Hz reference and 30-Hz variable-phase) and the ILS signals of 90 Hz and 150 Hz are provided by separate frequency dividers.



Generator section of the VOR/ILS Unit; processing of modulation signals

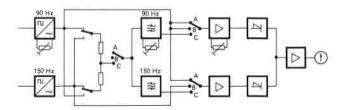
After conversion from squarewave to sinewave shape, the 30-Hz reference signal modulates the frequency of a 9960-Hz oscillator, while the variable signal is added to the reference signal after the squarewave-to-sinewave conversion.

The digitally processed 90-Hz and 150-Hz signals are also taken through a squarewave/sinewave converter and are added in resistive network after the DDM divider. An output amplifier provides the appropriate signal level for the SMDU, the other AF output (continuous) is for general AF measurements.

Self-testing facility of the VOR/ILS Unit

By means of the built-in self-testing facility, the VOR/ILS Unit can be adjusted exactly to the rectified voltage of the signal generator (SMDU) and the measuring systems as well as their error limits checked.

The VOR phase meter is checked by connecting it to a point of zero reference phase in the generator section and adjusted, if required. The free-running 1.08-MHz signal can be compared with a 1.08-MHz crystal-oscillator frequency and subsequently adjusted.



Self-testing facility of the VOR/ILS Unit (ILS section)

test assemblies

VOR/ILS TEST ASSEMBLIES 3

The ILS signals can be adjusted as follows. In switch position A, the same signal is applied to both measuring channels to ensure identical gain setting. In position B, the 90-Hz and the 150-Hz signals are separately applied to the measuring channels and their amplitudes adjusted with respect to each other (to DDM zero). In position C, the insertion loss in the measuring paths can be checked and the differences compensated for.

Specifications		
Frequency range		
Setting, indication	on drum soalo. 7	Iz using option SMDU-B3 7-digit readout
Scale resolution	(crystal 10 MHz, up to 50 MHz: 1	aging 5×10 ⁻⁸ /month) or 10 Hz
	above 800 MHz:	10 or 100 Hz
Fine tuning using synchronize Steps corresponding to	er option	
channel spacing	. 12.5/20/25/50/	100/150 kHz
Frequency instability after wa	rmup	
Free-running oscillator Using synchronizer	<5×10 ⁻⁸ (+10	for 0.14 to 1050 MHz Hz for f ≧525 MHz)
Spectral purity Spurious frequencies	down >110 dB (>90 dB for
S/N ratio at 20 kHz from	0.14 to 50 MHz a	and 392 to 525 MHz)
carrier, test band 1 Hz		dB below 50, 525 MHz)
Spurious AM	down >80 dB	
RF output I	connector adapt	abla
Output EMF and power	connector, adapt 0.05 μ V to 2 V =	-139 to +13 dBm
Frequency response, attenuator error	up to 500 MHz <	<±1 dB
VSWR	up to 1.05 GHz < <1.2 (above 525	<±2 dB MHz: <1.4)
RF overvoltage protection	automatically disc	connects BE output
Max. permissible power	50 W (or 50 V D	C)
RF output II (rear panel)	>20 mV into 50 s	Ω (without AM)
Frequency meter/	10.11	
with option	15 Hz to 525 MH 10 mV	z / 0.5 to 1 GHz 30 mV
Sensitivity	1 Hz (10 Hz, above 20 MHz:	10 Hz (100 Hz)
	10/100 Hz)	
Specifications for	Navigation	Radiotelephone
AF generator/modulation ur	nit/measuring ins	navigation model
Modulation frequencies	. 15 Hz to 150 kHz	2,0.3/0.4/1/2.7/3/6 kHz
Output voltage	. 5 mV to 1 V into	
		200 Ω
Distortion	<0.2 (0.5) % 10 mV to 3 V	<0.5% (0.1 to 10 kHz) 10 mV to 10 V
Error limits	± (2% of rdg +	± (2% of rdg +
ricoundricoporiso/ weighting		
filter Deviation meter,	average	rms/CCITT
distortion meter, SINAD ratio meter,		
CCITT filter	see Radiotelepho on page 109	ne Test Assembly
VOR/ILS modulation VOR/ILS Unit		
	inter at	
VOR modulation signal, cons 30-Hz signal	sisting of:	
Fixed-frequency error limits Incremental tuning	+0.5% and	+1.5%
Distortion	<0.5% and	± 1-3 %
Phase shift between the 30-Hz signals in steps of		
continuously between steps 9960-Hz auxiliary carrier		
Frequency accuracy	±2×10-3	
	480 Hz	
Distortion	<1%	
Distortion 1020-Hz communication signa Frequency accuracy Distortion	<1% I ±1.5%	

ILS modulation signals
 90-Hz and 150-Hz signals

 Frequency accuracy
 ±3×10⁻⁴

 Incremental tuning
 ±0.5% and ±1.5%

 Distortion
 <0.5%</td>

 Deviation of signal amplitudes
 at DDM 0
 Indicator section (measurement of demodulated generator signal) VOR signals: VOH signals: Digital phase readout Resolution Error Modulation-depth indication four digits 0.02 <0.05° odulation-depth indication for 30 Hz and 9960 Hz Bange nominal value ±5% Error <1% Frequency-deviation indication Range ±5% (from nominal value) Error <1% ILS signals: Modulation-depth indication for 90 Hz and 150 Hz nominal value ±5% Range Error Analog indication of DDM values Ranges 0.02 and 0.2 <4% from DDM value + 2% of fsd VOR/ILS Unit with Decade DDM Step Switch Sum of individual depths of Power measurement SMDU-Z1 SMDU-Z1 Measurement ranges 0.05 to 0.3/ 0 1 to 0.6/ 1/3/10/30 W 2/6/20/60 W Modulation measurement Measurement ranges 0 to 40/100% 0 to 40/100% Input power 0.1 to 30 W 0.2 to 60 W General data
 Rated temperature range
 +10 to +45°C

 Storage temperature range
 -40 to +70°C

 AC supply
 115/125/220/235 V ±10%

 (130 to 160 VA)
 (130 to 160 VA)
 Dimensions, weight 492 mm×555 mm×436 mm, 46 kg Vibration test in accordance with VDE 0411 Ordering information Order designations for VOR/ILS Test Assemblies (please order units separately) ► Order No. Signal Generator SMDU Synchronizer option B1 249.3011.38 Radiotelephone & navigation model . VOR/ILS Unit with Decade DDM Step Switch 214.3115.10 without Decade DDM Step
 AM Unit SMDU-Z1/30 W
 242.2010.52

 SMDU-Z1/60 W
 242.2010.53

 VOR/ILS Test Assembly SMDU-V
 with Decade DDM Step Switch
 249.3011.80
 Options

 Options

 SMDU-B1: Synchronizer
 249.6340.02

 SMDU-B2: Overload Protection
 249.7346.02

 SMDU-B3: 1.05-GHz Frequency
 249.9484.02

 SMDU-B4: 1-GHz Frequency
 249.9484.02

 SMDU-B4: 1-GHz Frequency
 250.0012.02

 SMDU-B5: 1.05-GHz
 275.1312.02

 Frequency Doubler 275.1312.02 Recommended accessories Signal Generator SMDU, standard version 249.3011.02 (for two-signal measurements) VOR Zero-phase Meter POR 242.0017.92 (data on page 114)

3 EXTENSION UNITS

test assemblies



- Resolution 0.01° in the most sensitive range
- Accuracy can be checked directly with an oscilloscope
- Deviation checking facility (display of modulation index)

The **POR** is a maintenance-free, high-sensitivity instrument for measuring the phase difference (up to 10°) between the variable and reference-phase components of a VOR signal and for checking the deviation of the VOR subcarrier. The VOR signal consists of the sum of a 30-Hz signal (variable component) and a 9960-Hz subcarrier which is frequencymodulated with a 30-Hz signal (reference component); the standard deviation of the subcarrier is 480 Hz corresponding to a modulation index of 16.

Uses

The precision zero-phase meter is suitable for use in the calibration laboratories of

- ▷ airline companies
- ▷ ATC authorities
- manufacturers for VOR transmitting and receiving equipment
- ▷ maintenance companies.

The zero-phase condition of VOR signals from sources such as VOR generators, ramp testers and VOR ground equipment can be measured with great accuracy. In addition, the POR is suitable for tracing signals in the subassemblies of VOR transmitting and receiving equipment. The phase of the test signal can be shifted $+30^{\circ}$ for checking the direction of phase rotation of resolvers and VOR generators.

In the deviation mode, the deviation of the VOR subcarrier is measured and the associated modulation index indicated.

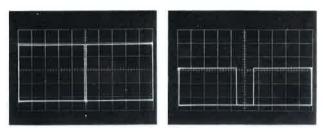
The instrument is outstanding in its ease of operation: it is only necessary to perform a minimum setting with the input signal.

Self-testing

Two test sockets (test voltages) on the rear panel permit checking of the accuracy of the instrument using an oscillo-scope.

Test socket 1 permits checking the effectiveness of the phase compensation section in the 30-Hz branch.

Test socket 2 enables display of the test voltage on an oscilloscope, the resolution being such that the highest possible resulting error is less than 0.01° ; see oscillograms above.



Output at test socket 2

Left: correctly functioning instrument, the gap in the oscillogram is narrow; right: with a phase error of 0.017° in the 9960-Hz branch, the width of the gap in the oscillogram is 10% of the entire display width.

Specifications
Phase indication
Ranges
Amplitude controls
coarseten-turn helipot finepotentiometer
Error of the zero phase in the
0.3° range
(phase measurement) 0.3° range
1° and 10° ranges
) entr
Deviation Indication
Indication range modulation index 0 to 20
modulation index
Indication error for $m = 16$, f = 30 Hz $\pm 1\%$ in
the temp. range +20 to +30 °C $\leq 1\%$ otherwise for f = 30 Hz ±1% $<5\%$ of rdg ±1.5% of fsd
Test input BNC female connector
Level requirement
Maximum permissible DC component
General data
Rated temperature range
Storage temperature range
(47 to 440 Hz); 9 VA Dimensions, weight
Dimensions, weight
Ordering information
Order designation ► VOR Zero-phase Meter POR 242.0017.92
Recommended extras

test assemblies

EXTENSION UNITS 3



The **Adjacent-channel Power Meter NKS** is used in conjunction with the SMDU RT Test Assembly to measure and evaluate all unwanted (power) spectral components of a transceiver in the adjacent channel.

The **power-test-receiver technique** used in the NKS determines the adjacent-channel power by means of an rms rectifier. This permits the total power to be measured and evaluated continuously and irrespective of the type of modulation. The NKS complies with all standard specifications for power test receivers.

Configuration of test assembly. Combined with the SMDU Radiotelephone Test Assembly according to the block diagram on page 108, the Adjacent-channel Power Meter measures the interference in the adjacent channel and indicates the ratio of carrier power to unwanted power in dB in three digits.

Measurement of adjacent-channel power involves nothing more than selection of the desired channel spacing (10/12.5/ 20 or 25 kHz) and the upper or lower adjacent channel. An automatic test program provides digital indication of the ratio of carrier to unwanted signal. The absolute power of the interfering signal is calculated from the power indication on the SMDU-Z1 or -Z2 and the ratio shown on the NKS.

Another use of the NKS is the selective measurement of spurious signals. In the mode "store carrier" the level of the carrier is stored. If the oscillator of the SMDU is then tuned to the frequency of the spurious signal, the ratio of carrier to unwanted signal is indicated in dB. The test assembly thus does the work of an analyzer.

Measurement of adjacent-channel interference due to transients – until now performed only roughly with an analyzer – is now possible with the NKS. Thanks to the precise performance of the memory circuit of the NKS, such interference can now be measured accurately.

Description

The NKS converts the signal of the test item to an IF of 455 kHz \pm channel spacing. The Signal Generator SMDU, with its high spectral purity, is used as an auxiliary oscillator. A control voltage, which permits automatic tuning of the frequency of the SMDU over a range of about 600 kHz, is derived from the IF of the NKS by a pulse discriminator.

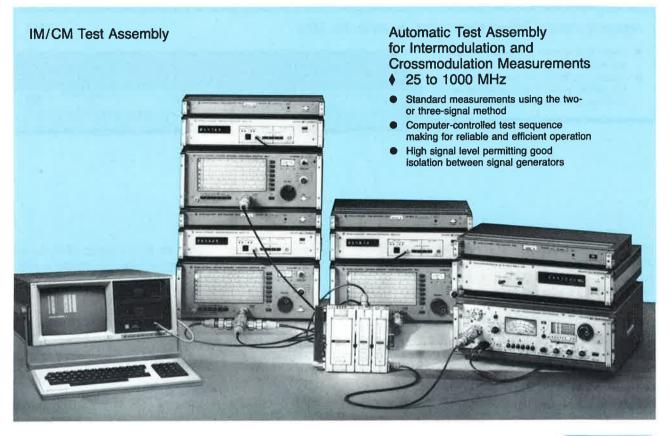
For selection of the adjacent-channel power of a radio set, high-grade 455-kHz mechanical bandpass filters are used, ensuring the required carrier suppression and covering the bandwidths specified for the various channel spacings. In conjunction with the SMDU, the IF is adjusted via the control loop so that the adjacent channel being investigated is within the passband of the associated filter.

Specifications

Frequency range	25 to 950 MHz
	$Z_{ln} \approx 50 \Omega$, BNC female connector
Input voltage range	0.1 to 2 V (max permissible 5 V)
Indut power range	
via SMDU-Z1 52 and Z2	0.1 to 30 W
via SMDU-Z1 53	0.2 to 60 W
LO Input (rear)	$Z_{\rm m} \approx 50$ O, BNC female connector
Input voltage range	0.05 to 0.2 V matched to SMDU
IF output	BNC female connector (rear)
IF output Frequency/output voltage	455 kHz/0.2 V into 50.0
Adjacent-channel power	100 11 12 10 12 1 11 10 50 12
measurement	complian with CEDT and ET7
	specifications
	channel spacing
	10 kHz
	12.5 kHz
	20 kHz
	25 kHz
Selectable spacing from	
useful channel	±1 and ±2 channels
Indication	carrier-to-unwanted-nower ratio in
Measurement range	0 to 89.9 dB in 10-dB steps.
	aman limita (0 5 dD
Weighting	rms value (crest factor 10)
Indication error after	
15-min warmup period	±3 dB (typ. ±2 dB)
Storage times	
Carrier reference:	
normal operation	automatic resetting every
	2 min approx.
storage operation	±1 dB deviation after 15 min
	±1 kHz deviation after 15 min
Measurement of transient	
behaviour	start delayed by 10 (±2) ms
	and 50 (±5) ms, duration 3 s
General data	
Rated temperature mono	104-14500
Rated temperature range	+10 to +45°C
Storage temperature range Power supply	115/125/220/225 V ±104/
and an	47 to 420 Hz (20 VA)
Dimensions, weight	492 mm x 78 mm x 434 mm 5 kg
	the ministro ministro mini, 5 kg
Onderstand 1. C	
Ordering information	
Order dealgration	
Order designation	Adjacent-channel Power Meter NKS 302.2410.03
Accessories supplied	1010 302.2410.03
Accessories supplied	
Connecting cables: LO input/SMDU	RF output II
AFC/BCD output	ts of SMDU
Power cable HF input/Freque	ncy Meter SMDU-Z
I OHICI CADIB	
Recommended extras	
	105 1175 00
IEC-bus Interface NKS-Z	195.1475.02

3 RF IM/CM TEST ASSEMBLIES

test assemblies



(IEC 625Bus)

Definitions and test procedures for RF distortion

When processing and transmitting RF signals, intermodulation and crossmodulation products occur due to the nonlinearity in the characteristics of active and passive components. This distortion is defined as follows:

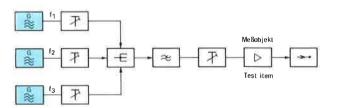
Intermodulation. If an input signal consists of several fundamental frequencies (e.g. picture carrier f_p , sound carrier f_s , colour subcarrier f_{sc}), unwanted combination frequencies are produced in the transmission channel ($f_{unwanted} = f_p + f_s - f_{sc}$) causing a moiré effect in the television picture.

Crossmodulation. Crossmodulation is the modulation of the useful signal by an interfering transmitter signal.

Test procedures. The procedures for measuring the receiver characteristics with respect to these two types of unwanted modulation are practically identical and they are laid down in standard specifications, such as DIN 45 004 (test procedures for antenna amplifiers), VDE 0855, or IEC and ZVEI recommendations.

These standards and the relevant specifications require measurements using the three-signal method in which a composite input signal is produced by interconnecting three signal generators in CW operation.

In the alternative **two-signal method** the combination frequencies produced are outside of the TV channel so that this test method is suitable only for evaluating broadband amplifiers.



Principle of test assembly for intermodulation and crossmodulation measurements using the three-signal method

The above-mentioned measurements require numerous, complicated operations and are time-consuming and expensive in the manual mode. If, however, modern computer control is used, these tests can be performed in a few seconds and a hard-copy test report obtained.

Automatic test assembly

This automatic test assembly is used for standard measurements of intermodulation (DIN 45 004, method K) and crossmodulation (method B) suppression to 75 dB using the threesignal method. In addition, intermodulation measurements according to the two-signal method and gain and frequencyresponse measurements are possible.

test assemblies

RF IM/CM TEST ASSEMBLIES 3

Applications. The computer-controlled RF test assembly permits saving of costs wherever frequent measurements of nonlinear distortion are to be performed on test items, such as

- channel amplifiers for centralized antenna systems
- ▷ wideband amplifiers for cable networks and CATV
- ▷ semiconductors and modules for amplifiers.

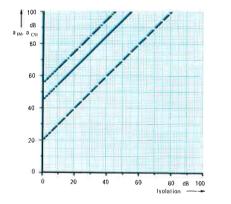
In addition to intermodulation measurements, other tasks such as in the production of RF cables, filters, tuners or antennas can be easily solved using the appropriate instrument configuration.

Ease of measurement due to basic software - versatility.

An automatic test assembly has a very wide range of application. The basic software – permitting control of the instruments integrated into the test system – is designed such that it can be used as the foundation for specific test programs. Thus, using the appropriate instruments, individual requirements can be met with a minimum of programming.

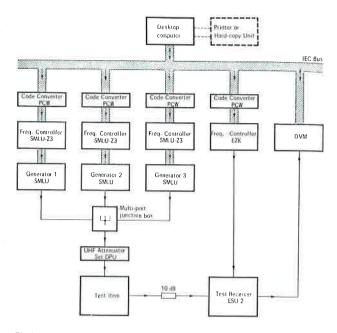
To measure for instancce intermodulation, it is sufficent to enter the channel frequency and the desired output level. The computer takes care of the rest in a few seconds: calculating and setting the correct frequency spacings and level ratios, setting the required output level, measuring the intermodulation product and calculating its relation to the sync peak.

Configuration – function. The nucleus of the test assembly for intermodulation and crossmodulation measurements is three or two (depending on the method used) Power Signal Generators SMLU covering the wide frequency range 25 to 1000 MHz. The high output power level of up to 2 W permits a high degree of isolation between the generators so that their outputs do not interact. For residual intermodulation products down 80 dB, the level applied to the test item is still 115 dB μ V (see diagram below). No external filters are required due to the good harmonics suppression of the SMLU of 40 dB.



Intermodulation and crossmodulation suppression a_{IM} and a_{CM} of SMLU as a function of isolation solid line: threesignal IM suppression referred to sync peak; dashed line: twosignal IM suppression referred to carrier chain-dotted line: CM suppression

A Frequency Controller SMLU-Z3, which is driven from the desktop computer, is used for programmed frequency setting of each signal generator. The Code Converters PCW establish the connection to the IEC bus and permit level programming. The selective VHF-UHF Test Receiver ESU 2 measures and indicates the unwanted products. Its frequency as well as the sensitivity switchover are programmed by the computer via the Frequency Controller EZK and an additional PCW. The DVM converts the ESU 2 output DC voltage, which is proportional to the measured value, and applies the digital result to the computer.



Block diagram of the Automatic RF Test Assembly for intermodulation and crossmodulation measurement

Specifications

(for specifications of the individual instruments see the corresponding type in the catalog)

Frequency range 1 kHz or 10 kHz SMLU output level up to 595 MHz: +33 dBm (2 W) 10 V into 50 Ω up to 1000 MHz +30 dBm (1 W) 7.07 V into 50 Ω Attenuation of output power Signal Generator SMLU . coarse: 35 dB in 5-dB steps fine: 10 dB UHF Attenuator Set DPU 0 to 140 dB in 1-dB steps; error ±0.05 to 1 dB -10 to +120 dBμV ≦±1 dB for V_{in} ≧1 μV Frequency instability using Frequency Controller EZK <100 Hz Frequency indication Basic software . . . digits 2 kbyte Storage capacity of magnetic-tape cartridge 256 kbyte 72 characters/line Print format Grafic display 19 cm ×14 cm

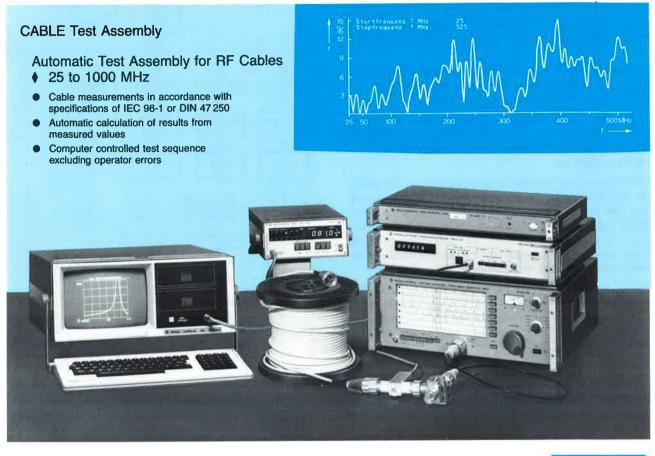
Ordering information

Order designations (order units separately)

Quant	ity Designation		Order No.
3 (2)	Power Signal Generator	SMLU	200,1009.03
3 (2)	Frequency Controller	SMLU-Z3	242.5019.92
4 (3)	Code Converter	PCW	244.8015.92
3 (2)	Coding Board for SMLU	PCW-Z	245.2610.02
1	Coding Board for EZK	PCW-Z	291.1113.02
1	VHF-UHF Test Receiver	ESU 2	252.0010.55
1	Frequency Controller	EZK	255.0010.02
1	UHF Attenuator Set	DPU	100.8960,50
1	Four-Port Junction Box	DVU 4	201.4018.02
	Three-Port Junction Box	DVU 3	100.5203.50
5	Cable for IEC Bus (24-core)	PCK	see page 19
1	Process Controller	PUC	see page 14
1	Digital Voltmeter	URV 4	292.5012.03
1	Cable for IEC-Bus		
2	(24/25-core)	SMPU-Z8	216.0188.02
1	Floppy disk (software)	SMLU-K1	240.9952.02

3 RF CABLE TEST ASSEMBLIES

test assemblies



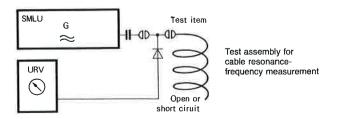


Definitions and test procedures for cable characteristics

For distortion-free singal transmission RF cables should exhibit certain characteristics whose determination is specified in IEC recommendation 96-1 and, with almost the some wording, in standard DIN 47250. The following RF parameters are to be measured:

- 1. mean characteristic impedance
- 2. uniformity of impedance
- 3. attenuation.

All these measurements can be performed automatically using this test assembly. If the screening efficiency is also to be determined automatically, a programmable test receiver (e.g. ESU 2) has to be added. Since, however, this measurement is required only for type approval of braided cables, it depends on the individual case whether automatic determination is of advantage.



For determination of the **mean characteristic impedance** a cable of suitable lenght, with its free end open or shorted, is loosely coupled to a generator. The value is found from the frequency spacing of the resonance maxima determined by a frequency response measurement and the total cable capacitance.

For measuring the **uniformity of impedance** a reflectometer is used: the frequency is varied in steps or continuously and the reflection coefficient plotted as a frequency function on the connected display unit or recorder; see diagram. This measurement is used for locating frequency-dependent reflection which is caused by imperfections distributed periodically over the full cable lenght.

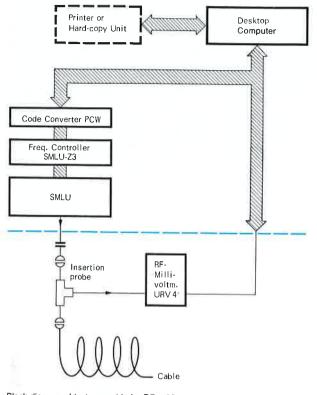
The **attenuation** can be determined by a two-port method – preferable for cables of higher attenuation – or from the width of the resonance peak. The resonance method is used to advantage for extremely low-loss cables or for lines whose far end is not accessible for a two-port measurement. The required test asembly corresponds to that for determining the mean characteristic impedance.

Automatic test assembly for RF cables

Control of the test sequence from a desktop computer replaces the time-consuming manual checkout, permitting an advantageous combination of automatic measurement and calculation of results. It prevents wrong results due to operator or arithmetic errors and furnishes a neat, reproducible test report.

test assemblies

RF CABLE TEST ASSEMBLIES 3



Block diagram of test assembly for RF cables

Versatility of application, basic software

The basic programs required for driving the connected measuring instruments have been designed to permit other measuring problems also to be solved. The fundamental principle in determining cable characteristics is a frequency response measurement; thus programs for related tasks can be readily established in a similar way. The basic routines required for later extension of the test assembly by R&S instruments are already available so that a variety of different automatic measurments is possible over the entire frequency range up to 1000 MHz.

Configuration and function

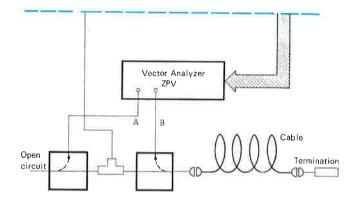
The RF generator included in the automatic test assembly is the Power Signal Generator SMLU, which is particularly suitable for general use thanks to its wide frequency range (25 to 1000 MHz) and high output level (2 W). A frequency controller, which is driven from the desktop computer, is used for programmed setting of the SMLU output frequency. For cable measurements, the high output power permits use of a wideband and thus easily operated meter. The RF Millivoltmeter URV 4 measures the resonance voltage at the cable end. The proportional output voltage of the millivolltmeter is applied, after A/D conversion, to the computer.

Control of the instruments and entry of the measured values into the computer are carried out by way of the internationalstandard IEC bus, which enables ready interconnection of all measuring instruments fitted with this interface. The Process Controller PUC from R&S is available for controlling the test sequence.

It contains displays which also permit graphic computing and uses the BASIC language. Thus program preparation and modification is very easy (see section 1).

The Vector Analyzer ZPV is used for measuring the reflection coefficient for evaluation of the uniformity of the characteristic impedance. The reflection coefficient is represented as a function of frequency on a display or recorder; frequency variation is in steps or continuous.

Extension of test assembly for RF cables by Vector Analyzer ZPV (e.g. for measuring impedance uniformity)



Specifications

(for specs of individual instruments see corresponding type in catalog)

Frequency range Frequency resolution Frequency error	10 kHz or 1 kHz
SMLU output level	up to 595 MHz: + 33 dBm (2 W) up to 1000 MHz: + 30 dBm (1 W)
Attenuation measurement range	20 5 dD is 0 5 dD share
Anonadadon medsurement range	39.5 dB in 0.5-dB steps
Meas. range of RF millivoltmeter	0.7 mV to 10 V
Measurement error	1.5% of rdg + freqresp. error (average: 1%; max. 15%)

Characteristic-Impedance measurement Measurement error ±0.2% + error of capac. meas.

Attenuation measurement

Measurement error ±0.2 dB

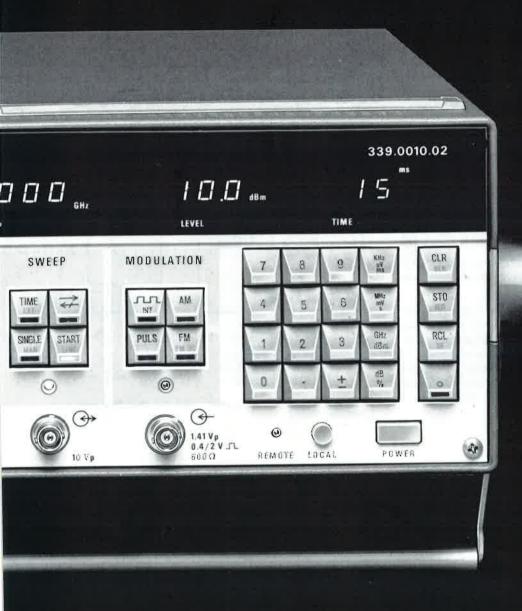
Ordering information	
Order designations of individual instruments	
Control units, software	
Process Controller PUC see page 14 Floppy disk (software)	
for PUC, SMLU-K3	
Code Converter PCW 244.8015.92	
Cable PCK for IEC bus, 24-core 292.2013.10 (1 m long)	
292.2013.20 (2 m long)	
Signal generators	
Power Signal Generator SMLU 200.1009.03	
Frequency Controller SMLU-Z3 242.5019.92	
Coding Board for SMLU, PCW-Z 245.2610.02	
Indicators	
Vector Analyzer ZPV	
Tuner ZPV-E2	
IEC-bus option ZPV-B1	
s-parameter option ZPV-B2 292.3810.02	
Insertion Adapter ZPV-Z1	
(2 req'd)	
Feed Unit ZPV-Z2	
Directional Coupler ZPV-Z3	
(2 req'd) 292.3110.50	
RF Millivoltmeter URV 4 292.5012.03	

Sweep Generator SWP, sweeper/signal generator/synthesizer combined in a single unit, 0.1 to 2500 MHz; details on page 126



0

sweep generators, sweep testers network analyzers



SWEPT-FREQUENCY MEASUREMENTS

sweep testers

Rational measurements using sweep testers

The increasing complexity of electronic circuits requires more accurate measurement results over ever wider frequency ranges. Swept-frequency measurements are a satisfactory solution which can also be applied to rationalized test methods. At present this is probably the most important and largest field of RF measuring technology.

The **advantages** are obvious: automatic curve display considerably reduces the measuring time, i.e. no variation of the characteristc occurs during the test procedure; as against point-by-point measurement, rapid variations of the measured values (dips) are evident. Moreover, the effects of interventions, such as alignment work, are discernible simultaneously and immediately even for several paramenters over the entire range of interest.



Even if computer-controlled point-by-point measurement is increasingly offered as an alternative, this technique cannot be used for a rapid overview or for continuous display of the variations occurring during alignment. However, with sweptfrequency measurements, even the advantage of logging the results need not be sacrificed; see the setup opposite using Polyskop SWOB 5.

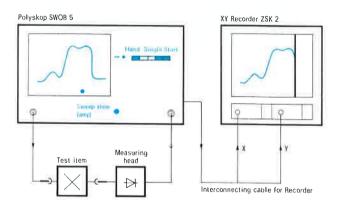
Sweep generators. The Sweep Generator SWP is an RF generator of the latest state of the art corvering a continuous frequency range from 0.1 to 2500 MHz. It can be universally used since it combines the functions and characteristics of a sweeper, a signal generator and a synthesizer in a single unit; it has memory capacity for complete device settings and can be remotely controlled via the IEC bus, which makes it suitable for use in automatic systems.



Sweep Generator SWP

Compact sweep assemblies combining the sweep generator, display and marker generator in one unit like the SWOB 5, permit particularly economic and easy-to-use test setup configurations; see also page after next under configuration of sweep testers.

In addition to the sweep generators and compact test assemblies described on the following pages and to the sweptfrequency test equipment listed in the table, the Rohde & Schwarz line offers a number of signal generators and measuring instruments for various applications which include or can be equipped with a swept-frequency capability, for example the Synthesizer Generator XPC on page 58 or the Vector Analyzer ZPV on page 142.



Logging of test results in single sweep (sweep time about 30 s) using XY Recorder ZSK 2 $\,$

	Frequency range	Designation	Туре	Order No. (complete No. see text)	Subranges	Sweep width	Sweep frequency Sweep time	Output EMF
	1 Hz to 1.3 MHz	Generator	SPN/ SMLU-Z	336.3019.02	1	entire range	10 ms to 1 s 2 to 200 s	10 V
	0.1 to 130 MHz	Sweep Generator	SMUV/ SMLU-Z	301.0120	3 (1)	entire range	10 ms to 1 s 2 to 200 s	1 V (10 V) 133 to +33 dBm
	25 to 1000 MHz	Power Sweep Generator	SMLU/ SMLU-Z	200.1009	7 (1)	entire range	10 ms to 1 s 2 to 200 s	10 (7) V into 50 Ω −13 to +33 dBm
W	0.1 to 2500 MHz	Sweep Generator	SWP	339.0010	1	entire range	10 ms to 100 s	-110 to +10 dBm
	0.1 to 1000 MHz	Polyskop	SWOB 5	333.0019	a	0.1 to 1000 MHz 5 to 1000 MHz 0.3 to 50 MHz and 0	20 ms to 2 s and manual control sawtooth	300 µV to 1 (2) V
	0.1 to 1300 MHz	Polyskop	SWOB 5	333.0019.53	1	0.1 to 1300 MHz 7 to 1300 MHz 0.3 to 50 MHz and 0	20 ms to 2 s and manual control sawtooth	300 µV to 1 (2) V

Sweep generators and sweep assemblies (overview)

ne

Applications

of RF swept-frequency measurements

Division into different application groups gives a better overview of the wide field in which swept-frequency measurements can be used to advantage. Essentially there are three groups which are determined by the tasks to be solved and the parameters to be measured:

- measurement on two- and four-terminal networks to determine the reflection and transmission characteristics by magnitude (scalar network analyzers)
- measurement on two- and four-terminal networks to determine the reflection and transmission characteristics by magnitude and phase (network analyzers)
- measurement or examination of generator signals with the aid of scanning receivers (spectrum analyzers)

The following text deals only with sweep assemblies used for the first group of measurements (for the second group see page 142 ff. and for the third group section 7). The first group is divided into wideband and narrowband swept-frequency measurements.

For the display, a high sensitivity and wide dynamic range, flat frequency response, simultaneous display of several curves and the largest possible screen – in particular for use in production – are required. If the advantages of sweptfrequency measurements are to be fully used, it is essential to have clear, easy-to discern frequency markers permitting satisfactory reading even on steep filter edges; moreover, when examining mixer configurations and tuners, suppression of an unwanted signal occurring at the test-item output due to the mixer should be possible during the return sweep.

The present, advanced state of thin-film and thick-film technology permits the construction of amplifiers featuring an almost flat amplitude-frequency response and good input and output matching over very wide ranges. Only modern sweep testers meeting the above requirements enable measurements on these modules.

Wideband swept-frequency measurements

In wideband wept-frequency measurements a large bandwidth, high spectral purity (harmonics and spuria), excellent amplitude stability, a low output reflection factor and a precise output-voltage divider are of primary importance for the generator. The possibility of switching over different preprogrammable generator settings, such as sweep width and frequency, at the push of a button is a desirable feature for use of the equipment in production and quality control.

Narrowband swept-frequency measurements

In narrowband swept-frequency measurements, in particular the spectral purity of the generator close to the carrier should be very high since the test items are mainly sharp-cutoff filters, especially crystal filters. To cover the high stopband attenuation of such filters, a wide dynamic range is required for the indicator, necessitating highly selective tracking receivers.

Configuration of sweep testers

Sweep testers determining by magnitude the quantity to be measured are used everywhere, however, especially in production and test departments since there normally only the magnitude of reflection coefficients and transmission factors is of interest. When aligning to minimum or optimum values, complex evaluation is also not required in most cases.

The simplest type of sweep tester comprises a sweep generator, a diode detector and, as the display unit, an oscilloscope whose horizontal deflection is driven from the generator. Compact sweepers are available for frequencies up to 1.3 GHz, the sweep generator, indicator and display secition being combined in one set. Such a compact sweeper has the following advantages: ease of operation since setting the sweep separately on the generator and on the display is not necessary and interconnections between the individual units are not required; high indication sensitivity since special amplifiers matched to the measuring head are used.

Assembly for	Voltage required for full picture height RF	Frequency-response flatness in sweep operation	Internal frequency markers	Dimensions in mm (W×H×D)	Text on page
600/50/≈5 Ω	0 to +1.3 V	≈3 dB	<u></u>	245×154×349	44
50 Ω	(0 to +10 V)	< ±1 dB	adjustable over entire range	492×290×514	60
50 Ω		$\leq \pm 0.8 \text{ dB}$	adjustable over entire range	484×260×436	70
50 Ω			6; 1/10/100 MHz	470×162×483	126
50 Ω 75 Ω		V_{oul} : <±0.5 dB	1/10/100 MHz	484×328×436	132
50 Ω		V _{out} : <±0.5 dB	1/10/100 MHz	484×328×436	132

Extension of sweep testers

Accessories are required to make full use of the sweptfrequency measurement capability. Directional couplers or VSWR bridges are available for measuring standingwave ratios or reflection. While a directional coupler is not to be recommended for wideband measurements since it has a frequency-dependent coupling attenuation, the VSWR bridge with its flat frequency response is especially suitable for this purpose.

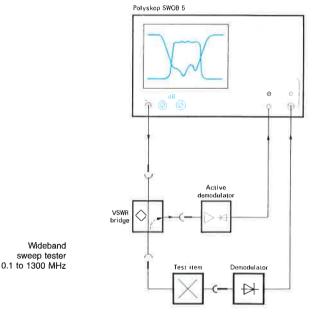
If the voltage curves at the input and output of a test item are to be observed simultaneously or the input voltage applied to the test item is to be displayed along with the reflection coefficient, insertion heads are required. These units consist of a certain length of coaxial line, the voltage being measured across the inner conductor.

Another possibility of extending a compact sweep tester is to use an active demodulator which considerably increases the measuring sensitivity. Demodulators of this type consist of a wideband preamplifier with low input reflection and an extremely flat frequency response plus a detector circuit at the amplifier output.

The new Digital Display Store BDS offers a number of additional functions and improves the measurement accuracy. Thanks to the constant readout time the display remains flickerfree even with slow sweeps. Correction or reference curves can be stored and combined by addition or subtraction with the sweep curve, so it is possible to compensate for frequency-response errors or to readily align any item being tested to a given response. and quality tests, for example, the entire amplitude/frequency characteristics of tested items can be transferred to the computer, checked for adherence to the tolerance limits and processed for statistical evaluation.

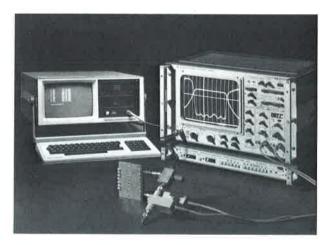
Wideband sweep tester

As has been mentioned above, the main application of sweep testers which measure quantities by magnitude is the display of the amplitude response and of the VSWR or return loss as a function of frequency. The test setup used in the example below consists of a compact Rohde & Schwarz sweeper – SWOB 5 (frequency range 0.1 to 1300 MHz), a VSWR bridge and an active demodulator. The test item is a bandpass filter.



The sweep generator voltage is applied to the VSWR bridge. The item under test is connected to the test output of the bridge, the test-item output being taken directly to the RF input of the sweep generator through the measuring head so that measurement of the voltage after the test item is possible with the correct termination. The voltage reflected at the filter input is measured via the bridge output with the aid of the Active Demodulator SWOB5-Z4.

Since the VSWR bridge has an attenuation of 6 dB between the test voltage input and the test item connector, a filter attenuation of more than 63 dB can still be displayed with a generator output of 0.5 V and a display input sensitivity of 170 μ V.

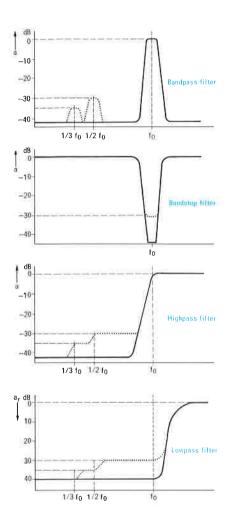


Wideband sweep assembly: Polyskop SWOB 5 (equipped with Logarithmic Amplifier SWOB5 E3), Digital Display Store BDS and Process Controller PUC (for data storage)

An IEC-bus interface in the BDS opens up the way for entirely new applications with the sweep tester. The connection of a desktop computing system makes it possible to read out, convert and re-enter all memory contents. In production Measurement error in wideband sweeping

caused by harmonics and spuria

Wideband detectors are almost exclusively used in sweep testers which measure quantities by magnitude; for this reason errors may occur especially when measuring filters if the suppression of harmonics and spuria in the sweep signal is lower than the stopband attenuation or return loss to be measured; see the following examples:



Bandpass filter. When reaching an integral submultiple of the passband frequency, the corresponding harmonics are allowed to pass through the filter and are evaluated. Below the passband, apparent attenuation dips are produced. The difference between the peak attenuation of these dips and the true passband attenuation of the filter corresponds to the suppression of the related harmonic.

Bandstop filter. Wehen passing through the stopband, all harmonics are evaluated simultaneously since they fall into the passband. This simulates too low a stopband attenuation. The maximum measurable stopband attenuation corresponds to the harmonics suppression at the stop frequency.

Highpass filter. While the fundamental passes through the stopband, the harmonics consecutively fall into the passband and are evaluated. A stepped stopband attenuation is displayed decrasing in accordance with the harmonics present; the difference between each point on the step curve and the amplitude in the passband corresponds to the suppression of the related harmonic.

Lowpass filter. Here errors may occur when measuring the return loss. While the test frequency sweeps through the passband of the filter where little reflection occurs (high return loss), the associated harmonics fall into the stopband, are heavily reflected and simulate a rising, staircase-like reflection characteristic.

Measurement errors of the above-mentioned type can be neglected to a large extent with a Polyskop test setup since spurious frequencies are typically 60 dB down (up to 1000 MHz) and harmonics are typically 40 dB down. Other advantages of these sweep test assemblies are the size of the screen (16 cm×22 cm), the display of vertical frequency markers covering the full screen height and the possibility of inserting three different horizontal lines at any position of the screen. In this way all details of the display can be easily recognized and evaluated.

Narrowband sweep tester

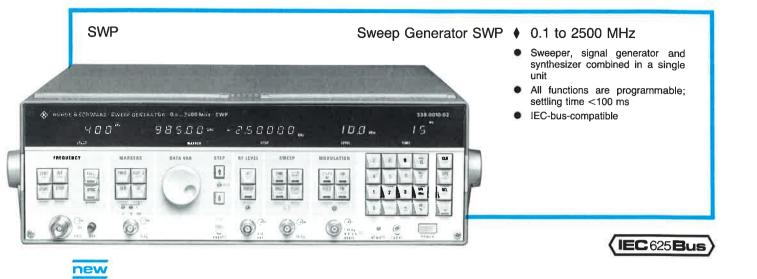
The photo below shows an example of a narrowband sweep tester consisting of the following instruments: Sweep Generator SWP (0.1 to 2500 MHz), Vector Analyzer ZPV (0.1 to 1000 or 0.3 to 2000 MHz) as selective tracking receiver and XY Recorder ZSK 2 as output unit. A crystal filter with very steep cutoff and high stopband attenuation is used as test item. This test setup enables logarithmic measurement over a dynamic range of more than 100 dB. The low spurious FM of the Sweep Generator SWP allows even extremely steep filter edges to be represented satisfactorily. The SWP delivers the deflection voltage for the recorder while the vector analyzer is automatically synchronized to the test frequency. The greatest possible sweep width is 1 MHz. Errors normally occurring with wideband sweeping do not take place, since the measurement is selective and no harmonics of the test signal fall within the sweep band due to the relatively small frequency variation with respect to the absolute frequency (for frequencies >1 MHz).

> Narrowband sweeper for 100 kHz to 2 GHz



4 SWEEP SIGNAL GENERATORS

sweep generators



Continous sweep

Aplitude

Outstanding performance

SWEEPER

Wide frequency range: 0.4 to 2500 MHz

Low content of harmonics and spurious signals: typically 40 and 50 dB down

Six variable frequency markers – level sweep –

Sweep time 10 ms to 100 s

SIGNAL GENERATOR

Amplitude modulation with low distortion

Pulse and frequency modulation

Calibrated output level +10 to -110 dB max., resolution 0.1 dB

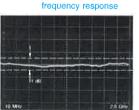
SYNTHESIZER

Crystal-referenced frequency setting

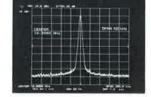
Low spurious FM: < 5 Hz (CCITT weighting)

Frequency resolution 1 kHz

Short settling time, continuous sweep



Spectral purity



Fields of application (examples on page 130)

General sweep techniques

Measuring magnitude of reflection and transmission factors

Network analysis

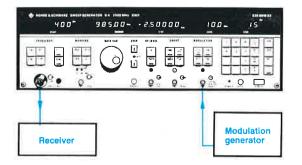
Ideal signal source for impedance, group-delay and s-parameter measurements using Vector Analyzer ZPV

Multi-source measurements (using 2 or 3 SWPs)

Transposer, mixer, tuner and intermodulation measurements

 Multi-source applications (AM, FM, pulse modulation)

Use as a universal signal generator



sweep generators

User-friendly design

- Keyboard entry for all parameters
- Variation through step key or knob
- Memory capacity for 10 full front-panel setups (saved in CMOS RAM)

SWEEP SIGNAL GENERATORS 4

Marker section

Six freely selected markers between 0.4 and 2500 MHz Crystal reference through Synchronizer option Additional harmonic markers 100/10/1 MHz (with option)

Programmability

All functions set from IEC bus (fitted as standard) Listener, talker, learn mode, service request Access to CMOS RAM in both directions via IEC bus Short setting times

Functional features

The Sweep Generator SWP is a general-purpose signal generator for use in development, production and servicing. The output signal can be continuously swept over the frequency range from 0.1 to 1.1 MHz and 0.4 to 2500 MHz.

The **Synchronizer** option permits CW operation and narrowband sweeping with low spurious FM. Frequency resolution is 1 kHz and settling time <100 ms.

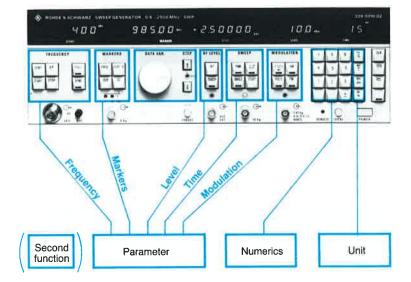
Output level. The **output level** is calibrated and presents a very flat frequency response; harmonics and spurious signals are typically down 40 and 50 dB, respectively – extraordinary values for a sweep generator; level setting is possible from +10 to 0 dBm with 0.1 dB resolution. Levels down to -110 dBm can be set in conjunction with the **Attenuator** option.

Level sweep facilitates, for example, the determination of the compression points of amplifiers and the compensation for frequency-response roll-off in the test configuration. **Modulation.** The SWP has been designed for different types of **modulation:** squarewave modulation with an internal signal; AM, FM and pulse modulation with an external signal. This affords the SWP great versatility as a signal source.

Frequency markers. A total of six variable **frequency markers** can be entered, the frequency of any one marker being indicated on the display. When the Synchronizer option is incorporated the markers are crystal referenced. The **Harmonic Marker** option produces **additional markers** at 100/10/1-MHz intervals. The marker identifying the displayed frequency and the 100-MHz or 10-MHz marker are highlighted by widening of the marker pulse.

Storage/recall. Up to nine* full front-panel setups can be stored and recalled with a single keystroke when needed.

* Ten including the last operating setup, which is stored when the unit is switched off $\!\!\!\!\!\!\!\!\!\!\!\!$



Data entry through keypad

Operating convenience

Operation

The clear arrangement of operating controls and displays and the optimized number of keys make operation very easy.

Second functions

A separate key (bottom of row to the right of the keypad) is provided to call up additional and special func-



tions, offering a maximum of capabilities without restraining the ease of operation.

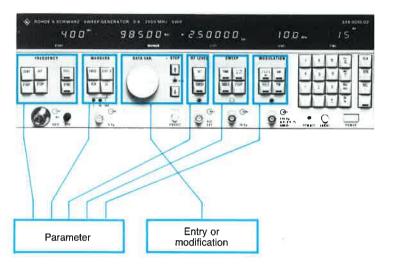
4 SWEEP SIGNAL GENERATORS

sweep generators

SWP - Sweep Generator

Operating convenience

Data entry or modification through ROTARY KNOB



through STEP KEYS



All settings can be affected in the same way as with the use of the rotary knob.

Step size is selectable through the keypad.

All settings can be varied using the rotary knob with the corresponding parameter key pressed.

Frequency and marker setting

(\$) RONDE & SCHWARZ - SWEEP SENER:	ator: 0.4.:2500 MHz - SWP
4 [] [] ^{dat}	9995,000 MHz - 80,5000,000
1967	BHTTA ::007
FREQUENCY MARKERS	Possibilities of entering frequency: 1 Centre frequency + sweep width 2 Start and stop frequencies 3 Overall range 0.1 to 2500 MHz 4 Synchronization (option)

Markers:

Example

FREQ

Total of six variable markers

Marker presentation

One marker





Marker pulse output widened

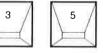
Three markers (display of markers 2, 3 and 5)

Marker

ident. 1 to 6







Keypad

Display

The three markers selected are highlighted by widened marker pulses.



DISP.3 Three marker ident.

Marker

frequency

Unit

Marker ident. 1 to 6

In this case there is no display of start and stop frequencies or of centre frequency and sweep width.

sweep generators

SWEEP SIGNAL GENERATORS 4

Programming

IEC-bus interface. The Sweep Generator SWP has an IEC-bus interface and is therefore particularly suitable for **use in automatic test systems.** All functions can be remote-controlled. In addition, the IEC-bus address can be changed via the keypad and read out on the display.



IEC-bus address displayed on SWP

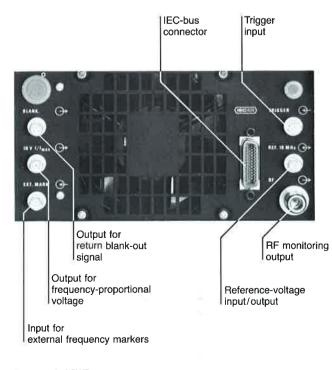
Functions. In addition to the conventional listener function, the SWP provides for "talker", "learn mode" and "service request".

In the **talker mode** all SWP settings and the self-test results can be transferred to the bus.

With the **learn mode**, manually entered settings can be stored in the external computer (of the test system) and sent back at any time. This greatly facilitates programming work.

Service request is important when a fault occurs in the equipment; moreover it is useful, for example, when a sweep is terminated.

In designing the IEC-bus control of the SWP particular importance has been attached to easy programmability.



Rear panel of SWP

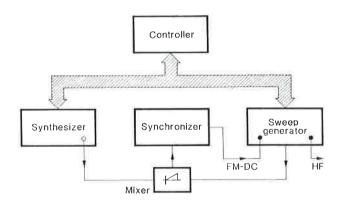
Extensions (options)

Synchronizer SWP-B1. In conjunction with the Synchronizer option the Sweep Generator SWP offers synthesizer performance with a lower frequency limit of 100 kHz. All frequency settings, including the markers, are crystalreferenced and spurious FM is greatly reduced. This opens up numerous and novel applications for the sweep generator.

Use of the Synchronizer option is particularly interesting for **narrowband sweeping** ($\Delta f < 1$ MHz) and for **CW operation** ($\Delta f = 0$), permitting measurements on crystal filters to be performed with the SWP.

Synchronization occurs at 1-kHz intervals. Settling time is <100 ms. In the wideband sweep mode the frequency counter ensures accurate setting of the start frequency and of the variable frequency markers.

SWP + Synchronizer replaces several instruments. With crystal-referenced frequency setting the SWP performs tasks which up to now called for several instruments; an example is shown below.



Example of conventional test assembly

Conventional systems for high frequencies require for the accurate frequency setting of the sweeper either an external synthesizer and a synchronizer or a microwave counter and – in many cases – a controller.

All this accessory equipment is superseded by the Sweep Generator SWP fitted with the Synchronizer option. This simplifies the test assembly and cuts down on purchase cost.

Reference Oscillator SWP-B11. This option improves the frequency stability of the Synchronizer (reducing the effects of temperature and crystal aging).

Attenuator SWP-B7. Using the Attenuator option the output level can be set in 0.1-dB steps from +10 dBm to -110 dBm.

Harmonic Marker SWP-B9. This option permits the display of markers with 100/10/1-MHz spacings. The markers representing the higher value (10 or 100 MHz) are highlighted by broader marker pulses. External marker signals can also be applied.

4 SWEEP SIGNAL GENERATORS

sweep generators

SWP -	Sweep Generator		Fie
Second fu	nctions	$\sqrt{2}$	
Additional activated the	settings, nrough key		
Parameter Key	Function	Display	
FREQUENC	Y		
MK	Centre frequency is replaced by any selected marker frequency	CENT MARKER	
CORR.	In operation without Syn- chronizer, frequency correction up to 10 MHz can be made with the rotary knob and is preserved in the case of frequency changes	C	•
MK-SWP	Start and stop frequencies each correspond to a freely selectable marker. Application: sweep magnifier	START MARKER STOP MARKER	
CW	CW mode can be called up directly (not only through $\Delta f=$ 0)		
MARKERS			
ΔМК	Instead of the marker frequency the difference between two selectable markers is displayed. Application: bandwidth measure- ments	MARKER	Þ
RF LEVEL			
EXT	External ALC		
No. 1 Commences			
SWEEP EXT	Sweeping through external saw. tooth		
MAN	Change of generator frequency within selected sweep bandwidth using rotary knob		S Fi Fr
LINE	AC supply-synchronized sweep		
			Fi
MODULATIC FM-DC			R
FM-DC	Coupling for external FM-DC sig- nal. Application: external syn- chronization		E
STEP			0
MAN	The step size for the data varia- tion using the STEP keys can be selected through the keypad		C Al Se Di
	• •		0 Fr
STO IEC RCL SF	Display of the set IEC-bus ad- dress. This address can simul- taneously be changed through the keypad	IEC	0 5 5 (8 H
SF	Call of special functions	SF	SI Li
TEST	With the second function of the PRESET key a self-test of the SWP functions can be triggered. More than 20 DC, AF and RF measurements are carried out and any faults (tolerances exceeded) indicated on the display.		Si Si Di Ri Le

Fields of application

General sweep techniques

Clear display of start and stop frequencies, marker frequencies (up to six markers) level and sweep time

All settings variable by rotary knob

Rapid switchover to a maximum of nine front-panel setups

Crystal-filter measurement, linearity measurement on active test items by level sweep (compression measurement)

Network analysis

The SWP is an ideal add-on to the Vector Analyzer ZPV in the range 100 kHz to 2000 MHz for vector measurements, impedance measurements, transmission measurements, group-delay measurements, s-parameter measurements

Multisignal measurement

SWP 1 for automatic sweep

SWP 2 for single sweep triggered by SWP 1

Synchronized sweep of two or more SWPs with frequency offset (e.g. of IF)

Use as signal generator (AM or FM).

Low spurious FM (with Synchronizer option) and versatile modulation capabilities open for the Sweep Generator SWP fields of application reserved formerly to conventional signal generators, for example, measurements on receivers.

Specifications (without options)

	· ·/
Frequency range/sweep range	. 0.4 to 2500 MHz
Frequency/sweep setting	
	a) start and stop frequencies or
	b) centre frequency and sweep width
Frequency display	
	resolution: 10 kHz
Resolution of sweep-width setting	
up to 20 MHz	
>20 to 250 MHz	
>250 to 2500 MHz	• 600 kHz
Error limits of frequency	
setting (CW or START)	, ±12 MHz ±0.5 MHz/°C
Output level (with attenuator option	
	. 0 to +10 dBm or 224 to 707 mV, 50 Ω
	. 0 to +4 dBm or 112 to 353 mV into 50 Ω
Setting	
Display	. 4 digits in mV, μV or dBm/dB;
o	resolution: 1% of setting or 0.1 dB . $\leq \pm 0.5$ dB at 100 MHz
	$\ge \pm 0.5 \text{ dB}$ at 100 MHz
Frequency-response flatness	$. \ge \pm 1$ dB (typ. ± 0.5 dB),
	referred to 100 MHz
Output (N female connector)	. 50 Ω, VSWR ≧1.25
Spectral purity	
Spurious FM	
(sweep width <20 MHz)	<5 kHz peak (30 Hz to 20 kHz)
Harmonics	>30 dB typ $>40 dB$ down
Spurious signals	≧50 dB down at 0.4 to 2000 MHz
	≧35 dB down at >2000 to 2500 MHz
Level sweep	
Setting	via keypad or knob
Setting range	0 to 10 dB
Display/resolution	4 digits in dB, mV, μV/0.1 dB
RF monitoring output	. N female connector on rear panel.
	$Z \approx 50 \Omega$
Level into 50 Ω	
Level into 50 Ω with Attenuator option	. ≈ -18 dBm CW
	≈ -24 dBm with AM

sweep generators

SWEEP SIGNAL GENERATORS 4

External level control	with positive detection voltage
Frequency sweep Internal sweep Setting	0.01 to 100 s via keypad or knob,
External sweep ¹)	
Sweep voltage	0 to 10 V
Frequency markers Setting	 6 adjustable markers via keypad or knob, resolution: 10 kHz ±0.1% of sweep width setting
Display	6 digits in GHz, MHz, kHz;
Error limits	1 or 3 markers ±12 MHz ±0.5 MHz/°C BNC female connector, ≈5 V
Reference oscillator	10 MHz
Crystal aging Temperature effect Output/input	$x < \pm 1 \times 10^{-6}$ /month
(switched internally)	BNC female connector on rear panel
Output level Input requirement for external reference	
Amplitude modulation	
Modulation frequencies Internal, squarewave	4.141-
External, AM	carrier freq. mod. freq.
	>1 to 10 MHz 0 to 3 kHz
Modulation depth	1 kHz mod. freq. carrier freq. mod. freq. >10 to 2500 MHz 0 to 10 kHz >1 to 10 MHz 0 to 3 kHz 0.4 to 1 MHz 0 to 1 kHz 0 to 80% 0 to 1 kHz
Setting	via kevpad or knob
Display Resolution for 0 to 9.9% mod.	3 digits 0.1% steps
10 to 80% mod.	1% steps
Error Modulation distortion with undistorted ext. signal	≤8% of mod. depth ≤5% for free = 1 kHz
Input requirement	
Frequency modulation	DC to 100 kHz (±1.5 dB)
Frequency deviation	0 to 10 MHz
Setting Display	3 digits in MHz or kHz
Resolution	$\leq 1.2\%$ or 125 Hz $\leq 3\% + 60$ Hz for $t \to -1$ kHz
Modulation distortion with	
undistorted mod. signal	$\Delta f \leq 500 \text{ kHz}$
Input for ext. signal Input requirement	BNC female connector, $Z = 600 \Omega$
Pulse modulation	external
Carrier frequency range Rise and fall times	<0.1 µs
Pulse repetition frequency Minimum pulse width	50 Hz to 50 kHz
On/off ratio	>80 dB (test bandwidth ≤10 kHz)
Input for ext. signal Input requirement	BNC female connector, Z \approx 600 Ω >2 V/<0.5 V (for on/off), max. 5 V
Blanking output	BNC female connector on rear panel TTL High on forward sweep Low on return sweep
Output for frequency- proportional voltage	BNC female connector on rear panel,
Level	$Z \approx 100 \Omega$ −10 V for f _{max} = 2500 MHz ≥10 kΩ
Remote control	for all operating modes and for data
IEC-bus interface	transfer in listener and talker functions in line with IEC 625-1,
Functions	connector: 24-way Amphenol SH1, AH1, T6, L4, SR1, RL1, PP1, DC1, DT1
Data of options	
Synchronizer SWP-B1	
	100 kHz to 2500 MHz, ∆f ≦1 MHz
Resolution Start-frequency setting Sweep width 0 to 1 MHz	1 kHz

Sweep width 0 to 1 MHz	1 kHz ≈10 kHz
Aarker frequency	

Ν

Sweep width ≦10 MHz 1 kHz >10 to 50 MHz 10 kHz >50 MHz 50 kHz

Frequency (CW) as for reference oscillator Marker-frequency error reference error $\pm 1.5 \times 10^{-3}$ of sweep width set $^{+2}_{-1}$ kHz
Sweep-width resolution
Weighting
Frequency range 0.1 to 20 MHz 25 Hz 5 Hz
>20 to 200 MHz< <100 Hz <15 Hz >200 to 2500 MHz< <250 Hz <50 Hz
Spurious responses at >200 kHz from carrier≧50 dB/≧35 dB down (0.1 to 2000 MHz/2000 to 2500 MHz)
Amplitude modulation 0 to 50% (external only) Frequency modulation ²)
FM frequency range 0.1 to 20 MHz 0.05 to 50 kHz >20 to 2500 MHz 0.05 to 20 kHz
Frequency response flatness ≦ ±2 dB referred to 1 kHz Frequency deviation 0.1 to 20 MHz
>20 to 100 MHz 0 to 5× $\frac{f (MHz)}{f_{mod} (kHz)}$ kHz, 100 kHz max.
>100 to 2500 MHz 0 to 500/fmod (kHz) kHz, 100 kHz max.
Resolution up to 10 kHz deviation 10 to 375 Hz 100 kHz deviation 0.1 to 3.75 kHz
Error
$\label{eq:undistorted ext. signal } \leq 0.5\% \mbox{ with } f_{mod} = 1 \mbox{ kHz} \\ \mbox{Pulse modulation } \mbox{ not possible with synchron. switched on } \end{cases}$

Reference Oscillator SWP-B11

Attenuator SWP-B7

Attenuation range	120 dB in 2-dB steps
Attenuation error	$\leq \pm$ (0.2 dB +1.3% of attenuation).
	1 dB max.
Typical error	\pm (0.1 dB +0.6% of attenuation).
	0.5 dB max.
Characteristic impedance	50 Ω
VSWR up to 1 GHz	≦1.2
up to 2.5 GHz	
Output level of SWP fitted	
	-110 to +10 dBm (0.7 µV to 707 mV)
with AM	-116 to +4 dBm (0.35 µV to 353 mV)
	into 50 Ω: resolution 0.1 dB

Harmonic Marker SWP-B93)

Marker spacing selectable	
via keypad	100/10/1 MHz
Marker output	≈5 V. BNC female connector
Frequency error	
	±0.2% of sweep-width setting ±2 kHz
External marker input	BNC female connector on rear panel
Level requirement	
Marker-frequency range	
. , ,	

General data

Rated temperature range	+5 to +45°C
Storage temperature range Power supply	
	47 to 63 Hz (180 VA max.) 470 mm × 162 mm × 483 mm 22 kg

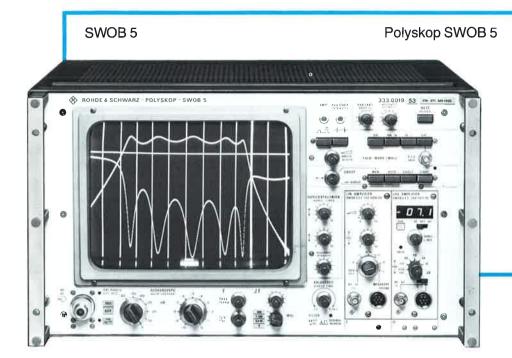
Ordering information

Order designation Sweep Generator SWP
SWP for 0.4 to 2500 MHz 339.0010.02
SWP for 0.4 to 1000 MHz 339,0010,04
Accessories supplied Power cable
Options
Synchronizer
Reference Oscillator . SWP-B11 339.9618.02
RF Attenuator SWP-B7 339.9718.02
Harmonic Marker SWP-B9 339.4716.02

¹) No marker generation is possible with external sweep.
 ²) With FM, spurious frequencies may occur at ≦300 Hz from the carrier.
 ³) With mismatch (p>0.5) and RF output levels ≧0 dBm, individual markers may drop out at sweep times <50 ms.

4 POLYSKOP

sweep testers



♦ 0.1 to 1300 MHz

- Compact sweep tester for singlechannel or dual-channel display with linear or logarithmic amplification (variable configuration)
- Wide dynamic range (75 dB) throgh low inherent noise and high output voltage
- Calibrated level line with logarithmic amplification plus two independently shiftable level lines
- Pulse or vertical-line frequency markers with crystal accuracy

Characteristics and uses

Polyskop SWOB 5 combines in a compact unit all the measuring facilities needed in an up-to-date sweep tester:

- sweep generator with an output EMF of 1 V (+6 dB if required), with output attenuator covering 70 dB;
- display section with linear or logarithmic amplifiers, with a dynamic range of 76 dB; large-size screen, marker generator, calibrated level marker and additional horizon-tal reference lines.
- The display section can be equipped with different amplifiers, see next page.

SWOB 5 is ideal for use in laboratories, test and production departments and wherever ease of operation is required together with large-screen display, high dynamic range and accurate results for either one-off tests or long series of measurements.

As the sweep width of SWOB 5 covers the whole frequency range, the frequency response of very wideband test items can be easily displayed within and even outside their service ranges.

Although wideband frequency-response and matching measurements are the most frequent applications, the very small spurious FM and high frequency stability also permit narrowband test items to be measured.

For accessories and test examples see pages 124 and 125

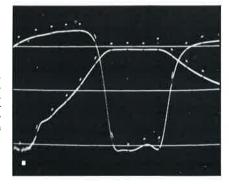
Description

The Sweep Generator delivers the swept RF in one band from 0.1 to 1000 MHz or 0.1 to 1300 MHz with model 53. Four modes can be switch-selected for sweep width:

1000 MHz	1300 MHz
5 to 1000 MHz	7 to 1300 MHz
0.3 to 50 MHz	0.3 to 50 MHz
0	0 (CW mode without sweeping and
	return blanking)

The output voltage of 0.5 into 50 Ω (for 1 V into 50 Ω by switchover on the rear) or 0.35/0.7 V for the 75- Ω model ensures an excellent dynamic range for the whole instrument. Even with the doubled output voltage the frequency response is guaranteed in the range from 5 to 300 MHz (flatness typically ± 0.25 dB, plus 0.2 dB with voltage doubling).

Reflection-coefficient and attenuation curves of 25-MHz bandpass filter with pulse frequenecy markers



The low spurious FM of typically 3 kHz allows a sharp display of steep filter slopes. Good harmonic suppression is also important when filters are to be checked without measurement errors (refer to page 125); the typical value for SWOB 5 is 40 dB.



The Display Section consists of two units:

measuring head and deflection amplifier.

Terminating probes and insertion units with different characteristic impedance and high-impedance probes are available for use as **measuring head**.

The **deflection amplifiers** are in the form of plug-in units, permitting optimum adaptation of the set to different measurement tasks and to the customer's requirements for price and performance. The following amplifier combinations are possible for linear and/or logarithmic display.

- 1. One linear amplifier (low-priced single-channel version)
- 2. Two linear amplifiers
- 3. One linear and one logarithmic amplifier
- Two logarithmic amplifiers (high comfort for most exacting requirements).

The **linear amplifier** boosts the detected voltage from the measuring head for display. It may be used wherever a display range of 20 to 30 dB and a defleciton factor of about 2 mV/cm are adequate.

The **logarithmic amplifiers** have, in conjunction with a terminating probe or insertion unit, a noise limit of typically 170 μ V, corresponding to a dynamic range of 70 dB with a sweep-generator output voltage of 0.5 V (even 76 dB is obtainable if the maximum output voltage of the sweep generator is changed to 1 V with the rear switch).

Use of the **Active Demodulator SWOB5Z4** gives a limit sensitivity of 20 μ V. With a permissible driving level of 50 mV for the Active Demodulator, the dynamic range is then about 70 dB.

Characteristics

of logarithmic amplifier plug-ins

Logarithmic Amplifier SWOB 5 E1

Range. The display range on the screen can be switched to 80/60/40/20 or 10 dB and shifted by more than 70 dB with the aid of a potentiometer. Any part of the display can thus be spread.

A shiftable **calibrated horizontal line** facilitates accurate level measurement. A ten-turn helical potentiometer permits vertical shifting with 0.1 dB resolution. The zero position can be varied with a control knob, the detent position of which corresponds to a reference level of 1 V. A lamp lights when the knob is not in this calibrated position. A filter can be switched into circuit for the observation of very small signals on the screen.

Compensation of spurious signals. Spurious signals such as may arise, for example, from the oscillator voltage of a tuner and which may limit the useful dynamic range are measured by both the linear and logarithmic amplifiers during the return sweep – while the RF is blanked – and compensated for.

Logarithmic Amplifies SWOB 5 E3

The Logarithmic Amplifier plug-in SWOB 5 E3 (photo) operates with the same wideband probes as the Logarithmic Amplifier SWOB 5 E1, namely: demodulator, insertion unit, logarithmic probe or active demodulator.



Front panel of Logarithmic Amplifier plug-in SWOB 5 E3

The **dynamic characteristics** – maximum input voltage 1 V, typical noise level 170 μ V – make for a dynamic range of 76 dB. The display range can be switch-selected for 100, 80, 50, 20 or 10 dB. The horizontal graticule of the SWOB 5 screen thus provides scales of 10, 8, 5, 2 and 1 dB/div. A positioning potentiometer allows shifting of the display over more than 70 dB, so any detail of the display curve may be spread.

The main advantages of this plug-in are:

- AF input for the connection of test item with a built-in rectifier,
- digital level indication,
- automatic setting of reference levels,
- signalling of excessive spurious levels,
- gain of active demodulator taken into account in level measurements.

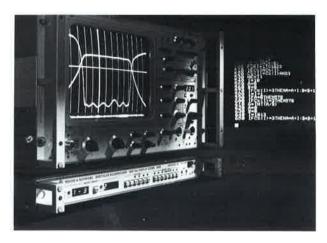
The characteristics when using the **AF input** are the same as for operation with an RF probe: maximum test voltage 1 V, noise level 170 μ V, dynamic range 76 dB, display range 100, 80, 50, 20 or 10 dB and vertical-positioning range greater than 70 dB. Positive or negative polarity can be selected with a switch.



Polyskop SWOB 5 – Log. amplifier

Logarithmic Amplifier SWOB 5 E3 (continued)

With the aid of a horizontal line, which is calibrated in level and can be shifted through about 100 dB with a frontpanel potentiometer, the level can be accurately measured at any point of the curve.



Filter characteristics (transmission/reflection) and level line on Polyskop SWOB 5 with plug-in E3 and Digital Disptay Store BDS

It is also possible to set the reference level by removing the test item and connecting the measuring head directly to the RF output of the Polyskop. If the reference line is shifted to make it coincide with the display line and the "0 dB" button is pressed, the dispay is calibrated with reference to the sweep-generator output level.

To prevent measuring errors being introduced by superposed **spurious signals** a **pilot lamp** is provided on the amplifier plug-in. A spurious signal is produced when the RF probe connector is used, for example in tuner measurements, through the local-oscillator reradiation that is practically always present; its maximum permissible level is 40 mV (4 mV with an active demodulator). Superposed DC of as much as \pm 6 V is permissible at the AF input. The spurious voltage is measured during the return sweep and the pilot lamp lights whenever the permissible limits are exceeded.

If an **active demodulator** is connected to the amplifier plugin, the calibrated level line is automatically lifted by 20 dB (gain of active demodulator), so in absolute measurements the level actually present at the input of the active demodulator is displayed. The noise level with the active demodulator is about 20 μ V or -94 dBV. Since the calibrated level line covers a range of about 100 dB (0 to -100 dBV) this level can be measured accurately.

Level indications on the log. amplifier is in $3\frac{1}{2}$ digits. The measured value can be indicated as an absolute value in dBV or mV or as a relative value in dB.

Autoranging is provided for **absolute measurements** in mV, the display ranges being 20, 200 and 2000 mV. The resolution of the digital display is 10 μ V, 100 μ V or 1 mV depending on the voltage range, or 0.1 dB for dBV or dB indication.

The **reference level for relative measurements** can be set at any point between 0 and -100 dBV. For this purpose the level switch is set to "dB", the calibrated level line adjusted to the desired position and the "0 dB" button pressed. The digital display is thus set automatically to 0 dB and when the level line is shifted the measured level is indicated in $\pm dB$ referred to the reference level. It is of course possible, by changing the level-switch position, to display the absolute level again whilst retaining the reference-level setting.

The automatic setting of the reference-level display is very expedient in transmission-factor measurements: the level line is adjusted to the input level of the test item.

The level switch is set to "dBV" and the level line adjusted to this reference value, then the level switch changed to "dB" and the "0 dB" button pressed. The level line can now be adjusted to the point of the displayed curve where the transmission factor is to be determined, for instance the maximum of a "ilter characteristic. The gain or attenuation of the test item is then read out in dB.

The **display** of the results is obtained on a long-persistence screen. The screen size of $21 \text{ cm} \times 16 \text{ cm}$ enables unstrained working. Four level lines (configuration with two amplifiers) and crystal-controlled vertical-line markers yield a coordinate grid of excellent clarity.

Frquency markers. Pulse or vertical-line markers provide a scale on the frequency axis with the decades identified by higher intensity; see illustration on page 132. A bright bar at the lower edge of the screen marks the adjusted sweep range on a scale.

IF markers option. An IF marker generator is available for measurements on TV tuners; see specifications under recommended extras. This option permits IF markers for the vision and sound carriers to be generated and to be displayed in addition to the other markers.

A recorder output with pen-lift contact and the possibility of triggering a counter connected at the rear by means of a manually adjustable brightup marker complete the outstanding measuring capabilities of SWOB 5.

POLYSKOP 4

Digital Display Store BDS

The **Digital Display Store BDS** – described in detail on page 138 – yields a flicker-free display even with slow sweep times and considerably extends the applications of the sweep tester thanks to a number of additional functions. The characteristic features of the BDS are:

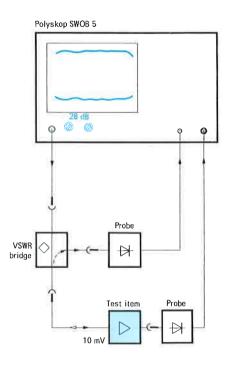
- display of slow sweeps as a stationary pattern
- four independent memories
- combination of contents of any memory by addition or subtraction
- insertion of additional frequency markers
- IEC-bus capability with option

Moreover, an additional option to the Digital Display Store permits noise suppression by taking the average over several sweeps.

The Digital Display Store is an ideal extension for the Polyskop SWOB 5 and especially designed for use with this instrument. The flat, 78-mm high unit as a bottom or top addon has the same width and depth as the SWOB 5 and is connected to the Polyskop via a 36-way female connector strip.

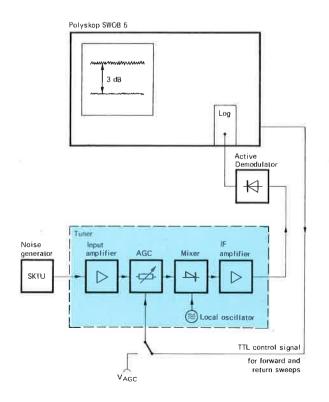
For operation of the SWOB 5 in conjunction with the BDS, the Display-store Interface Option SWOB5B6 is required (Order No. 333.5410.02). Instruments from Serial No. 871551 on are ready for the interface to be fitted.

Task. Measurement of amplitude/frequency response and matching on active broadband test items, such as cable-TV and antenna amplifiers.

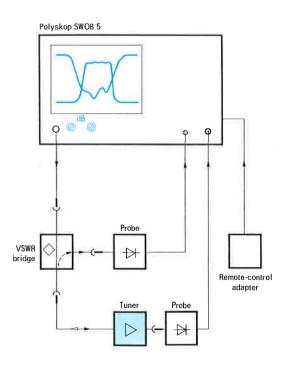


Examples

Task. Measurement of noise characteristics of TV tuners.



Task. Measurement of amplitude/frequency response and matching on TV tuners using automatic sweep-width adjustment.





Polyskop SWOB 5 –	- Specifications
Specifications of SWOE	5
(Values in parentheses are	e valid for model 53)
	 0.1 to 1000 MHz (0.1 to 1300 MHz) (in one band; only centre frequency and sweep width need be adjusted)
5-1000 (7-1300)	four ranges full frequency range variable:
0.3-50	5 to 1000 MH2 (7 to 1300 MHz)
0 Spurious FM (NARROW)	
Sweep linearity	better than 1 : 1.1 Δf and centre frequency (coarse/fine)
external	via remote-control input ±3% of fs
Centre-frequency adjustment Sweep-width adjustment (ext. potentiometer $\approx 5 \text{ k}\Omega$)	0 Ω for Δf_{min} , R_{max} for Δf_{max}
Sweep time	 0 to 5 V for 2 to 0.02 s 50 mV into 50 Ω BNC female connector on rear
Output EMF	
	(can be increased by 6 dB rear switch)
Connector Frequency-response flatness of output voltage with match- termination	. N female - < ±0.5 dB (typ. ±0.25 dB)
	for 0.1 to 1000 MHz (0.1 to 1300 MHz),
with 6-dB increase .	<0.15 dB for 10 MHz sweep ±0.2 dB in addition
Output attenuator Error coarse (10-dB steps) fine (1-dB steps) Harmonics (for EMF = 1 V or 0.7	$ \begin{array}{l} (5 \text{ to } 300 \text{ MHz}, \text{ otherwise } +1 \text{ dB}) \\ . \text{ 0 to } 70 \text{ dB in 1-dB steps} \\ . \leq \pm 0.5 \text{ dB} \\ . \leq \pm 0.2 \text{ dB} \end{array} \right\} \text{ overall error} $
0.1 to 1 MHz	v) ≧30 dB down
(0.5 to 1300 MHz) Non-harmonic spurious signals 0.1 to 1000 MHz	
up to 1300 MHz	
Frequency sweep Mode AUTO	. forward/return with RF blanked dur-
MAN	ing return manual sweep adjustment triggered by button or external trigger
Sweep time AUTO	
SINGLE	continuously adjustable
Triggering Ext_trigger level	$_{\star}$ \approx +5 V (at rear input)
external.	100 MHz; 100/10 MHz; 10/1 MHz; error < ±1 × 10 ⁻⁴ 1 to 1300 MHz, ≈ 0.2 V (50 Ω)
Marker type Oriented along frequency axis (internal)	pulse and vertical-line markers
Brightup marker Trigger signal for counter	ulated to highlight the decades by MAN adjustment in AUTO mode
Level lines	 two; separate adjustment of vertical position; common adjustment of intensity
Useful display area	
Recorder output	
Connector	$R_{out} = 5 k\Omega$ 6-pole female (1 channel) or BNC female (2 channels)
¹) Spurious markers may appear w (rear switch on +6 dB setting).	ith increased output level

External X deflection	±1 V (symmetri	cal about zero)
	for full display w rising edge:	
	forward 0.02 t	o 2 s,
Connector	falling edge: return 0.01 to	
Connector	7-pole female of	riear
Amplifier plug-ins		
Logarithmic Amplifier SWO	B5 E1	
Measurement range	10/00/10/00/00	
(full display height)	10/20/40/60/80) dB
(with Demodulator SWOB5 Z1 or RF Insertion Unit SWOB5 Z3)	typ. 170 μV (with	h filter)
Max. test voltage Display adjustment range	1 V (with SWOE >70 dB	35 Z1 or Z3)
Level line, calibrated in dB Reference level	shiftable by -12	dB; detent position
Adjustment range	calibrated at 1 V 0 to $< -100 \text{ dB}$	/ = 0 dB , resolution 0.1 dB
Error limits Lowpass filter	tvp. +1.5 dB (wi	th SWOB5 Z1 or Z3)
3-dB point	≈ 40 Hz	
Connector for measuring head	25 mV RF (2.5 m ulator)	V with active demod-
Logarithmic Amplifier SWOI	B5 E3	
Inputs		eas. head
Input impedance	≈100 kΩ su	itable for
	SV	easuring heads WOB5 Z1, Z2, Z3 Z4
Measurement using Demodulator SWOB5 Z1 or		
RF Insertion Unit SWOB5 Z3		
Measurement range Display adjustment range	>70 dB	00 dB
Noise level	typ. 170 μV typ. ±1.5 dB	
Max. test voltage	1 V (measuring-	head RF input)
Measurement via AF Input Measurement range		
(full display height)	>70 dB	00 dB
Noise level	tvp. 170 μV	(//Ab _60 dB
Max. test voltage	1 V	
Level line calibrated in mV,		
dBV and dB		
Adjustment range, absolute measurement		100 to 0 dBV
Level indication	31/2 digits	
Voltage indication range Resolution	20 mV 200 mV 10 µV 100 µV	/ 2000 mV 1 mV
dBV and dB ranges Resolution .	>100 dB 0.1 dB	
Indication error	0.1 dB or 2% ±	
Lowpass filter	indicated	on basic unit,
3-dB point		
Compensation of spurious signals		
	±6 V	
	±6 V	Meas. head 40 mV RF (4 mV with Active Demodulator)
A pilot lamp lights when the spuriou		(4 mV with Active Demodulator)
	is level exceeds t	(4 mV with Active Demodulator)
A pilot lamp lights when the spuriou	is level exceeds t	(4 mV with Active Demodulator)
A pilot lamp lights when the spuriou Linear Amplifier SWOB5 E2 Inputs	is level exceeds ti 2 . AF²) . 500 kQ	(4 mV with Active Demodulator) he permissible limit. Meas. head connector 500 kQ
A pilot lamp lights when the spuriou Linear Amplifier SWOB5 E2 Inputs	s level exceeds t 2 . AF²) . 500 kΩ . BNC female	(4 mV with Active Demodulator) he permissible limit. Meas. head connector 500 kΩ 7-pole female
A pilot lamp lights when the spuriou Linear Amplifier SWOB5 E2 Inputs	s level exceeds t 2 . AF²) . 500 kΩ . BNC female	(4 mV with Active Demodulator) he permissible limit. Meas. head connector 500 kΩ 7-pole female =/≈ (compensation
A pilot lamp lights when the spuriou Linear Amplifier SWOB5 E2 Inputs Input impedance Connector Input selector positions	is level exceeds the second s	(4 mV with Active Demodulator) he permissible limit. Meas. head connector 500 kΩ 7-pole female =/~
A pilot lamp lights when the spuriou Linear Amplifier SWOB5 E2 Inputs	is level exceeds the second s	(4 mV with Active Demodulator) he permissible limit. Meas. head connector 500 k Ω 7-pole female = $/\approx$ (compensation for spurious RF
A pilot lamp lights when the spuriou Linear Amplifier SWOB5 E2 Inputs Input impedance Connector Input selector positions	s level exceeds the second s	(4 mV with Active Demodulator) he permissible limit. Meas. head connector 500 kΩ 7-pole female = /≈ (compensation for spurious RF signals in test item) <15 mV
A pilot lamp lights when the spuriou Linear Amplifier SWOB5 E2 Inputs Input impedance Connector Input selector positions	s level exceeds the second s	(4 mV with Active Demodulator) he permissible limit. Meas. head connector 500 kΩ 7-pole female = /≈ (compensation for spurious RF signals in test item)

²) Connector for probe or test item containing a demodulator.



Measuring heads	
Demodulator SWOB5 Z1 (with built-in termination)	
Immediance 50.0 75	Ω
Connector N male N	male
Frequency range	
VSWR≦1.1 ≦ up to 1000 MHz	1.1
≦1.2 up to 1300 MH	z
Frequency-response	±0.5 dB
tvp. +0.25 dB tv	
0 1 to 1300 MHz ≦1 dB	
Max test voltage, rms	10 V DC
Max. test voltage, rms	1 m) and 7-pole
male conn	ector
RF Insertion Unit SWOB5 Z3	
	5Ω
Connector N male N Frequency range 0.1 to 1300 MHz 0	male
VSWR≦115 ≦	1.25
up to 1000 MHz	
≦1.3 up to 1300 MH: Frequency response	Z
flatness 0.4 to 1000 MHz $\leq \pm 0.5$ dB $\leq typ. \pm 0.25$ dB ty	±0.5 dB
typ. ±0.25 dB ty 0.1 to 1300 MHz≦1 dB	p. ±0.25 dB
Max test voltage rms 1 V	
Max. permissible input voltage 5 V AC or Connection to lin/log amplifier via cable (10 V DC
Connection to lin/log amplifier via cable (1 m) and 7-pole
male conn	ector
Log. Probe SWOB5 Z2	
Impedance (depending on frequency and attenuator)	
$\begin{array}{llllllllllllllllllllllllllllllllllll$	∏ 0.5 t0 2.5 pr Z
(rough indication up Frequency response flatness < ±1 dB	to 1300 MHz)
Attenuation of probe tips $0/20/40 \text{ dB}$	
Input voltage range 0.2 mV to 1 V/2 mV	' to 10 V/
20 mV to 100 V (rm: Input circuitunbalanced, non-floa	s)
Demodulator SWOB3-Z (probe with BNC male connect	or)
Frequency range 0.5 to 400 MHz (rough indication up	to 1300 MHz)
Indul Indedadce	
at 50 MHz≧30 kΩ 2 to 3 p	F
at 200 MHz ≧10 kΩ Input voltage min 50 mV for full c	tisplay height.
max permissible 5	V RF,
max. permissible 5 ¹ superimposed DC u Output signal ³)	p to 100 V
for 50 mV _{ms} (0.5 to	400 MHz)
Active Demodulator (50 or 75 Ω depending on model)	
Input voltage range $\dots \dots \dots$	
Frequency-response flatness $\leq \pm 2$ dB for 5 to 13	800 MHz
Input VSWR ↓ ≦1.3	
Specifications of recommended extras	
VSWR Bridge SWOB4-Z 50 or 75 Ω	ZRB 50 Ω
Frequency range	5 to 2000 MHz
Test-item connector N male	N female
RF input N female Output to detector . N female	N female N female
Directivity≧40 dB	≧46 dB
Insertion loss ≈6.5 dB	≈6.5 dB
Overvoltage Protection (for RF input or output)	
Response threshold	
Switching time≦3 ms	
Digital Display Store see next page	

Digital Display Store see next page

Extension (options)

(mounting with electrical connections via irreversible connectors of basic unit)

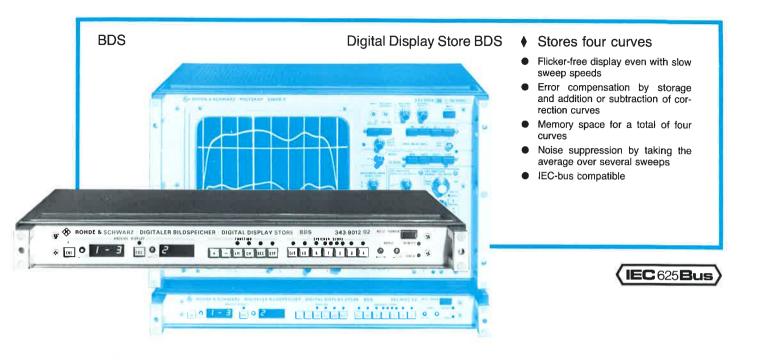
External Control SWOB5 B1

Switchover int./ext. via slide switch: lamp lights in ext. mode
Input
Voltage adjustment 0.1 to 0.5 V, continuous
Slow Sweep
X voltage ±2 V for max. deflection Y voltage 1 V for max. deflection
Sweep time
Connectors

IF Markers SWOB5 B3/B4	
Input Frequency range	0.5 to 150 MHz
Input impedance VSWR	50 Ω
with lowpass filter	≦1.3 in range 5 to 150 MHz
display	
Max. permissible input voltage	5 to 150 MHz), max 200 mV 5 V AC or 10 V DC
Number of markers	lators
Marker frequencies	33.4 MHz, 38.9 MHz 2 × 10 ⁻⁵
Display-store Interface	
	required for operation of SWOB5 with BDS; units from serial No. 871 551 on
Connector	are prepared for retrofitting 50-pole female,
	suitable for connection of BDS
General data	
Rated temperature range	05 4- 10080
Power supply	$110/125/220/235 \text{ V} \pm 10\%$,
Dimensions, weight	-25 to +60 C 110/125/220/235 V ±10%, 47 to 63 Hz (180 VA) 484 mm×294 mm×436 mm, 25 kg
Ordering information	
	Polyskon SWOR5
Order designation SWOB5, without amplifier plug-ins:	
50-Ω model, 0.1 to 1000 MHz 50-Ω model, 0.1 to 1300 MHz 75-Ω model, 0.1 to 1000 MHz	333.0019.52 333.0019.53
75-Ω model, 0.1 to 1000 MHz	333.0019.72
Amplifier plug-ins:	333.5610.02
Log. Amplifier SWOB5 E1 . Log. Amplifier SWOB5 E3 . Lin. Amplifier SWOB5 E2	349.3512.02
Measuring heads:	333.5010.02
Demodulator SWOB5 Z1	000 7540 50
50-Ω model 75-Ω model	
RF Insertion Unit SWOB5 Z3 50-Ω model	000.0040.50
50-Ω model	
Log. Probe	333.9016.02
Active Demodulator SWOB5 74	
50-Ω model	
Accessories supplied	power cable
Recommended extras and extens	ions (options)
VSWR Bridge SWOB4-Z 50-Ω model	. 912.7003.00
75-Ω model VSWR Bridge ZRB	912 7303 00
Overvoltage Protection SWOB5-Z5	
Recorder Adapter	
Cable SWOB4-Z Recorder Adapter	
Cable SWOB4-Z RF connecting cable	
(1 m, 50 Ω, N male conn.) (1 m, 75 Ω, N male conn.)	100.7670.10 100.7687.10
Extensions (options)	
External Control Option SWOB5 B1 . Slow Sweep Option SWOB5 B2 .	333.6700.02
	333.9616.02
IF Markers Option Motherboard SWOB5 B3	333.9716.02
additionally required:	
Crystal Oscillator SWOB5 B4 33.4 MHz and 38.9 MHz	. 333.9916.30
Accessories	040 0040 00
Digital Display Store BDS Display-store Interface SWOB5 B6 .	. 343.8012.02
Interface SWOB5 B6 . IEC-bus Interface BDS-B4	333.5410.02 . 343.9602.02
Average-value Mernory	
Basic Software for control	
of BDS/SWOB5 via Process Controller	
PUC BDS-K1	358.1919.02
³) Non-linear signal characteristic:	up to ≈30 mV (V _{RF}) squarewave,
from $\approx 0.5 \text{ V}$ (V _{RF}) linear.	

4 DISPLAY STORE

sweep testers



Characteristics, uses

In conjunction with Polyskop SWOB 5, the **Digital Display Store BDS** permits simultaneous, flicker-free display of two curves plus the associated frequency markers, level lines and frequency range. The 1024-point horizontal and 256point vertical resolution of the pattern yields an accurate representation of the original curve.

Moreover, the Digital Display Store offers a number of functions which considerably extend the applications of the Polyskop SWOB 5.

Memory space. In addition to the two curves represented as a flicker-free pattern, two further curves can be saved in additional memories. But data can also be stored in the buffer memories used for displaying the instantaneous values measured, so that a total of four curves can be stored.

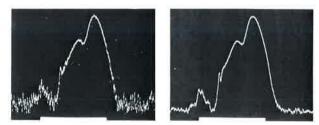
A built-in battery ensures that the stored data are maintained even in the case of AC supply failure or after the Digital Display Store has been switched off.

Modes. Both channels permit the sum or difference of any two memory contents to be displayed; thus **error correction** and displaying the **drift from nominal** are possible.

Additional frequency markers. An additional memory permits markers to be inserted at any position in addition to the SWOB 5 frequency marker graticule; in this way, frequencies which are of special interest can be highlighted, for instance.

Recording. The stored curves can be output via a built-in interface directly to an XY recorder. In this mode, the sweep time increases to about 60 seconds.

Noise suppression. To complement the basic version of the BDS, an option is available permitting the average to be taken over 4, 8 or 16 successive sweeps. Thus random interference on the sweep curve, e.g. noise, can be suppressed to a large extent.



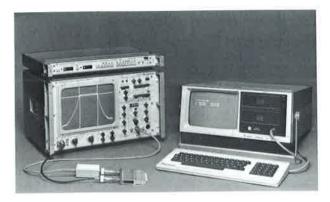
Frequency response display: (left) signal with heavy noise component and (right) after taking the average over successive sweep with the corresponding BDS option

Computer-aided evaluation of sweep curves on Polyskop SWOB 5

The IEC-bus Interface Option BDS-B4 enables not only the transfer of all stored data but also problem-free computeraided evaluation of the results on the sweep system SWOB 5 using for instance the R&S Process Controller PUC. The advantages of using a computer become most evident where previously lengthy manual settings or calculations were required. Via the bidirectional data interface (IEC bus) of the BDS the resulting curves and markers can be directly displayed on the Polyskop screen.

Measurement examples. The position of any frequency markers or level lines can be easily and accurately calculated and output on the PUC; on the other hand markers and lines can be superimposed on the Polyskop screen at exactly defined positions.

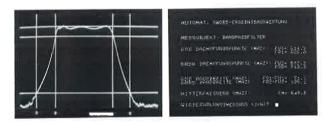




Computer-aided sweep test assembly with Polyskop SWOB 5, Digital Display Store BDS and Process Controller PUC

For measurements on amplifiers and filters, criteria like the **3-dB point** can automatically be selected from the measured data, the associated frequencies be recorded and the corresponding markers be superimposed on the screen.

It is not only possible to evaluate individual measuring points numerically, but to convert **complete curves into any other waveform** and output it again, for example if the VSWR is to be determined from the measured return loss or if a frequency axis with linear scale is to be converted into one with logarithmic scale.



Measured curve with additionally superimposed frequency markers and level lines as well as displaying on PUC

BDS software. In order to relieve the user from lengthy programming, a BDS software BDS-K1 has been prepared. It offers a great number of applications in the form of single routines which are mostly independent of each other. These routines can be combined by means of a few program steps for the evaluation of whole test sequences; this evaluation can be made very rapidly since most of the subroutines are written in machine language.

Description

The analog signal corresponding to the test voltage (Y axis) on the Polyskop is converted in the BDS into digital signals of 8-bit word lenght. 1024 addresses are available on the X axis for this purpose; they can be processed completely in about 20 ms. Four 8-kbit CMOS memory chips enable the separate storage of four different curves. Additional CMOS memories preserve the information on frequency markers, frequency range and level lines. The low current drain of the CMOS RAMs permits the data to be stored for extended periods with the aid of dry cells. The overall function of the unit is controlled by a clock system with a fundamental frequency of about 600 kHz.

The nucleus of the Average-value Memory Option is a 12-bit adder and a 12-bit memory, where the intermediate results and finally the result of a maximum of 16 sweeps are temporarily stored. The function of the IEC-bus Interface Option calls for its use as a listener and as a talker.

Specifications	
Specifications	
Screen	
Display refresh time	approx. 20 ms
Resolution: horizontal	1024 points
vertikal	
Inputs	36-way female connector
X input	., Z _{in} >100 kΩ,
	deflection voltage positive-going; max. amplitude 10 V
	position of starting point
Minaut	can be set between -10 and 0 V
Y input	Z _{in} >100 kΩ, V _{in} : nominal 0 to 2.5 V,
	maximum voltage
Trigger input	adjustable from 2 to 3 V
Frequency-marker	
and level-line inputs	SWOB 5 compatible
Outputs	36-way female connector
Youtput	$Z_{out} <1 k\Omega$ output corresponds $Z_{out} <1 k\Omega$ to input voltage
Trigger output	TTL low triggers forward sweep
Frequency-marker	
and level-line outputs	SWOB 5 compatible
Recorder outputs	
Voutput	$Z_{out} < 1 \ k\Omega$ output
Y output for level reference line	$Z_{out} < 1 \text{ k}\Omega$ $Z_{out} < 3 \text{ k}\Omega$ $Z_{out} < 1 \text{ k}\Omega$ $Z_{out} < 1 \text{ k}\Omega$
with AF signal	connectors: BNC female
Pen lift	connector on rear panel
Curve display and storage	
Number of curves displayed simultaneously	2
saved	. 2 (can be expanded to 4)
in intermediate storage total storable	4
Storage without AC supply voltage	max. 6 months depending on charge
	remaining in internal dry batteries, state-of-charge check provided
Functions	a) addition and subtraction of contents of two memories
	b) insertion of additional
	frequency markers
	c) slow sweep in chart recording mode (approx. 60 s)
with option	averaging over 4, 8 or 16 sweeps to
IEC-bus connector	reduce noise component interface in accordance with
	IEC 625-1,
Interface functions	24-way Amphenol connector AH1, SH1, L4, T8, DC1
Interface functions	A. A. B.
General data	
Operating temperature range Storage temperature range	-40 to +70°C
Power supply	100/120/220/240 V ±10%
	47 to 63 Hz (20 VA) 492 mm×78 mm×383 mm
Weight	
Ordering information	
Order designation	► Digital Display Store BDS
	343.8012.02
Accessories supplied	power cord
Extensions (options)	
IEC-bus Interface BDS-B4	343.9602.02
Average-value Memory BDS-B5	
Display-store interface SWOB5-E Basic Software BDS-K1	36 333.5410.02
Basic Sonware BDS-K1	330.1919.02



network analyzers

Characteristic features of a network analysis system

With the aid of network analysis the response of a test item with respect to reflection and transmission (transmission factor and attenuation ratio) can be investigated. In the RF range this is usually made by measurement of complex voltages, in particular of the s-parameters. At lower frequencies – especially in the AF range – a current-voltage measurement is however also possilbe.

System design

A network analysis system is made up of four components:

generator, receiver, display unit and accessories.

In addition there is often the possibility of controlling all functions of the network analyzer via a process controller, e.g. via the IEC-bus data interface. This **further component** is not absolutely necessary, but has gained an increasing importance in the past years since the requirements are for a greater number of test parameter evaluations with higher accuracy (see three-point error correction) but shorter measuring times.

System generator. Depending on the particular application, either a sweep generator or a synthesizer/signal generator is used as generator in the system. The advantage of a sweeper is that a wide frequency range can be swept through within a short time (e.g. a range of 1 GHz in 100 ms), with continuously varying output signal and the test item not requiring time for settling upon every change of frequency. The deviation from the absolute frequency accuracy (a few MHz for sweepers operating in the GHz range) and the relatively high spurious FM of a few kHz do not however allow measurements on narrowband test items such as crystal filters. Therefore, synthesizers are used in such cases which feature very high frequency accuracy and stability, but a spurious FM in the Hz range. Their disadvantage is however that there is no continuous frequency change and that they require longer settling times then the sweeper. In automatic systems synthesizers are preferably used for point-to-point measurement.

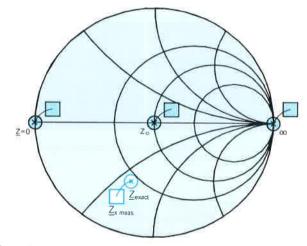
Sweeper and synthesizer in one unit. The Sweep Generator SWP introduced by Rohde & Schwarz in April 1982 combines the advantages of a sweeper and a synthesizer in one unit to the latest standard (frequency range 0.1 to 2500 MHz, see also page 126). Now continuous sweeping of both narrowband and broadband test items is possible with just one generator. **Receiver.** Broadband demodulators, which are for instance used in scalar network analyzers (SWOB 5), are not suitable for measuring the network parameters by magnitude **and phase.** Therefore **tracking receivers** and receivers operating on the sampling principle are used. Both types of receiver carry out selective measurements with small bandwidth and usually have a lower sensitivity limit of 1 μ V which corresponds to a dynamic range of about 120 dB referred to 1 V.

Display unit. A screen, pointer instrument, LED, recorder, plotter or similar can be used.

The accessories of the system are also significant for the measurement; they include directional couplers and VSWR bridges (see page 152) as well as an adapter for the test item.

Reflections on accuracy

Three-point error correction is employed to eliminate errors caused by the test setup as far as possible. According to this method the **shortcircuit** ($\underline{Z} = 0$), matching (Z_0) and **opencircuit** (∞) are measured at a certain frequency f_1 by the network analyzer (see following diagram) and are transformed in an external computer into the ideal values plotted on the horizontal axis of the Smith chart. When connecting now an unknown test item to the test setup and transforming the measured value (Z_x meas) as before, the accurate impedance value ($Z_{accurate}$) of the test item is obtained.



Three-point error correction at frequency f_1 \Box =measured values, \otimes =transformed values

The error in measurement is only about 1% referred to the reflection coefficient even on the outer circle of the Smith chart. Additional errors caused by inaccurate frequency setting of the generator can be largely avoided by using a synthesizer. For more than one test frequency calibration routines must be available for each further frequency.

The **advantages of the three-point error correction** are convincing:

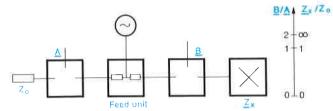
- improvement of accuracy (see above),
- error correction referring to complete test setup, including calibration of adapters and cables between directional couplers or VSWR bridges and test item,
- measurement even possible in coaxial systems of different standard (e.g. measurement on an item using 75-Ω system with a 50-Ω network analyzer).

network analyzers

Reflection measurement without bridges and couplers

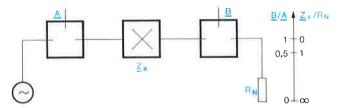
Even when using the three-point error correction, the network analyzer cannot differentiate between impedance values from 10 k Ω to ∞ due to the residual error of about 1% on the outer circle.

The following diagram shows the simplest method of reflection measurement without VSWR bridge or direction coupler. As can be seen from the nomogram, a small error in the measurement of the voltage ratio $\underline{B}/\underline{A}$ entails a great error in the measurement of Z_x at high impedances ($\gg Z_o$). There is no network analyzer whatsoever on the market which could employ this method for high impedances.



Result from $\underline{B}/\underline{A}$ ratio measurement as a function of impedance \underline{Z}_x (in reflection measurement)

If the network analyzer is however also able to operate on the voltage division principle (see diagram below) and to convert the measured values into impedances, measurement in the $M\Omega$ range is also possible.



Result from $\underline{B}/\underline{A}$ ratio measurement as a function of impedance \underline{Z}_x (when using voltage division principle)

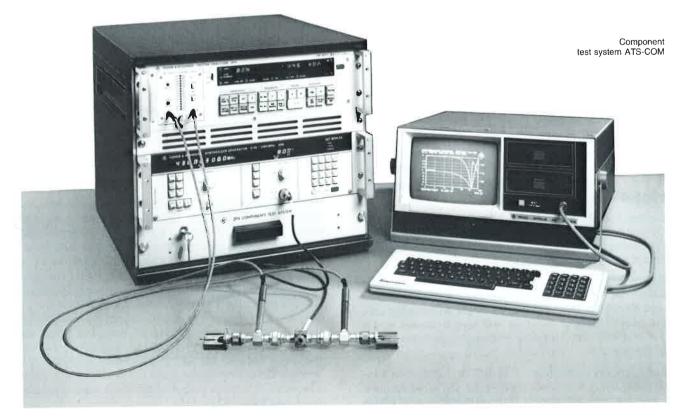
Applications

From the great number of possible applications of network analyzers the measurement on components such as RF chokes and capacitors is to be dealt with in greater detail.

In practical operation it is for instance necessary to measure a capacitor with respect to its C and tan δ values at its intended operating frequency. The VSWR bridges available on the market only allow a measurement below 10 MHz; this does not directly give a clue to the RF response of the capacitor.

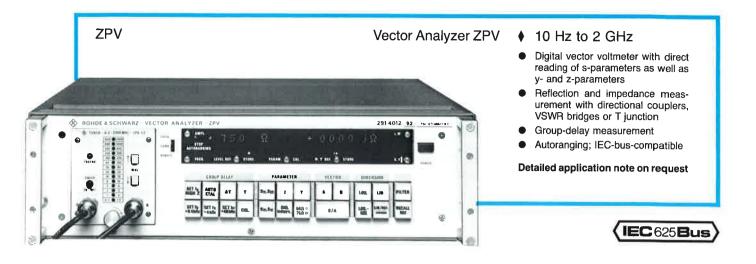
A network analyzer system made up of the Synthesizer Generator XPC (page 58), the Vector Analyzer ZPV (page 142) and the Process Controller PUC (page 14) enables measurements of R, L, C, Q and tanð up to 1 GHz. The error for tanð values of 10^{-4} is about 15%. The same applies to measurements on RF chokes with respect to self-inductance, self-resonant frequency and quality at a certain test frequency. This measurement is based on an analysis of parallel-resonant circuits.

The measuring system as shown on the photo below can be supplied by Rohde & Schwarz including the software. The test assembly is also suitable for measurements on crystals (to IEC 444) and diodes.



4 VECTOR ANALYZERS

network analyzers



Characteristics and uses

The **Vector Analyzer ZPV** implements a novel technique for the measurement of complex quantities. Its functional principle is that of a dual-channel vector voltmeter measuring amplitude and phase. As in conventional vector voltmeters, the frequency is synchronized in the reference channel, so that a selective measurement is performed at one frequency.

Combined with a **microprocessor**, the ZPV decisively simplifies all complex measurement procedures. All functions are fully automated and the required value is read out directly on the display. Thus the ZPV surpasses conventional analog vector voltmeters in operating convenience and display possibilities. Its typical applications are control engineering, crystal, antenna, amplifier and filter measurements.

The ZPV is equipped for voltage measurements by magnitude and phase. Automated measurement of twoport parameters and of group delay is additionally possible.

Using different tuners (see next page) and the appropriate measuring facilities (directional couplers, etc., see recommended extras on page 152) the Vector Analyzer can be fittet to meet the user's specific requirements with respect to frequency range and test method.

Display possibilities. The two digital readouts of the ZPV indicate both components of the measured complex quantity. The display can be in cartesian or polar coordinates, linear, logarithmic, absolute or relative.

Autoranging. Range selection is fully automatic due to the built-in microprocessor so that the measured value can be read off directly after selecting the mode and physical unit. For swept-frequency operation and special display modes the amplitude and frequency autoranging facilities can be disconnected.

Automatically tuned filter. The ZPV incorporates an automatically tuned filter which provides for stable indication of noise-corrupted test signals. The microprocessor analyzes the stability of the signal and determines the time constant required for fluctuation-free display of the result.

Calibration at the push of a button. For complex measurements a reference plane has to be defined. This is done in the ZPV at the push of a button, determining phase zero, magnitude = unity and reference characteristic impedance. These values are stored in the built-in microprocessor and maintained even when changing the test mode so that new calibration is required only if the test setup is modified.

Swept-frequency operation, recorder outputs. Control voltages monitored by the microprocessor ensure that highprecision signals are always available at the X and Y outputs. Transient response of the synchronization stage due to sampling is suppressed. Consequently the Vector Analyzer ZPV can also be used in swept-frequency operation; however, the sweep rate of the ZPV, which is slow compared with sweeper display units, has to be considered. The test results obtained in swept-frequency checkouts can be plotted on a recorder or displayed on a storage oscilloscope up to a dynamic range of 110 dB. For narrowband sweeping, for instance in crystal testing, additional special outputs are available.

System compatibility. All functions of the Vector Analyzer are fully programmable. The IEC bus permits both settig of all modes on the instrument and outputting of all test results. Various methods of data transfer ensure optimum data transmission speed. In addition to the separate output of real and imaginary components or magnitude and phase, the complete complex quantity can be transmitted as one data word. The readout is either dependent on the measurement time or independent of time so that optimum use of the measuremet speed is made. Manually selected modes can be output via the IEC bus. Comprehensive software packages are available for instance for the R&S Process Controller PUC, the Tektronix Computing System 4051 or the HP Desktop Computer 9835, to facilitate programming of automatic measurements; see page 152.

VECTOR ANALYZERS 4

Vector measurement

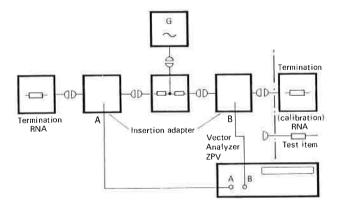
In this mode the ZPV measures the voltages in channels A and B and indicates them in absolute mV or dBm values and relative to any presettable reference value in dB. Simultaneously the phase difference between channels A and B is read out. The voltage ratio between the two channels can be indicated linearly and logarithmically – in absolute or relative values – or with its real and imaginary components.

Two-port measurement

The s-parameters, impedance and admittance values can be read out on the digital ZPV display either in cartesian or in polar coordinates. Impedance and admittance are indicated both in absolute values and normalized to the characteristic impedance, the reference being either 50 or 75 Ω . The ZPV permits impedance calculation for test setups based on the voltage measurement method. High impedances can be measured by the voltage-divider method with all tuner plugins. The type used is entered with the aid of a pushbutton.

The **s-parameters** are read out linearly or logarithmically. Direct indication of the VSWR is also possible. The reference plane is defined at the push of a button, the reference phase and amplitude being automatically stored in the ZPV. The **s-parameter accuracy-improvement software** available for the recommended computers permits extremely accurate transmission and reflection measurements with respect to reference values; see page 148.

For two-ports in the range <100 MHz the voltage measurement method can be used (see figure below) whereas use of an impedance-match bridge or directional couplers is to be preferred at higher frequencies (>100 MHz) because of the increased accuracy.



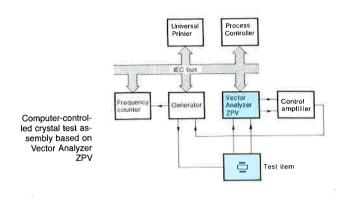
Two-port measurement based on the voltage method

Group-delay measurement

Combined with an FSK generator the ZPV can be used to mesure group delay with high resolution (typ. 1 ns). From the phase variation resulting from the frequency shift, the equipment calculates the group delay and gives a direct readout in nanoseconds. An automatic calibration routine calibrates the frequency shift of the signal generator.

Measurement of crystal equivalent-circuit parameters

Furthermore, the ZPV permits all crystal data to be determined within seconds. Together with a Z measurement the resonant impedance can be displayed without the use of an external computer.



Description (modes)

The ZPV is of modular construction; the tuner is therefore exchangeable.

ZPV-E3 . 6 ZPV-E2 G G **7PV-E1** TURER IDHE - 60 MHE ZPY-EI ٦ 0 Exchangeable 10.18 tuners for ZPV witz P 1011T

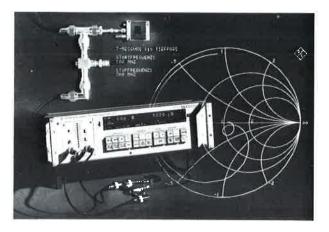
Tuner ZPV-E1. The ZPV-E1 covers the frequency range from 10 Hz to 50 MHz. It has a wide dynamic range and is suitable for use at low frequencies – e.g. measurements on control loops and in acoustics – as well as for video measurements, group-delay measurements and impedance measurements from the VLF to the HF range.

The ZPV-E1 has two high-impedance inputs fitted with BNC female connectors permitting connection of probes or 10:1 attenuator probes (e.g. the R&S 10:1 Attenuator Probe UTKS). Insertion adapters enable measurements in systems using 50- Ω coax too, for instance impedance measurements with the VSWR Bridge ZRB.

VECTOR ANALYZERS 4

network analyzers

Vector Analyzer ZPV - measuring procedures



Vector Analyzer ZPV fitted with Tuner ZPV-E3 used for filter measurement according to T-junction method

Tuner ZPV-E2. The ZPV-E2 covers the frequency range of 100 kHz to 1 GHz (typ. 1.2 GHz). Its two associated probes permit voltages to be measured with high impedance. Insertion units are combined with the probes for measurements in coaxial systems. Directional couplers can also be connected through the insertion units.

Tuner ZPV-E3. The ZPV-E3, in conjunction with the basic unit ZPV, permits vector measurements, two-port measurements and group-delay measurements in coaxial systems over a wide range of frequency and signal level. It is thus possible to take full advantage of the measuring and processing capabilities offered by the ZPV (see page 142). The frequency coverage of 300 kHz to 2000 MHz is twice that of the tuner with probes, ZPV-E2, and thereby considerably extends the range of possible applications of the basic unit.

The input impedance of the test inputs, which are fitted with female N connectors, is 50 Ω . This permits simple and straightforward test setups since the test circuits used can be connected directly to the ZPV-E3. There is no need for the insertion unit and associated termination required with the ZPV-E2.

Description of ZPV Tuners

With the Tuner ZPV-E1, a frequency counter determines the precise input frequency and a microprocessor drives the mixer/oscillator in order to obtain an intermediate frequency of 20 kHz. Narrowband filters extract the desired frequency spectrum, the filters being automatically connected depending on the input frequency and input level.

The Tuners ZPV-E2 and ZPV-E3 convert the input signals of the channels A and B with the aid of two sampling mixer stages over a wide frequency range to an intermediate frequency of 20 kHz, the fundamental of the input signals being retained with amplitude and phase fidelity. The shape of the curve is also more or less retained unless the spectral

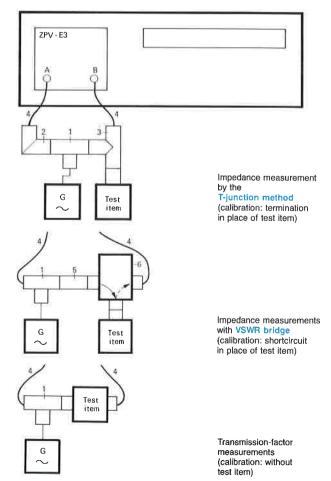
components of the input signals exceed 1000 or 2000 MHz. The IF signals are available at the outputs of the basic unit. Only the fundamental is used for signal evaluation. The tuners cover 14 frequency subranges. The required subrange is selected either manually or automatically under the control of the basic unit. Tuning to the fundamental of the input signal of channel A takes place automatically within the subranges. Channel B is then tuned to the same receive frequency.

Measuring methods

Reflection-coefficient and impedance measurements can be made with directional couplers or VSWR bridges (figure in the middle) or by the simple T-junction method (top), a new measuring method that greatly simplifies the test setup and, as a result, drastically cuts down its costs. After entry of the type of desired test setup at the push of a button on the basic unit the parameter of interest can be determined using the calculating power of the internal microprocessor and is read out digitally. Whereas the entire frequency range of the Tuner ZPV-E3 is utilized with this T-junction method, directional couplers or VSWR bridges restrict the frequency range according to their particular characteristics. The last figure shows how simple it is to carry out transmission-factor measurements

Legend

- 1 = Feed-in
- 2 = Angle piece
- 3 = T junction
- 4 = Pair of measuring cables 5 = Two-way plug
- 6 = VSWR bridge



VECTOR ANALYZERS 4

ZPV-Z5

S-parameter Test Adapter ZPV-Z5

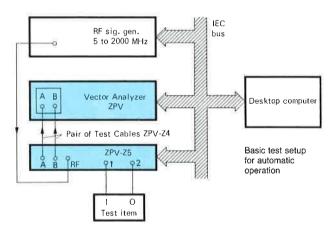
- ♦ 5 to 2000 MHz
- Measurement of all four s-parameters without modification to the test setup
- High directivity: 46 dB
- IEC-bus-compatible

In conjunction with a suitable network analyzer, e.g. the Vector Analyzer ZPV, the **S-parameter Test Adapter ZPV-Z5** permits measurement of all four s-parameters without modification to the test setup.

Characteristics and uses

High directivity, wide frequency range. Thanks to the high directivity of the VSWR bridges of 46 dB, even items with very small reflection coefficients can be tested. The Test Adapter covers almost the entire frequency range of the Tuner ZPV-E3 due to its wide bandwidth of 5 to 2000 MHz; it can of course also be used with the Tuner ZPV-E2 in the range 5 to 1000 MHz.

IEC-bus compatibility. The Test Adapter can be controlled via the IEC bus and thus combined with an IEC-buscompatible signal generator and a desktop computer to form an attractively priced, automatic network analyzer.



Connections, settings, measurements. The Test Adapter is connected to the RF generator and to channels A and B of the Vector Analyzer (see above). The test item input and output are taken to ports 1 and 2 of the ZPV-Z5.

In manual operation the s-parameter to be measured is selected by pressing the corresponding front-panel key; in automatic operation it is set via the IEC bus by a desktop computer, e.g. the Process Controller PUC or the Tektronix 4051, 4052.

The key labeling and the programming commands correspond to the s-parameters to be measured. To measure for instance the input reflection coefficient s_{11} , S11 is simply entered via the computer.

Description

The ZPV-Z5 is of symmetrical design to permit the measurement of input and output parameters. The reference branch includes a line for compensating the electrical lengths in the test branches; tedious length compensation by adding a suitable line section is thus no longer required. If a test item cannot be linked up directly to the test sockets of the ZPV-Z5, the input and output of the test item need simply be connected via identical cable sections and a third section of the



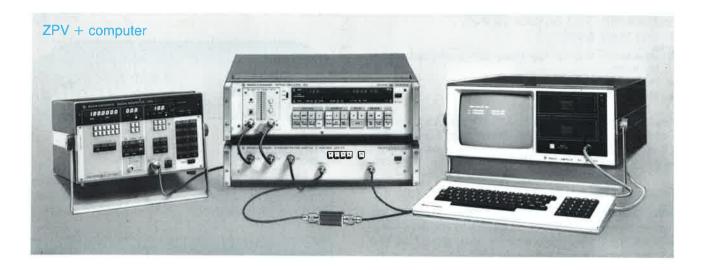
(IEC 625 Bus)

same lenght inserted into the reference branch. To provide a power supply for active components, two DC Feed Units ZPV-Z6 can be connected.

Specifications of ZPV-Z5
Frequency range
N female connectors Input loading≦0.5 W
Directivity
RF input – reference output A 8 dB ports 1, 2
test output B 22 dB Measurement error
Variation with frequency of magnitudes of reflection coeffi-
cient and transmission factor ≤ ±1.2 dB (difference-frequency response between test output B and reference output A)
Frequency-proportional phase error±6°×f (f in GHz)
(between test output B and reference output A)
Measurement error due to inherent reflection $\leq \pm 0.05 \times Irl^2$ (up to 1000 MHz) $\leq \pm 0.1 \times Irl^2$ (up to 2000 MHz)
where r is the reflection coefficient of the test item
Phase error due to inherent reflection $\pm 6^{\circ} \times Irl^{2}$ (up to 2000 MHz)
VSWR mismatch (ports 1, 2) r ≦10% (uo to 1000 MHz) r ≦15% (up to 2000 MHz)
Relay switching time
System
Factory-set address
General data
Rated temperature range +18 to +30 °C Operating temperature range +10 to +45 °C
Storage temperature range -45 to +70°C AC supply 115/125/220/235 V ±10%,
47 to 440 Hz (25 VA) Dimensions, weight
Ordering information
Order designation S-parameter Test Adapter
ZPV-Z5 335.1112.50
Recommended extras IEC-bus Cable PCK, 1 m
Precision Termination RNA, 50 Ω 272.4510.50 Termination RNB, 50 Ω ;
only required with ZPV-E2
Pair or Test Cables ZPV-Z4; only required with ZPV-E3
DC Feed Unit ZPV-Z6
For computer-controlled operation
Accuracy-improvement Software see pages 148 and 152
Specifications of DC Feed Unit ZPV-Z6
Frequency range
Connectors: RF
DC telephone jacks (4 mm)

4 NETWORK ANALYZERS

network analyzers



Computer-controlled Network Analyzer

- 10 Hz to 2000 MHz
- Fully automated measurement of all two-port parameters
- Graphic display
- High measurement rate
- Expandable with IEC-bus-compatible equipment

System configuration, characteristics

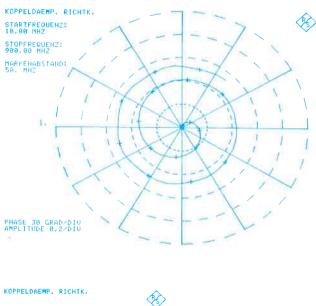
When combining the Vector Analyzer ZPV with a programmable frequency generator and a controller, a fully automatic network analyzer system is obtained.

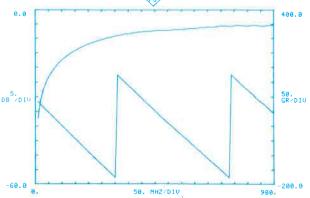
Controller. For controlling the ZPV, the Rohde & Schwarz Process Controller PUC and the Tektronix Systems 4051 and 4052 are especially well suited. For details on computers see section 1. In addition, the HP 9835 and HP 9845 computers can also be employed.

Generator. Various Rohde & Schwarz generators are suitable for use with the ZPV. For somewhat less stringent frequency-accuracy requirements, the Power Signal Generator SMLU can be used in the range from 25 MHz to 1 GHz. The Synthesizer Generator XPC and the Signal Generator SMS permit precision measurements in the ZPV range up to 1 GHz. The Sweep Generator SWP which covers the entire frequency range of the ZPV Tuner ZPV-E3 is also suitable. The Generator SPN is available for network analysis in the AF range.

Software. For this combination of instruments, Rohde & Schwarz offers easy-to-handle software (see pages 147 and 148) so that a minimum of time is required to get acquainted with the application of the network analyzer. The preprogrammed measurement and display modes can be called up with code numbers. Graphic display in particular shows the efficiency of the basic software: the curves plotted can be made available directly as hardcopy documentation (for examples of programming and graphic display see to the right).

The resulting automatic network analyzer system (see figure above) is superior in many respects to the computer-controlled systems used hitherto: the high intelligence of the ZPV makes operation and programming simple and easy to understand. The test speed, in particular for impedance and admittance measurements, is very high since computing and control are performed to a large extent in the ZPV at optimum speed.





Coupling attenuation of a directional coupler represented in polar coordinates (top) and in cartesian coordinates (bottom); output on hardcopy unit greatly reduced scale)

NETWORK ANALYZERS 4

Measurement capabilities, operation

The system fully automates all measurements that are possible with the ZPV, i.e. depending on the ZPV version:

voltage measurements by magnitude and phase, s-parameter, impedance and admittance measurements, group-delay measurements.

Comprehensive basic software facilitates not only the operation of the analyzer system but also programming. The user need not learn any programming language. Ready-made test routines can be called up by means of code numbers.

Basic software

The Basic Software (ZPV-K1, -K4 or -K10 depending on type of computer) permits both easy programming of pointby-point measurements as they are required for final inspection and graphic display of continuous frequency-dependent curves (for two examples of such curves output on the hardcopy unit, see preceding page). There are different ways of outputting the test result: numerical display on the screen or by a printer and graphic display on the screen or output on a hardcopy unit. Comparing of nominal and actual values is also possible. For the table compiling the setting commands see below and for an extract of the list of code numbers associated with the Basic Software see righthand column, top.

Accuracy-improvement software permitting high-accuracy sparameter measurements is available for the recommended computers (see next page).

Setting commands

AR.	amplitude range
FR.a	frequency range
GØ	tendency indication OFF
G1	tendency indication ON
HZ.	frequency value
KO	recorder output OFF
K1	recorder output ON
PO.	phase offset
SH	high measurement speed
SL	low measurement speed
TE	external triggering
TI	internal triggering
TR	reference value (10 ASCII characters)
TS	device status word (10 ASCII characters)



Computer-controlled network analyzer assembly comprising Vector Analyzer ZPV, Sweep Generator SWP (synthesizer), S-parameter Test Adapter ZPV-Z5 and Process Controller PUC

Extract of code number list for Basic Software ZPV-K1

As an example only the input data and the graphics output are listed in detail (for complete list see data sheet 292 401).

Program start	Y = 1 generator SMPU
	Y = 2 generator SMLU
	Y = 3 generator SPN
	Y = 4 generator SMS
	Y = 5 generator XPC/SMPC
	Y = 6 generator SWP

Input data	Physical unit	Code No.
Test frequency	MHz	2
Test level	dBm	3
Shift of reference plane	cm	6
Relative dielectric constant		7
Sweep start frequency	MHz	9
Sweep stop frequency	MHz	10
Sweep step width	MHz	11
Number of markers		13
Frequency deviation for group		
delay measurement	kHz	14
Operational settings Calibration/reference values Output of single-shot measureme Output of swept-frequency measu Program execution		17 to 26 27 to 31 33, 34 35, 37 39 to 43
Individual measurements		
Vector measurement Parameter measurement Group-delay measurement DC voltage measurement		45 to 59 62 to 78 82, 83 84
Graphic display		
Diagrams		85 to 92
Graphic data output Smith chart or polar coordinates		96
Magnitude (real component) in cartesian coordinates	dolovů-	97
Phase (imaginary component, group in cartesian coordinates	ганаул	98

Example of programming for Tektronix Graphic Computing System 4051 using Basic Software ZPV-K1

100	INIT
110	Y=1
120	GOSUB 1
130	Y=10
140	GOSUB 9
150	Y=900
160	GOSUB 10
170	Y=10
180	GOSUB 11
190	GOSUB 78
200	Y1=+60
210	Y2=0
220	S\$="DB"
230	T\$="KOPPELDAEMP, RICHTK."
240	GOSUB 90
250	GOSUB 97
260	Y1=-200
270	Y2=400
280	Y\$="GR"
290	GOSUB 92
300	GOSUB 98
310	EHD



ZPV Software

High-accuracy s-parameter measurement using accuracy-improvement software for ZPV

The accuracy-improvement software (see righthand column and recommended extras) for use with the Network Analyzer (page 146) permits fully automatic and extremely accurate s-parameter measurements over the entire frequency range of the tuner plug-ins.

The accuracy-improvement software includes the proven elements of the basic software (page 147) plus an extension to enable corrected measurements. For this purpose, the test setup is measured prior to the test run using calibration standards. During the actual measurement the readings obtained from the ZPV are corrected in the desktop computer using the values specific to the test setup that were determined during calibration. The high-accuracy test result is displayed graphically or numerically on the screen of the computer.

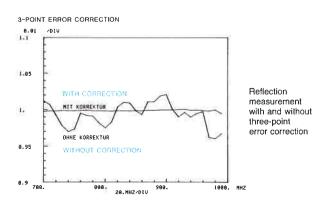
Sources of error, requirements for correction. Basically measurements of the transmission factor and of the reflection coefficient have to be distinguished.

In transmission measurements errors are caused mainly by the frequency response of cables, test adapters and the instrument itself. All frequency-response errors can be eliminated by the so-called simple error correction.

In reflection measurements - using bridges or directional couplers - there are three main sources of error: a) directivity, b) mismatch at the test port, c) frequency response or frequency-dependent coupling attenuation between the test port and the test output. These errors are eliminated by socalled three-point error correction (using the accuracyimprovement software dispenses with the coupler in the reference channel).

Simple error correction can be used both for transmission measurements and reflection measurements with insertion heads or T junctions in the region of |r| = 0. It is based on the capability of the ZPV to perform measurements related to a reference value. For measurements over a wide frequency range, the reference values are stored in the desktop computer.

Three-point error correction is employed exclusively for reflection-coefficient measurements using bridges or directional couplers. In this case the ZPV readings are converted in the desktop computer after the correction factors have been established in the form of three complex constants by calibrated measurements (K1 for the directivity of the test bridge, K₂ for the frequency response of the test setup and K₃ for the reflection coefficient of the bridge test port).



Example of s-parameter correction software

for the desktop computers

PUC from Rohde & Schwarz, Tektronix 4051 and 4052, Hewlett Packard 9835 and 9845 (no graphics)

Measurements

47

49

54

55

57

62

- 45 s11 or s22 measurement without correction no dimension, degrees no dimension, degrees no dimension, degrees 46 s11 or s22 measurement with correction s_{11} or s_{22} measurement with 3-point correction s21 or s12 measurement without correction no dimension, degrees 50 s_{21} or s_{12} measurement without correction 51 s_{21} or s_{12} measurement with correction dB, degrees no dimension, degrees 53 s21 or s12 measurement with correction dB, degrees B/A measurement without correction no dimension, degrees B/A measurement without correction dB, degrees no dimension, dearees B/A measurement with simple correction dB, degrees 58 B/A measurement with simple correction
- Z-measurement without correction 59 Z-measurement with simple correction 61 Z-measurement with 3-point correction

Ω, jΩ

Ω, jΩ Ω, jΩ

Physical unit

Measurements using S-parameter Test Adapter ZPV-Z5

- 70 s11 measurement 71 s₂₂ measurement
- 73 s21 measurement 74 s12 measurement

only for logarithmic diagram

Calibration

- 33 calibration for simple correction
- calibration for 3-point correction calibration for simple correction
- 65 calibration for 3-point correction

Numerical output of measurements

37 output on display 38 output on printer

Specifications

Automatic Network Analyzer	
corresponding to page 146	
Frequency range 10 Hz to 2000 MHz Resolution depending on signal gene Measurement capabilities voltage lin or log, vectors cartesian coordinates s parameters; impedance admittance; group delay	s in polar or
Time required for display of complete locus 10 to 20 s (about 50 points) for complex measurement 200 ms for levels >100 µ Programming IEC-bus (IEC 625-1), IEE	١V

VECTOR ANALYZERS 4

S	p	e	ci	fi	Ca	ati	0	n	S	

ZPV basic unit

Display of measured quantities Vector measurement

P Polar-coordinate representation

Log indication (absolute) in dBm (0 dBm corresponding to 1 mW into 50 Ω) Log indication (relative) in dB

..... 4 digits, resolution 0.1 dB 4 digits, resolution 0.1 dB (for values <1 dB: 0.01 dB) Indication of reference value for relative voltage measurements in dBm

..... 4 digits, resolution 0.1 dB

Magnitude of ratio

Lin indication 3 digits with floating decimal point, max. resolution 0.001 Log indication 4 digits, resolution 0.1 dB

Phase

Readout in degrees	,
Indication of phase reference value in degrees	
value indegrees	

C Cartesian-coordinate representation

Lin indication 3 digits with floating decimal point, max. resolution 0.001 Calibration of reference phase and level automatic by pushbutton

s-parameter measurement

Test method	for frequencies <100 MHz:
	direct voltage measurement
	for frequencies >100 MHz:
	use of directional coupler or
	VSWR bridge
Calibration of reference	
phase and level	automatic by pushbutton
Characteristic impodance	50 0/75 0 owitch colocted

Polar-coordinate representation

Lin indication of magnitude	3 digits with floating decimal point,
	max. resolution 0.001
	4 digits, resolution 0.1 dB
Indication of phase in degrees	4 digits, resolution 0.1°
VSWR	4 digits with floating decimal point

C Cartesian-coordinate representation

Impedance or admittance measurement

Characteristic impedance \ldots 50 $\Omega/75 \Omega$, switch-selected

Polar-coordinate representation

Absolute indication of magnitude in Ω or mS

Normalized indication of

3 digits with floating decimal point, max. resolution 0.1 Ω or 0.1 mS

C Cartesian-coordinate representation

Absolute indication in $\Omega, k\Omega$ or mS, μ S 3 digits with floating decimal point, max. resolution 0.1 Ω or 0.1 μ S

0	Group-delay measurement	
	ndication	max. resolution 1 ns
1	Frequency shift Measured quantities Modes	0.4/4/40 kHz, switch-selected group delay and group-delay variation
1	Programming	
	System	
	nterface functions T6, TE6	talker capability with secondary address, series polling and
1		automatic unaddressing listener capability with automatic
1	SR1 DC1 DT1	device clear
	Iming (typical values)	device nigger
	Time required for addressing	
F	Time required for data transfer	
	of first data word	0.5 ms
	Code	ISO 7-bit decimal
1	Delimiters	16 different characters can be set (factory setting: CR)
-	Test outputs	
	X and Y outputs for recorder Output-voltage range	
(Output impedance	1 kΩ
	r and φ output for narrowband sw	
	Output voltage range r Output voltage range φ Output impedance	-0.5 to +0.5 V 1 kΩ
	Test bandwidth	≦100 μV) BNC
	IF outputs for channels A and B	
	Output frequency	
	Connector	
	DC voltage test input Input voltage range Input impedance Connector	0 to +10 V, resolution 2.5 mV $>\!100~\text{k}\Omega$ BNC
	For specifications of ZPV pl see next page	us Tuners ZPV-E1 to E3
	General data (basic unit)	
	Rated temperature range Storage temperature range Power supply	+10 to +45°C -40 to +75°C 115/125/220/235 V ±10%, 47 to 420 Hz (110 VA), safety class 1
	Overall dimensions (W×H×D) Weight (including options and Tuner ZPV-E2)	(VDE 0411 or IEC 348) 492 mm×161 mm×514 mm

For order designations see page 152



Specifications	ZPV plus Tuner		
	ZPV-E1	ZPV-E2	ZPV-E3
		(accuracy specifications apply with free	
requency range	10 Hz to 50 MHz	0.1 to 1000 MHz	0.3 to 2000 MHz
equency subranges		0.1 to 0.3 MHz	0.3 to 1 MHz
	(no swept operation)	0.3 to 1 MHz	1 to 2 MHz
	20 to 80 kHz 70 to 170 kHz	1 to 2 MHz 2 to 3 MHz	2 to 3 MHz 3 to 6 MHz
	150 to 360 kHz	3 to 6 MHz	6 to 10 MHz
	320 to 730 kHz	6 to 10 MHz	10 to 20 MHz
	670 kHz to 1.5 MHz	10 to 20 MHz	20 to 30 MHz
	1.3 to 3.1 MHz	20 to 30 MHz	30 to 60 MHz
	2.8 to 6 MHz	30 to 60 MHz	60 to 100 MHz
	5.6 to 12 MHz	60 to 100 MHz	100 to 200 MHz
	11 to 25 MHz	100 to 200 MHz	200 to 300 MHz
	22 to 52 MHz	200 to 300 MHz	300 to 600 MHz
		300 to 600 MHz	600 to 1000 MHz
		600 to 1000 MHz	1000 to 2000 MHz
nge overlap	typ. 10%	typ. 10%	typ. 10%
nge setting	automatic	automatic or by hand	
ning	automatic to signal	automatic to signal in channel A	
	at SYNC input	°	
ld range		0.2 to 0.4 MHz	(f <1 MHz)
			1 to 1000 MHz)
solution of internal frequency counter			
equency output only via IEC bus)			HE
	1 kHz (ŕ >25 kHz)		
rept operation	W	thin frequency subranges	
ximum sweep rate	2 MHz/s (t >100 kHz)	0.3 to 3 MHz/s	
and increased and a second sec	0.2 MHz/s (25 kHz <f <100="" khz)<="" td=""><td>3 to 30 MHz/s</td><td></td></f>	3 to 30 MHz/s	
ut impedance		probes: 50 kΩ 2 pF	50 Ω
	1 MΩ 17 pF	with 100:1 attenuator	VSWR <1.2 (up to 1.5 GHz)
winnum innut velterer with suit to	101/1461 1001/1001	probe: 6 MΩ 2 pF	<1.9 (up to 2 GHz)
xImum Input voltage without demage	10 V (AC), ±30 V (DC)	3 V (AC), ±50 V (DC)	5 V _{rms} , ±15 V (DC)
osstalk attenuation		≧100 dB (f <500 MHz)	≥100 dB (f <500 MHz)
	\geq 95 dB (5 MHz <f <40="" mhz)<="" td=""><td>≧80 dB (f >500 MHz)</td><td>≥80 dB (500 MHz <f <1000="" mhz)<="" td=""></f></td></f>	≧80 dB (f >500 MHz)	≥80 dB (500 MHz <f <1000="" mhz)<="" td=""></f>
	≧90 dB (f >40 MHz)	(referred to signals	≧70 dB (f >1000 MHz)
out sensitivity		at probe tips)	
annel A	5V (20 Hz <1 <50 kHz)	1200 vV hm 400 vV (f <1 MHz)	1200 w/ hm 400 w// (<1 MH-)
	1 μV (50 kHz <f <25="" mhz)<="" td=""><td>1200 μV, typ. 400 μV (f <1 MHz) 400 μV, typ. 150 μV (f >1 MHz)</td><td>1200 μV, typ. 400 μV (f <1 MHz) 1000 μV, typ. 300 μV (f >1 MHz)</td></f>	1200 μV, typ. 400 μV (f <1 MHz) 400 μV, typ. 150 μV (f >1 MHz)	1200 μV, typ. 400 μV (f <1 MHz) 1000 μV, typ. 300 μV (f >1 MHz)
	3 μV (f >25 MHz)	400 μa, typ. 150 μa (t >1 tainz)	1000 µv, typ. 300 µv (t >1 tviriz)
annel B	same as channel A	3 µV, typ. 1 µV	5 µV, typ. 3 µV
NC channel	20 mV (f < 25 kHz)	5 μа, цр. т μа	5 μν, typ. 5 μν
	10 mV, typ. 6 mV (f >25 kHz)		
aximum measurable input voltage	to multiple of my (i > Lo mile)		
nannels A and B	1 V,	0.3 V (f <1 MHz)	0.3 V (f <1 MHz)
	9.999 V with 10:1 probe	1 V (f >1 MHz)	1 V (f >1 MHz)
	and U×10 buttons pressed		
NC channel	max. 1 V		-
st bandwidth (selectable as desired			
via IEC bus)	V 10 Hz 200 Hz 1 kHz	2 kHz	2 kHz
	300µV-	100 µV	100µV
	soop+-	NOUP WITH A STATE OF A	TOOLA
ector measurement		30 Hz	30 Hz
Polar-coordinate representation			+
gnitude of voltage	10Hz 4kHz 25kHz 50MHz	0,1 MHz 1000	0.3 MHz 2000
asurement error with constant		· · · · · · · · ·	
ut level of	50 mV ¹):	100 mV:	100 mV:
	±0.1 dB (20 Hz <f <1="" mhz)<="" td=""><td>±0.4 dB (f <0.3 MHz)</td><td>±0.2 dB (f <100 MHz)</td></f>	±0.4 dB (f <0.3 MHz)	±0.2 dB (f <100 MHz)
	±0.2 dB (1 MHz <f <10="" mhz)<="" td=""><td>±0.2 dB (0.3 MHz <f <100="" mhz)<="" td=""><td>±0.5 dB (100 MHz <f <500="" mhz)<="" td=""></f></td></f></td></f>	±0.2 dB (0.3 MHz <f <100="" mhz)<="" td=""><td>±0.5 dB (100 MHz <f <500="" mhz)<="" td=""></f></td></f>	±0.5 dB (100 MHz <f <500="" mhz)<="" td=""></f>
			±1.2 dB (500 MHz <f <1500="" mhz<="" td=""></f>
	±0.3 dB (1>10 MHz)	±0.6 dB (100 MHz <f <500="" mhz)<="" td=""><td></td></f>	
	\pm 0.3 dB (f >10 MHz) (see also table on page 151)	±0.6 dB (100 MHz <f <500="" mhz)<br="">±1.5 dB (f >500 MHz)</f>	±1.2/-2.3 dB (f >1500 MHz)
	(see also table on page 151)		
asurement range within permissible input	(see also table on page 151)	±1.5 dB (f >500 MHz)	±1.2/-2.3 dB (f >1500 MHz)
asurement range within permissible input	(see also table on page 151)		
asurement range within permissible input el range adout error at fixed frequency	(see also table on page 151) -110 to +110 dB	±1.5 dB (f >500 MHz) -90 to +70 dB	±1.2/-2.3 dB (f >1500 MHz) -90 to +70 dB
asurement range within permissible input el range adout error at fixed frequency	(see also table on page 151) -110 to +110 dB ±1.5% (V _{in} >1 mV)	±1.5 dB (f >500 MHz) -90 to +70 dB ±1.5% (at f >250 MHz	±1.2/-2.3 dB (f >1500 MHz) -90 to +70 dB 1.5% (at f >1000 MHz
asurement range within permissible input el range adout error at fixed frequency	(see also table on page 151) -110 to +110 dB ±1.5% (V _{in} >1 mV) ±5% (100 μV <v<sub>in <1 mV)</v<sub>	±1.5 dB (f >500 MHz) -90 to +70 dB	±1.2/-2.3 dB (f >1500 MHz) -90 to +70 dB
asurement range within permissible input el range adout error at fixed frequency vith calibration button (linearity)	(see also table on page 151) -110 to +110 dB ±1.5% (V _{in} >1 mV)	±1.5 dB (f >500 MHz) -90 to +70 dB ±1.5% (at f >250 MHz	±1.2/-2.3 dB (f >1500 MHz) -90 to +70 dB 1.5% (at f >1000 MHz
asurement range within permissible input el range	(see also table on page 151) -110 to +110 dB $\pm 1.5\%$ (V _{in} >1 mV) $\pm 5\%$ (100 μ V <v<sub>in <1 mV) (see also table on page 151)</v<sub>	±1.5 dB (f >500 MHz) -90 to +70 dB ±1.5% (at f >250 MHz for V _{in} <0.3 V only)	$\pm 1.2/-2.3$ dB (f >1500 MHz) -90 to +70 dB 1.5% (at f >1000 MHz for V _{In} <0.3 V only)
asurement range within permissible input el range adout error at fixed frequency vith calibration button (linearity) vithout calibration button	(see also table on page 151) -110 to +110 dB $\pm 1.5\%$ (V _{in} >1 mV) $\pm 5\%$ (100 μ V <v<sub>in <1 mV) (see also table on page 151)</v<sub>	± 1.5 dB (f >500 MHz) -90 to +70 dB $\pm 1.5\%$ (at f >250 MHz for V _{in} <0.3 V only) $\pm 3\%$ (f <100 MHz)	±1.2/-2.3 dB (f >1500 MHz) -90 to +70 dB 1.5% (at f >1000 MHz for V _{in} <0.3 V only) ±3% (f <500 MHz)
asurement range within permissible input el range adout error at fixed frequency vith calibration button (linearity) vithout calibration button	(see also table on page 151) -110 to +110 dB $\pm 1.5\%$ (V _{in} >1 mV) $\pm 5\%$ (100 μ V <v<sub>in <1 mV) (see also table on page 151)</v<sub>	±1.5 dB (f >500 MHz) -90 to +70 dB ±1.5% (at f >250 MHz for V _{in} <0.3 V only)	$\pm 1.2/-2.3$ dB (f >1500 MHz) -90 to +70 dB 1.5% (at f >1000 MHz for V _{in} <0.3 V only) $\pm 3\%$ (f <500 MHz) $\pm 6\%$ (500 MHz) <1 <1500 MHz)
asurement range within permissible input el range adout error at fixed frequency vith calibration button (linearity) vithout calibration button difference between A and B)	(see also table on page 151) -110 to +110 dB $\pm 1.5\% (V_{in} > 1 \text{ mV})$ $\pm 5\% (100 \ \mu\text{V} < V_{in} < 1 \text{ mV})$ (see also table on page 151) $\pm 2\% \text{ (f } > 20 \text{ Hz})$	± 1.5 dB (f >500 MHz) -90 to +70 dB $\pm 1.5\%$ (at f >250 MHz for V _{in} <0.3 V only) $\pm 3\%$ (f <100 MHz)	±1.2/-2.3 dB (f >1500 MHz) -90 to +70 dB 1.5% (at f >1000 MHz for V _{in} <0.3 V only) ±3% (f <500 MHz)
asurement range within permissible input el range adout error at fixed frequency vith calibration button (linearity) vithout calibration button difference between A and B) ase	(see also table on page 151) -110 to +110 dB $\pm 1.5\% (V_{in} > 1 \text{ mV})$ $\pm 5\% (100 \mu V < V_{in} < 1 \text{ mV})$ (see also table on page 151) $\pm 2\% \text{ (f } > 20 \text{ Hz})$ see also table on page 151	± 1.5 dB (f >500 MHz) -90 to +70 dB $\pm 1.5\%$ (at f >250 MHz for V _{in} <0.3 V only) $\pm 3\%$ (f <100 MHz)	$\pm 1.2/-2.3$ dB (f >1500 MHz) -90 to +70 dB 1.5% (at f >1000 MHz for V _{in} <0.3 V only) $\pm 3\%$ (f <500 MHz) $\pm 6\%$ (500 MHz) <1 <1500 MHz)
asurement range within permissible input el range . adout error at fixed frequency vith calibration button (linearity) vithout calibration button difference between A and B)	(see also table on page 151) -110 to +110 dB $\pm 1.5\% (V_{in} > 1 \text{ mV})$ $\pm 5\% (100 \ \mu V < V_{in} < 1 \text{ mV})$ (see also table on page 151) $\pm 2\% \text{ (f } > 20 \text{ Hz})$ see also table on page 151 and footnote ¹)	± 1.5 dB (f >500 MHz) -90 to +70 dB $\pm 1.5\%$ (at f >250 MHz for V _{in} <0.3 V only) $\pm 3\%$ (f <100 MHz) $\pm 6\%$ (f >100 MHz)	$\pm 1.2/-2.3$ dB (f >1500 MHz) -90 to +70 dB 1.5% (at f >1000 MHz for V _{in} <0.3 V only) $\pm 3\%$ (f <500 MHz) $\pm 6\%$ (500 MHz <f <1500="" mhz)<br="">$\pm 12\%$ (1500 MHz <f <2000="" mhz)<="" td=""></f></f>
asurement range within permissible input el range . adout error at fixed frequency vith calibration button (linearity) vithout calibration button difference between A and B) ase asurement range	(see also table on page 151) -110 to +110 dB $\pm 1.5\% (V_{in} > 1 \text{ mV})$ $\pm 5\% (100 \mu V < V_{in} < 1 \text{ mV})$ (see also table on page 151) $\pm 2\% (f > 20 \text{ Hz})$ see also table on page 151 and footnote ¹) $-180^{\circ} \text{ to } +180^{\circ}$	± 1.5 dB (f >500 MHz) -90 to +70 dB $\pm 1.5\%$ (at f >250 MHz for V _{in} <0.3 V only) $\pm 3\%$ (f <100 MHz)	$\pm 1.2/-2.3$ dB (f >1500 MHz) -90 to +70 dB 1.5% (at f >1000 MHz for V _{in} <0.3 V only) $\pm 3\%$ (f <500 MHz) $\pm 6\%$ (500 MHz) <1 <1500 MHz)
asurement range within permissible input el range adout error at fixed frequency vith calibration button (linearity) vithout calibration button difference between A and B) ase asurement range nlinearity at fixed frequency (level applied	(see also table on page 151) -110 to +110 dB $\pm 1.5\% (V_{in} > 1 \text{ mV})$ $\pm 5\% (100 \mu V < V_{in} < 1 \text{ mV})$ (see also table on page 151) $\pm 2\% \text{ (f } >20 \text{ Hz})$ see also table on page 151 and footnote ¹) $-180^{\circ} \text{ to } +180^{\circ}$	± 1.5 dB (f >500 MHz) -90 to +70 dB $\pm 1.5\%$ (at f >250 MHz for V _{in} <0.3 V only) $\pm 3\%$ (f <100 MHz) $\pm 6\%$ (f >100 MHz) -180° to +180°	$\pm 1.2/-2.3$ dB (f >1500 MHz) -90 to +70 dB 1.5% (at f >1000 MHz for V _{in} <0.3 V only) $\pm 3\%$ (f <500 MHz) $\pm 6\%$ (500 MHz <f <1500="" mhz)<br="">$\pm 12\%$ (1500 MHz <f <2000="" mhz)<br="">$\pm 12\%$ (1500 MHz <f <2000="" mhz)<br="">-180° to +180°</f></f></f>
asurement range within permissible input el range . adout error at fixed frequency with calibration button (linearity) vithout calibration button difference between A and B) ase asurement range . nlinearity at fixed frequency (level applied oth test inputs) .	(see also table on page 151) -110 to +110 dB $\pm 1.5\% (V_{in} > 1 \text{ mV})$ $\pm 5\% (100 \mu V < V_{in} < 1 \text{ mV})$ (see also table on page 151) $\pm 2\% \text{ (f } >20 \text{ Hz})$ see also table on page 151 and footnote ¹) $-180^{\circ} \text{ to } +180^{\circ}$ $< 0.5^{\circ} \text{ at } V_{A} = V_{B} = 50 \text{ mV}$	$\pm 1.5 \text{ dB (f > 500 \text{ MHz})}$ -90 to +70 dB $\pm 1.5\%$ (at f >250 MHz for V _{in} <0.3 V only) $\pm 3\%$ (f <100 MHz) $\pm 6\%$ (f >100 MHz) -180° to +180° <0.5° at V _A = V _B = 100 mV	$\pm 1.2/-2.3$ dB (f >1500 MHz) -90 to +70 dB 1.5% (at f >1000 MHz for V _{in} <0.3 V only) $\pm 3\%$ (f <500 MHz) $\pm 6\%$ (500 MHz <f <1500="" mhz)<br="">$\pm 12\%$ (1500 MHz <f <2000="" mhz)<br="">-180° to +180° <0.5° at V_A = V_B = 100 mV</f></f>
asurement range within permissible input el range . adout error at fixed frequency with calibration button (linearity) vithout calibration button difference between A and B) ase asurement range . nlinearity at fixed frequency (level applied oth test inputs) .	(see also table on page 151) -110 to +110 dB $\pm 1.5\% (V_{in} > 1 \text{ mV})$ $\pm 5\% (100 \mu V < V_{in} < 1 \text{ mV})$ (see also table on page 151) $\pm 2\% \text{ (f } >20 \text{ Hz})$ see also table on page 151 and footnote ¹) $-180^{\circ} \text{ to } +180^{\circ}$ $< 0.5^{\circ} \text{ at } V_{A} = V_{B} = 50 \text{ mV}$	$\pm 1.5 \text{ dB}$ (f >500 MHz) -90 to +70 dB $\pm 1.5\%$ (at f >250 MHz for V _{in} <0.3 V only) $\pm 3\%$ (f <100 MHz) $\pm 6\%$ (f >100 MHz) -180° to +180° <0.5° at V _A = V _B = 100 mV < $\pm 3°$ (f <0.3 MHz)	$\pm 1.2/-2.3$ dB (f >1500 MHz) -90 to +70 dB 1.5% (at f >1000 MHz for V _{in} <0.3 V only) $\pm 3%$ (f <500 MHz) $\pm 6\%$ (500 MHz) <1 <1500 MHz) $\pm 12\%$ (1500 MHz <f <2000="" mhz)<br="">-180° to +180° <0.5° at V_A = V_B = 100 mV < $\pm 1°$ (f <100 MHz)</f>
asurement range within permissible input el range . adout error at fixed frequency with calibration button (linearity) vithout calibration button difference between A and B) ase asurement range . nlinearity at fixed frequency (level applied oth test inputs) .	(see also table on page 151) -110 to +110 dB $\pm 1.5\% (V_{in} >1 \text{ mV})$ $\pm 5\% (100 \mu V < V_{in} <1 \text{ mV})$ (see also table on page 151) $\pm 2\% \text{ (f } >20 \text{ Hz})$ see also table on page 151 and footnote ¹) $-180^{\circ} \text{ to } +180^{\circ}$ $< 0.5^{\circ} \text{ at } V_{A} = V_{B} = 50 \text{ mV}$ see table on page 151	$\pm 1.5 \text{ dB (f > 500 \text{ MHz})}$ -90 to +70 dB $\pm 1.5\% (\text{at f > 250 \text{ MHz}}$ for V _{in} <0.3 V only) $\pm 3\% (f < 100 \text{ MHz})$ $\pm 6\% (f > 100 \text{ MHz})$ $-180^{\circ} \text{ to } +180^{\circ}$ $< 0.5^{\circ} \text{ at V}_{A} = \text{V}_{B} = 100 \text{ mV}$ $< \pm 3^{\circ} (f < 0.3 \text{ MHz})$ $\leq \pm 1^{\circ} (0.3 \text{ MHz} < f < 100 \text{ MHz})$	$\pm 1.2/-2.3$ dB (f >1500 MHz) -90 to +70 dB 1.5% (at f >1000 MHz for V _{In} <0.3 V only) $\pm 3\%$ (f <500 MHz) $\pm 6\%$ (500 MHz <f <1500="" mhz)<br="">$\pm 12\%$ (1500 MHz <f <2000="" mhz)<br="">-180° to +180° <0.5° at V_A = V_B = 100 mV < $\pm 1°$ (f <100 MHz) $\leq 44°$ (100 MHz) <f <500="" mhz)<="" td=""></f></f></f>
	(see also table on page 151) -110 to +110 dB $\pm 1.5\% (V_{in} > 1 \text{ mV})$ $\pm 5\% (100 \mu V < V_{in} < 1 \text{ mV})$ (see also table on page 151) $\pm 2\% \text{ (f } >20 \text{ Hz})$ see also table on page 151 and footnote ¹) $-180^{\circ} \text{ to } +180^{\circ}$ $< 0.5^{\circ} \text{ at } V_{A} = V_{B} = 50 \text{ mV}$	$\pm 1.5 \text{ dB (f > 500 \text{ MHz})}$ -90 to +70 dB $\pm 1.5\% (\text{at f > 250 \text{ MHz}} \text{ for V}_{in} < 0.3 \text{ V only})$ $\pm 3\% (f < 100 \text{ MHz})$ $\pm 6\% (f > 100 \text{ MHz})$ $-180^{\circ} \text{ to } +180^{\circ}$ $< 0.5^{\circ} \text{ at V}_{A} = V_{B} = 100 \text{ mV}$ $< \pm 3^{\circ} (f < 0.3 \text{ MHz})$ $< \pm 1^{\circ} (0.3 \text{ MHz}) \text{ f } < 100 \text{ MHz})$	$\pm 1.2/-2.3$ dB (f >1500 MHz) -90 to +70 dB 1.5% (at f >1000 MHz for V _{in} <0.3 V only) $\pm 3\%$ (f <500 MHz) $\pm 6\%$ (500 MHz <f <1500="" mhz)<br="">$\pm 12\%$ (1500 MHz <f <2000="" mhz)<br="">-180° to +180° <0.5° at V_A = V_B = 100 mV < $\pm 1^{\circ}$ (f <100 MHz) < $\pm 4^{\circ}$ (100 MHz <f <500="" mhz)<br="">$\leq \pm 6^{\circ}$ (500 MHz <f <1500="" mhz)<="" td=""></f></f></f></f>
asurement range within permissible input el range . adout error at fixed frequency with calibration button (linearity) vithout calibration button difference between A and B) ase asurement range . nlinearity at fixed frequency (level applied oth test inputs) .	(see also table on page 151) -110 to +110 dB $\pm 1.5\% (V_{in} >1 \text{ mV})$ $\pm 5\% (100 \mu V < V_{in} <1 \text{ mV})$ (see also table on page 151) $\pm 2\% \text{ (f } >20 \text{ Hz})$ see also table on page 151 and footnote ¹) $-180^{\circ} \text{ to } +180^{\circ}$ $< 0.5^{\circ} \text{ at } V_{A} = V_{B} = 50 \text{ mV}$ see table on page 151	$\pm 1.5 \text{ dB (f > 500 \text{ MHz})}$ -90 to +70 dB $\pm 1.5\% (\text{at f > 250 \text{ MHz}})$ for V _{in} <0.3 V only) $\pm 3\% (f < 100 \text{ MHz})$ $\pm 6\% (f > 100 \text{ MHz})$ $-180^{\circ} \text{ to } +180^{\circ}$ $< 0.5^{\circ} \text{ at } V_{A} = V_{B} = 100 \text{ mV}$ $< \pm 3^{\circ} (f < 0.3 \text{ MHz})$ $< \pm 1^{\circ} (0.3 \text{ MHz} < f < 100 \text{ MHz})$ $< \pm 4^{\circ} (100 \text{ MHz} < f < 500 \text{ MHz})$ $< \pm 6^{\circ} (500 \text{ MHz} < f < 1000 \text{ MHz})$	$\begin{array}{l} \pm 1.2/-2.3 \ \text{dB} \ (f > 1500 \ \text{MHz}) \\ \hline -90 \ \text{to} \ +70 \ \text{dB} \\ \hline 1.5\% \ (at \ f > 1000 \ \text{MHz} \\ \text{for} \ V_{\text{in}} < 0.3 \ \text{V only}) \\ \hline \pm 3\% \ (f < 500 \ \text{MHz}) \\ \pm 6\% \ (500 \ \text{MHz} < f < 1500 \ \text{MHz}) \\ \pm 12\% \ (1500 \ \text{MHz} < f < 2000 \ \text{MHz}) \\ \hline -180^{\circ} \ \text{to} \ +180^{\circ} \\ < 0.5^{\circ} \ at \ V_{\text{A}} = V_{\text{B}} = 100 \ \text{mV} \\ < \pm 1^{\circ} \ (f < 100 \ \text{MHz}) \\ < \pm 4^{\circ} \ (100 \ \text{MHz}) \\ < \pm 6^{\circ} \ (5500 \ \text{MHz}) \\ < \pm 6^{\circ} \ (5500 \ \text{MHz}) \\ < \pm 12^{\circ} \ (1500 \ \text{MHz}) \\ < \pm 12^{\circ} \ (1500 \ \text{MHz}) \\ < \pm 12^{\circ} \ (1500 \ \text{MHz}) \\ \end{array}$
asurement range within permissible input el range adout error at fixed frequency vith calibration button (linearity) vithout calibration button difference between A and B) ase asurement range nilnearity at fixed frequency (level applied ooth test inputs) act of frequency variation	(see also table on page 151) -110 to +110 dB $\pm 1.5\% (V_{in} > 1 \text{ mV})$ $\pm 5\% (100 \mu V < V_{in} < 1 \text{ mV})$ (see also table on page 151) $\pm 2\% \text{ (f } > 20 \text{ Hz})$ see also table on page 151 and footnote ¹) $-180^{\circ} \text{ to } +180^{\circ}$ $< 0.5^{\circ} \text{ at } V_{A} = V_{B} = 50 \text{ mV}$ see table on page 151 reference frequency 100 kHz	$\pm 1.5 \text{ dB (f > 500 \text{ MHz})}$ $-90 \text{ to } +70 \text{ dB}$ $\pm 1.5\% (\text{at f > 250 \text{ MHz}} \text{ for V}_{in} < 0.3 \text{ V only})$ $\pm 3\% (f < 100 \text{ MHz})$ $\pm 6\% (f > 100 \text{ MHz})$ $-180^{\circ} \text{ to } +180^{\circ}$ $< 0.5^{\circ} \text{ at V}_{A} = V_{B} = 100 \text{ mV}$ $< \pm 3^{\circ} (f < 0.3 \text{ MHz})$ $< \pm 1^{\circ} (0.3 \text{ MHz} < f < 100 \text{ MHz})$ $< \pm 4^{\circ} (100 \text{ MHz} < f < 500 \text{ MHz})$ $< \pm 6^{\circ} (500 \text{ MHz} < f < 100 \text{ MHz})$ $= 6^{\circ} \text{ requency 10 \text{ MHz}}$	$\pm 1.2/-2.3$ dB (f >1500 MHz) -90 to +70 dB 1.5% (at f >1000 MHz for V _{in} <0.3 V only) $\pm 3\%$ (f <500 MHz) $\pm 6\%$ (500 MHz <f <1500="" mhz)<br="">$\pm 12\%$ (1500 MHz <f <2000="" mhz)<br="">-180° to +180° <0.5° at V_A = V_B = 100 mV < $\pm 1°$ (f <100 MHz) < $\pm 4°$ (100 MHz <f <500="" mhz)<br="">< $\pm 4°$ (100 MHz <f <1500="" mhz)<br="">< $\pm 12°$ (1500 MHz <f <2000="" mhz)<br="">< $\pm 12°$ (1500 MHz <f <2000="" mhz)<br="">< $\pm 12°$ (1500 MHz <f <2000="" mhz)<br="">< $\pm 12°$ (1500 MHz <f <1500="" mhz)<br="">< $\pm 12°$ (1500 MHz <f <1500="" mhz)<="" td=""></f></f></f></f></f></f></f></f></f>
asurement range within permissible input el range	(see also table on page 151) -110 to +110 dB $\pm 1.5\% (V_{in} > 1 \text{ mV})$ $\pm 5\% (100 \mu V < V_{in} < 1 \text{ mV})$ (see also table on page 151) $\pm 2\% \text{ (f } > 20 \text{ Hz})$ see also table on page 151 and footnote ¹) $-180^{\circ} \text{ to } +180^{\circ}$ $< 0.5^{\circ} \text{ at } V_{A} = V_{B} = 50 \text{ mV}$ see table on page 151 reference frequency 100 kHz	$\pm 1.5 \text{ dB (f > 500 \text{ MHz})}$ $-90 \text{ to } +70 \text{ dB}$ $\pm 1.5\% (\text{at f > 250 \text{ MHz}} \text{ for V}_{in} < 0.3 \text{ V only})$ $\pm 3\% (f < 100 \text{ MHz})$ $\pm 6\% (f > 100 \text{ MHz})$ $-180^{\circ} \text{ to } +180^{\circ}$ $< 0.5^{\circ} \text{ at V}_{A} = \text{ V}_{B} = 100 \text{ mV}$ $< \pm 3^{\circ} (f < 0.3 \text{ MHz} \text{ of } < 100 \text{ MHz})$ $< \pm 4^{\circ} (100 \text{ MHz} \text{ cf } < 100 \text{ MHz})$ $< \pm 4^{\circ} (100 \text{ MHz} \text{ cf } < 100 \text{ MHz})$ $< \pm 4^{\circ} (100 \text{ MHz} \text{ cf } < 100 \text{ MHz})$ $< \pm 6^{\circ} (500 \text{ MHz} \text{ cf } < 1000 \text{ MHz})$ $= 6^{\circ} (500 \text{ MHz} \text{ cf } < 1000 \text{ MHz})$ $= 6^{\circ} (500 \text{ MHz} \text{ cf } < 1000 \text{ MHz})$ $= 6^{\circ} (500 \text{ MHz} \text{ cf } < 1000 \text{ MHz})$ $= 6^{\circ} (500 \text{ MHz} \text{ cf } < 1000 \text{ MHz})$	$\begin{array}{l} \pm 1.2/-2.3 \ dB \ (f > 1500 \ MHz) \\ -90 \ to \ +70 \ dB \\ 1.5\% \ (at \ f > 1000 \ MHz \\ for \ V_{in} < 0.3 \ V \ only) \\ \\ \pm 3\% \ (f < 500 \ MHz < f < 1500 \ MHz) \\ \pm 6\% \ (500 \ MHz < f < 1500 \ MHz) \\ \pm 12\% \ (1500 \ MHz < f < 2000 \ MHz) \\ -180^\circ \ to \ +180^\circ \\ \\ < 0.5^\circ \ at \ V_A = V_B = 100 \ mV \\ < \pm 1^\circ \ (f < 100 \ MHz < f < 500 \ MHz) \\ < \pm 4^\circ \ (100 \ MHz < f < 500 \ MHz) \\ < \pm 6^\circ \ (500 \ MHz < f < 2000 \ MHz) \\ < \pm 12^\circ \ (1500 \ MHz < f < 2000 \ MHz) \\ < \pm 12^\circ \ (1500 \ MHz < f < 2000 \ MHz) \\ < \pm 12^\circ \ (1500 \ MHz < f < 2000 \ MHz) \\ < 0.05^\circ / dB \end{array}$
asurement range within permissible input el range adout error at fixed frequency vith calibration button (linearity) vithout calibration button difference between A and B) ase asurement range nilnearity at fixed frequency (level applied ooth test inputs) act of frequency variation	(see also table on page 151) -110 to +110 dB $\pm 1.5\% (V_{in} > 1 \text{ mV})$ $\pm 5\% (100 \mu V < V_{in} < 1 \text{ mV})$ (see also table on page 151) $\pm 2\% \text{ (f } > 20 \text{ Hz})$ see also table on page 151 and footnote ¹) $-180^{\circ} \text{ to } +180^{\circ}$ $< 0.5^{\circ} \text{ at } V_{A} = V_{B} = 50 \text{ mV}$ see table on page 151 reference frequency 100 kHz	$\pm 1.5 \text{ dB (f > 500 \text{ MHz})}$ $-90 \text{ to } +70 \text{ dB}$ $\pm 1.5\% (\text{at f > 250 \text{ MHz}} \text{ for V}_{in} < 0.3 \text{ V only})$ $\pm 3\% (f < 100 \text{ MHz})$ $\pm 6\% (f > 100 \text{ MHz})$ $-180^{\circ} \text{ to } +180^{\circ}$ $< 0.5^{\circ} \text{ at V}_{A} = V_{B} = 100 \text{ mV}$ $< \pm 3^{\circ} (f < 0.3 \text{ MHz})$ $< \pm 1^{\circ} (0.3 \text{ MHz} < f < 100 \text{ MHz})$ $< \pm 4^{\circ} (100 \text{ MHz} < f < 500 \text{ MHz})$ $< \pm 6^{\circ} (500 \text{ MHz} < f < 100 \text{ MHz})$ $= 6^{\circ} \text{ requency 10 \text{ MHz}}$	$\begin{array}{l} \pm 1.2/-2.3 \ \text{dB} \ (f > 1500 \ \text{MHz}) \\ \hline -90 \ \text{to} \ +70 \ \text{dB} \\ \hline 1.5\% \ (at \ f > 1000 \ \text{MHz} \\ \text{for} \ V_{\text{in}} < 0.3 \ \text{V only}) \\ \hline \pm 3\% \ (f < 500 \ \text{MHz} < f < 1500 \ \text{MHz}) \\ \pm 12\% \ (1500 \ \text{MHz} < f < 2000 \ \text{MHz}) \\ \pm 12\% \ (1500 \ \text{MHz} < f < 2000 \ \text{MHz}) \\ \hline -180^{\circ} \ \text{to} \ +180^{\circ} \\ \hline < 0.5^{\circ} \ at \ V_{\text{A}} = V_{\text{B}} = 100 \ \text{mV} \\ < \pm 1^{\circ} \ (f < 100 \ \text{MHz} < f < 500 \ \text{MHz}) \\ < \pm 4^{\circ} \ (100 \ \text{MHz} < f < 500 \ \text{MHz}) \\ < \pm 12^{\circ} \ (1500 \ \text{MHz} < f < 2000 \ \text{MHz}) \\ < \pm 12^{\circ} \ (1500 \ \text{MHz} < f < 2000 \ \text{MHz}) \\ < \pm 3^{\circ} \ (500 \ \text{MHz} < f < 2000 \ \text{MHz}) \\ < \pm 3^{\circ} \ (500 \ \text{MHz} < f < 2000 \ \text{MHz}) \\ < 3^{\circ} \ \text{over entire range} \end{array}$
asurement range within permissible input el range adout error at fixed frequency vith calibration button (linearity) vithout calibration button difference between A and B) ase asurement range nilnearity at fixed frequency (level applied ooth test inputs) act of frequency variation	(see also table on page 151) -110 to +110 dB $\pm 1.5\% (V_{in} > 1 \text{ mV})$ $\pm 5\% (100 \mu V < V_{in} < 1 \text{ mV})$ (see also table on page 151) $\pm 2\% \text{ (f } > 20 \text{ Hz})$ see also table on page 151 and footnote ¹) $-180^{\circ} \text{ to } +180^{\circ}$ $< 0.5^{\circ} \text{ at } V_{A} = V_{B} = 50 \text{ mV}$ see table on page 151 reference frequency 100 kHz	$\pm 1.5 \text{ dB (f > 500 \text{ MHz})}$ $-90 \text{ to } +70 \text{ dB}$ $\pm 1.5\% (\text{at f > 250 \text{ MHz}} \text{ for V}_{in} < 0.3 \text{ V only})$ $\pm 3\% (f < 100 \text{ MHz})$ $\pm 6\% (f > 100 \text{ MHz})$ $-180^{\circ} \text{ to } +180^{\circ}$ $< 0.5^{\circ} \text{ at V}_{A} = \text{ V}_{B} = 100 \text{ mV}$ $< \pm 3^{\circ} (f < 0.3 \text{ MHz} \text{ of } < 100 \text{ MHz})$ $< \pm 4^{\circ} (100 \text{ MHz} \text{ cf } < 100 \text{ MHz})$ $< \pm 4^{\circ} (100 \text{ MHz} \text{ cf } < 100 \text{ MHz})$ $< \pm 4^{\circ} (100 \text{ MHz} \text{ cf } < 100 \text{ MHz})$ $< \pm 6^{\circ} (500 \text{ MHz} \text{ cf } < 1000 \text{ MHz})$ $= 6^{\circ} (500 \text{ MHz} \text{ cf } < 1000 \text{ MHz})$ $= 6^{\circ} (500 \text{ MHz} \text{ cf } < 1000 \text{ MHz})$ $= 6^{\circ} (500 \text{ MHz} \text{ cf } < 1000 \text{ MHz})$ $= 6^{\circ} (500 \text{ MHz} \text{ cf } < 1000 \text{ MHz})$	$\begin{array}{c} \pm 1.2/-2.3 \ dB \ (f > 1500 \ MHz) \\ -90 \ to \ +70 \ dB \\ 1.5\% \ (at \ f > 1000 \ MHz \\ for \ V_{in} < 0.3 \ V \ only) \\ \\ \pm 3\% \ (f < 500 \ MHz) \\ \pm 6\% \ (500 \ MHz < f < 1500 \ MHz) \\ \pm 12\% \ (1500 \ MHz < f < 2000 \ MHz) \\ \\ -180^{\circ} \ to \ +180^{\circ} \\ < 0.5^{\circ} \ at \ V_{A} = V_{B} = 100 \ mV \\ < \pm 1^{\circ} \ (f < 100 \ MHz) \\ < \pm 4^{\circ} \ (100 \ MHz < f < 1500 \ MHz) \\ < \pm 6^{\circ} \ (500 \ MHz < f < 1500 \ MHz) \\ < \pm 12^{\circ} \ (1500 \ MHz < f < 1500 \ MHz) \\ < \pm 6^{\circ} \ (500 \ MHz < f < 1500 \ MHz) \\ < \pm 6^{\circ} \ (500 \ MHz < f < 1500 \ MHz) \\ < \pm 2^{\circ} \ (1500 \ MHz < f < 2000 \ MHz) \\ < \pm 3^{\circ} \ over \ entire \ range \\ (referred \ to \ 2\times 100 \ mV \ at \ both \ test \ (referred \ to \ 2\times 100 \ mV \ at \ both \ test \ (referred \ to \ 2\times 100 \ mV \ at \ both \ test \ (referred \ to \ 2\times 100 \ mV \ at \ both \ test \ (referred \ to \ 2\times 100 \ mV \ at \ both \ test \ (referred \ to \ 2\times 100 \ mV \ at \ both \ test \ (referred \ to \ 2\times 100 \ mV \ at \ both \ test \ (referred \ to \ 2\times 100 \ mV \ at \ both \ test \ (referred \ to \ 2\times 100 \ mV \ at \ both \ test \ (referred \ to \ 2\times 100 \ mV \ at \ both \ test \ (referred \ to \ 2\times 100 \ mV \ at \ both \ test \ (referred \ to \ 2\times 100 \ mV \ at \ both \ test \ (referred \ to \ 2\times 100 \ mV \ at \ both \ test \ (referred \ to \ 2\times 100 \ mV \ at \ both \ test \ (referred \ to \ 2\times 100 \ mV \ at \ both \ test \ (referred \ to \ 2\times 100 \ mV \ at \ both \ test \ (referred \ to \ 2\times 100 \ mV \ at \ both \ test \ (referred \ to \ 2\times 100 \ mV \ at \ both \ test \ (referred \ to \ 2\times 100 \ mV \ at \ both \ test \ $
asurement range within permissible input el range adout error at fixed frequency vith calibration button (linearity) vithout calibration button difference between A and B) ase asurement range nlinearity at fixed frequency (level applied obth test inputs) ect of frequency variation	(see also table on page 151) -110 to +110 dB $\pm 1.5\% (V_{in} > 1 \text{ mV})$ $\pm 5\% (100 \mu V < V_{in} < 1 \text{ mV})$ (see also table on page 151) $\pm 2\% \text{ (f } > 20 \text{ Hz})$ see also table on page 151 and footnote ¹) $-180^{\circ} \text{ to } +180^{\circ}$ $< 0.5^{\circ} \text{ at } V_{A} = V_{B} = 50 \text{ mV}$ see table on page 151 reference frequency 100 kHz	$\pm 1.5 \text{ dB (f > 500 \text{ MHz})}$ $-90 \text{ to } +70 \text{ dB}$ $\pm 1.5\% (\text{at f > 250 \text{ MHz}} \text{ for V}_{in} < 0.3 \text{ V only})$ $\pm 3\% (f < 100 \text{ MHz})$ $\pm 6\% (f > 100 \text{ MHz})$ $-180^{\circ} \text{ to } +180^{\circ}$ $< 0.5^{\circ} \text{ at V}_{A} = \text{ V}_{B} = 100 \text{ mV}$ $< \pm 3^{\circ} (f < 0.3 \text{ MHz} \text{ of } < 100 \text{ MHz})$ $< \pm 4^{\circ} (100 \text{ MHz} \text{ cf } < 100 \text{ MHz})$ $< \pm 4^{\circ} (100 \text{ MHz} \text{ cf } < 100 \text{ MHz})$ $< \pm 4^{\circ} (100 \text{ MHz} \text{ cf } < 100 \text{ MHz})$ $< \pm 6^{\circ} (500 \text{ MHz} \text{ cf } < 1000 \text{ MHz})$ $= 6^{\circ} (500 \text{ MHz} \text{ cf } < 1000 \text{ MHz})$ $= 6^{\circ} (500 \text{ MHz} \text{ cf } < 1000 \text{ MHz})$ $= 6^{\circ} (500 \text{ MHz} \text{ cf } < 1000 \text{ MHz})$ $= 6^{\circ} (500 \text{ MHz} \text{ cf } < 1000 \text{ MHz})$	$\begin{array}{l} \pm 1.2/-2.3 \ \text{dB} \ (f > 1500 \ \text{MHz}) \\ \hline -90 \ \text{to} \ +70 \ \text{dB} \\ \hline 1.5\% \ (at \ f > 1000 \ \text{MHz} \\ \text{for} \ V_{\text{in}} < 0.3 \ \text{V only}) \\ \hline \pm 3\% \ (f < 500 \ \text{MHz} < f < 1500 \ \text{MHz}) \\ \pm 12\% \ (1500 \ \text{MHz} < f < 2000 \ \text{MHz}) \\ \pm 12\% \ (1500 \ \text{MHz} < f < 2000 \ \text{MHz}) \\ \hline -180^{\circ} \ \text{to} \ +180^{\circ} \\ \hline < 0.5^{\circ} \ at \ V_{\text{A}} = V_{\text{B}} = 100 \ \text{mV} \\ < \pm 1^{\circ} \ (f < 100 \ \text{MHz} < f < 500 \ \text{MHz}) \\ < \pm 4^{\circ} \ (100 \ \text{MHz} < f < 500 \ \text{MHz}) \\ < \pm 12^{\circ} \ (1500 \ \text{MHz} < f < 2000 \ \text{MHz}) \\ < \pm 12^{\circ} \ (1500 \ \text{MHz} < f < 2000 \ \text{MHz}) \\ < \pm 3^{\circ} \ (500 \ \text{MHz} < f < 2000 \ \text{MHz}) \\ < \pm 3^{\circ} \ (500 \ \text{MHz} < f < 2000 \ \text{MHz}) \\ < 3^{\circ} \ \text{over entire range} \end{array}$
asurement range within permissible input el range adout error at fixed frequency vith calibration button (linearity) vithout calibration button difference between A and B) ase asurement range nilnearity at fixed frequency (level applied obt test inputs) act of frequency variation	(see also table on page 151) -110 to +110 dB $\pm 1.5\%$ (V _{in} >1 mV) $\pm 5\%$ (100 μ V <v<sub>in <1 mV) (see also table on page 151) $\pm 2\%$ (f >20 Hz) see also table on page 151 and footnote¹) -180° to +180° <0.5° at V_A = V_B = 50 mV see table on page 151 reference frequency 100 kHz see table on page 151</v<sub>	$\pm 1.5 \text{ dB (f > 500 \text{ MHz})}$ $-90 \text{ to } +70 \text{ dB}$ $\pm 1.5\% (\text{at f > 250 \text{ MHz}} \text{ for V}_{in} < 0.3 \text{ V only})$ $\pm 3\% (f < 100 \text{ MHz})$ $\pm 6\% (f > 100 \text{ MHz})$ $-180^{\circ} \text{ to } +180^{\circ}$ $< 0.5^{\circ} \text{ at V}_{A} = \text{ V}_{B} = 100 \text{ mV}$ $< \pm 3^{\circ} (f < 0.3 \text{ MHz} \text{ of } < 100 \text{ MHz})$ $< \pm 4^{\circ} (100 \text{ MHz} \text{ cf } < 100 \text{ MHz})$ $< \pm 4^{\circ} (100 \text{ MHz} \text{ cf } < 100 \text{ MHz})$ $< \pm 4^{\circ} (100 \text{ MHz} \text{ cf } < 100 \text{ MHz})$ $< \pm 6^{\circ} (500 \text{ MHz} \text{ cf } < 1000 \text{ MHz})$ $= 6^{\circ} (500 \text{ MHz} \text{ cf } < 1000 \text{ MHz})$ $= 6^{\circ} (500 \text{ MHz} \text{ cf } < 1000 \text{ MHz})$ $= 6^{\circ} (500 \text{ MHz} \text{ cf } < 1000 \text{ MHz})$ $= 6^{\circ} (500 \text{ MHz} \text{ cf } < 1000 \text{ MHz})$	$\begin{array}{c} \pm 1.2/-2.3 \ dB \ (f > 1500 \ MHz) \\ -90 \ to \ +70 \ dB \\ 1.5\% \ (at \ f > 1000 \ MHz \\ for \ V_{in} < 0.3 \ V \ only) \\ \\ \pm 3\% \ (f < 500 \ MHz) \\ \pm 6\% \ (500 \ MHz < f < 1500 \ MHz) \\ \pm 12\% \ (1500 \ MHz < f < 2000 \ MHz) \\ \\ -180^{\circ} \ to \ +180^{\circ} \\ < 0.5^{\circ} \ at \ V_{A} = V_{B} = 100 \ mV \\ < \pm 1^{\circ} \ (f < 100 \ MHz) \\ < \pm 4^{\circ} \ (100 \ MHz < f < 1500 \ MHz) \\ < \pm 6^{\circ} \ (500 \ MHz < f < 1500 \ MHz) \\ < \pm 12^{\circ} \ (1500 \ MHz < f < 1500 \ MHz) \\ < \pm 6^{\circ} \ (500 \ MHz < f < 1500 \ MHz) \\ < \pm 6^{\circ} \ (500 \ MHz < f < 1500 \ MHz) \\ < \pm 2^{\circ} \ (1500 \ MHz < f < 2000 \ MHz) \\ < \pm 3^{\circ} \ over \ entire \ range \\ (referred \ to \ 2\times 100 \ mV \ at \ both \ test \ (referred \ to \ 2\times 100 \ mV \ at \ both \ test \ (referred \ to \ 2\times 100 \ mV \ at \ both \ test \ (referred \ to \ 2\times 100 \ mV \ at \ both \ test \ (referred \ to \ 2\times 100 \ mV \ at \ both \ test \ (referred \ to \ 2\times 100 \ mV \ at \ both \ test \ (referred \ to \ 2\times 100 \ mV \ at \ both \ test \ (referred \ to \ 2\times 100 \ mV \ at \ both \ test \ (referred \ to \ 2\times 100 \ mV \ at \ both \ test \ (referred \ to \ 2\times 100 \ mV \ at \ both \ test \ (referred \ to \ 2\times 100 \ mV \ at \ both \ test \ (referred \ to \ 2\times 100 \ mV \ at \ both \ test \ (referred \ to \ 2\times 100 \ mV \ at \ both \ test \ (referred \ to \ 2\times 100 \ mV \ at \ both \ test \ (referred \ to \ 2\times 100 \ mV \ at \ both \ test \ (referred \ to \ 2\times 100 \ mV \ at \ both \ test \ (referred \ to \ 2\times 100 \ mV \ at \ both \ test \ (referred \ to \ 2\times 100 \ mV \ at \ both \ test \ (referred \ to \ 2\times 100 \ mV \ at \ both \ test \ $

1) Additional measurement error at 20 kHz due to direct reception of input frequency: 1% and 0.6°.

VECTOR ANALYZERS 4

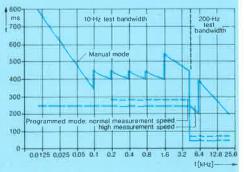
	ZPV plus Tuner						
s-parameter measurement	ZPV-E1	ZPV-E2 (accuracy specifications apply with free	ZPV-E3 juency autoranging switched off)				
Measurement ranges and measurement errors	see vector measurement of magnitud used must be taken into account	de of ratio and phase; in addition, errors a	nd measurement limits of the test setup				
Impedance/admittance measuren	nent						
Measurement error	see ve	ctor measurement of magnitude of ratio a	ind phase				
Measurement range Z measurement HIGH-Z button pressed Y measurement HIGH-Z button pressed	0 to 9999 kΩ 0.1 to 9999 mS	same as for ZPV-E1	same as for ZPV-E1				
Group-delay measurement							
Frequency shift 40 kHz Measurement range Measurement error (for Vin >30 mV) Frequency shift 4 kHz		1 to 10,000 ns, resolution 1 ns $<\pm3\%$ ±3 ns (f = 0.1 to 1000 MHz)	1 to 10,000 ns, resolution 1 ns < ±3% ±3 ns (f >1 MHz)				
Measurement range	< ±3% ±30 ns	same as for ZPV- E1	same as for ZPV-E1				
Measurement range Measurement error (for V _{in} >30 mV) Measurement shift \1 as desired	< ±3% ±300 ns	same as for ZPV-E1	same as for ZPV-E1				
Measurement range	resolution 10 ns (f >25 kHz) 1 ns to 9999 μs	-	-				
Resolution of internal frequency counter	resolution 1 ns (1 <25 kHz) 0.1 Hz (1 <25 kHz) 1 kHz (1 >25 kHz)	-	-				
Measurement times							
Time required for							
synchronization (autom.)	1 <25 kHz: none 25 kHz <f 15="" <10="" mhz:="" ms<br="">10 MHz <f 30="" <50="" mhz:="" ms<br="">(typ. 20 ms)</f></f>	<20 ms	<20 ms				
vector or s-parameter measurement	10 Hz <f <25="" khz:<br="">see diagram below 25 kHz <f <50="" mhz:<br="">35 ms</f></f>	30 ms (level >100 μV) 80 ms (level <100 μV)	30 ms (level >100 μV) 80 ms (level <100 μV)				
	(1-kHz bandwidth, normal measurement speed) 70 ms (1-kHz bandwidth,						
impedance measurement	high measurement speed) same as for vector measurement +25 ms same as for vector measurement	50 ms (level >100 μV) 100 ms (level <100 μV) 150 ms (level >30 mV)	50 ms (level >100 μV) 100 ms (level <100 μV) 150 ms (level >30 mV)				
group deny measurement	+120 ms (level >30 mV) +370 ms (level <30 mV)	400 ms (level <30 mV)	400 ms (level <30 mV)				
General data (ordering information see	next page)						
Rated temperature range							
Operating temperature range Storage temperature range Overall dimensions (W×H×D) Weight	. −40 to +75°C . 93 mm×105 mm×440 mm	same as for ZPV-E1	same as for ZPV-E1				
	. <i>2.1</i> Ny	2.2 kg	and the				

Error of voltage and phase magnitude when using Tuner ZPV-E1 as a function of input voltage and frequency. All the values specified are \pm values referred to 50 mV and 100 kHz.

t V -				1 DI MILL
100 mV-			02 dB 0 1° + 0 08° - 1	0.3 dB 0.1°+0.08° f
30 mV-	dB 0,7°	0 dB 0 t	0.2 dB 0 1°+ 0 06° 1	0.3 dB 0.1°+0.06° f
10 mV 3 mV- 0 15		0.45.40.000	02 dB 02°+006° 1	0.3 dB 0.2°+0.06°- 1
3 my - 0 1	idB 0.8°	0.15 dB 0.2°	0.25 dB 0.2°+0.06°-1	0.35dB 0.2°+0.06° 1
300 µV -	0.5 dB 0.9°	0.5 dB 0.5°	0.6 dB 0.5° + 0.06° 1	0.7 dB 0.5°+ 0.06°. f
100 µV No values specified	0.5 dB	0,5 dB 2°		
30 µV -	1 dB	5°	1.1 dB 5*+ 0.06*+ f	1.2 dB 0.5°+0.06°
10 µV 10 Hz	50 Hz 25	kHz 1 M	/iHz 10 l	MHz 50 MHz

Time required for vector or s-parameter measurement over the frequency range from 10 Hz to 25 kHz using Tuner ZPV-E1

Cio MH2



4 VECTOR ANALYZERS

network analyzers

Order designations	
Basic unit	
ZPV without tuner	Vector Analyzer ZPV
	291,4012,93
Tuners	000 0510 00
ZPV-E1 10 Hz to 50 MHz ZPV-E2 100 kHz to 1 GHz	292.0010.02
ZPV-E2 100 kHz to 1 GHz including 2 BNC adapters 237 3 ground terminals 237	7.5650.00
2 insulators 237	7.5020.02
2 100:1 dividers 237	7,2550.02
2 insulators 237 2 100:1 dividers 237 1 probe tip 237 1 accessory case 292 ZPV-E3 300 kHz to 2 GHz	2.0827.00
ZPV-E3 300 kHz to 2 GHz	301.7018.02
Options (for retrofitting)	
EC-bus Option	ZPV-B1 292.3610.02 (including 2 m IEC-bus
	cables)
S-parameter Option Group-delay Option	ZPV-B2 292.3810.02 ZPV-B3 292.3910.02
and a priority option	(including calibration
	cable for 50 ns)
Recommended extras	7PV-71 202 2712 50
nsertion Adapter N female/male connectors)	(at least two units
Feed Unit, 50 Ω	(at least two units required) ZPV-Z2
connectors: generator – BNC,	
others – N female) Directional Coupler, 45 dB, 50 Ω	
RF input: N male, others N fema	ale) (at least two units
Pair of Test Cables, 50 Ω, N male	ale) (at least two units required) ZPV-Z4 335.1012.50 ZPV-Z5 335.1112.50
S-parameter Test Adapter	ZPV-Z5 335 1112 50 ZPV-Z6 265 3512 02
/SWR bridges /SWR Bridge 50 Ω	ZRB 335 2819 50
50 O	SWOB4-7 912 7003 00
/5Ω	SWOB4-Z 912 7303.00
Ferminations, attenuators, coup	
Precision Termination	RNA 272.4510.50 RNB 172.4910.50
Shortcircuit N male connector	017.8080.00
Shortcircuit N male connector Attenuator, 10 dB	DNF 272.4210.50 N/BNC 118.2812.00
ouniere angle connectore	
Feedthrough Termination	RAD 289.8966.00
with ZPV-E1 only)	
Equipment and accessorian automatic network and	es to expand the ZPV into
Controllers	
Process Controller	
PUC without keyboard	PUC-Z1 345 2011 04
Iser Keyboard	PUC-Z2 345.2111.06
Pedal Switch	PUC-Z3 345.2211.02
Software Basic Software for	
Process Controllers PUC	ZPV-K10 291.8818.02
	ZPV-K1 292.2113.02

ZPV-K5

PUC-B2 PUC-B5 PUC-B6

PUC-B7

SMS

SWP XPC SPN

IEC-bus cable, 1 m PCK 292.2013.10

Tektronix 4051, 4052 HP 9835 and 9845

Signal Generator

Sweep Generator Synthesizer Generator Generator

291.8918.02

292.2213 02 292.2513 02

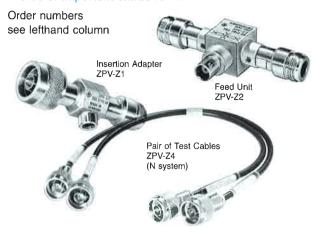
345.2711.02 343.6103.02 345.3118.02

345.2811.02

302.4012.22

339.0010.02 337.8014.52 336.3019.02

Photos	of	impor	tant	extras	for	7PV
1 110103		IIIIDOI	lant	CAUGS		<u>~</u> I V



VSWR Bridge ZRB ♦ 5 to 2000 MHz

The ZRB permits accurate measurement of reflection coefficient for magnitude and phase and is particularly suitable for use in conjunction with the Vector Analyzer ZPV (page 142) or the Polyskop SWOB 5 (page 132).



ZRB

Directivity Characteristic impedance	
Reflection coefficient	
at test-item connector	< 0.09
Measurement error	<0.09 0.005 + 0.09 r ² (r = measured reflection coefficient)
Attenuation	,
Input to test-item connector Test-item conn. to output.	
Max. load	
Dimensions (without connectors)	
Order designation	► VSWR Bridge ZRB 335.2819.50



VSWR Bridge SWOB 4-Z 10 to 1000 MHz

For reflection-coefficient measurements in conjunction with the Polyskop SWOB 5 (page 132) or the Vector Analyzer ZPV (page 142). Depending on the indicator used, either the magnitude alone or the magnitude and phase of the reflection coefficient can be determined.

Characteristic impedance	50 or 75 Ω , connectors: N male (test item) N female (input/output)
Directivity	
Measurement error	$0.01 \pm 0.12 r^2$ (r = measured reflec-
Transmission loss Dimensions (without connectors)	
Order designation 50-Ω model 75-Ω model	VSWR Bridge SWOB 4-Z 912.7003.00

Options

Signal generators

Additional items

DIRECTIONAL COUPLERS 4

Directional Coupler ZPV-Z3 for measuring s-parameters

- ♦ 1 to 1000 MHz
- High precision due to directivity >45 dB
- Universal application with high and low power levels at test item
- Robust construction



Principle and characteristics

The measurement of current by magnitude and phase (vector measurement) remains a difficult problem. It has therefore become common practice to evaluate derived quantities, i.e. forward wave (a) and reflected wave (b) instead of current and voltage.

Forward wave a =
$$\frac{V}{2\sqrt{Z_L}} + \frac{1\sqrt{Z_L}}{2}$$

Reflected wave b = $\frac{V}{2\sqrt{Z_L}} - \frac{1\sqrt{Z_L}}{2}$

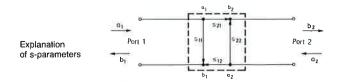
These wave quantities can be measured with good accuracy in a relatively simple way using directional couplers.

The **directional coupler**, by definition, combines current and voltage according to these formulas and delivers at its outputs voltages proportional to a and b. It is mainly characterized by its directivity, which expresses in dB the degree to which a clear distinction is possible between forward wave and reflected wave.

The Rohde & Schwarz directional couplers here proposed for s-parameter measurements feature high directivity; it is >45 dB, affording an error <0.6%.

s-parameter measurement. When the input and output waves $(a_1, b_1; a_2, b_2)$ are measured instead of currents and voltages at a two-port (see diagram), the s-parameters are represented by the following ratios:

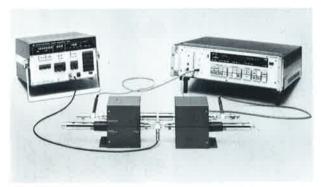
- $b_1/a_1 = s_{11}$ Input reflection coefficient at port 1 with port 2 match-terminated
- $b_2/a_1 = s_{21}$ Forward transmission coefficient from port 1 to port 2 with port 2 match-terminated
- $b_2/a_2 = s_{22}$ Output reflection coefficient at port 2 with port 1 match-terminated
- $b_1/a_2 = s_{12}$ Backward transmission coefficient from port 2 to port 1 with port 1 match-terminated



For measuring s-parameters one directional coupler for the input quantities, one for the output quantities and a third (reference coupler) for the voltage required to form the ratio are needed.

Construction

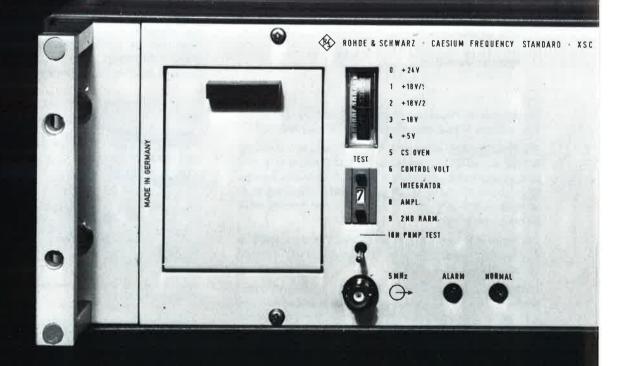
The directional couplers are of symmetrical design. It is therefore possible to interchange the connections to the test item and to the indicator, thereby applying alternatively a high level (e.g. for power amplifiers) or a low level (e.g. for antenna amplifiers) to the test item. This opens up a wide range of applications in RF measurements.



Reflection measurement using Signal Generator SMS, Vector Analyzer ZPV and Directional Couplers ZPV-Z3

Specifications
Frequency range 1 to 1000 MHz Characteristic impedance 50 Ω (both ends) 45 dB Directivity 45 dB Coupling attenuation at 1 GHz 3 dB Max. permissible forward power 0.5 W Connectors at input N male to instrument N female to test item precision N female
Dimensions, weight
Order designation Directional Coupler ZPV-Z3 292.3110.50
Recommended extres
Termination RNA 272.4510.50 1 set of charts DIN-A3 format 274.1619.00
Impedance meters and signal generators
Vector Analyzer ZPV page 142 Power Signal Generator SMLU page 70
(For other signal generators see section 2)

Caesium Frequency Standard XSC with Digital Clock CADM; details on page 158



0

standardfrequency and standard-time systems



1

5 FREQUENCY STANDARDS

Frequency standards

Frequency standards are the heart of many test and communications sets, governing their frequency accuracy. Supplying at least one signal with a very stable period which is not affected by environmental conditions and which is always an integral fraction of a second, frequency standards are also time standards.

There exist primary and secondary standards as for mechanical measurements.

Primary frequency standards produce the output frequency with a caesium beam atomic clock as defined by the 13th general conference on weights and measures of October, 1967. Such units are used for scientific purposes, for navigation and for calibration tasks.

Secondary frequency standards are used to a much greater extent, particularly in electronic measurements and communications engineering. Their accuracy and stability, though inferior, still amply fulfil the practical requirements. Moreover, with the aid of commercially available equipment (frequency controllers, standard frequency receivers and phase recorders: XKE 2, XKP) the secondary standards can be corrected at any time by radio – automatically, if necessary – against primary standards. The advantages of simpler design make up for the reduced accuracy of the secondary standards: high reliability and relatively low purchasing and operating costs. Primary standard frequency transmissions can be received all over the world.

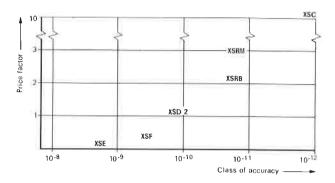
Class of accuracy. A secondary frequency standard is characterized by the **aging** of its oscillator. This is the monotonic frequency drift which is independent of environmental influences. All Rohde & Schwarz frequency standards are so designed that the frequency error due to external effects is of the same order as the guaranteed daily aging. This value determines the class of accuracy, which is **typical** of the quality of the standard.

Stability is the general term for **accurate** information about the frequency drift caused by aging and environmental influences (long-term and short-term frequency stability and frequency drift).

Instrument models. Rohde & Schwarz makes frequency standards of different frequency stability to meet a wide range of requirements. The sets also differ in other features, such as automatic frequency correction capability (XSD 2, XSRM), built-in standby battery, higher or lower setting accuracy of the frequency trimmer. A suitable frequency standard can thus be selected for every application.

standard-frequency and

The frequency standards of high stability (XSC, XSRM and XSD 2) are designed for continuous operation because aging decreases with the operating time. Shortness of warmup time is less important than low power consumption to save the built-in or external battery. In contrast, the oscillator modules XSRB, XSE and XSF have a particularly short warmup time, small dimensions and low weight.



Relation between price and accuracy (stability) of frequency standards

R&S line of standard-frequency and standard-time modules

The new generation of R&S modular standard-frequency and standard-time units allows economical, customized standard-frequency and standard-time systems to be made up (overview on page 160).

The individual modules are compact functional blocks that can be combined into systems exactly in line with technical requirements. This flexibility permits adaptation to the user's needs and, moreover, fitting of additional modules if different technical needs arise at a later date.

Electrical characteristics

All modules are designed for **supply** with 22 to 32 V DC. Connection to all conventionally used AC supply voltages is possible by means of the Power Supply XSRM-Z laid out for a maximum permanent output current of 1.6 A. The XSRM-Z contains a 0.8-Ah NiCd cell battery for buffer operation, which feeds the units connected (e.g. the XSRM for a maximum of one hour) in case of an AC supply failure. The buffer circuit is also effective when modules are fed direct from an airborne 28 V DC supply.

When a Rubidium, Frequency Standard XSRM and other modules have a common power supply, the XSRM automatically has priority during its warmup phase (about 20 minutes) of higher current drain, meaning that the other modules connected are not fed via the associated connectors during this period.

standard-time systems

Once the warmup phase is completed, the current consumption of the XSRM drops to about 0.7 A, so that 0.9 A is available to feed other modules. Only one XSRM can be operated at a time from one power supply. The standby power supply of the Caesium Frequency Standard XSC functions in a similar way, offering 0.55 A for feeding other modules only after a warmup period of about 20 minutes. Here again a NiCd cell battery ensures continuity of operation in case of an AC supply failure.

Connecting cables. Two-pole connecting cables, both ends equipped with LEMO connectors, are used to convey the supply voltage from the Power Supply XSRM-Z or the Caesium Frequency Standard XSC to the modules.

For the connection of two loads to one DC output of the Power Supply XSRM-Z it is recommended to use the DC connecting cable with order number 346.2015.02 (0.5 m long, fitted with LEMO connectors).

Two-pole cables with one LEMO connector and two banana plugs are provided for feeding the modules from an external battery. One such cable is supplied with each module. RF and control signals are transmitted via coaxial cables with BNC male connectors.

Typical current drain after warmup at 24 V DC and +25 °C ambient temperaturte:

XSRM	0.7 A*	XSRM-Z3	0.18 A
XSC	1.05 A	XSRM-Z	0.09 A
XSD 2	0.06 A	(freq. conv.)	
XKE 2	0.40 A	CADM w/o	0.25 A
		with LED display	0.30 A

*During warmup approx. 1.8 A.

FREQUENCY STANDARDS 5

Construction, functional blocks

The modules are compact units with a front-panel width of

- 50 mm (XSRM-Z, XSRM-Z3) or
- 100 mm (XSRM, XSD 2, XKE 2, CADM, Power Supply XSRM-Z) or
- 200 mm (XKP)

and a height of 133 mm, in line with DIN and ANSI recommendations.

Individual modules can be combined into stable functional setups (see also page 160 for possible combinations) in the following ways:

For 19" racks, 19" cabinets, DIN racks

A 19" frame (237.6840.02), which may be inserted in 19" racks or 19" cabinets (237.7317.02) or mounted in DIN racks with the aid of adapters, accommodates any modules of 50, 100 and 200 mm width up to an overall width of 400 mm.

The standard frame has two 50-mm and two 100-mm wide blank panels screwed to both its front and rear sides, leaving space for 100 mm module width.

Smaller module groups (except XKP) of 250 mm maximum width may be incorporated into a smaller cabinet of 5/8 of 19" width with a fixed frame (237.6040.02). Blank panels of 100 mm and 50 mm for both the front and rear are included.

The Caesium Frequency Standard XSC is always incorporated in a special 19" frame and delivered with a cabinet. Instead of the blank panel a module of 100 mm width (or two of 50 mm) can be inserted.

Overview

Output frequencies	Designation	Туре	Order No.	Frequency error	Stability (aging after 10 days of operation)	Output voltage EMF	Source impedance Ω	Text on page
Frequenc	y standards							Module system 160
5 MHz	Caesium- Frequency Standard	XSC	299.4011.02	7×10-12	$<3\times10^{-12}$ for the whole tube life	2 V	50	158
5 MHz	Rubidium Frequency Standard	XSRM	238.4011.02	-	$<1\times10^{-11}/month$ typ. $<8\times10^{-12}/month$	1 V	50/100	162
5 MHz	Crystal Oscillator	XSD 2	283-6010-02		<2×10 ⁻¹⁰ /day	1 V	50/100	163

Oscillator modules

5 MHz	Rubidium Oscillator	XSRB	216.0213.03	-	$<2 \times 10^{-11}$ /month	1 V	50	168
1 to 10 MHz	Crystal Oscillator	XSE	100.7641 (complete No. see text)		<3× 10 ⁻⁹ /day	0.5 V	500	170
5 MHz	Crystal Oscillator	XSF	100 5578.02		<5×10 ⁻¹⁰ /day	0.5 V	500	170

5 CAESIUM FREQ. STANDARD

standard-frequency and



While secondary frequency standards, such as the Rubidium Frequency Standard XSRM and the Rubidium Oscillator XSRB (which are dealt with later), require recalibration in spite of their high frequency stability, this is not necessary for primary frequency standards.

The **Caesium Frequency Standard XSC** is a primary frequency standard whose frequency is basically determined by the beam tube principle so that it requires no recalibration during its whole life.



Caesium Frequency Standard XSC and Digital Clock CADM

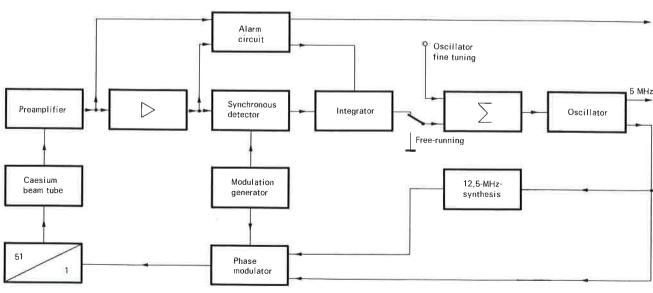
Characteristics and uses

The XSC is ideal for all applications in which frequency recalibration is not feasible, e.g. in mobile use, or where it is impossible to receive a standard reference frequency.

The Caesium Frequency Standard XSC features the most modern design, small dimensions and low power consumption. In the case of AC supply failures, a standby power supply automatically takes over and is recharged when the AC supply voltage is present again.

Extension units

For extending the XSC, the R&S standard frequency module line is available (see page 160). In addition to the standard frequency of 5 MHz, the Frequency Converter XSRM-Z delivers output signals at 0.1 MHz, 1 MHz and 10 MHz.



Block diagram of Caesium Frequency Standard XSC

standard-time systems

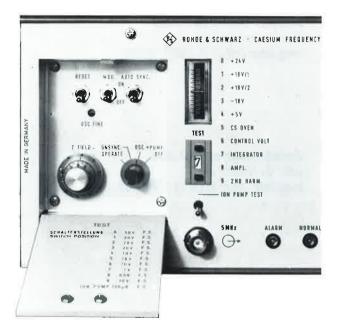
CAESIUM FREQ. STANDARD 5

The Phase Comparator XSRM-Z3 permits easy phase comparison between the Caesium Frequency Standard XSC and external test items at the frequencies 1/2/3 to 10 MHz.

In conjunction with the Digital Clock CADM the XSC constitutes a clock of absolute accuracy which can be used for control purposes and as a mobile time reference.

Operation

The XSC is extremely easy and convenient to operate. A number of its functions can be readily checked with the aid of a front-panel switch,. The frequency-determining elements are protected by a flap to prevent unauthorized access to the instrument settings.



Front panel of Caesium Frequency Standard XSC

Description

The Caesium Frequency Standard XSC uses a hyperfine level transition in the caesium-133 atom as a reference to keep a 5-MHz crystal oscillator in phase lock. The caesium beam tube used is an ultramodern development meeting higherst requirements with respect to reliability, long life and other essential characteristics. The 5-MHz crystal oscillator features extremely low noise and aging.

Specifications
Output frequency . 5 MHz,
with option XSRM-Z:
0.1/1/5/10 MHz Output EMF 2 V _{rms}
Output impedance 50 O
Connectors BNC female on front and rear panel
Harmonics
S/N ratio with offset from carrier
1 Hz
10 Hz 120 dB test bandwidth
100 Hz
1 kHz 140 dB J
Frequency stability
Error at 0 to 50 °C≦7×10 ⁻¹²
Reproducibility <3×10 ⁻¹²
Setting error≦2×10 ⁻¹³
Long-term drift (referred to tube life)
Short-term drift
for $\tau = 1 \text{ s} \dots 3 \times 10^{-11}$
10 s 1×10-11
100 s 5×10 ⁻¹² 1000 s 2×10 ⁻¹²
10,000 s
100,000 s 3×10-13
General data
Operating temperature range 0 to +50°C
Storage temperature range -20 to +50 °C
Humidity max. 95% (for operating
temperature range) Vibration
Vibration MIL-STD-167-1 Power supply
AC supply
47 to 440 Hz (70 VA)
External battery 22 to 28 V, max. 40 W
Internal battery backup time (standby): 0.5 h Dimensions, weight
(XSC alone) 492 mm×161 mm×514 mm, 23 kg
Guarantee period for caesium
beam tube

Ordering information

Order designation Caesium Frequency Standard XSC 299.4011.02

Accessories supplied

- 1 two-core connecting cable (for external battery) 1 RF connecting cable (0.5 m, BNC) 1 connecting cable (0.1 m, for standby power supply) 1 power cable

Options (see page 166)

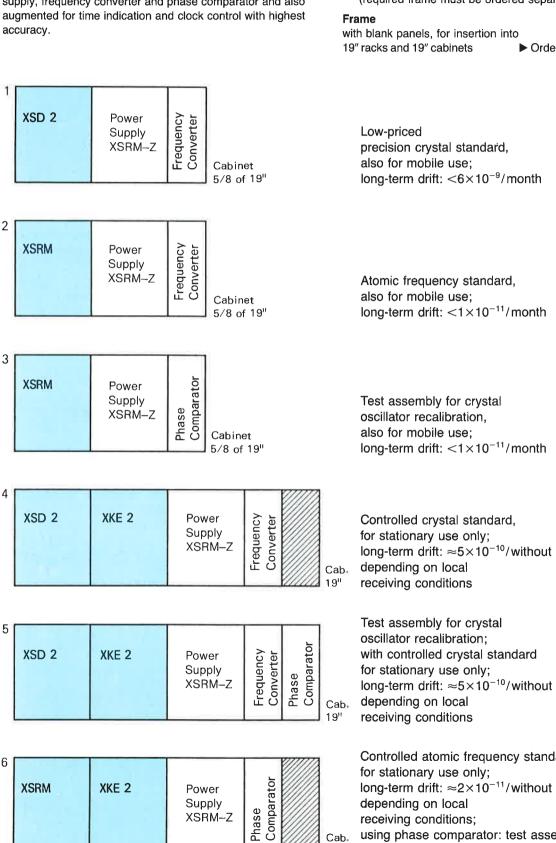
Frequency Converter XSRM-Z	238.0616.02
Phase Comparator XSRM-Z3	278.9314.02
Digital Clock CADM	299.6014.02

5 STANDARD FREQUENCY **MODULES**

Standard-frequency module system

The Rubidium Frequency Standard XSRM and the Crystal Oscillator XSD 2 (if required in conjunction with the Standard Frequency Receiver XKE 2) are the basic units of a modular system which can be extended step by step by a power supply, frequency converter and phase comparator and also augmented for time indication and clock control with highest accuracy.

standard-frequency and



Available standard cabinets for housing the modules:

Cabinet

a) 5% of 19", with frame and blank panels

Order No. 237.6040.02

Order No. 237.7317.02

b) 19", without frame (required frame must be ordered separately)

Order No. 237.6840.02

long-term drift: $\approx 5 \times 10^{-10}$ /without limit,

long-term drift: $\approx 5 \times 10^{-10}$ /without limit,

Controlled atomic frequency standard, long-term drift: $\approx 2 \times 10^{-11}$ /without limit, using phase comparator: test assembly

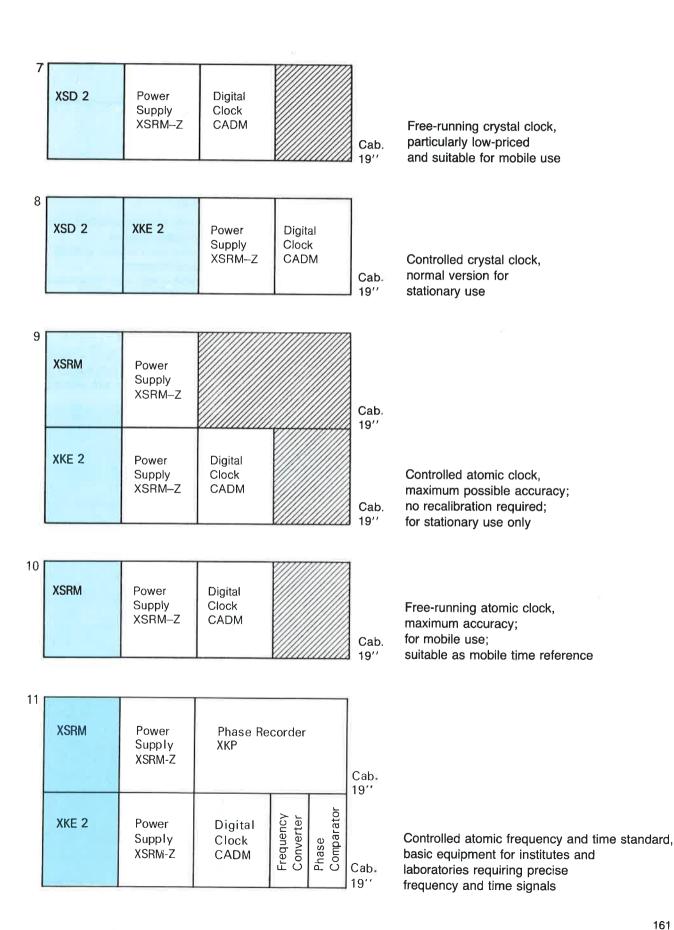
for crystal oscillator recalibration

19"

standard-time systems

FREQUENCY/TIME 5 **STANDARDS**

Standard-frequency/standard-time module system



161

5 FREQUENCY STANDARDS

standard-frequency and



The design of this compact **Rubidium Frequency Standard** is based on R&S's more than 40 years of experience in building standard-frequency equipment. Up-to-date technology has been employed, resulting in a very small and favourably priced instrument. In addition to the excellent technical performance, high reliability is of great importance, particularly for controlling TV transmitters.

The XSRM is the basic unit of a modular system and can be expanded by a standby power pack (see power supply) and a plug-in frequency converter which delivers several coherent frequencies. These 19" subunits form a modular system and can be combined according to the requirements (see page 160).

Output frequency, stability. The XSRM delivers a 5-MHz sinusoidal output voltage (1 V EMF) of extremely high spectral purity (S/N ratio \ge 125 dB). The frequency drift due to aging is less than 1×10^{-11} /month. In conjunction with the Frequency Converter XSRM-Z frequencies of 10 MHz, 5 MHz, 1 MHz and 100 kHz can be generated.

Description

The XSRM makes use of one of the atomic resonances of Rb 87, an isotope of the alkali metal rubidium. The Rubidium Frequency Standard operates on the gas-filled cavityresonator principle with optical excitation and optical scanning. A precision crystal oscillator is continuously controlled, compensating for the drift due to aging.

Power supply. The basic unit is for DC voltage. The builtin stabilizer handles voltages varying from 22 to 32 V.

The optional power pack enables operation from the AC supply. Should the AC supply fail, a built-in battery automatically takes over and is recharged when AC power is restored (see page 166).

Rubidium Frequency Standard XSRM

- ♦ 5 MHz
- Long-term drift $<1 \times 10^{-11}$ /month (typ. 8×10^{-12})
- High spectral purity of output signal
- (signal-to-noise ratio ≧125 dB)
- High reliability and long life
- Three years guarantee for spectral lamp and resonant cell

Applications

Due to its excellent characteristics, the XSRM opens up a variety of applications, such as

- > control of standard-frequency and standard-time systems
- > mobile and fixed radionavigation systems
- > satellite communications and time multiplex systems
- ▷ geodesy, research in natural resources
- > single-sideband transmission at very high frequencies
- ▷ control of TV transmitters with precision offset
- ▷ colour TV central control of studio sync generators
- ▷ radar systems, signal encoders
- ▷ calibration of synthesizers and counters.

With its high short-term stability, the XSRM is suitable for buffer operation of caesium standards, which feature even higher frequency accuracy but worse short-term stability.

Specifications	
Output frequency Output EMF	
Harmonics S/N ratio (at ≧100 Hz from carrier) Non-harmonic spurious frequencies	>30 dB down ≧125 dB (1-Hz bandwidth)
Stability	
Long-term drift	$\leq 1 \times 10^{-11}$ /month, typ. 8×10 ⁻¹² /month
(standard deviation) Effect of ambient temperature Effect of supply voltage	≦2×10 ⁻¹² /°C
Frequency correction	
Setting range mechanical, with potentiometer Setting error electrical, via control input	$\leq 5 \times 10^{-12}$
Nominal conditions Rated temperature range Storage temperature range Warmup time for $\Delta f/f < 10^{-10}$	-40 to +70°C
General data	
Power supply Current drain	22 to 32 V (DC) max. 1.8 A during warmup approx. 0.7 A after warmup at 24 V and +25°C
Dimensions, weight	100 mm×132 mm×390 mm, 3.7 kg
Ordering information	
Order designation	Rubidium Frequency Standard XSRM 238.4011.02
Recommended extra modules	see pages 160 and 166
Guarantee period for spectral lamp	and resonant cell: 3 years

standard-time systems

FREQUENCY STANDARDS 5

Crystal Oscillator XSD 2

- ♦ 5 MHz
- Classe of accuracy 10⁻¹⁰
- High spectral purity of output signal
- Input for frequency-correction voltage



The **Crystal Oscillator XSD 2** is a particularly low-priced frequency source in the R&S standard-frequency module line. It features low aging and high short-term stability, and is very little affected by temperature variations.

The XSD 2 can be combined with any of the other units of the modular system (see pages 160/161).

When used with the Power Supply XSRM-Z (see page 166) the Crystal Oscillator has a backup time of more than 6 hours.

Output frequency, stability. The Crystal Oscillator delivers a 5-MHz sinusoidal signal of high spectral purity directly at two outputs (output EMF 1V). The frequency drift due to aging is less than 2×10^{-10} /day.

For different frequencies, the XSD 2 can be used in conjunction with the Frequency Converter XSRM-Z (see page 166) so that signals of 10 MHz, 5 MHz, 1 MHz and 100 kHz are available in phase lock.

Frequency correction. The frequency of the XSD 2 can be corrected with the aid of a calibrated potentiometer and via a control-voltage input, for instance with the Standard Frequency Receiver XKE 2.

Power supply. The XSD 2 uses 24 V DC, but the built-in regulator handles supply fluctuations between 22 and 32 V without affecting the accuracy.



XSD 2 used in a setup for calibration laboratories

Example of application

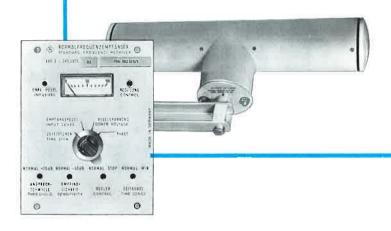
The combination of XSD 2 plus XKE 2 is a particularly lowpriced setup for producing precise frequencies for use in calibration laboratories – although, if the accuracy requirements are more stringent, the combination of the Rubidium Frequency Standard XSRM and the XKE 2 is to be preferred.

Specifications	
Output frequency	5 MHz 1 V _{ms} \pm 10%, Z _{out} = 50 Ω \pm 10% (rear socket) Z _{out} = 100 Ω \pm 10% (front-panel socket)
S/N ratio (at ≧100 Hz from carrier), 1-Hz test bandwidth	>30 dB down >130 dB BNC female
Stability	
Long-term drift after 5 days of cont. operation after 30 days of cont. operation Short-term drift (standard deviation)	<2×10 ⁻¹⁰ /day
Effect of ambient temperature Effect of supply voltage variations Effect of load (open circuit/50 Ω)	<5×10 ⁻¹¹ /°C <1×10 ⁻¹¹ /10%
Frequency correction	2×10-7
Nominal conditions	
Rated temperature range \dots Storage temperature range \dots Warmup time for $\Delta f/f \leq 10^{-8}$	-40 to +70°C
General data	
Power supply Current drain	22 to 32 V DC max. 300 mA (approx. 60 mA after warmup at 24 V and +25°C) 100 mm×132 mm×390 mm, 2.5 kg
Dimensions, weight	100 mm×132 mm×390 mm, 2.5 kg
Ordering information	
Order designation	Crystal Oscillator XSD 2 283 6010 02
Recommended extra modules	see pages 160 and 166

5 FREQUENCY STANDARDS

standard-frequency and

XKE 2 + Ferrite Antenna



The **XKE2** is a universal standard frequency receiver which permits control of crystal and atomic frequency standards. It is available for all frequencies in the range 10 to 200 kHz, including the frequencies of the OMEGA-navigation transmitters in use all over the world.

Characteristics and uses

The receiver includes a preselection circuit, thus featuring excellent characteristics with respect to sensitivity and protection against interference. In addition, the Standard Frequency Receiver XKE2 uses ALC so that high reliability is ensured even under adverse conditions of reception.

The combination of Standard Frequency Receiver XKE 2 and the Crystal OscillatorXSD 2 (see page 163) replaces the time-proven setup XKE/XSD and is a particularly low-priced solution to the problem of producing precise standard frequencies.

The accuracy is increased when using the combination XKE2/XSRM (Rubidium Frequency Standard, see page 162). Thanks to the higher inherent stability of the XSRM, a considerably longer control time constant can be selected, enabling improved averaging of the frequency variations of the received signal caused by propagation fluctuations.

The frequency accuracy of the XKE 2/XSRM combination corresponds to an unlimited long-term drift of 2×10^{-11} . The receiver is designed for a control time constant which can be extended up to 148 days.

The broadband, active Ferrite Antenna XKE 2-Z1 (see photo) is particularly suitable asreceiving antenna. Its 50- Ω output impedance matches the receiver. The antenna is weather-proof and can be installed either indoors or outdoors depending on the receiving conditions; power supply: 10.5 V DC \pm 10%, max. 6 mA.

Description

The Standard Frequency Receiver comes as a subunit for a 19" chassis and can be combined with all other modules of the R&S standard-frequency system.

The XKE 2 is equipped with a time-signal output so that when receiving time-signal-modulated standard-frequency transmitters the corresponding time information is simultaneously available.

Standard Frequency Receiver XKE 2

- 10 kHz to 200 kHz
- Recalibration of crystal and atomic frequency standards
- Selectable receive frequencies (plug-in boards)
- High sensitivity and excellent protection against interference thanks to preselection
- Time-signal output
- Worldwide reception of OMEGA-navigation transmitters

Specifications

opeenieuterie	
Receive frequency f ₁	internally selectable; other frequencies possible in the range
Input voltage of receive frequency f1	10 to 200 kHz
Input impedance	100 µV to 1 V
Controlled frequency f2	
Input voltage of controlled frequency f2 Input impedance	>500 Ω
Capture range for controlled frequency $f_2 (\Delta f/f) \dots$	>1 × 10 ⁻⁷
	8 time-constant factors internally selectable: $16/32/64/128/256/512/$ $1024/2048 \times 6.25 \times 10^{-7}$ (s/V); for accelerated control:
	1×6-25×10 ⁻⁷ s/V
	externally switchable to smallest factor
Control inputs	
Time-constant switching	smallest control time constant
Receiver-sensitivity switching	control stop
Hoodiver sensitivity switching	40-dB attenuation
Outputs	
Control voltage	0 to +10 V, max. 5 mA;
Phase difference	
Filase difference	short-circuit-proof;
Received-signal level	0 to 100 μs phase difference
neceived signal level	short-circuit-proor;
	approximated logarithmic indication ≈ 4 dekades
Time signal	TTL levels
Fault signal 1-MHz standard frequency	TTL levels
i mine standard noquency	$Z_{out} = 50 \Omega$; phase-locked
General data	to receive frequency
Phase error as function of	
ambient temperature	<1 µs/10 °C (<5 µs for OMEGA
Rated temperature range	frequencies) 0 to +50°C
Storage temperature range Power supply	$-40 \text{ to } +70^{\circ}\text{C}$
Current drain	max 400 mA
Dimensions, weight	100 mm×132 mm×390 mm, 2.5 kg
Ordering information	
Order designations	Standard Frequency Receiver XKE 2 291.0017.02
Filter XKE 2-B1	
for 60, 75 and 77.5 kHz for other frequencies (on request)	. 299.3015.02
Accessories supplied	
1 two-core connecting cable (for ex	ternal battery)
2 RF connecting cables (BNC) 1 connecting cable (for control volta 1 two-core connecting cable (for sta	
Recommended extras	
	299.3515.50
	RF connecting cable (BNC) 25 m, 103.1238.00

standard-time systems

DIGITAL CLOCK 5

Digital Clock CADM

- Years/days/hours/ minutes/seconds
- Time information in BCD code
- Phase adjustment with a resolution of 0.1 µs
- Control output for slave clocks
- Seconds pulses produced from 5 MHz
- Synchronization input



The **Digital Clock CADM** is an extension of the R&S standard-frequency module line permitting standard-time systems to be set up. It can be combined with the Crystal Oscillator XSD2, the Rubidium Frequency Standard XSRM and the Caesium Frequency Standard XSC.

Characteristics, uses

The CADM features interference rejection which meets the most stringent requirements so that even in the case of heavy ambient disturbance, for instance in mobile use, no time error occurs.

In conjunction with atomic frequency standards the CADM is a high-quality precision clock complying with the strictest specifications stipulated for time standards. It can be used in time-signal systems, for master clock control, for scientific purposes and as a mobile time standard.

The accuracy of the clock is determined by the frequency stability of the time interval generator. The R&S product range includes interval generators accurate to 10^{-10} /day and the high-accuracy Caesium Frequency Standard XSC (5×10⁻¹² with no systematic drift).

Time display, setting and readout. The time is read out digitally in hours, minutes and seconds on the CADM front panel. Calendar display can be selected with the aid of the DIGIT button, the current number of the day of the year (0 to 364 or 365) being read out plus a year figure. The year figure is counted in cycles from 0 to 3, with 0 marking a leap year. The Digital Clock can be advanced and run backwards using pushbuttons. The time can be set with high accuracy thanks to a digitally adjustable phase shifter with a resolution of 0.1 μ s. The CADM can be started automatically via a synchronization input, and a key switch prevents unauthorized access to the instrument settings.

In addition to the digital time display on the front panel the time information is also available as a BCD code at the female multiway connector on the rear panel. The CADM also supplies a time advance signal whose polarity alternates every 1 s or 1 min for controlling **external time systems** (e.g. slave clock systems from Siemens).

Pulses of 20 μ s duration, delayed or undelayed, are available at two BNC outputs for time comparison measurements and synchronization purposes.

An automatic monitoring circuit indicates interruptions of normal operation, detecting even momentary faults.

Specifications

Readout Display of	
time of day	hours 00 to 23
	minutes 00 to 59 seconds 00 to 59
	seconds 00 to 59
calendar	
	year figure 0 to 3
	(0 = leap year)
Time setting	
	setting error ±0.1 µs
Control, signal inputs	
Input for timebase signal	
Input frequencies	1/2/2.5/5/10 MHz
Input frequencies Input level Input impedance Synchronizing input	0.2 to 2 V _{ms}
Input impedance	>500 Ω, BNC female connector
Synchronizing input	TTL levels, positive; BNC female
	connector
Synchronizing error	1.5 μs ±0.5 μs
Signal outputs	
Seconds pulses	
undelayed (clock normal)	
Output EMF	+ 2 to + 20 V (adjustable)
Output impedance	50 Ω, BNC female connector
Rise time	
delayed (clock delay)	
Phase of deleved appoints	pulses, except for phase position
Phase of delayed seconds pulse referred to undelayed	
seconds pulse	adjustable from 0 to 0.99999999 s
	with phase shifter (0.1-µs steps)
Control signal for clock systems	
Waveform	
	each polarity of 1 s or 1 min duration
Outertail	(switch-selected)
	±12 V or ±24 V (int. selectable)
Output current	37-way female (Canpon)
Connector Time information given	vears (vear figure) days hours
	minutes seconds
Output levels	TTL (BCD code), negative or positive
	logic selectable
Connector	37-way female (Cannon)
Performance monitoring	
-	interruptions of normal operation are
	automatically stored and indicated
Tamper-proofing the time setting	by disabling the operating controls
	with the exception of the lime-of-day/
	calendar selector
General data	
Rated temperature range	+5 to +45°C
Storage temperature range	-20 to +70 °C
Power supply	22 to 32 V DC
Current drain	0.25 A (LED display switched off)
Dimensions, weight	0.3 A (LED display switched on)
Dimensions, weight	100 mm×132 mm×375 mm, 2 kg
Ordering information	
0	
Order designation	Digital Clock CADM
	299.6014.02
Accessories supplied:	
Power cable for connection to stand	by power supply;
battery cable for connection to an ex	
	tore): 27 way Cannon

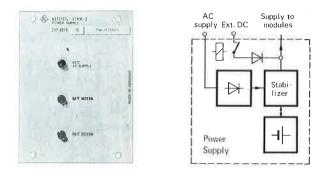
battery cable for connection to an external battery; RF connecting cable (2 BNC connectors); 37-way Cannon connector; adapter board for operating individual plug-in cards when withdrawn from the unit



standard-frequency and

Additional units of standard-frequency module system (overview see pages 160 and 161)

Power Supply XSRM-Z



The Power Supply XSRM-Z contains a maintenance-free NiCd cell battery which feeds the instruments connected (e.g. XSRM or XSD2) for one to six hours in the case of AC supply failure. The XSRM-Z delivers a peak current of 1.6 A.

During AC supply operation, the battery is automatically charged. Switchover from AC-supply to battery operation is also automatic.

The self-heating effects is only slight since high efficiency is obtained by a control circuit making use of the angle of current flow. The XSRM-Z can also be fed from an external battery. Three front-panel lamps indicate the mode of operation (AC supply/internal battery/external battery). The internal-battery lamp starts flashing if the charge falls below a threshold level.

Specifications of Power Supply XSRM-Z
Input voltage
Voltage during battery operation
XSRM), battery operation at 25°C General data Rated temperature range -20 to +45°C
Storage temperature range20 to +50°C Dimensions, weight
Ordering information
Order designation Power Supply XSRM-Z 237.8013.02
Accessories supplied Power cable 1 two-core connecting cable (for XSRM) 1 two-core connecting cable (for external battery)

Frequency Converter XSRM-Z



The Frequency Converter XSRM-Z is driven with the 5-MHz signal delivered by the XSRM, XSC or XSD 2. Each of the frequencies – 10 MHz, 5 MHz, 1 MHz and 0.1 MHz – is available at two parallel outputs on the front and rear panels. All signals are sinusoidal and phase-locked to the input signal.

The Frequency Converter can be powered from the Power Supply XSRM-Z.

Specifications of Frequency Converter XSRM-Z
Input 5 MHz Permissible range of input voltage 0.2 to 2 V _{ms} Input impedance ≥500 Ω Connector BNC female
$\begin{array}{c c c c c c c c c c c c c c c c c c c $
General data Supply voltage 22 to 32 V DC Current drain max. 90 mA Rated temperature range -20 to +45°C Storage temperature range -20 to +60°C Dimensions, weight 50 mm×132 mm×342 mm, 1 kg
Ordering information Order designation Frequency Converter XSRM-Z 238.0616.02

FREQUENCY COMPARATORS

Phase Comparator XSRM-Z3



The Phase Comparator XSRM-Z3 is used for checking and recalibrating control frequencies, derived for instance from crystal oscillators in counters and synthesizers.

Any 5-MHz source of appropriate accuracy (e.g. XSRM, XSD2) can be used as the reference. Frequency differences between 1×10^{-6} to 1×10^{-9} can be determined directly on the panel meter. The recorder output per-

mits considerably smaller errors to be logged or frequency and phase deviations to be recorded over a longer period of time.

Any test item with a frequency of 1 MHz or an integral multiple of it (up to 10 MHz) can be measured. A rotary switch on the front panel permits the Phase Comparator to be set to the corresponding input frequency.

Phase Recorder XKP for standard frequency comparison

- Frequency and phase recording at 50 Hz to 5 MHz
- Linear indication (sawtooth) 0 to 360°
- Frequency evaluation over one hour to within $\pm 2 \times 10^{-12}$
- DC input for YT recording

A simple method of determining the difference between two almost identical frequencies is to measure the mutual phase deviation within a set time interval. The Phase Recorder XKP serves this purpose.

The test result is recorded in the form of a sawtooth voltage with constant amplitude (corresponding to 360° phase difference). The instantaneous value of this voltage corresponds to the phase difference between the frequencies being compared. The voltage variation within a set time interval is a measure of the frequency difference.

The main application of the XKP is the monitoring of standard-frequency and standard-time systems. Due to its wide frequency range, it is suitable for determining the relative frequency error of atomic frequency standards (accuracy 10^{-12} to 10^{-13}) and for measuring at lower frequencies down to the AC supply frequency. The XKP can also be used as a YT recorder (DC input voltage: 0 to 5 V/0 to 10 V), e.g. together with the XKE 2 or XSRM-Z3.

The set is AC-supply and/or battery operated, the battery taking over only on AC supply failure. The XKP comes as $\frac{1}{2}$ of a 19" unit and fits in the modular standard-frequency system XSRM-Z. Two Phase Recorders XKP can be accommodated side by side in a 19" Frame XSRM-Z 237.6840.02. The XKP can also be inserted into the Cabinet XSRM-Z ($\frac{5}{6}$ of 19", Order No. 237.6040.02).

Specifications of Phase Comparator XSRM-Z3

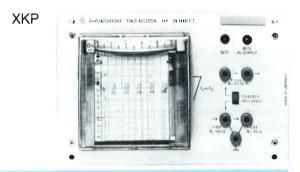
Input frequency f _{st}	
Input frequency fx 1/ Input voltage range 0.1 Indication of phase difference 0 t Recorder output 0 t Sr 0 Output impedance >1	I to 2 V o 1 μs (= 0 to 360°) o 5 V (= 0 to 1 μs), mA max.

General data

Rated temperature range	
Supply voltage	22 to 32 V DC
Current drain	
Dimensions, weight	50 mm×132 mm×342 mm, 0.9 kg

Ordering information

Order designation	Phase Comparator XSRM-Z3 278.9314.02
	2/0.9314.02

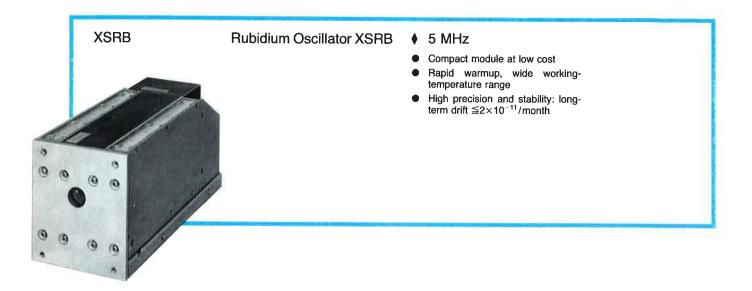


Specifications of Phase Recorder XKP

Frequency range	
AC input voltage Input impedance (frequency-	0.3 to 10 Vms
dependent, mostly inductive)	
at 50 Hzabove 1 kHz	
	2 BNC female, floating (on rear panel)
DC input voltage	
(for use as YT recorder)	
	$Z_{in} = 5 k\Omega/10 k\Omega$, telephone jacks (on front and rear panel, connected in
	parallel)
Indication	wax-paper dot recorder
Paper feed	20 mm/h and 120 mm/h, selectable;
	error (with battery operation) <5 × 10 ⁻⁴ /°C
DC output voltage	
	phase difference, 5 mA max.
Zero drift	(short-circuit-proof), $Z_{out} < 10 \Omega$
Output connectors	
General data	
Rated temperature range	-10 to +50°C
Storage temperature range	−10 to +50 °C −20 to +70 °C
Storage temperature range	-20 to +70°C
Storage temperature range Power supply AC supply	20 to +70°C 115/125/220/235 V +10/-15%, 50 Hz (6 VA); 60 Hz if required
Storage temperature range	-20 to +70°C 115/125/220/235 V +10/-15%, 50 Hz (6 VA); 60 Hz if required 11 to 16 V, 320 mA, internally
Storage temperature range Power supply AC supply	20 to +70°C 115/125/220/235 V +10/-15%, 50 Hz (6 VA); 60 Hz if required 11 to 16 V, 320 mA, internally selectable
Storage temperature range Power supply AC supply Battery (external)	-20 to +70 °C 115/125/220/235 V +10/-15%, 50 Hz (6 VA); 60 Hz if required 11 to 16 V, 320 mA, internally selectable 21 to 32 V (not to be charged from XKP)
Storage temperature range Power supply AC supply Battery (external)	-20 to +70°C 115/125/220/235 V +10/-15%, 50 Hz (6 VA); 60 Hz if required 11 to 16 V, 320 mA, internally selectable 21 to 32 V (not to be charged
Storage temperature range Power supply AC supply Battery (external)	-20 to +70 °C 115/125/220/235 V +10/-15%, 50 Hz (6 VA); 60 Hz if required 11 to 16 V, 320 mA, internally selectable 21 to 32 V (not to be charged from XKP)
Storage temperature range Power supply AC supply Battery (external)	-20 to +70 °C 115/125/220/235 V +10/-15%, 50 Hz (6 VA); 60 Hz if required 11 to 16 V, 320 mA, internally selectable 21 to 32 V (not to be charged from XKP)
Storage temperature range Power supply AC supply Battery (external) Dimensions, weight Ordering information Order designation	 -20 to +70°C 115/125/220/235 V +10/-15%, 50 Hz (6 VA); 60 Hz if required 11 to 16 V, 320 mA, internally selectable 21 to 32 V (not to be charged from XKP) 202 mm×132 mm×370 mm, 4.5 kg ▶ Phase Recorder XKP
Storage temperature range Power supply AC supply Battery (external) Dimensions, weight Ordering information	-20 to +70°C 115/125/220/235 V +10/-15%, 50 Hz (6 VA); 60 Hz if required 11 to 16 V, 320 mA, internally selectable 21 to 32 V (not to be charged from XKP) 202 mm×132 mm×370 mm, 4.5 kg
Storage temperature range Power supply AC supply Battery (external) Dimensions, weight Ordering information Order designation (½ of 19" unit)	 -20 to +70°C 115/125/220/235 V +10/-15%, 50 Hz (6 VA); 60 Hz if required 11 to 16 V, 320 mA, internally selectable 21 to 32 V (not to be charged from XKP) 202 mm×132 mm×370 mm, 4.5 kg ▶ Phase Recorder XKP 156.3541.02
Storage temperature range Power supply AC supply Battery (external) Dimensions, weight Ordering information Order designation	 -20 to +70°C 115/125/220/235 V +10/-15%, 50 Hz (6 VA); 60 Hz if required 11 to 16 V, 320 mA, internally selectable 21 to 32 V (not to be charged from XKP) 202 mm×132 mm×370 mm, 4.5 kg ▶ Phase Recorder XKP 156.3541.02 power cable, connecting cable (1.5 m) for external
Storage temperature range Power supply AC supply Battery (external) Dimensions, weight Ordering information Order designation (½ of 19" unit)	 -20 to +70°C 115/125/220/235 V +10/-15%, 50 Hz (6 VA); 60 Hz if required 11 to 16 V, 320 mA, internally selectable 21 to 32 V (not to be charged from XKP) 202 mm×132 mm×370 mm, 4.5 kg ▶ Phase Recorder XKP 156.3541.02 power cable, connecting cable (1.5 m) for external battery,
Storage temperature range Power supply AC supply Battery (external) Dimensions, weight Ordering information Order designation (½ of 19" unit)	 -20 to +70°C 115/125/220/235 V +10/-15%, 50 Hz (6 VA); 60 Hz if required 11 to 16 V, 320 mA, internally selectable 21 to 32 V (not to be charged from XKP) 202 mm×132 mm×370 mm, 4.5 kg ▶ Phase Recorder XKP 156.3541.02 power cable, connecting cable (1.5 m) for external

5 OSCILLATOR MODULES

standard-frequency and



The **Rubidium Oscillator XSRB**, which features similar electric characteristics to the Rubidium Frequency Standard XSRM (see page 162) is available for incorporation into instruments and systems. This competitively priced module has been designes as a compact module to be used by other manufacturers in their own equipment.

Characteristics and uses

The XSRB is suitable for inclusion in all mobile and stationary instruments and systems calling for an extremely precise frequency reference as a control or monitoring signal.

Output signal. The output of the XSRB is a sinusoidal signal at 5 MHz. The EMF is 1 V and the signal-to-noise ratio is better than 130 dB. Thorough screening ensures that the effects of external magnetic fields are kept to a minimum. Two auxiliary outputs allow the use of an external meter for continuous monitoring of the oscillator or for checking that the control voltage remains within the permissible range. A frequency-correction input is also provided so that the oscillator frequency can be trimmed by comparison with an even more precise signal such as a standard-frequency broadcast. If the oscillator fails, an alarm signal is given at a separate output.

Frequency stability. The XSRB is over a hundred times more accurate than conventional crystal oscillators – thereby guaranteeing an adequate safety margin. The frequency drift of the XSRB due to aging is less than 2×10^{-11} per month. The unit can therefore replace precision crystal oscillators – a substitution which can also be justified on economic grounds particularly since the long-term stability and precision of the output signal eliminate the need for costly readjustments.

Applications. High-stability signals (standard frequencies) are called for in communications and navigation systems; typical examples are

precision offset operation of TV transmitters, control of standard-frequency systems, SSB transmission at very high frequencies, satellite radio and geodesy, extraterrestrial communications. Further applications are found in microwave spectroscopy. More generally the XSRB is ideal for controlling precision counters, synthesizers and crystal oscillators.

Description

The standard frequency source in the XSRB is a resonant mode of atoms of rubidium 87, an isotope of the alkali metal rubidium. By means of a spectral lamp and a resonant cell a control signal is developed and used to compensate for the aging of a crystal oscillator.



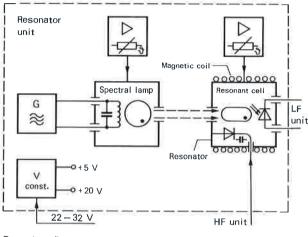
A typical application of the XSRB: precision-offset operation of a TV transmitter

standard-time systems

OSCILLATOR MODULES 5

Supassemblies. The XSRB consists of four subassemblies:

- 1. Resonator unit with spectral lamp, resonant cell and their respective ovens; this unit is electrically and magnetically screened (see block diagram)
- 2. HF unit (frequency division and comparison)
- 3. LF unit (control signal processing)
- 4. Crystal oscillator unit with oven



Resonator unit

Instaliation. The front of the XSRB serves as both mounting plate and heatsink. The temperature measured on this plate should never be outside the range -25 to +60 °C, which is also the admissible ambient temperature range.

Contract of the second s	
Output frequency Output EMF (sinusoidal) Connector	1 V $\pm 10\%$; Z _{out} = 50 Ω Cannon male connector strip DAM –
Harmonics	11 W 1 P
Non-harmonic frequencies	width)
Stability	
Long-term drift Short-term (1 s) drift	≦2×10 ¹¹ per month
(standard deviation) Effect of ambient temperature	$\leq 1 \times 10^{-11}$ $\leq 4 \times 10^{-10}$ across the specified temperature range
Effect of operating voltage	<2×10-11/10%
Effect of external magnetic field	
Effect of atmospheric pressure	\leq 5×10 ⁻¹³ /mbar for altitudes between 0 and 10,000 m
Frequency correction	
Adjustment range using potentiometer	
Setting error using external control input	
Control voltage range	
General data	
Alarm signal output Rated temperature range	changeover contact
(temperature of mounting plate)	-25 to +60°C
Storage temperature range Warmup time for frequency error less than 1×10-9	-40 to +70°C approx. 10 min. at +25°C
Supply voltage requirement (negative earth)	
Current drain	
during warmup during normal operation	approx. 0.7 A at 24 V and +25°C
Dimensions	see drawing below 3.3 kg

Ordering information

Order designation PRubidium Oscillator

Specifications

XSRB 216.0213.03

Accessories supplied: tool for changing spectral lamp, 1 female connector strip with mating male connector.

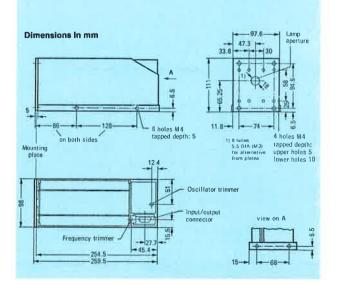
The spectral lamp and the resonant cell carry a 3-year guarantee.





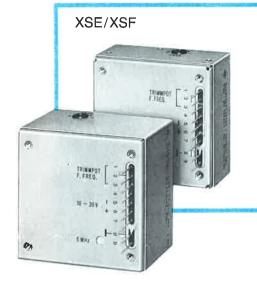
Power requirements. The oscillator is designed for operation from a DC supply voltage. This may vary within the range 22 to 32 V thanks to the action of the built-in stabilizer. Operation from any standard battery supply of the appropriate voltage is therefore feasible.

The XSRB is extremely easy to service. The spectral lamp can be changed very rapidly.



5 OSCILLATOR MODULES

standard-frequency and



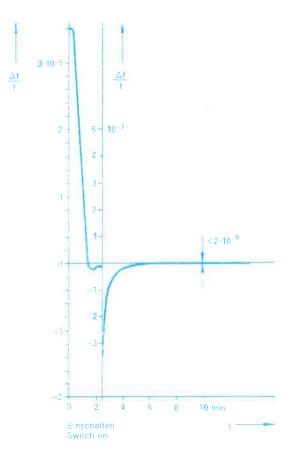
Crystal Oscillator XSE ♦ 1 to 10 MHz Crystal Oscillator XSF ♦ 5 MHz

- Class of accuracy 10⁻⁹ for XSE, 10⁻¹⁰ for XSF
- Extremely short warmup period
- Operating range 10 to 30 V, -40 to +65°C

Plug-in Crystal Oscillators XSE (top) for 1 to 10 MHz and XSF for 5 MHz; shown on larger scale than usual

The **Crystal Oscillators XSE and XSF** are suitable for incorporation into high-quality frequency counters, standard frequency generators and decade exciters.

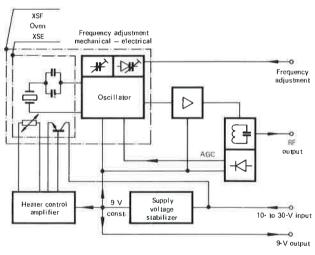
The main differences between the two types are in the frequency stability, warmup time (see table) and available output frequency. The **XSF** is designed for 5 MHz whereas the **XSE** is available for 1, 5 or 10 MHz; other frequencies between 1 and 10 MHz on request.



Warmup response of XSE using 5-MHz crystal (3rd harmonic) referred to values obtained after 60 minutes of operation

Common specifications and construction

The unusually wide ranges of temperature and operating voltages permit use of the crystal oscillators under extreme ambient conditions with negligible effect on frequency accuracy.



Block diagram of Crystal Oscillators XSE and XSF

The crystal frequency can be adjusted with a trimmer (coarse) and varactor (fine). An external potentiometer must be connected to drive the varactor. The required stabilized reference voltage is available from the crystal oscillator.

Both modules (XSE and XSF) are equipped with an oven. In the XSE, only the crystal and the frequency-determining components are kept at a constant temperature while in the XSF the oscillator circuit is also accommodated in the oven.

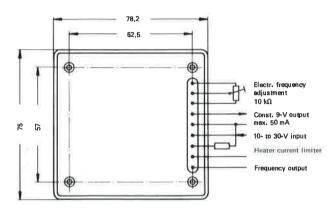
Rapid warmup of the oven is possible by connecting a wire link between two solder tags. If a suitable resistor is inserted instead of the link, any heater current below maximum can be selected to suit the capacity of the available power supply. Since high ripple voltage is permissible for warmup, the operating voltage need not be stabilized in many cases.

standard-time systems

OSCILLATOR MODULES 5

The sudden change from maximum heater current to normal operating current can be utilized for the delayed connection of further loads via relays.

The XSE and XSF have identical pin assignments. The pins are arranged such that the modules can be connected directly to a printed circuit board.



Pin assignments of Crystal Oscillators XSE and XSF

Specifications of XSE and XSF

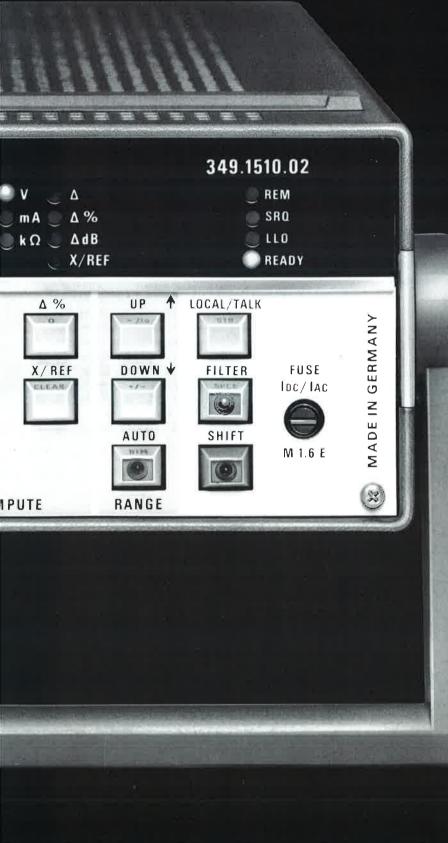
Stability Freq. error with ambient temp. of 25°C and rapid warmup after 1.5 min after 4 min after 7 (5) min after 7 (5) min after 30 min Aging after 30 days of continuous operation Short-term drift for $\tau = 1.5$ (standard deviation) Output EMF	XSE 1 to 5 MHz 5 to 10 MHz <1 × 10 ⁻⁶ <1 × 10 ⁻⁷ <1 × 10 ⁻⁸ <3 × 10 ⁻⁹ /d <2 × 10 ⁻⁹ /d >0.5 V	XSF 5 MHz <1 × 10 ⁻⁶ <1 × 10 ⁻⁶ <2 × 10 ⁻¹⁰ /d ≦2 × 10 ⁻¹¹
Freq. error with ambient temp. of 25 °C and rapid warmup after 1.5 min after 4 min after 7 (5) min after 70 min Aging after 30 days of continuous operation Short-term drift for $\tau = 1$ s (standard deviation) Output EMF	$<1 \times 10^{-7}$ $<1 \times 10^{-8}$ $<3 \times 10^{-9}/d < 2 \times 10^{-9}/d$	<1 × 10 ⁻⁸ <2×10 ⁻¹⁰ /d
temp. of 25 °C and rapid warmup after 1.5 min after 4 min after 7 (5) min after 30 min Aging after 30 days of continuous operation Short-term drift lor $\tau = 1$ s (standard deviation) Output EMF	$<1 \times 10^{-7}$ $<1 \times 10^{-8}$ $<3 \times 10^{-9}/d < 2 \times 10^{-9}/d$	<1 × 10 ⁻⁸ <2×10 ⁻¹⁰ /d
warmup after 1.5 min after 4 min after 7 (5) min after 30 min Aging after 30 days of continuous operation Short-term drift for $\tau = 1$ s (standard deviation) Output EMF	$<1 \times 10^{-7}$ $<1 \times 10^{-8}$ $<3 \times 10^{-9}/d < 2 \times 10^{-9}/d$	<1 × 10 ⁻⁸ <2×10 ⁻¹⁰ /d
after 1.5 min after 4 min after 7 (5) min after 30 min Aging after 30 days of continuous operation Short-term drift for $\tau = 1 s$ (standard deviation) Output EMF	$<1 \times 10^{-7}$ $<1 \times 10^{-8}$ $<3 \times 10^{-9}/d < 2 \times 10^{-9}/d$	<1 × 10 ⁻⁸ <2×10 ⁻¹⁰ /d
after 4 min after 7 (5) min after 7 (5) min Aging after 30 days of continuous operation Short-term drift lor $\tau = 1 s$ (standard deviation) Output EMF	$<1 \times 10^{-7}$ $<1 \times 10^{-8}$ $<3 \times 10^{-9}/d < 2 \times 10^{-9}/d$	<1 × 10 ⁻⁸ <2×10 ⁻¹⁰ /d
after 7 (5) min after 30 min Aging after 30 days of continuous operation Short-term drift for $\tau = 1 s$ (standard deviation) Output EMF	<1 × 10 ^{-a} <3 × 10 ⁻⁹ /d <2 × 10 ⁻⁹ /d	<1 × 10 ⁻⁸ <2×10 ⁻¹⁰ /d
after 30 min Aging after 30 days of continuous operation Short-term drift for $\tau = 1 s$ (standard deviation) Output EMF	<3×10 ⁻⁹ /d <2×10 ⁻⁹ /d	<1 × 10 ⁻⁸ <2×10 ⁻¹⁰ /d
of continuous operation Short-term drift for $\tau = 1 s$ (standard deviation) Output EMF		
Short-term drift for $\tau = 1 s$ (standard deviation) Output EMF		
for τ = 1 s (standard deviation) Output EMF	>0.5 V	≦2×10 ⁻¹¹
(standard deviation) Output EMF	>0.5 V	≦2×10 ⁻¹¹
Output EMF	>0.5 V	======
	>0.5 V	
	500.0	>0.5 V
Output impedance S/N ratio (referred to 1-Hz	500 Ω	500 Q
bandwidth, spacing		
from carrier >100 Hz)	>110 dB >120 dB	>120 dB
Nominal operating voltage	10 to 30 V	10 to 30 V
Heater current (adjustable)	0.17 to 0.6 A	0.4 to 0.8 A
Average current require-		
ment at +22 °C ambient		
temperature and		
$V_{n} = 12 V$	160 mA	175 mA
$V_s = 24 \text{ V}$	80 mA	100 mA
Warmup time at 30 V, Imm +22°C amb. temp.	1 min	3 min
and the second	1.000	5 11111
General data	the set the set	Carlos Caracitas
Operating temperature range		-40 to +65°C
Storage temperature range Weight	-50 to +80°C 200 g	-50 to +80°C 300 g
weight	200 g	300 g
Ordering information	1	
Order Nos.		
1 MHz output frequency	100.7641.02	100.5578.02
5 MHz output frequency	100.7641.05	00.0010.002
10 MHz output frequency	100.7641.10	
PAL colour subcarrier	100.7641.04	
Other frequencies	100.7641.49	

171

Digital Multimeter UDS 5, DC 1 μ V to 1200 V, AC 500 μ V to 800 V (20 Hz to 200 kHz), IEC-bus-compatible; details on page 182



voltmeters · power meters



VOLTMETERS 6

Electronic voltmeters

Rohde & Schwarz makes voltmeters of high sensitivity and for applications over a very wide frequency range. In addition to the indicator section these instruments comprise **electronic circuitry** such as broadband and selective amplifiers, mixers, oscillators, log converter circuits and rectifiers.

All the models presented in this catalog are electronic voltmeters; they are tabulated in two main groups, each possessing particular common features:

1. DC and broadband voltmeters

2. Selective voltmeters (section 7)

Whereas the selective voltmeters are dealt with separately in section 7 of this catalog, all **DC and broadband voltmeters**, both with analog and digital readout and including system units, are described in the present section.

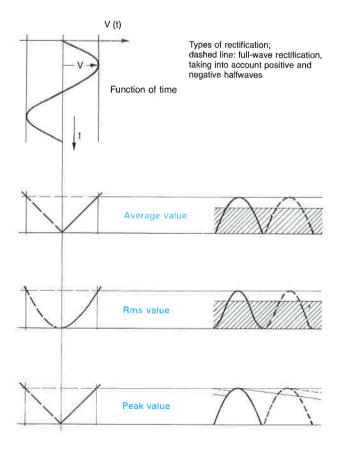
The **table on page 178** gives an overview, the broadband voltmeters being listed according to their use as digital multimeters, DC voltmeters, AC/RF voltmeters.

Following the general description of voltmeter features, the characteristics typical of each group are briefly outlined.

General characteristics of voltmeters

Meter rectifiers

An AC voltage must be rectified for measurement. Three types of rectification are distringuished according to the weighting of the waveform: average, response, rms response and peak response.



Rectification modes

Signal shape	Average value	Rms value	Peak value
	$V_{av} =$	V _{rms} =	V _{pp} =
General	$\begin{array}{c c} T_{i} \\ \hline T_{i} \\ T_{i} \\ 0 \end{array} \middle v (t) \bigg dt$	$\sqrt{\frac{1}{T_i}} \int_{0}^{T_i} v^2 (t) dt$	$V_{p+} + V_p$
Sinewave	$V_{p, \sum_{\tau}} \frac{1}{\pi} \int_{0}^{\pi} \sin \omega t d\omega t$	$\sqrt{V_{p} \times \frac{1}{\pi} \int_{0}^{\pi} \sin^{2} \omega t d\omega t}$	$2 \times V_{\rho}$
	$= V_p \times 0.638$	$= V_{p} \times 0.707$	$V_p = V_{p \perp} = V_p$
R&S voll- meters	UDL 3, UDS 6	URE, UPGR UDL 4, UDS 5, (URV 3, 4)	UPGR (URV 3 4)

Average-responding rectification (see diagram below left). The average value (V_{av}) of an AC voltage is the integral of the magnitude of the AC voltage over a period of time; this corresponds to the area between the function of time and the zero line, averaged over the period of observation T_i. Voltmeters with average-responding rectifier are calibrated so that they indicate the rms value for sinewave voltages. The voltmeters UDL 3 and UDS 6 are fittet with an average-responding rectifier and can be optimally used where sinewave AC voltages are to be measured; superimposed noise voltages are not entered into the measurement result as long as they are sufficiently small against the useful signal and comply with the following requirement: $V_{useful} \times f_{useful} > V_{noise} \times f_{noise}$

voltmeters

RMS-responding rectification: The rms value (V_{rms}) is derived from the squares of the momentary voltages, averaged over the period of observation T_i. The square root is taken mainly to achieve a linear scale characteristic. The parabolic curve required for squaring is obtained through a circuit developed and patented by Rohde & Schwarz, whose outstanding features are high accuracy, a high crest factor and a wide frequency range. The Psophometer UPGR and the RMS Voltmeter URE from R&S operate on this principle. The URE is also able to measure the true rms value of AC+DC voltages. Voltmeters using rms-responding rectification are: UDL 4, UDS 5, UPGR, URE and (for low test voltages) URV, URV3, URV4.

Peak-responding rectification. Voltmeters with peak-responding rectifiers measure the peak value of the momentary voltage. They have a storage capacitor which is charged up to the peak value and discharged slowly so that there is sufficient time for reading. Distinction is made between positive (V_{p+}) and negative (V_{p-}) peak-responding rectification as well as peak-to-peak rectification (V_{pp}). The psophometer contains a peak-responding rectifier with defined rise and fall time constants for weighted noise measurements (quasipeak-responding rectifier); the value V_p/ $\sqrt{2}$ is indicated, i.e. the rms value for sinewaves. For test voltages >1 V the voltmeters URV, URV3, and URV4 measure the peak-to-peak value and indicate V_{pp}2/ $\sqrt{2}$.

voltmeters

Test signal shapes, factors

 $\ensuremath{\mathsf{Crest}}\xspace$ factor C is the ratio of peak value to rms value of an AC voltage

$$C = \frac{|peak value|}{rms value} = \frac{|V_p|}{V_{rms}}$$

and is an essential criterion mainly for measuring nonsinusoidal AC voltages in which large short-time amplitudes alternate with longer intervals, so that high peak values are prevailing and the rms values are low. The measuring instrument must be able to transfer the peak amplitudes free of distortion to ensure error-free measurement.

Form factor F is the ratio of rms value to average value

$$\mathsf{F} = \frac{\mathsf{rms value}}{\mathsf{average value}} = \frac{\mathsf{V_{rm}}}{\mathsf{V_{av}}}$$

This factor is relevant for instruments with average-responding rectifier. Since the form factor for sinewave signals is

$$\mathsf{F} = \frac{0.707}{0.637} = 1.11$$

The scale of such instruments is usually multiplied by a factor 1.11 so that for sinewave voltages the rms value can be read off. With different waveforms errors do however occur. A symmetrical squarewave for instance has the form factor $F = \frac{1}{1} = 1$, rms and average value are identical and the reading error for the rms value is +11%.

Input impedances

In electronic **voltmeters with amplifier input** the input impedance is generally well defined and can be represented by a resistance and a lossy capacitance in parallel. **Broadband voltmeters** normally have an input impedance of about 10 MHz shunted by 30 pF (e.g. URE). This amounts to \approx 50 Ω at 100 MHz. The parallel capacitance of any connected coaxial cable (30 to 100 pF) makes the input impedance still lower. Improvement of the input conditions is possible using a **voltage divider probe.**

Diode probes include a capacitively coupled half-wave rectifier. Their input capacitance of \approx 2 pF can be reduced to about 0.5 pF by plug-in dividers, but this involves a loss in sensitivity. Diode probes permit measurements with high impedance at frequencies up to 1 GHz.

Digital voltmeters for DC voltage measurements usually have an input impedance of 10 MΩ, high-grade instruments with $R_{in} > 10 \ G\Omega$ permitting also measurement of voltages up to 16 V (UDS 5) or 14 V (UDS 6) without any loading. With a measurement range of 100,000 digital steps and an input impedance of 10 MΩ, a source impedance of 100 Ω causes an additional error in indication of 1 digit. The extremely high input impedance of >10 $G\Omega$ is therefore very important for measurements on sources with high impedances.

AC voltage functions Sinewave/squarewave pulses

Terms and relationships of the two basic AC voltage functions, i.e. sinewave and squarewave pulses:

Term	Sinewave pulses	Squarewave pulses
Reciprocal duty cycle	f =-	-0
Duty cycle	g = -	$\frac{1}{r} = \frac{t_d}{t_p} \qquad t_p = \text{pulse period}$
Crest factor	$C = \sqrt{\frac{2}{g}} = \sqrt{2 \times r}$	$C = \sqrt{\frac{1}{g} - 1} = \sqrt{r - 1}$
Form factor	$F = \frac{\pi}{2} \times \frac{1}{\sqrt{2 \times g}}$ $= \frac{\pi}{2} \times \sqrt{\frac{r}{2}}$	$F = \frac{1}{2 \times \sqrt{g-g^2}}$ $= \frac{1}{2 \times \sqrt{\frac{1}{r} - \frac{1}{r^2}}}$
Average value	$V_{av} = V_{pp} \times \frac{g}{\pi}$	$V_{av} = V_{pp} \times 2 (g - g^2)$
Rms value	$V_{rms} = V_{DD} \times \frac{1}{2} \sqrt{\frac{g}{2}}$	$V_{rms}=V_{pp}\times\sqrt{g-g^2}$

Noise voltages, reference potential

The voltage of a test point to common return (ground, earth) is to be determined in most measurement.

If both the test voltage source and the voltmeter are earthed through the earth conductor of the AC supply, noise pickup may result in the test circuit. This can often be remedied by plugging the source and the voltmeter into a twin wall socket.

Measurements using a broadband voltmeter are invalidated by noise voltages. The erroneous results is not immediately recognized unless the test voltage can be reduced to 0.

Noise pickup does not occur in a voltmeter with floating input, a facility required for measurements between two test points which both have a voltage to earth.

Measurements on balanced audio-frequency transmission systems call for instruments with balanced test input and high common-mode rejection.

A noise voltage may also originate in the input stages of the voltmeter and affect the result, especially in the most sensitive ranges. For example, a noise voltage of about 15 μ V whose spectrum lies mainly below 10 kHz is produced in the amplifier input of a voltmeter with 1 M Ω ||30 pF. This noise component is negligible if the voltage source has a low impedance (e.g. 50 Ω).



voltmeters

Noise voltages

With **digital voltmeters** the suppression of noise voltages (e.g. AC hum) is dependent on the type of analog/digital conversion. With integrating A/D converters and suitable selection of the integration time, which must be exactly one or several AC periods, the AC hum suppression can be optimized.

Broadband voltmeters with rectifier input measure the rms value of small test voltages up to 30 mV and the peak or peak-to-peak value (URV family) of voltages above 1 V. The meter reads the rms value of a sinewave in the entire measurement range.

The probes and insertion units of the millivoltmeters of the URV family have, in addition to the detector circuit for the RF voltage to be measured, a comparison detector of similar design to which the comparision voltage produced by a control loop in the basic unit is applied. The control loop provides for a voltage-proportional meter scale throughout the measurement range.

The measuring heads can be freely interchanged; the accuracy depends only on the degree of matching of the characteristics of the two diodes used in each measuring head for the measurement and comparison circuits. Any measuring head combined with any basic unit therefore complies with the data-sheet specifications.

Broadband voltmeters

DC voltmeters

The test signal (test voltage) passes through a DC amplifier of selectable gain and is applied to the meter.

A chopper amplifier first changes the test voltage into an AC voltage, which is amplified and then rectified in a synchronous rectifier. The chopper amplifier is outstanding for its low zero drift and is therefore used in DC voltmeters of very high sensitivity (UIG, URV).

Broadband voltmeters with rectifier input

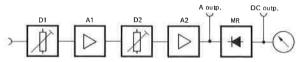
A rectifier which covers a wide voltage range changes the unknown AC voltage into a DC voltage. This DC voltage is processed in the basic unit and indicated. The broadband coverage of this voltmeter type depends on the mechanical design of the meter rectifier and on the RF characteristics of the rectifier diodes.

A probe (if necessary, with plug-in divider) incorporating a capacitively coupled half-ware rectifier is used for measurements on non-coaxial circuits. It features high input impedance and very low input capacitance. The voltage indication depends on the type of ground connection and on the source impedance of the test voltage source.

Measurements in coaxial circuits are carried out with the aid of coaxial RF insertion heads. They incorporate a diode detector inserted in the inner conductor or connected via a piston attenuator and permit broadband voltage measurements to be made up to 2 GHz with low reflection. With match-termination, the indicated voltage equals the voltage of the forward wave. The voltage indication with mismatch lies between twice the voltage of the forward wave and 0.

Broadband voltmeters with amplifier input

Sensitive broadband (amplifier) voltmeters are normally designed according to the following principle:



Simplified diagram of an amplifier voltmeter

The high-impedance input divider D1 covers two or three steps and prevents overloading of the amplifier A1. This is followed by the low-impedance main divider D2 (10-dB steps). Both dividers together with the amplifiers A1 and A2 form a broadband amplifier which can also be used as a preamplifier (via amplifier output A outp.) for insensitive meters or recorders. The design of the final stage of the main amplifier depends on whether low-impedance or high-impedance driving of the meter rectifier MR and which type of rectification is used. The DC voltage output (DC outp.) permits the connection of a recorder or digital voltmeter.

Broadband voltmeters

with balanced amplifier input

The input section of the Psophometer UPGR consists of a balanced attenuator and a balanced amplifier which are accommodated in a shielding can and isolated from the rest of the circuitry by a broadband transformer and a transformer-coupled power supply. A high-impedance balanced input (100 k Ω) with very high common-mode rejection is thereby realized.

voltmeters



Weighted measurement of noise level

DIN, CCIR and CCITT specify weighted measurements for determining the noise levels in telephone and electroacoustic broadband transmission systems.

Simulation of the subjective noise effect is achieved with a psophometric weighting filter and the dynamic behaviour of the meter rectifier and movement.

The Psophometer UPGR permits noise voltage to be measured in compliance with the international standard recommendations.

Digital voltmeters and multimeters

With the development of digital multimeters digital measurement techniques have been applied in all fields of electronic and electrical engineering. LSI circuitry has allowed these instruments to become more compact and less expensive in spite of their higher degree of intelligence. Present day range of equipment encompasses simple pocket multimeters as well as system voltmeters with built-in memory and data manipulation functions.

Digital voltmeters offer some advantages as compared with analog-reading meters:

- higher accuracy and resolution,
- error-free reading,
- greater operating convenience (auto-ranging),
- system compatibility.

With short-time unstable voltages the purely digital indication may however be difficult to read and confusing. The combination of a digital display with an analog trend indication in a single unit – like in the Voltmeters URV 4 and URE from R&S – offers optimum operating convenience in such cases.



RMS Voltmeter URE; can also convert the measured values to different units

The <u>BMS Voltmeter URE</u> can read out the measured values in all customary units and can automatically calibrate itself. Thanks to the built-in, non-volatile memory all calibration data, the reference value and the reference impedance for readout in dBm are preserved when the instrument is switched off. The microprocessor-controlled error correction of the rms-value rectifier has made it possible to combine both high measurement speed and accuracy with wide bandwith.

The Digital Multimeter UDS 5 is a universal multimeter of high precision. Like the RMS Voltmeter URE it can display the measured values in different units and convert them into relative values. All measuring functions and ranges are calibrated via the built-in microprocessor. With a measuring rate of up to 80 measurements per second the UDS 5 is particularly suitable for use in systems.

Calculation and manipulation of measured data – a capability embodied in the intelligent System Voltmeter UDS 6 – opens up entirely new dimensions for measuring techniques; 10 built-in programs allow user-oriented display and evaluation of measured data, such as linearization of mechanicalelectrical transducers and presentation of measured data in terms of mechanical quantities.

System voltmeters

The IEC bus, an international standard, makes it readily possible to set up automatic test assemblies using an IEC-bus controller, e.g. the Process Controller PUC.

The IEC-bus interfaces IEC 625-1 (IEEE 488) are already integrated into the latest models, as for instance in the Digital Multimeter UDS 5. The System Voltmeter UDS 6, the RMS Voltmeter URE and the RF Millivoltmeter URV 4 are available with IEC-bus interface on request. They cover a wide range of measurement tasks:

Precision measurement of DC voltage, AC current and resistance,

rms- or average-value measurements of AC voltages up to 200 kHz,

rms-value measurements of current up to 20 kHz,

true rms-value measurements of AC and AC + DC voltages up to 20 MHz and

broadband measurements of RF voltages or levels up to 2 GHz.

With the Scanner UDS 6-Z1 the UDS 6 can form a test system with a maximum of 255 test channels which are controlled via the IEC-bus interface of the UDS 6.

In conjunction with other IEC-bus compatible instruments (overview in section 1) complex test assemblies for multiple applications and tasks can be set up.

6 VOLTMETERS OVERVIEW

voltmeters

Display (digits) Designation Type Order No. Measured quantities	Measurement range Resolution or fsd of lowest subrange	Error limits
---	--	--------------

Digital multimeters

3½ V _{DC} , V _{AC} I _{DC} , I _{AC} , R	Digital Multimeter	UDL 3	346.7117-02	V: 100 μV to 1000 (700) V I: 1 μA to 2 A R: 100 mΩ to 20 MΩ	100 μV 1 μΑ 100 mΩ	0.1% 0.5% 0.2%
4½ V _{DC} , V _{AC} I _{DC} , I _{AC} , R	Digital Multimeter	UDL 4	346.7800.02	V: 10 μV to 1200 (1000) V I: 10 nA to 2 A R: 100 mΩ to 20 MΩ	10 μV 10 nA 100 mΩ	0.03% 0.2% 0.05%
5½ V _{DC} , V _{AC} I _{DC} , I _{AC} , R	Digital Multimeter	UDS 5	349.1510.02	V: 1 μV to 1200 V I: 100 nA to 1.6 A R: 1 mΩ to 16 MΩ	1 μV 100 nA 1 mΩ	0.003% 0.05% 0.004%
6½ V _{DC+} V _{AC} R	System Voltmeter	UDS 6	346.9210.02	V: 100 nV to 1100 V R: 100 μΩ to 14 MΩ	100 nV 100 μΩ	0.001% 0.001%

DC voltmeter

DC voltage	DC Microvoltmeter	UIG	203-5111.02	0.2 μV to 320 V (30 kV) 1 pA to 320 mA	10 μV 10 ρA	±1.5%	a

AC/RF voltmeters

15 Hz to 100 kHz	Psophometer	UPGR	248.1915.02	1 μV to 350 V -110 to +53 dB	10 µV	±2%
10,000 steps I DC voltage II 10 Hz to 20 MHz	RMS Voltmeter	URE	342.1214.02	I 0 to +300 V II 50 μV to 300 V	1 μV 1 μV	0.1% +10 digits AC: see table page 204
I DC voltage II 10 kHz to 2 GHz	RF-DC Millivoltmeter	URV	216.3612.02	1 50 μV to 1050 V II 0.5 mV to 10.5 V (1050 V)	1 3 mV II 3 mV	I 1% II 1.5% of fsd (inherent error)
10 kHz to 2 GHz	Millivoltmeter	URV 3	302-9014.02	0.7 mV to 1050 V	3 mV	2% of fsd (inherent error)
4000 steps V _{AC} /level 10 kHz to 2 GHz	Millivoltmeter	URV 4	292.5012	U: 700 μV to 1000 V V: -50 to +73 dBm	1 μV 0.01 dB	1% (inherent error)



VOLTMETERS OVERVIEW 6

voltmeters

Rectification (type of weighting)	Max. crest factor	Input impedance	Parallel capacitance	Special features	Dimensions in mm (W×H×D)	Text on page
					Digital mu	Iltimeter
verage		10 MΩ	100 pF	audible alarm	170× 89× 38	180
200	E	10.100	75 55		216	101

rms	5	10 MΩ	75 pF		216× 73× 225	181
rms	5.5	>10 GΩ 1 MΩ (V _{AC})	40 pF	IEC-bus- compatible	241× 110× 361	182
average		100 GΩ 1 MΩ (V _{AC})	150 pF	(with option) scanner available	443× 89× 465	188

DC voltmeter

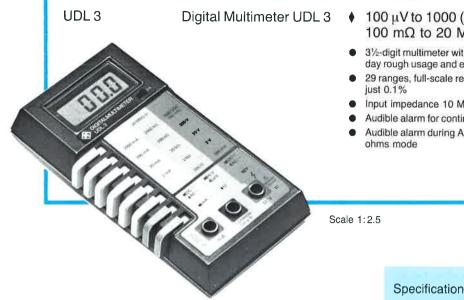
	100 dB	162× 198 238× 302
--	--------	-------------------------

AC/RF voltmeters

peak rms	5	unbal. 1 ΜΩ bal. 600 Ω/ 10 kΩ/100 kΩ	40 pF	max. gain 70 dB	210× 184× 263	199
rms	5	10 MΩ	40 pF	IEC-bus-compatible DC output meas. value conversion	241× 110× 355	202
I II peak rms		I 10 MΩ Il probe or insertion unit	10 pF 2.5 to 0.5 pF	max. gain 50 dB	162× 238× 275	206
peak rms		probe or insertion unit	2.5 to 0.5 pF	recorder output	241× 110× 219	208
peak rms	10	probe or insertion unit	2.5 to 0.5 pF	IEC-bus-compatible log. recorder output	241× 110× 219	210

DIGITAL MULTIMETERS 6

voltmeters



100 μV to 1000 (700) V/1 μA to 2 A 100 mΩ to 20 MΩ

- 31/2-digit multimeter with LCD-display handy, built to take everyday rough usage and electrical overloads
- 29 ranges, full-scale reading of 1999; high precision: basic DC error
- Input impedance 10 MQ
- Audible alarm for continuity, semiconductor and TTL testing
- Audible alarm during AC overload or accidental application of AC in

The Digital Multimeter UDL 3 is an extremely practical, small, battery-powered unit, which with its basic accuracy (0.1% error on DC) is as good as many a laboratory or bench instrument, yet which is also ideal for mobile/external applications thanks to its ruggedness, low weight (315 g) and large, high-contrast LCD display as well as to other advantages.

Range resolution. The UDL 3 has a total of 29 ranges, of which DC and AC voltage have five each with a maximum resolution of 100 µV.

DC and AC current have four ranges each, with a maximum resolution of 1 µA.

Resistance measurements can be made in six ranges up to 20 M Ω (19.99) with a high output voltage, or in five ranges with a low output voltage, with a resolution in the lowest range of 100 m Ω . When Hi-V is selected the opencircuit output voltage is around 2.8 V, and in the Lo-V mode around 250 mV.

Accuracy, display. The UDL 3 has an unusually high accuracy for an instrument in its price range. The maximum error ist just $\pm 0.1\%$ of reading +1 digit for DC and $\pm 0.5\%$ +4 digits for AC at frequencies between 50 and 500 Hz.

The large liquid crystal display (digits 13 mm high) is easy to read in all lighting conditions - including sunlight. The decimal point is positioned automatically; for negative voltages or currents a minus sign appears, otherwise the input is positive. If the input exceeds the range set then all the digits are blanked except for MSD, decimal point and sign.

An audible alarm is built into the UDL 3 for ease of use in the bottom three resistance ranges, to signal overload in the AC voltage ranges, to warn when AC voltage is applied by mistake when the unit is in the resistance mode, or when the input voltage is too negative.

Recommended extras
Carrying case UDL 3-Z1
Other accessories see under UDL 4 on page 181 and details on page 196

Specifications	
Voltage/current measurements	
DC and AC voltage	DC and AC current
Nominal range Resolution	Nominal range Resolution
200 mV 100 μV	2 mA 1 µA
200 mV 100 μV 2 V 1 mV	2 mA 1 μA 20 mA 10 μA 200 mA 100 μA
20 V 10 mV 200 V 100 mV	200 mA 100 μA 2000 mA 1 mA
1000 V (700 V) 1 V	(Fused: 250 V/2 A)
Maximum input voltage, DC	±1000 V on all ranges
AC	±1000 V on all ranges 700 V _{rms} , 30 to 500 Hz, all ranges
	630 V _{DC} , on 200-mV range ±1 kV _{DC} , on all other ranges
Input impedance	10 M Ω , for AC, in parallel with 100 pF
Error limits	
DC voltage	± (0.1% of rdg +1 digit) ± (0.01% of rdg +0.01% of range)/°C
AC voltage	\pm (0.5% of rdg +4 digits) for 50 to
	500 Hz
Temperature effect	± (1% of rdg +6 digits) at 30 Hz ± (0.02% of rdg +0.02% of range)/°C
DC current	\pm (0.5% of rdg +1 digit)
Temperature effect	± (0.02% of rdg +0.01% of range)/°C
AC current	
Temperature effect	± (0.75% +4 digits) for 50 to 500 Hz ± (0.03% of rdo +0.02%)/°C
	_(
Resistance measurements	
Nominal range Resolution	Output current at end of nominal range Hi-V Lo-V
200 Ω 100 mΩ 2 kΩ 1 Ω 20 kΩ 10 Ω 200 kΩ 100 Ω 200 kΩ 100 Ω 200 kΩ 1 kΩ	2 mA — 1 mA 125 μA 140 μA 12.5 μA 14 μA 1.25 μA 1,4 μA 125 nA 140 nA 12.5 nA
20 kΩ 10 Ω	140 μA 12.5 μA
200 kΩ 100 Ω	1 mA 125 μA 140 μA 12.5 μA 14 μA 1.25 μA
2000 kΩ 1 kΩ 20 MΩ 10 kΩ	14 μΑ 1.25 μΑ 1,4 μΑ 125 nA 140 nA 12.5 nA
Maximum input voltage	
Open-circuit output voltage	2.8 V (Hi-V), 250 mV (Lo-V)
Error limits	Hi-V Lo-V
200-Ω range	$\pm (0.2\% + 3 d) - + (0.2\% + 2 d)$
20 MΩ range	$\begin{array}{c} \pm (0.1\% + 1 \text{ d}) \\ \pm (0.3\% + 1 \text{ d}) \\ \pm (1\% + 2 \text{ d}) \end{array} $
Temperature effect	± (0.01%/°C to 0.02%/°C)
Display	31/2-digit LCD (digits 13 mm high),
	1999 maximum count, floating point; polarity: minus if indicated, otherwise
	plus
Reading rate	
General data	
General Gala	
	0.1
Operating temperature range	0 to +40°C standard 9-V battery IEC 6E22
Operating temperature range Power supply battery	standard 9-V battery IEC 6F22; battery life 100 to 200 hours; alarm
Operating temperature range	standard 9-V battery IEC 6F22; battery life 100 to 200 hours; alarm signal when battery has run down
Operating temperature range Power supply battery	standard 9-V battery IEC 6F22; battery life 100 to 200 hours; alarm signal when battery has run down via external power supply
Operating temperature range Power supply battery	standard 9-V battery IEC 6F22; battery life 100 to 200 hours; alarm signal when battery has run down
Operating temperature range Power supply battery	standard 9-V battery IEC 6F22; battery life 100 to 200 hours; alarm signal when battery has run down via external power supply
Operating temperature range Power supply battery AC supply Dimensions, weight (with batteries) .	standard 9-V battery IEC 6F22; battery life 100 to 200 hours; alarm signal when battery has run down via external power supply
Operating temperature range Power supply battery	standard 9-V battery IEC 6F22; battery life 100 to 200 hours; alarm signal when battery has run down via external power supply 170 mm×89 mm×38 mm, 0.315 kg

der designation	Digital Multimeter UDL 3 346.7117.02
cessories supplied	test cable, terminals, battery

Acc

DIGITAL MULTIMETERS 6

UDL 4

Digital Multimeter UDL 4 \blacklozenge 10 μ V to 1000 V/10 nA to 2 A 100 m Ω to 20 M Ω

- Inexpensive 4½-digit multimeter for lab and service applications; high resolution, wide range, excellent stability; CMRR >120 dB at DC
- 25 ranges; rms sensing; basic DC error as small as 0.03%
- AC supply or NiCd battery pack (charger is already installed)

Scale 1:2.5



Specifications

Specifica	ations				
Voltage/cur	rent measurem	ents			
DC/AC volta	age	DC/AC cu	rrent		Il scale
Nominal range	Resolution	Nominal range	Resolu		splay
100 mV 1 V 10 V 100 V 1000 V (Voc: 1200 V	10 μV 100 μV 1 mV 10 mV 100 mV ′; V _{AC} : 1000 V)	100 µA 1 mA 10 mA 100 mA 1000 mA	0.1 1 10 100	μΑ μΑ 1 μΑ 19 μΑ se	9.99 1 9999 9 999 9 99 9 99 e below
Maximum in		±1	200 V mor	nentary, al	l ranges
DC and AC	e Courrent nce		ited to 2 A	30 Hz to 1 by fuse	
Error limits a	ind interference	rejection for	r		
V _{DC} 100-n Rang Temp	nV range es ≧1 V erature effect	±(±(0.03% of i 0.03% of i 0.003% of	nput +2 d) nput +1 d) input +0.0	01%
CMRI Norm	Ral mode rejectio	, . , . , >1	range)/°C 20 dB at E dB at 50 H	DC, >100 d Iz	dB at 50 Hz
	500 Hz 0		it +20 d 0.		
2 to 2	0 kHz 1	1% of input	+20 d 0.	1% of inp	ut +0.02%
Inc. Up to	10-mA range (0.1% of inpu		f range 01% of in	put +0.001%
	es ≧100 mA		o ut +1 d 0	f range 02% of in	
I _{AC} 50 Hz	to 1 kHz).75% of inp	ul+20d 0		put +0=02%
5 to 2	0 kHz	1.5% of inpu	ut +20 d 0	f range .1% of inp f range	ul +0:02%
	measurements				
Nominal ran 1 kΩ	ge Full scale	display He	solution		current mA
10 kQ	19.999	9 kΩ 1 kΩ	1 Ω	330	μΑ
100 kΩ 1000 kΩ	199.99	kΩ	10 Ω	35 3.8	μΑ
1000 KΩ 10 MΩ	1999.9 19.999	kΩ kΩ 1 MΩ 10	00 Ω	0.3	ο μΑ 35 μΑ
Max. input vo Maximum op	oltage		0 V DC or 5 V	AC	
Range ≦1	emp. effect 00 kΩ)5% +1 d/	0.005% + range	0.001% of
	000 kΩ			range	
1	0 ΜΩ		25% +1 d/	0.02% +0 range	005% of
Reading rat	e v	2.5	5 readings/	secound	
General dat	a mperature range		I to J EE®	C (0 to 1.4	0°C using
		Ni	Cd battery	pack)	
Power suppl	y AC supply battery	Ni pa	Cd battery rately, 6 ho	pack, to be	ordered se-
Dimensions,	weight		arges 6 mm×73	mm×225	mm, 1.1 kg
Ordering	informatic	n			
Order desig	nation		Digital Mul 346 7800.		DL 4

Accessories supplied test cable, terminals, power cable

The **Digital Multimeter UDL 4** provides laboratory accuracy, resolution, range and stability at a new low price for an instrument in this class.

The UDL 4 has circuitry for rms voltage and current measurements (20 Hz to 20 kHz, crest factors as high as 5). It can be powered either from a rechargeable battery pack or from the built-in AC line power supply, which doubles as battery charger. The UDL 4, light and easy to carry, is suitable for all lab and field applications.

Range, resolution. 25 ranges for DC voltages up to 1200 V and AC voltages up to 1000 V (both with maximum resolution of 10 μ V), as well as DC and AC currents up to 2 A with up to 10 nA resolution, and resistance up to 20 MΩ with maximum resolution of 100 mΩ. Overranging up to 100%.

Accurscy. The basic error limits of just $\pm 0.03\%$ for DC voltage measurements and 0.4% for AC voltage measurements are outstanding for this class of instrument, as is the accuracy of 0.05% for resistance measurements up to 100 k Ω (0.1% at 1 M Ω).

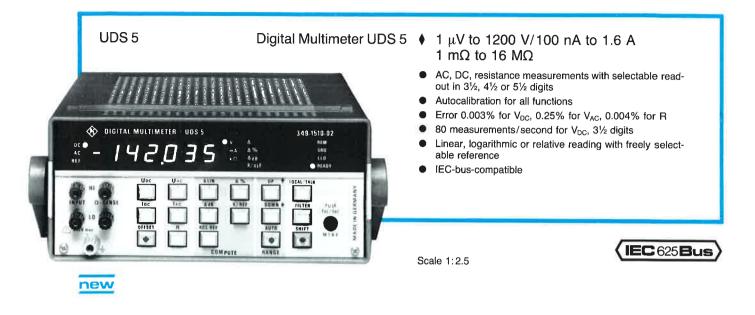
Display. 7-segment LED, 11 mm high digits; polarity (+/-) displayed for all DC measurements. Overload indicated by blanking of all digits.

Extensive range of accessories. For use in many other applications, the capabilities of the UDL 4 can be expanded using accessories such as temperature sensors, current clamps and high-voltage probes: see recommended extras and details on page 196.

Recommended extras (* also suitable for use with UDL 3)	
Carrying Case	
10-A Current Shunt* UDL 4-Z2	
150-A Clamp-on Current Probe* UDL 4-Z3 346.8113.02	
1000-A Clamp-on Current Probe* UDL 4-Z4 346.8165.02	
19"-rack Adapter	
Temperature Probe*	
40-kV High-voltage Probe* UDL 4-Z7 346.8313.02	
NiCd Battery Pack UDL 4-Z8 346.8365.02	
For details see page 196	

6 DIGITAL MULTIMETERS

voltmeters



The **Digital Multimeter UDS 5** is an extremely cost-effective intelligent and high-speed 5½-digit instrument with convenient readout. With its integrated IEC-bus interface it is fully system-compatible. Its compact design makes the UDS 5 ideal for use on the bench and in the rack.

Measurement functions

- V_{DC} DC voltage
- V_{AC} AC voltage, true rms measurement
- I_{DC} DC current
- I_{AC} AC current, true rms measurement
- R resistance

These keys are used to select the measurement functions of the UDS 5. The corresponding unit V, mA or k Ω and the mode AC or DC are simultaneously displayed.

Display of measured value. The display panel of the UDS 5 is divided into several sections. A 7-segment LED display can be selected to read out $3\frac{1}{2}$, $4\frac{1}{2}$ or $5\frac{1}{2}$ digits (details on page 184).

The LED array to the left of the display indicates AC or DC mode or reference. The LED array to the right of the display indicates the unit: V, mA, $k\Omega$, ΔV , ΔmA , $\Delta k\Omega$, $\Delta \%$, ΔdB or X/REF.

Blinking of the display shows that the result is invalid, for example, because the range is exceeded in the functions V_{DC} , V_{AC} , I_{DC} and I_{AC} . When the range of resistance measurement is exceeded, an overflow indication appears.

The outer right LED array indicates the status of IEC-bus operation:

- REM remote
- SRQ service request
- LLO local lockout

(switchover to manual not possible)

READY value in output store valid

Measurement rate and display range. The UDS 5 features three different measurement rates, which are coupled to the integration time of the A/D converter and therefore involve displays of $3\frac{1}{2}$, $4\frac{1}{2}$ or $5\frac{1}{2}$ digits.

The FILTER key is used to switch the lower two measurement rates. The highest rate (3½-digit display) can be selected via the IEC-bus or using special function 3. Up to 80 measurements/s are possible for V_{DC} in this mode. The shortest measurement duration with triggered operation is 15 ms with functions-dependent transient times being taken into account internally. The first value triggered and measured is thus correct. The highest resolution is obtained for 5½ digits with a maximum of 160 000 steps (5 measurements/s for V_{DC}).

Measurement processing

ΔLIN	•	measured value - reference
∆dB	•	20 log measured value reference
$\Delta\%$	•	$100 \times \frac{\text{measured value} - \text{reference}}{\text{reference}}$
X/REF	•	measured value reference

These keys permit the measurement to be represented as different forms of relative values.

A measured value or a value entered via the keypad (second key functions) may serve a reference. Three reference values, one each for voltage, current and resistance, can be stored. These values can be transferred to the non-volatile memory using special function 2.

The reference values stored in the UDS 5 are read out on the display through the RCL REF key.

OFFSET I measured value - offset

Using this key the displayed value can be subtracted from all subsequent measurements, thus suppressing unwanted offset voltages (zero correction with freely selected zero level).

Measurement - range selection is possible in three different ways:

- Automatic range selection

 AUTO key on
- Locking of the selected measurement range

 AUTO key off
- Variation of the measurement range in steps

 by pressing the UP↑ and DOWN↓ keys.
 When the UP↑ or DOWN↓ key is pressed, the nominal value of the new measurement range is momentarily displayed.

Second key functions. Pressing the SHIFT key activates the second key functions for numerical data entry and special functions (SPEC depressed):

0 • Display test

1

- Entry and checking of IEC-bus address
- 2 Permanent storage of reference values
- 3 9 31/2-digit measurement display
- 4 Calibration date (autocalibration)
- 5 Error message
- 6 Software check
- ...
 Check and test programs

DIGITAL MULTIMETERS 6

Autocalibration. The calibration consists in the adjustment of the complete instrument for a total of 20 measurement ranges from the front panel or via the IEC-bus. It is only necessary to call up calibration function, enter nominal value, apply calibration voltage, current or resistance to the input terminals and to start calibration.

The calibration can be performed in any sequence or only for some of the measurement ranges. The calibration factors are retained in non-volatile memory and protected against inadvertent alteration.

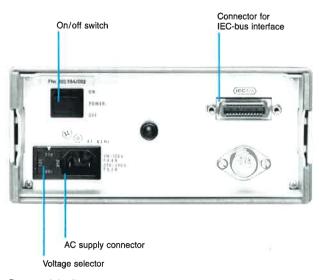
This reliable and intelligent autocalibration reduces maintenance times to minutes, affords high stability (no potentiometers) and enhances availability.

Measurement processing. The UDS 5 is a state-of-the-art multimeter offering:

- High-impedance DC voltage mesurement >10 GΩ up to 16 V, 10 MΩ up to 1200 V
- True rms weighting of AC voltags and AC currents
- Integrating pulse-width conversion technique for high noise rejection
- Three different integrating times: 2, 20 and 200 ms
- Analog section with floating input via optocoupler

The integration times of 20 and 200 ms provide effective rejection of hum with DC voltage, DC current and resistance measurements (50 Hz at 20 and 200 ms, 60 Hz at 200 ms).

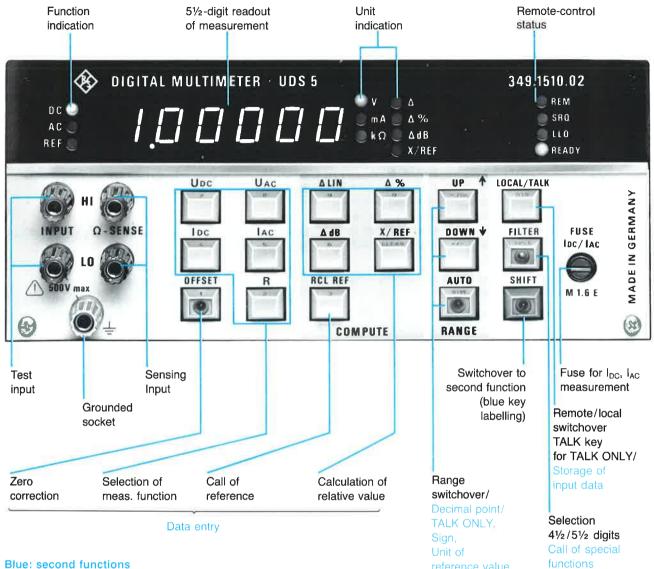
Construction. The Digital Multimeter UDS 5 is housed in a compact all-metal casing, which in conjunction with the shielded IEC-bus connector reduces radio interference. The well-organized layout on three circuit boards – analog section, processor, display/keyboard – together with comprehensive test and self-test programs makes servicing particularly easy.



Rear-panel details

DIGITAL MULTIMETERS 6

voltmeters



Blue: second functions

Operation

Selection of display length

 $4\frac{1}{2} \Leftrightarrow 5\frac{1}{2}$ digits

31/2 (41/2) digits

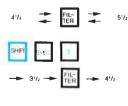


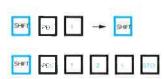


IEC-bus address Display of

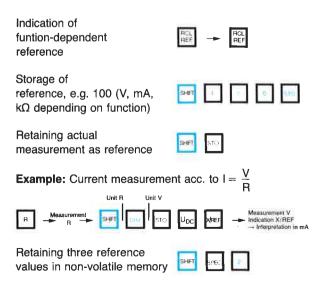
selected address

Entry, e.g. 25





Reference value



DIGITAL MULTIMETERS 6

Remote control

The following tables list the functions, instructions and outputs for remote control of the Digital Multimeter UDS 5 from a controller via the IEC-bus. Further instructions provide for autocalibration and for the special functions.

Setting commands

Command	Function		
C1	Basic setting: (DCL, SDC after addressing) FØ, NØ, OØ, UØ, RDUØ, W3, QØ, Y1		
F0 F1 F2	Readout 5½ digits 4½ digits 3½ digits		
NØ N1	Output with without alphaheader		
00 O1	Offset calculation off on		
UØ U3 U4 U5 U6	$ \begin{array}{c c} \text{Direct} \ (V, \text{ mA}, \text{k}\Omega) \\ \Delta \text{ LIN} & \text{referred to} \\ \Delta \% & \text{function-} \\ \Delta \text{ dB} & \text{dependent} \\ \text{X/REF} & \text{reference} \end{array} \right\} \text{ Output} $		
Y0 Y1	Auto Zero ^{off} on		
Y?	Query whether Auto zero on or off (SRQ generated with suitable coded SRQ byte)		
RDU, RDUØ RDU1 RDU2 RDU3 RDU4 RDU5	Autoranging V _{DC} V _{DC} range 0.1 V 1 V 10 V 100 V 1000 V		
RAU, RAUØ RAU1 to RAU5	Autoranging V _{AC} Ranges as for V _{DC}		
RDI, RDIØ RDI1 RDI2	Autoranging I _{DC} I _{DC} range 10 mA 1000 mA		
RAI, RAIØ RAI1 RAI2	Autoranging I _{AC} I _{AC} range 10 mA 1000 mA		
RR, RRØ RR1 RR2 RR3 RR4 RR5 RR6	Autoranging R R range 0.1 kΩ 1 kΩ 10 kΩ 100 kΩ 1000 kΩ 10,000 kΩ		

Interface commands

Command	Function	
WØ W1 W2 W3 W4 W5 W6 W7 W8	NL CR ETX CR + NL EOI NL + EOI CR + EOI ETX + EOI CR + NL + EOI	
QØ Q1	SRQ function off on	
H1	Auxiliary control character (PET timeout correction)	

Data entry commands

Command	Function
DU/datum/	Reference for V_{DC}/V_{AC} measurement
DI/datum/	Reference for I_{DC}/I_{AC} measurement
DR/datum/	Reference for resistance measurement

Start commands

Command	Function
XØ	Clear command for X3/X4
X1	Trigger command (= GET)
X2	Trigger command + retaining of meas- urement for reference
X3	Setting command for triggering on call of measurement
X4	Setting command for continuous triggering
X5	Trigger command + retaining of meas- urement as offset + offset calculation on
ZØ	Output of reference according to function (V, I, R)
Z5	Output of offset

Special commands

Command	Function
SØ S4	LED test Display of date and condition of calibration according to function (V _{DC} , V _{AC} , I _{DC} , I _{AC} , R)
S5	Indication of any hardware malfunction in coded form

Delimiters

Symbol	Designation	ASCII decimal equivalent	Recommended use				
CR NL ETX	Decimal point Carriage return New line	44 13 10 3	Separator between commands End delimiters				
EOI		Setting of the EOI line by the last character sent also recognized as delimiter					

Service Request

Instrument status	Status byte (decimal)
Measured value ready	80 85
One of several text lines ready Calibration value retained	86
Automatic offset on off	87 88
Syntax error	96
Input datum error Controller call for measurement	98
without trigger	99
Hardware error	100
UDS 5 not ready for output	101
Calibration error	113

DIGITAL MULTIMETERS 6

UDS 5 - Digital Multimeter

Specifications

DC voltage measurement

Nominal range	5½ digits	 Resolution — 4½ digits 	3 ¹ /2 digits	Maximum reading (5½ digits)	Erro 24 h, ±1°C	t limits at T _{cal} 1), 5½ ± (% of rdg + c 3 months, ±5°	ounts)	Input resis	t stance
0.1 V V	1 μV 10 μV	10 μV	100 μV	.160000 V	$0.004 + 2^2)$	0.010 +22)	0.012 +22)	>10	
o v	100 μV	100 μV 1 mV	1 mV 10 mV	1 60000 V 16 0000 V	0.003 +2 0.003 +1	0.009 +2 0.007 +1	0.011 +2 0.009 +1	>10	
00 V	1 mV	10 mV	100 mV	160.000 V	0.003 +1	0.012 +2	0.016 +2	>10 10 M	
000 V	10 mV	100 mV	1 V	1200.00 V	0.005 +1	0.010 +1	0.014 +1	10 M	
Maximum input M Hi to Lo, Hi to g	ground	1200 V	peak	1200.00 V	Temperature co	efficient, ± (% or rd	lq + count)/°C	+1	
Hi to Lo, Hi to g Lo to ground	oround DC, 50 (60) Hz	500 V 2 ±0.05% in dB w Normal mode A	peak peak vith 1 kΩ in Lo Common AC mode AC	lead Common : mode DC	Temperature con Range 0.1 V 1 V 10 V 100 V 1000 V .	2 - 2 - 2 - 2 - 2 - 2 - 2 - 2 - 2 - 2 -	lg + count)/° C 		
Hi to Lo, Hi to g Lo to ground loise rejection D 5 4	2700000 200, 50 (60) Hz 1/2 digits	500 V 2 ±0.05% in dB w Normal mode <i>A</i> 64 (64) 64 (14)	peak peak vith 1 kΩ in Lo Common AC mode AC 130 (130)	lead Common : mode DC	Temperature con Range 0.1 V 1 V 10 V 100 V . 1000 V . Measurement ra		lg + count)/° C 	+1 +0.1 +0.1 +0.1	3½ 80/s

AC voltage measurement - true rms

Nor	minal range	5½ digits	Resolution 4½ digits	3½ digits	Maximum reading (5 ¹ /2 digits)	Input impedance
0.1 1 10 100 1000		1 μV 10 μV 100 μV 1 mV 10 mV	10 μV 100 μV 1 mV 10 mV 100 mV	100 μV 1 mV 10 mV 100 mV 1 V	160000 V 1.60000 V 16.0000 V 160.000 V 800.00 V	1 MΩ 40 pF

Error limits over 1 year

Range	Error limits at T _{cal} 1) ±5°C, 5½ digits, V >1% of nominal range sinewave voltage, ±(% of rdg + counts) 20 to 50 Hz 50 to 100 Hz 100 Hz to 10 kHz 10 to 20 kHz 20 to 50 kHz 50 to 100 kHz 100 to 200 kHz						
0.1 V 1 to 350 V 350 to 800 V	$\begin{array}{rrrr} 2.4 & +100 \\ 1.8 & + & 50 \\ 2.0 & + & 50 \end{array}$	$\begin{array}{rrrr} 0.5 & +100 \\ 0.5 & +50 \\ 0.6 & +50 \end{array}$	$\begin{array}{cccccccccccccccccccccccccccccccccccc$	1.2 +300 0.7 +250 0.9 +250	5 +900 2.5 +850 2.7 +850	20 +3000 10 +3000	

For 4½ digits: ½0 number of counts For 3½ digits: ½00 number of counts +1

Maximum input voltage Hi to Lo, Hi to ground	$\begin{array}{llllllllllllllllllllllllllllllllllll$	
Temperature coefficient, ± (% of rdg + counts)/°C Range 20 Hz to 20 kHz Range >20 Hz	Manual operation (change of display) 5/s 30/s 50 Computer control: interval	3½ 50/s
Crest factor	between trigger and output of first byte	600 ms

DC current measurement

Nominal range	5½ digits	Resolution - 41/2 digits	3½ digits	Maximum reading (5½ digits)		at T _{cal} 1), ±5°C, 5½ digits year, ± (% of rdg+ counts) I >0.5 A
10 mA 1 A	100 nA 10 μA	1 μΑ 100 μΑ	10 μA 1 mA	16.0000 mA 1600.00 mA	0-05 +10 0.07 +10	0.1 +30
For 4½ digits: ½ For 3½ digits: ½ Temperature coe Ranges 10 mA	efficient, ± (% o	f rdg + counts)/°C)	Input protection		250 V max. (1.6-A fusi
Voltage drop Range 10 mA Range 1 A ⊕					ate (without range switching	Digits 5 ¹ /2 4 ¹ /2 3 ¹ /2

 $T_{cal} = 20$ to 25°C, 23°C on delivery ²) With offset correction ³) Δ calculation or offset compensation adds 5 ms on average (1 to 10 ms). The first measurement is correct if triggering is coincident with the test-signal entry ⁴) First measurement (>10% of nominal range); triggering coincident with test-signal entry

DIGITAL MULTIMETERS 6

AC current measurement - true rms

Nominal range	5½ digits	- Resolution 4 ¹ / ₂ digits	3½ digits	Maximum reading (5½ digits)		1) ±5°C, 5½ digits, 1>1% of t ave voltage, 1 year, ± (% of rd 50 Hz to 10 kHz)
10 mA I A For 4½ digits: ½0 For 3½ digits: ½100			10 μΑ 1 mA	16.0000 mA 1600.00 mA	2 +50 2 +50	0.5 +70 0.5 +70	1 +90 1 +90	
Temperature coeffi Ranges 10 mA, 1				Mai		ge switching) Digits 5½ display)5/s	4½ 30/s	3½ 50/s
Voltage drop Range 10 mA Range 1 A				bety	nputer control: interval ween trigger and output of nax. deviation (counts) ⁴).	first byte	600 ms 5	600 m: 1

Resistance measurement

Nominal range	5½ digits	 Resolution 4½ digits 	3½ digits	Maximum reading (51/2 digits)	Erro 24 h, ±1°C	r limits at Tcal ¹), 5½ ± (% of rdg 3 months, ±5°	⁄₂ digits ——— + counts) C 1 year, ±5°C	Test current/ max. voltage
0.1 kΩ	1 mΩ	10 mΩ	100 mΩ	.160000 kΩ	0.005 +22)	0.013 +2 ²)	$0.016 + 2^{2}$	1 mA/7.5 V
l kΩ	10 mΩ	100 mΩ	1 Ω	1.60000 kΩ	0.004 +2	0.012 +2	0.015 +2	1 mA/7.5 V
0 kΩ	100 mΩ	1 Ω	10 Ω	16.0000 kΩ	0.004 +2	0.012 +2	0.015 +2	100 μA/7.5 V
100 kΩ	1 Ω	10 Ω	100 Ω	160.000 kΩ	0.006 +2	0.017 +2	0.020 +2	10 µA/7.5 V
000 kΩ	10 Ω	100 Ω	1 kΩ	1600.00 kΩ	0.006 +2	0.020 +2	0.025 +2	10 μA/23 V
0000 kΩ	100 Ω	1 kΩ	10 kΩ	16000-0 kΩ	0.020 +2	0.130 +2	0.140 +2	1 μA/23 V

Temperature coefficient, ± (% of rdg +	count)/*	С
Range 0.1 kΩ	0.0010	+1
1 kΩ, 10 kΩ	0.0010	+0.1
100 kΩ, 1000 kΩ	0.0023	+0.1
10000 kΩ	0.0160	+0.1

Measurement	rate	(without	range	switchina)
modouronion	iaco	(1111110041	, c	onnonnig/

Digits	51/2	41/2	31⁄2
Range 0.1 to 1000 kΩ Manual operation Computer control, interval	2.4/s	15/s	50/s
between trigger and output of first byte ³) $\alpha_{\rm MADDAR}$ Range 10,000 k Ω	420 ms	55 ms	20 ms
Manual operation Computer control: interval	2.2/s	11/s	11/s
between trigger and output of first byte ³)	460 ms	100 ms	100 ms

 $\overline{T_{cal}} = 20$ to 25 °C, 23 °C on delivery ⁽²⁾ With offset correction ⁽³⁾ Δ calculation or offset compensation adds 5 ms on average (1 to 10 ms). The first measurement is correct if triggering is coincident with the test-signal entry ⁽⁴⁾ First measurement (>10% of nominal range); triggering coincident with test-signal entry

Additional characteristics

Measurement functions	DC voltage AC voltage rms DC current AC current rms Resistance
Measurement ranges	
DC voltage AC voltage DC current Resistance Range setting	500 μV to 800 V, 20 Hz to 200 kHz 100 nA to 1.6 A 10 μA to 1.6 A, 20 Hz to 20 kHz 1 mΩ to 16 MΩ, automatic two-wire/ four-wire switchover
Reference value	key entry or actual measurement
Zero correction	using offset key
Autocalibration	from front panel or IEC bus for all measurement functions
Second key functions	for data entry, entry and checking of IEC-bus address, test programs and autocalibration
Remote control	IEC bus (IEC 625-1/IEEE 488) SH1, AH1, T5, L4, SR1, RL1, DC1 and DT1

Readout of measured value	linear, logarithmic or relative to freely selected reference $V, mA, k\Omega, \Delta V, \Delta mA, \Delta k\Omega, \Delta \Delta, \Delta dB$ or dimensionless quotient (X/REF)
General data	
Operating temperature range Storage temperature range Power supply Dimensions (W×H×D) Weight Ordering information	100/120/220/240 V ±10%, 47 to 63 Hz (30 VA)
Order designation	349.1510.02 UDL 4-Z2 346.8065.02 UDL 4-Z3 346.8113.02 UDL 4-Z4 346.8165.02 UDL 4-Z6 346.8265.02 UDL 4-Z7 346.8313.02

6 SYSTEM VOLTMETERS

voltmeters



The **System Voltmeter UDS 6** is a microprocessor-controlled precision instrument with a completely new concept which offers a degree of versatility never before available.

The UDS 6 is the answer to many complex test problems; depending on its use, it can be characterized as a

- precision voltmeter (multimeter) for laboratory applications and general measurement tasks,
- voltmeter for storing and processing the results,
- system unit for test setups using other interface-compatible instruments (see also page 192).

Measurement, evaluation and storage

Precision measurements. DC voltage, AC voltage and resistance. For DC voltage: resolution 100 nV, error 1×10^{-5} ; variable integration time.

Measurement processing. A total of ten programs for multiplication, limit monitoring, statistics, etc. (see page 189), including time control of test programs lasting up to 96 hours; checkpoint selector (scanner) on page 193.

Data management. Automatically stores measurement data and results in 50 locations; further 30 locations for manual entry.

Stored data can be recalled at any time, for instance for further calculations. All the results can be replaced or entirely erased.

Outstanding features

Out of its range of excellent characteristics, the following features of the instrument should be particularly stressed: resolution 100 nV or 100 $\mu\Omega$, extremely high linearity, variable scale length and integration time, input impedance >100 G Ω , and common-mode rejection 150 dB.

Reading rate. The UDS 6 can easily handle a flood of measurements – at the push of a button 330 readings per second can be obtained.

The settling time of the UDS 6 is extremely short: just 1.6 ms.

Filtering. A digital filter can be connected to ensure maximum accuracy and to suppress noise. In this case, the integration time is increased to 1.28 s and the measurement cycle is locked to the AC supply frequency.

Ease of operation

Despite its many capabilities and functions, the System Voltmeter is almost as easy to operate as an ordinary pocket calculator. The panel controls – pushbuttons with built-in LEDs to confirm the entry – are logically grouped and colour-coded with corresponding coloured legends to guide the user effortlessly through the most complex routines. If an entry has not been completed, the associated LED flashes to remind the operator.

The UDS 6 used as a laboratory digital voltmeter

The System Voltmeter can be used like any other precision DVM in the laboratory. The only difference with respect to conventional DVMs is the instrument's ability to record fully automatically 50 consecutive measurements, even in manual operation. The user can ignore the grey buttons and their corresponding legends. In the manual mode the UDS 6 will measure

- DC voltage: the average value of the input signal during the selected integration time.
- AC voltage: the mean value of the AC component of the input signal; the rms value is displayed if the input signal is sinusoidal.
- Resistance: the average value of the resistance measured during the selected integration time.

Panel controls for manual measurements. The pushbuttons for manual measurements are captioned white on black, the buttons themselves also being black. It is easy to see how to use them: a group of three is used to select the desired measurement function; the measurement range is selected by the buttons on the row beneath, autoranging is of course also possible. The range selected and the autoranging mode are indicated by a corresponding LED.

Indication cycle. The UDS 6 can display measurements either singly or repetitively, as selected by the SAMPLE or TRACK buttons. SAMPLE gives a single new reading each time the button is pressed whereas TRACK causes the display to be continuously updated for each measurement.

SYSTEM VOLTMETERS

With the filter connected into circuit, the integration time is extended; the reading is then updated six times per second (with 6×9 scale length selected: every 1.28 s).

The scale length and the integration time of the A/D converter can be selected (3½ up to 6½ digits) with the (blue) DISPLAY button in conjunction with the buttons captioned 3×9 to 6×9 (white on vlue).



Panel controls for manual measurements, e.g. display and scale length (3×9 to 6×9) as well as integration time

The UDS 6 used as a DVM for measurement processing

The keyboard includes a (grey) PROGRAM button, which can help you solve a lot of measurement problems. Measurement data can be processed in accordance with the user's specifications thus providing more meaningful results than straightforward voltage or resistance indication.

Measurements are processed as they are made and the results are directly displayed on the UDS 6 after pressing a few buttons. The microprocessor not only controls the DVM functions but also offers true data processing capability.

Programs for measurement processing. To process the measurements, nine diffrent programs can be called up (see righthand column and table on next page), providing a total of 26 individual results. A tenth program using the UDS 6 internal clock as a time reference offers time control over the following measurement functions: start, stop, preset intervals. Programming to cover a maximum of 96 hours is possible. Thus the instrument can be left unattended for instance over the entire weekend, and the complete final results can be recalled at the beginning of the working week.

The programs can be used separately or consecutively. For instance, the mean room temperature can be continuously measured over 24 hours with any required interval between measurements.

Many of the programs can perform more than one type of calculation. With some programs the user can choose the calculation to be performed, with other programs he can choose the information to be displayed during the measurement and processing.

Below, the ten different programs are described in the righthand column, and summarized in tabular form with the individual calculations on the next page.

The 10 programs of the System Voltmeter UDS 6

- Multiplication by constant c
 - Each measurement is multiplied by a constant c (>1 or <1) which is entered via the keyboard. Typical applica-

tion: conversion of output signals from flow transducers, e.g. into litres/min.

- 2 Percentage deviation referred to nominal value n Each measurement is compared with the entered nominal value n, and the percentage deviation is displayed. Typical application: quality control.
- 3 Offset by subtracting a constant from each measurement. Using a constant with negative value, addition is also possible. Application: measuring the output currents from sensor/transmitter system. In conjunction with program 1, conversion into engineering units is possible.
- 4 Ratio obtrained by division (measurement/nominal value). Three different calculations can be selected: linear, logarithmic (gain, etc. in dB), inverse ratio (e.g. for conductance calculation).
- 5 Maximum and minimum by storing and updating measurements (peak-to-peak value found by subtracting minimum from maximum); four different results can be displayed, see table on the next page.
- 6 Limit monitoring by entering two constants and comparing the measurement with the limits: an additional symbol may be displayed, e.g. a high bar if the upper limit is exceeded. Five different results can be selected; see table on next page.
- 7 Statistics by storing each measurement and carrying out the calculations internally. Application: quality assurance. The UDS 6 can carry out the following calculations for the five different results, in the middle of taking measurements (all the results are ready to be recalled at the end of a run):
 - 0: each measurement 3: updated standard deviation

$$R = x$$

$$R = \sqrt{\frac{1}{i} \sum_{k=1}^{i} (x_k - \overline{x})^2}$$

1: updated average

$$R = \frac{1}{i} \sum_{k=1}^{i} x_k = \overline{x}_k$$

2: updated variance

4: updated rms

$$R = \frac{1}{i} \sum_{k=1}^{i} (x_k - \overline{x})^2 \qquad R = \sqrt{\frac{1}{i} \sum_{k=1}^{i} x_k^2}$$

- 8 Temperature measurement using thermocouples The UDS 6 measures the output voltage of a thermocouple, linearizes it and displays the result in °C or °F. The linearization tables for four types of result are built into the memories; see table.
- 9 Time control of measurements and processing over a maximum of 96 hours.
 - 0: program run in modes SAMPLE: continuous to the end, TRACK: continuously repeats measurement and displays latest reading
 - 1: start/stop operation, with real time of day if desired
- **9** Polynomial evaluation by measurement and linearized display, for instance outputs from non-linear devices using the equation $R = c_0 + c_1x + c_2x^2 + c_3x^3$. The constants c_0 to c_3 are entered after calling up the program.

6 SYSTEM VOLTMETERS

voltmeters

UDS 6 - System Voltmeter

Program summary

Program	Type of result	Display	Calculation		En	try	Rec	all sequence
1 Multi- plication		Product	R = cx	c: constant	c	Multiplier	с	Multiplier
2 % deviation	1000	∆% from nominal	$R = 100 \frac{x - n}{n}$	n: nominal	n	Nominal	n	Nominal
3 Offset		Offset	$R = x - \Delta$	∆: offset		Offset		Offset
4 Ratio	0 1 2 3	Meas./ref. dB Power Inverse ratio	R = x/r $R = 20 \log x/r$ $R = x^2/r$ R = r/x	r: reference value x/r must be positive r: resistance r: reference value	r r r r	Reference value Reference value Resistance Reference value	ŕ	(a) Type of result (b) Reference value
5 Maximum/ minimum	0 1 2 3	Each measurem Maximum Minimum Peak to peak	R = x R = max. x R = min. x R = max. x - min. x				H L PP	(a) Type of result (b) Maximum (c) Minimum (d) Peak to peak
6 Limit monitoring	-	Measurement value	$ \begin{array}{l} x > H = HI \\ x < L = LO \\ H > x > L = GO \\ Comparator fuzz < 1 dig \end{array} $	H: upper limit L: lower limit pit	HL	Upper limit Lower limit	nH nL nG H, L	(a) Number >H (b) Number <l (c) Number in tol. (d, e)</l
7 Statistics	0 to 4	Measurement value	See pervious page unde	ər 7				(a) Type of result n/AV/VA/Sd/rS
8 Temperature of thermo- couple	0 1 2 3 4 to 7	°C for Cu/Con °C for Pt/PtRh °C for Fe/Con °C for NiCr/NiAt °F for each type above	$ \begin{array}{c} R = a + bx_{p} + cx_{p}^{2} + c \\ \left(\begin{array}{c} x_{p} = x_{i} + a' + b'A \\ a, b, c, a', b', c' stc \end{array} \right. \end{array} $	$\frac{dx_{\rho^3}}{+c'A^2}$;	A	Room temp⊨°C Room temp. °F	A	(a) Type of function (b) Room temp. in °C (a) in °F
9 Time	0 1		Clock: locked to AC sup Run time and interval be max. 95 : 59 : 59 h Resolution 1 s	ply; time span 96 h etween readings:	tr t tb,	Progr. = run time Time, tA Start tc Interv., stop		(a) Type of timing otherwise as entry
0 Polynomial evaluation	-	Polynomial solution	$R = c_0 + c_1 x + c_2 x^2 + c_1 x + c_2 x^2 $	c ₃ x ³		c ₀ to c ₃ (constant)		c_0 to c_3 (constant)



Display, keyboard and entry

Large/small readings. Depending on the application and the measurement period, a considerable amount of data has to be handled and high values must be displayed, as in program 7. The UDS 6 can process over **1000 million** readings and display both very large and very small values.

If a number exceeds the display range of $\pm 9\,999\,999$, the display changes to exponent form. The range is then 10^{63} to 10^{-63} . A measurement of 3 mV for instance – divided by an assumed constant of 2000 – yields a reading of 1.5×10^{-6} .

Interactive display. In addition to showing voltmeter measurements and the results of processing, the UDS 6 display is used to set up programs and to recall processing results. The display and the keyboard constitute an **interactive system** for the operator: the display presents numbers,

Preliminary information for calling up value from history file

words, or a mixture (alphanumeric form) to guide the user as to the steps to be taken.

In the case of programs with several types of result, the one selected is displayed in addition to the program number Constants are displayed as they are keyed in. The display says FULL if more than three programs are called up.

Due to the limitations of the 7-segment format, special characters such as H for the entry of the upper limit (or L for the lower limit) have been selected. During the recall of the results, the UDS 6 display briefly indicates which result is about to appear, for example

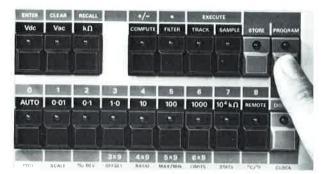
nH followed by number of measurements "high"

- nL followed by number of measurements "low"
- nG followed by number of measurements "go"
- H followed by upper (high) limit
- L followed by lower (low) limit.

The interactive display of the System Voltmeter UDS 6 keeps the user informed on the steps he has to take next.

SYSTEM VOLTMETERS 6

Keyboard. Easy operation is essential for a user-oriented test system. With the System Voltmeter UDS 6 this has been achieved by grouping the keys into logical patterns, the buttons being colour-coded with the corresponding coloured legend. In this way a minimum of keys is required.



Keyboard offers wide range of input, output, calculation and storage functions

Black buttons:	for measurement functions and ranges (V, R)
Blue buttons:	for scale length (number of digits)
Program button:	this (grev) button causes all the others to

e.g. switchover from simple DVM function to measurement processing.

Entry. Program numbers, types of result and constants are keyed in using the buttons on the bottom row marked 0 to 9; the polarity of constants and decimal points are entered via the buttons on the top row. The entries appear in the display as they are keyed.

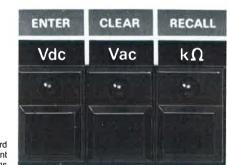
- ENTER is used to enter program numbers, etc., into the memory; a typical sequence could be: Program 4 ENTER
- CLEAR is used to erase the data in the display and in the memory; if program 9 is cleared, the internal clock is not reset. Example: P 7 CLEAR
- RECALL is used to recall all the results of a program at the end of a program run, since during the run only one result can be shown.
- EXECUTE is a heading for the TRACK and SAMPLE buttons which are the start buttons for program execution (see also under program 9); after pressing these keys, the function of the keys reverts to the black captions.
- COMPUTE is activated while the measurements are being processed (the built-in LED lights up); pressing this button stops the processing and the UDS 6 operates from then on as a normal DVM. The results processed so far can be recalled. To continue processing with the same data, it is merely necessary to press the COMPUTE button again.
- REMOTE switches the UDS 6 when operated via the RS-232 interface from manual to remote-controlled operation and vice versa; when using the IECbus interface, only switchover to manual operation; the LED lights up in both cases to show the remote control mode.

Data management

History file. It has already been mentioned that the UDS 6 can store 50 consecutive measurement values, automatically and independently of the mode selected (measurement processing or basic DVM function). To read from this memory, press the STORE button. In the STORE mode, the grey captions assume a slightly different significance than they have in the processing mode: the RECALL button is now used to read the stored data in sequence; the file can be accessed either forwards or backwards, as selected with the +/- button.

Data modification (manipulation). The UDS 6 contains a further area of memory with 30 locations for manual storage of any data, such as measurement values, programs or results. These data can be modified, updated, manipulated and erased. Stored measurements can be recalled as base data for further calculations. The STORE button is the key to a wide range of new possibilities in data management.

Data management via the keyboard. In the STORE mode the white-on-grey captions apply for the remaining buttons, as in the processing mode.



Area of keyboard for data management functions

The ENTER button is used to write data from the display into a selected memory location.

The CLEAR button is used to erase the displayed data (similar to the CE button on a pocket calculator), permitting operator mistakes while keying-in to be rectified without erasing stored data.

The RECALL button enables the contents of a specified memory location to be read out and displayed.

The buttons marked 0 to 9 are used to specify memory locations. In conjunction with +/- and the decimal point, the number keys can be used to enter constants which are to be stored.

The keyboard and the display are fully interactive. The address is displayed when the specified memory location is called up. Constants are built up digit by digit in the display, thus avoiding entering an incorrect figure.

Conclusion: The operation of the System Voltmeter UDS 6 is as easy as that of a pocket calculator; its computational capacity is, however, many times greater.



System Voltmeter UDS 6/UDS 6-B1

System use

Fitting the System Voltmeter UDS 6 with a system interface option (ordered separately) extends its range of application and makes it suitable for **use in automatic test systems.** In conjunction with a printer or a VDU, the instrument can operate as a simple, inexpensive test system without needing a controller.

System interface. The system interface adds the following new capabilities:

Comprehensive interactive data transfer between the user and the System Voltmeter as well as between the system controller (e.g. Process Controller PUC), the UDS 6 and all the other system components; the option is a combination of two data interfaces in one unit: the IEC bus, and RS 232 C (V.24).

Full system control using a system-compatible desktop computer.

Optimum flexibility of application, from use in the laboratory through to the fully automatic test system with realtime or preprogrammed operation.

The **IEC-bus interface** meets IEC 625-1 and IEEE 488; it is fitted with both a 24-way and a 25-way connector (see photo below). The following functions can be executed:

- SH1 source handshake RL1 remote/local
- AH1 acceptor handshake PP2 parallel poll
- T5 talker L3 listener
- DC1 device clear
- DT1 device trigger

SR1 service request

RS-232-C interface (CCITT V.24). The interface comprises eight lines: four handshake and four communication lines, including protective ground and common.

Baud rate: 110, 150, 300, 600, 1200, 2400, 4800 and 9600.

Simple point-to-point communication. Measurements, processing or data management information in the UDS 6 can be called up via a data terminal which can then be used to display the results.

Preprogrammed control. Programming commands for setting the UDS 6 to different modes of operation can be transmitted via a data terminal.

Automatic control. If the data terminal has a mass storage device (magnetic-tape or floppy-disk unit) or the test system includes a system controller (microcomputer), the UDS 6 (fitted with option UDS 6-B1) can operate without operator intervention.

Program troubleshooting. The UDS 6 permits rapid fault locatoin when entering the program. In the case of a dubious result, each program parameter entered can be recalled by sending the ASCII character "?". Moreover, sending character "E" causes a complete listing of all the program parameters.

Data input. All the functions of the System Voltmeter can be controlled via the IEC-bus or the RS-232-C interface. All entries of measurement functions and ranges, programs and data-manipulation commands are coded in ASCII, individually or in strings. The instruction set of the UDS 6 is compatible with the two different types of interface.

Data output. The measurements are output in the form of an alphanumeric string:

Sp VDC Sp Sp + 1.23456E + 03

The first six characters – the alphanumeric header – can be suppressed if they cannot be read by the user's terminal.

Additional information is presented to the right of the measurement data, e.g. HI/LO information from program 6, measurement timing, or the program in use.

VDC -0.000287E-02

System expansion: Scanner UDS 6-Z1

If measurements are to be taken not at a single point but in a rapid sequence at many different points, the **Scanner UDS 6-Z1** (for detailed description see next page) offers a neat and cost-effective solution. Neat because the Scanner is housed in a slim case which matches that of the UDS 6. Cost-effective because it contains 16 analog channels, and does not require an interface of its own: it is controlled by the voltmeter interface, connected via a single socket at the rear.

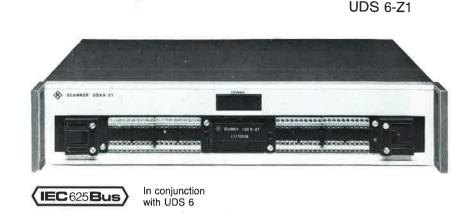
	• • • • • • • • • • • • • • • • • • •		
Connector for scanner		RS-232-C (V.24) interface	IEC bus, 25-way 24-way

Rear panel of System Voltmeter UDS 6 with connectors for Scanner UDS 6-Z1 plus IEC-625-1 and RS-232-C interfaces

SYSTEM VOLTMETERS 6

Scanner UDS 6-Z1

- 16 channels
- Checkpoint selector, an ideal DVM expansion for rapid data acquisition
- Typical scanning speed 130 channels/s
- Control and programming by the DVM via IEC bus or RS-232-C interface
- Four-terminal plus guard scanning



The **Scanner UDS 6-Z1** is an extremely efficient and lowpriced checkpoint selector whose internal and external design matches the System Voltmeter, expanding the UDS 6 into an automatic large-scale data acquisition system with a high scanning speed.

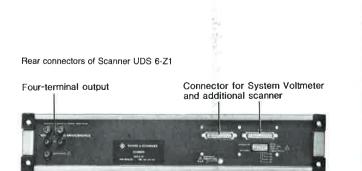
Characteristics

Number of checkpoints; terminals used. The Scanner is able to poll 16 different checkpoints, each input channel being of the four-terminal-plus-guard type. It can be used for either voltage or resistance measurement. The checkpoints of interest are connected via two screw-terminal blocks, each of eight channels. The channels are coded hexadecimally from 0 to F.

The actual scanner assembly has a switching speed of 130 channels per second (typical) with an extremely low inherent noise voltage.

To match the input terminals of the UDS 6, the analog signals are brought out at 4-mm rear sockets: there is a total of five lines, four for the analog signals as required for resistance measurement using the Kelvin bridge technique, and one as a guard line.

The control lines and the power supply are connected via a standard 25-way Cannon cable. The logic required for the scanner control is included in the System Voltmeter which also provides for channel selection. Expansion in blocks of 16 channels (up to a total of 255) is possible by the provision of a second connector socket.



Systems use

In the simplest system configuration, an individual Scanner UDS 6-Z1 is controlled from a printing terminal (teletype) or a VDU with its keyboard. The System Voltmeter to which the Scanner is connected supplies the results to the data terminal. Thus up to 16 checkpoints can be scanned and the data and processing results logged.

Moreover, the Scanner can also be **used in larger systems** where a desktop computer or the Process Controller is included for control.

Specifications of Scanne	r UDS 6-Z1
Checkpoint switchover	
Channels	16 (15 if unit is in block 0)
Switching elements Operating time	5-pole reed relays
Settling time	6 ms (as set in DV/M)
Release time	<1 ms
Thermal error	±5 μV
Maximum ratings	
	130 Vms, 200 Vo
Input voltage (HI/LO)	10 V _P
Voltage between input and earth Voltage between channel inputs .	
Switched signal voltage	200 V
Isolation between channel inputs	
Signal connectors	
	each with 8 channels
General data	
Operating temperature range	
Storage temperature range Power supply	
Dimensions, weight	e.g. UDS 6
Dimensions, weight	433 mm×88 mm×460 mm, 7 kg
Ordering information	
ordening information	
Order designation	Scanner UDS 6-Z1
Accessories supplied	346.9510.02 25-way control cable (connection of
	UDS 6 to UDS 6-Z1), 346.9584.02;
	2 handles and 2 side panels for rack mounting;
	2 Screw-terminal Blocks UDS 6-Z2,
	each for 8 channels
Recommended extras	
5-way test cable UDS 6	
to UDS 6-Z1	346.9384.02

 5-way test cable UDS 6
 346.9384.02

 5-way test cable UDS 6-Z1
 to UDS 6-Z1

 to UDS 6-Z1
 346.9378.02

 Screw-terminal Block UDS 6-Z2
 346.9578.02 (two items required)



System Voltmeter UDS 6

Specifications

DC voltage measurement

Digital filter selected

Nominal Resolution range				24 h, ±1 °C ± (% rdg + digits)		Error limits at +20 °C 6 months, ±5 °C ± (% rdg + digits)		1 year, ±5 °C ± (% rdg + digits)		Input resistance	
10 mV	100 nV	0.0140000 V	0.001	40	0.003	40	0.004	40	>100	GΩ	
100 mV	100 nV	0.1400000 V	0.001	40	0.003	40	0.004	40	>100	GΩ	
1 V	1 μV	1.400000 V	0.0006	4	0.003	4	0.004	4	>100	GΩ	
10 V	10 µV	14.00000 V	0.0005	4	0.0018	4	0.0025	4	>100	GΩ	
100 V	100 µV	140.0000 V	0.0008	6	0,003	6	0.004	6	10	MΩ	
1000 V	1 mV	1400.000 V	0.0008	6	0.003	6	0.004	6	10	MΩ	
Error limits (+/-											
with reduced s	cale length		0.002	1 + 4 μV	0.004	2 + 4 μV	0.006	2 + 4 µ\	/		
		4×9		1 + 4 μV		1 + 4 μV	-	1 + 4 μ\	/		
		3×9		1		1		1			

Max. input voltage
with autoranging
in manual mode
Reading rate with scale length 10000 6×9 5×9 4×9 3×9
Measurement/s
(without filter; otherwise less) 6 43 182 330
Error limits valid for 6×9 scale length

Error in the case of high speed operation:

Without digital filter, an additional error of \pm (25 μV + 1 digit) must be added to the above limits for all scale lengths.

 Temperature effect (max. ±)

 Ranges 10 mV to 1 V
 0.0004% of rdg/°C

 10 V
 0.0003% of rdg/°C

 100 V, 1000 V
 0.0005% of rdg/°C

 Zero drift (max. ±)
 0.2 μV/°C

AC voltage measurement

Digital filter selected

Nominal Resolution Displayed range full scale	Resolution		Error limits at +20 °C								
		±1°C to 10 kHz dg + digits)	40 Hz to 50 kHz ± (% rdg + digits)		6 months, $\pm 5^{\circ}$ C 50 Hz to 10 kHz \pm (% rdg + digits)		40 Hz to 50 kHz ± (% rdg + digits)				
100 mV	1 μV	0.140000 V	0.03	20	0.1	20	0.05	20	0.15	20	
1 V	10 μV	1.40000 V	0.03	20	0.1	20	0.05	20	0.15	20	
10 V	100 µV	14.0000 V	0.06	20	0.2	20	0.08	20	0.25	20	
100 V	1 mV	140.000 V	0.06	20	0.2	20	0.08	20	0.25	20	
1000 V	10 mV	1400.00 V	0.06	20	0.2	20	0.08	20	0.25	20	

AC voltage, continued

Nominal range			Error limits	
	50 Hz 1	ar, ±5°C to 10 kHz dg + digits)		to 50 kHz rdg + digits)
100 mV	0.07	20	0,2	30
1 V	0.07	20	0.2	30
10 V	0.1	20	0.3	30
100 V	0.1	20	0.3	30
000 V	0.1	20	0.3	30

Max. input voltage	750 V _{rms} (up to 20 kHz) 200 V _{rms} (above 20 kHz) DC component: 400 V
Input impedance Overload protection	1 MΩ <150 pF 250 V _p , ranges ≦1 V 1.2 kV, ranges ≧10 V

Error limits	for input signals > 5×9 scale length	>2% FS;
Error limits with reduced scale lend (basic error of rdg same as in table above, however, different digit error) Scale length 50 Hz to 10 kHz, digits 40 Hz to 50 kHz, digits Response time	3×9 2 2	4×9 3 3 onent, the first 99.8% of a step
Upper frequency limit	0.5 measurement	s/s
Filter	must be selected if specified accura maintained	for f <400 Hz acy is to be
Temperature effect (max. ±) Ranges 100 mV, 1V ≧10 V	0.005% of rdg/°0 0.01% of rdg/°C	2

SYSTEM VOLTMETERS 6

Resistance measurement using four-terminal technique

Digital filter selected 6×9 scale length

Nominal range	Resolution	Displayed full range	24 h, ± ± (% rd	1°C lg + digits)	6 mont	hits at +20°C hs, ±5°C dg + digits)	1 yea ± (% + digi		Measuring current
10 Ω	100 μΩ	0.0140000 kΩ	<u>in -</u>	80	0.006	90	0.01	90	1 mA
100 Ω	100 μΩ	0.1400000 kΩ	0.001	80	0.005	90	0.006	90	1 mA
1 kΩ	1 mΩ	1_400000 kΩ	0.001	8	0.005	9	0.006	9	1 mA
10 kΩ	10 mΩ	14.00000 kΩ	0.001	8	0.005	9	0.006	9	1 mA
100 kΩ	100 mΩ	140.0000 kΩ	0.002	8	0.006	9	0.007	9	10 µA
1 MΩ	1Ω	1400.000 kΩ	0.002	8	0.006	9	0.007	9	10 µA
10 MΩ	10 Ω	14000.00 kΩ	0.005	8	0.015	9	0.015	9	1 μΑ
Fror with redu	iced scale length		_		50	x g			4 × 9 / 1 year
10 Ω			222	8	0.01	9	0.01	9	\pm (2 digits + 6 m Ω
00 Ω			0.003	8	0.01	9	0.01	9 9	
1 kΩ			0.003	2	0.007	3	0.01	3	3 × 9 / 1 year
10 kΩ			0.003	2	0.007	3	0.01	3	± 2 digits
00 kΩ			0.003	2	0.007	3	0.01	3	0.12
1 MΩ			0.004	2	0.008	3	0.01	3	
10 MΩ			0.01	2	0.02	3	0.02	3	

Error in the case of high-speed operation:

Without digital filter, an additional error of \pm (25 m Ω + 1 digit) must be added to the above limits for all scale lengths.

Additional characteristics

Interference rejection ratio in dB of peak interference to 1 digit reading error						
	ode rejection	ode				
voltage		••••	1.1 kV _p with	n autor	anging	
1.1×FS in manual mode DC voltage measurement						
			Integr time	dB	Integr time	dB
Scale I	ength 6×9 5×9		160 ms 20 ms	>90	1.28 s 160 ms	>90 >90
	4×9		2.5 ms 0.3 ms	_	160 ms	>90
					100 1110	>90
Common	-mode rejection	•••••§	. measured v LO input lin		= 1 kΩ in	
	nissible common-					
voltage . DC voltad	e measurement	• • • • • • • •	. 500 V DC c	or 500	Vp	
Common-mode rejection for DC >150 dB						
AC >164 dB at 50 and 60 Hz AC voltage measurement						
Common-mode rejection for DC >150 dB AC >50 dB at 50 and 60 Hz						
The integration time is locked to the phase of the AC-supply frequency; full series- and common-mode rejection is ensured despite AC-supply fluctuations up to $\pm 3\%$.						
Temperat	ture measuremer	nt #	program 8 s	selecte	d;	
			the cold-jun must be wit scale length	hin O t		
Type of	Measurement	Resolu-			Error limi	
thermo-	range in °C	tion °C	over 1 wee	ek	over 1 year	
				-	•	
T B	-100 to +400 0 to 1000	0.1 0.25	0.9 6		±1.5 ±7	
	1000 to 1750	1	3		±4	
J K	0 to 750 -120 to +1370	0.1 0.1	06 09		±1.5 ±1.7	
T: Cu/Co	n, R: Pt/PtRh, J:	Fe/Con,	K: NiCr/NiAl	1		

ver) 0 kg
ng
l only)
0 kg

MULTIMETER ACCESSORIES 6

voltmeters

Accessories for UDL 3/UDL 4/UDS 5/UDS 6

Carrying cases and a wide range of accessories are available for the Digital Multimeters UDL 3 and UDL 4 described on pages 180 and 181 to extend their range of applications.

Some of these accessories can also be used with the Multimeters UDS 5 and UDS 6 and are identified accordingly:

3) 4) 5) 6) below the photo implies that the accessory is suitable for use with the corresponding instrument, e.g. 3) for UDL 3 or 5) for UDS 5.

Clamp-on Current Probes

UDL 4-Z3



4)



3) 4) 5) 6)

10-A Current Shunt

UDL 4-Z2

Characteristics

Power Supply

It permits the Digital Multimeter **UDL 3** to be operated from the AC supply. When the supply cable is connected to the voltmeter, the internal battery is automatically switched off.

Battery Pack

UDL 4-Z8

UDL 3-Z2

The battery pack permits the **UDL 4** to be operated independently of the AC supply. When the multimeter is connected to the AC supply, the battery pack is recharged via the internal power supply (also when the UDL 4 is switched off).

10-A Current Shunt

UDL 4-7.2

This shunt extends the current measurement ranges of the Digital Multimeters **UDL 3**, **UDL 4**, **UDS 5** and **UDS 6** up to 10 A. It can also be used with other multimeters.

Clamp-on Current Probes

UDL 4-Z3/UDL 4-Z4

In conjunction with the **UDL 3**, the **UDL 4** or the **UDS 5** (or with any other AC ammeter) the current probes permit AC measurements

up to 150 A with UDL 4-Z3 and up to 1000 A with UDL 4-Z4.

The transformation ratio of 1000:1 yields a readout in A if the corresponding measurement range has been selected.

40-kV High-voltage Probe

UDL 4-Z7

The high-voltage probe for the **UDL 3**, **UDL 4**, **UDS 5** and **UDS 6** can be used for measurements up to max. 40 kV and is also suitable for use with all multimeters with 10 M Ω input impedance for DC voltage measurements. If the 100-V range is selected on the multimeter, it reads out the high voltage in kV.

Temperature Probe

With the aid of the temperature probe the Digital Multimeters **UDL 3, UDL 4, UDS 5** and **UDS 6** or any other voltmeter can measure temperatures between -65 °C and +150 °C rapidly and easily.

Rack Adapter

UDL 4-Z5

UDL 4-Z6

Up to two Digital Multimeters **UDL 4** can be installed in a 19" rack with the aid of the rack adapter. A blank panel is supplied with the adapter.

MULTIMETER ACCESSORIES 6

Specifications/ordering information

Power supply 220 V, 50 Hz Output voltage 9 V DC Max. output current 30 mA Insulation to VDE 055/1	
Order designation Power Supply Adapter UDL 3-Z2 346-7369.02	

Operating time when fully charged	approx. 6 hours
Charging time	max. 16 hours
Order designation	Battery Pack UDL 4-Z8 346,8365.02

Measured current	0 to 10 A,
Output voltage	briefly up to 20 A
Error limits	±0.5% from 0 to 400 Hz
Order designation	
	346.8065.02

	UDL 4-Z3	UDL 4-Z4
Max. current measured	150 A	1000 A
Transformation ratio	1000:1	1000:1
		100011
	30 to 1000 Hz	50 to 5000 Hz
Fron limits	+2% at	
Max diamator of ourrent	30 10 400 HZ	SU and BU HZ
	44.0	E4
carrying wire	11.5 mm	54 mm
Order designation	▶ 150-A Clamp-on	► 1000-A Clamp.on
	340.0113.02	340.6165.02
Frequency range of measured current Isolating voltage Error limits Max. diameter of current- carrying wire	30 to 1000 Hz 3000 V ±2% at 30 to 400 Hz 11.5 mm	50 to 5000 Hz 2000 V at 50 Hz ±2% at 50 and 60 Hz 54 mm

Max. voltage measured
Voltage coefficient $max2 \times 10^{-6}/V$ Input impedance $1 \text{ G}\Omega$ Temperature coefficient $max. 1 \times 10^{-4}/^{\circ}\text{C}$
Order designation 40-kV High-voltage Probe UDL 4-Z7 346.8313.02

Temperature measurement range -65 to +150 °C Output voltage 1 mV/°C Error limits ±1°C between -10 and +110°C beyond this range linearly increasing error up to +2/+4°C at -65°C and 0/+3°C at +150°C Permissible temperature for handle and cable 70°C Power supply 9 V (built-in battery IEC 6 F 22) Order designation ► Temperature Probe UDL 4-Z6 346.8265.02
Order designation 19" Rack Adapter UDL 4-Z5 346.8213.02

DC VOLTMETERS 6

voltmeters



DC Microvoltmeter UIG

- 0.2 μV to 320 V
 0.2 μV
 0.2 (up to 30 kV with probe) 1 pA to 320 mA
- High sensitivity; floating circuitry
- Amplifier output -50 to +100 dB
- Independent of Ac supply, battery sufficient for 10,000 operating hours
- Use as input adapter, e.g. in conjunction with digital multimeters or with any low-sensitivity DC recorder

The DC Microvoltmeter UIG is a very accurate and sensitive measuring instrument with an amplifier output. The MOS-FETs in the chopper and the precision design of the amplifiers keep the power consumption so low that one battery is sufficient for 10,000 operating hours (battery voltage can be checked on meter). Since the circuit is isolated from the case, the UIG can be operated off earth.

Measurement ranges and input resistances. DC-voltage and DC-current ranges are set by means of two switches, one for numerical values and the other for units. The fullscale value is determined by the positions of the two switches.

Switch 2, numer	cal values:	0.01/0.03/0.1/0.3/1/3
1 1 2		10/30/100/300
Switch 1, units:	mV/V nA/uA/mA	$\begin{array}{l} (R_{in} = \ 10/50 \ M\Omega) \\ (R_{in} = \ 1 \ M\Omega/1 \ k\Omega/1 \ \Omega) \end{array}$

Switch 1 in position mV: the amplifier is directly connected to the voltage-test terminal; ranges 10 uV to 300 mV with 10-MO input resistance. Position V: a 60-dB attenuator is connected ahead; range 10 mV to 300 V with 50-M Ω input resistance. In the positions nA, uA and mA, the amplifier is shunted by the resistances 1 M Ω , 1 k Ω and 1 Ω and connected to the current-test terminals.

Reading. The measured value is indicated on a meter having a mirror scale of 105°; class of accuracy 0.5. Since the zero is in the middle of the scale, no polarity reversal is required. The electrical zero need only be adjusted in the most sensitive ranges.

Accuracy. In the temperature range +10 to +35°C the error is below 2.5% in all ranges, at room temperature 1.5% (without noise and drift). Typical values of voltage and current drifts: 50 nV/°C and 1 pA/°C; typical values of noise: 0.3 μV_{pp} and 0.8 pA_{pp}.

Amplifier output. Open-circuit voltage 1 V at full-scale deflection. Gain adjustable in 10-dB steps from -50 to +100 dB, error limit 0.5%.

Examples of application

Compared with a classical voltmeter, the UIG offers a far higher, sensitivity and complete off-earth operation at an input resistance of 50 M Ω in the range 1 mV to 320 V. The

following examples are only some of the applications possible with the UIG.

Measurement of low resistances such as contact resistances, winding and printed-circuit conductor resistances (measured with the aid of a power source). Measurement range with a test current of 1 A: 1 $\mu\Omega$ to 320 m Ω ; with 1 mA: 1 m Ω to 320 Ω ; direct resistance readings.

Insulation-resistance measurements (by means of current measurement). Resistance up to 10 TO can be measured with a test voltage of 10 V.

Bridge measurements. Null detection and error measurements according to the deflection method can be carried out. With a bridge supply voltage of 10 V, a resolution of 0.2×10^{-6} can be achieved.

Measurement of rectified diode voltages. An RF voltage of 0.7 mV produces a rectified voltage of approximately 10 µV on an ideal diode. This corresponds to full-scale deflection in the most sensitive range of the UIG.

Semiconductor measurements, e.g. pinch-off voltage and gate current of field-effect transistors, offset voltage and offset current of operational amplifiers.

Specifications
Measurement ranges and input resistances see text on the left Minimum readable voltage $0.2 \ \mu V$ Maximum readable voltage $320 \ V$ Minimum readable current <1 pA Maximum readable current $320 \ mA$ Error limit 1.5% Maximum values at test input 500 V
Voltage, position V
Amplifier output 1 V; R _{out} = 1 kΩ Power supply 6 single cells IEC-R 20 Dimensions, weight 162 mm×238 mm×302 mm, 4 kg
Order designation DC Microvoltmeter UIG 203.5111.02
Accessories supplied 1 set of batteries 1.5 V/IEC-R 20 Recommended extra 40-kV DC Probe (UDL 4-Z7) 346.8313.02

PSOPHOMETERS 6

Psophometer UPGR

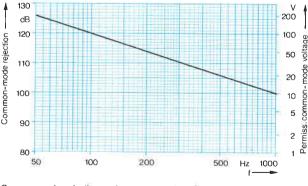
- 15 Hz to 100 kHz
 - 3 µV to 350 V/-110 to +53 dB
- Psophometer complying with CCIR (DIN 45405 and CCITT by means of accessory filter)
- Psophometer complying with CCITT (using telephone weighting filter)
- High-impedance balanced and unbalanced inputs
- Quasi-peak-responding detector complying with CCIR and DIN and true rms-responding detector with switchselected time constant complying with CCITT



Combined with its two options the **Psophometer UPGR** complies with the relevant recommendations of CCIR, CCITT and DIN 45405. It is used for

- wideband level and voltage measurements in the AF range from 15 Hz to 100 kHz, and for
- measurement of weighted and unweighted noise voltages and levels in electroacoustic broadband and telephone transmission systems.

The UPGR has a high-impedance balanced input with excellent common-mode rejection (diagram below). It can be switched for balanced measurements with 600 Ω , 10 k Ω and 100 k Ω input impedance, high-impedance measurement of the voltage to earth of the a- and b-wires, direct measurement of common-mode voltage and – via an isolated BNC female connector – floating measurement of AF voltages.

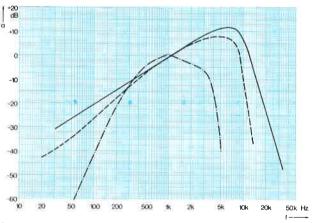


Common-mode rejection and common-mode voltage of UPGR versus frequency

Weighted noise measurements can be performed with the following filters:

broadcast weighting filter in line with CCIR (built-in)

broadcast weighting filter UPGR-Z2 in line with old standards of CCITT and DIN (option; can be readily substituted for the CCIR filter) telephone weighting filter UPGR-Z1 in line with CCITT (option; can be attached and connected at the rear of the set).



Standard characteristics of psophometric filters

Full line: program weighting filter complying with CCIR Rec. 468 (future DIN standard) Dashed line: program weighting filter complying with DIN 45405 and CCITT Rec. P. 53 B (old) Chain-dotted line: telephone weighting filter complying with CCITT Rec. P. 53 A

The following unweighted measurements can be made with the UPGR:

Unweighted noise measurements in the range 31.5 Hz to 16 kHz via the built-in CCIR filter

Unweighted noise measurements in the range 31.5 Hz to 20 kHz in line with DIN via the filter UPGR-Z2 (see above)

Accurate voltage and level measurements in the wideband range of 15 Hz to 100 kHz, e.g. in stereo channels and on control and pilot tones.

External filters can be connected at the rear for special measurement tasks. In conjunction with the Octave Filter PBO or Third-octave Filter PBT, for example, a rough spectral analysis of the test signal is possible. The Telephone Weighting Filter UPGR-Z1 can also be connected here.

6 PSOPHOMETERS

voltmeters

UPGR



Filter UPGR-Z2 (option) in accessory case (broadcast weighting filter for old standard)



Rear of UPGR with Telephone Weighting Filter UPGR-Z1 attached

For indication of the test results, the meter of the UPGR can be switched for peak reading according to DIN and CCIR or rms reading to CCITT. When the instrument is driven to full-scale deflection, the crest factor should not be higher than 10 in rms measurements corresponding to an overdrive capacity of 17 dB relative to sinewave voltages. In the case of peak-responsive measurements the overdrive capacity is 20 dB; this is of special importance for weighting short individual pulses. A combined overdrive indication for the amplifier and the rms-responding detector prevents erroneous measurements.

Outputs. DC output: A voltage proportional to the rms or peak value is available for connection of a recorder or digital voltmeter. AC output: The UPGR can be used as a balanced preamplifier for oscilloscopes, headphones output, etc.

The UPGR can be powered from batteries (permitting floating operation and mobile use) or from the AC supply.

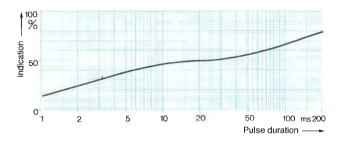


When the UPGR is operated in this position an additional error of 1% of fsd is to be taken into account

Meter rectifiers

CCIR and DIN 45405 specify a peak-responding detector, the older CCITT standard only an rms-responding mode, for measuring the noise voltage. The UPGR therefore incorporates both rectifier types which, in conjunction with the meter, exhibit the dynamic behaviour required by the standard specifications.

The peak-responding detector measures the quasi-peak value, which depends on the duration of the signal pulse (see diagram). This value is determined such that when measuring a sinewave voltage the rms value is indicated and not the peak value, which is 3 dB higher. When measuring white noise with the quasi-peak-responding detector, the readout is about 4 dB higher than the rms value. With this kind of indication the annoyance of pulse-type noise voltages is weighted.



Peak indication as a function of pulse duration in measurements with single bursts of a 5000-Hz sinewave signal (amplitude corresponds to 100% indication with continuous signal)

The rms-responding detector is used to measure the true rms value of noise voltages as well as CCITT-weighted noise voltage. It recommends itself for **general voltage and level measurements**, including non-sinusoidal waveforms (distorted sinewaves, squarewaves, sinewave bursts). Small superimposed noise voltages cause only slight errors since the indicated value is the sum of the squares of test voltage and noise voltage. Such errors can be taken into account by calculation.

The high sensitivity of the UPGR (full-scale deflection in the most sensitive range 30 μ V/-90 dB, approximate indication down to 10 μ V/-100 dB) permits measuring very high S/N ratios as well as the S/N ratios of equipment handling low signal levels.

Overdrive capacity

The **high overdrive capacity** of the set (undistorted amplification of amplitudes up to 20 dB above fullscale value with sinewave voltages) guarantees correct weighting and indication of very short and high noise peaks. A **combined overdrive indication** for the amplifiers and detectors precludes erroneous measurements.

PSOPHOMETERS 6

Specifications
Frequency range, wideband
measurements psophometric/flat filter in line with CCIR psophometric filter (DIN/CCITT)
Options
Test inputs, measurement ranges
Balanced input (a and b)

Unbalanced input (c) isolated BNC socket Chassis connection 4-mm knurled terminal (grey) Input impedance tolerance ±1%

Footnotes

- Footnotes

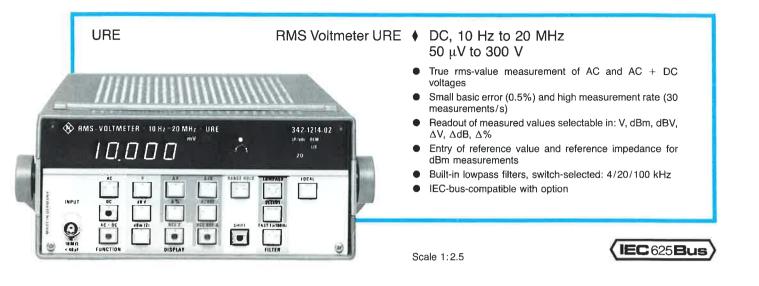
 Reference for level measurement: 0 dB = 0.7746 V (1 mW into 600 Ω).
 The differential input impedance is 10 kΩ for direct measurement of unbalanced voltage component (common mode).
 Warning! When measuring dangerous voltages make sure that the cabinet is reliably connected to the earth conductor. The UPGR is not intended for use in heavy-current networks.
 Multiply scale indication by 10 or add 20 dB (20-dB attenuator is switched in).
 The balance conditions of CCITT and DIN 45405 are fulfilled for measurements in positions 5 and 6 (in position 4: typical values).
 Subrange 10 µV/-100 dB is provided for rough indication only (right-hand switch position without engraving).

Switch pos.		Input circuit	R _{in}	Cou- Voltage pling total rge subrange		Le total rge	vel ¹) subrange	
1 2 3	V _{ab} /earth V _b /earth V _a /earth	unbal., common mode unbal., V_b to earth unbal., V_a to earth	1 ΜΩ²) 1 ΜΩ 1 ΜΩ	AC	30 μV to 350 V³)	as below × 10 ⁴)	−90 to + 53 dB³)	as below + 20 dB⁴)
4 5 6 7	$\begin{array}{c} V_{a}/{}_{b}{}^{5}) \\ V_{a}/{}_{b}{}^{5}) \\ V_{a}/{}_{b}{}^{5}) \\ V_{c}/chassis \end{array}$	bal., high impedance bal., high impedance bal., low impedance unbal., floating	100 kΩ 10 kΩ 600 Ω 100 kΩ	AC DC DC AC	3 μV to 35 V	(10/) ⁶) 30/ 100 μV/ to / 3/10/30 V	−110 to +33 dB	(-100/) ⁶) -90/-80/ to / -10/0/+10/+20/ + 30 dB

For rough indication only Connectors, bal. input . unbal. input	shielded	two-pol	e female	
Input protection				
Rms-responding detector Detector time constant FAST	30 ms fo			
Peak-responding detector	overdrive		by 20 dB	
Charge/discharge time constant	1 ms/25	0 ms	19 20 00	
Indication Indication ranges	~20 to +	⊦3 dB fo	er, mirror or level V for volt	
Overdrive capacity ahead of filter	100 time	s or 40 c	B (with si	newaye
	referred	to fed at	1 kHz)	
Overdrive indication	red rang	e of che	ck meter	
Error limits of indication with sineward etection; 15 Hz to 100 kHz, $l_{amb} = -$ Frequency-response error in % of ro	+15 to +3	30°C	ns-respor	nding
Switch positions 1 to 3 15 to 30 Hz 30 Hz to 5 kHz 5 to 20 Hz 20 to 100 kHz Below 3 mV well-defined measure Switch positions 4 to 7 15 to 30 Hz 30 Hz to 20 kHz 20 to 100 kHz Indikator range 10 µV Additional error of detector Peak-responding detector Effect of operating position	± 3 ± 2 ± 5 0/-30 ment is n 30 and 1 ± 3 ± 2 ± 4 typically $\pm 3\%$ (wi 3 and 5) in line wi add. erro normal o	ot possi 00 μV same a: th peak th CCIF r of ±19 ne	± 2 ± 1 ± 2 ± 3 ble (inher $300 \mu V$ ± 2 ± 1 ± 3 s for 30 - μ factor bet and DIN	V to /30 V V range ween
Inherent noise (depending on opera	•	'	_	
Switch position Max value in μV, rms		4 19	5 12	6 and 7 8
peak		30	17	10

Outputs	
	 1 V, 1 kΩ, knurled terminals 100 mV, 600 Ω, isolated BNC,
Phones (15 Hz to 20 kHz)	70 dB max. gain
Connection of external filter Compensation of passband	2 isol. BNC female connectors, 600 G
attenuation	0 to 3 dB
General data	
Power supply battery	6 single cells 1.5 V: ≈3 mA
	approx 2000 hours per set 100 to 260 V, 47 to 420 Hz (1 VA)
Dimensions	210 mm×181 mm×281 mm
Weight w/o batt./w. power supply	4.2 kg/4.8 kg
Ordering information	
Order designation	Psophometer
UPGR for battery operation	248.1915.02 (incl. battery) 248.1915.03
or arrier no supply operation	210.101000
Recommended extras	
Telephone Weighting Filter UPGR-Z Broadcast Weighting Filter UPGR-Z	1 (CCITT) as external filter 248.3718.0
19" rack adapter 085.5548.00 (for t	two UPGR units)
Third-octave Filter PBT 235.3014.0	677.00 (if only one UPGR is incorp.)
Octave Filter PBO 201.5520.02	

6 AC VOLTMETERS



The **RMS Voltmeter URE** uses an rms-responding rectifier circuit of new design and permits true rms-value measurement with wide bandwidth and both high measurement speed and accuracy. A microprocessor provides for error correction and converts the measured values for readout in different selectable units. The IEC-bus interface option permits the use of the URE in automatic test assemblies.

Measured quantities. The URE measures DC voltages and the rms value of AC and AC + DC voltages in the frequency range from 10 Hz to 20 MHz. For AC + DC voltage measurements the microprocessor measures alternately the DC and the AC voltage and determines the total rms value by square-law addition of the individual components.

Measurement speed. The URE provides three different measurement speeds: SLOW, FAST and SUPERFAST (1/3/ 30 measurements per second). The FAST button is for switchover between SLOW and FAST. SUPERFAST can be selected via the IEC us or with the aid of service function 3. The lower cutoff frequency of the URE is matched to the selected measurement rate by automatically selected high-pass filters in the AC measuring circuit. Hence, lowfrequency AC voltages can only be measured at a slow rate, and the suppression of the DC measuring circuit is greater, the lower the selected measurement rate.

Measuring functions. The AC. DC and AC \div DC buttons permit selection of AC, DC or AC + DC measurement. The measured values are read out in V or mV and autoranging is enabled.

DC measurement. In this switch position the URE measures the DC voltage component up to a maximum of ± 300 V with a resolution of 1 μV in the most sensitive measurement range. A higher-order lowpass filter automatically selected with the measurement speed suppresses superimposed AC voltages.

AC measurement. In this mode the RMS Voltmeter measures the rms value of AC voltages in the range from 50 μ V to 300 V at crest factors of up to 5. The frequency range is 10 Hz to 10 MHz (typ. 20 MHz), the lower cutoff frequency as a function of the measurement rate is 10 Hz, 100 Hz or 1 kHz. For suppression of unwanted frequencies the upper cutoff frequency can be limited to 100 kHz, 20 kHz or 4 kHz with the aid of a built-in lowpass filter. The filter is switched in with the LOWPASS button, the cutoff frequency of the filter is selected with the SELECT button.

AC + **DC** measurement. For AC + DC measurements the URE carries out alternately an AC and a DC measurement and reads out the calculated rms value of the AC + DC voltage. Voltage components whose frequencies are less than the lower cutoff frequency of the AC measuring circuit are not fully considered. Measurement range and bandwidth are as described under DC and AC measurement.

Display of measured value. The display panel of the URE is subdivided into several sections (see photo on page 203). The measured value is read out on a 4½-digit 7-segment **LED display** and the associated unit by luminous letters arranged next to it. If the numerical value is positive the sign is blanked. Blinking of the display shows that the result is invalid, e.g. because the range is exceeded. If the measured value is below the range, only the last digit blinks.

For quick detection of any changes in the measured value the URE has a **tendency indication** which also facilitates adjustments and maximum/minimum settings. It consists of LEDs arranged in a circle, the lighted LED corresponding to the momentary measured value. If the measured value becomes higher or lower this light dot follows quasianalogously clockwise or counterclockwise. The two **illuminated displays** on the right indicate the selected **cutoff frequency of the lowpass filter** for AC measurements and the current **remote control mode** of the URE.

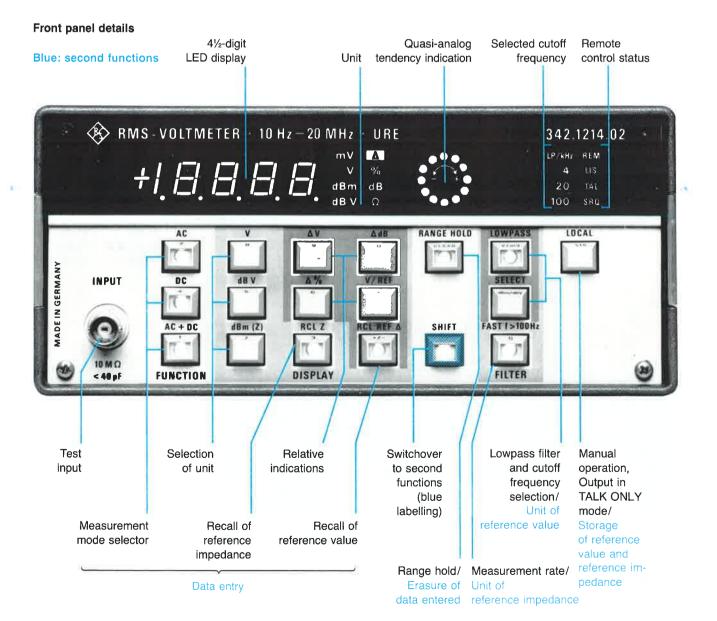
AC VOLTMETERS 6

Conversion of measured value. The microprocessor of the URE converts the measured values, if desired, at the push of a button for readout in different units.

Reference values may be entered from 1 μ V to 19999 V, reference impedances from 0.1 m Ω to 19999 Ω . The measured value can also directly be used as reference value. The table on page 204 shows in detail the many ways of displaying the results in the RMS Voltmeter URE.

The following readouts can be selected:

VoltageLevel	Unit V or mV dBV	Button V dBV
 Power level (referred to reference impedance entered) Voltage deviation 	dBm	dBm(Z)
from reference value	V or mV	ΔV
 Relative voltage deviation from reference value in dB Relative voltage deviation 	dB	ΔdB
from reference value in %	%	Δ %
 Ratio of measured value to reference value 	_	V/REF
Also indicated are:		
 Stored reference value 	V, mV, dBV, dBm	RCL REF∆
 Stored reference impedance for power level measurement 	Ω	RCL Z



URE - RMS Voltmeter

Example for flexible display of results

Measured values/conversion			Referenc	e values ¹)	Deviations from reference value					
Voltage Level			Impedance	V, dBV, dBm	absolute					
Button: V/mV			V/mV, dBV/ dBm; STO	ΔV	∆dB	$\Delta\%$	V/REF			
10.000 V 1.0000 V 0.125 mV	20.00 dBV .00 dBV -78.06 dBV	33.01 dBm 13.01 dBm –65.05 dBm	50.00 Ω	1.0000 V	9.000 V 0. V –0.999 V	20.00 dB 0. dB 78.06 dB	900.0 % 0. % -99.98 %	10.000 1.0000 .0001		
1.0000 V	00 dBV	12.22 dBm	60.00 Ω	₊1000 mV	.9999 V	80 00 dB	19999 %	10000		
1.0000 V	00 dBV	11.25 dBm	75.00 Ω		.9999 V	80 00 dB	19999 %	10000		
1.0000 V	00 dBV	6.20 dBm	240.0 Ω		.9999 V	80 00 dB	19999 %	10000		
10.000 V	20 00 dBV	22.22 dBm	600.0 Ω	.0010 mV	10.000 V	140.00 dB ²)	19999 %	19999		
2.400 V	7 60 dBV	9.81 dBm		.7750 V	1.625 V	9.81 dB	209 7 %	3.097		
10.000 V 12.57 V 2.236 V 25.00 V	20 00 dBV 21.99 dBV 6 99 dBV 27 96 dBV	10.00 dBm 35.00 dBm 20.00 dBm 40.96 dBm	10000 Ω 50.00 Ω	1.0000 V 20.00 dBV 20.00 dBm 10.00 dBm	9.000 V 2.570 V 0. V 24.29 V	20:00 dB 1.99 dB 0. dB 30.96 dB	900.0 % 25.70 % 0 % 3.436 %	10.00 1.2570 1.0000 35.36		

Entered value or measured value used; values remain stored until new value is entered.
 dBμV.

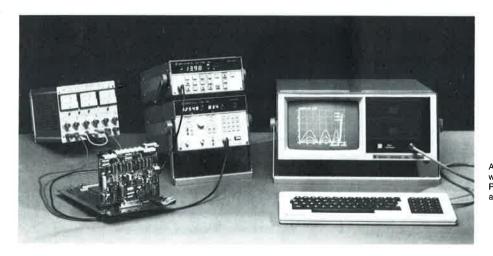
Service functions. The service functions of the URE are only rarely required and therefore no separate buttons are provided for them. These functions can be called up by pressing a certain combination of buttons. The functions display test, display of IEC-bus address or autocalibration, for instance, can easily be executed by entering a code number via the keyboard.

IEC-bus Option URE-B1. This option permit all functions of the voltmeter to be remotely controlled. The maximum measurement speed of 30 measurement per second makes the URE an ideal AF system voltmeteer.

DC Output Option URE-B2. This output supplies a DC voltage proportional to the indicated numerical value which permits logging of the measured values on a recorder. Thanks to the manifold conversion capabilities of the URE the scale can be linear or logarithmic. The output voltage range is -2 V to +2 V with least increments of 1 mV.

The relationship between the analog output voltage and the measured value is as follows:

Output voltage	Readout without decimal point	Example: Readout	V _{out}
V	10 000	11.500 V 37.25 dBV 1.13%	+1.150 V -0.372 V +0.011 V



Automatic filter measurement with RMS Voltmeter URE, Process Controller PUC and Generator SPN

DIGITAL VOLTMETERS 6

Specifications		Readout of measured values	
opeenioutiono		Units of measured parameters	V or mV
Basic unit		(see also text)	dBV
basic unit			dBm
Measured parameters	DC voltage		ΔV or ΔmV ΔdB, Δ%
	AC voltage		ratio (without unit)
	AC + DC voltage	Measured value, digital	41/2-digit 7-segment LED display
Frequency range		Tendency indication	quasi-analog indication by light
Measurement without lowpass			dot travelling in a circle
filter	10 Hz to 20 MHz	Resolution in lowest subrange	
Cutoff frequency (-3 dB) of		Digital steps	10,000
switch-selected lowpass filters		Error limits (at tamb +15 to +30°C)	
	40 dB/decade	DC	0.1% of rda +10 diaits
Measurement ranges		AC (crest factor <3)	see table below
DC voltage	0 to +300 V	AC + DC (crest factor <3)	
AC voltage	50 µV to 300 V		plus 10 digits
Range setting	automatic or manual	Additional error at crest factor 3 to 5	3% of rdo
automatic			0
manual .	with optimum switching speed	Temperature effect (at tamb +5 to +	15 and +30 to +45°C)
	prevents autoranging from	DC	(0.01% of rdg +1 digit)/°C
	switching to a lower range	AC, up to 1 MHz	0.05% of rdg/°C
	or	up to 10 MHz	0.15% of rag/°C
	selection of any range via	Data of antiona	
	service function	Data of options	
Input connector	BNC female, floating	IEC-bus Option URE-B1	
Input impedance	10 M Ω shunled by <40 pF	Interface to IEC 625-1 standard for o	
Loading capacity up to 20 kHz	$V_p = 600 \text{ V}, V_{rms} = 300 \text{ V}$	Interface functions	
Loading capacity up to 20 kHz up to 500 kHz above 500 kHz	$V_p = 350 \text{ V}, V_{rms} = 200 \text{ V}$	Commentant	DT1
Max common-mode voltage	$\sqrt{ms} \sqrt{1 - \sqrt{10}} \sqrt{12}$	Connector	24-way, Amphenol
	,	Analog-output Option URE-B2	
Common-mode rejection	>100 dB up to 100 Hz >100 dB up to 10 kHz	Output impedance	
		Output voltage range	
Measurement rate		Resolution Error limits	
(measurements/second)		Endi minits	< ±2 mv
SLOW $(f_1 = 10 \text{ Hz})$	0.8 (AC + DC; 0.4)	General data	
FAST $(f_1 = 100 \text{ Hz})$ SUPERFAST $(f_1 = 1 \text{ kHz})$	3 (AC + DC: 1.5) 20 (AC + DC: 15)		
Settling times to 0.1% of fsd	00 (NO + DO. 13)	Operating temperature range	+5 to +45°C, safety class 1 to
(without changing the range)		Storage temperature range	IEC 359 (no dew accumulation)
SLOW		Power supply	100/120/220/240 V +10%
FAST			47 to 63 Hz (35 VA)
SUPERFAST	25 ms	Radio interference	complies with VDE 0871/0875 and
Weighting			MIL-STD 461 B
Max. crest factor	5	Dimensions, weight	220 mm×109 mm×340 mm, 4.4 kg
Reference value	entered via keyboard or	Ordering information	
	directly as measured value	Ordering information	
Entry of reference impedance		Order designation	RMS Voltmeter URE
(for dBm measurement)	range 0.0001 to 19999 Ω		342.1214.02
		Options	
		IEC-bus Option URE-B1	342.2910.02
		DC Output Option URE-B2	342.2810.02
		Recommended extras	
		19" Rack Adapter ZZA-22 .	078.8222.00

Input-voltage-dependent frequency response error

* This additional error is almost negligible when the lowpass filter is switched into circuit or when considering the calculated inherent noise of the URE.

300 V							
200 V -				200 V	Not permissible 00 V		
200 V			20 kHz	500 kHz			
	9			1.5%	3%	οv	
25 V -				(0.15 dB)	(0,3 dB)	- AND	o v
20 1						8 - S - S - S	5 V
4 mV -	2% (0.2 dB)	1% (0.11 dB)	05% (007 dB)	0.7% (0.09 dB)	1.5% (0.15 dB)	4% (0.35 dB)	typ. 10% (typ. 1 dB)
					3% (0.3 dB)	7% (0.65 dB)	typ. 15% (typ. 1.5 dB)
1 mV -	2% (0.2 dB)	1% (0.11 dB)	0.5% (0.07 dB) plus 1.5/(VmV) digit or 0.015/(V/	0,7% (0,09 dB) mV) ² dB*	3% (0.3 dB)	7% (0.65 dB)	typ. 15% (typ. 1.5 dB)
50 µV -							
SLOW: FAST: SUPERF	10	00 Hz 20	i 0 Hz 100 0 Hz 2 kHz	kHz 1	MHz 3	MHz 10	MHz 20 MHz

6 RF-DC MILLIVOLTMETERS

voltmeters



RF-DC Millivoltmeter URV ♦ DC, 10 kHz to 2 GHz

- High sensitivity for DC and AC, lowest subrange 3 mV fsd
- Basic error 2.5% for RF measurement, 1% for DC measurement
- Two probe inputs facilitate two-port measurements
- RF voltage measurement in coaxial systems up to 350 V
- Battery operation: floating system

The **RF-DC Millivoltmeter URV** belongs to the time-proven URV series which is continuously being adapted to the state of the art.

The instrument features high sensitivity and accuracy, and a comprehensive range of accessories, such as probes, attenuators, insertion heads and adapters, make it suitable for many applications.

The URV has both V and dB scales (0 dB = 0.7746 V; 1 mW into 600 Ω).

Applications

Measurements on resonant circuits in oscillators, narrowband amplifiers and filters, the extremely low loading causing only slight damping and detuning.

RF voltage measurements on broadband amplifiers. The slight load capacitance produces no phase shift, say, in feedback amplifiers.

Measurements on the outputs of low-power transmitters up to 200 W or of power stages.

Maximum, minimum, nominal-value adjustment of voltages. Measurement of the 3-dB points as a function of frequency.

Frequency-response measurements on two-port networks (gain, attenuation) are readily carried out with the URV, one probe being connected to the input and one to the output of the test item with switch selection on the URV.

Characteristics

Measurement ranges and input impedances. Measurements are possible direct at the DC input (4 mm knurled) terminals) from 50 μ V to 1050 V into 10 M Ω .

Two equivalent inputs (three-pole female connectors) permit the simultaneous connection of two measuring heads for AC or RF measurements. They can be switch-selected on the instrument. Combined with its various options (see specifications) the URV offers the following capabilities:

Use of

probe alone (0.5 mV to 10.5 V, $C_{in} = 2.5 \text{ pF}$)

probe +20-dB divider (up to 100 V, $C_{in} = 1 \text{ pF}$)

- +40-dB divider (up to 1000 V, $C_{in} = 0.5 \text{ pF}$)
 - $+75\text{-}\Omega$ adapter (makes up a termination for 75- Ω coaxial systems; 0.1 to 500 MHz, max. 2 W)
 - +coaxial BNC insertion adapter (with or without divider; for example up to 350 V with 40-dB divider)

Coaxial insertion heads with low reflection coefficients

10-V insertion head (500 μ V to 10.5 V, 50 Ω : 10 kHz to 2 GHz; 75 Ω : up to 1.6 GHz) 100-V insertion head (5 mV to 105 V, 1 MHz to 2 GHz with 50 Ω)

Coaxial insertion heads and 75- Ω adapters are available for different connector systems; see specifications.

URV with accessories and recommended extras



RF-DC MILLIVOLTMETERS 6

Accuracy

The measuring heads are instrument-compatible; combined with any URV basic unit each probe and insertion head complies with the specified error limits without any adjustment.

At room temperatur the error limits of the URV are 0.5% of rdg +0.5% of fsd for DC voltage measurements, 1.5% of fsd plus frequency response of probe and insertion unit for AC measurements; see table below.

Frequency response error in % of reading

Measuring head	10 k Range		2 5			5		1Hz 2	10 MHz	100 MH		5		Iz 2
10-V insertion	0.1 to 10 V	I	Proze	ent v	/ M	(1		2	5	7	12	20
unit 50Ω	0.7 to100 mV						:	2		3	7	10	12	20
10-V insertion	0-1 to 10 V				T					2	5	7	15	
unit 75Ω	0.7 to 100 mV	2						3	7	10	15			
100-V insertion	1 to 100 V				20	5	2		1	2	5	7	12	20
unit 50 Ω	7 to1000 mV				30	10	3		2	3	7	10	12	20
	0.1 to 10 V		20	5	2				1	3	7	18		
RF probe *)	0.7 lo100 mV		20	5	ĺ.,,				3	5	10	15		
with	1 10 100 V							20	11	1;	3 16			
20-dB divider	7 Io 1000 mV							20	13	15	5 20			
with	10 to 1000 V						15		6	8	12			
40-dB divider	0.07 to10 V						20		8	10) 15			
with 75-Ω	0 1 to 10 V		20	5	2				1	3	10			
adapter	0.7 to100 mV		20	5					3	5	12			

*) Probe alone or with 20-dB or 40-dB divider in BNC adapter (50-Ω coaxial system).

Reflection coefficients

Measuring head	10 Zo	kHz	100 kHz	1 MHz	10 MHz	100 MH		5	1 GH	
10-V insertion unit	50 Ω	Refle	ection coeffi	icient 1			2	5	10	15
	75 Ω			3			5	15	20	
100-V insertion unit	50 Ω			1					2	2
75-Ω adapter	75 Ω			1.5		3	10	Ø		

Indication weighting

The URV has a 105° mirror scale which indicates the rms value for sinusoidal voltages. With non-sinusoidal voltages, the true rms value is indicated independently of the waveform in the ranges up to 30 mV (3 V with divider). For voltages of 1 V and higher, the test circuit operates as a full-wave peak-responding detector for all measuring heads.

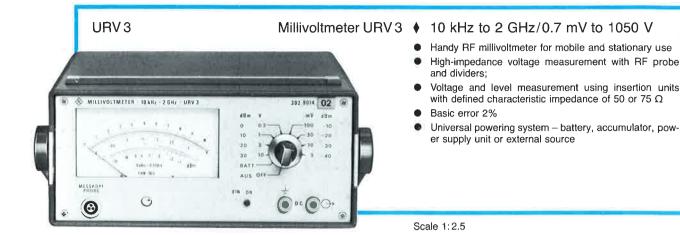
Functional description

The RF probe and the insertion units both have two similarly designed detector circuits, one for the RF voltage to be measured and the other for the comparison voltage generated in the instrument. The difference of the two detected voltages is taken via an attenuator to a chopper amplifier followed by a filter and a control loop. The squarewave thus processed is converted to a sinewave and according to the measurement range drives the comparison detector circuit. Since matched diode pairs with identical characteristics are used in the detector circuits, the indicated voltage is proportional to the amplitude of a sinusoidal test voltage.

Specifications	
DC voltage range	3/10/30/100/300 mV/
AC voltage range	1/3/10/30/100/300/1000 V
Level, URV with dB scale	-64 to +22.5 (62.5) dB
	1/3/10 V -50/to/+20 dB
With probe/10-V insertion unit	0.2 mV to 10.5 V
probe + divider 20 dB/100-V insertion unit	
40 dB	20 mV to 1050 V
Frequency range	100 kHz to 1 GHz
with 20-dB divider	(as indicator 2 GHz) 2 to 500 MHz
with 40-dB divider	1 to 500 MHz
with 75-Ω adapter 10-V insertion unit, 50 Ω 75 Ω	10 kHz to 2 GHz (3 GHz)
100-V insertion unit, 50 Ω	1 MHz to 2 GHz (3 GHz)
Input impedance	
DC input Probe	$>$ 80 k Ω (up to 10 MHz). C _{in} \approx 2.5 pF
with 20-dB divider	>1 M Ω (up to 20 MHz), C _{in} = 1 pF >10 M Ω (up to 20 MHz), C _{in} = 0.5 pF
Insertion units	50 Ω , 75 Ω , acc. to order; reflection coefficient up to 200 MHz:
	1 (3)%, see also table on left
Loading capacity	Max. values for V _{DC} V _{rms} (sinewave)
DC input	1200 V 800 V
with 20-dB divider	1000 V 150 V
with 40-dB divider (100 MHz) with 40-dB divider (500 MHz)	1000 V 1050 V 1000 V 210 V 50 V 15 V
10-V insertion unit	50 V 15 V
100-V insertion unit 75-Ω adapter (up to 200 MHz)	12 V 12 V
Common line ref. lo chassis	
Error limits	$\pm 0.5\%$ of fed
at $t_{amb}=+15$ to $+30^{\circ}\text{C}$	0.5% of rdg 2% of fsd
plus frequency response error	see table on left
DC output	
Open-circuit voltage	1 kΩ
Settling time	500 ms
	+5 to +40°C
Operating temperature range	+5 to +40°C 20 to +60°C (w/o meas. head) 25 to +75°C (w/o meas. head and
Operating and storage temperature	batt.)
range for measuring heads	0 to +45°C
Dimensions, weight	162 mm×238 mm×275 mm, 4 kg
Ordering information	
Order designation	► RF-DC Millivoltmeter URV
URV with dBm scale	216.3612.02 216.3612.03
Accessories supplied	RF probe with earth cable and clip,
A REPORT OF A	earth sleeve, earth strip, hook tip, solder tip, 20-dB divider, 40-dB
6 batteries, R-20, IEC	divider 017.0015.00
Recommended extras	
Accessory Set URV-Z6	292.5364.02 consisting of:
	20-dB divider 241.1510.00, 40-dB divider 241.1710.00,
	BNC Adapter URV-Z 241.1110.02 for RF probe (including matching sleeve for voltage divider
75-Ω Adapter URV-Z3	
for RF probe	243.9118.70 including adapters from UNI-9 female
	to 2.5/6 male 243 9260.00 1.6/5.6 male 243.9276.00
	BNC male 243.9282.00
BE Insertion Units	
RF Insertion Units	
10-V Insertion Unit URV-Z2 . 100-V Insertion Unit URV-Z4	50 Ω 50 Ω 75 Ω N connector Dezifix B Dezifix B 288.8010.55 288.8010.54 288.8010.74 283.7716.55 — —
10-V Insertion Unit URV-Z2	50 Ω 50 Ω 75 Ω N connector Dezifix B Dezifix B 288.8010.55 288.8010.54 288.8010.74

6 RF MILLIVOLTMETERS

voltmeters



The **Millivoltmeter URV 3**, the analog unit of the URV family, is a highly sensitive and accurate voltage and level meter for the frequency range from 10 kHz to 2 GHz (up to 3 GHz if only used as an indicator).

A broad range of accessories, such as probe, dividers, insertion units and adapters, and battery operation capability permit versatile mobile and stationary use of voltmeter.

Applications

RF voltage measurement. High-impedance measurements with RF probe in broadband amplifiers, on resonant circuits of oscillators, narrowband amplifiers and filters; measurements with impedance-matched RF insertion unit at the outputs of transmitters and other coaxial systems. True rms-value measurement possible up to 3 V and peakvalue measurement from 1 V RF voltage.

Adjustment to maximum, minimum or nominal value. Determination of the 3-dB points as a function of frequency.

Gain or attenuation measurement on passive or active four-terminal networks as a function of frequency (frequency response).

Level measurement in dBm referred to 0 dBm = 1 mW into $Z = 50 \Omega$ (0.2236 V), correction of level indication (according to relation 10 log $\frac{50}{Z}$): -1.76 dB at $Z = 75 \Omega$.

Characteristics

The URV 3 affords extremely constant indication and zero setting as well as easy reading of measured values. Low capacitive and resistive loading by the RF probe minimize measuring errors introduced by detuning of resonant circuits, damping and unwanted phase shifts in feedback networks, etc. Mismatching is megligible thanks to the low reflection coefficient of the RF insertion units.

Measuring principle, measuring heads. In accordance with the well-proven control method used by the URV instruments (see page 207 under functional description), the RF voltage is converted into a proportional DC voltage with high linearity so that the accuracy is exclusively determined by the matching of the characteristics of the diodes incorporated in the measuring head. This makes the **measuring heads freely interchangeable** within the URV family without degrading the error limits. Depending on the order number selected, the RF probe is supplied with the URV 3; the other accessories are recommended extras.

Connections and measuring possibilities:

Measurement using

probe	alone (700 μ V to 10.5 V, C _{in} = 2.5 pF)
probe	+20-dB divider (up to 105 V, $C_{in} = 1 \text{ pF}$)
	+40-dB divider (up to 1050 V, $C_{in} = 0.5 \text{ pF}$)
	+coaxial BNC adapter (with or without divider; with
	40-dB divider for instance up to 350 V)
	+75-Ω adapter (RF voltage measurement in
	75-Ω coaxial systems, 100 kHz to 500 MHz)

coaxial insertion units with low reflection coefficients 10-V insertion unit (700 μ V to 10.5 V, 50 Ω : 10 kHz to 2 GHz, 75 Ω : 10 kHz to 1.6 GHz) 100-V insertion unit (7 mV to 105 V, 1 MHz to 2 GHz, 50 Ω)

Appropriately terminated, the 100-V insertion unit is suitable for measurements on power stages up to 200 W.

URV 3 with measuring heads and insertion units plus case accomodating small parts



Input Impedance of RF probe. The input impedance of the RF probe is given by the input capacitance C_{in} (see to the right) and the parallel input resistance R_p , which is dependent on the test voltage (100 k Ω to 1 M Ω between 1 mV and 10 V) and, above 3 MHz, also on the frequency.

Indication, waveform weighting. The RF voltage and level are indicated on a precision moving-coil meter on separate scales in eight subranges which can be manually selected. The level indication in dBm is valid for $50-\Omega$ coaxial systems but can also be used to advantage for relative measurements in case of an undefined source impedance.

Rms-value measurement. The URV 3 measures and reads the rms value in the three most sensitive measurement ranges. At voltages above 1 V, it measures the peak-to-peak value (V_{pp}) but reads out the value V_{pp}/ $2\sqrt{2}$ corresponding to the rms value for sinusoidal voltages.

Accuracy. The operational error consists of the basic error plus the frequency-response error. At room temperature the basic error is 2%; for the frequency-response error see the table below.

Frequency response error in % of reading

Measuring head	10 J Range	kHz 2	100 5	kHz	2		IHz 2	10 MHz	100			5		Hz 2 6 2
10-V insertion	0 1 Io 10 V	Pro	ent	у.М			1			2	5	7	12	20
unit 50 N	0.7 to 100 mV					;	2	100		3	7	10	12	20
10-V insertion	0 1 to 10 V						1			2	5	7	15	
unit 75 Ω	07io100mV					-	2			3	7	10	15	
100-V insertion unit	1 lo 100 V			20	5	2		1		2	5	7	12	20
50 Ω	7 101000 mV			30	10	3		2		3	7	10	12	20
	0 1 to 10 V	20	5	2				1		3	7	18		
RF probe *)	0 7 to100 mV	20) 5	1				3		5	10	15		
with	1 to 100 V						20	11		13	16			
20-dB divider	7 lo1000 mV						20	13		15	20			
with	10 to 1000 V					15		6		8	12			
40-d8 divider	0.07 io10 V					20		8		10	15			
with 75-Ω	0 1 to 10 V	20	5	2				1		3	10			
adapter	0.7 to100 mV	20) 5					3		5	12			

*) Probe alone or with 20-dB or 40-dB divider in BNC adapter (50- Ω coaxial system).

Reflection coefficients

Vensuring head	10 Zo	kHz 100 kHz	1 MHz	10 MHz	100 MHz 2	5			Hz i 6
10-V insertion unit	50 Ω	Reflection coeff in %	icient 1		10	2	5	10	15
	75 Ω		3	4		5	15	20	
100-V insertion unit	50 n	1.	1					1	2
75-Ω adapter	75 Ω		1.5		3	10			

Specifications
Instrument
Test Input
Parameters measured voltage (V, mV)/level (dBm)
Frequency range
Voltage range 700 µV to 1050 V (with dividers)
Subranges
Level range
Subranges40/-30/-20/-10/0/+10/
+20/+30 dBm
Level reference 0 dBm corresponding to 1 mW into 50 Ω (0.2236 V)
Range of indication 300 to 700 µV or -57 to -50 dBm

Connection of measuring head		socket (for l	JRV meas. heads)
Recorder output (shortcircuit-pro	,		
Output voltage	. 1 V at final 3.3 V at fin	value 10,	
	10 V at fina	al value 10 i	n range 10 V
Output impedance	. 1 kΩ	forward to an	a un d
Polarity			Junu
Setting time			
	(increasing	with decrea	asing volt.)
RF measuring heads	. RF probe v	with 20-dB a	nd 40-dB
	dividers as 75-Ω adap	well as BN	C adapter and
		lion unit (50	, 75 Ω)
In the second second	100-V inse	rtion unit (5	0 Ω)
Input impedance of RF probe with 20-dB divider	. H _p >80 KL B _a >1 MO	(up to 10 10	MHZ , $C_{in} = 2.5 \text{ pF}$ MHZ , $C_{in} = 1 \text{ pF}$
with 20-dB divider	. R _p >10 M	(up to 20	MHz), $C_{in} = 0.5 \text{ pF}$
Voltage rating	V DC	Vrms (sine	w.)Vp
RF probe with 20-dB divider	400 V 1000 V	15 V 150 V	22 V 220 V
with 40-dB dividor			
up to 100 MHz up to 500 MHz 10-V insertion unit 100-V insertion unit 75-Ω adapter (P _{max} = 2 W)	= 1000 V	1050 V	1500 V
10-V insertion unit	. 50 V	210 V 15 V	22 V
100-V insertion unit	1000 V	150 V	220 V
$75-\Omega$ adapter ($P_{max} = 2 W$)	12 V	12 V	17 V
Frequency ranges			
RF probe	2 GHz if or	1 GHz (from the used as	20 kHz to
with 20-dB/40-dB divider	1 to 500 M	Hz/0.5 to 5	00 MHz
10-V insertion unit 50 O	- 10 kHz to 2	GHz (up to	3 GHz if only
10-V insertion unit, 75Ω	. 10 kHz to	uicator) 1.6 GHz	
100-V insertion unit, 50 Ω	1 MHz to 2	2 GHz	
75-Ω adapter	100 kHz to	500 MHz	
Voltage ranges (level ranges Z =			
RF probe, 10-V insertion unit RF probe with 20-dB divider	700 µV to	10.5 V/-50	to +33 dBm
100-V insertion unit	7 mV to 10	05 V/-30 to	+53 dBm
RF probe with 40-dB divider	. 70 mV to	1050 V/-10	to +73 dBm
Error limto (cinqueque volt	(0000)		
Error limts (sinewave volt	ages)		
Operational error - basic error			
Operational error = basic error			
Basic error at t _{amb} +20 to +25 °C t _{amb} +15 to +30 °C t _{amb} + 5 to +40 °C			
Basic error at t _{amb} +20 to +25 °C t _{amb} +15 to +30 °C t _{amb} + 5 to +40 °C			
Basic error at t _{amb} +20 to +25°C t _{amb} +15 to +30°C t _{amb} + 5 to +40°C General data	2% of fsd 2.5% of fs 2.5% of fs	d d +2% of ro	lg
Basic error at t _{amb} +20 to +25°C t _{amb} +15 to +30°C t _{amb} + 5 to +40°C General data	2% of fsd 2.5% of fs 2.5% of fs	d d +2% of ro	lg
Basic error at t _{amb} +20 to +25 °C t _{amb} +15 to +30 °C t _{amb} + 5 to +40 °C General data Rated temperature range Operating temperature range	2% of fsd 2.5% of fs 2.5% of fs 2.5% of fs -20 to $+6-20$ to $+6$	d d+2% of ro 0°C Mea 50°C 0 75°C -19	lg asuring heads to +45°C 5 to +60°C
Basic error at t _{amb} +20 to +25 °C t _{amb} +15 to +30 °C t _{amb} + 5 to +40 °C	2% of fsd 2.5% of fs 2.5% of fs -25% of fs -20 to +6 -25 to +7 battery cor	d d +2% of ro 0°C Mea 0°C 0 75°C -11 npartment fo	lg asuring heads to +45°C 5 to +60°C or operation with:
Basic error at t _{amb} +20 to +25 °C t _{amb} +15 to +30 °C t _{amb} + 5 to +40 °C General data Rated temperature range Operating temperature range	2% of fsd 2.5% of fs 2.5% of fs -25 to +4 -25 to +7 battery cor 4 single ce	d d+2% of ro 10°C Mea 50°C 0 5°C -11 npartment fo lls 1.5 V, R-2	asuring heads to $+45$ °C 5 to $+60$ °C or operation with: 20, DIN 40 866
Basic error at t _{amb} +20 to +25 °C t _{amb} +15 to +30 °C t _{amb} + 5 to +40 °C General data Rated temperature range Operating temperature range	2% of fsd 2.5% of fs 2.5% of fs 2.5% of fs -25 to +7 battery cor 4 single ce and IEC, Ie supply uni	d d+2% of ro 0°C Mea 5°C -11 npartment fo lls 1.5 V, R-3 ead-acid acc t external s	asuring heads to +45°C 5 to +60°C or operation with: 20, DIN 40866 umulator or AC
Basic error at t _{amb} +20 to +25 °C t _{amb} +15 to +30 °C t _{amb} + 5 to +40 °C General data Rated temperature range Storage temperature range Power supply	2% of fsd 2.5% of fs 2.5% of fs 2.5% of fs -20 to +6 -20 to +6 -25 to +7 battery cor 4 single ce and IEC, le	d d+2% of ro 0°C Mea 5°C -11 npartment fo lls 1.5 V, R-3 ead-acid acc t external s	asuring heads to +45°C 5 to +60°C or operation with: 20, DIN 40866 umulator or AC
Basic error at t _{amb} +20 to +25 °C t _{amb} +15 to +30 °C t _{amb} + 5 to +40 °C General data Rated temperature range Operating temperature range	2% of fsd 2.5% of fs 2.5% of fs -25% of fs -25 to +7 battery cor 4 single ce and IEC, le supply uni 5 to 8 V/38	d d +2% of ro 0°C Mea 0°C 0 5°C -11 npartment fo lls 1.5 V, R- aad-acid acco t: external s 5 mA	asuring heads to +45°C 5 to +60°C or operation with: 20, DIN 40866 umulator or AC
Basic error at t _{amb} +20 to +25 °C t _{amb} +15 to +30 °C t _{amb} + 5 to +40 °C General data Rated temperature range Operating temperature range Storage temperature range Power supply	2% of fsd 2.5% of fs 2.5% of fs -20 to +6 -25 to +7 battery cor 4 single ce and IEC, le supply uni 5 to 8 V/3: approx. 20	d d +2% of ro 0°C Mea 50°C 0 5°C - 11 Ils 1.5 V, R-2 cad-acid acc t: external s 5 mA	lg asuring heads to +45°C 5 to +60°C or operation with: 20, DIN 40 866 umulator or AC ource
Basic error at t _{amb} +20 to +25 °C t _{amb} +15 to +30 °C t _{amb} + 5 to +40 °C General data Rated temperature range Operating temperature range Storage temperature range Power supply	2% of fsd 2.5% of fs 2.5% of fs -20 to +6 -25 to +7 battery cor 4 single ce and IEC, le supply uni 5 to 8 V/3: approx. 20	d d +2% of ro 0°C Mea 50°C 0 5°C - 11 Ils 1.5 V, R-2 cad-acid acc t: external s 5 mA	lg asuring heads to +45°C 5 to +60°C or operation with: 20, DIN 40 866 umulator or AC ource
Basic error at t _{amb} +20 to +25 °C t _{amb} +15 to +30 °C t _{amb} + 5 to +40 °C General data Rated temperature range Operating temperature range Storage temperature range Power supply Service life Battery (alkali-manganese cells Lead-acid accumulator	2% of fsd 2.5% of fs 2.5% of fs -20 to +6 -25 to +7 battery cor 4 single ce and IEC, le supply uni 5 to 8 V/3: approx. 20	d d +2% of ro 0°C Mea 50°C 0 5°C - 11 Ils 1.5 V, R-2 cad-acid acc t: external s 5 mA	lg asuring heads to +45°C 5 to +60°C or operation with: 20, DIN 40 866 umulator or AC ource
Basic error at t _{amb} +20 to +25 °C t _{amb} +15 to +30 °C t _{amb} + 5 to +40 °C General data Rated temperature range Storage temperature range Power supply Service life Battery (alkali-manganese cells Lead-acid accumulator Dimensions, weight	2% of fsd 2.5% of fs 2.5% of fs 2.5% of fs -20 to +6 -25 to +7 battery cor 4 single ce and IEC, le supply uni 5 to 8 V/3: approx. 20 . 241 mm×	d d +2% of ro 0°C Mea 50°C 0 5°C -11 Ils 1.5 V, R-2 aad-acid acc t: external s 5 mA 00 h 1 h	lg asuring heads to +45°C 5 to +60°C or operation with: 20, DIN 40 866 umulator or AC ource 9 mm, 2.5 kg
Basic error at t _{amb} +20 to +25 °C t _{amb} +15 to +30 °C t _{amb} + 5 to +30 °C General data Rated temperature range Operating temperature range Storage temperature range Power supply Service life Battery (alkali-manganese cells Lead-acid accumulator Dimensions, weight Ordering information Order designation	2% of fsd 2.5% of fs 2.5% of fs -2.5% of fs -25 to +7 battery cor 4 single ce and IEC, le supply uni 5 to 8 V/3: s) approx. 20 approx. 77 . 241 mm×	d d + 2% of ro 0°C Mea 0°C 0 75°C - 14 npartment fo lls 1.5 V, R-3 ead-acid acc acc acid acc acc acid acc t external s 5 mA 00 h 110 mm × 21	lg asuring heads to +45°C 5 to +60°C or operation with: 20, DIN 40 866 umulator or AC ource 9 mm, 2.5 kg
Basic error at t _{amb} +20 to +25 °C t _{amb} +15 to +30 °C t _{amb} + 5 to +40 °C General data Rated temperature range Storage temperature range Power supply Service life Battery (alkali-manganese cells Lead-acid accumulator Dimensions, weight	2% of fsd 2.5% of fs 2.5% of fs -2.5% of fs -25 to +7 battery cor 4 single ce and IEC, le supply uni 5 to 8 V/3: s) approx. 20 approx. 77 . 241 mm×	d d + 2% of ro 0°C Mea 0°C 0 75°C - 14 npartment fo lls 1.5 V, R-3 ead-acid acc acc acid acc acc acid acc t external s 5 mA 00 h 110 mm × 21	lg asuring heads to +45°C 5 to +60°C or operation with: 20, DIN 40 866 umulator or AC ource 9 mm, 2.5 kg
Basic error at t _{amb} +20 to +25 °C t _{amb} +15 to +30 °C t _{amb} + 5 to +30 °C General data Rated temperature range Operating temperature range Storage temperature range Power supply Service life Battery (alkali-manganese cells Lead-acid accumulator Dimensions, weight Ordering information Order designation	2% of fsd 2.5% of fs 2.5% of fs -2.5% of fs -25 to +7 battery cor 4 single ce and IEC, le supply uni 5 to 8 V/3: s) approx. 20 approx. 77 . 241 mm×	d d + 2% of ro 0°C Mea 0°C 0 75°C - 14 npartment fo lls 1.5 V, R-3 ead-acid acc acc acid acc acc acid acc t external s 5 mA 00 h 110 mm × 21	lg asuring heads to +45°C 5 to +60°C or operation with: 20, DIN 40 866 umulator or AC ource 9 mm, 2.5 kg
Basic error at t _{amb} +20 to +25 °C t _{amb} +15 to +30 °C t _{amb} + 5 to +30 °C t _{amb} + 5 to +40 °C General data Rated temperature range Operating temperature range Storage temperature range Power supply Power supply Service life Battery (alkali-manganese cells Lead-acid accumulator Dimensions, weight Ordering information Order designation URV 3 with probe URV 3 with probe URV 3 without probe	2% of fsd 2.5% of fsd 2.5% of fs 2.5% of fs -20 to +6 -25 to +7 battery cor 4 single ce and IEC, le supply uni 5 to 8 V/3: approx. 20 approx. 70 .241 mm× ► Millivoltr 302.901 .002.901	d d +2% of ro 50°C 0 5°C -11 Ils 1.5 V, R-2 ad-acid acc t: external s 5 mA 100 h h 110 mm×21 44.02 44.12 g earth cable	lg asuring heads to +45°C 5 to +60°C or operation with: 20, DIN 40 866 umulator or AC ource 9 mm, 2.5 kg
Basic error at t _{amb} +20 to +25 °C t _{amb} +15 to +30 °C t _{amb} + 5 to +30 °C t _{amb} + 5 to +40 °C General data Rated temperature range Operating temperature range Storage temperature range Power supply Power supply Service life Battery (alkali-manganese cells Lead-acid accumulator Dimensions, weight Ordering information Order designation URV 3 with probe URV 3 without probe	2% of fsd 2.5% of fsd 2.5% of fs 2.5% of fs -20 to +6 -20 to +7 -20 to +7 -25 to	d d +2% of ro 0° C Mea 0° C 0 fo^{\circ}C -1! mpartment fo lls 1.5 V, R- ad-acid acc acc acid accid acc t: external si 5 mA 00 h h 110 mm×21 neter URV (14.02 14.12 g earth cable ve, earth str	lg asuring heads to +45°C 5 to +60°C or operation with: 20, DIN 40 866 umulator or AC ource 9 mm, 2.5 kg
Basic error at t _{amb} +20 to +25 °C t _{amb} +15 to +30 °C t _{amb} + 5 to +30 °C t _{amb} + 5 to +40 °C General data Rated temperature range Operating temperature range Storage temperature range Power supply Power supply Service life Battery (alkali-manganese cells Lead-acid accumulator Dimensions, weight Ordering information Order designation URV 3 with probe URV 3 with probe URV 3 without probe	2% of fsd 2.5% of fsd 2.5% of fs 2.5% of fs -20 to +6 -25 to +7 battery cor 4 single ce and IEC, le supply uni 5 to 8 V/3: approx. 20 approx. 70 .241 mm× ► Millivoltr 302.901 .002.901	d d +2% of ro 0° C Mea 0° C 0 fo^{\circ}C -1! mpartment fo lls 1.5 V, R- ad-acid acc acc acid accid acc t: external si 5 mA 00 h h 110 mm×21 neter URV (14.02 14.12 g earth cable ve, earth str	lg asuring heads to +45°C 5 to +60°C or operation with: 20, DIN 40 866 umulator or AC ource 9 mm, 2.5 kg
Basic error at t _{amb} +20 to +25 °C t _{amb} +15 to +30 °C t _{amb} + 5 to +30 °C t _{amb} + 5 to +40 °C General data Rated temperature range Operating temperature range Storage temperature range Power supply Power supply Service life Battery (alkali-manganese cells Lead-acid accumulator Dimensions, weight Ordering information Order designation URV 3 with probe URV 3 with probe CRF Probe URV-Z7 (only with model 02)	2% of fsd 2.5% of fsd 2.5% of fs 2.5% of fs -20 to +6 -20 to +7 -20 to +7 -25 to	d d +2% of ro 0° C Mea 0° C 0 fo^{\circ}C -1! mpartment fo lls 1.5 V, R- ad-acid acc acc acid accid acc t: external si 5 mA 00 h h 110 mm×21 neter URV (14.02 14.12 g earth cable ve, earth str	lg asuring heads to +45°C 5 to +60°C or operation with: 20, DIN 40 866 umulator or AC ource 9 mm, 2.5 kg
Basic error at t _{amb} +20 to +25 °C t _{amb} +15 to +30 °C t _{amb} + 5 to +30 °C t _{amb} + 5 to +40 °C General data Rated temperature range Operating temperature range Storage temperature range Power supply Storage temperature range Power supply Storage temperature range Dever supply Storage temperature range Storage temperature range Dower supply Storage temperature range Dower supply Dower supply Dower supply Dimensions, weight Dimensions, weight Dimensions	2% of fsd 2.5% of fsd 2.5% of fs 2.5% of fs -20 to +6 -25 to +7 battery cor 4 single ce and IEC, le supply uni 5 to 8 V/3: approx. 20 approx. 77 .241 mm× ► Millivoltr 302.901 .002	d d +2% of ro 0° C Mea 0° C 0 5° C 0 ts c -11 lls 1.5 V, R- ad-acid acc t: external s 5 mA 00 h h 110 mm ×21 0 h 110 mm ×21 44.02 44.12 g earth cable ve, earth str case	lg asuring heads to +45°C 5 to +60°C or operation with: 20, DIN 40 866 umulator or AC ource 9 mm, 2.5 kg 9 mm, 2.5 kg 9 with clip, ip, hook tip,
Basic error at t _{amb} +20 to +25 °C t _{amb} +15 to +30 °C t _{amb} +15 to +30 °C t _{amb} + 5 to +40 °C General data Rated temperature range Operating temperature range Storage temperature range Power supply Power supply Power supply Power supply Dimensions, weight Ordering information Order designation URV 3 with probe URV 3 with probe URV 3 with out probe Condering Supplied RF Probe URV-Z7 (only with model 02) 4 batteries, R-20, IEC Recommended extras	2% of fsd 2.5% of fsd 2.5% of fs 2.5% of fs -20 to +6 -20 to +6 -25 to +7 battery cor 4 single ce and IEC, le supply uni 5 to 8 V/3: s) approx. 20 approx. 7C . 241 mm× ► Millivoltr 302.901 302.901 comprising earth sleever solder tip, -292.5364.1 divider, 40	d d +2% of ro 0°C Mea 0°C 0 75°C -01 75°C -01 115 1.5 V, R- 20 20 20 20 20 20 20 20 20 20 20 20 20	lg asuring heads to +45°C 5 to +60°C or operation with: 20, DIN 40.866 umulator or AC ource 9 mm, 2.5 kg 9 mm, 2.5 kg 9 mm, 2.5 kg 9 mm, 2.5 kg 9 mm, 2.5 kg
Basic error at t _{amb} +20 to +25 °C t _{amb} +15 to +30 °C t _{amb} + 5 to +40 °C General data Rated temperature range Operating temperature range Storage temperature range Power supply Power supply Storage temperature range Dimensions, weight Ordering information Order designation URV 3 with probe URV 3 with out probe Accessories supplied RF Probe URV-Z7 (only with model 02) 4 batteries, R-20, IEC Recommended extras Accessories URV-Z6	2% of fsd 2.5% of fsd 2.5% of fs 2.5% of fs -20 to +6 -25 to +7 battery cor 4 single ce and IEC, le supply unit 5 to 8 V/3: approx. 20 approx. 20 302.901 302.901 comprising earth sleever solder tip, -292.5364.1 divider, 40 URV-Z for reducing s	d d +2% of ro 5°C 00 5°C 01 5°C 01 15°C 01 15°C 01 15°C 01 15°C 01 15°C 01 10°C 01 10°	lg asuring heads to +45°C 5 to +60°C or operation with: 20, DIN 40 866 umulator or AC ource 9 mm, 2.5 kg 9 mm, 2.5 kg
Basic error at t _{amb} +20 to +25 °C t _{amb} +15 to +30 °C t _{amb} +15 to +30 °C t _{amb} + 5 to +40 °C General data Rated temperature range Operating temperature range Storage temperature range Power supply Power supply Power supply Power supply Dimensions, weight Ordering information Order designation URV 3 with probe URV 3 with probe URV 3 with out probe Condering Supplied RF Probe URV-Z7 (only with model 02) 4 batteries, R-20, IEC Recommended extras	2% of fsd 2.5% of fsd 2.5% of fs 2.5% of fs -20 to +6 -20 to +6 -25 to +7 battery cor 4 single ce and IEC, le supply unit 5 to 8 V/33 s) approx. 20 approx. 7C . 241 mm× ► Millivoltr 302.901 302.901 . 302.901 . 292.5364.1 divider, 40 URV-Z for reducing s 243.9118.	d d +2% of ro 0°C Mea 0°C 0 75°C -1! mpartment fo lls 1.5 V, R- cad-acid acc dad-acid acc dad-acid acc t. external s 5 mA 00 h 110 mm×21 neter URV (14.02 14.12 g earth cable ve, earth str case 02 comprisir -dB divider, RF probe, i leeve for divider, O7 0 comprisir	lg asuring heads to +45°C 5 to +60°C or operation with: 20, DIN 40 866 umulator or AC ource 9 mm, 2.5 kg 9 mm, 2.5 kg
Basic error at t _{amb} +20 to +25 °C t _{amb} +15 to +30 °C t _{amb} + 5 to +40 °C General data Rated temperature range Operating temperature range Storage temperature range Power supply Power supply Storage temperature range Dimensions, weight Ordering information Order designation URV 3 with probe URV 3 with out probe Accessories supplied RF Probe URV-Z7 (only with model 02) 4 batteries, R-20, IEC Recommended extras Accessories URV-Z6	2% of fsd 2.5% of fsd 2.5% of fs 2.5% of fs -20 to +6 -20 to +7 -20 to +7 -20 to +7 -25 to +7 -25 to +7 -25 to +7 -25 to +7 -25 to +7 -21 -25 to +7 -25	d d +2% of ro 0°C Mea 0°C 0 75°C -11 mpartment fo lls 1.5 V, R- 2 ad-acid acco t: external si 5 mA 00 h 110 mm×21 neter URV 3 14.02 14.12 g earth cable ve, earth str case 02 comprisii deve for di 70 comprisii 9 socket to 2 connector a	lg asuring heads to +45°C 5 to +60°C or operation with: 20, DIN 40866 umulator or AC ource 9 mm, 2.5 kg 9 mm,
Basic error at t _{amb} +20 to +25 °C t _{amb} +15 to +30 °C t _{amb} +5 to +30 °C t _{amb} + 5 to +40 °C General data Rated temperature range Operating temperature range Storage temperature range Power supply Service life Battery (alkali-manganese cells Lead-acid accumulator Dimensions, weight Ordering information Order designation URV 3 with probe URV 3 with probe URV 3 with model 02) 4 batteries, R-20, IEC Recommended extras Accessories URV-Z6 75-Ω adapter URV-Z3 BF insertion units	2% of fsd 2.5% of fsd 2.5% of fs 2.5% of fs -20 to +6 -20 to +7 -20 to +7 -20 to +7 -25 to +7 -25 to +7 -25 to +7 -25 to +7 -25 to +7 -21 -25 to +7 -25	d d +2% of ro 0°C Mea 0°C 0 75°C -11 mpartment fo lls 1.5 V, R- 2 ad-acid acco t: external si 5 mA 00 h 110 mm×21 neter URV 3 14.02 14.12 g earth cable ve, earth str case 02 comprisii deve for di 70 comprisii 9 socket to 2 connector a	lg asuring heads to +45°C 5 to +60°C or operation with: 20, DIN 40866 umulator or AC ource 9 mm, 2.5 kg 9 mm,
Basic error at t _{amb} +20 to +25 °C t _{amb} +15 to +30 °C t _{amb} +5 to +30 °C t _{amb} + 5 to +40 °C General data Rated temperature range Operating temperature range Storage temperature range Power supply Power supply Dimensions, weight Ordering information Order designation URV 3 with probe URV 3 with probe URV 3 with model 02) 4 batteries, R-20, IEC Recommended extras Accessories URV-Z6 75-Ω adapter URV-Z3 RF insertion units (other connectors on request)	2% of fsd 2.5% of fsd 2.5% of fs 2.5% of fs 2.5% of fs -20 to +6 -20 to +6 -25 to +7 battery cor 4 single ce and IEC, le supply uni 5 to 8 V/33 approx. 20 approx. 70 .241 mm× Millivoltr 302.901 302.901 302.901 302.901 .292.5364.1 divider, 40 URV-Z for reducing s 243.9118 from UNI-5 to 1.6/5.6 50 Ω N connect	d d +2% of ro 0° C Mer 0° C 0 75°C -01 Hs 1.5 V, R- raad-acid acct t: external s 5 mA 00 h 110 mm×21 h110 mm×10 mm×1	lg asuring heads to $+45^{\circ}$ C 5 to $+60^{\circ}$ C or operation with: 20, DIN 40 866 umulator or AC ource 9 mm, 2.5 kg 9 mm,
Basic error at t _{amb} +20 to +25 °C t _{amb} +15 to +30 °C t _{amb} +5 to +30 °C t _{amb} + 5 to +40 °C General data Rated temperature range Operating temperature range Storage temperature range Power supply Service life Battery (alkali-manganese cells Lead-acid accumulator Dimensions, weight Ordering information Order designation URV 3 with probe URV 3 with probe URV 3 with model 02) 4 batteries, R-20, IEC Recommended extras Accessories URV-Z6 75-Ω adapter URV-Z3 BF insertion units	2% of fsd 2.5% of fsd 2.5% of fs 2.5% of fs 2.5% of fs -20 to +6 -20 to +6 -25 to +7 battery cor 4 single ce and IEC, le supply uni 5 to 8 V/33 approx. 20 approx. 70 .241 mm× Millivoltr 302.901 302.901 302.901 302.901 .292.5364.1 divider, 40 URV-Z for reducing s 243.9118 from UNI-5 to 1.6/5.6 50 Ω N connect	d d +2% of ro 0° C Mer 0° C 0 75°C 0 flls 1.5 V, R-2 ad-acid acct t: external s 5 mA 00 h 110 mm×21 110 mm×21 44.02 44.12 g earth cable ve, earth str case 02 comprisin -dB divider, RF probe, i leeve for div 70 comprisin 0.5 coxet to 2 0.5 coxet to 2 5. 288.801	lg asuring heads to $+45^{\circ}$ C 5 to $+60^{\circ}$ C or operation with: 20, DIN 40 866 umulator or AC ource 9 mm, 2.5 kg 9 mm,
Basic error at t _{amb} +20 to +25 °C t _{amb} +15 to +30 °C t _{amb} +5 to +30 °C t _{amb} + 5 to +40 °C General data Rated temperature range Operating temperature range Storage temperature range Power supply Service life Battery (alkali-manganese cells Lead-acid accumulator Dimensions, weight Ordering information Order designation URV 3 with probe URV 3 with probe URV 3 with probe Que y a without probe Accessories supplied RF Probe URV-Z7 (only with model 02) 4 batteries, R-20, IEC Recommended extras Accessories URV-Z6 75-Ω adapter URV-Z3 RF insertion units (other connectors on request) 10-V Insertion Unit URV-Z4 Power Supply (6 V) EGT-Z	2% of fsd 2.5% of fsd 2.5% of fs 2.5% of fs 2.5% of fs -20 to +6 -25 to +7 battery cor 4 single ce and IEC, le supply unit 5 to 8 V/3 3) approx. 20 approx. 70 .241 mm× ► Millivoltr 302.901 302.901 302.901 302.901 302.911 8.292.5364.1 divider, 40 URV-Z for reducing s 243.9118. from UNI-5 to 1.6/5.6 50 Ω N connect 288.8010.1 283.7716.5	d d +2% of ro 0° C Mer 0° C 0 75°C 0 flls 1.5 V, R-2 ad-acid acct t: external s 5 mA 00 h 110 mm×21 110 mm×21 44.02 44.12 g earth cable ve, earth str case 02 comprisin -dB divider, RF probe, i leeve for div 70 comprisin 0.5 coxet to 2 0.5 coxet to 2 5. 288.801	lg asuring heads to $+45^{\circ}$ C 5 to $+60^{\circ}$ C or operation with: 20, DIN 40 866 umulator or AC ource 9 mm, 2.5 kg 9 mm,
Basic error at t _{amb} +20 to +25°C t _{amb} +15 to +30°C t _{amb} +15 to +30°C t _{amb} +5 to +40°C General data Rated temperature range Operating temperature range Storage temperature range Power supply Power supply Dimensions, weight Ordering information Order designation URV 3 with probe URV 3 with probe URV 3 with out probe Accessories supplied RF Probe URV-Z7 (only with model 02) 4 batteries, R-20, IEC Recommended extras Accessories URV-Z6 75-Ω adapter URV-Z3 RF insertion units (other connectors on request) 10-V Insertion Unit URV-Z4 Power Supply (6 V) EGT-Z (220/115 V, 50/60 Hz), with con	2% of fsd 2.5% of fsd 2.5% of fs 2.5% of fs 2.5% of fs -20 to +6 -20 to +6 -25 to +7 battery cor 4 single ce and IEC, le supply uni 5 to 8 V/33 approx. 20 approx. 70 .241 mm× Millivoltr 302.901 302.901 302.901 302.901 302.901 302.901 302.901 302.911 comprising earth sleever solder tip, 292.5364.1 divider, 40 URV-Z for reducing s 243.9118 from UNI-5 to 1.6/5.6 50 Ω N connect 288.8010.1 283.7716.5 -	d d +2% of ro 0° C Mer 0° C 0 75°C 0 flls 1.5 V, R-2 ad-acid acct t: external s 5 mA 00 h 110 mm×21 110 mm×21 44.02 44.12 g earth cable ve, earth str case 02 comprisin -dB divider, RF probe, i leeve for div 70 comprisin 0.5 coxet to 2 0.5 coxet to 2 5. 288.801	lg asuring heads to $+45^{\circ}$ C 5 to $+60^{\circ}$ C or operation with: 20, DIN 40 866 umulator or AC ource 9 mm, 2.5 kg 9 mm,
Basic error at t _{amb} +20 to +25 °C t _{amb} +15 to +30 °C t _{amb} +5 to +30 °C t _{amb} + 5 to +40 °C General data Rated temperature range Operating temperature range Storage temperature range Power supply Service life Battery (alkali-manganese cells Lead-acid accumulator Dimensions, weight Ordering information Order designation URV 3 with probe URV 3 with probe URV 3 with probe Que y a without probe Accessories supplied RF Probe URV-Z7 (only with model 02) 4 batteries, R-20, IEC Recommended extras Accessories URV-Z6 75-Ω adapter URV-Z3 RF insertion units (other connectors on request) 10-V Insertion Unit URV-Z4 Power Supply (6 V) EGT-Z	2% of fsd 2.5% of fsd 2.5% of fs 2.5% of fs 2.5% of fs -20 to +6 -20 to +6 -25 to +7 -20 to +6 -25 to +7 -25 to +7 -25 to +7 -25 to +7 -25 to +7 -25 to +7 -21 -25 to +7 -25 to +7	d d +2% of ro 0° C Mea 0° C 0 for C 0	lg asuring heads to $+45^{\circ}$ C 5 to $+60^{\circ}$ C or operation with: 20, DIN 40 866 umulator or AC ource 9 mm, 2.5 kg 9 mm,

6 RF MILLIVOLTMETERS

voltmeters



The **URV 4** – the first digital meter of the URV series – is a highly sensitive and accurate **millivoltmeter** measuring RF voltages and levels from 10 kHz to 2 GHz, up to 3 GHz if only used as indicator. Both high-impedance measurements using the probe of low capacitive loading and voltage measurements in any coaxial system (up to 350 V) or systems of standard characteristic impedance (50 and 75 Ω) are possible. To this end a comprehensive range of accessories such as probes and measuring heads is available.

System compatibility. The URV 4 is available with and without IEC-bus interface, the characteristics remaining the same. In addition to the conventional applications (see also URV and URV 3), the instrument fitted with the IEC-bus connector is especially, suitable for use in automatic test assemblies and systems.

The digital display gives a readout of the voltage or the level. Its high resolution and accuracy (4000 steps for measuring voltage; 10,000 steps without autoranging) is optimally matched to the overall accuracy of the measuring head and the meter. The measurement ranges can also be pushbutton-selected after switching off the autoranging. The levels are indicated directly in dB relative to 1 mW into 50 Ω in all subranges. When the unknown signal falls out of the selected subrange, the display of the URV 4 flashes.

Additional analog indication. To facilitate trimming (tendency indication) and for coarse measurements an additional analog indication is provided on the URV 4 in the form of a row of LEDs. The coverage is 30 dB in steps of 1 dB. Since two LEDs light between steps, level differences of 0.5 dB are discernible. The reference value for the analog scale can be taken from the five additional range indications.

Automatic zeroing. The URV 4 features automatic zeroing for voltage measurements in the most sensitive measurement range. It sets the electrical zero at the press of a button doing away with the tedious and error-prone zero setting by means of a zero adjustment potentiometer. Zero correction is not required in the higher measuring ranges.

A level-proportional DC voltage (100 mV/dB) is available at the recorder output provided on the rear panel of the URV4. Thus with the aid of automatic ranging continuous recording is possible over a dynamic range of 83 dB. The URV 4 can be powered from the AC supply or an external battery (automatic switchover depending on available AC supply voltage).

Measuring heads (probes, insertion units, adapters)

The measuring heads are freely interchangeable – also with those of the predecessor type URV. Depending on the order number selected, the RF probe is supplied with the URV 4, the other extras are recommended for use with the set.

0 μV to 10 V
0 kHz to 1 GHz (indicator up to 2 GHz)
mV to 100 V/2 to 500 MHz
mV to 1000 V/1 to 500 MHz
ith or without divider): measurement in
y coaxial system up to 350 V
robe +40 dB)
0 μV to 10 V/100 kHz to 500 MHz
Ω: 700 μV to 10 V
10 kHz to 2 GHz (50 Ω)
7 mV to 100 V
1 MHz to 2 GHz



Input impedance of RF probe. The input impedance of RF probe is given by the input capacitance C_{in} (see to the right) and the parallel input resistance R_p , which is dependent on the test voltage (100 k Ω to 1 M Ω between 1 mV and 10 V) and, above 3 MHz, also on the frequency.

Waveform weighting. The URV 4 measures and reads out the rms value in the three most sensitive measurement ranges. At voltages above 1 V, it measures the peak-to-peak value (V_{pp}), but reads out the value V_{pp}/2 $\sqrt{2}$ corresponding to the rms value for sinusoidal voltages. The following table gives **permissible crest factors** for different test voltages with a weighting error of 2 and 5% (blue for peak-value measurement).

Probe +	10-V insertion unit	20-dB divider + 100-V insertion unit	40-dB divider
Error	2 / 5%	2 / 5%	2 / 5%
V _{meas}	crest factor	crest factor	crest factor
3 mV	10/13		
10 mV	3/4		
30 mV	1.7/2	10 / 13	
100 mV		3/4	
300 mV		1.7/2	10 / 13
1 V	2.2/3.8		3/4
3 V	4.1/7.2		1.7/2
10 V	8.0/ 15	2.2/3.8	
30 V		4.1/7.2	
100 V		8.0/15	2.2/3.8
300 V			4.1/7.2
1000 V			8.0/ 15

Accuracy. The operational error consists of the basic error plus the frequency-response error; see the corresponding tables.

Basic error in the indicating range 300 to 4000 or -20 to +5 dBm on the analog scale

	Voltage me	easurement +)	Level measurement				
	4 mV to 10 V	0.7 to 4 mV	-35 to+33 dBm	-45 to -35 dBm	-50 to-45 dBn		
		1 % of rdg + 30 digits		0.4 dB	0.6 dB		
+15 to +30 °C	2 % of rdg + 3 digits	2 % of rdg + 40 digits	0.3 dB	0.6 dB	0.8 dB		
+ 5 to +40 °C	3 % of rdg + 5 digits	5% of rdg + 50 digits	0.5 dB	1 dB	1.2 dB		

-) Used only as indicator at voltages $<0.7\mbox{ mV}$ or levels $<-50\mbox{ dBm},$

Frequency-response error (reflection coefficients as for URV)

Measuring head	10 Range		2 1		kHz		14	AHz 2		100 MH		5		Hz 2 6
10-V insertion	0_1 to 10 V	1	Prozi	ent	/ M			1		2	5	7	12	20
unit 50Ω	0.7 to100 mV							2		3	7	10	12	20
10-V insertion	0.1 to 10 V							1		2	5	7	15	
unit 75Ω	0 7 to 100 m.V							2		3	7	10	15	
100-V insertion unit	1 to 100 V				20	5	2		1	2	5	7	12	20
50 Ω	7 to1000 mV				30	10	3		2	3	7	10	12	20
	0 1 to 10 V		20	5	2				1	3	7	18		
RF probe *)	0.7 to100 mV		20	5					3	5	10	15		
with	1 lo 100 V							20	11	13	16			
20-dB divider	7 to 1000 mV							20	13	15	20			
with	10 to 1000 V						15		6	8	12			
40-dB divider	0,07 lo10 V						20		в	10	15			
with 75-Ω	0.1 to 10 V		20	5	2				1	3	10			
adapter	0,7 to100 mV		20	5		-			3	5	12			

*) Probe alone or with 20-dB or 40-dB divider in BNC adapter (50-Ω coaxial system).

Spe	cifi	cati	ons
-----	------	------	-----

Instrument

Test I	nput
--------	------

Parameters measured	voltage/level (dBm)
Frequency range	10 kHz to 2 GHz
Voltage range	700 µV to 1000 V
Subranges	4/40/400 mV/4/10 V

RF MILLIVOLTMETERS 6

Level range	50 to +73 dBm				
Level range	40/-20/0/+20/+40 dB				
Level reference	. 0 dBm corresponding to 0.2236 V (1 mW into 50 Q)				
Range of indication	300 to 700 μV				
Range setting	autoranging pushbuttons for manual setting to next				
	higher/lower subrange				
Auto zeroing	elektronic zeroing by pushbutton				
	control for measuring RF voltages				
Readout of measured value	<4111V				
Range indication, analog	5 LEDs for subranges				
digital Digital display	decimal point and unit (mV/V/dB)				
Voltage	4 digits (4000 steps, 10,000 steps with-				
	out autoranging) recolution 1 uV				
Analog level indication	4 digits plus polarity sign, res. 0.01 dB				
Indication range	 –25 to +5 dB, step size 1 dB, 				
Descendes output	resolution 0.5 dB				
Recorder output	1 KΩ, shortcircuit-proof positive or negative level-proportional				
	DC voltage, 0 V at 0 dBm (223.6 mV),				
Dynamic range	100 mV per dB input level variation 83 dB corres, to -5 to +3.3 V				
	interface in accordance with IEC 625-1				
	for controlling the operating modes				
Interface functions	SH1, AH1, T5, L4, SR1, RL1, DC1 level-dependent, up to 30 meas./s				
Connection of measuring head	three-pole female connector (for URV measuring head)				
DE monouring hands	· · · ·				
RF measuring heads	RF probe with 20-dB and 40-dB dividers as well as BNC adapter and				
	75-Ω adapter				
	10-V insertion unit (50, 75 Ω) 100-V insertion unit (50 Ω)				
Input Impodence of PE probe	. ,				
with 20-dB divider	$\begin{array}{l} R_p > 80 \ \text{k}\Omega \ (\text{up to 10 MHz}), \ C_{\text{in}} = 2.5 \ \text{pF} \\ R_p > 1 \ \text{M}\Omega \ (\text{up to 20 MHz}), \ C_{\text{in}} = 1 \ \text{pF} \end{array}$				
with 40-dB divider	$R_p > 10 M\Omega (up to 20 MHz), C_{in} = 0.5 pF$				
Voltage rating RF probe	V DC V _{rms} (sinew.) V _p 400 V 15 V 22 V				
HF probe	400 V 15 V 22 V 1000 V 150 V 220 V				
with 40-dB divider					
up to 100 MHz	1000 V 1050 V 1500 V				
10-V insertion unit	50 V 15 V 22 V				
100-V insertion unit \dots 75- Ω adapter (P _{max} = 2 W) \dots	1000 V 1050 V 1500 V 1000 V 210 V 1500 V 50 V 15 V 22 V 1000 V 150 V 220 V 12 V 12 V 7 V				
Frequency ranges RF probe	100 kHz to 1 GHz (2 GHz)				
with 20-dB/40-dB divider	2 to 500 MHz/1 to 500 MHz				
10-V insertion unit 50 Ω 10-V insertion unit 75 Ω	10 kHz to 2 GHz (indicator: 3 GHz)				
100-V insertion unit 50 Ω	1 MHz to 2 GHz				
75-Ω adapter					
Voltage ranges (level ranges)					
	700 μ V to 10 V/-50 to +33 dBm				
RF probe with 20-dB divider, 100-V insertion unit	7 mV to 100 V/-30 to +53 dBm				
RF probe with 40-dB divider	70 mV to 1000 V/-10 to +73 dBm				
Error limits	see lefthand column under accuracy				
	and a contract and a contracy				
General data					
Rated temperature range	+5 to +40°C				
	-20 to +60°C (measuring head)				
	 -20 to +60°C (measuring head: 0 to +45°C) 				
	$0 to \pm 45^{\circ}C$				
Storage temperature range	0 to +45°C) -25 to +75°C (measuring head: -15 to +60°C)				
Storage temperature range	0 to +45°C) -25 to +75°C (measuring head: -15 to +60°C)				
Storage temperature range	0 to +45°C) -25 to +75°C (measuring head: -15 to +60°C) 115/220 V ±10%, 47 to 440 Hz (4 VA, model 03: 6 VA) 11 to 28 V, 300 (450) mA at 12 V .241 mm×110 mm×219 mm,				
Storage temperature range Power supply, AC supply ext. battery Dimensions, weight	0 to +45°C) -25 to +75°C (measuring head: -15 to +60°C) 115/220 V ±10%, 47 to 440 Hz (4 VA, model 03: 6 VA) 11 to 28 V, 300 (450) mA at 12 V				
Storage temperature range Power supply, AC supply ext. battery Dimensions, weight Ordering information	0 to +45°C) -25 to +75°C (measuring head: -15 to +60°C) 115/220 V ±10%, 47 to 440 Hz (4 VA, model 03: 6 VA) 11 to 28 V, 300 (450) mA at 12 V 241 mm×110 mm×219 mm, 2.6 kg (2.9 kg)				
Storage temperature range Power supply, AC supply	0 to +45°C) -25 to +75°C (measuring head: -15 to +60°C) 115/220 V ±10%, 47 to 440 Hz (4 VA, model 03: 6 VA) 11 to 28 V, 300 (450) mA at 12 V 241 mm×110 mm×219 mm, 2.6 kg (2.9 kg) ► Millivotmeter URV 4				
Storage temperature range Power supply, AC supply	0 to +45°C) -25 to +75°C (measuring head: -15 to +60°C) 115/220 V ±10%, 47 to 440 Hz (4 VA, model 03: 6 VA) 11 to 28 V, 300 (450) mA at 12 V 241 mm×110 mm×219 mm, 2.6 kg (2.9 kg) ► Millivotmeter URV 4				
Storage temperature range Power supply, AC supply . ext. battery . Dimensions, weight Ordering information Order designation	0 to +45°C) -25 to +75°C (measuring head: -15 to +60°C) 115/220 V ±10%, 47 to 440 Hz (4 VA, model 03: 6 VA) 11 to 28 V, 300 (450) mA at 12 V 241 mm×110 mm×219 mm, 2.6 kg (2.9 kg) ► Millivoltmeter URV 4 with probe without probe 292.5012.02 292.5012.12 292.5012.03 292.5012.13				
Storage temperature range Power supply, AC supply ext. battery . Dimensions, weight Ordering information Order designation URV 4 without IEC-bus connector . with IEC-bus connector . (10 kHz to 1 GHz)	0 to +45°C) -25 to +75°C (measuring head: -15 to +60°C) 115/220 V ±10%, 47 to 440 Hz (4 VA, model 03: 6 VA) 11 to 28 V, 300 (450) mA at 12 V 241 mm×110 mm×219 mm, 2.6 kg (2.9 kg) ► Millivoltmeter URV 4 with probe without probe 292.5012.02 292.5012.12 292.5012.03 292.5012.13				
Storage temperature range Power supply, AC supply	0 to +45°C) -25 to +75°C (measuring head: -15 to +60°C) 115/220 V ±10%, 47 to 440 Hz (4 VA, model 03: 6 VA) 11 to 28 V, 300 (450) mA at 12 V 241 mm×110 mm×219 mm, 2.6 kg (2.9 kg) ► Millivoltmeter URV 4 with probe without probe 292.5012.02 292.5012.12 292.5012.03 292.5012.13 292.5012.04 —				
Storage temperature range Power supply, AC supply ext. battery Dimensions, weight Ordering information Order designation URV 4 without IEC-bus connector with IEC-bus connector (10 kHz to 1 GHz) Accessories supplied RF probe URV-Z7, same as for URI RF probe 342.3600.04 (only for m	0 to +45°C) -25 to +75°C (measuring head: -15 to +60°C) 115/220 V ±10%, 47 to 440 Hz (4 VA, model 03: 6 VA) 11 to 28 V, 300 (450) mA at 12 V 241 mm×110 mm×219 mm, 2.6 kg (2.9 kg) ► Millivotmeter URV 4 with probe without probe 292.5012.02 292.5012.12 292.5012.03 292.5012.13 292.5012.04 — V3 (only for models 02 and 03 of URV 4), odel 04 of URV 4),				
Storage temperature range Power supply, AC supply ext. battery . Dimensions, weight Ordering information Order designation URV 4 without IEC-bus connector with IEC-bus connector (10 kHz to 1 GHz) Accessories supplied RF probe URV-Z7, same as for URI RF probe URV-Z7, same as for URI RF probe 342.3600.04 (only for m connector for battery; power cable	0 to +45°C) -25 to +75°C (measuring head: -15 to +60°C) 115/220 V ±10%, 47 to 440 Hz (4 VA, model 03: 6 VA) 11 to 28 V, 300 (450) mA at 12 V 241 mm×110 mm×219 mm, 2.6 kg (2.9 kg) ► Millivotmeter URV 4 with probe without probe 292.5012.02 292.5012.12 292.5012.03 292.5012.13 292.5012.04 — V3 (only for models 02 and 03 of URV 4), odel 04 of URV 4),				
Storage temperature range Power supply, AC supply ext. battery . Dimensions, weight Ordering information Order designation URV 4 without IEC-bus connector . with IEC-bus connector . (10 kHz to 1 GHz) . Accessories supplied RF probe URV-Z7, same as for UR RF probe URV-Z7, same as for UR	0 to +45°C) -25 to +75°C (measuring head: -15 to +60°C) 115/220 V ±10%, 47 to 440 Hz (4 VA, model 03: 6 VA) 11 to 28 V, 300 (450) mA at 12 V 241 mm×110 mm×219 mm, 2.6 kg (2.9 kg) ► Millivotmeter URV 4 with probe without probe 292.5012.02 292.5012.12 292.5012.03 292.5012.13 292.5012.04 — V3 (only for models 02 and 03 of URV 4), odel 04 of URV 4),				

page 209

Adapter ZZA-1 for 19" racks 1.... 078.8016.00



power meters

Power measurement at high frequencies

Active power is defined in electrical engineering as the product of the magnitudes of current and voltage, taking account of the phase angle between them:

$$P_{active} = \left| \underline{V}_{rms} \right| \left| \underline{I}_{rms} \right| \cos \varphi$$

This applies, of course, also for RF power.

The frequency range in which a power measurement according to this formula is practicable extends from a few Hz to about 10 kHz. A dynamometer inserted into the current and voltage paths accomplishes the multiplication with correct phase.

At higher frequencies the dynamometer can no longer be used to measure power. Two completely different methods are employed here represented by the output power meter (absorption type) and the directional power meter, which also differ in their fields of application.

Power meters and reflectometers

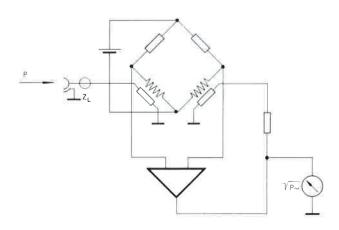
Output power meters

Output power meters practically have a resistive input impedance, the standard values being 50, 60 or 75 Ω (Z₀). They thus reflect only a small portion of the incident wave energy while the major part is converted into heat. The power indication of the output power meter is derived from the measurement of the heat produced (calorimeter).

The Microwave Power Meter NRS operates according to this principle.

The power consumed in matched probe is converted into heat and unbalances a very sensitive bridge. The power of a standard resistor required to compensate for the unbalance is a measure of the power applied to the probe.

The principle of the output power meter is shown in the following diagram.



Power measurement using temperature-dependent resistors in a bridge circuit

Directional power meters

Directional power meters are inserted into a transmission line and measure the incident and reflected powers according to a directional-coupler principle. Transmitter output power and antenna or load matching can be checked simultaneously with this type of power meter.

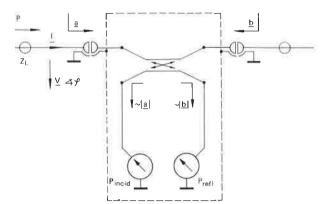
The reflection coefficient is obtained as

VSWR

$$\left|\underline{\mathbf{r}}\right| = \mathbf{V} \frac{\mathsf{P}_{\mathsf{refl}}}{\mathsf{P}_{\mathsf{incid}}}$$

and

√Prefl/Pincid



Power measurement using directional coupler

Instruments operating on this principle are the Power Meters NAU and NAUS.

Overview

Several instruments with different power and frequency ranges are available for use in the frequency range of 1 to 1000 MHz; see table on next page.

Type NAN with its power range extending up to 1.2 kW is suitable for power measurement and matching indication in the **shortwave range**.

With a power range of 30 W NAUS 3 is ideal for **measurements on RT equipment** between 25 and 1000 MHz. All frequency bands and power classes of the radio sets are covered without exchanging any measuring heads or inserts. The AM Unit SMDU-Z1 and the Power Test Adapter SMDU-Z2 are destined for use in RT and air navigation test assemblies, but can also operate on their own.

For **higher-power applications**, e.g. measurement on transmitter systems, NAUS 4 (25 to 1000 MHz, 110 W) and NAUS 5 and 6 (25 to 1000 MHz, 340 W and 1100 W, resp.) are available.

Adjacent-channel **interference components** of radio equipment are measured and weighted by the **Adjacent-channel Power Meter NKS** in conjunction with the RT Test Assembly SMDU. The NKS is therefore described in section 3 page 115 among the test assemblies.

power meters

POWER METERS 6

Frequency range	Designation	Туре	Order No.*	Power range	Sub- ranges	Error of fsd	Indication of small refl. components	Text on page
1.5 to 30 MHz	HF-Wattmeter & Matching Indicator	NAN	100.2727	0 to 1.2 kW	4	±8% ìncl. freq. resp.		213
25 to 1000 MHz	Directional Power Meter	NAUS 3 NAUS 4	288.8610 289.9010	20 mW to 34 W 50 mW to 110 W	5 5	page 215	20 mW to 34 W 50 mW to 110 W	214
25 to 1000 MHz	Directional Power Meter	NAUS 5 NAUS 6	349-8014.55 349-8314.54	0.2 to 340 W 0.5 to 1100 W	5 5	page 216	0.2 to 340 W 0.5 to 1100 W	215
1 to 1050 MHz	AM Unit	SMDU-Z1	242.2010	50 mW to 30 W 0.1 to 60 W	5 5	± (8% of rdg +1.5% of fsd)		106
1 to 1050 MHz	Power Test Adapter	SMDU-Z2	242.4012.52	50 mW to 30 W	5	± (8% of rdg +1.5% of fsd)		106
0 to 15 GHz	Microwave Power Meter + Probe	NRS	100.2433.92 100.2440	0.1 to 330 mW ¹)	5	±1.5 (2.3) %		217

* If seven-figure designation is given, see text for complete (nine-figure) order No.

¹) The measurement range can be extended with high-power attenuators (section 10).

HF Wattmeter & Matching Indicator NAN

- ♦ 1.5 to 30 MHz
- Reflection-coefficient range of 0 to 100%
- Power range up to 1200 W, direct reflection indication with 20 W incident power

The HF Wattmeter affords direct power and reflection-coefficient reading in the shortwave range. The instrument is suitable for measuring the power of HF transmitters and for matching antennas, therapeutic equipment and other loads.

The NAN consists of a measuring head and an indicator. The measuring head is connected into the transmission line. It accomodates two directional couplers and is connected to the indicator section with a cable. The indication of incident or reflected power as well as reflection can be switch-selected.

The measuring-head connector is an RF female connector 4/13, DIN 47 284, that can be adapted to many other connector systems.

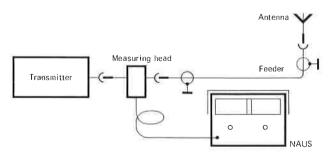
Specifications 1.5 to 30 MHz 36/120/360/1200 W 0 to 100% for direct reflection-coefficient 20 W 1200 W 50 Ω <2% ±8% of fsd (with temperature frequency response error correction curve) measuring head: 76 mm×76 mm×100 mm Dimensions indicator: 130 mm×180 mm×105 mm HF-Wattmeter & Matching Indicator NAN 100.2727.50 Order designation

6 POWER METERS



The **Directional Power Meters NAUS** are handy, easy to operate and designed for in-situ servicing of radiotelephone equipment, radio installations (up to 110 W with NAUS 4) and walkie-talkies of low output. Owing to their wide frequency and power ranges the NAUS power meters can be used over the entire radiotelephone bands for the output levels of most types of radiotelephone equipment.

The power meters of the NAUS series are similar in appearance and design; they differ mainly in their power handling capacities, see above. The instruments consist of an indicator (case with carrying handle, see photos) and a separate measuring head, which can be connected in either direction. The incident and the reflected power are indicated on separate meters so that – also due to the wide continuous frequency range – operating errors are precluded.



Power measurement on antenna feeder using NAUS

Measurement ranges. The power range of the NAUS power meters is divided into five subranges; it extends from 20 mW to 34 W, from 50 mW to 110 W, from 200 mW to 340 W or from 500 mW to 1100 W depending on the model; fsd is obtained with 0.3 W, 1 W, 3 W or 11 W in the most sensitive range. The range of the 30-W models can be extended to 68 W by inserting a High-power Attenuator RBU (3 dB, see section 10).

Indication and accuracy. The instruments deliver correct results under all conditions: the indication is highly stable and insensitive to temperature fluctuations. Since the rectifier diodes are very lightly driven, both meter scales are linearly calibrated and the indications can be easily read. True average power indication is also given of non-sinusoidal signals (modulated transmitter). The negligible internal losses do not impair the measurements.

Input and output. The measuring head is available in the following models depending on the order number:

NAUS 3 50 Ω Dezifix B or N female/male, all adaptable

NAUS 4 50 Ω N female/male, adaptable.

Suitable screw-in assemblies for conversion to other connector systems (e.g. UHF or BNC): please enquire.

Since the two measuring channels are alike, the forward direction is arbitrary.

Design and power supply. The measuring head of the NAUS consists of a directional coupler. The input power is fed through to the load with almost no attenuation (electrical length of line 140 mm). The secondary line is matched at both ends. Voltages proportional to the incident and reflected power are coupled into this line and rectified. An RC section is used to compensate for the frequency response of the coupler. The rectified signal voltages are fed via the connecting cable to the instrument which includes shielded chopper amplifiers, and are then displayed separately.

The power supply uses five 1.5-V batteries (R20, acc. to DIN or IEC). These can be easily replaced after removing the cabinet cover (voltage check by pressing a pushbutton on the lefthand meter). Owing to the very low current drain, a set of

power meters

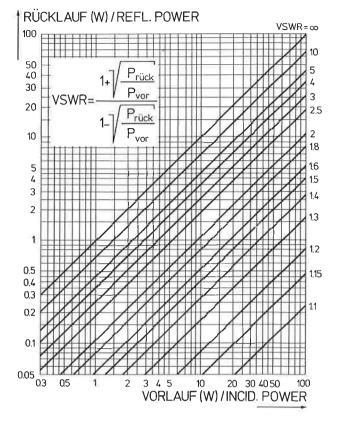
POWER METERS 6

commercially available, leakproof batteries has a lifetime of almost one year with continuous operation (>7000 operating hours).



Directional Power Meter NAUS 4 (50 mW to 110 W)

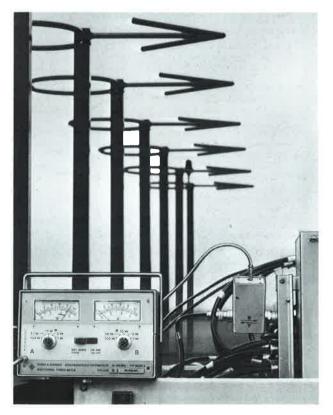
A diagram (right) for determining the VSWR as a function of the incident andd reflected power is provided on the rear of the instrument.



Graph to derive VSWR from incident and reflected power (provided on the rear panel of each instrument)

On a stiff a stiff a st

Measurement of incident and reflected power in the feeder of an antenna for airtraffic control with the Directional Power Meter



Specifications		
Frequency range	25 to 1000 MHz	
	NAUS 3	NAUS 4
Permissible incident and		
Permissible incident and reflected power Indication ranges Lowest power reading Indication error Effect of temperature	. 34 W	110 W
indication ranges	- 0.34/1.1/3.4/11/ 24 M	1.1/3.4/11/34/
Lowest power reading	20 mW	50 mW
Indication error	≦3% of rdg	≦3% of rdg
	±2% of fsd	±2% of fsd
Effect of temperature	. ≦0.25%/°C	≦0.25%/°C
at and above 30 MHz up to 30 MHz Characteristic impedance	≥26 dB	≧30 dB ≥26 dB
Characteristic impedance	50 Ω	50 Ω
VSWR	. ≦1.03	≦1.03
Transmission loss		
up to 300 MHz up to 500 MHz	.≦0.1 dB	0.08 dB 0.15 dB
up to 1000 MHz	≤0.25 0B≤0.75 dB	0.35 dB
Electrical length of transmission	- <u>_</u> 0.70 db	0.00 00
channel	- 140 mm	140 mm
General data (all models)		
Rated temperature range		
Storage temperature range Power supply	5 single cells 1.5	v
	R 20 IEC	
Battery life	. >7000 hours	
Dimensions indicator	230 mm×150 mn	n×130 mm
measuring head 50 Ω .	125 mm×105 mn	n× 45 mm
60 Ω.	4 ka	
Ordering information		
Order designations	► Directional Pow	wer Meter

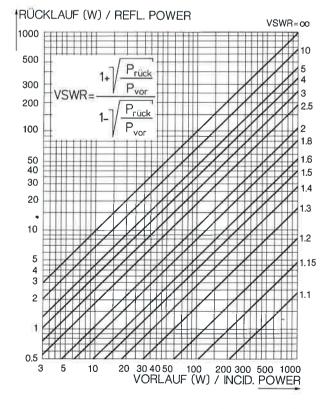
6 POWER METERS

power meters



Apart from their higher power rating the **Directional Power Meters NAUS 5 and NAUS 6** are the same in design and performance as the NAUS 3 and NAUS 4 models described on pages 214, 215. Like these they consist of an **indicator** (case with carrying handle) and a separate **measuring head** which can be connected in either direction. The incident and the reflected power are indicated on separate meters in five subranges.

The power supply uses five 1.5-V cells which are easy to replace and last for more than 7000 operating hours on average.



Graph to derive VSWR from incident and reflected power (provided on the rear panel of each instrument)

Applications: Owing to their higher power-handling capacity the NAUS 5 and NAUS 6 can be used for power and VSWR measurements on modulated or unmodulated transmitter, radio equipment in general and power stages (amplifier alignment). Each unit is provided on its rear panel with a graph enabling the user to read the VSWR from the incident and the reflected power.

Specifications		
opeemeations	NAUS 5	NAUS 6
Frequency range	25 to 1000 MHz	25 to 1000 MHz
Indicator		
Meter calibration	in W	I, linear scale
Subranges		11/34/110/
Lowest power reading	110/340	340/1100 0.5 W
Maximum indicent and		0.5 **
reflected power		1100 W % of rdg ±2% of fsd
Temperature effect	≦47 ≦0.	25%/°C
Directivity at and above 30 MHz	. ≧30	
up to 30 MHz	. ≧26	d B
Measuring head		
Characteristic impedance		-
VSWR Transmission loss	. ≦1.	03
up to 300 MHz		≦0.05 dB
up to 500 MHz		≦0.1 dB 140 mm
Connectors (adaptable) ¹)	N female/	Dezifix B ²)
	N male	
General data (both types)		
Nominal temperature range		
Power supply	5 single cells 1.5	V, R20
Battery life		
Battery check Dimensions of indicator		
measuring head	. 125 mm×105 mr	
Weight	. 4 kg	
Ordening informati		
Ordering information		
Order designation		ver Meter
NAUS 5 (340 W) NAUS 6 (1100 W)	349.8014.55	
14,000 (1100 W)	349.0314.34	
1) Suitable entrui in eccent l'an far		
 Suitable screw-in assemblies for UHF connector: male 017.7384.0 	0, female 017.521	7.00:
Dezifix B: 018.2486.00; please or	der separately.	
2) When using N connectors for NAU power of 1.1 kW can only be meas	ured up to 650 MH	ted that the max. z due to the size of
the connectors.		

power meters

Mccoware Power Meter NRS
4. Subset of SGH2
B. Subset of SGH2
B. Automatic zero adjustment

The **NRS** makes high-accuracy power measurements on test items to be terminated with 50 Ω (coaxial lines). Its wide frequency range ensures a large field of application, especially in the RF range.

Power range. The power range of 0.1 to 330 mW is divided into five subranges 3/10/30/100/300 mW, corresponding to 5-dB steps. Continuous range extension up to 60 kW is possible by means of attenuators of high powerhandling capacity or load resistors with an output for an accurately known insertion loss (see section 10).

Indication and accuracy. Only active power is measured and indicated. AC signals of any waveform, even very short pulses, are correctly measured. As the NRS has a flat frequency response from DC to 15 GHz it also provides a true power indication of frequency spectra. The error limits are $\pm 2\%$ of the reading of the mW scale. The accuracy can be greatly improved through the use of an external indicator. The rear output of the NRS delivers a DC voltage V₀ which equals to within $\pm 0.2\%$ the original rms voltage V_s of the source. The power is calculated from the voltage V₀ read on a digital voltmeter

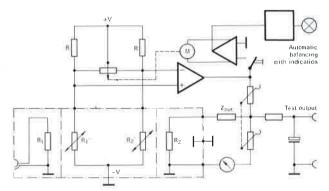
$$P = \frac{1}{Z_0} \left(\frac{V_0}{2}\right)^2 = \frac{V_0^2}{4Z_0}$$

The error of power measurement is in this case ${<}\pm0.4\%$ of reading.

The settling time of the NRS is short relative to other calorimetric power meters. It is less than 10 s at power values >1 mW.

Connection (probe). The unknown is picked up by a probe. Probes for the NRS are available with 50 Ω input impedance (to be ordered separately). They can be used with any basic unit and are interchangeable. The probes are equipped with coaxial connectors which can readily be adapted to the Dezifix A or Dezifix B system (screw-in assembly supplied with the probe). Adaptations to other systems, e.g. to N or APC 7 systems, are possible.

Test output. A test output for the connection of a DC recorder or analog/digital converter is provided at the rear of the NRS. (For output voltage see "Indication and accuracy"; $Z_{out} = 2 \ k\Omega \ \pm 10\%$). Moreover, the NRS has an input for triggering the automatic balancing facility, which makes it suitable for incorporation into automatic test assemblies.



Simplified diagram of Power Meter NRS

Specifications

$\begin{array}{llllllllllllllllllllllllllllllllllll$
$ \begin{array}{llllllllllllllllllllllllllllllllllll$
$\begin{array}{llllllllllllllllllllllllllllllllllll$
$ \begin{array}{llllllllllllllllllllllllllllllllllll$
$ \begin{array}{llllllllllllllllllllllllllllllllllll$
$ \begin{array}{llllllllllllllllllllllllllllllllllll$
$\begin{array}{llllllllllllllllllllllllllllllllllll$
to RF input voltage Temperature effect $\leq \pm 0.03\%$ /° C
Temperature effect ≦ ±0.03% /° C
Settling time for powers ≥1 mW ≤10 s for 100% ±2.0% of rdg
Setting time for powers $\leq 1 \text{ mW}$ $\geq 10 \text{ s for } 100\% \pm 2.0\% \text{ or } rdq$
5
Probes 50 Ω
0 to 15 GHz
Reflection coefficient
0 to 4.5 GHz
up to 11 GHz
above
Connector Dezifix A1)
Dimensions, weight 484 mm×150 mm×336 mm, 12 kg
Ordering information
Order designations
Basic unit Microwave Power Meter NRS
100.2433.92
Probes 50 Ω, 0 to 15 GHz ▶ Probe for NRS, 100.2440.50
Accessories supplied
for basic unit power cable, connecting cable
(2 m, basic unit-probe)
for 50-Ω probe 1 adapter from Dezifix A to B
¹) Adapter from Dezifix A to B is delivered with the probe.
Coupling mechanism II (400.0133.00) permits connection to APC 7.

Test Receiver ESV; combined with test antennas it forms the Field-strength Meter HUF for 20 MHz to 1 GHz; details on pages 234 and 254



test receivers-field-strength meters wave analyzers-modulation analyzers



7 SELECTIVE VOLTMETERS

test receivers

Test receivers

Fields of application

Test receivers are used for **frequency-selective** measurements of voltage and – combined with suitable antennas – of electrical and magnetic **field strength**. They have applications in laboratories and test departments wherever signal levels, non-linearities, noise and modulation characteristics of signal generators and amplifiers are to be measured. Organisations using radiocommunications (postal, broadcasting, military, commercial security, civil) employ test receivers and field-strength meters for **propagation measurements** in planning and determining the coverage of communications networks. In this context the measurement of horizontal and vertical antenna radiation patterns is an important application.

Radiomonitoring services use test receivers to check the transmissions from the individual stations for compliance with the technical specifications – an essential condition for simultaneous operation of the different communications networks without mutual interference. These checks involve measurements of level, spurious signals, centre frequency and bandwidth.

Radio-interference measurements open another important field of application for test receivers. In the civilian sector the aim is to secure undisturbed broadcast reception, whereas in the industrial and military fields electromagnetic compatibility (EMC) plays a more and more important role because of the increasing complexity of electronic systems. Here test receivers measure the interference in terms of current, voltage or field strength, depending on the type of transducer (antenna) connected to the receiver. Weighting curves for the readings are specified for civilian applications in VDE 0876; EMC is indicated as peak voltage or as spectral voltage density.

Frequency range	Designation	Туре	Order No. (complete No.: see text)	Voltage range	Fs of lowest subrange	Error of voltage indication
9 kHz to 30 MHz	Test Receiver	ESH 2	303 2020 52	−30 to +137 dBμV	-10 dBμV	<1 dB
9 kHz to 30 MHz	Programmable Test Receiver	ESH 3	335-8017-52	−30 to +137 dBμV	−10 dBµV	<1 dB
25 to 300 MHz	VHF Field-strength Meter and Test Receiver	HFV	203.6018	1 µV to 0.1 V	10 µV	<2 dB
20 to 1000 MHz	Test Receiver	ESV	342.4020	-10 to +137 dBµV	+10 dΒμV	<1.2 dB
20 to 1300 MHz	Test Receiver	ESVP	354.3000	−18 to +137 dBμV	0 dBμV	<1 dB
25 to 1000 MHz	VHF-UHF Test Receiver	ESU 2	252-0010	−10 to +120 dBμV	10 dΒμV	<1 dB
25 to 1000 MHz	VHF-UHF Selective Test Equipment	MSU	253.2016.55	−10 to +120 dBμV	10 dΒμV	<1 dB
	Progr. VHF-UHF Test Equipment	MSUP	253.3512.55	Data same as MSU; IEC-	bus compatible, softw	are available
9 kHz to 1000 MHz	Automatic Test Equipment	MSUP + ESH 3 + PUC	see p. 248	−30 (−10) to +137 dBμV	−10/+10 dBµV	<1 dB

new

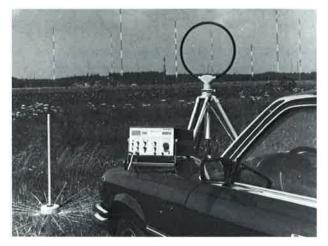
new

SELECTIVE VOLTMETERS 7

Instrument features

Test receivers always use superhet circuitry with multiple conversion. They have **filters preceding the first mixer**, providing the wide dynamic range required for radio interference measurements. State-of-the-art models produce all the internal conversion frequencies by **frequency synthesis**. The receive frequency which has been set is displayed digitally. Automatic voltage calibration can be triggered on command.

Field-strength measurements are usually made with mobile stations (vehicles, helicopters), especially when propagation and coverage are to be determined. Portability and **battery operation** are thus important criteria in the choice of the test receiver. On the other hand, computer control is demanded for radio-interference measurements, radio-monitoring and test systems. With the present state of technology, it is not efficient to combine both features in one instrument type. R&S therefore offers two series of test receivers for the frequency range 9 kHz to 1 GHz: the ESH 2, HFV, ESV and ESU 2 have built-in batteries for mobile use while the ESH 3, ESVP and MSUP are equipped with an **IEC 625 interface** for computer controlled operation.



Field-strength Meter HFH 2 for 9 kHz to 30 MHz

Frequency response dB	Noise voltage	Input impedance	Interme 1st IF	diate fre MHz 2nd IF		IF band width kHz	Image frequency rejection	Dimensions in mm (W×H×D)	Text on page
automatic calibration by pushbutton	<−30 dBµV	50 Ω	75	9	0.03	10/2.4/ 0.5/0.2	>100 dB	347× 206× 484	222
automatic calibration	<−30 dBµV	50 Ω	75	9	0.03	10/2.4/ 0.5/0.2	>100 dB	492× 205× 514	226
calib. possible at any frequency	<0.7 μV	50 Ω	400	10,7		120	>80 dB	326× 96× 290	252
automatic calibration by pushbutton	<−10 dBµV	50 Ω	810.7 310.7	10.7		7.5/12/ 120/1 MHz	>80 dB	347× 206× 484	234
	< -18 dBµV	50 Ω	810.7 310.7	10,7		7.5/12/ 120/1 MHz	>80 dB	492× 205× 514	238
calib. possible at any frequency	≦−13 dBµV	50/60/75 Ω	199.3/ 339.3	10.7	0.45	15/120/300	>70 dB	492× 195× 556	242
calib. possible at any requency	≦−13 dBµV	50 Ω	199.3/ 339.3	10.7	0.45	15/120/300	>70 dB	520× 400× 535	244
MSUP: data same as MSU								520× 534× 635	248
calib. possible at any requency	<-30/<−10 dBµV	50 Ω	up to 3 75 at high	9	0.030 same as	0.2/0.5/2.4/ 10 MSU	>100 dB >70 dB	520× 710× 635	248, 249

7 HF TEST RECEIVERS

test receivers



- ♦ 9 kHz to 30 MHz/-30 to +137 dBµV
- Synthesizer-based test receiver offering crystal-referenced frequency display, 100 Hz resolution
- Level range >165 dB
- Automatic voltage calibration at the push of a button
- Interference measurements in line with CISPR, VDE, MIL and VG
- AC supply and battery operation

The **ESH 2** is a manually operated, sensitive and overloadprotected test receiver offering a very wide dynamic range and maximum ease of operation. Compact construction, the wide range of power supplies that can be used, and low power consumption make the receiver suitable for use in fixed stations as well as for mobile and portable applications.

Thanks to its excellent characteristics and the availability of a wide range of accessories, the applications of the ESH 2 include **interference measurements** and **field-strength measurements**; for use of ESH 2 as the Field-strength Meter HFH 2 see page 251.

Covering the frequency range from 9 kHz to 30 MHz, the ESH 2 can tune to any signal from LF to the upper shortwave range, where it overlaps with the ESV (page 234).

Characteristics, uses (ESH 2 alone)

The ESH 2 needs no accessories to operate as a selective voltmeter (test receiver) with a level range from -30 to +137 dBµV, for example, for measurements, in 50- Ω coaxial systems. The Active Probe ESH 2-Z2 is available for measuring high-impedance test items. Relative and absolute selective voltage measurements are possible even in the presence of a multitude of signals.

Automatic calibration at the push of a button and excellent receiver selectivity permit accurate measurements of closely spaced signals with very different levels, for example: SSB two-tone measurements, spurious-content and ideband-noise measurements on signal generato.s, intermodulation and distortion measurements, noise figure measurements.

The calibration-generator output can be used for twoport measurements over an attenuation range of more than 100 dB and a gain range of more than 50 dB; see diagram on the right.

Signal ealuation. Four switch-selected IF bandwidths and numerous test outputs make it easy to carry out a wide range of measurements:

wideband IF output, 75 MHz,, for the connection of a panoramic display or a wave analyzer,

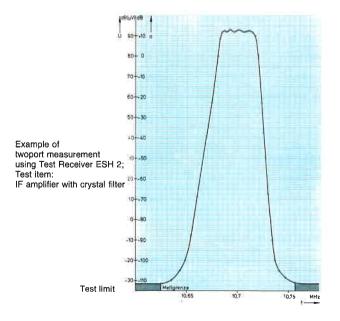
narrowband IF output, 30 kHz, for an oscilloscope,

AM/FM demodulator outputs,

recorder output for level and frequency offset,

output for the connection of a frequency counter.

Overload of the input or of other important circuits is recognized by the test receiver and automatically signalled.



HF TEST RECEIVERS 7

Auxiliary instruments for additional applications

Interference measurement. Interference voltage and interference current can be measured in accordance with the relevant standards (CISPR, FCC, MIL, VG, VDE). The following accessories are available for this purpose (see specifications on page 225 and page 230):

Active Probe	ESH 2-Z2
Passive Probe	ESH 2-Z3
Current Probe	ESH 2-Z1
Artificial Mains Network	ESH 2-Z5 and
Pulse Limiter	ESH 3-Z2

In addition to the overload indication and automatic calibration which have already been mentioned, the ESH 2 has other features which are particularly important in interference measurements:

level indication taking into consideration the conversion factor of the sensor, e.g. directly in $dB\mu A$,

frequency-dependent automatic switchover of weighting and of calibration pulse for CISPR 1 or 3,

peak indication with selectable hold time,

IF bandwidths of 200 Hz and 9 kHz in line with CISPR,

IF bandwidth of 10 kHz in line with MIL.

In interference measurements the Loop Antenna HFH 2-Z2 is used to measure the magnetic component and the Rod Antenna HFH 2-Z1 the electric component.

Radiomonitoring, remote frequency measurement. In conjunction with a receiving antenna and a frequency counter the test receiver can be used in radiomonitoring, since it features excellent frequency accuracy and stability and is capable of demodulating A1A, A3E, J3E (formerly A1, A3, A3J) and FM transmissions. With a frequency counter connected to the ESH 2 generator output, high-accuracy remote frequency measurements can be performed. The test receiver then functions as an active filter of high selectivity.

Field-strength measurements. Completed by the following antennas the test receiver can be used for field-strength measurements (see also Field-strength Meter HFH 2 on page 251):

Active Rod Antenna	HFH 2-Z1 (9 kHz to 30 MHz)
Active Loop Antenna	HFH 2-Z2 (9 kHz to 30 MHz
Inductive Probe	HFH 2-Z4 (100 kHz to 30 MHz)

Another Loop Antenna, HFH 2-Z3, is available as an accessory for measurements on very weak signals in the frequency range of 9 to 150 kHz. The Roof-mounting Kit HFH 2-Z5 permits the HFH 2-Z2 to be operated on top of test vehicles.

Propagation measurements and measurements of coverage in the radio-monitoring field can also be carried out; with an YT recorder connected to the corresponding output, fieldstrength observation is possible over extended periods of time.

The digital readout of the reference level in $dB\mu V/m$, which takes into consideration the conversion factor of the antenna used, is an important asset in field-strength measurements.

Ease of operation, setting functions

The correction of the level indication taking into account antenna factors and conversion factor of sensors, the automatic level calibration and many more features affording ease of operation make it possible to make do with a minimum of operating controls. Thanks to the clear arrangement of the front panel, even unskilled staff can soon learn to operate the instrument.

Frequency setting. The whole range from 9 kHz to 30 MHz is covered without band switching, in 100-Hz/1-kHz or 10-kHz steps. The 6-digit LCD frequency display in crystal-controlled. The frequency setting is retained in a memory even while the instrument is switched off.

Sensitivity, level switching. The measurement range for sinewave signals of $-30 \text{ dB}\mu\text{V}$ to $+137 \text{ dB}\mu\text{V}$ is determined at the lower limit by the inherent noise at 200 Hz IF bandwidth and at the upper limit by the maximum dissipation in the RF attenuator. Sensitivity is set for the RF and IF sections using attenuators with 10-dB steps, see front panel section.



Front panel section with controls for level, bandwidth, weighting and display

In the AUTO position of the IF attenuator, the IF gain is automatically controlled as a function of bandwidth and display mode in such a way that the receiver's internal noise is always below 0 dB on the display.

Bandwidths, signal weighting. IF bandwidth is switchselected at 10 kHz, 2.4 kHz, 500 Hz or 200 Hz. The signal weighting mode can be switched to average or peak with different hold times (e.g. 3 s) or noise weighting in line with CISPR.



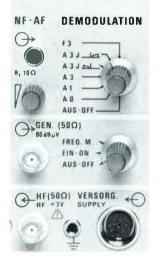
ESH 2 = Test receiver

Level indication. The meter has a linear range of 20 dB and two logarithmic ranges of 40 and 60 dB. The measured level is obtained from the meter indication and the digital reference value displayed in the same line, e.g. $-20 \text{ dB}\mu\text{V}$ in the photo on page 223.

Overload indication. If one of the stages in the metering path of the receiver is overloaded the reference-value display flashes. This indication operates with sinewave noise as well as with pulses.

Internal calibration, battery check. Automatic calibration, initiated at the push of button or when the bandwidth is changed, guarantees reproducibility of the measurements and ease of operation. In the case of battery operation the state of charge of the batteries can also be checked at the push of a button.





Front-panel section: demodulation and AF settings; output for calibration signal and frequency measurement; RF input and power supply connection

Signal demodulation, outputs. The ESH 2 is designed for a multitude of signal waveforms including SSB and frequency modulation: it can be switched to N0N, A1A, A1B, A3E, J3E, formerly A0, A1, A3, A3J (upper or lower sideband) and F3E as well as G3E. Numerous outputs are provided for signal evaluation, recording or plotting:

- wideband output at 1st IF (75 MHz) for the connection of a panoramic display
- narrowband output at 30-kHz IF for the connection of an oscilloscope
- AM and FM demodulator outputs
- outputs for the connection of recorders for level and frequency offset

The power supply is either direct from a 12-V source, from the 12-V battery pack (delivered without batteries), from a 24-V supply (additional adapter required) or from the local AC supply via the power supply unit (safety class II; see photo on the right), which can at the same time recharge or tricklecharge the 12-V battery.

Description

The Test Receiver ESH 2 is a triple heterodyne receiver covering the receiving range from 9 kHz to 30 MHz by means of 16 RF filters, the first 14 of which are fixed-tuned and the upper two tracking with the receive frequency via varicaps. The intermediate frequencies are 75 MHz, 9 MHz and 30 kHz. The signal to be measured passes from the RF attenuator, which is adjustable in steps of 10 dB and through which the calibration signal is fed in during calibration, via the filter group to the first mixer, where it is converted to the first IF of 75 MHz by a synthesizer.

After passing through a crystal filter of 10 kHz bandwidth the signal is converted from 75 MHz to 9 MHz. Two further crystal filters, which can be switch-selected, provide bandwidths of 2.4 kHz and 500 Hz. The following 9-MHz amplifier contains the control element for the nominal gain of the receiver with automatic calibration. After conversion to the last intermediate frequency of 30 kHz the signal is amplified in a 40-dB amplifier, this range being adjustable in 10-dB steps. The IF bandwidth can be decreased to 200 Hz using a mechanical filter. The signal passes through a logarithmic or a linear amplifier with an active demodulator or undergoes interference weighting according to CISPR Publicatoin 1 or 3, depending on the selected indicating mode. A second, independent 30-kHz IF amplifier with AGC operates in parallel with the indicating branch into a demodulator for AM, SSB and FM.

Construction

Even though heavy shielding is provided, this compact receiver weighs only 20 kg. The modern cassette design, using primarily plug-in PC boards on a motherboard, makes the ESH 2 very easy to service, whilst at the same time the interior space of the receiver is optimally utilized. The use of high-grade components and the low self-heating as a result of the moderate power drain (approx. 12 W in battery operation) further cut down the failure expectancy of the receiver. A plastic cover may be put on the front or rear panel to protect the receiver during transport or when it is being operated outdoors.





HF TEST RECEIVERS 7

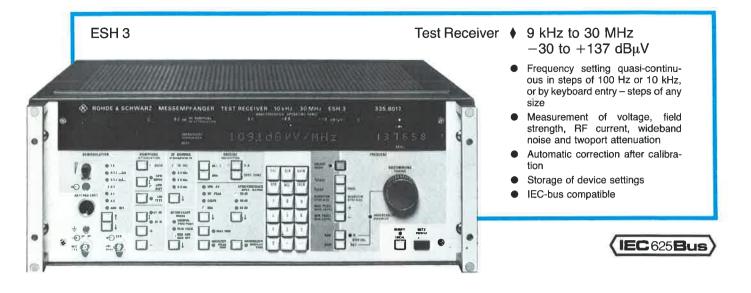
RFI	Input. VR with	BF attenuatio	on ≥10 dB	Z _{in}	= 50 C	2, BNC female	9	
	with	RF attenuation	on 0 dB \dots	<2				
W	ith RF a	attenuation 0 c	B	130	dB _µ V			
b.f.a.	· · · · · · · · · · ·	attenuation ≧1 oulse energy i enuation ≧20	10.1					
Osc	illator r	eradiation	dB	1 m <0	nWs dBμV			
9	to <15	out filters 0 kHz		bar	Idpass	filters		
1!	50 kHz	to <10 MHz . 0 MHz		13	suboct	ave filters		
2	0 to <3	0 MHz		trac	king fil	iter		
		e immunity, uency rejectio				tup 100 dB		
IF re	ejection	**		. >1	00 dB,	typ. 110 dB		
NON	Ineanu		spacing ≥4	10 k⊢	lz)			
Туре	э	Signal	ncy range 1 S/N	150 k	Hz to :	30 MHz Intercept poi	nt	
		level dBμV	ratio dB			(guaranteed) dBm	typical dBm	
a)	k ₂	100	>55			+47	+60	-
	d ₂ d ₃	100 90	>50 >65			+43 +15	+55 +20	
b)		100	>80			+73	+100	
	d ₂ d ₃	100 100	>60 >53			+53 +20	+75 +25	
Cros	smodu		/00			+20	+25	
Ar	n interfe	ring signal wit				Hz spaced >1	00 kHz	
at	a level	duces 3% mo						
	eakage ariation	of indication a	at a field					
sti	rength	of 10 V/m (with	$f \neq f_o$)	. <1	dB			
		te frequencie						
IF ba	andwid	ths (for avera	age and pe	ak)				
Nom	iinal Iwidth			3-di		6-dB	6:60-dB	
					dw.	(±10%)	ratio	
200	Hz²) Hz			160	Hz ³) Hz ³)	200 Hz 630 Hz	≈1:5 ≈1:5	
2.4 k	Hz			2.4	kHz	2.6 kHz 9.5 kHz	≈1.1.8	
IF ba	andwidt	h (-6 dB) for		8 KH	1Z°)	9.5 KHZ	≈1:2.4	21
		nts acc. to CI and VDE 087		0.2	kHz/9	kHz		
			-			switchover)		
		ise a (f _{in} >50						
Aver Peak	age	B = 200 Hz $B = 200 Hz$		typ.	-30 d	BμV BuV		
CISE	PR 1	B=9 kHz	Z INTERACION	typ.	-6 d	Βμν		
CISF		B = 200 Hz noise indicatio						
		kHz, B = 200		dBA				
				20-	122	Guaranteed v	alues	
				10-	~	×.		
				0	Typ,	-	Ť.	
	ige rar	ige		.04	9 20	30 40 50	kHz	
	er limit 3 above	internal noise	level)	see	interna	al noise		
Uppe	er limit .			137	dB	to <−6 dBµ\	,	
Volta	ige indi	cation		mov	ing-coi	io <-6 αθμν il meter,		
		ges, linear		swit	chable	back-lighting		
		logarithm	ic	40 c	B/60			
Туре	s of ind	battery cl	neck .	tolei avei		narker		
				pea	k 🌷	Rehold time		
						3 s hold time bl. 1 & 3)		
		cation error n. 20 dB						
Vin	>16 d	B above inter		<1	dB			
		rror of log. co		<2	dB			
			- 1					
1)								
Dro	vided t	o improve the	setting ac	curao	w. 1	5 MHz or 10 M		
²) Re	duced a	accuracy whe	n measuring	g sine	waves	at 200 Hz bai	ndwidth	
lac	Iditiona	measuring el	(BD C.5 0B)	uue	to rece	iver tuning in s	acha oi	

Calibration generator	
Calibration generator Average/Peak CISPR	sinewave generator
Types of demodulation	Non, A1A, A1B, A3E, J3E, F3E, G3E; A0, A1, A3, A3J (LSB, USB), F3
Outputs Sig. generator EMF (ref. voltage, can be switched off)	86 dBuV ±0.5 dB: 50 Q
Connector for antenna supply	BNC female connector
AF signal, adjustable	up to 3.5 V; 10 Ω; jack JK 34 50 Ω; BNC female connector <12 ±3 dB, bandwidth corresponds
IF 30 kHz EMF at fs	to RF bandwidth 1 kΩ; BNC female connector 2 V, bandwidth corresponds
AM demodulator	to IF bandwidth 10 kΩ; BNC female connector 1 V at 100% mod.
EMF	±0.5 V for 5 kHz deviation 50-pole Amphenol female connector
Frequency offset Level 1 in average, peak modes in CISPR	± 5 V for ± 5 kHz offset; 10 kΩ +5 V for fs
Level 2	10 kO output impodance in all modee
Reference frequency input	
General data	
Rated temperature range	 -10 to +45 °C -25 to +70 °C (without batteries) -10 to +60 °C (with batteries)
Power supply	either via power supply unit or from battery pack, see photo on the left
	110/125/220/235 V +10/-15%, 47 to 420 Hz (60 VA);
Battery pack	VDE 0411 safety class II (DIN 47411) +12 V, 8.5 to 9.5 Ah, operating life ≈4 h per charge
Battery input	4-pole special socket supply: +10.8 to +14.5 V/≈1 A
Charging input	4-pole special socket
Ordering information	
Order designation	Test Receiver ESH 2 303,2020,52
Accessories supplied	
Recommended extras	50-pin Amphenol male connector
For interference measurements:	
RF Current Probe	
Aktive Probe (9 kHz to 30 MHz, high impedance) Passive Probe	
(9 kHz to 30 MHz, VDE 0876) Artificial Mains Network	. ESH 2-Z5 338.5219.52
(9 kHz to 150 kHz/30 MHz, VDE 08 Pulse Limiter	. ESH 3-Z2 357.8810.52
For field-strength measurements (de Rod Antenna	
Loop Antenna	HFH 2-Z2 335.4711.52
Tripod Inductive Probe	HFU-Z . 100.1114.02
Roof-mounting Kit (for Loop Antenna HFH 2-Z2)	
General: Headphones 24-V Adapter	110.2959.00 ESH 2-Z4 338.4512.02
6-V Lead-acid Storage Battery 9.5 Ah (2 required) 19" Adapter	338.4012.00
Protective Cover for front or	ESH 2-Z7 338.4112.00
rear panel (2 recommended)	ESH 2-Z8 303.2065.00
XYT Recorder ZSKT	
sensitivity <10 mV into 50 Ω , e.g. P	M 6676/04 from Philips
For operation with other type of artit Attenuator	

(addition 100 Hz. ³) ±20%.

7 HF TEST RECEIVERS

test receivers



The automatic **Test Receiver ESH 3** which measures and demodulates AM double-sideband, single-sideband, pulse-modulated and FM signals as well as interference in the range of 9 kHz to 30 MHz is suitable for manual and programmed use as a

- selective RF voltmeter (in conjunction with a current probe, it can also measure RF currents in the range 0.1 to 30 MHz)
- field-strength meter in conjunction with the test antennas of the HFH 2
- building block in automatic test systems.

The ESH 3 has the same RF, IF and demodulator circuits as the ESH 2 (pages 222 to 225); it thus features the same excellent characteristics and covers the same fields of application. In addition, the ESH 3 is equipped with microcomputer circuitry and an evaluation unit, which make it a versatile, intelligent test receiver with a maximum of **operating convenience.**

Extended signal evaluation capabilities and **extra features** and **functions** characterize the ESH 3:

- Digital level indication in selectable units
- Measurement of frequency offset, frequency deviation and modulation depth
- Automatic ranging (for low noise or low distortion) or presetting of RF and IF attenuation
- Tuning in programmed steps, e.g. 9-kHz channel pattern or for harmonic measurements
- Automatic scanning with data output to printers or recorders (XY, YT or radiomonitoring recorder)
- Storage of last and nine additional device settings even when the unit is switched off or the supply interrupted

- Automatic correction after calibration, ensuring full measurement accuracy at all frequencies, IF bandwidths, display modes and types of demodulation
- IEC-bus interface for computer control

Further characteristics, uses

The ESH 2 is ideal when only manual operation is required and portability and battery-power capability are wanted; the ESH 3 comes into its own when automation is needed to improve efficiency, when **computer** control is required and the maximum versatility in terms of measurement functions is important.

In conjunction with the Programmable VHF-UHF Test Equipment MSUP (page 249) and the new Test Receiver ESVP (page 238), signals and interference can be measured automatically in the range 9 kHz to 1 or 1.3 GHz in accordance with the relevant international regulations.

The antennas, the RF current probe, the probes and the artificial mains network available for the ESH 2 can also be used with the ESH 3.

Selective voltage measurement. For use in the laboratory and test department for measurements on signal generators (level of fundamental, harmonics and non-harmonic spurious signals, sideband noise, frequency deviation and modulation depth); twoport measurements (filter attenuation up to >100 dB, gain up to 57 dB) with automatic recording of frequency response with an XY recorder; amplifier measurements (frequency response, noise figure, overdrive capacity, intermodulation and crossmodulation characteristics).

Field-strength measurement. Propagation and coverage measurements are possible in conjunction with the rod, loop and probe antennas of the HFH 2 (page 251).

In radiomonitoring the ESH 3 can be used to measure: field strength and range of fluctuation of field strength with max./ min. indication, frequency (remote measurement with add-on frequency counter), frequency offset, frequency deviation and modulation depth.

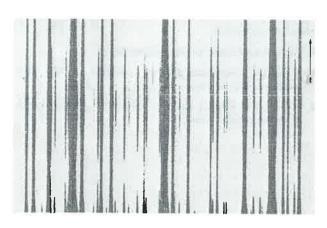
HF TEST RECEIVERS 7

Data-logging capabilities in radiomonitoring

- 1. Output of all measured data to a printer via the IEC-bus interface with the ESH 3 in the talk-only mode.
- Recording of amplitude spectrum on a XY recorder. The values entered for start and stop frequencies and minimum and maximum levels determine the end values of the scales.
- Long-term recording of frequency-band occupancy using the R&S Radiomonitoring Recorder ZSG 3. One ESH 3 permits up to five different frequency bands with different recording thresholds to be constantly observed and their occupancy to be recorded on five ZSG 3 recorders; see recording below.



Automatic interference-voltage measurement with programmed phase-switching: Test Receiver ESH 3, Artificial Mains Network ESH 2-Z5, Process Controller PUC and Code Converter PCW



Recording of frequency-band occupancy using Test Receiver ESH 3 and Radiomonitoring Recorder ZSG 3 $\,$

Radio-interference measurements in line with CISPR Publ. 1 and 3 and VDE 0875 and interference measurements complying with MIL standards and VG regulations are possible with the following special weighting modes:

CISPR: The weighting complies with CISPR 3 in the frequency range 9 to 149.9 kHz and with CISPR 1 in the range 150 kHz to 30 MHz.

> Combining the receiver with the Artificial Mains Network ESH 2-Z5 forms a test assembly for **radio interference voltage measurements** in line with CISPR.

MIL: For the measurement of wideband noise according to MIL standards and VG regulations the MIL mode applies. The bandwidth correction values are automatically taken into account and the results are indicated in dBµV/MHz or dBµV/m MHz for field strength and dBµA/MHz for current.

When using the (four-wire) Artificial Mains Network ESH 2-Z5 the Code Converter PCW can be employed for computercontrolled phase switching. Use in computer-controlled test systems. Computer control proves the optimum solution when, for example, extended data-logging capabilities or special methods of evaluation are required or when irregularly distributed test frequencies call for different IF bandwidths, classes of demodulation, display modes, etc.

Operation, functions

The front-panel **controls** of the ESH 3 are arranged in an easy-to-understand way in spite of the multitude of functions, and logically organized according to frequency, display mode, IF bandwidth, attenuation (sensitivity) and demodulation.

A 13-digit alphanumeric display facilitates data entry (frequencies, measuring times, limit levels) and reads out the measured results. In addition, the analog value of the input voltage is indicated within the limits of the demodulator operating range by a row of LEDs. Another LED row indicates the frequency offset, see detail photo below.



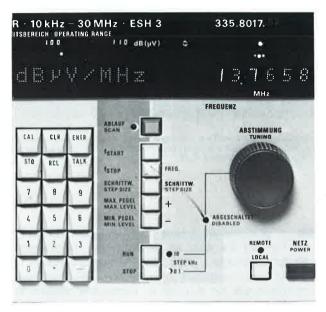
Front-panel section with frequency display and alphanumeric display, e.g. for results of measurements

All active functions are indicated by LEDs. If serious operating errors are made, or when a fault occurs in the main modules, an error message is issued with an error code. The end of long-term tests is indicated by a buzzer.

7 HF TEST RECEIVERS

test receivers

ESH 3 - Test Receiver



Front panel section with controls for frequency entry and recall

Frequency setting or frequency entry can be carried out in different ways:

- 1. with tuning knob in steps of 100 Hz or 10 kHz (quasi-continuous)
- 2. at a keystroke in steps of any preset size, e.g. in 9-kHz steps, or in steps of the width of the fundamental frequency to measure harmonics
- 3. by keyboard entry
- 4. by automatic frequency scanning over up to five subranges, with any desired preset start and stop frequencies and step sizes.

Tuning is facilitated by a calibrated offset indication. The last, and nine further complete device settings can be stored.

Sensitivity, measurement ranges. The voltage range in the average mode extends from -30 to +137 dBµV. Frequency offset is indicated – depending on IF bandwidth – from -5 to +5 kHz, frequency deviation from 0 to 5 kHz; modulation depth can be measured from 0 to 100% and gain from -110 to +57 dB.

Calibration. Two different calibration processes are initiated depending on whether the calibration button is pressed for a shorter or longer period:

- 1. Check and, if necessary, correction of level and frequency-offset calibration
- Measurement of all the calibration correction values that do not vary with time, for frequency response, IF bandwidth, logarithmic amplifier and detector – and storage in a non-volatile memory.

Output of results. The measured value is converted into a level with or without logarithmic conversion; RF and IF attenuation, all correction values and transducer conversion factors – if applicable – are added and conveyed together with their physical unit to the alphanumeric display and the IEC-bus interface.

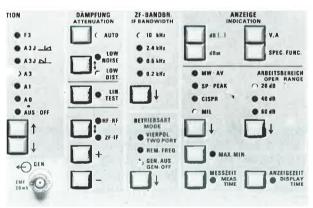
A 24-pole output permits the connection of three types of recorders XY, YT and radiomonitoring recorders. The ESH 3 automatically adjusts to the recorder type connected by selecting the required drive to the A/D converter.

The IEC-bus interface is provided with all the listener and talker capabilities covered in the standard: the limited capabilities of the widely commercial available controllers have, however, also been taken into consideration. For example, it is also possible to use computers without serial-and parallel-poll capability.

Computer control of the ESH 3 via the IEC bus provides the following capabilities:

- Execution of complex test programs
- Automatic evaluation of large quantities of data from various points of view
- Use of the ESH 3 together with other programmable measuring instruments.

Front-panel section with operating controls for display, IF bandwidth, mode, attenuation and demodulation



Specifications of ESH 3	
Frequency range	9 kHz to 29.9999 MHz 1. quasicontinuous with knob in steps of 100 Hz or 10 kHz 2. keyboard entry 3. in steps of any preset size 4. automatic scanning
Indication Resolution Setting error ¹)	. 6 digit LED display
RF Input VSWR	Z_{in} = 50 Ω, BNC female connector <1.2 with RF attenuation ≥10 dB <2 with RF attenuation 0 dB

HE TEST RECEIVERS

Osci	lator rer	adiatior			<1 μV				
Maxi wil	mum in th RF at	put volta tenuatio			3 V =	130 d 137 d	IBµV IBuV		
			nity, non				.041		
Imag		ency rej	ection		. >100 0		p. 120 dB		
		s:a)Fı (≧	equency 40 kHz	range off carr	10 to 15 ier)	50 kH:			
Туре		Signal	equency	s/N	150 KH2		cept point		
_		level dBμV		ratio dB		guara dBm	anteed	typical dBm	
a)	k2 d2 d3	100 100 90		>55 >50 >65		+30 +25 +15		+45 +40 +20	
b)	k ₂ d ₂ d ₃	100 100 100		>80 >60 >52		+75 +55 +20		+100 +75 +25	
An sp	smodula interfer aced >	ence si 100 kHz	gnal of m	n = 30° roduce:	s 3% m	n = 1 odulat			
1st IF	mediate				. 75 MH	z			
2nd I 3rd II	F			 	. 9 MH . 30 kHz	z			
IF b		ths (for	average	and p	eak) 3-dB		6-dB	6.0	0-dB
	width				bandw (±10%		bandw. (±10%)	ratio	
200 H	−lz ²)	· · · « ·		****	160 Hz	3) 3)	200 Hz 630 Hz	* 1	
2.4 k	Hz				2.4 kH	z	2.6 kHz 9,5 kHz	≈ 1	1 8 2 4
IF ba meas	ndwidth suremer	n (-6 dl nts acc.		4	0.2 kH				
(1 00			20070 .				witchover)	
Inter Avera		se a (f _{in}	>50 kH B = 200		tvo –3	80 dB	υV		
Peak	R 1		B = 200 B = 200 B = 9 B = 200	Hz kHz	typ2 typ6	22 dB dB	μV μV		
			ication . = 200 Hz						
					dB a				
					20- 4	< ^G	uaranteed	l values	
					10- Typ	~	-		
					9	40	30 40	50 kHz	
Meas Volta	uremer ae	nt range	95						
Lov	ver limit		level)		see inte	ernal	noise		
			• • • • • • • •			IBμV;			
Me	asurem	ent erro	r		146 dB				
ave	erage, 2	0 dB					V _{in} ≧16 di		
					IF band	fwidth	e Iz, depeno 1		
Frequ	iency de	eviation			0 to 5 I	Hz, c	tepending	on	
	odulatio		1			0%			
Indic	ation of	measu	ired valu	e vin			anumeric o e and unit		
					ment fo	r leve	l, frequention depth	cy offset	, devia-
Level dig	ital in dE						olution 0.1		
ana	in µ\ ≊log .	/, mV et			row of	31 LE tecto	blution 1 L Ds within r, with digi laries	operating	
im	prove th	e settin	a accura	CV			or 10 MH		
²) Re (ad	duced a	ccuracy	when m	easurir	ng sinew) due to	aves a receiv	at 200 Hz ver tuning i	bandwid in steps	lth of

100 Hz. ³) ±20%.

Operating range of IF detector 20, 40, 60 dB Indicating modes average, peak average, peak CISPR (Publ. 1 & 3) broadband noise acc. to MIL stand. max./min.levels over preset period of observation Frequency offset digital in kHz analog Frequency deviation in kHz Modulation depth in % 3 digits, resolution 10 Hz row of 16 LEDs 3 digits, resolution 10 Hz 2 digits, resolution 1% 4 digits, resolution 0.1 dB Gain in dB Classes of demodulation lasses of demodulation NON, A1A, A1B, A3E, J3E, F3E, G3E Former designations FM, A0, A1, A3, A3J (USB, LSB), F3 Outputs Generator (ref. voltage, can be switched off) 86 dBµV ± 0.5 dB; 50 Ω, BNC female connector
 Connector for antenna supply and antenna coding
 12-pole Tuchel female μ to 3.5 V, 10 Ω; jack

 IF 75 MHz
 50 Ω, BNC female con-transition
 up to 3.5 V, 10 Ω ; jack JK 34 50 Ω , BNC female connector Gain (input at 0 dB) 12 \pm 3 dB, bandwidth corresponds to RF bandwidth 1 k Ω , BNC female connector 2 V, bandwidth corresponds to IF IF 30 kHz EMF at max. analog indication bandwidth AM demodulator 10 kΩ, BNC female connector EMF FM demodulator EMF 10 kΩ, bNC female connector 10 kΩ, BNC female connector \pm 0.5 V for 5 kHz deviation \pm 5 V for 5 kHz deviation \pm 5 V for 5 kHz offset Z_{out} = 10 kΩ, BNC female connector 0 to +5 V between boundaries of capalog indication Frequency offset Analog level output 1 (average, peak, MIL) CISPR Analog level output 2 (CISPR) Analog level output 1 Recorder output Reference frequency input 5/10 MHz, switch-selected; required EMF: 1 V across 50 Ω interface according to IEC 625-1, 24-pole Amphenol connector; functions: AH1, L4, SH1, T5, RL1, SR1, PP1, DC1, DT1, C0 Remote control General data +5 to +45°C −25 to +70°C 115/125/220/235 V ±10% 47 to 440 Hz (70 VA) 492 mm×205 mm×514 mm, 25 kg Rated temperature range Storage temperature range Power supply Dimensions, weight Ordering information eiver ESH 3 1.52 0

•	
Order designation	Test Rece 335,8017.
Accessories supplied	
Recommended extras	

For interference measurements		
RF Current Probe	ESH 2-Z1	
Active Probe	ESH 2-Z2	299.7210.52
Passive Probe	ESH 2-Z3	299.7810.52
Artificial Mains Network		338.5219.52
Pulse Limiter		357.8810.52
For field-strength measurements (de	tails on pag	ges 230 to 233):
Rod Antenna		
Loop Antenna		
Inductive Probe		
General:		110 0050 00
Headphones		110.2959.00
Recorders:		
XY Recorder ZSK 2		
XYT Recorder ZSKT Radiomonitoring Recorder ZSG 3		

7 ESH 2/ESH 3 ACCESSORIES

Accessories for the Test Receivers ESH 2 and ESH 3 for field-strength and radio-interference measurements

Overview

Designation				Measur	ements (app	lication)	
		Page	Current	Voltage high-imp.	Field electric	strength magnetic	Radio interference
Measuring aids for ESH 2 and	ESH 3						
Rod Antenna	HFH 2-Z1	231			•		•
Loop Antenna	HFH 2-Z2	231				•	•
Loop Antenna	HFH 2-Z3	232				•	•
Inductive Probe	HFH 2-Z4	232				•	•
Clamp-on RF Current Probe	ESH 2-Z1	230	٠				•
Active Probe	ESH 2-Z2	231		•			•
Passive Probe	ESH 2-Z3	231		•			•
Artificial Mains Network	ESH 2-Z5	233					•
Attenuator	ESH 2-Z11	233					•
Pulse Limiter	ESH 3-Z2	233					•
Tripod	HFU-Z	233				•	•
×							
Other accessories			for use wi	th			
24-V Adapter	ESH 2-Z4	233	ESH 2 and	ESV			
Roof-mounting Kit (for Loop Antenna HFH 2-Z2)	HFH 2-Z5						

Current measurements

Clamp-on RF Current Probe ESH 2-Z1

Selective or broadband measurements of both very small and very large RF currents on conductors are easy to perform with the aid of the ESH 2-Z1. It is shielded against electrostatic effects and built to VDE standard.



Specifications
Frequency range
Measurement range using ESH 2/ESH 3 (IF bandwidth 200 Hz, average-value indication)
Lower limit (frequency-dependent)
Transfer admittance
Max. permissible current with t >10 kHz 10 A f<500 Hz 50 A Max. diameter of conductor under test 13.5 mm
General data
Rated temperature range -10 to +55°C Storage temperature range -25 to +70°C RF connector BNC male
Termination
Coding plug (conversion factor) 12-pole Tuchel-type Dimensions (diameter/height) 55 mm/20 mm Weight
Order designation Ciamp-on RF Current Probe ESH 2-Z1 338.3516.52
¹) Conversion factor = logarithm of the ratio between the output voltage and the input current; automatically taken into account in the readout on the ESH 2 and ESH 3.

ESH2/ESH3 ACCESSORIES 7

High-impedance voltage measurements

Active Probe ESH 2-Z2/Passive Probe ESH 2-Z3

For high-impedance measurements of, say, narrow-band wanted signals on lines or narrow-band or broadband interference signals at the receiver input or antenna cabling, use of shielded probes is recommended. They contain internal high-pass filter sections to reject supply voltages.

The **Active Probe ESH 2-Z2** is designed for measuring AC voltages over the frequency range 9 kHz to 30 MHz on lines that do **not** carry AC supply voltage.

ESH 2-Z2



The **Passive Probe ESH 2-Z3** (to VDE 0876 standards) is particularly suitable for measuring radio interference voltages on, for example, AC-supply-voltage-carrying lines.

Specifications		
	ESH 2-Z2	ESH 2-Z3
Frequency range		30 MHz
Attenuation ¹)	10 dB	40 dB
Attenuation error $(Z_{source} = 50 \Omega) \dots$	<1 dB	<1 dB for
(2source - 50 12)		f = 30 kHz to 30 MHz
		<+1/-2 dB for
B.d		f = 9 kHz to 30 MHz
Measurement range using ESH 2/ESH 3		
(IF bandwidth 200 Hz,		
average value indication)		
Lower limit (frequency-dependent)		+10 dBuV, approx.
(nequency-dependent)	approx.	TTO ODAY, approx.
Upper limit	120 dBμV	154 dBµV
Input impedance	118 kΩ ±5% shunted by 8 pF	
	shunled by 8 pr	(with 50-Ω termination)
Max. input voltage for f <500 Hz		(A.C
for f <500 Hz	. 3 V	250 V
for $f = 9 \text{ kHz}$ to 30 MHz	3 V	50 V
Order designation		
	ESH 2-Z2	
Assessming supplied	299.7210.52	299.7810.52
Accessories supplied Accessories kit		
Probe tip		
Recommended extras		
BNC Adapter URV-Z	. 241.	1110.02
Dito Adapter UNV-2	. 241.	1110.02
1) Automatically taken into acc	ount in the readout	on the ESH 2 and ESH 3
, rational only taken into act	ount in the readout	on the correcting correction.
the second se		

Field-strength measurements

Active Probe ESH 2-Z2 with accessories; the Passive Probe ESH 2-Z3 includes an additional probe tip with hand guard

Rod Antenna HFH 2-Z1, Loop Antenna HFH 2-Z2

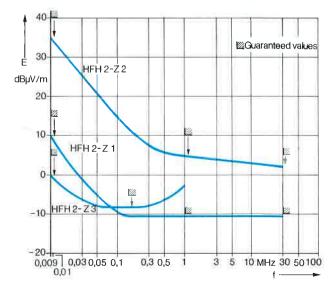
HFH 2-Z1 • Broadband active Rod A antenna and for measur HFH 2-Z2 • Active Loop Antenna HFH 2-Z2 for measuring the magnetic field-strength component

Broadband active Rod Antenna HFH 2-Z1 for use as a general-purpose receiving antenna and for measuring the electrical field-strength component

Data on page 232

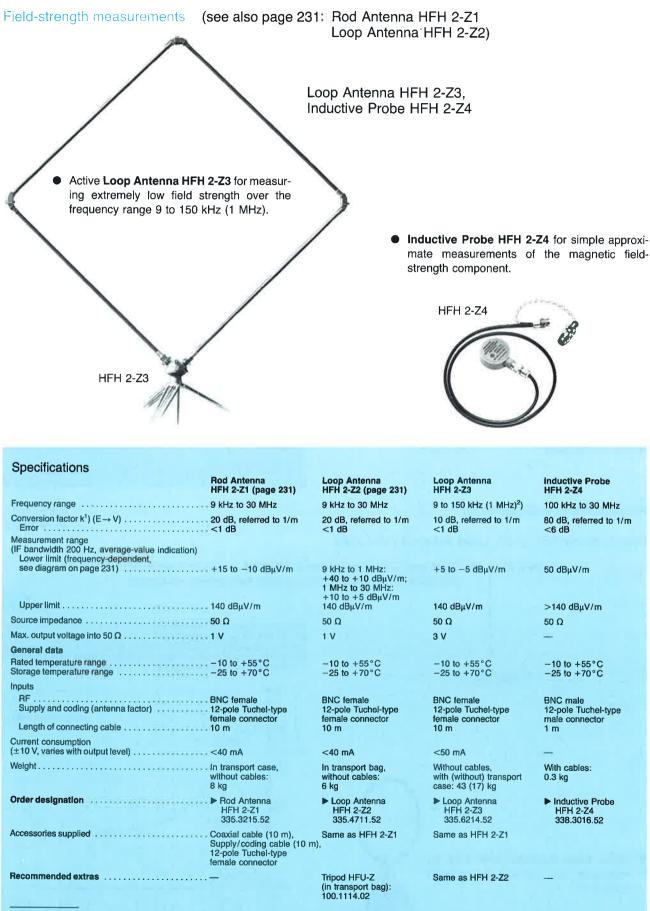
HFH 2-Z1 HFH 2-Z2

Minimum measurable field-strength level (for S/N = 1) of the antennas HFH 2-Z1, -Z2 and -Z3 as a function of the frequency (average-value indication and 200 Hz IF bandwidth). In the CISPR indicating mode the minimum measurable field-strength goes up by about 6 dB over the range, 9 kHz to 149.9 kHz (CISPR 3) and about 23 dB over the range 150 kHz to 30 MHz (CISPR 1)



7 ESH2/ESH3 ACCESSORIES

test receivers



¹) Conversion factor = logarithm of the ratio between the output voltage and the input field strength; automatically taken into account in the readout on the ESH 2 and ESH 3.

²) The antenna can be used up to 1 MHz without any derating of performance data.

ESH2/ESH3 ACCESSORIES 7

Interference measurements

Artificial Mains Network ESH 2-Z5

For interference measurements on AC-supply-dependent loads a circuit must be provided to ensure that the AC supply voltage is supplied to the test item, on the one hand, and, on the other hand, that the AC supply represents a defined source impedance for the test item, that interference from the AC supply does not reach the test circuit, and that the defined interference voltage produced by the test item can be connected to a test receiver suitable for radio interference measurements, such as the ESH 2 or ESH 3.

The Artificial Mains Network ESH 2-Z5 meets the requirements laid down in VDE 0876 and CISPR 3. It uses aircored coils and contains an artificial hand and a choke to suppress interference on the ground line. A built-in blower with a separate AC supply provides automatically controlled cooling or continuous cooling, as required.

ESH 2-Z5



For integration in an IEC-bus system the Artificial Mains Network ESH 2-Z5 can also be remote controlled using a code converter, such as the PCW from Rohde & Schwarz.

Other accessories

24-V Adapter ESH 2-Z4

The ESH 2 as well as the ESV can be powered from a 24-V DC mains supply via the 24-V Adapter ESH 2-Z4 which may be mounted at the rear of the receiver in the place of the power supply or battery pack.

Specifications
Input voltage range (protected against reversal of polarity) +18 to +32 V Input connector (mating connector is supplied with the ESH 2-Z4) 6-way male standard
Output voltage range +12.5 V ±0.5 V Output connector 4-way female special Maximum output current (short-circuit-proof) 1.8 A
Rated temperature range -10 to +45 °C Storage temperature range -25 to +70 °C Dimensions (W×H×D) 205 mm×172×50 mm Weight 1 kg
Order designation > 24-V Adapter ESH 2-Z4 338.4512.02
Accessories supplied Mating connector, female 018.6946.00

ESH 2-75 ESH 2-Z11/ESH 3-Z2

Other accessoires for use in radio-interference measurements are listed in the table on page 230, for example

Attenuator ESH 2-Z11 and Pulse Limiter ESH 3-Z2.

They are recommended to protect the receiver's internal attenuator from excessive AC supply interference when working with the Artificial Mains Network (see specifications).

Specifications
Frequency range 10 to 150 kHz (30 MHz) Equivalent circuit (to VDE 0876) $(50 \ \mu H + 5 \ \Omega)$ shunted by 50 Ω Error limits (to VDE 0876) $\pm 20\%$ Continuous-rated output current $4 \times 25 \ A$ Max. instantaneous output current $4 \times 20 \ A$ Cooling
Connectors AC supply inputs 4×32 ACekon male
Blower connector
Remote control input 50-way Amphenol female Artificial hand telephone jacks General data Rated temperature range
Storage temperature range -25 to +70 ° C AC supply (blower) 220 V, 20 VA Overall dimensions (W×H×D) 492 mm×294 mm×603 mm Weight 25 kg
Order designation Artificial Mains Network ESH 2-Z5 338.5219.52
Accessories supplied Power cord, RF connecting cable, 50-way Amphenol male connector
Recommended extras (for automatic measurements) Code Converter PCW 244.8015.92 Process Controller PUC see Page 14 Attenuator ESH 2211, 349.7518.52
Pulse Limiter ESH 3-Z2

ESH 2-Z4 HFU-Z

Tripod HFU-Z

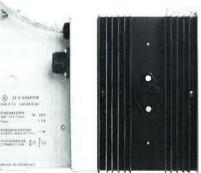
el P

is recommended for supporting the Loop Antennas HFH 2-Z2 and -Z3 (pages 231/232).

Order designation ► Tripod HFU-Z

110.1114.02

ESH 2-Z4



VHF-UHF TEST RECEIVERS

test receivers



The **ESV** is a manually operated, sensitive and overloadprotected test receiver offering a very wide dynamic range and maximum ease of operation. Compact construction, wide range of power supplies and low power consumption make the receiver suitable for use in fixed stations as well as for mobile and portable applications. The Test Receiver is available as model 52 (20 to 520 MHz) or as model 53 (20 to 1000 MHz).

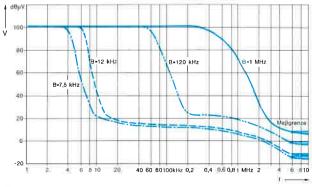
Thanks to its excellent characteristics and the availability of a wide range of accessories, the applications of the ESV include interference measurements and field-strength measurements.

Characteristics, uses (ESV alone)

The ESV needs no accessories to operate as a selective voltmeter (test receiver) with a level range from -10 to $+137~dB\mu V$, for example, for measurements in 50- Ω coaxial systems. Relative and absolute selective voltage measurements are possible even in the presence of a multitude of signals.

Automatic calibration at the push of a button and excellent receiver selectivity permit accurate measurements of closely spaced signals with very different levels, for example: adjacent-channel measurements, spurious-content and sideband-noise measurements on signal generators, intermodulation and distortion measurements, noise figure measurements. **Signal evaluation.** Four switch-selected IF bandwidths and numerous test outputs make it easy to carry out a wide range of measurements:

- wideband IF output of 10.7 MHz for the connection of a panoramic display or a wave analyzer
- narrowband IF output of 10.7 MHz for connecting an oscilloscope
- AM/FM demodulator outputs
- recorder output for level and frequency offset





Auxiliary instruments for additional applications

Interference measurement. Interference voltage, interference current and interference power can be measured in accordance with the relevant standards (CISPR, VDE, FCC, MIL, VG). The following accessories are available for this purpose:

VHF Current Probe ESV-Z1 (20 to 300 MHz)

Absorbing Clamp MDS-21 (30 to 1000 MHz; see p. 255).

In addition to the overload indication and automatic calibration, which have already been mentioned, the ESV has other features which are particularly important in interference measurements:

level indication taking into consideration frequency-independent conversion factors of the sensor, e.g. directly in $dB\mu A$,

peak indication with selectable hold time,

IF bandwidth of 120 kHz in line with CISPR,

scale range for measurements to CISPR: 10 dB, linear, IF bandwidths of 12 kHz, 120 kHz and 1 MHz in line with MIL.

Radiomonitoring. In conjunction with a receiving antenna the test receiver can be used in radiomonitoring, since it features excellent frequency accuracy and stability. It is capable of measuring and demodulating A0 (NON), A3 (A3E) and F3 (F3E) transmissions and comprises a squelch and a switchable AF filter.

Field-strength measurements. Completed by the following antennas the Test Receiver ESV becomes the Fieldstrength Meter HUF:

Broadband Dipole HUF-Z1 (20 to 80 MHz)

1

Log-periodic Antenna HL 023 A1 (80 to 1300 MHz), with mast, tripod and cable set

For radiomonitoring applications the HUF can be used to measure antennas, propagation and coverage. It features a field-strength measurement error of <3 dB complying thus with the CCIR Recommendation 378-1. Long-term field-strength variations can be recorded if a YT recorder is connected to the recorder output.

VHF-UHF TEST RECEIVERS

Ease of operation, setting functions

The correction of the level indication taking into account conversion factors of sensors, the automatic level calibration and many more logic functions make it possible to make do with a minimum of operating controls. Thanks to the clear arrangement of the front panel, even unskilled staff can learn to operate the instrument.

Frequency setting. The whole range from 20 to 1000 MHz is covered without band switching, in 1-kHz, 10-kHz or 100-kHz steps. The 6-digit LCD display is crystal-referenced. The frequency setting is retained in a memory even while the instrument is switched off.

Sensitivity setting. The measurement range for sinewave signals of -10 to +137 dBµV is determined at the lower limit by the inherent noise at 7.5-kHz IF bandwidth and at the upper limit by the maximum dissipation in the RF attenuator. Sensitivity is set for the RF and IF sections using attenuators with 10-dB steps, see front-panel section.



Front-panel section with controls for sensitivity, bandwidth, weighting and display

In the AUTO position of the IF attenuator, the IF attenuation is automatically controlled as a function of bandwidth and display mode in such a way that the receiver's internal noise is always below 0 dB on the display.

Bandwidths, signal weighting. If bandwidth is switchselected at 7.5 kHz, 12 kHz, 120 kHz and 1 MHz. The signal weitghting mode can be switched to average or peak with different hold times (1 s, 3 s) or noise weighting in line with CISPR.

7 VHF-UHF TEST RECEIVERS

test receivers

ESV - Test Receiver

Level indication. The meter has a linear range of 20 dB and two logarithmic ranges of 40 and 60 dB. The measured level is obtained from the meter indication and the digital reference value displayed in the same line, e.g. 40 dB μ V in the photo on page 235.

Overload indicator. If one of the stages in the metering path of the receiver is overloaded the reference-value display flashes. This indication operates with sinewave voltages as well as with pulses.

Internal calibration, battery check. Automatic calibration, initiated at the push of a button or when the bandwidth is changed, guarantees reproducibility of the measurements and ease of operation. In the case of battery operation the state of charge of the batteries can also be checked at the push of a button.





Front-panel section: demodulation and AF setting; RF input, squelch and power supply for Current Probe

Signal demodulation, outputs. The ESV is designed for a multitude of modulation types: it can be switched to A0, A3 (AF wide or narrow) and F3 (AF wide or narrow). Numerous outputs are provided for signal evaluation, recording and plotting:

- wideband IF output of 10.7 MHz for the connection of a panoramic display or a wave analyzer
- narrowband output of 10.7 MHz for the connection of an oscilloscope
- AM and FM demodulator outputs
- output for the connection of recorders for level and frequency offset

Thepower supply is either direct from a 12-V source, from the 12-V battery pack (delivered without batteries), from a 24-V supply (24-V Adapter ESH 2-Z4 required) or from the local Ac supply via the power supply unit (safety class II; see photo below), which can at the same time recharge or trickle-charge the 12-V battery.

Description

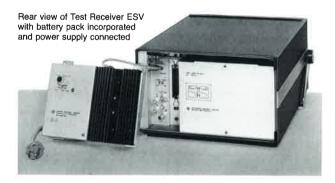
The ESV is a double heterodyne receiver with a phase-synchronized tuning oscillator. The input signal passes via an RF attenuator to one of nine bandpass filters (depending on input frequency) and then to a high-power ring mixer where it is converted to the 1st IF of 810.7 MHz (20 to <520 MHz) or of 310.7 MHz (up to <1000 MHz). The signal is then amplified and filtered in multi-section filter circuits. Another mixer stage produces the second IF of 10.7 MHz.

Further signal path: After filtering (crystal filters of 7.5, 12 and 120 kHz and LC filter of 1-MHz bandwidth), IF amplification (switchable in 10-dB steps) and rectification, the signal passes through circuits producing peak and average values and undergoes weighting to CISPR before it reaches the display.

An amplifier for monitoring AM signals and a limiter amplifier for FM signals are operative in parallel to this measurement and display section. Four demodulators permit reception of AM and FM signals with four different IF bandwidths.

Construction

Even though heavy shielding is provided, this compact receiver weighs only 20 kg. The modern cassette design, using primarily plug-in PC boards on a motherboard, makes the ESV very easy to service, whilst at the same time the interior space of the receiver is optimally utilized. The use of high-grade components and the low self-heating as a result of the low power drain (approx. 20 W in battery operation) further cut down the failure expectancy of the receiver. A plastic cover may be put on the front or rear panel to protect the receiver during transport or when it is being operated outdoors.



Specifications

	Models 52 and 53	Model 53
Frequency range	20 to 519.999 MHz	520 to 999.999 MHz
Frequency setting		th knob
Resolution (step width)	1, 10 or 100 kHz, s 6-digit LCD,	
Setting error Max. setting error	switchable back-lig 1 × 10 ⁻⁵	nting
(at 520 or 1000 MHz)	<5 kHz	<10 kHz

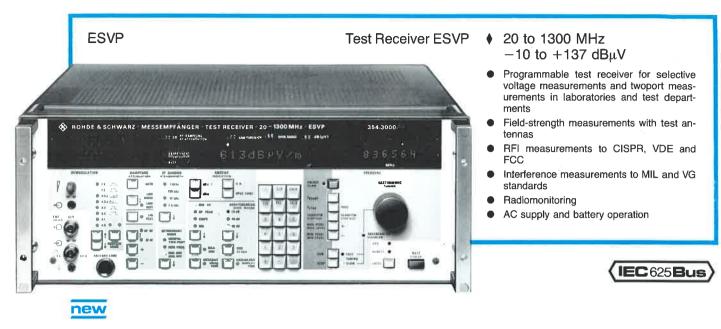
RF input VSWR with RF attenuation ≧10 dB	. Z _{in} = 50 Ω, N fem	ale connector
VSWR with RF attenuation ≥10 dB	. <1.2	
0 dB Oscillator reradiation Internal input filters	 <2 <10 dBμV 5 tracking filters 	<20 dBµV 4 tracking filters
Interference immunity, non-linear Image-frequency rejection	Ttles	
(1st IF)	>80 dB	>80 dB
IF rejection	typ. 100 dB	typ. 90 dB >80 dB
	typ 100 dB	typ. 90 dB
d ₃ intercept point	>+13 dBm	>+13 dBm
k2 intercept point	3 + 40 dBm	typ. +20 dBm >+40 dBm
	typ. +50 dBm	typ. +50 dBm
Blocking (typical, frequency-dependent) An interfering signal spaced >2 M influences the display of a signal (RF attenuation 0 dB) at a level of Shielding effectiveness Indication at a field strength	to be measured by if >110 dBµV	re frequency ≺1 dB
of 10 V/m (with f = 1st IF)	. <−5 dBµV	
(adjust $f = f_{interf.}$ for calibration)		
Intermediate frequencies		
1st IF 2nd IF	810.7 MHz	310-7 MHz 10.7 MHz
		1.0.7 10112
IF bandwidths (for average and pe	ak) –6 dB	6:60-dB ratio
Nominal -3 dB bandwidth (±20%) 7.5 kHz	(±10%)	0.00-0D ratio
7.5 kHz	8 3 kHz	≈1.2
120 kHz 110 kHz	120 kHz	≈1.2 ≈1.3
1 MHz 0.8 MHz	1 MHz	≈1.4
IF bandwidth (-6 dB) for measurements to CISPR		
(Publ. 2 and 4) and VDE 0875	120 kHz (automat	ically switched
	on with measurem	nents to CISPR)
AF bandwidth (-3 dB) narrow		
wide		
Internal noise (automatic on) Average B = 7.5 kHz	.<−10 dB _µ V	<-8 dBµV
Peak B = 7.5 kHz	typ14 dBµV	typ. −12 dBµV
CISPR	typ -4 dBµV	typ2 dBµV
		Lab. to delta
Voltage range Lower limit		F
(3 dB above internal noise level)	−10 dBμV	-8 dBµV
Upper limit		
(RF attenuation ≥10 dB) Inherent spurious responses	equivalent to < - 5	dBuV
Voltage indication	moving-coil meter	switchable
Scale ranges	back-lighting	
CISPR		
linear	20 dB	
logarithmic	tolerance range	
Types of indication	average	
	peak peak with 3 s hold	time
	CISPR (Publ. 2 a	
Maximum permissible input level RF attenuation 0 dB		
DC voltage	7 V	
Sinusoidal AC voltage Pulses (spectral density)	120 dBµV	
RF attenuation $\leq 10 \text{ dB}$	96 dBµV/MHz	
(no DC separation)		
DC voltage Sinusoidal AC voltage		
(at 10 dB/≧10 dB)	130 dBµV/137 dB	μV
Max. permissible pulse voltage Max. permissible pulse energy	100 V	
Voltage indication error		
average, linear, 20 dB, for an		
unmodulated sinewave signal,		
16 dB above noise indication B = 120 kHz, 1 MHz	<1.0 d0	
B = 7.5 kHz, 12 kHz	<15 dB	
peak, linear, 20 dB	same as average,	additional toler-
	ance for wideband urements	interference meas-
	. eento	

VHF-UHF TEST RECEIVERS 7

	Models 52 and 53 Model 53		
CISPR, linear, 10 dB (for impulsive interference)			
Additional error due to	<1.3 UD		
temperature effect at log 40 dB/log 60 dB	<1 dB		
Types of demodulation			
	A3E (A3) (AF wide or narrow)		
	F3E (F3) (AF wide or narrow) with and without carrier squelch		
Outputs			
Connector for supply and coding of accessories	12-note Tuckel female connector		
AF signal, EMF adjustable	up to 3.5 V, 10 Ω, jack JK 34		
IF 10.7 MHz wide (approx. 2 MHz) Gain (RF attenuation 0 dB)	50 Ω, BNC female connector		
Gain (RF attenuation 0 dB) .	7.5 dB		
EMF at fsd, lin.	100 mV		
AM demodulator EMF	1 V _m at 50% modulation		
3-dB bandwidth >0.3 MHz (dep	ending on IF bandwidth)		
FM demodulator EMF at IF bandwidths			
7.5 kHz and 12 kHz	±1 V _{pp} for ±1 kHz offset		
Recorder outputs	±1 V _{pp} for ±100 kHz offset 50-pole Amphenol female connector		
Frequency offset at			
7.5 kHz and 12 kHz	± 1 V for ± 1 kHz offset, Z _{out} = 10 kΩ		
120 kHz and 1 MHz	± 1 V for ± 100 KHz offset, Z _{out} = 10 kΩ		
Level 1 in average, peak modes, in CISPR	+4 V for fsd. B _e = 10 kO		
Level 2 in CISPR	output with lowpass filter		
	simulating meter response, to CISPR (2 and 4);		
	+2 V for fsd $R_s = 10 kΩ$		
Input for ext. reference frequency			
	across 50 Ω, sinewave, BNC female connector		
General data	bivo ternale connector		
Rated temperature range	-10 to $+45^{\circ}$ C -25 to $+70^{\circ}$ C (without bottories)		
Rated temperature range	-10 to +60°C (with batteries)		
Power supply	either via power supply unit or from		
AC power supply unit	115/125/220/235 V +10/-15%,		
	47 to 420 Hz (70 VA) VDE 0411, safety class II		
Battery pack	(DIN 57411)		
	operating life >3 h per charge		
Battery input	ext. battery +10.8 to 15 V. tvp. 1.8 A		
Dimensions	18 kg 19 kg		
with batteries	20 kg 21 kg		
Ordering information			
Order designation	Tast Bereiver ESV		
Test Receiver ESV, 20 to 520 MHz Test Receiver ESV, 20 to 1000 MHz	342.4020.52		
Accessories supplied	battery pack (without batteries) battery connector LEMO F. c 23046.7		
Programmends d	50-pin Amphenol male connector		
Recommended extras Options:			
Option 0.5 to 1 GHz (for model 52)	ESV-B2 353.6012.02		
For interference measurements: VHF Current Probe (20 to 300 MHz)			
Absorbing Clamp (30 to 1000 MHz) Adapter (BNC female to N male)	MDS-21 194.0100.50 118.2812.00		
For field-strength measurements:			
Broadband Dipole (22 to 80 MHz) Logperiodic Antenna			
(80 to 1300 MHz) Tripod	HL 023 A1 577.8017.02 HEU-Z 100 1114 02		
Tripod Mast (for tripod) RF cable (7 m)	HFU-Z 100.1120.02		
General:	HFU2-25 252.0055.55		
Headphones	110.2959.00		
Headphones . 24-V Adapter . 6-V Lead-acid Storage Battery 9.5 A 19" Adapter .	ESH2-Z4 338.4512.02 b (2 required) 338.4012.00		
19" Adapter	ESH2-Z6 338.4312.02		
Protoctive Cover for front or rear	ESV-Z2 353.7319.02		
panel (2 recommended)	ESH2-Z8 303.2065.00		
Recorders: XYT Recorder	ZSKT		

VHF-UHF TEST RECEIVERS

test receivers



The **Test Receiver ESVP** measures and demodulates AM double-sideband, single-sideband, pulse-modulated and FM signals as well as narrowband and wideband interference. High overload capacity, a wide dynamic range and manifold evaluation capabilities make the ESVP suitable for

selective voltage and twoport measurements - in automatic test systems too -

and all applications in the field of radiomonitoring and EMC measurements.

In its frequency-related characteristics and application capabilities the ESVP is very similar to the ESV (page 234), in measurement convenience, intelligence and system compatibility to the ESH 3 (page 226); its frequency range overlaps and extends that of the ESH 3.

Special features of ESVP

- Synthesizer; frequency resolution 1 kHz, with SSB 100 Hz
- High measurement accuracy error <1 dB
- Wide dynamic range: noise figure typical 8 dB (preamplifier on) 3rd-order IP typical +20 dBm (preamplifier off)
- Automatic gain correction in the whole frequency range after calibration
- Measurement of voltage, field strength, current, spectral density and attenuation constant with display of physical unit; conversion and bandwidth correction factors are automatically taken into account.
- Additional evaluation capabilities for radio-monitoring: modulation-depth and frequency-deviation measurements, remote frequency and frequency-offset measurements thanks to internal IF counter, connection of radiomonitoring recorders (maximum of 5 ZSG 3), SSB demodulator, AF filter, squelch with programmable threshold, indication of date and time of day.
- Storage of 10 complete device settings and of 5 data sets for automatic frequency scanning

Further characteristics, uses

Selective voltage measurement. With its measurement range -15 to +137 dB μ V the ESVP on its own is an automatic high-precision selective voltmeter for laboratory, testing and servicing applications. RF currents in the frequency range 20 to 300 MHz can be measured in conjunction with the VHF Current Probe ESV-Z1. Excellent receiver selectivity permits the measurement of adjacent-channel power and of nonharmonic spurious signals of generators. Other important applications are the measurement of intermodulation, crossmodulation and distortion and the determination of noise figures.

Frequency-response/attenuation measurement with cal-

ibration generator. The calibration generator output of 90 dB μ V across 50 Ω is ideally suited for frequency-response measurements on amplifiers and filters; attenuation can be measured up to 105 dB and gain up to 47 dB. The VHF Current Probe ESV-Z1 facilitates the measurement of shielding effectiveness on cables and a VSWR bridge can be used for return-loss measurements on two-terminal networks (e.g. antennas) and twoports.

Signal evaluation capabilities

Four switch-selected IF bandwidths: 7.5/12/120 kHz/1 MHz Average and peak indication, pulse weighting to CISPR 2 and 4 with programmable measurement times

Demodulation of commonly used FM and AM modes, SSB (USB, LSB) included

Wideband IF output of 10.7 MHz for panoramic display and spectrum analyzer

Narrowband IF output for oscilloscope

AM and FM demodulator outputs

Recorder outputs for level and frequency offset

Digital readout of modulation depth, frequency offset and frequency deviation

Trigger input for level and frequency measurement of short signals.

Recording. Harmonic, nonharmonic and sideband noise spectra, gain and attenuation curves can be readily plotted on an XY recorder. The start and stop frequencies and the maximum and minimum levels set on the ESVP define the recorder writing area. The frequency scale can be linear or logarithmic. Chart paper complying with VDE/FTZ/MIL can be used.

Remote control. The IEC-bus interface possesses all standard listener and talker capabilities. Commercial controllers without parallel poll capability can be used.

Special applications of ESVP

EMI measurements. Programmable automatic frequency scanning with direct printer/recorder control gives the ESVP a considerrable advantage over earlier test receivers. Accessories, such as current probes and broadband antennas, are available for measurements of interference voltages, currents and field strengths in line with the relevant standards (CISPR, VDE, MIL, VG); see specifications on page 241.

Further advantages of ESVP in interference measurements:

- Conversion factors are automatically taken into account
- Bandwidth factors are taken into account in measurements of spectral density to MIL and VG
- Peak indication with programmable hold time for narrowband and wideband interference measurements to MIL and VG
- Average indication with programmable integration time for narrowband interference measurements
- Indication to CISPR with determination of maximum within the programmed measurement time

Radiomonitoring, propagation and coverage measurements. Thanks to its outstanding RF characteristics, switch-selected IF bandwidths and types of demodulation, the wide range of available test antennas and its programmability, the ESVP is idal for use in radiomonitoring with remote frequency measurement, determination of frequency-band occupation and for propagation and coverage measurements. It offers the following possibilities:

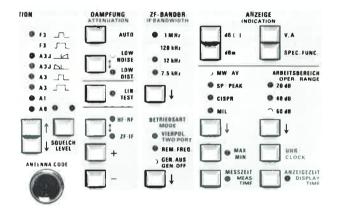
- Graphical representation of field strength in particular frequency bands, in the form of line spectra or segmented curves, on an XY recorder, with additional output of fieldstrength levels and, say, frequency offset on a printer
- Measurement of the variation range of field-strength level within a preset time (1 to 1000 s)
- Recording of field strength as a function of time for plotting antenna radiation patterns, for example in helicopters, and for measurement of channel occupation
- Recording of frequency-band occupation as a function of time, using the Radiomonitoring Recorder ZSG 3
- Reduction of data volume in automatic scanning mode: only signal levels above the preset threshold are taken to the computer.

Where highest operating speed is important and controller capacity must be saved, the IEC-bus interface of the ESVP offers the following possibilities:

The controller instructs each ESVP (and ESH 3) to permanently scan a particular frequency range and to issue SR when the programmed level is exceeded – whereupon the controller identifies the calling receiver by a serial poll and accepts the measured data – or to answer a parallel poll of the controller.

Operation

The operating controls are logically organized in functional groups on the front panel; all settings are indicated by LEDs.



Front-panel section with operating controls for demodulation, attenuation, IF bandwidth and display $% \label{eq:restricted}$

The operating philosophy of the ESVP is basically the same as that of the Test Receiver ESH 3, which covers the lower frequency range from 9 kHz to 30 MHz. **Operator errors are signalled** by the ESVP: when a logically inhibited key is pressed, the LED of the inhibiting function blinks; when the demodulator operating range is exceeded or essential stages are overloaded (even with pulses), the display blinks; when illegal data is input or an essential module fails, a coded error message appears together with a sound signal.

The 15-digit alphanumeric display of the ESVP outputs the measured data with physical unit and is used for checking the formatted input of setting data.

Frequency setting is possible in different ways (quasicontinuous, via keyboard, etc.; see specifications).

The **level measurement range** is selected either manually by separate setting of RF and IF attenuation or by automatic setting of RF attenuation with the IF attenuation setting being determined by the selected IF bandwidth and indicating mode.

Storage. A battery-buffered memory in the ESVP can store the last and nine more complete device settings. It also stores all the correction values obtained from an automatic calibration process for frequency response, IF bandwidths and demodulator characteristic.

7 VHF-UHF TEST RECEIVERS

test receivers

ESVP - Test receiver

Measuring convenience

The physical unit is selected automatically and **conversion** factors are taken into account, so the user need not do any additional work to perform measurements. Reading errors are virtually excluded.

The frequency-dependent **antenna factors** of passive R&S antennas are also automatically taken into account when a special function is selected. Conversion factors of other probes can be permanently stored in the ESVP using a process controller via the IEC-bus interface.

One of three demodulator operating ranges can be selected to suit the measurement task: 20/40/60 dB. Accordingly, the automatic attenuation setting is in steps of 10, 20 or 30 dB. The operating range also determines the range of the analog level indication, which consists of a row of 31 LEDs. The range limits and RF attenuation are digitally displayed.

Calibration. By a short or long push of the calibration button, function 1 or 2 is initiated:

- 1 Adjustment of IF gain and frequency offset to the rated value at 100 MHz, followed by a check of the level measurement at the set frequency.
- 2 Measurement and storage of all calibration correction values that are constant over a long time: frequency response, gain differences between IF bandwidths and demodulator linearity.

During operation the IF gain is adjusted each time a new frequency and IF bandwidth is set, so the rated levels are obtained at the IF and recorder outputs.

Thanks to this method, calibration of individual functions is very seldom necessary and automatic measurements take much less time than would be required if a calibration were performed at each new frequency.

Construction

Modular design, signature-analysis capability and selftest routines afford easy serviceability. All modules are independently exchangeable; the RF and μ P modules are of state-of-the-art cassette design.

Specifications

	20 to (1000) 1300 1. in 1 kHz/100 kH least increment 100 Hz	z steps with knob;
	 keyboard entry in steps of any automatic scannel 	preset size
Indication Resolution Setting error (freq. prop.)	8-digit LED display 1 kHz/100 Hz (SS	/ 3B)
Setting ends (ned, prop.)	freq_input 5/10 Mi improvement	Hz for accuracy
RF Input VSWR	$Z_{ln} = 50 \Omega$, N fem <1.2 with RF attent <2 with RF attent	nuation ≧10 dB
Oscillator reradiation at RF input without pre-amplifier		
and with RF attenuation 0 dB (with pre-amplifier 15 dB less)	· · · · ·	= 520 to <1020 MHz
	typ. 35 to 45 dBμ\ typ. 65 to 15 dBμ\	(f_{01}) $(2 \times f_{01})$ for $f_{in} =$ 1.02 to 1.3 GHz
Pre-amplifier	and input filter: ≈-	tween RF attenuator + 10 dB
Input filters Maximum input level	RF atten.	
DC voltage	0 dB 7 V	≧10 dB 7 V
Sinewave AC voltage	130 dBµV	137 dBμV (at ≧10 dB)
Max. pulse voltage		150 V
energy (10 μs)		1 mWs
Interference immunity, non-linearities	pre-amplifier without	with
Image frequency rejection		
20 to <520 MHz 520 to <1020 MHz	>80 dB (typ.	>80 dB) typ. >80 dB (100 dB
1.02 to 1.3 GHz		75 to 60 dB, typ.
Spurious responses in range 1.02 to 1.3 GHz		
for 2×fin -932.1 MHz	down 40 to 80 dB,	
IF rejection	tvp. 100 dB	>80 dB, typ. 100 dB
d ₃ intercept point	>+13 dBm,	>+3 dBm,
k2 intercept point		typ. +8 dBm >+35 dBm
	typ. +55 dBm	

Desensitization (typical, frequency-dependent): An interfering signal spaced >2 MHz from the receive frequency influences the display of the measured signal by <1 dB (RF attenuation 0 dB) at a
level of 100 dBμV Shielding effectiveness Voltage indication at a field strength of 3 V/m 0 dBμV
Radio Interference from internal microcomputer, etc
Intermediate frequencies 1st IF f _{in} <520 MHz
IF bandwidths (for average and peak values) Nominal -3 dB -6 dB 6:60 dB bandwidth (±20%) (±10%) ratio, typ. 7.5 kHz
$\begin{array}{l lllllllllllllllllllllllllllllllllll$

VHF-UHF TEST RECEIVERS 7

Voltage range (with pre-amplifier)	
Lower limit	
Upper limit Inherent spurious responses Voltage indication	137 dBµV (RF attenuation \ge 20 dB) < −5 dBµV (equivalent input voltage)
digital in dBμV, dBm in μV, mV, V	3 digits
analog	LED row over operating range of IF rectifier with digital display of range
Operating ranges of IF detector	limits 20, 40, 60 dB
Indicating modes	average value (progr. averaging time)
	peak value (progr. hold time) spectral density measurements to MIL, CISPR (Publ. 2 and 4);
Manual of marine	programmable averaging, hold and measuring times: 5 ms to 100 s
Measurement of maximum and minimum levels	the maximum and minimum levels are determined from individual measure- ments of 0.1 s duration each; programmable measuring time: 1 to 1000 s
Measuring error (level indication)	
Average indication for unmodulated sinewave signal ≧16 dB above inter-	
nal noise	<1 dB
Additional error in operating ranges 40 und 60 dB	typ. <0.5 dB
Average/peak	tracking generator (sinewaye)
CISPR, MIL in addition Error of analog level indication Operating range 20 dB	tvp <2 dB
40, 60 dB	typ <4 dB
Frequency offset	indication: digital in kHz, resolution 0.1 to 100 Hz
Measuring times	analog with LED row 100 ms to 10 s
Frequency deviation (+/-, peak)	indication in kHz, 4 digits, resolution 0.1/0.01 kHz
Measurement range Measuring error for S/N ≧30 dB	1 to 500 kHz
Modulation depth	indication in %, 3 digits,
Measurement range Measuring error for S/N ≧40 dB	≈1 to 99% (150% pos. peak) <3 counts, typ.
Gain measurement	indication in dB, 4 digits,
Measurement range	resolution 0.1 dB -105 to +47 dB
Error Demodulation modes	<1 dB, <0.5 dB typ. A3E, J3E, F3E (former designations A3, A3J, F3); in addition: NON (A0) for zero beat adj. A1A (A1) 1-kHz beat note
Squelch	
	-20 to +137 dBµV
	internal clock module, permanently in operation from internal battery
Remote control	interface to IEC 625-1 (IEEE 488), 24-pole Amphenol connector; functions: AH1, L4, SH1, T5, SR1, PP1, DC1, DT1, RL1, C0
Max. data rate Talker mode Listener mode	approx, 5 kbyte/s
Internal frequency, e.g. scan	
mode in steps < 100 MHz exceeding a 100-MHz digit	tvp. 70 ms
Internal RF level switch Max. measuring rate with PUC, measuring time 5 ms	25 ms/step
Front-panel outputs	
Generator output (switch-selected) . EMF	$Z_{out} = 50 \Omega$, N female connector 96 dB _μ V ±0.3 dB
Connector for supply and coding of test antennas, etc.	12-pole Turchel female connector
AF output EMF	adjustable up to 3.5 V

Uner accessories XYT Recorder ZSG 3, Universal Printer PUD 2 (in this catalog).

¹) The ESVP contains a Li battery for buffering the CMOS-RAMs. Storage at high temperatures over extended periods curtails the life of this battery.

VHF-UHF TEST RECEIVERS

test receivers

ESU 2



25 to 1000 MHz -10 to +120 dBμV

- Manually and remotely controllable test receiver for field-strength measurements, CISPR and MIL interference measurements, selective voltage measurements in laboratories and test departments, and for radiomonitoring.
- Error ≦1 dB automatic voltage calibration
- Indication modes: average, peak, VDE and CISPR weighting

The manually and remotely controllable **VHF-UHF Test Receiver ESU2** is designed for the measurement and demodulation of AM and FM signals, and for the measurement of TV, pulse-modulated and interference signals in the range 25 to 1000 MHz. It is of very versatile use.

By itself, the ESU2 is a top-class RF voltmeter – add the 25-to-300-MHz clamp-on probe and it can also measure RF current from -30 to +100 dB μ A.

The VHF-UHF Field-strength Meter HFU 2 is a combination of the ESU2, a 25-to-80-MHz broadband dipole, an 80-to-1300-MHz log-periodic antenna, mast and tripod. The overall measurement band is 25 to 1000 MHz; see page 254.

As a system component the ESU2 can easily be used with a frequency controller, a panoramic adapter, recorders and test assemblies; see pages 244 and 248.

High RF-input sensitivity and linearity, together with an internal calibration standard, make for unambiguous and precise measurements. A close-tolerance attenuator extends the linear 20-dB meter range to give a **measurement range of** -10 to +120 dB_µV.

Test receiver applications

Laboratories and test departments Versatile selective voltmeter, offering many ways of evaluating each input; measurement of RF current from -30 to +100 dBµA using current probe for 25 to 300 MHz.

The reference voltage output of the ESU2 permits fieldstrength calibration and **measurements on twoports** with an overall range (attenuation, gain) of 130 dB; swept measurements over frequency subranges are possible using the Panoramic Adapter EZP for display.

Television measurements. The peak-responding indication permits direct measurement of the sync-peak rms visioncarrier level independently of the picture content. Using the average-value indication, the sound carrier and the noise level can be measured to obtain the signal-to-noise ratio. The two direct-coupled AM-demodulator outputs are particularly useful for measuring hum- and cross-modulation on the pilot carriers in cable TV networks. Interference measurements. The ESU2 incorporates a weighting filter as required for radio interference measurement according to the procedures laid down in VDE 0875 and by CISPR. Interference field-strength measurements can be made with the help of antennas. Radio noise power measurements are also possible using the Absorbing Clamp MDS-21. Wideband interference can be measured according to MIL standards (electromagnetic compatibility measurements) on a separate calibrated scale. Measurements of single pulses or pulse trains with low repetition rates are possible thanks to a peak response with a hold time of 3 s.

Remote frequency measurement. The test receiver can be switched over to remote frequency measurement via the rear remote-control inputs, the RF input signal being stabilized to 20 mV EMF and brought out at the generator output without frequency shift. The signal is filtered in accordance with the selected IF bandwidth. The signal frequency can be displayed on a frequency counter connected to the ESU 2.

Auxiliary instruments for diversified applications

Frequency Controller EZK displays the reception frequency with a resolution of 1 kHz. With digital frequency control (DFC) the set frequency is held to within 100 Hz, meaning that the ESU2 is always ready for operation even when handling intermittent signals.

Panoramic Adapter EZP displays the spectrum of the received signal with different resolution bandwidths. The sweep width can either be set to cover up to a full receiver subrange (RF analysis) or up ± 1 MHz from the receive frequency (IF analysis). The receiver plus adapter forms an analyzer with tuned preselection in the subrange for the RF analysis mode.

An XY recorder, e.g. ZSK2, can be directly driven from the X and Y recorder outputs of the ESU2 to record voltage or field strength.

Battery Unit. This mounts on the rear panel and renders the receiver independent of an AC supply, for example, in field-strength measurements.

Programmability. All settings of ESU2 can be programmed via two rear-panel inputs, including frequency selection if the Frequency Controller EZK is used. It is also possible to use both manual and programmed operation simultaneously, as well as to connect several ESU2s for master-slave operation.

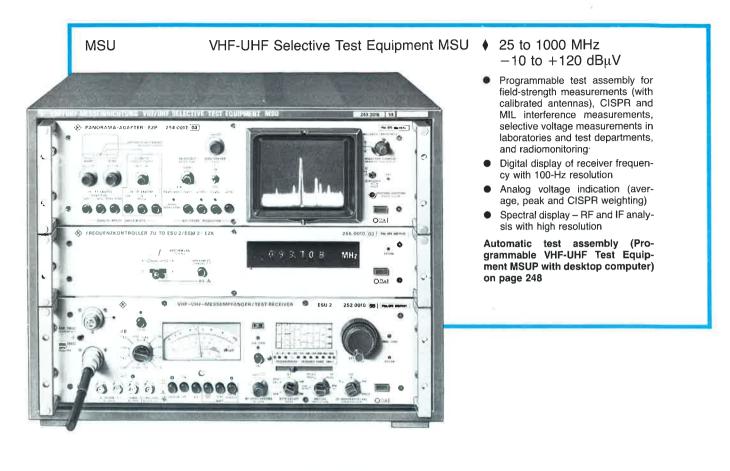
Specifications	
Frequency range	(20) ¹) 25 to 1000 MH~
Subranges	24 to 42 MHz 265 to 420 MHz 40 to 70 MHz 410 to 605 MHz 67 to 110 MHz 595 to 805 MHz
Frequency setting	170 to 270 MHz range selection: slide switch
Deschutze	tuning: coarse/fine drive for drum dial (2 m long)
Resolution	- 100 kHz/mm (1 MHz/mm) - <±(1 × 10 ⁻³ fm + 100 kHz)
AFC	(after calibration)
RF Input	
VSWR	adaptable
Noise figure (typical)	<1.5 for switch positions $>\pm20$ dB
	10 dB up to 1000 MHz
	1 V _{ms} for switch positions $\leq +10$ dB 3 V _{ms} for switch position +20 dB 5 V _{ms} for switch position s \geq +30 dB
Intermodulation attenuation for two signals in RF passband	. 70 dB typical, referred to 1 μV (0.3 μV
Oscillator reradiation at RF input	in level switch position - to up)
with 50-Ω termination . RF screening (cabinet model with b in battery operation and with	attery unit)
to with at reception frequency	indication <10 dB μ V with level switch position \leq +10 dB
	(RF input terminated)
Suppression of spurious respons	es
within RF passband	
Level switch at −10 dB ≧0 dB	>70 dB referred to 1 µV
Image-frequency rejection	>70 dB
Intermediate frequencies	
1st IF	199.3 MHz for subranges 1, 2 and 6
2nd IF/6-dB bandwidths	339.3 MHz for other subranges
3rd IF	450 kHz (6-dB bandwidth 120 kHz)
Measurement range	
	-10 to +120 dBuV for linear aver-
	-10 to +120 dBµV for linear aver- age-value indication; 10-dB steps
Measurement error (after calibration)	age-value indication; 10-dB steps
Measurement error (after calibration) Indicated noise (15 kHz bandwidth)	age-value indication; 10-dB steps $\leq \pm 1$ dB for V _{in} $\geq 1 \mu$ V ≤ -13 dBuV typical = 16 dBuV
Measurement error (after calibration) Indicated noise (15 KHz bandwidth) Indication Indication range	age-value indication; 10-dB steps $\leq \pm 1 \text{ dB for V}_{\text{in}} \geq 1 \mu \text{V}$ $\leq -13 \text{ dB}\mu\text{V}$, typical -16 dB μ V analog, illuminated scale
Measurement error (after calibration) Indicated noise (15 kHz bandwidth) Indication Indication range Lin	age-value indication; 10-dB steps $\leq \pm 1$ dB for V _{in} $\geq 1 \mu V$ ≤ -13 dB μV , typical -16 dB μV analog, illuminated scale 20 dB
Measurement error (after calibration)	age-value indication; 10-dB steps $\leq \pm 1$ dB for V _{in} $\geq 1 \mu V$ ≤ -13 dB μV , typical -16 dB μV analog, illuminated scale 20 dB 60 dB; 40 dB log peak value in dB $\mu V/MHz$ at 300 kHz bandwidth
Measurement error (after calibration) . Indicated noise (15 KHz bandwidth) . Indication range Lin . Log . For interference measurement	age-value indication; 10-dB steps $\leq \pm 1$ dB for V _{in} $\geq 1 \mu V$ ≤ -13 dB μV , typical -16 dB μV analog, illuminated scale 20 dB 60 dB; 40 dB log peak value in dB μV /MHz at 300 kHz bandwidth 7 dB
Measurement error (after calibration)	age-value indication; 10-dB steps $\leq \pm 1$ dB for V _{in} $\geq 1 \mu V$ ≤ -13 dB μ V, typical -16 dB μ V analog, illuminated scale 20 dB 60 dB; 40 dB log peak value in dB μ V/MHz at 300 kHz bandwidth 7 dB average value, lin and log; peak value, lin and log
Measurement error (after calibration) . Indicated noise (15 KHz bandwidth) . Indication range Lin . Log . For interference measurement	age-value indication; 10-dB steps $\leq \pm 1$ dB for V _m $\geq 1 \mu V$ ≤ -13 dB μ V, typical -16 dB μ V analog, illuminated scale 20 dB 60 dB; 40 dB log peak value in dB μ V/MHz at 300 kHz bandwidth 7 dB average value, lin and log;
Measurement error (after calibration) . Indicated noise (15 KHz bandwidth) . Indication range Lin . Log . For interference measurement	age-value indication; 10-dB steps $ \leq \pm 1 \text{ dB for } V_{in} \geq 1 \mu V $ $ \leq -13 \text{ dB}\mu V, \text{ typical } -16 \text{ dB}\mu V $ analog, illuminated scale $ 20 \text{ dB} $ $ 60 \text{ dB}; 40 \text{ dB log peak value in } \\ dB\mu V/MHz \text{ at } 300 \text{ kHz bandwidth } \\ 7 \text{ dB} $ $ average value, \text{ lin and log; } \\ peak value, \text{ lin and log } \\ and \text{ lin with } 3 \text{ s hold time } \\ weighted according to VDE 0876 and CISPR Publ. 2 and 4 $
Measurement error (after calibration) . Indicated noise (15 kHz bandwidth) . Indication range Lin . Log . For interference measurement Indication modes	age-value indication; 10-dB steps $\leq \pm 1 \text{ dB for V}_{\text{m}} \geq 1 \mu\text{V}$ $\leq -13 \text{ dB}\mu\text{V}, \text{ typical} -16 \text{ dB}\mu\text{V}$ analog, illuminated scale 20 dB 60 dB; 40 dB log peak value in dB}\mu\text{V/MHz at 300 kHz bandwidth} 7 dB average value, lin and log; peak value, lin and log; and lin with 3 s hold time weighted according to VDE 0876 and CISPR Publ. 2 and 4 AM and FM or A1A, A3E and F3E
Measurement error (after calibration)	age-value indication; 10-dB steps $\leq \pm 1$ dB for V _m $\geq 1 \mu V$ ≤ -13 dB μ V, typical -16 dB μ V analog, illuminated scale 20 dB 60 dB; 40 dB log peak value in dB μ V/MHz at 300 kHz bandwidth 7 dB average value, lin and log; peak value, lin and log; peak value, lin and log and lin with 3 s hold time weighted according to VDE 0876 and CISPR Publ. 2 and 4 AM and FM or A1A, A3E and F3E (A1, A3 and F3) EMF = 86 dB μ V, Z _e = 50 Q;
Measurement error (after calibration)	age-value indication; 10-dB steps $\leq \pm 1$ dB for V _m $\geq 1 \mu V$ ≤ -13 dB μ V, typical -16 dB μ V analog, illuminated scale 20 dB 60 dB; 40 dB log peak value in dB μ V/MHz at 300 kHz bandwidth 7 dB average value, lin and log; peak value, lin and log; peak value, lin and log and lin with 3 s hold time weighted according to VDE 0876 and CISPR Publ. 2 and 4 AM and FM or A1A, A3E and F3E (A1, A3 and F3) EMF = 86 dB μ V, Z _e = 50 Q;
Measurement error (after calibration)	age-value indication; 10-dB steps $\leq \pm 1 \text{ dB for V}_{m} \geq 1 \mu V$ $\leq -13 \text{ dB}\mu V, \text{ typical} -16 \text{ dB}\mu V$ analog, illuminated scale 20 dB 60 dB; 40 dB log peak value in dB $\mu V/MHz$ at 300 kHz bandwidth 7 dB average value, lin and log; peak value, lin and log; peak value, lin and log; and lin with 3 s hold time weighted according to VDE 0876 and CISPR Publ. 2 and 4 AM and FM or A1A, A3E and F3E (A1, A3 and F3) EMF = 86 dB $\mu V, Z_s = 50 \Omega$; N female connector, adaptable EMF = 200 mV, 50 Ω ; BNC EMF = 15 mV (unmod.), 120 kHz
Measurement error (after calibration) . Indicated noise (15 kHz bandwidth) . Indication range Lin . Log . For interference measurement Indication modes . Types of demodulation) Outputs Reference voltage 10.7-MHz IF	age-value indication; 10-dB steps $\leq \pm 1$ dB for V _m $\geq 1 \mu V$ ≤ -13 dB μ V, typical -16 dB μ V analog, illuminated scale 20 dB 60 dB; 40 dB log peak value in dB μ V/MHz at 300 kHz bandwidth 7 dB average value, lin and log; peak value, lin and log; peak value, lin and log; and lin with 3 s hold time weighted according to VDE 0876 and CISPR Publ. 2 and 4 AM and FM or A1A, A3E and F3E (A1, A3 and F3) EMF \approx 86 dB μ V, Z _s \approx 50 Ω; N female connector, adaptable EMF \approx 15 mV (unmod.), 120 kHz bandwidth 50 Ω; BNC
Measurement error (after calibration) . Indicated noise (15 kHz bandwidth) . Indication range Lin . Log . For interference measurement Indication modes . Types of demodulation) Outputs Reference voltage . 10.7-MHz IF	age-value indication; 10-dB steps $\leq \pm 1 \text{ dB for V}_{m} \geq 1 \mu V$ $\leq -13 \text{ dB}\mu V, \text{ typical} -16 \text{ dB}\mu V$ analog, illuminated scale 20 dB 60 dB; 40 dB log peak value in dB}\mu V/MHz at 300 kHz bandwidth 7 dB average value, lin and log; peak value, lin and log; peak value, lin and log; and lin with 3 s hold time weighted according to VDE 0876 and CISPR Publ. 2 and 4 AM and FM or A1A, A3E and F3E (A1, A3 and F3) EMF = 86 dB}\mu V, Z_s = 50 \Omega; N female connector, adaptable EMF ≈ 200 mV, 50 Ω; BNC EMF ≈ 15 mV (unmod.), 120 kHz bandwidth, 50 Ω; BNC ≤1.2 W (adjustable) into 8 to 16 Ω, JK-34 inzk
Measurement error (after calibration) . Indicated noise (15 kHz bandwidth) . Indication range Lin . Log . For interference measurement Indication modes . Types of demodulation) Outputs Reference voltage 10.7-MHz IF	age-value indication; 10-dB steps $\leq \pm 1 \text{ dB for V}_n \geq 1 \mu V$ $\leq -13 \text{ dB}\mu V, \text{ typical } -16 \text{ dB}\mu V$ analog, illuminated scale 20 dB 60 dB; 40 dB log peak value in dB\mu V/MHz at 300 kHz bandwidth 7 dB average value, lin and log; peak value, lin and log; peak value, lin and log; and lin with 3 s hold time weighted according to VDE 0876 and CISPR Publ. 2 and 4 AM and FM or A1A, A3E and F3E (A1, A3 and F3) EMF = 86 dB\mu V, Z_s = 50 \Omega; N female connector, adaptable EMF ≈ 15 mV (unmod.), 120 kHz bandwidth, 50 Ω; BNC EMF ≈ 15 mV (unmod.), 120 kHz bandwidth, 50 Ω; BNC EMF = 2 V, adjustable) into 8 to 16 Ω, JK-34 jack
Measurement error (after calibration) . Indicated noise (15 kHz bandwidth) . Indication range Lin . Log . For interference measurement Indication modes . Types of demodulation) Outputs Reference voltage . 10.7-MHz IF . 450-kHz IF . AF Squelch . Video 0 to 500 kHz	age-value indication; 10-dB steps $\leq \pm 1 \text{ dB for V}_n \geq 1 \mu V$ $\geq -13 \text{ dB}\mu V, \text{ typical} -16 \text{ dB}\mu V$ analog, illuminated scale 20 dB 60 dB; 40 dB log peak value in dB μ V/MHz at 300 kHz bandwidth 7 dB average value, lin and log; peak value, lin and log; peak value, lin and log and lin with 3 s hold time weighted according to VDE 0876 and CISPR Publ. 2 and 4 AM and FM or A1A, A3E and F3E (A1, A3 and F3) EMF = 86 dB μ V, Z ₈ = 50 Ω; N female connector, adaptable EMF ≈ 200 mV, 50 Ω; BNC EMF ≈ 15 mV (unmod), 120 kHz bandwidth, 50 Ω; BNC $\leq 1.2 W (adjustable) into 8 to 16 Ω, JK-34 jack switch-selected, threshold adjustable EMF = 2 V, adjustable over 70 dB, 75 Ω; BNC$
Measurement error (after calibration) . Indicated noise (15 kHz bandwidth) . Indication range Lin . Log . For interference measurement Indication modes . Types of demodulation) Outputs Reference voltage . 10.7-MHz IF . 450-kHz IF . AF Squelch . Video 0 to 500 kHz	age-value indication; 10-dB steps $\leq \pm 1 \text{ dB for V}_n \geq 1 \mu V$ $\geq -13 \text{ dB}\mu V, \text{ typical} -16 \text{ dB}\mu V$ analog, illuminated scale 20 dB 60 dB; 40 dB log peak value in dB μ V/MHz at 300 kHz bandwidth 7 dB average value, lin and log; peak value, lin and log; peak value, lin and log and lin with 3 s hold time weighted according to VDE 0876 and CISPR Publ. 2 and 4 AM and FM or A1A, A3E and F3E (A1, A3 and F3) EMF = 86 dB μ V, Z ₈ = 50 Ω; N female connector, adaptable EMF ≈ 200 mV, 50 Ω; BNC EMF ≈ 15 mV (unmod), 120 kHz bandwidth, 50 Ω; BNC $\leq 1.2 W (adjustable) into 8 to 16 Ω, JK-34 jack switch-selected, threshold adjustable EMF = 2 V, adjustable over 70 dB, 75 Ω; BNC$
Measurement error (after calibration) . Indicated noise (15 kHz bandwidth) . Indication range Lin . Log . For interference measurement Indication modes . Types of demodulation) Outputs Reference voltage . 10.7-MHz IF . 450-kHz IF . AF Squelch . Video 0 to 500 kHz	age-value indication; 10-dB steps $\leq \pm 1 \text{ dB for V}_n \geq 1 \mu V$ $\leq -13 \text{ dB}\mu V, \text{ typical } -16 \text{ dB}\mu V$ analog, illuminated scale 20 dB 60 dB; 40 dB log peak value in dB\mu V/MHz at 300 kHz bandwidth 7 dB average value, lin and log; peak value, lin and log; peak value, lin and log; and lin with 3 s hold time weighted according to VDE 0876 and CISPR Publ. 2 and 4 AM and FM or A1A, A3E and F3E (A1, A3 and F3) EMF = 86 dB\mu V, Z_s = 50 \Omega; N female connector, adaptable EMF ≈ 15 mV (unmod.), 120 kHz bandwidth, 50 Ω; BNC EMF ≈ 15 mV (unmod.), 120 kHz bandwidth, 50 Ω; BNC EMF = 2 V, adjustable) into 8 to 16 Ω, JK-34 jack

VHF-UHF TEST RECEIVERS 7

Recorder outputs	
X for frequency	
	10 kΩ
Connectors for Panoramic Adapter EZP, Frequency	
Controller EZK and for remote control	
remote control	multiway female connector strips
Coopifications of succession	
Specifications of recommen	ided extras
for interference measureme	ents:
RF Clamp-on Current Probe ESU-	Z
Frequency range	
Measurement range with ESU and HFV	0.1 uA to 0.1 A
Max, diameter of line measured	13.5 mm
Permissible DC or AC component . Characteristic impedance of cable .	. <50 A . 60 Ω (Dezifix B)
for field-strength measurem	ents:
Broadband Dipole HFU 2-Z1	
Frequency range	25 to 80 MHz
Antenna impedance	50 Ω, VSWR <2
Antenna factor k	7.2 to 12.2 dB (frequency dependent –
Connector	curve supplied)
Connector	N female, adaptable 3 m long (0.8 m demounted), 2.5 kg
Log-periodic Broadband Antenna	
Frequency range	80 to 1300 MHz
Antenna impedance	50 Ω, VSWR <2 from 80 to 1000
Antenna factor k	MHz 2.5 to 24 dB
	(frequency dependent
Dimensions, weight	1.7 m long, 2 m wide
Dimensions, weight	(1.7 m \times 0.5 m demounted), 6 kg
General data	
Rated temperature range	0 to +40°C -25 to +70°C
AC supply	115/125/220/235 V +10/-15%
Battery operation	(65 VA)
with battery unit	holds 20 NiCd cells IEC KR 33/61,
(bench model only) from external battery	approx. 3.5 hours operating time 21 to 28 V, negative earth
Charging	internal charger; charging time for battery unit 14 hours; charging cur-
	rent for external battery 400 mA
Dimensions, weight Cabinet model	
(with battery unit empty)	492 mm×195 mm×556 mm; 27 kg
19" rackmount	483 mm×133 mm×507 mm; 22 kg
Ordering information	
Order designations	VHE-UHE Test Resolver ESU 0
	19" rackmount 19" bench model
50-Ω model with N-type connector (standard version)	252.0010.54 252.0010.55
(standard version)	252.0010.58 252.0010.59
50-Ω model (Dezifix B, adaptable) 60-Ω model (Dezifix B, adaptable) 75-Ω model (Dezifix B, adaptable)	252.0010.51 252.0010.52 252.0010.61 252.0010.62
75-Ω model (Dezifix B, adaptable)	252.0010.71 252.0010.72
Accessories supplied	
Power cable, battery cable, battery u	unit (with bench model)
Recommended extras	
For bench model: 20 NiCd cells RS IEC KR 33/61, order designation per	cell 252 6001 00
Headphones (with Plug PL-55)	110.2959.00
RF Clamp-on Current Probe (25 to 300 MHz)	ESU-Z 100 1137 02
RF Cable	204,1090,02
Absorbing Clamp BNC female - N male adapter	MDS-21 194.0100.50 118.2812.00
Antennas for field-strength measures	ments (see above)
Loo-periodic Broadband	HFU 2-Z1 253.0113.55
Antenna	HL 023 465 8716 55
	10.000 1111111 400.01 10.00
¹) A model with slightly restricted spe	

 2) 60- and 75- Ω models are also available with modified specifications.

test receivers



The VHF-UHF Selective Test Equipment MSU is designed for the measurement and demodulation of AM and FM signals, and for the measurement of TV, pulse-modulated and interference signals. It is composed of the following instruments:

VHF-UHF Test Receiver ESU 2	(see page 242)
Frequency Controller EZK	(see page 245)
Panoramic Adapter EZP	(see page 246)

Great ease of operation of the equipment makes for precise and efficient measurements: internal reference for automatic voltage calibration, seven-digit display of receiver frequency, high sensitivity (typical noise figure 8 dB up to 400 MHz, 10 dB up to 1000 MHz), wide dynamic range and good imagefrequency and IF rejection (precluding measurement ambiguities), panoramic display covering up to an ESU2 subrange, recorder outputs, TTL logic for remote control and connection facilities for slave equipment.

Frequency setting and accuracy. The reception range of 25 to 1000 MHz is covered in nine subranges selected by a slide switch. Frequency can be adjusted continuously by a coarse/fine drive on the ESU2 drum dial, no change of the direction of rotation being necessary at the range end (resolution 100 kHz to 1 MHz/mm). The Frequency Controller displays the set frequency in seven digits with 1 kHz resolution. Switch-selected AFC and an A1 demodulator further facilitate the tuning procedure.

With digital frequency control (DFC) of the EZK, the set frequency remains locked to the crystal frequency (resolution of display 100 Hz). Quasi-continuous frequency variation in three speeds is simultaneously possible by means of a Kellog switch.

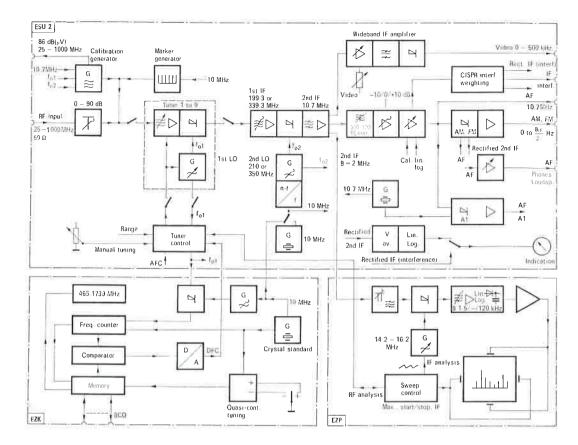
Sensitivity, voltage calibration, display. As the noise figure it typically 10 dB up to 1000 MHz, voltages of 0.3 μ V can be measured with the smallest bandwidth. Voltage calibration of the Test Receiver is possible within one second by the press of a button. The input and calibration signals pass through a level switch with motor-controlled 10-dB steps, extending the linear indication range of 20 dB (Test Receiver) to a measurement range covering -10 to +120 dB μ V, and correspondingly the logarithmic ranges of 60 dB (Test Receiver) and 70 dB (Panoramic Adapter). Display modes: average, peak, VDE and CISPR weighting.

Bandwidth. The bandwidths are fixed for the IF wideband amplifier (1 MHz) and the Panoramic Adapter (2 MHz) and can be switch-selected (300, 120 or 15 kHz) for the 10.7-MHz signal via the 2nd-IF amplifier as required for further evaluation.

Panoramic display The EZP displays the spectrum of the RF input signal across a maximum of an ESU2 subrange. Band occupancy, level, frequency (spacing) and modulation can thereby be assessed. The tuning of the Test Receiver is facilitated by a position marker produced in the EZP.

The following display modes and widths are possible:

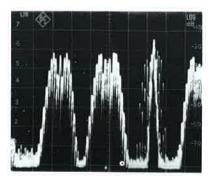
- a) RF analysis covering full subrange (max. 200 MHz with ESU 2).
- b) IF analysis with a maximum display width of 2 MHz. More information under EZK on page 245.



Block diagramm of VHF-UHF Selective Test Equipment MSU

Demodulation, **outputs**. The Test Receiver is designed for AM, FM and pulse modulation and has a video output for 0 to 500 kHz. The audio section delivers the demodulated and amplified signal to the loudspeaker or phones outpu. It contains a switch-selected squelch. The various outputs (IF, demodulator, AF and recorder outputs) afford great versatility.

Operation, programming, slave equipment. All functions of the receiver front-panel controls can be remotely controlled via rear connectors. Frequency setting is programmable in BCD code. It is also possible to use both manual and programmed operation simultaneously. Slave units ESU 2 + EZK can be connected to the Test Equipment.



IF analysis: Modulation spectrum of one occupied and three free public-landmobile-service channels; display width 200 kHz, resolution 1.5 kHz



The **Frequency Controller EZK** in conjunction with the Receiver ESU 2 and the Panoramic Adapter EZP performs the following functions:

- 1. Measurement of a manually set receive frequency between 25 and 1000 MHz, which is displayed as a frequency marker on the Panoramic Adapter
- 2. Crystal-controlled locking to set receive frequency
- 3. Quasi-continuous digital tuning
- Digital setting of receiver (range selection and tuning) to a BCDprogrammed frequency
- 5. Master-slave operation.

To perform function 1, the EZK measures the oscillator frequency of the receiver and, taking into account the intermediate frequency of the receiver range selected, indicates the receive frequency (data output available after each measurement).

For performing functions 2 to 5, the EZK contains, in addition to the frequency meter, an adjustable up/down counter, which serves as a nominal-value store, and a comparator which controls the receiver (range selection and tuning voltage).

EZK

test receivers

MSU/EZK+EZP

EZK

Modes. Three modes of operation are possible: manual, digital frequency control (DFC) and external (remote control).

After manual operation of the range switch and the tuning knob, the Frequency Controller gives a 6-digit readout of the set frequency and outputs the frequency information in BCD.

In the DFC mode, the EZK keeps the receive frequency constant with crystal accuracy. With external control, the frequency information is applied in TTL to the BCD inputs and entered upon an external command. In both cases, the frequency is displayed in seven digits.

Slave operation, e. g. in DF systems. For this purpose, the EZK control input and data output are wired such that the output of the master unit simply has to be connected to the input of the slave unit. Slave units can be operated in series or in parallel and set to different modes. In unattended operation, the receivers of the slave units can deliver the information content via CORs to magnetic tape recorders.

EZP



The **Panoramic Adapter EZP** in conjunction with a suitable receiver, such as the ESU 2 or ESM 2, permits spectral display within a particular frequency range. The screen display supplies information on band occupancy, and on the level, modulation and frequency spacing of the individual signals.

The panoramic display covers a wider band than the receiver and thus considerably facilitates receiver tuning, the exakt tuning frequency being marked on the screen by a light spot.

Display modes and sweep widths

- a) Broadband display RF analysis over the full subrange width (max. 200 MHz for ESU 2 and ESM 2). By setting start/stop markers, a particular section of this range can be displayed either alone or together with the latter in the two-line mode, the receiver tuning frequency remaining marked.
- b) IF analysis with a maximum sweep width of 2 MHz and automatic setting of optimal sweep time or resolution bandwidth.

In both cases, lin or log amplitude display can be selected. The gain is continuously adjustable in the linear mode. **Recording of screen displays.** The EZP delivers output signals with TTL and analog levels for driving auxiliary units, such as recorders and recording systems. In addition to semi-automatic recording of screen displays by means of an XY or a YT recorder, it is possible to perform long-term recordings of the frequency band occupancy, using for instance the Radiomonitoring Recorder ZSG 3. Reference lines for frequency calibration can be set easily and accurately on the EZP. The adjustable recorder threshold can be inserted on the screen display as a level reference line.

External control. The essential switching functions, e. g. all pushbutton functions, lin-log switchover, free selection of sweep times, stopping and triggering the internal sawtooth generator, can be remote-controlled. It is also possible to blank the CRT or to insert additional frequency markers.

The internal graticule of the CRT can be illuminated. The frame in front of the screen can be folded up to accept a camera.

Specifications of EZK
Frequency range approx. 0 to 1000 MHz
Range with Receivers ESU 2,
ESM 2
Crystal aging after 30 days of
operation $\leq 2 \times 10^{-9}$ /day
Modes
Local operation
Receive frequency measurement . front-panel switch set to MANUAL
Receiver tuning
Measurement rate 10 measurements/s Display 6-digit LED display;
resolution 1 kHz
Receive frequency hold mode front-panel switch set to DFC (digital frequency control)
Quasi-continuous receiver
tuning (DFC int.) relative to instantaneous frequency:
freely selectable by means of Kellog
switch on EZK front panel; tuning rate in pos. and neg. direction:
1 kHz/s, 10 kHz/s, 100 kHz/s (others:
please enquire)
Measurement rate
Display
receiver)
Remote control (DFC) programmable via control line Nominal frequency entry BCD parallel, by store command,
setting time with Receivers ESU 2 and
ESM 2: typical 0.5 s
Display
Master-slave operation by connecting data output of master
EZK to control input of slave EZK
Data output after each measurement; output
released by print command
Inputs, outputs
Control input/data output
7 decades BCD-coded, TTL pos.
(adaptation to negative logic possible)
General data
Rated temperature range 0 to 40 °C
Storage temperature range
47 to 440 Hz (50 VA)
Dimensions weight
19" bench model 492 mm×116 mm×514 mm, 13.3 kg
19" rackmount 483 mm×88 mm×508 mm, 12.3 kg
Ordering information
Order designations Frequency Controller EZK
19" bench model 255.0010.02
19" rackmount 255.0010.03
Accessories supplied cable for connection of EZK to receiver;
power cable

VHF-UHF TEST EQUIPMENT 7

0	0 10 11
Specifications of EZP	Specificatio (Specifications o
Frequency	
Dynamic range (interference-free) ≧70 dB Range of indication log	Frequency rang Frequency settin
Required signal level for full output	10 C 10 C
Limit sensitivity with 1.5-kHz resolution $\leq 2 \mu V (S + N)/N = 2$	
RF analysis (Receiver ESU 2 or ESM 2) Sweep width	
Maximum range or subrange of receiver	Frequency displa
(200 MHz with ESU 2, 500 MHz with ESM 500) Start/stopany section of full sweep width	Noise figure up
Max. + start/stop simultaneous (two-line) display of	RF Input
range or subrange and section Resolution (corresponding to 3-dB bandwidth)	
for maximum sweep width 120 kHz (according to CISPR Rec.) for start/stop mode	Suppression of s
Shape factor of filter ≈1/15 Frequency marking by shiftable markers,	responses within with level switc
frequency indication on receiver Sweep time	Image-frequency IF rejection
IF analysis	Intermediate fre
Sweep width 2 MHz 200 kHz 20 kHz	2nd IF
corresponding to	6-dB bandwidt 3rd IF
to 3-dB bandwidth)	6-dB bandwidt
(minimum sweep time automatically selected)	Measurement ra
Sweep time	Measurement en
marker	Voltage indicati
Remote control digital programming of all functions, TTL neg., adaptable to pos. logic	
Control inputs for sweep width, resolution, lin/log, time	
control, local oscillator "off", trace blanking, external marker, stopping	Indication modes
and triggering of sawtooth Outputs	Demodulation .
Recorder outputs	Panoramic displa
Digital	wideband (sub
Analog sawtooth voltage, X and Y control for recorder, general Y control, recorder	Narrowband disp
drive control Operating voltage for	Level display
external units	Screen size
Display rectangular CRT with GL (P2) screen: internal graticule 10 cm × 8 cm,	Conserved data
0 to -70 dB	General data Rated temperatu
General data Rated temperature range 0 to +40 °C	AC supply
Storage temperature range -40 to +70 °C AC supply 115/125/220/235 V +10/-15%,	Dimensions, weig
47 to 440 Hz (35 VA)	
19" bench model	Ordering in
19" rackmount	Order designation
Ordering information for EZD	(complete system
Ordering information for EZP	MSU without RF Accessories supp
Order designations Panoramic Adapter EZP Normal IF analysis only	
Version (no remote control) 19" bench model 254.0017.02 254.0017.04	Recommended
19" rackmount	Radio Monitoring Connecting ca
19" bench model	XY Recorder 7.SH Headphones (wit
Accessories supplied power cable 025.2365.00,	RF Clamp-on Gu RF cable for conr
connecting cable 251.9494.00	Absorbing Clamp BNC-female to N
for receiver, filter 254.2149.00 Recommended extras	(for RF Current Antennas for field
Siemens Polaroid Camera Rel. 3B952a	Recorder Adapte Code Converter I
(please order direct from Siemens) Camera adapter	Code Converter I
or Steinheil Camera	
with Adapter for OKF	

Specifications of Selecti (Specifications of ESU 2, page 243	ive Test Equipment MSU
Frequency range	 a) continuous with subrange slide switch and coarse/line drive; drum dial 2 m in length, resolution 100 kHz in lowest subrange b) quasi-continuous on EZK in three speeds with digital display; steps and resolution 100 Hz c) external in BCD, setting time typ. 0.5 s including automatic range selection
Noise figure up to 400 MHz	6 digits with manual tuning (ESU 2) 7 digits with tuning through EZK 8 dB (typ.)
up to 1000 MHz	10 dB (typ.) 50 Ω , N female connector, adaptable
Immunity to interference	
Suppression of spurious responses within RF passband with level switch at - 10/≥0 dB Image-frequency rejection	
IF rejection	>80 dB
Intermediate frequency/bandwid	and the second se
2nd IF 6-dB bandwidth 3rd IF 6-dB bandwidth	10.7 MHz 15/120/300 kHz 450 kHz \ only for CISPR inter- 120 kHz \ ference measurements
	-10 to +120 dBµV for linear average- value indication; 10-dB steps
Measurement error	
	60 dB, 40 dB log peak value for MIL measurement of wideband interference in $dB\mu V/Hz$
- Contractor of the	7 dB for CISPR interference measure- ment
	average value, lin and log; peak value, lin and log, weighted according to VDE 0876 and CISPR Publ. 2 and 4
Demodulation	AM and FM or A1A, A3E and F3E (A1, A3 and F3)
Panoramic display wideband (subrange) display	resolution or any detail with 50 kHz
Narrowband display (IF analysis)	resolution 20 kHz to 2 MHz display width with resolution bandwidths 1.5/4.5/15 kHz
Level display	>70 dB log or 20 dB lin
General data	
Rated temperature range AC supply	0 to +40°C 115/125/220/235 V +10/~15%
	47 to 420 Hz (140 VA) 520 mm×400 mm×535 mm, 60 kg
Dimensions, weight .	520 mm×400 mm×535 mm, 60 kg

nformation for MSU

Order designation	► VHF-UHF Selective Test
	Equipment MSU
(complete system)	253.2016.55
MSU without RF analysis	253.2216.99
Accessories supplied	
	tery cable for connection to ESU 2
Descurrent and a discurrent statement of the statement of	

d extras

Radio Monitoring Recorder ZSG 3	. 242.6015.92
Connecting cable (EZP-ZSG 3)	. 251 9488.00
XY Recorder 7SK 2	247 4010.04
Headphones (with plug PL 55)	. 110 2959.00
RF Clamp-on Current Probe ESU-Z (25 to 300 MHz)	. 100.1137.02
RF cable for connection of RF Current Probe	. 204.1090.02
Absorbing Clamp MDS-21	. 194 0100.50
BNC-female to N-male adapters	
(for RF Current Probe and MDS-21)	. 118.2812.00
Antennas for field-strength measurements see HFU 2 (pag	e 252)
Recorder Adapter ESU 2-Z1	. 290.6011.92
Code Converter PCW	. 244.8015.92

test receivers

ESU 2, computer-controlled



Automatic VHF-UHF Test Equipment

♦ 25 to 1000 MHz/- 10 to + 120 dBµV

consisting of

Programmable VHF-UHF Test Equipment MSUP and Process Controller PUC

- Dialog programs available for various applications
- Control complying with IEC standards; therefore simple extension with further measuring instruments

The **Programmable VHF-UHF Test Equipment MSUP** is composed of the VHF-UHF Selective Test Equipment MSU described on page 244 and the IEC-bus Adapter ESU 2-Z4. It constitutes a compact IEC-bus-compatible test system for selective measurements of voltage and twoport parameters. In conjunction with clamp-on RF current probes and calibrated antennas, current and field-strength measurements are possible. A frequency counter can be inserted into the IEC-bus Adapter for remote frequency measurement with the MSUP (photo: top; not supplied). The loudspeaker incorporated in the ESU 2-Z4 facilitates aural monitoring of the modulation content for radiomonitoring and acoustic assessment of radio interference measured according to CISPR and VDE 0875. A button on the ESU 2-Z4 permits rapid transition to manual operation.

Control, characteristics. The MSUP Test Equipment is controlled by the Process Controller PUC. This desktop computing system gives numerical and graphic display of the results.

The software available with the test assembly consists of a basic program containing complete control, self-check, test and calculating routines, with which the user can compile individual programs without difficulties, and of **prepared dialog programs** for various applications.

The advantage of computer control lies in

shorter test time,

automatic preparation of test reports which are easy to interpret,

elimination of operating erros.

The dialog programs are so written that even untrained operators may use the system.

Uses

The system is intended for all situations where a great number of measurements must be carried out, logged and evaluated with constant high accuracy and reliability. This especially applies to measurements of spectral characteristics of useful and unwanted signals.

A search program for **radiomonitoring** is used to measure within a specified frequency range the input voltages exceeding a certain value. With the aid of an IEC-bus-compatible frequency counter in the ESU 2-Z4, the respective frequencies are determined. Another dialog program permits level and fequency measurements for radiomonitoring on fixed frequencies which are stored in the computer.

When measuring e-m interference according to MIL specifications and VG regulations the test system permits separate detection of sinewave and wideband interference sources.

In the case of **radio-interference measurements** according to CISPR and VDE 0875 this test system is the first to offer the possibility of automatically recording the test results over a large dynamic range.

When measuring the harmonics of a signal or the absolute value of the transfer constant of twoport networks the possibility to obtain derived quantities (voltage ratios) by processing measured values (voltages) offered by the computing system is profitably used; during field-strength measurements the computing system automatically considers the (frequency-dependent) antenny factor (k).

Specifications of MSUP
Frequency range
RF input N female connector IEC-bus connector 24-way, female (Amphenol) Operating temperature range 0 to +40 °C AC supply 115/1125/220/235 V (180 VA) Dimensions, weight 520 mm×534 mm×635 mm, 70 kg
Order designation Programmable VHF-UHF Test Equipment MSUP 253.3512.55
Recommended extras
Desktop computing system Process Controller
PUC see page 14
Basic Software ESU 2-K4
IEC-bus Cable PCK
Frequency Counter Philips PM 6615/04 with PM 9676
IEC-bus Adapter as individual unit
IEC-bus connector 24-way, female
Connectors for ESU 2 and EZK three 50-way, female
AC supply 115/125/220/235 V (30 VA)
Dimensions, weight
19" bench model (design 80) 492 mm×161 mm×514 mm, 11 kg 19" rackmount 483 mm×133 mm×506 mm, 10 kg
Order designation IEC-bus Adapter ESU2-Z4
19" cabinet model 253.3012.02
19" rackmount 253.3012.03

HF-VHF-UHF TEST EQUIPMENT 7

Automatic Test Equipment

9 kHz to 1000 MHz

−30 (−10) to +137 dBµV

consisting of

Test Receiver ESH 3 VHF-UHF Test Eqpt MSUP Process Controller PUC 9 kHz to 30 MHz 25 to 1000 MHz

Ready-made programs available for various applications

• Can be controlled via IEC bus, thus easy to expand if required

For basic configuration see Specifications.

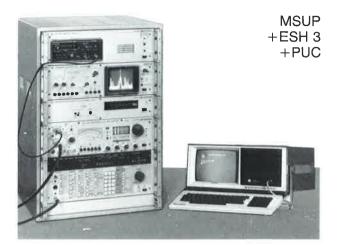
The Automatic Test Equipment is used for selective measurements and demodulation of signal and interference voltages; built-in signal outputs make it suitable for twoport measurements, and in conjunction with current probes and calibrated antennas RF current and field-strength can be measured. In the remote-frequency-measurement mode, both the ESH 3 and the ESU 2 perform as active filters between the RF inputs and the generator output. A frequency counter can be inserted in the ESU 2-Z4 to measure the frequency at the generator output. Loudspeakers in the ESH 3 and the ESU 2-Z4 (for ESU 2) make it possible to monitor the modulation aurally. Further IEC-bus compatible instruments can be added: Relay Matrix PSU for the connection of antennas or other transducers to the RF inputs or for switchover of the ESH 3 and ESU 2 generator outputs to the frequency-counter inputs; Control Unit RB 014 with Code Converter PCW for the control of an antenna rotator to adjust the azimuth in field-strength measurements; Signal Generator SMS for measurements on tuners and for generation of higher field strengths than those obtainable at the generator outputs of the receivers.

Control, Characteristics

The MSUP includes an IEC-bus interface in the ESU 2-Z4 for driving the ESU 2 and EZK, as well as for the digital voltmeter in the ESU 2-Z4 and for an optional frequency counter. The Software ESH 3-K1 offers applications in radiomonitoring, radio-interference measurements according to CISPR, EMI measurements according to MIL specifications and VG regulations as well as laboratory measurements (twoport and harmonics) in the frequency range from 9 kHz to 1000 MHz. Thanks to the internal control function of the ESH 3, the computer can load this receiver with measurement tasks, which are then performed automatically.

Uses

The frequency range from 9 kHz to 1000 MHz covers all the broadcasting bands and the most important of the other radio services. The Test Equipment can be used for determining frequency-band occupation, for propagation and coverage measurements and remote frequency measurements for radiomonitoring purposes. Programs for the measurement of the relevant field-strength data in a preset frequency range or for remote level and frequency measurements at fixed frequencies can easily be prepared. Even without a computer, the occupation of up to six frequency bands can be



determined as the ESH 3 on its own is capable of driving five Radiomonitoring Recorders ZSG 3.

When **measuring EMI** according to MIL specifications and VG regulations, separate detection of sinewave and wideband interference is possible. The conversion factors of the antennas and current probes specified in the MIL standards are included in the computer software.

In the case of radio-interference measurements according to CISPR and VDE 0875, computer control is possible in the frequency range up to 30 MHz in conjunction with the Artificial Mains Network ESH 2-Z5. A Code Converter PCW is used for programmed phase switching. Radiointerference power can be measured with the aid of the Absorbing Clamps MDS (page 255) and radio-interference field strength with the calibrated antennas of the VHF-UHF Field-strength Meter HUF.

In **laboratories and test departments** the Test Equipment is ideal for the automatic measurement of twoport gain and attenuation, reflection coefficient, harmonics and spuria of transmitters and oscillators and, with add-on signal sources, for measuring overdrive capacity.

Specifications of the Automatic Test Equipment
For data on individual instruments see in this catalog: ESH 3 page 226 EZK page 245 PUC page 14 ESU 2 page 242 EZP page 246
Frequency range 9 kHz to 1000 MHz Frequency setting quasi-continuous, resolution 100 Hz
RF Inputs Z _{In} = 50 Ω 9 kHz to 30 MHz BNC female connector 25 to 1000 MHz N female connector
Measurement ranges 9 KHz to 30 MHz -30 to +137 dBµV 25 to 1000 MHz -10 to +137 dBµV Remote control inputs 2 IEC-bus connectors, 24-pole Amphenol
General data Operating temperature range 0 to +40 °C Power supply 115/125/220/235 V (250 VA) Dimensions, weight 520 mm×710 mm×635 mm, 90 kg
Order designation choice of component units by R&S or by customer as required; for desig- nations of individual instruments, see elsewhere in this catalog
Recommended extras Software for PUC: ESH3-K1 Software for other computing systems: please enquire. IEC-bus cable PCK (2 m long) Frequency counter (Philips) PM 6615/04 with PM 9676

field-strength meters

Field-strength meters and receivers

Magnetic field strength (A/m) and electric field strength (V/m) are measured in practice in V/m or μ V/m or in dB μ V/m. The electric and magnetic fields are related according to E = HZ₀, where Z₀ = $\sqrt{\mu_0/\epsilon_0}$ = 120 $\pi\Omega$ is the field characteristic impedance of free space.

The measurement of electric or magnetic field strength is reduced to a voltage or power measurement by means of a calibrated antenna. The calibrated test receivers¹) employed here can also be used for other measuring and monitoring purposes.



VHF-UHF Field-strength Meter HUF for propagation measurements, measurement of radiation patterns and interference field strength The antennas used at frequencies below 30 MHz are broadband. The dimensions are small compared to the wavelength. The electric field strength is measured with rod antennas of constant length and the magnetic component with loop antennas. At higher frequencies (above 25 MHz) tuned antennas with broadband characteristics (dipoles or log-periodic antennas) are used. Probes of small dimensions are suitable for determining field configurations.

The **test receivers** are selective heterodyne receivers with switch-selected bandwidth. The built-in standardizing oscillator allows a voltage calibration of the receiver at any frequency. Switch-selected attenuators in the IF section and at the receiver input extend the meter range, which is calibrated in dB. Linear indication covering 20 dB or logarithmic indication over 40 or 60 dB can be switch-selected. Test receivers meet stringent requirements in regard to ultimate selectivity, rejection of spurious responses and stray fields. In addition to a recorder output, AF and IF outputs are provided for the connection of interpreting equipment, such as analyzers, panoramic units or oscilloscopes.

In conjuntion with a radio interference indicator, **interference field measurements** complying with VDE 0876 or CISPR recommendations can be carried out.

The Absorbing Clamp MDS (see page 255) in conjunction with a radio-interference measuring receiver permits radio interference power issued from the power cable of an interference source to be measured in the frequency range 30 to 300 (1000) MHz according to VDE 0875.

Monitoring receivers (Part of the Rohde & Schwarz line of communications equipment; see separate data sheets) need not provide for accurate measurement of input voltage or power. The switchable attenuators and the standardizing oscillator are omitted. On the other hand, the monitoring receivers feature high setting accuracy for the reception frequency and excellent stabilization of the AF output voltage at different input levels. Adequate selectivity and heavy rejection of spurious responses and intermodulation preclude errors in observation. IF and AF outputs allow the connection of accessories for the evaluation of the received signal.

Frequency range	Designation	Туре	Order No	Voltage range	Field-strength range	Antennas	See also page
0.009 to 30 MHz	Field-strength Meter Clamp-on RF Current Probe	HFH 2	335.3015.52 338-3516-52	-30 to +137 dBμV 0.1 μA to 0 ₁ 1 A	−3 to +140 dBμV/m —	2 loop antennas 1 rod antenna —	251
0.009 to 30 MHz	Test Receiver	ESH 3	335-8017-92	−30 to +137 dBµV	-3 to +140 dBµV/m	same as HFH 2, but to separate order	226
25 to 300 MHz	VHF Field-strength Meter	HFV	203.6018:02	0 to 100 dBμV (1 μV to 0.1 V)	3 to 121 dBµV/m	<60 MHz sh dipole >60 MHz tun dipole	252
20 to 1000 MHz	Field-strength Meter	HUF	354-1520.53	–10 to +137 dBμV	-7.5 to $\pm 140~dB\mu V/m$	broadband dipole, log-per- antenna	254
20 to 1300 MHz	Test Receiver	ESVP	354.3000.52	–15 to +137 dBμV	12.5 to +140 dBµV/m	same as HUF, but to separate order	238
25 to 1000 MHz	VHF-UHF Field- strength Meter	HFU 2	253.0013.55	−10 to +120 dBµV	-7.5 to +143 dBµV/m	broadband dipole log-periodic antenna	

 Special-purpose receivers (HF, VHF and UHF ATC, VHF and TV relay reception) are described in separate data sheets.

1ew

field-strength meters

HF FIELD-STRENGTH METERS 7

Field-strength Meter HFH 2

♦ 9 kHz to 30 MHz

- Uses: propagation measurements, radiomonitoring, testing RF shielding, selective measurement of very small voltages, measurements of interfering fields in line with VDE, CISPR, MIL and VG specifications
- Wide measurement range: 140 dB
- Accuracy complying with CCIR recommendations
- Direct indication of field strength in dB_μV/m, RF current in dB_μA and voltage in dB_μV

The **Field-strength Meter HFH 2** is used to measure wanted-signal fields – propagation, coverage, antenna patterns, monitoring – as well as interfering fields in accordance with MIL, CISPR, VDE and VG specifications in the frequency range 9 kHz to 30 MHz.

The HFH 2 consists of Test Receiver ESH 2 Rod Antenna HFH 2-Z1 Loop Antenna HFH 2-Z2 Tripod and accessories (see specifications).

The Test Receiver ESH 2 is a synthesizer design (detailed description on pages 222 to 225) and is tuned quasicontinuously in steps of 100 Hz, or of 10 kHz for rapid search operations. Frequency is indicated on a 6-digit LCD using a crystal reference.

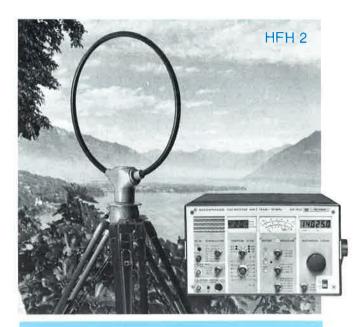
Switch-selection of four bandwidths (200 Hz, 500 Hz, 2.4 kHz, 10 kHz), linear or logarithmic average or peak indication and calibration at the press of a button, among other features, ensure that accurate and reproducible results are obtained rapidly:

- The conversion factors of the antennas and the current probe are automatically taken into account so that a corrected display of the measured value and unit of measurement is obtained directly.
- Overloading of the main receiver stages is immediately recognized and signalled.
- Control of the IF gain as a function of bandwidth and indication mode ensures that the minimum S/N ratio required is maintained.
- Pulse calibration with CISPR indication, sinewave calibration with average and peak-value indication; automatic changeover when the bandwidth is switched.

The AC power supply of the receiver is readily replaced by the rechargeable battery unit which is provided with the HFH 2. Direct powering from a 12-V or 24-V vehicle supply is also possible.

Since all receiver settings are maintained during "off" periods, the receiver can be switched off during measurement intervals in order not to waste the capacity of the battery.

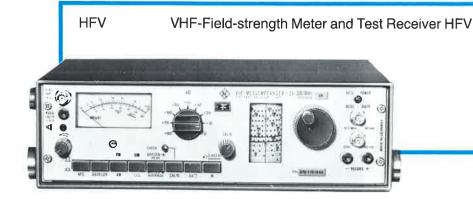
Antennas. The Field-strength Meter is delivered with an inductive probe as well as a rod antenna and a loop antenna for 9 kHz to 30 MHz. A special loop antenna for sensitive measurements in the range 9 kHz to 1 MHz is available to separate order; its conversion factor is automatically taken into account.



Specifications of HFH 2

Measurement range Using Rod Antenna HFH 2-Z1		
Lower limit	15 to -10 dBµV/m	-10 dBµV/m
Lower limitUpper limit	140 dBµV/m	140 dBµV/m
Using Loop Antenna HFH 2-Z2		
Lower limit	40 to 10 dBµV/m	10 to -5 dBµV/m
Upper limit	140 dBµV/m	140 dBµV/m
Using Loop Antenna HFH 2-Z3		
Lower limit	5 to -5 dBuV/	m
Upper limit	140 dBuV/m	
Using Inductive Probe HFH 2-2	Z4 (100 kHz to 30 MH	Hz)
Lower limit	50 dBµV/m	
Upper limit	>140 dBµV/m	
Measurement error (incl. antennas)		
(incl. antennas)	<2 dB (within 10 dB c	
		be taken into account)
Test Receiver ESH 2	more information on	page 225
Frequency range		
Antenna input	$Z_{in} = 50 \Omega$; BNC fem	
	VSWR <1.2 (<2)	
Measurement range,		
average reading	-30 to +137 dBµV	- Ch
Indication ranges Measurement error		dB.
weasurement error		
Antennas		
Rod Antenna HFH 2-Z1	9 kHz to 30 M	H7
Connector	BNC male Z	= 50 O
Conversion factor k	20 dB length =	= 1 m
Loop Antenna HFH 2-Z2	9 kHz to 30 M	Hz
Connector Conversion factor k	BNC male, Zs	= 50 Ω
Conversion factor k	20 dB	
Loop diameter	60 cm	
Loop Antenna HFH 2-Z3 (to be	e ordered separately)	
Frequency range	9 kHz to 1 MH	Z
Connector	BNC male, Zs	= 50 17
Conversion factor k Measurement range with ES	1000	dBuV/m
Side length of loop, weight .	240 cm 17 kg	dbµv/m
olde length of loop, weight .	(with transport	case 43 ko)
General data	(mar nanopon	
ESH 2: temperature range, po supply, dimensions, we		
supply, untensions, we	igner acc page 220	
Ordering information		
•	b Eigld stress	th Motor HEU 0
Order designation	► Fleid-streng 335.3015.5	
Evolom components (item		
System components (items ca		
Test Receiver ESH 2		2
(incl. battery unit without batter Rod Antenna HFH 2-Z1.	iy)	
		2
Loop Antenna HFH 2-Z2,		
9 kHz to 30 MHz		2
Tripod HFU-Z (in transport bad) 100.1114.0	2
9 kHz to 30 MHz Tripod HFU-Z (in transport bag Inductive Probe HFH 2-Z4		2
Recommended extras	see overview of	on page 230
Roof-mounting Kit HFH 2-Z5		
(for Loop Antenna HFH 2-Z2) .		2

7 VHF FIELD-STRENGTH METERS field-strength meters



25 to 300 MHz

- Frequency range covered in one band
 Measurement range 0 to 100 dBµV; indication range log 60 dB, lin 20 dB; peak- and average-value modes
- Interference measurement according to VDE and CISPR (with Pulse Weighting Unit)

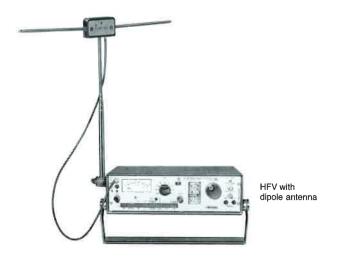
The selective instrument HFV for 25 to 300 MHz is available in three models to suit different applications (models 02/03 and 05; see ordering information):

Field-strength with rotatable and tiltable dipole, with optionmeter al Pulse Weighting Unit

Test receiver for radiomonitoring and selective laboratory measurements, 50 Ω input, IF bandwidth 36 kHz, squelch

The main characteristics such as frequency range, voltage range, demodulation, etc. are the same for the two models, only the application-oriented data for bandwidth and interference weighting and the equipment configuration differ.

The VHF Field-strength Meter HFV (models 02 and 03) with dipole antenna is used for measurements of radiosignal propagation and of interfering fields existing in the particular service area. Its high performance makes it also suitable for laboratory use as a selective microvoltmeter for absolute and relative measurements. Input impedance 50 Ω .



A dipole which may be tilted and rotated, with a coaxial feeder, is used as **antenna** for field-strength measurements. It operates as a shortened dipole between 25 and 60 MHz and as a tunable halfwave dipole from 60 to 300 MHz. Field strength is determined from the indicated voltage with the aid of an antenna-factor curve.

The **test receiver** – a heterodyne receiver with high IF – is tunable through the whole range without band switching. Adequate ultimate selectivity is ensured by the selective input and by a bandpass filter. A crystal filter with a 6-dB bandwidth of 120 kHz (36 kHz for model 05) is provided in the second IF stage of 10.7 MHz. A substantially low-distortion reproduction of FM broadcasts is thus also possible. A builtin pulse generator supplies pulses of 100 Hz repetition frequency with constant amplitude up to 300 MHz, permitting voltage calibration at any frequency.

Measurement ranges and signal evaluation. The instrument indicates the average and peak values of the IF signal over a linear range of 20 dB or a logarithmic range of 60 dB. With the 8×10 dB attenuator, the linear indication covers an overall range of 100 dB. Average-value indication is used to measure AM and FM signals. Peak-value measurement allows, for example, the sync-peak rms value of the picture carrier in TV signals to be indicated independent of the picture information. Furthermore, signals from pulse-modulated transmitters and interfering signals can be measured. The 10.7-MHz IF output allows observation on an oscilloscope. The AF and recorder outputs provide further possibilities for the evaluation of AM and FM signals.

Pulse Weighting Unit. The Field-strength Meter is available with or without Pulse Weighting Unit. In conjunction with this accessory, the HFV presents the overdriving capacity required according to VDE 0876 and CISPR Publ. 2 and complies with the tolerances admitted for bandwidth and weighting (attenuation adjustable in 5-dB steps). Weighted measurements of interference field strength and – with the Absorbing Clamb MDS (see page 255) – **measurements of radio interference power** complying with VDE 0875 are possible.

RF current measurements from 0.1 μ A to 0.1 A can be carried out in conjunction with the Clamp-on RF Current Probe at frequencies from 25 to 300 MHz.

field-strength meters VHF FIELD-STRENGTH METERS 7



Measurement of signal and interference fields near the highway

Test receiver for radiomonitoring. HFV model 05 is used for reception of AM and FM signals. With an IF bandwidth of 36 kHz it is particularly suitable for operation in particular channels. Logarithmic indication over 60 dB, a switchselected squelch and AFC are ideal features for radiomonitoring. A built-in calibration oscillator together with linear indication facilitates the accurate measurement of received signals. A halfwave dipole is supplied with the set for accurate determination of field strength.

Laboratory use (applies to all models). In the laboratory the HFV is suitable as a selective microvoltmeter. The circuitry is designed to ensure good suppression of spuria and intermodulation. RF currents can be measured with the aid of the RF Current Probe ESU-Z (see recommended extras).

The **power supply** of the HFV is either from a local AC supply or from the built-in battery (about 7 hours of operation, charging time about 14 hours).

Specifications	
Frequency range	25 to 300 MHz
Setting error (temperature	
range +10 to +30 °C)	<±5 × 10 ⁻³ × f _{in} ±500 kHz 300 kHz/mm
AFC	switch-selected
Antenna	
25 to 60 MHz 60 to 300 MHz	shortened halfwave dipole
	tuneu nanwave ulpole
Models 02, 03 .	50.0
05	
VSWR Level switch position <20 dB	2 (typical)
≧20 dB	
IF/bandwidths/interference reject	
1st IF	400 MHz
2nd IF	120 kHz ±10%
05	36 kHz ±2 kHz
IF rejection	
RF leakage with battery op.	
Oscillator reradiation at RF input with match-termination	<30 µV
Measurement range, indication	
Measurement range, linear	
Voltage	0 to 100 dBμV
Field strength, min. 50-Ω model max. 50-Ω model	103 to 123 dBµV/m
Measurement range, logarithmic	
Measurement error Voltage measurement	<±2 dB
Field-strength measurement	<±4 dB
Indication	average/peak, switch-selected 20 dB
log	60 dB
Demodulation	AM/FM, switch-selected
	only in model 05, switch selected
Outputs	10.7 MHz 7
Video (only model 05)	0 to 16 kHz, $Z_{out} \approx 100 \text{ k}\Omega$
Phones	
	built-in, switch-selected
General data	110/115/125/220/235 V +10/-15%
	47 to 63 Hz (10 VA)
Charging	47 to 63 Hz (10 VA) 10 NiCd cells RS 1.8 (IEC KR 26/50) built-in charging circuit,
Dimensions	charging time 14 hrs
without leather case	367 mm×113 mm×270 mm
with leather case	428 mm×135 mm×294 mm
leather case)	9.5 kg
Ordering information	
Ū	
Order designations Field-strength Meter	► VHF Field-strength Meter HFV
without Pulse-weighting Unit	203 6018.02
with Pulse-weighting Unit . Test Receiver	
for radiomonitoring	203 6018.05
Accessories supplied	dipole antenna, tape measure.
	antenna-factor curve, leather case, power cable
Recommended extras	antenna-factor curve, leather case,
Headphones HFV-Z	antenna-factor curve, leather case, power cable 204.0220.00
Headphones HFV-Z DEAC cell (10 required) Clamp-on RF Current	antenna-factor curve, leather case, power cable 204.0220.00 020.3805.00
Headphones HFV-Z DEAC cell (10 required)	antenna-factor curve, leather case, power cable 204.0220.00 020.3805.00 100.1137.02

Recorder output (not floating)

8.5 V at fsd, required recorder input impedance $\geqq100~k\Omega$

VHF-UHF FIELD-STRENGTH METERS



Field-strength Meter HUF

- 20 to 1000 MHz
- Test assembly for measurements of propagation characteristics and coverage, antenna patterns and radio interference with CISPR and VDE weighting, radiomonitoring
- Two broadband antennas covering the whole frequency range
- Wide measurement range: -7.5 (+13) to 140 dB_µV/m ۲

The Field-strength Meter HUF is equally suitable for signaland interfering-field-strength measurements in the range 20 to 1000 MHz and for radiomonitoring.

The HUF consists of

Test Receiver ESV 20 to 1000 MHz (page 234), Broadband Dipole HUF-Z1 20 to 80 MHz, antenna mast and accessories.

The Test Receiver ESV (for description see page 234) constituting the heart of the system is ideal for portable use and manual operation. It features

- synthesizer technique affording crystal-referenced frequency indication
- high overload capacity and high overall selectivity
- AC-supply and battery operation

Four switch-selected IF bandwidths (7.5/12/120 kHz/1 MHz), AM and FM demodulators with switch-selected AF filter and adjustable squelch, four weighting modes (CISPR, peak with 3 s or 1 s hold time, and average) and three ranges of indication (20/40/60 dB) facilitate a great number of applications for useful-signal and interference measurements.

A built-in loudspeaker, a phone outpu, two IF outputs (one for connection of an IF analyzer), DC-coupled AM and FM demodulator outputs and recorder outputs for frequency deviation and level permit signal evaluation.

field-strength meters

Antennas. Broadband dipole of constant length for the range 20 to 80 MHz with compensated antenna impedance and approximately constant antenna factor in the range 25 to 80 MHz. For measurements above 80 MHz: log-periodic broadband antenna with a gain of 6.5 dB.

The antenna height on the mast can be adjusted from 1 to 5 m. The azimuth and polarization plane are freely adjustable; the elevation angle can be varied by $\pm 30^{\circ}$.

Field-strength measurement. Field strength in dBuV/m is obtained by adding the antenna factor k (in dB) and the measured voltage (in dBµV). The antenna factor of the broadband dipole is taken into account via the coding input of the ESV, so field strength can be read in $dB\mu V/m$ on the ESV in the range 25 to 80 MHz.

Programmed field-strength measurements are possible using the Test Receiver ESVP (20 to 1300 MHz, page 238.

interference field measurement. The HUF is a standard instrument for radio interference measurements in line with national and international (CISPR) specifications.

Accessory units, see under ESV, page 234.

Specifications	
opeemeations	
Frequency range Measurement range	20 to 1000 MHz
lower limit	-7.5 to +13 dBuV/m
upper limit	140 dBµV/m')
Measurement error	<3 dB including antenna
Test receiver	Test Resolver ESV 20 to 1000 MHz
Antenna input	50 O: N female connector
Antenna input Measurement range	-10 to ± 137 dBuV
Measurement error	<1.5 dB
Antennas	
Broadband Dipole HUF-Z1	20 to 80 MHz
Antenna connector	50 Ω. N female
VSWR	
Antenna factor k	22.5 to 14 dB (frequency-depen-
	dent) ²)
Dimensions, weight	
	0.9 m long, 0.13 m dia ; 2.5 kg
Log-periodic Broadband	
Antenna HL 023 AL	
Connector	
VSWR	<2 (up to 1000 MHz) 2 5 to 23 dB in range 80 to 1000 MHz
	frequency-dependent
Dimensions, weight	length 1.7 m width 2 m
	knocked down 1 7 m×0 5 m; 5 kg
Antenna mast (epoxy glass)	
Adjustment ranges	
Antenna height	1 to 5 m
Polarization	any
Azimuth	
Elevation	
Dimensions, weight	
	36 kg (incl. accessories)
Tripod HFU-Z	
	down), 9 kg
Order decignation	Eigld strength Motor HUE
Order designation	
	354,1520,53
System breakdown (delivery of indiv	354,1520,53 vidual items possible)
System breakdown (delivery of indiv Test Receiver ESV	354.1520.53 vidual items possible) 342.4020.53
System breakdown (delivery of indiv Test Receiver ESV Broadband Dipole HUF-Z1	354,1520,53 vidual items possible) 342,4020,53 358,0512,52
System breakdown (delivery of indiv Test Receiver ESV Broadband Dipole HUF-21 LP Broadband Antenna HL 023 AL	354,1520,53 /idual items possible) 342,4020,53 358,0512,52 577,8017,02
System breakdown (delivery of indiv Test Receiver ESV Broadband Dipole HUF-Z1	354,1520,53 /idual items possible) 342,4020,53 358,0512,52 577,8017,02
System breakdown (delivery of indiv Test Receiver ESV Broadband Dipole HUF-Z1 LP Broadband Antenna HL 023 AL Tripod HFU-Z Mast with swivel arm and antenna bracket, HFU-Z	354,1520,53 //dual items possible) 342,4020,53 358,0512,52 577,8017,02 100,1114,02 100,1120,02
System breakdown (delivery of indiv Test Receiver ESV Broadband Dipole HUF-Z1 LP Broadband Antenna HL 023 AL Tripod HFU-Z Mast with swivel arm and antenna bracket, HFU-Z Connecting Cable HFU-Z5, 7 m long	354,1520,53 /idual items possible) 342,4020,53 358,0512,52 577,8017,02 100,1114,02 100,1120,02 252,0055,55
System breakdown (delivery of indiv Test Receiver ESV Broadband Dipole HUF-Z1 LP Broadband Antenna HL 023 AL Tripod HFU-Z Mast with swivel arm and antenna bracket, HFU-Z	354,1520,53 /idual items possible) 342,4020,53 358,0512,52 577,8017,02 100,1114,02 100,1120,02 252,0055,55
System breakdown (delivery of indiv Test Receiver ESV Broadband Dipole HUF-Z1 LP Broadband Antenna HL 023 AL Tripod HFU-Z Mast with swivel arm and antenna bracket, HFU-Z Connecting Cable HFU-Z5, 7 m long	354,1520,53 /idual items possible) 342,4020,53 358,0512,52 577,8017,02 100,1114,02 100,1120,02 252,0055,55
System breakdown (delivery of indiv Test Receiver ESV Broadband Dipole HUF-Z1 LP Broadband Antenna HL 023 AL Tripod HFU-Z Mast with swivel arm and antenna bracket, HFU-Z Connecting Cable HFU-Z5, 7 m long Headphones	354.1520.53 /idual items possible) 342.4020.53 358.0512.52 577.8017.02 100.1114.02 100.1120.02 252.0055.55 110.2959.00
System breakdown (delivery of indiv Test Receiver ESV Broadband Dipole HUF-Z1 LP Broadband Antenna HL 023 AL Tripod HFU-Z Mast with swivel arm and antenna bracket, HFU-Z Connecting Cable HFU-Z5, 7 m long	354,1520,53 idual items possible) 342,4020,53 358,0512,52 577,8017,02 100,1114,02 100,1120,02 252,0055,55 110,2959,00 frequency dependent. The ESV

handling capacity of the internal attenuators of the Broadband Dipole HUF-21 is also 140 dB_iU/m.
 ²) On delivery, the HUF-Z1 has an antenna factor higher by 5 dB for coding on the ESV. The antenna factor here specified can be obtained by changing two soldered links.

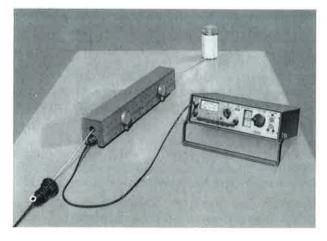
Absorbing Clamp MDS-21 ♦ 30 to 1000 MHz

- Direct measurement of RF interference power on power cords and connecting cables of electrical appliances
- Meter reading in dBµV on interference measuring receiver corresponds to RF interference power in dBpW



Measurement of interference power in the VHF range

For perfect reception of radio and television signals, interference from electrical appliances must be kept within certain limits. The amount of interference from an interference source is expressed in terms of voltage, power, current or field strength. On account of direct radiation, the interference in the metric-wave range has up to now been defined as the field strength prevailing at a certain distance. The reliability of this rather inconvenient measurement depends on numerous parameters. The absorbing clamp*) considerably simplifies measurements on interference sources whose dimensions are small compared to the wavelength.



Test setup consisting of VHF Field-strength Meter HFV and Absorbing Clamp for the measurement of interference power

The **Absorbing Clamp** MDS-21 in conjunction with an interference measuring receiver according to CISPR, Publ. 2, e.g. ESV, permits the interference to be measured directly as the noise power introduced by the interference source in the power cord. Measurements with the MDS Absorbing Clamp are easier and more reliable than field-strength measurements. Moreover, the Absorbing Clamp is insensitive to external radiation. Operating priciple and functioning. Interference is mainly radiated from the power cord of the interference source. For this reason, a ferrite absorber is provided inside the MDS Absorbing Clamp, which encircles the power cord and acts as a resistance to the RF interference power. A calibrated interference-measuring receiver, connected to the input, measures the RF current flowing through the absorber via a current converter. Because, with this arrangement, there is no matching between the interference source, the power cable and the absorber, the Absorbing Clamp must be slid along the power cord to adjust for maximum interference power. By suitable design of the absorber and choice of the conversion ratio of the current converter, the reading obtained on the calibrated interference-measuring receiver in dB μ V corresponds to a power indication in dBpW.

Construction The units consist of a plastic case of two parts hinged together, each containing a set of ferrite ring halves. These are fixed in plastic spring holders, thus forming a duct for the power cord of the interfering appliance. Eccentric catches provide the required contact pressure. Rollers are provided to facilitate moving the Absorbing Clamp when searching for interference maxima.

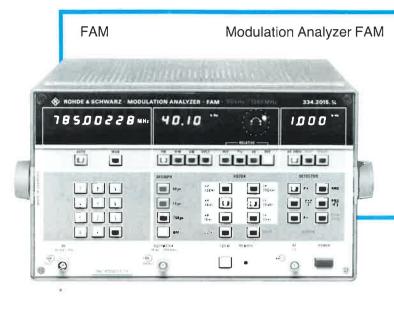
MDS-21 version up to 1000 MHz. Effective shielding and use of a correction curve make radio-interference measurements on lines and cables possible up to 1000 MHz.

Specifications	
Diameter of appliance power cable Dimensions, weight	
Order designation	Absorbing Clamp MDS-21 (50 Ω) 194.0100.50
Accessories supplied	1 coaxial cable (MDS → interference receiver), 5 m long, with BNC male connectors

^{*)} after Meyer de Stadelhofen (Switzerland)

MODULATION METERS

IEC 625 Bus



۲ 55 kHz to 120 (1360) MHz

- Microprocessor-controlled unit for analyses of modulated RF signal, with simultaneous frequency measurement
- Modulation measurement with AM, FM and ϕM
- Switch-selected highpass and lowpass filters for various test bandwidths; CCITT and CCIR weighting filters
- Modulating-signal measurement using weighting filters (AF voltmeter or psophometer function)
- IEC-bus-compatible



The Modulation Analyzer FAM offers a maximum of convenience for modulation measurements on AM, FM and phasemodulated signals. All functions being microprocessor-controlled, manual operation is reduced to a minimum. Modulation measurements over a range of carrier frequencies from 55 kHz to 1360 MHz are performed more precisely and more easily with the FAM than with previously available equipment. The IEC-bus interface makes the instrument systemcompatible and suitable for use in automated test assemblies.

Types of measurements. The Modulation Analyzer can be used for measurements otherwise calling for up to five different instruments. It features the following capabilities:

- Measurement of modulation depth, frequency deviation and phase deviation
- Simultaneous carrier-frequency measurement with 1 Hz or 10 Hz resolution
- Measurement of modulation frequency with 1 Hz resolution
- Distortion measurement down to <0.1%, also SINAD indication in dB
- AF voltage measurement with weighting filters (psophometer function)
- Evaluation of external AF signals

Unwanted modulation can be measured and weighted accurately on account of switch-selected test bandwidths and standard weighting filters.

Field of application. The basic model covers a carrierfrequency range of 55 kHz to 120 MHz and offers a very economical and high-performance solution for measuring tasks in FM and AM broadcasting and certain radiotelephony and other radio services.

The Frequency-range Extension Option - which can be fitted when the main unit is originally produced, or added later - extends the frequency range up to 1360 MHz, thus covering practically all radio services.

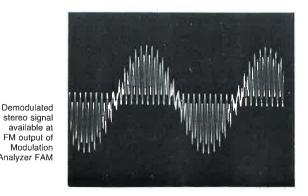
Special features. The FAM exhibits negligible inherent noise and excellent linearity.

Residual FM being less than 1 Hz in the basic frequency range (proportionally increasing above) with CCITT weighting and 5 Hz with 20 kHz weighting bandwidth, whilst residual AM is as low as 0.01%, the FAM permits unwanted modulation to be measured precisely.

The FM stereo noise of FAM model 54, being -72 dB referred to 40 kHz deviation, CCIR weighting, permits precise S/N-ratio measurements, say, on FM broadcast transmitters.

The transmission linearity of the FAM fulfils the exacting demands involved in wideband modulation methods used, for example, in FM broadcasting. Excellent amplitude and phase linearity make distortion-free demodulation of multiplex signals possible; see application example on page 258.

Distortion of less than 0.1% and crosstalk attenuation of 50 dB guarantee accurate results of measurement.



stereo signal available at FM output of Modulation Analyzer FAM

modulation analyzers

MODULATION METERS

Setting, Measurement, Display

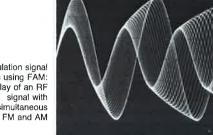
The front panel of the FAM is divided into three functional sections for easy operation and clear presentation of the results, several parameters being displayed simultaneously:

Left-hand section	Carrier-frequency display and entry (with manual tuning)
Middle section	Result display and setting of operating modes
Right-hand section	Modulating-signal display measuring section for modulating frequency, distortion, SINAD

Modulation measurement, display. The middle section is used for setting the type of modulation and time constant. selecting the filter and displaying the modulation measurement result. An additional, analog display in the form of a light spot moving around a circle greatly facilitates adjustments by providing trend indication. The user simply selects the type of modulation – AM, FM or ϕ M – and, with FM, one of three deemphasis time constants. The Modulation Analyzer demodulates signals of any mode of modulation including simultaneous FM and AM; see photo below.



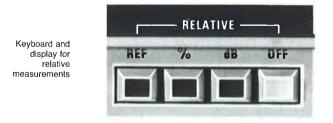
Front panel section; display of modulation measurement results and setting of operating modes



Modulation signal analysis using FAM: display of an RF signal with simultaneous

> Weigthing. Three HP and three LP filters provide a great variety of weighting bandwidths and suppress unwanted signals. CCITT and CCIR standard filters (perceived loudness) can be inserted or retrofitted as options for standard S/N measurements.

> Display of results (absolute or relative). The measured modulation can be desplayed as an absolute value or relative to a key-entered reference value. This is very convenient if modulation is to be determined as a function of modulation frequency or carrier frequency.



Frequency setting. Setting is performed fully automatically under microprocessor control; see description on next page. When a signal is applied, the FAM tunes automatically to the input frequency within 3 s and displays this frequency in the I. h. section with a resolution of 10 Hz.

If automatic tuning is not desired in specific cases, the frequency can be set via the keyboard (this is important for instance when measuring selective calling equipment, with data transmission and other techniques where no continuous signal is available).

For such specific measurements, the other automatic functions can also be suppressed. RF atenuator or AF range can be held at or brought to a particular setting.

The high resolution ($\leq 0.25\%$) and the high accuracy of the modulation depth indication (1.5%) permit precise measurements without needing recalibration.

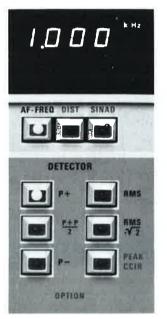
Type of detection. The measurement of the AF modulating-signal amplitude can be performed either with peak responding detection (most frequently employed for measuring wanted modulation) or with rms responding detection (for example for measuring unwanted modulation). The CCIR weighting filter option includes the prescribed quasi-peak responding detector.

7 MODULATION METERS

modulation analyzers

Modulation Analyzer FAM, continued

Modulation-frequency/distortion measurement. The frequency of the modulating signal is displayed in the r. h. section of the front panel. The 0.1-Hz resolution is required for measuring frequencies of calling signals or code signals for squelch switching.



Front-panel section: display and keyboard for modulating-frequency and distortion measurement

Option FAM-B8 is available for **measuring the distortion** of the modulating signal. Measurements can be made at 30 fixed frequencies from 30 Hz to 20 kHz. The measurement is automatically initiated by the microprocessor when the frequency of the modulating signal lies within the measurement range. The FAM displays

either distortion in % or SINAD in dB.

Evaluation of external AF signals. The AF section, comprising the weighting filter, frequency counter, detector and distortion meter, can be used for the evaluation of an external AF signal via a separate input socket. The Modulation Analyzer can thus be used as an automatic AF voltmeter and as a psophometer.

IEC-bus interface. The Modulation Analyzer has an IECbus interface so it can be controlled by an external computer, e.g. the R&S Process Controller PUC. The FAM can receive setting and trigger instructions and can output measured data to the computer, meaning that it can function as both listener and talker. Thus it is suitable for use in automatic measuring systems for testing transmitters and transceivers in development, production and quality control.

Description

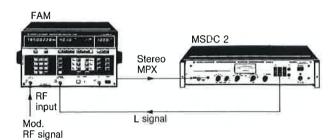
The FAM is made up of RF, IF and AF sections and the microcomputer circuitry. The RF section contains a counter for measuring the frequency of the input signal, an AGC stage and a mixer. The IF section comprises AM and FM demodulators and the AF section evaluates the demodulated signal. The microprocessor handles the settings, data acquisition, and I/O operations of keyboard and display.

Sepcial features of the RF section. The input frequency range of the FAM basic unit is 55 kHz to 120 MHz divided into two bands: frequencies up to 3.5 MHz are processed directly in the IF section, those between 3.5 and 120 MHz undergo a

single frequency conversion. A frequency-range-extension option adds a third band above 120 MHz with double frequency conversion.

The microprocessor detects the presence of an input signal by a search process using level detectors in the RF and IF sections and a frequency counter. From this information it derives the setting of the first local oscillator and performs the RF level adjustment.

Input signals above 120 MHz are converted to the range below 120 MHz by the second local oscillator when the 1.36-MHz Frequency-range Extension option is used. The microprocessor calculates the input frequency from the frequency of the second local oscillator. The input frequency is displayed.



Measurement of stereo multiplex signals using Modulation Analyzer FAM

Extensions (options)

The FAM can be delivered or retrofitted with a number of options to suit different requirements:

1-GHz/1.36-GHz Frequency-range Extensions FAM-B2

extend the frequency range of the FAM up to 1000 or 1360 MHz (two models with otherwise equal characteristics).

CCITT Weighting Filter FAM-B6

for weighted measurement of unwanted modulation using standard perceived-loudness-characteristic filter.

CCIR Weighting Filter FAM-B7

for weighted measurement of unwanted modulation using standard perceived-loudness-characteristic filter. The required quasi-peak-responding detector is built in.

DIST and SINAD Meter FAM-B8

for automatic measurement of modulation distortion, including external signals at 30 fixed frequencies from 30 Hz to 20 kHz.

Reference Oscillator SMS-B1

temperature controlled, improves the frequency stability (temperature coefficient 1×10^{-7} in the operating temperature range; crystal aging 5×10^{-8} /month).

Specifications

Frequency range
With option FAM-B2 1.36 GHz 55 kHz to 1360 MHz
With option FAM-B2 1 GHz
Frequency setting automatic ¹) or manual
Display 8 digits
Resolution, f <1000 MHz 10 Hz or 1 Hz
f ≧1000 MHz 100 Hz or 10 Hz
Frequency error and drift ±1 digit + error of reference freq.
Reference oscillator standard option SMS-B1
Crystal aging
Temperature coefficient
total op. range
Frequency measurement and automatic tuning for AM ≦80%;
for $f_{ln} \ge 550$ MHz up to 60%.

modulation analyzers

MODULATION METERS 7

RF Input	7. = 50.0 PM	IC female connector
Input level range	$\Delta n = 50 \Omega, BN$	C lemale connector
55 kHz to 550 MHz	10 mV to 3 V	(-27 to +22.5 dBm)
550 to 1050 MHz	20 mV to 3 V	(-21 to +22.5 dBm)
1050 to 1360 MHz RF attenuator programmable	30 mV to 3 V	(-17 to +22.5 dBm)
Amplitude modulation measurem		
Modulation frequency range		Hz Iz for f _{in} <3.5 MHz
Max. measurable modulation depth	100%	
Display	4 digits + anal	og indication
Units	absolute: %: re	elative: % or dB
Resolution Error (peak-resp. detector)	0.25% (of read	ing), max.: 0.005% (AM)
(nlus neak residual AM)		
f _{mod} 30 Hz to 60 kHz 60 to 100 kHz Residual AM ²) weighted with	≦±2%	≦±5%
60 to 100 kHz	≦±4%	≦±10%
CCITT filters (rmsresp.	≧550 MHZ	>550 MHZ
detector)	≦0.01%	≦0.02%
Weighting bandwidth		
30 Hz to 20 kHz CCIR weighting	≦0.05% ≤0.05%	≦0.05% ≤0.1%
Incidental AM with FM ³)	=0.03 %	=0.176
(f _{mod} 1 kHz, 50 kHz deviation,		
meas. bandwidth 30 Hz to 3 kHz)	0.1%	
AF distortion (at AF output;	<120 MH-	>120 MH~
f _{mod} 30 Hz to 20 kHz) 40% mod 40 to 80% mod	≦0.2%	>120 MHz ≦0.4% ≤0.6%
		≦0.6%
AM modulation range programmable	Э	
Frequency modulation measurem	ent (with input f	frequ. ≧4.25 MHz)
Modulation frequency range		
Max. measurable frequency		
deviation		og indigation
DisplayUnits		
Resolution		
Error	deviation ≦100) kHz dev. >100 kHz
with peak -resp. detector (plus)	Seak residual FN	M)
f _{mod} 30 Hz to 60 kHz 60 to 100 kHz	≤±1.5% ≤±3%	≦±3% ≦±6%
with rmsresp. detector (plus p	eak residual FM)
fmod 30 Hz to 60 kHz	≦±3%	≦±3%
60 to 100 kHz		≦±6%
Residual FM at f	≦120 120 to	550 to 1050 to
With COLT which the set	MINZ 550 MIN	z 1050 MHz 1360 MHz
With CCITT weighting and rmsresp. detector	<1 Hz <3 Hz	<6 Hz <12 Hz
Weighting bandwidth 30 Hz	=1112 =0112	=0112 =12112
to 20 kHz, with rmsresp.		
detector With CCIR weighting and	≦5 Hz ≦14 Hz	: ≦25 Hz ≦ 50 Hz
deemphasis and squelch	≦6 Hz —	
Stereo S/N ratio (CCIR)		
ref. to 40 kHz deviation		
$(f_{in} \le 120 \text{ MHz}, V_{in} \ge 20 \text{ mV}) \dots$ Incidental FM with AM	72 dB, typical	
$(f_{mod} 1 \text{ kHz}, \text{m} = 50\%; \text{test}$		
bandwidth 30 Hz to 3 kHz)	≦20 Hz	
AF distortion (at AF output;		
f _{mod} 30 Hz to 20 kHz) 75 kHz deviation	50.1%	
500 kHz deviation		(reg. >10 MHz)
Stereo separation		
at fmod 30 Hz to 15 kHz	≧46 (typ. 50) d	B at stereo output
f _{mod} 1 kHz Deemphasis	≤50 0B 50/75/750 up	switch-selected
FM modulation range programmable)	Smithreeletteu
Phase modulation measurement (
Modulation frequency range		
Maximum measurable phase		
deviation	500 rad (up to	1 kHz modfreq.)
Display	4 digits + anale	og indication
Units	0.25% max : 0	elative: %, 08
Error with peak-resp. detector	$\leq \pm 3.5\% \pm 0.6\%$	ak residuat @M
with rmsresp. detector	≦+5% +resi	dual φM
Residual φM at f≦		550 to 1050 to
		z 1050 MHz1360 MHz
Weighted with CCITT filter: . rad ≤	0.002 ≦0.003	≦0.006 ≦0.012
bandwidth 30 Hz to 20 kHz: . rad \leq AF distortion (at AF output),	0.005 20.01	≥0.02 ≥0.04
deviation 4 rad≦		
φM modulation range programmable		

²) With input level 6 dB above minimum; >250 mV for f_{in} <3.6 MHz.
 ³) In frequency range specified for FM measurement.
 ⁴) Only for retrofitting in earlier FAM models.

AF detector			
Peak-responding detector	positive or negative	peak of AF or	
	their arithmetic mea	าก	
Hms-responding detector	true rms response, indication as rms or for sinewave converted to peak; crest factor 10		
Weighting filters			
High pass (1-dB cutoff			
frequency		3 by changing	
	connection), 30 Hz and 300 Hz	(12 dB/octave)	
Low pass (3-dB cutoff frequency)	3/20/200 kHz(24 d	B/octave min.)	
CCIR filter (option FAM-B7)	Rec. P53 weighting network :	acc. to CCIR	
	Rec. 468-2 (Rev. 7	8) combined with	
	quasi-peak detecto	r i la	
AF frequency display			
Frequency range Display			
Resolution			
Error at f >100 Hz	. ±1% at S/N >40 (dΒ	
f <100 Hz			
Distortion measurement		3	
Test frequencies (total of 30)	30/40 to 100 Hz 200/300 to 1000 H	7	
	2/3 to 10 kHz		
Automatia husing (O/blackor)	12.5/15/17.5/20 k		
Automatic tuning (S/N >30 dB)	automatic audiabali	when fragments	
Display	is outside of measu	rable range	
Display	4 digits, THD in %	or SINAD in dB	
Display range Error (THD ≦10%)	0.1 10 50%, 6 10 60	D OB (SINAD)	
Test frequency programmable			
AF voltmeter			
Frequency range			
Measurement range Display	0.1 mV to 3 V (ma)	. 5 V peak)	
Units		ve: %, dB	
Resolution	0.1 mV		
Error with LP 3/20 kHz without LP	$\ge \pm 1.5\% \pm 0.1 \text{ m}$ $\le \pm 1.5\% \pm 0.4 \text{ m}$	((30 Hz to 60 kHz)	
	$\leq +3\% +0.4 \text{ mV}/$	60 to 100 kHz)	
Weighting	all AF measuring fa	cilities in the FAM	
	(detectors, weightin frequency counter,		
	meter) can also be	used in voltage	
Innut	measurements (ex		
Input	Z _{In} ≧400 kΩ 300 female connector	pr, noating; BNC	
Voltage range programmable			
Outputs			
AM signal output (Vme)	max. 1 V across 2	kΩ at 100% mod	
FM stereo signal output (Vms)	1.5 V at 40 kHz de	v. corresp. to	
	+ 6 dBm across 6 see FM)		
AF output (V _{rms})	. 350 mV to 1 V dep	ending on	
	modulation of AF v	oltage	
IEC-bus Interface		00).	
	IEC 625-1 (IEEE 4 24-pin Amphenol c		
Listener and talker functions	. AH1, T4, L2, RL1,	DC1	
Measurement time (frequency, RF			
	with frequency reso 10 Hz/100 Hz		
For triggered RF and	10 HZ/100 HZ	TAEL2	
modulation measurement		C 00070	
FM, φM AM		≦2050 ms ≦2300 ms	
General Data		110 110	
Operating temperature range	+ 5 to +45°C		
Storage temperature range	~-40 to +70°C		
Power supply	47 to 440 Up (00 to	(A) and also also also	
Dimensions, weight	47 to 440 Hz (80 V 347 mm × 206 mm	\times 370 mm, 12 kg	
		,	
Ordering information			
Order designation	Modulation Analy	/zer FAM	
FAM 55 kHz to 120 MHz	334.2015.54		
Accessories supplied	power cable, adapt	er (IOFPC boards)	
Options Reference Oscillator	SMS.R1 202.00	18.02	
1.36-GHz Frequency-range		1	
Extension	FAM-B2 334.491	8.02	
1-GHz Frequency-range	FAM-B2 324 404	8.04	
1-GHz Frequency-range Extension	FAM-B2 334.491 FAM-B4 334.591	8.04 4.02	
1-GHz Frequency-range Extension IEC-625-1 Interface ⁴) CCITT Filter	FAM-B4 334.591 FAM-B6 334.561	4.02	
1-GHz Frequency-range Extension IEC-625-1 Interface ⁴) CCITT Filter CCIR Filter	FAM-B4 334.591 FAM-B6 334.561 FAM-B7 334.551	4.02 4.02 4.02	
1-GHz Frequency-range Extension IEC-625-1 Interface ⁴) CCITT Filter	FAM-B4 334.59 FAM-B6 334.56 FAM-B7 334.55 FAM-B8 334.57	4.02 4.02 4.02 4.02	

259

XYT Recorder ZSKT, a general-purpose two-axis recorder details on page 264

14

and the second s

.....

......

......

HSZ

XAL - RECO

х л.1 - 201 вонов . .

....



8 XY-YT RECORDERS

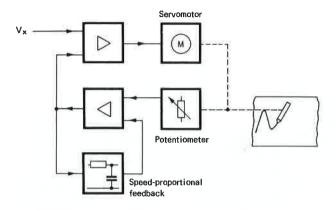
recorders

Introduction

A quantity recorded as a function of time or of another variable can be readily interpreted and precisely evaluated.

Principle of potentiometer-type recorders

The self-balancing potentiometer principle is illustrated in the following diagram:

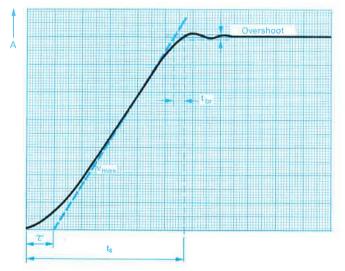


Simplified diagram of potentiometer-type recorder

The input voltage V_x is compared with the output voltage of the balance potentiometer, which is fed from a reference voltage source. If there is a difference, the motor acts on the potentiometer and thereby on the stylus until balance is restored. The speed-proportional feedback affords optimal damping of the system.

Dynamic behaviour of the potentiometer-type recorder

Whether a quickly varying quantity is represented faithfully depends on the dynamic characteristics of the recorder. The step function is most commonly used to test a recorder for maximum writing speed, time constant of recording system and overshoot or damping. The typical step function is shown below:



Step function of a recorder and definition of terms

The servomotor has reached its final speed v_{max} after about 3 τ . The asymptote to the slewing function with the slope v_{max} intersects with the time axis at the point τ .

The braking force of the servomotor is greater than the starting force, since the polarity is reversed at full rpm; therefore an optimally damped system has a shorter braking time than starting time, typically about 0.5τ .

The settling time is the sum of starting time τ , running time at constant speed v_{max} and braking time $t_{br}\approx 0.5~\tau$ (see diagram). For a step of amplitude A the settling time is obtained as

$$t_s \approx 1.5\tau + \frac{A}{v_{max}}$$

The time constant of the servosystem can also be determined from the starting acceleration "a", which is specified by many manufacturers, and the final speed v_{max}

 $\tau = \frac{v_{max}}{a}$.

Here it is to be noted that "a" is the starting acceleration from standstill and not equal to the maximum acceleration a_{max} during braking, which is in practice about 1.5 a to 1.8 a.

Some basic concepts

Linearity. The departure of indication from linear response is stated in percent of the calibrated width of the chart as a function of the input level.

Reproducibility (hysteresis, deadband). Coincidence obtained with repeated plotting of the same pairs of values or time functions. (Hysteresis or deadband designates the departure occuring with repeated plotting of the same value, referred to the higher or lower values; the departure is stated in percent of the calibrated width of the chart.)

Maximum writing speed v_{max} . Final speed of the recording carriage produced by the servomotor in response to a step function on one coordinate axis.

Time constant τ . Characteristic quantity of the servo system, indicating the time required by the recording carriage to reach 63% of the maximum writing speed.

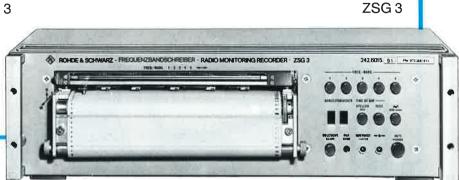
Settling time t_s . Time the stylus takes with a step function from the start until it reaches the full amplitude to within ± 1 mm without exceeding this tolerance again.

recorders

RADIOMONITORING RECORDERS 8

Radiomonitoring Recorder ZSG 3

- Electro-sensitive recording of radio signals with automatic time-of-day printout
- Five individually selected frequency markers
- Visible and audible end-of-paper signals



Characteristics and uses

The **Radiomonitoring Recorder ZSG 3** records the radio signals picked up within a selected frequency band by a receiving system, thus constituting a valuable supplement for radiomonitoring stations.

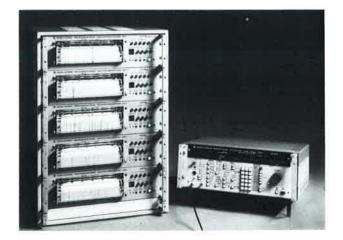
The signals are traced on electrosensitive paper in the form of horizontal lines. The sawtooth voltage which tunes the receiver is also used to control the stylus over a chart width of 200 mm. The deflection of the recording electrode is thus a measure of the instantaneous reception frequency. The recorded trace length depends upon the adjusted threshold, the receiver bandwidth and the field strength. Recording by means of the voltage-controlled electrode is only effected during the forward sweep. A constant paper feed gives an accurate time scale, which is 30 or 60 s/line when the ZSG 3 is used in conjunction with the Radiomonitoring/Recording System MFBR.

Orientation and evaluation are facilitated by additionally recording up to five frequency markers. The ZSG 3 also records every full hour on the righthand margin.

Description

The Radiomonitoring Recorder ZSG 3 operates on the principle of the self-balancing potentiometer. The input V_{e} must be a sawtooth voltage which also tunes the receiver of the

Up to five frequency bands (with adjustable thresholds) can be recorded simultaneously in conjunction with a single Test Receiver ESH 3 (see also "Data-logging capabilities" on page 227)



radiomonitoring/recording system. Recording is electrosensitive, producing a black trace at the point where the recording electrode touches the paper when the electrode voltage is applied. This so-called Z control is accomplished by the processed signal of the receiver output.

An additional recording device, controlled by the paper feed and the hours pulse derived from a clock system, records every full hour on the righthand margin by way of sevensegment figures.

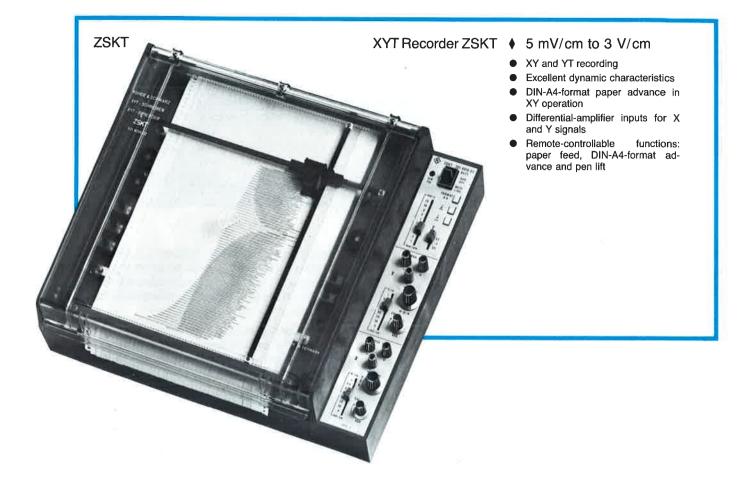
Specifications

242,7863,00

Recording principle	voltage-controlled recording head
Recording voltage	<42 Vms
Intensitiv control	
Recording paper	electrosensitive, blanck paper
Size of paper roll	width 230 mm, diameter 50 mm.
one of paper for the transferrer	length 20 m
Paper feed	
Advance	
Free running	
Paper-advance control	by return pulse of sawtooth (TTL)
Paper output	nowing out or rolled up
End-of-paper signal	pliot lamp and buzzer
Time-of-day recording	
	on righthand margin
Control	by hour pulse from a clock system
	(TTL or contact)
Time setting at beginning	
of recording	by pushbutton and 7-segment
	readout on front panel
Frequency markers	by 5 manually adjustable electrodes,
	individually selected by pushbuttons
Z control	digital or analog
Digital	with TT cional
Analog (adi threahold)	with TTE Signal $0 \neq 0 \neq 0$
Analog (adj. threshold)	$100 + 100$, $n_{in} - 200$ M2
Output	TTL signal
0. 1. 11	
Servo circuit	
Deflection factor	0.5 V/cm (+10 V for 20 cm)
Deflection factor	0.5 V/cm (+10 V for 20 cm) differential input, floating: $R_{in} = 40 \text{ K}\Omega$
Deflection factor	differential input, floating; $R_{in} = 40 \text{ K}\Omega$
Deflection factor	differential input, floating; $R_{in} = 40 \text{ K}\Omega$ ±0.1% of fsd (±0.2 mm)
Deflection factor	differential input, floating; $R_{in} = 40 \text{ K}\Omega$ ±0.1% of fsd (±0.2 mm) 200 mm
Deflection factor Input Nonlinearity Calibrated chart width Overlow	differential input, floating; $R_{in} = 40 \text{ K}\Omega$ ±0.1% of fsd (±0.2 mm) 200 mm 2 mm to the right and to the left
Deflection factor Input Nonlinearity Calibrated chart width Overlow Position of zero	differential input, floating; $R_{in} = 40 \text{ K}\Omega$ ±0.1% of fsd (±0.2 mm) 200 mm 2 mm to the right and to the left left, setting range ±2 cm
Deflection factor Input Nonlinearity Calibrated chart width Overlow	differential input, floating; $R_{in} = 40 \text{ K}\Omega$ ±0.1% of fsd (±0.2 mm) 200 mm 2 mm to the right and to the left left, setting range ±2 cm
Deflection factor Input Nonlinearity Calibrated chart width Overlow Position of zero Maximum recording speed	differential input, floating; $R_{in} = 40 \text{ K}\Omega$ ±0.1% of fsd (±0.2 mm) 200 mm 2 mm to the right and to the left left, setting range ±2 cm
Deflection factor Input Nonlinearity Calibrated chart width Overlow Position of zero Maximum recording speed General data	differential input, floating; $R_{in} = 40 \text{ K}\Omega \pm 0.1\%$ of fsd (±0.2 mm) 200 mm 2 mm to the right and to the left left, setting range ±2 cm 20 cm/s
Deflection factor Input	differential input, floating; $R_{in} = 40 \text{ K}\Omega \pm 0.1\%$ of fsd (±0.2 mm) 200 mm 2 mm to the right and to the left left, setting range ±2 cm 20 cm/s 36-pole female at the rear
Deflection factor Input	differential input, floating; $R_{in} = 40 \text{ K}\Omega \pm 0.1\%$ of fsd (±0.2 mm) 200 mm 2 mm to the right and to the left left, setting range ±2 cm 20 cm/s 36-pole female at the rear
Deflection factor Input Nonlinearity Calibrated chart width Overlow Position of zero Maximum recording speed General data Connectors Rated temperature range	differential input, floating; R _{in} = 40 KΩ ±0.1% of fsd (±0.2 mm) 200 mm 2 mm to the right and to the left left, setting range ±2 cm 20 cm/s 36-pole female at the rear +10 to +35°C
Deflection factor Input Nonlinearity Calibrated chart width Overlow Position of zero Maximum recording speed General data Connectors Rated temperature range	differential input, floating; $R_{in} = 40 \text{ K}\Omega \pm 0.1\%$ of fsd (±0.2 mm) 200 mm 2 mm to the right and to the left left, setting range ±2 cm 20 cm/s 36-pole female at the rear
Deflection factor Input Nonlinearity Calibrated chart width Overlow Position of zero Maximum recording speed General data Connectors Rated temperature range AC supply	differential input, floating; $R_{in} = 40 \text{ K}\Omega \pm 0.1\% \text{ of fsd } (\pm 0.2 \text{ mm})$ 200 mm 2 mm to the right and to the left left, setting range $\pm 2 \text{ cm}$ 20 cm/s 36-pole female at the rear $\pm 10 \text{ to } \pm 35^{\circ}\text{C}$ 115/125/220/235 V $\pm 10\%$, 100 VA (3 A)
Deflection factor Input Nonlinearity Calibrated chart width Overlow Position of zero Maximum recording speed General data Connectors Rated temperature range AC supply Dimensions	differential input, floating; $R_{in} = 40 \text{ K}\Omega \pm 0.1\%$ of fsd (±0.2 mm) 200 mm 2 mm to the right and to the left left, setting range ±2 cm 20 cm/s 36-pole female at the rear +10 to +35°C 115/125/220/235 V ±10%, 100 VA (3 A) 484 mm×150 mm×436 mm
Deflection factor Input	differential input, floating; $R_{in} = 40 \text{ K}\Omega \pm 0.1\%$ of fsd (±0.2 mm) 200 mm 2 mm to the right and to the left left, setting range ±2 cm 20 cm/s 36-pole female at the rear +10 to +35°C 115/125/220/235 V ±10%, 100 VA (3 A) 484 mm×150 mm×436 mm 12.6 kg
Deflection factor Input Nonlinearity Calibrated chart width Overlow Position of zero Maximum recording speed General data Connectors Rated temperature range AC supply Dimensions	differential input, floating; $R_{in} = 40 \text{ K}\Omega \pm 0.1\%$ of fsd (±0.2 mm) 200 mm 2 mm to the right and to the left left, setting range ±2 cm 20 cm/s 36-pole female at the rear +10 to +35°C 115/125/220/235 V ±10%, 100 VA (3 A) 484 mm×150 mm×436 mm 12.6 kg
Deflection factor Input	differential input, floating; $R_{in} = 40 \text{ K}\Omega \pm 0.1\%$ of fsd (±0.2 mm) 200 mm 2 mm to the right and to the left left, setting range ±2 cm 20 cm/s 36-pole female at the rear +10 to +35°C 115/125/220/235 V ±10%, 100 VA (3 A) 484 mm×150 mm×436 mm 12.6 kg
Deflection factor Input Nonlinearity Calibrated chart width Overlow Position of zero Maximum recording speed General data Connectors Rated temperature range AC supply Dimensions Weight, cabinet included	differential input, floating; $R_{in} = 40 \text{ K}\Omega \pm 0.1\%$ of fsd (±0.2 mm) 200 mm 2 mm to the right and to the left left, setting range ±2 cm 20 cm/s 36-pole female at the rear +10 to +35°C 115/125/220/235 V ±10%, 100 VA (3 A) 484 mm×150 mm×436 mm 12.6 kg
Deflection factor Input	differential input, floating; $R_{in} = 40 \text{ K}\Omega \pm 0.1\%$ of fsd (±0.2 mm) 200 mm 2 mm to the right and to the left left, setting range ±2 cm 20 cm/s 36-pole female at the rear +10 to +35°C 115/125/220/235 V ±10%, 100 VA (3 A) 484 mm×150 mm×436 mm 12.6 kg
Deflection factor Input Nonlinearity Calibrated chart width Overlow Position of zero Maximum recording speed General data Connectors Rated temperature range AC supply Dimensions Weight, cabinet included not included Ordering information	differential input, floating; $R_{in} = 40 \text{ K}\Omega \pm 0.1\%$ of fsd (±0.2 mm) 200 mm 2 mm to the right and to the left left, setting range ±2 cm 20 cm/s 36-pole female at the rear +10 to +35°C 115/125/220/235 V ±10%, 100 VA (3 A) 484 mm×150 mm×436 mm 12.6 kg 11.6 kg
Deflection factor Input Nonlinearity Calibrated chart width Overlow Position of zero Maximum recording speed General data Connectors Rated temperature range AC supply Dimensions Weight, cabinet included not included Ordering information	differential input, floating; $R_{in} = 40 \text{ K}\Omega \pm 0.1\%$ of fsd (±0.2 mm) 200 mm 2 mm to the right and to the left left, setting range ±2 cm 20 cm/s 36-pole female at the rear +10 to +35°C 115/125/220/235 V ±10%, 100 VA (3 A) 484 mm×150 mm×436 mm 12.6 kg 11.6 kg
Deflection factor Input Nonlinearity Calibrated chart width Overlow Position of zero Maximum recording speed General data Connectors Rated temperature range AC supply Dimensions Weight, cabinet included not included Ordering information	differential input, floating; $R_{in} = 40 \text{ K}\Omega \pm 0.1\%$ of fsd (±0.2 mm) 200 mm 2 mm to the right and to the left left, setting range ±2 cm 20 cm/s 36-pole female at the rear +10 to +35°C 115/125/220/235 V ±10%, 100 VA (3 A) 484 mm×150 mm×436 mm 12.6 kg 11.6 kg
Deflection factor Input Nonlinearity Calibrated chart width Overlow Position of zero Maximum recording speed General data Connectors Rated temperature range AC supply Dimensions Weight, cabinet included not included Ordering information	differential input, floating; $R_{in} = 40 \text{ K}\Omega \pm 0.1\%$ of fsd (±0.2 mm) 200 mm 2 mm to the right and to the left left, setting range ±2 cm 20 cm/s 36-pole female at the rear +10 to +35°C 115/125/220/235 V ±10%, 100 VA (3 A) 484 mm×150 mm×436 mm 12.6 kg 11.6 kg
Deflection factor Input Nonlinearity Calibrated chart width Overlow Position of zero Maximum recording speed General data Connectors Rated temperature range AC supply Dimensions Weight, cabinet included not included Ordering information Order designation 19" cabinet model 19" rackmount	differential input, floating; $R_{in} = 40 \text{ K}\Omega \pm 0.1\%$ of fsd (±0.2 mm) 200 mm 2 mm to the right and to the left left, setting range ±2 cm 20 cm/s 36-pole female at the rear +10 to +35°C 115/125/220/235 V ±10%, 100 VA (3 A) 484 mm×150 mm×436 mm 12.6 kg 11.6 kg
Deflection factor Input Nonlinearity Calibrated chart width Overlow Position of zero Maximum recording speed General data Connectors Rated temperature range AC supply Dimensions Weight, cabinet included not included Ordering information Order designation 19" cabinet model 19" rackmount Accessories supplied	differential input, floating; R _{in} = 40 KΩ ±0.1% of fsd (±0.2 mm) 200 mm 2 mm to the right and to the left left, setting range ±2 cm 20 cm/s 36-pole female at the rear +10 to +35°C 115/125/220/235 V ±10%, 100 VA (3 A) 484 mm×150 mm×436 mm 12.6 kg 11.6 kg
Deflection factor Input Nonlinearity Calibrated chart width Overlow Position of zero Maximum recording speed General data Connectors Rated temperature range AC supply Dimensions Weight, cabinet included not included Ordering information Order designation 19" cabinet model 19" rackmount	differential input, floating; R _{in} = 40 KΩ ±0.1% of fsd (±0.2 mm) 200 mm 2 mm to the right and to the left left, setting range ±2 cm 20 cm/s 36-pole female at the rear +10 to +35°C 115/125/220/235 V ±10%, 100 VA (3 A) 484 mm×150 mm×436 mm 12.6 kg 11.6 kg • Radiomonitoring Recorder ZSG 3 242.6015.92 242.6015.91 f recording paper 088.3117.00;

8 XYT RECORDERS

recorders



Characteristics and uses

The **ZSKT** is an extremely fast and accurate two-axis recorder with outstanding dynamic characteristics. It permits **XY and YT recording** and can be battery-powered and remotely controlled.

With these and many other features the ZSKT can be **univer**sally used, for example for mobile operation, for acoustic applications thanks to its high writing speed, or for automatic recording thanks to DIN-A4-format paper advance in the XY mode.

The **dynamic characteristics** of the recorder are virtually the same on both axes because of the identical construction. Events changing simultaneously in both directions at a fast rate can therefore be recorded practically free of distortion.

With a maximum writing speed of more than 120 cm/s and a maximum acceleration of more than 6 g, the ZSKT sets new standards in its price category. Nonlinearity is less than 0.2% referred to the calibrated writing width; the reproducibility error is less than 0.5 mm. Overshoot is very small at ± 1 mm.

The useful writing area of the ZSKT is 180 mm×240 mm in XY operation. YT recording is possible with 180 mm width for more than 250 hours without interruption using the minimum chart speed of 1 mm/min and a paper roll that is 15 m long. For details on paper advance and recording see under description.

Remote control is possible for pen lift, paper advance in YT operation. DIN-A4-format advance in XY operation and start/ stop. The stepping motor for paper advance can be controlled via a separate input, any paper speed up to 20 mm/s being adjustable. The remote-control capability makes the ZSKT ideal for use in automatic systems.

Description

Operating principle. The ZSKT operates on the principle of a self-balancing potentiometer. A new design of the recording system allows reduced driving forces. The lower current drain makes battery operation possible.

Input amplifiers. Differential amplifiers are used in the input-stage, which makes connecting the signal sources very easy. The common-mode voltage may be as high as 100 V (common-mode rejection 60 dB).

Deflection sensitivity. The deflection factor can be set in eight calibrated steps from 5 mV/cm to 1 V/cm. Uncalibrated variation is also possible giving scale factors of \times 1 to \times 3, i.e. to a maximum of 3 V/cm.

Zero. The zero can be shifted over the whole writing width and suppressed by up to one full writing width; setting by means of ten-turn potentiometer.

recorders

XYT RECORDERS 8

Electronic limiting of writing area prevents the recording system from bouncing against a mechanical stop when the input amplifier is overdriven. This reduces wear of the mechanical parts, considerably enhancing the life expectancy and reliability of the recorder.

Recording. Fibre-tipped pens – available in different colours – are used for recording. The pen snaps into the penholder clip. The recording is made on paper rolls at least 15 m long and preprinted with a millimeter grid, or on individual sheets. Different modes of paper feed are used in XY operation and YT operation:

XY operation. At the push of a button the paper is advanced by 300 mm. The advance is controlled by a stepping motor so that the pen shifts to a horizontal grid line at a distance of exactly 300 mm.

YT operation. The X input amplifier is cut off. Instead of X deflection the paper is advanced by the stepping motor. True YT recording is thus possible without time limitation. The paper speed can be set in ten steps from 20 mm/s to 1 mm/ min.

Power supply. The ZSKT is normally powered from the local AC supply, but it can also be used with external DC-voltage sources (+15 to +20 V and -15 to -20 V) or batteries; see photo below. The operating time with battery supply is at least 20 hours and even longer if the dynamic characteristics of the recorder are not fully utilized.



on top of battery pack

Mechanical design. The case of the ZSKT is a one-piece fibreglass-reinforced moulding. The writing area with the driving mechanism is protected by a transparent cover. When the cover is opened the servomotors are switched off.

The **battery pack** can be fastened with two screws to the base of the recorder. Recorder and battery pack thus form a unit that is easy to transport and can be used anywhere.

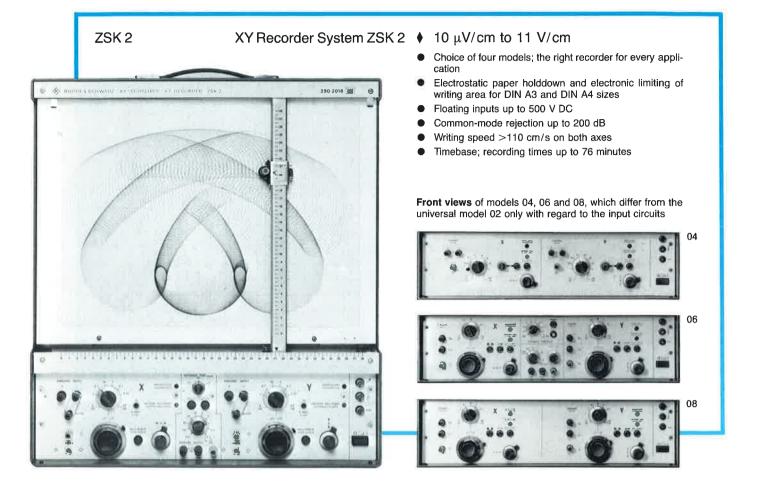
A **rack adapter** available as an extra permits easy mounting of the ZSKT in a standard 19" rack.

Specifications	in the second second
Recording system	
Writing area in XY operation Writing width in YT operation	180 mm×240 mm
Recording paper	rolls, width 220 mm or individual
Recording pen	DIN-A4-format sheets fibre-tipped pens not less than 120 cm/s in both direc-
Acceleration	tions
Mechanical time constant of servosystem	
6-dB cutoff frequency for ±1 cm deflection	
Settling time for full-scale deflection in Y direction	~15112
X direction	≈190 ms
Nonlinearity	0.5 mm
Overshoot Pen control	±1 mm by pushbutton or remote control
XY inputs	
Test inputs	3 knurled terminals for X and Y directions, designated
Input circuits	+1 + 1 + 1
Deflection factor, calibrated	X and Y deflection
	max. error 0.2%
uncalibrated	1 MΩ
	± one full writing width, using ten-tum potentiometer
Common-mode rejection Max. permissible common-mode	>60 dB
voltage	100 V (between input and _L)
Paper feed Drive	
Start/stop	by switch (continuous advance),
	by pushbutton (advance in DIN-A-4- format steps) or by remote control
Paper advance	(continuous or in steps)
XY operation	DIN-A4-format advance (exactly 300 mm) or smaller steps,
YT operation, internal	max. duration of advance 15 s switch-selected speeds
	1, 2, 5, 10, 20 mm/s 1, 2, 5, 10, 20 mm/min
YT operation, external Required drive voltage	
Pulse repetition frequency fp Chart speed	0 to 420 Hz
	$= 300/6272 \cdot f_{p}$ (Hz)
General data Operating temperature range	+5 to +45°C
Storage temperature range . Power supply	-20 to +70°C
	source
AC supply operation	(+15 to +20 V and -15 to -20 V) 115/220 V ±10%,
Battery operation	47 to 63 Hz (10 VA) from battery pack (with meter),
	28 single cells IEC R-20; 20 hours of operation using battery pack with
Dimensions, weight	
with battery pack	380 mm×150 mm×320 mm, 7.5 kg
Ordering information	
Order designation	► XYT Recorder ZSKT
Accessories supplied	301.9010.02 1 roll of recording chart
	1 set of fibre-tipped pens power cable
Recommended extras	
Battery Pack ZSKT-Z2	
Recording chart (roll of 15 m) Log. Recording Chart ZSKT-Z9 (for	
Impulse Sound-level Meter EGT) Fibre-tipped pens (set of 4 pens)	
red	301.9456.00 301.9479.00
green	301.9491.00 301.9433.00
Set of fibre-tipped pens	And the last films has
(on of each of about colours)	201 0510 00

(on of each of above colours) 301.9510.00 19" Rack Adapter ZSKT-Z1 302.1813.02

8 XY-YT RECORDERS

recorders



Type familiy, characteristics, uses

The ZSK 2 family is a range of high-quality XY and YT recorders featuring high writing speed, precision and reliability.

Models of the ZSK-2 recorder system

The **ZSK 2 family** offers a user-oriented selection of four models. They differ mainly in the characteristics of the input section; see data on next page.

List of models:

- 02 Universal model
- 04 Standard model
- 06 Lab model with timebase
- 08 Lab model

The wide deflection-factor range of 10 μ V/cm to 11 V/cm, the timebase generator and an internal DC voltage source for offset compensation (depending on model) offer a great variety of applications.

The electrostatic paper holddown grips charts of DIN A3 size (297 mm×420 mm) or smaller. Switch-selected limiting of the writing range to DIN A3 or DIN A4 ensures that the stylus remains within the selected useful area. Overdriving is indicated.

Plotting with ballpoint or fibre pen in four selectable collours; see recommended extras.

The input amplifiers of models 02, 06 and 08 are floating and isolated from ground for both the X and Y axes. Therefore the connection of test signals that are referred to different common points for the X and Y axes does not cause any problem.

A timebase generator incorporated in models 02 and 06 permits plotting of quantities varying in time. Model 06 includes in addition an isolated DC voltage source for offset compensation in the range 1 mV to 10 V.

Remote control is possible for lowering/lifting the recording stylus, forward and return sweep of the timebase and zero offset.

Outputs. The connections for remote control and the outputs for the deflection-proportional voltage and the timebase generator are combined in a multiway connector at the rear of the set.

recorders

XY-YT RECORDERS 8

Description

The ZSK 2 operates on the principle of the self-balancing potentiometer. This affords excellent linearity and accuracy. The potentiometer circuit is isolated from the test circuit by buffer amplifiers.

The X and Y amplifiers of the universal model 02 are floating, guarded differential amplifiers and feature exceptionally high common-mode rejection.

The differential amplifiers of the standard model 04 are referred to ground potential.

The laboratory models 06 and 08 are equipped with floating differential amplifiers without guard. Both models offer the possibility of selecting normal or inverted operation.

The ZSK 2 can be mounted in racks with the aid of a 19" rack adapter (see recommended extras).

Specification				
Specifications of input section	Universal model 02	Standard model 04	Lab model with timebase 06	Lab model 08
Deflection factor	6 cal. × 1 to × 11	5 mV/cm to 3 V/cm 8 × 1 to × 3 0.3%	100 μV/cm to 11 V/cm 5 cal. × 1 to × 11 0.2% ±2.5 div.	100 μV/cm to 11 V/cm 5 cal. × 1 to × 11 0.2% ±2.5 div.
Input circuit Input resistance . Max. input voltage Common-mode voltage Common-mode rejection DC AC (50 Hz); range: ≦1 mV/cm 10 mV/cm 0.1 and 1 V/cm	guard; X, Y isol. from ground .10 MΩ (1 MΩ) .500 V (≦1 V/cm) .500 V .>160 dB w. filter w/o filter .>200 dB >140 dB .>160 dB >100 dB	diff ampl., for X and Y 1 MΩ 100 V 100 V >60 dB	floating impl., X, Y isol. from ground 1 MΩ 100 V (≦1 V/cm) 400 V 200 V >160 dB w. filter w/o filter >170 dB >110 dB >130 dB >70 dB >120 dB >60 dB	floating ampl., X, Y isol. from ground 1 MΩ 100 V (≦1 V/cm) 400 V 200 V >160 dB w. filter w/o filter >170 dB >110 dB >130 dB >70 dB >120 dB >60 dB
Zero offset Timebase generator Steps Error limits Output Offset voltage source Steps Continuous adjustment Max. voltage to chassis.	. ±1 full scale X, Y: 0.2 to 120 s/cm 9 ±1% 0.1 V/cm 	±1 full scale 	±1 full scale X: 0.1 to 20 s/cm 8 ±1% 0.1 V/cm 1 mV to 10 V 8 ×0.1 to×1 200 V ≨5×10 ⁻⁵ /°C	±1 full scale

S	ysten	n spe	cifica	ations
---	-------	-------	--------	--------

Calibrated chart area	280 mm×380 mm (DIN A3)
Electronic limiting	a) 280 mm×180 mm (DIN A4),
	b) 380 mm×280 mm (DIN A3).
	switch-selected
Paper holddown	electrostatic
Stylus	ballpoint pen or
	fibre-tipped pen (see extras)
Lowering of stylus	by pushbutton or ext. control
Max. writing speed	
Mechanical time constant	> 110 cm/s on X and 1 axes
of servosystem	25 mc
Max. settling time for fsd	25 1115
on X axis (380 mm)	100 mm
on Y axis (280 mm)	
Overshoot	310 ms
Linearity	
Reproducibility	0.2 mm
DC voltage output	retransmitting potentiometer,
	<1 Ω, shortcircuit-proof
Zero setting, ext	
Ratio recording	by external reference voltage
Rated value of	
nominal voltage	1.000 V
Operating voltage range	0.5 to 1.5 V (Vin max: 50 V)
Input resistance	1 MΩ (≦2 μA)
and the second	
General data	
Rated temperature range	
Operating temperature range	
Storage temperature range	
Power supply	115/125/220/235 V +10/-15%
	47 to 420 Hz (50 to 150 VA,
	depending on recording mode)
Dimensions	440 mm×490 mm×160 mm

Ordering information

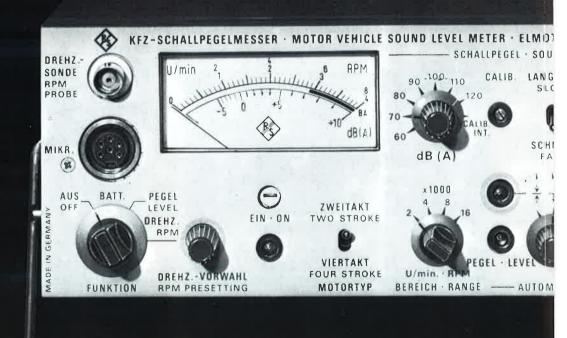
Order designations	► XY Recorder ZSK 2
02 Universal Model	290.2016.02
04 Standard Model	290.2016.04
06 Lab Model with timebase	290.2016.06
08 Lab Model	290.2016.08
Accessories supplied	
Set of Ballooint Pene using	

..... 290,4860.00

Recommended extras

neooniniended extrag		
19" Rack Adapter ZSK 2-Z	290.2097.00	
Transport Cover (aluminium)		
ZSK 2-Z	290.2100.00	
Adapter for Fibre-tipped Pen		
ZSK 2-Z3	290.4919.02	
Set of Fibre-tipped Pens ZSK 2-Z4		
(2× black, 1× red, 1× green,		
1× blue)	247.7855.00	
Disposable pens (sets of five)	fibre-tipped	FPI ballpoint
	ZSK 2-Z4	ZSK 2-Ż5
black		290.4783.00
red	247.7790.00	290.4825.00
blue		290.4802.00
green	247.7832.00	290.4848.00
36-way male connector	247.7055.00	

Motor-vehicle Sound-level Meter ELMOT for rpm-dependent measurements; details on page 278







B

FNr 870723/ .

HNELL

н Ш Т Т

hin.

MATIK -

AUS

LÖSCHEN

RESET



Why sound-level measurement?

9

The most frequent objective of sound-level measurement is **noise abatement:** the advance of civilization and industrialization is accompanied by an increasing noise exposure suffered by man, which has reached such a level that countermeasures are urgently called for. Noise surrounds us by day and night, where we dwell, where we work, where we travel.

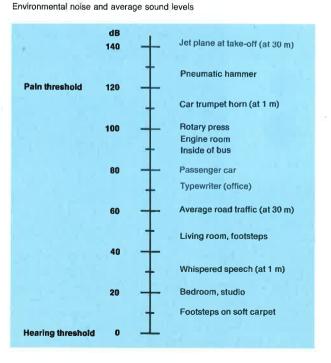
Noise **at the place of work** is of particular concern, considering that loss of hearing induced by noise is the No. 1 occupational illness in industrialized nations. Prolonged exposure to noise levels exceeding 85 dB is injurious to hearing. Even much lower levels – depending on the physical and mental condition and the activities of the people concerned – may cause them considerable annoyance, reduce their productivity and have adverse effects ont their nervous systems eventually leading to damage to their health. To counteract these risks, legislative bodies and unions have worked out regulations defining appropriate noise limits.

Such differentiated noise-limit regulations exist already in some countries or are under preparation, the regulations being partly enforced by law and partly laid down in management-union agreements. For example, the regulations concerning noise at the place of work issued by the government of the Federal Republic of Germany in May 1976 give the following noise level limits averaged over 8 hours (rating sound level, see page 272),

- 55 dB (A) for primarily brainwork
- 70 dB (A) for simple or to a great extent mechanized office work or comparable activities
- 85 dB (A) for any other activities; under certain circumstances, which mus be justified, up to 90 dB (A).

Sound-level measurement in residential area

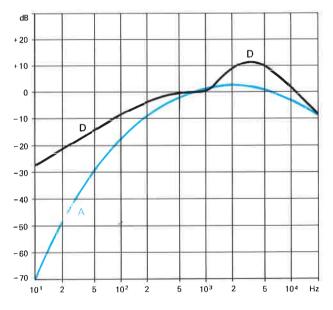




Some concepts in sound measurements

The physical measure of sound intensity is the rms value of the (alternating) **sound pressure p** measured in pascals (Pa) with 1 Pa = 10 µbar or 1 N/m². Considering the very wide dynamic range of human sound perception, extending over six decades, the logarithmic measure, i.e. **sound-pressure level L**, is more convenient, giving easier-to-follow figures. L is 20 times the logarithm of sound pressure referrred to the hearing threshold of 2×10^{-5} Pa and is **measured in dB**. The human ear responds to sound-pressure levels from 0 to 130 dB (see dB scale on preceding page). A level increase of 10 dB corresponds approximately to a doubling of the loudness sensation as registered by the ear.

To take account of the strong frequency dependence of loudness sensation, sound-level meters must be provided with **frequency weighting** networks. Four weighting curves, A, B, C and D are internationally standardized. The present tendency toward unification and simplification has led to curve A now being prescribed for the large majority of measurements. Aircraft noise is measured using curve D, see diagram below.



Relative attenuation of weighting networks referred to 1 kHz

The measured quantity is denoted weighted sound level – or simply **sound level** – if a weighting filter is used for the measurement (without filter, sound-pressure level is measured). The weighting curve used is indicated as an index to the symbol L, for instance L_A , L_D . When specifying results, the index letter is often added in parentheses to the unit, e.g. 70 dB (A).

Noise measurements, in particular, call for a distinction to be made between the

instantaneous sound level L and the

equivalent sound level L_{eq} averaged over a predetermined period of time.

A measurement of **instantaneous values** permits observation or recording of sound-level variations with time. Applications are most diversified, e.g. checking noise-abating measures on machines or determining sound propagation in rooms, building or residential areas.

Time weighting. Almost all instantaneous-value soundlevel meters have analog meter indication since this is best suited to the visualization of varying levels. Depending on the complexity and price class of the instrument, the time weightings

fast, slow, impulse, peak and maximum hold can be switch-selected.

In the fast mode the indication follows the varying level as quickly as permitted by the meter response (τ =125 ms); with slow, very unsteady pointer movements are electrically damped. With impulse weighting a circuit whose time constant is τ =3 s holds impulse sound events such that their rms value can be read. The peak mode measures the peak value (not rms) of even shorter sound pulses, e.g. shots.

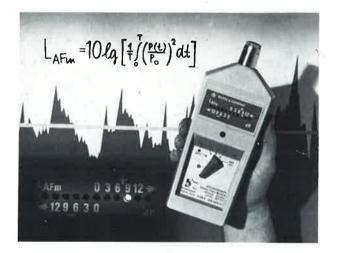
The time weighting is indicated by a second index to the quantity symbol: F meaning fast, S slow and I impulse. With frequency weighting A, for example, there are three level designations: L_{AF} , L_{AS} and L_{AI} .

Below: Instantaneous-value measurement using Impulse Sound-level Meter EGT on large building site



9 SOUND-LEVEL MEASUREMENTS acoustic instruments

Characteristics of sound-level meters. The requirements are laid down in IEC and DIN standards. Precision instruments must comply with DIN standard IEC 651. This standard distinguishes between four classes numbered from 0 to 3 each with its own set of specifications defined. Class 1 (Type 1) is identical with the requirements of DIN 45 633, 1 and 2, and class 2 (Type 2) is in line with DIN 45 634. The qualification in line with these standards can be certified in Germany by type-approval through PTB (Federal-German Office of Standards). Thereby the instruments are admitted for official calibration, which is required in many cases. The user of a type-approved instrument is always sure that it complies with the relevant standard specifications.



Integrating sound-level meters have gained special importance in the last few years. They evaluate the varying sound level accurring over a predetermined time, e.g. a work shift, and form the mean sound level whose annoyance effect is assumed to be equal to the actual sound effect. The mean level is used for comparison of the different noise levels.

DIN 45 641 and 45 645 specify two variants of mean level $L_{\rm m}$, namely the equivalent continuous sound level L_{eq} and the rating level L_{r} . The latter rates impulse sound higher than L_{eq} because of the higher annoyance it causes to man. In the Federal Republic of Germany L_{r} is commonly referred to for noise at places of work, whereas traffic noise, which contains few impulse components, is generally assessed by L_{eq} . The present international standards ISO R 1996 and ISO R 1999 refer to L_{eq} only.

The rating level can be obtained by two different methods leading practically to the same result. Graphs of the different weighting modes and associated designations are compiled in the table below, as many users may not yet be familiar with these distinctions.

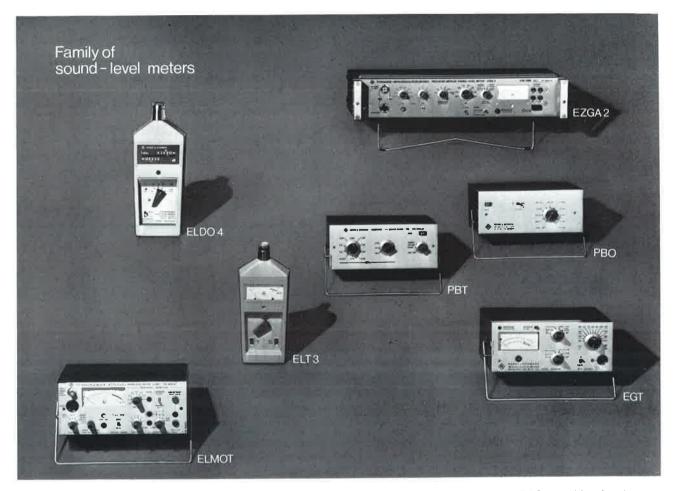
The Integrating Sound-level Meter ELDO 4 gives a direct indication of the mean sound level for the selected measurement duration

ured quantit e averaging L _{AF}	y Sound-level integration (example: impulsive sound)	Designation of mean level equivalent continuous level	
L _{AF}	L 0 5 10 15 20 25 30 8	L _{eq}	
			s
L _{AI}	L T=3s 5 10 15 20 25 30 8	L _{AIm} rating sound level	mean level L _m
L _{AFT}	Clock period T= 3s or 5s	L _r	
ι	• AFT	0 5 10 15 20 25 30	AFT When When the

Below: Relationship between time-weigthing modes and mean levels

acoustic instruments

SOUND-LEVEL METERS 9



All instantaneous-value reading R&S sound-level meters are type-approved, i.e. they are admitted for calibration by PTB (Federal-German Office of Standards).

Overview of sound-level meter data

Frequency range	Designation	Туре	Order No.	Measurement range	Time weighting, meas. quantity	Error limits	Standard	Dimensions (W×H×D) in mm	Text on page
			1.0			_		1.	

Instantaneous-value sound-level meters

16 Hz to 16 kHz	Sound-level Meter	ELT 3	215.8510.02	25 to 120 dB	F/S	1 dB	DIN 45.634 IEC 123 IEC 651 Typ 2	104 × 233 × 43	274
10 Hz to 20 kHz	Portable Impulse Sound-level Meter	EGT	220.5174-02	24 to 160 dB	F/S/I max-value store	1 dB	DIN 45633, sheets 1 & 2 IEC 179, 651 Typ 1	212 × 88 × 158	275
10 Hz to 20 kHz	Precision Impulse Sound-level Meter	EZGA 2	220.7660.02	20 to 160 dB	F/S/I/Peak maxvalue store	1 dB	DIN 45633, sheets 1 & 2 IEC 179, 651 Typ 1	484 × 105 × 336	276
10 Hz to 20 kHz	Motor-vehicle Sound-level Meter	ELMOT	235.4010.02	55 to 130-dB	F/S maxvalue store	1 dB	DIN 45 633 IEC 179 IEC 651, Typ 1	218 × 88 × 158	278

Integrating sound-level meters

16 Hz to 16 kHz	Integrating Sound-level Meter	ELDO 4	219.4026-02	43 to 100 dB	$L_{AFm} \; (= L_{eq})$	1 dB response tolerance of LEDs	104 × 233 × 43	280
				· · · · · · · · · · · · · · · · · · ·				

9 SOUND-LEVEL METERS



The **Sound-level Meter ELT 3** is a new and very inexpensive instrument with measuring characteristics in line with DIN 45 634 and IEC 651 Type 2. Several features, such as pickup pattern and sound-volume range, also comply with DIN 45 633, IEC 179.

The ELT 3 comes in a flat and compact format at low weight.

Due to the good performance and handiness, the Soundlevel Meter ELT 3 is suitable for a wide variety of applications, e.g. for noise measurements in industry or traffic, in residential areas or for investigations made by health service. The wide level range permits measurements of sound events ranging from the loudest noise to levels that lie below the values permissible in residential areas at night.

Simple operation renders the ELT 3 suitable for use even by non-technical personnel.

Microphone. The capacitor microphone that is used makes the instrument largely insensitive to structureborne vibrations, e.g. in applications in vehicles. Pressure compensation in the microphone eliminates the effects of fluctuating air pressure.

Indication, weighting. The ELT 3 indicates the rms value of sound level with A weighting in dB, and can be switched to fast or slow response.

Calibration. Absolute calibration of the sound-level meter is possible with the Sound-level Calibrator ELEB, see page 283. **Output.** An AC output (0.8 V_{rms} at fsd) enables connection of a sound-level integrator for example. This combination is an extremely favourably priced, portable measuring setup for determining equivalent continuous sound level L_{eq} or mean level of varying noise, for example.

The 9-V battery of the power supply suffices for over 200 hours of operation.

Specifications

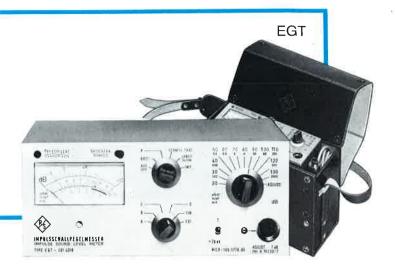
(Characteristics comply with DIN 45	634 and IEC 651 Type 2)
Measuring range	25 to 120 dB(A) over po
	$(p_o = 2 \times 10^{-5} Pa = 0 dB)$
Range switching	
Error limits	
Frequency range	16 HZ IO 16 KHZ
	rectification
Meter speeds	
Scale	-5 to 0 to +10 dB battery check
Precision microphone	capacitor microphone,
	omnidirectional characteristic
Main direction of sound incidence	from front along longitudinal axis
	of set
Operating temperature range	-10 to +50°C
Temperature dependence, referred to 20 ° C	<0.5 dB
AC output	
Power supply	
	battery check on meter
Average battery life	>200 h
Dimensions, weight	104 mm × 233 mm × 43 mm, 0.55 kg
Ordering information	
Order designation	Sound-level Meter ELT3 215.8510.02
Accessories supplied*)	battery, carrying case
Recommended extras	Wind Screen MKPM-Z 100 5810.02
	Tripod Bracket ELT-Z3 215 8940.02
	Tripod MKPM-Z2 154.5899.02
For measurements	
near ground level	Tripod Mount ELT-Z 215.9469.02
Sound-level Calibrator ELEB	201.5443.90
*) If a calibration certificate is require	d, the instrument will be forwarded
to the respective authority for calit	pration and delivery.

acoustic instruments

SOUND-LEVEL METERS 9

Impulse Sound-level Meter EGT

- 10 Hz to 20 kHz/24 to 160 dB
- Type-approved by PTB; admitted for official calibration and for measurements good in law; precision data in line with DIN 45 633, IEC 651 Type 1, IEC 179
- Noise measurement with weighting curves A, B, C and D, with linear response or via external filters
- Recording outputs, AC or battery power supply



The portable **Impulse Sound-level Meter EGT** covers the wide test range of 24 to 160 dB and fulfils the requirements of the German Standard DIN 45633, sheet 1, for presicion sound-level meters, and sheet 2 for impulse sound-level meters, and of IEC 651 Type 1.

Microphone. The Standard Microphone MKPM is used as an electro-acoustic transducer (capacitor-type microphone with two-stage impedance transformer), receiving its polarizing and supply voltage from the EGT. Its low-impedance output makes the use of long connecting cables possible (up to 100 m). The microphone capsule can be replaced by the Adapter 100.5803.02 for connection of the Acceleration Pickup EBVB. Acceleration measurements can then be performed.

Test range (sensitivity). The total range of 24 to 160 dB is covered as follows: Switchable in 10-dB steps from 24 to 130 dB, +10 dB fsd on panel meter, +20 dB by reducing the polarizing voltage of the microphone.

Weighting. A, B, C, D and linear can be selected as required. In addition, external filters can be connected via BNC sockets, the 3-dB insertion loss being compensated in the EGT.

Indication. The test result is shown on a moving-coil meter with rms rectification. Scale calibration -5 to +10 dB with resolution of 1 dB. Overdriving (e.g. extreme peak factors) is signalled by a warning lamp. By means of a push/slide switch it is possible to hold the maximum meter indication of a transient event.

Calibration check is provided by feeding an internal calibration voltage to the microphone capsule.

Outputs. The weighted AC signal voltage is available at the AF output, e.g. for recording on tape or for an AC-voltage recorder.

Power supply. Instead of the usual 1.5-V single cells an accumulator or a power supply/charger can be employed.

Carrying case. This is supplied with the instrument and can also hold the microphone and spare batteries. A double case accommodating the EGT plus an octave or third-octave filter (see page 282) is available as an extra.

Specifications		
	Hz to 20 kHz	
Ranges for weighted sound level 24	to 160 dB	
with external filters		
for sound-pressure measurement = 0.0 for acceleration measurement = = 0.0	11 to 2000 m/s ²	
for voltage measurement 0.0	01 to 2000 mV	C D lin
for voltage measurement 0.0 Equivalent noise level (with we microphone)	Bighting A D	21 24 27
External filter connection Br	$NC, Z = 600 \Omega$	
Indication	ored: discharge <0	5 dB/min
Scala	5 to 0 to +10 dB	
Outputs, AC	V, 100 Ω	
Scala	V fsd, 200 kΩ	159 mm 97 kg
Dimensions, weight 21	2 mm × 00 mm ×	156 mm, 217 kg
Ordering information		
Order designation	Impulse Sound-leve	el Meter EGT
EGT incl. carrying case and bat- teries, plus Microphone		
MKPM, 1.2-m cable		
and wind screen	220.5174.02	
Recommended accessories for the E For airborne-sound measurements	:GT*)	
	Order Nos.	Page
(second microphone with 1.2-m cable)	220.5180.02	283
Microphone cable		200
1.2 m	100.5784.05 100.5784.02	
10 m	100.5784.03	
20 m	100 5784 04 100 5784 06	
Tripod MKPM-Z2	154.5899.02	
For vibration measurements		
Acceleration Pickup EBVB	100 5000 00	283
sensitive to acceleration	100.5890.02 100.5884.02	283
EBVB Adapter .	100.5803.02	
Impedance transformer	110.0410.02	
For selective measurements Octave Filter PBO .	201.5520.02	282
Third-octave Filter PBT	235.3014.02	
Connecting Cable EGT-Z (PBO/PBT)	205 3016.02	
For voltage measurements		
Voltage Adapter EGT-Z	201.5489.02	
Power supply		
Lead Storage Battery EGT-Z Power Supply/Charger EGT-Z	201.5437.00 201.5414.00	
Calibration equipment	201.3414.00	
Sound-level Calibrator ELEB	201.5443.90	283
Recording equipment		
YT recorder	please enquire	
Connecting cable for tape recorder Carrying Case EGT-Z	201 5514.02 201 5508.02 201.5337.00	
Double case (leather)	201.5337.00	
*) If a calibration certificate is required	the instrument will	he forwarded
to the respective authority for calibra		00 101 101 000

9 SOUND-LEVEL METERS

acoustic instruments



The **Impulse Sound-level Meter EZGA 2** is ideal for use in test setups or systems for acoustic measurements. it is particularly suitable for long-term noise monitoring and recording, for the determination of the noise-exposure index, and for sound analyses in conjunction with external filters. The EZGA 2 complies with DIN 45 633, sheets 1+2, and IEC 651 Type 1. The wide dynamic range of the logarithmic DC output and the remote-control capability render the EZGA 2 particularly suitable for use in automated test systems incorporating data-processing equipment.

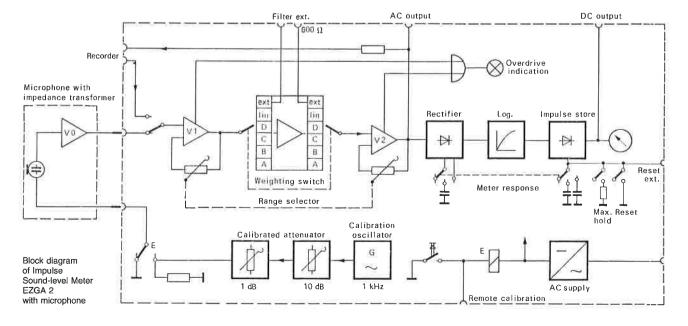
Indication and dynamic range. The extremely wide logarithmic indicating range of 50 dB and the 75-dB dynamic range of the rms-responding rectifier enable long-term measurements to be made without range switching.

Modes of indication. Any of the four modes, i.e. FAST, SLOW, PULSE and PEAK, can be switched so that either the instantaneous signal level or the maximum level is indicated. The maximum level is stored and can be erased with a switch

on the front panel or by remote control, an important prerequisite for use in automated systems.

Level calibration. The built-in calibration generator can be adjusted in 1-dB steps between 50 and 130 dB by local or remote control. Any calibration level can thus be applied as a reference during long-term noise recording.

Recording outputs. The EZGA 2 is provided with AC and DC and DC outputs and with a socket for the connection of a tape recorder. AC and DC recording outputs with a dynamic range of about 60 dB (crest factor+15 dB) are provided; of particular importance is the logarithmic DC output which permits wideband level recording on DC recorders without great demands on the speed of the recorder.



acoustic instruments

SOUND-LEVEL METERS 9

Microphone. The capacitor-type Standard Microphone MKPM (page 283) can be electrically heated from the EZGA 2 and is thus optimally protected against environmental influences. For fixed outdoor use, the microphone can also be supplied with a weather shield. The low output impedance of the MKPM permits the use of connecting cables up to 100 m long.

Acceleration measurements between 0.003 and 3000 m/s² can be made in conjunction with an acceleration pickup and adapter, see under MKPM. Connection is made via the impedance transformer of the microphone after unscrewing the microphone capsule.

Description

The signal voltage delivered by the microphone first passes through the impedance converter V0 and the amplifiers V1 and V2 with weighting filters connected in between; see block diagram on the preceding page. The feedback networks are coupled to the range selector and determine the sensitivity of the instrument, which may be between 40 and 110 dB for a 0-dB reading on the meter (fsd = +30 dB). In addition, the polarizing voltage (150 V) of the microphone can be reduced by 20 dB thereby increasing the upper sound-pressure limit to 160 dB.

The output signal of amplifier V2 is then applied to an rmsresponding rectifier, which can also be switched to peakresponsive rectification; this is followed by a logarithmicfunction generator. The output of the subsequent holding circuit for impulse operation or storage is connected to the panel meter with parallel DC measuring or recording ouput.

The AC amplifiers can be overdriven by 14 dB (crest factor 5). An overdrive indicator with a response time of <1 ms monitors the amplifiers V1 and V2, which would otherwise be endangered in the case of excessive overdriving. To check the calibration, a reference voltage can be applied to the low end of the microphone¹). This voltage can also be used for checking the voltage divider of the range selector and the accuracy of the scale.

Specifications		
Frequency range Frequency response (linear mode) without microphone with Microphone MKPM	<0.5 dB (20 Hz t	o 16 kHz)
Frequency weighting Sound-level range Equivalent sound level and lower r threshold (with Microphone MKPM	A, B, C, D, LINEA 20 to 160 dB esponse	
with weighting curve A	equivalent sound level (max.) dB 22 24	lower response threshold (max.) dB 27 29
C D LIN FILTER EXT.	27 30 30	32 35 35 20

Indication	by panel meter with logarithmic 50-dB
Scale engraving	scale; 0-dB point shiftable in 10-dB steps -20 to 0 to +30 dB,
obalo origitating	measuring range: 0 to +30 dB range overlap: -20 to 0 dB
Rectifier	ms-responding (calibrated at max. output with test-signal crest factor
Time weighting	of 5) FAST, SLOW, PULSE,
	fall-off ≈1 dB/s)
	MAX. HOLD for any of the above four modes (fall-off <0.2 dB/ min)
Overdrive indication	i by signal lamp; response time 200 μs, minimum on-time ~500 ms
Error limits	
Under normal conditions (acc. to DIN 45633),	at dD
Additional error caused by	
temperature variations between - 10 and + 50 ° C	<0.5 dB
variation of relative humidity between 10 and 90%	, <0.3 dB
variation of barometric pressure by ±10%	<0.2 dB
Effect of non-audio interference Mechanical vibrations of	
1 m/s ² (rms)	
from 20 to 1000 Hz Electromagnetic field of 80 A/m	. max. 90 dB equivalent sound level
(rms) at 50 Hz	. max. 80 dB equivalent sound level at to PEAK, the error limits specified only to +30 dB.
Calibration	
A Manual 44	microphone capacitor for adjustment of calibration level in
	1-dB steps between 50 and 130 dB
Standards complied with	IEC 170 and 179 A
Connections	IEC Draft Type 1, ANSI Type 1
Microphone	Microphone MKPM
	3-pole socket for 200-mV AC output and for input (input voltage adjustable between 0 and 10 V)
AC output	2.5 V _{ms} at fsd, 600 Ω, 4-mm-connector strip on rear panel
	+2.5 V at fsd (50 mV/dB), 600 Ω , 4-mm-connector strip on rear panel
	 a) switchover to calibration signal b) erasure of MAX. HOLD store
External filter	via rear BNC sockets, 600 Ω
General data	
Storage temperature range	110 to 125/220 to 235 V +10/-15%,
Dimensions with cabinet	47 to 63 Hz (5 VA) 484 mm × 105 mm × 336 mm
Weight 19" cabinet model/ rackmount	7.1 kg/4.75 kg
Ordering information	Precision Impulse Sound-level
	Meter EZGA 2
19" cabinet model	220.7660.03 (one mating multipoint connector for rear inputs
Accessories supplied	is supplied) 1 power cable
Recommended extras*) Standard Microphone MKPM Sound-level Calibrator ELEB Wind Screen for MKPM	201.5443.90
*) If a calibration certificate is require the respective authority for calib	red, the instrument will be forwarded to
the respective autionty for call	and and addressly.

¹) The calibration signal is taken via the capacitance of the microphone so that the effects of the impedance transformer and microphone cable are also taken into account.

9 SOUND-LEVEL METERS

ELMOT Motor-vehicle Sound-level Meter ELMOT



- 10 Hz to 20 kHz/55 to 130 dB (A)
- Sound-level meter and rpm counter in one instrument, combined indication
- Characteristics comply with ISO standard, ISO/DIS 5130 and EC guidelines for measurement of noise in immendiate vicinity of stationary vehicles
- Sound-level measurement according to DIN 45 633 and IEC 179; type-approved by PTB; admitted for official calibration and for measurements good in law
- Logic-circuit enables one-man operation in combined sound-level/rpm measurement
- Rapid readiness for use with contactless rpm probe

General remarks on motor-vehicle noise measurement

Noise measurements on motor vehicles according to the earlier valid standard ISO R 362 were practically impossible on a large scale and in vehicle maintenance and traffic checks because of the test conditions laid down, for instance the large distance of 7 meters at which the measurement was to be made.

The measurement of noise in the immediate vicinity of stationary vehicles offers a better solution. Relevant standards – ISO/DIS 5130 and EC guidelines – have already been introduced. The measuring distance will be reduced to 0.5 meters and the disturbance caused by ambient noises and reflections thus largely eliminated.

The **measuring method** provides for the testing of a stationary motor vehicle under certain conditions and with the microphone located very near: to one side of the exhaust outlet at a distance of 0.5 meters, and at an angle of 45° to the vertical plane of the direction of the exhaust emissions with the engine running at 75% of the speed at which maximum horsepower is developed.

To enable efficient measurements under these conditions (one-man operation) and with optimum setting accuracy, Rohde & Schwarz developed the

Motor-vehicle Sound-level Meter ELMOT

The combination in this instrument of rpm and sound-level measurement, plus a logic circuit, simplifies and automates the measurement of vehicle noise. The measurement becomes devoid of problems and can be performed by a single person with no worries about errors in setting or readout. Rpm is measured by means of a contactless inductive rpm probe clamped on a spark-plug cable. Apart from two-stroke and four-stroke engines no further distinction need be made between engine types as in the case of capacitive probes. The ELMOT is battery-powered, compact and complies in precision with DIN 45633; it is type-approved by PTB and admitted for official calibration.

Uses

The features of the ELMOT were selected so that it can be employed by automobile manufacturers in development and testing, by vehicle-inspection authorities, motor workshops and, primarily, by the police. In addition to its mode of operation with automatic coupling of rpm and sound-level measurement, this instrument can also be used as an independent sound-level meter or revolution counter. With an XY recorder connected to the DC outputs it is also possible to display logarithmic sound-level characteristics over 40 dB as a function of rpm.

Operation

Setting, reference value. The reference value for the operating conditions of an engine is the engine speed S at which it produces its maximum horsepower. The standard gives three versions:

- I Stabilization to $\frac{3}{4}$ S (or $\frac{1}{2}$ S for motorcycles with S >5000 rpm).
- II As under I and then sudden release of the throttle; only the highest sound level that occurs is noted.
- III Sudden increase of rpm (or by pumping) to $\frac{3}{4}$ S ($\frac{1}{2}$ S), and again only the highest sound level is noted.

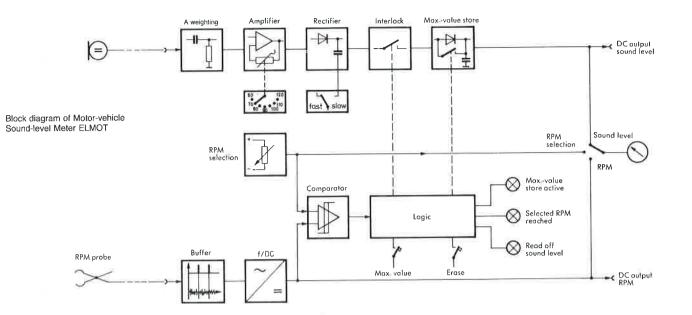
Measuring procedure. The complete process is as follows:

- 1) Set up microphone next to exhaust.
- 2) Lift engine bonnet and clamp rpm probe to spark-plug cable.
- 3) Sit in driver's seat with ELMOT and start engine. Turn ELMOT rotary switch "automatic" to setting 1 (¾ S), for example, and select rpm.

When the throttle is operated, the ELMOT meter indicates the rpm and a red LED signals when the preselected rpm ($\pm 2\%$) is reached. At the same time the measured sound level is electronically stored. If the rpm figure remains within the tolerance for at least 1 s, a yellow LED ("level") signals that the held sound-level value can be read off.

acoustic instruments

SOUND-LEVEL METERS 9



Specifications

Features

With diesel engines the rpm cannot be electrically determined. This is possible using an optical probe which is available as an accessory.

Indication of maximum sound level. This device enables reliable measurement of the noise of moving vehicles. From the side of the road, for example, it is possible to ascertain immediately whether a conspicuously noisy vehicle is louder than prescribed limits and should be stopped for a noise measurement which could then, if necessary, be used as legal evidence.

Shortened measurement time. The measurement time can be factory-adjusted to 0.2 s instead of 1 s on customer's request. This is preferable, for example, for measuring racing motorcycles of very high rpm, which by present rules have to be tested before every contest.

DC output for logarithmic sound-level characteristics. In many special investigations it is desirable to plot sound level versus rpm using an XY recorder. Here logarithmic level representation offers better evaluation.

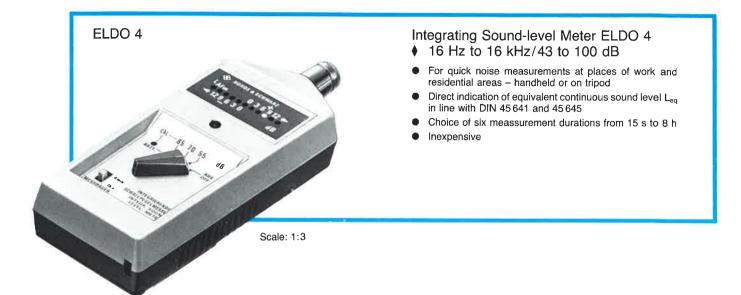
Robust and handy tripod and microphone holder. These parts are designed to withstand the rough handling encountered in practice, for example, in motor car repair shops. The holder is provided with a device for setting distance and angle.

Specifications
Sound-level meter (all characteristics comply with DIN 45 633 and IEC 651 Type 1, IEC 179)
Frequency range 10 Hz to 20 kHz Measurement range 55 to 130 dB (A) Range selection in 10-dB steps
Indication moving-coil meter with rms-responding rectification Scale range
Time weighting
Precision microphone Type MKPM (DIN 45 633) Internal calibration by stabilized voltage, f = 1 kHz
DC outputlog 50 mV/dB lin 2 V at fsd
AC output
Ppm counter Measurement ranges 2000/4000/8000/16 000 rpm Error ±3%
Rpm measurement via spark-plug cables by means of inductive rpm probe DC output
Automatic evalution circiut holds sound level when preset
rpm are reached Engine conditions I for $n = \frac{3}{4}$ S II for $n \le \frac{3}{4}$ S downwards III for $n \le \frac{3}{4}$ S upwards
General data Rated temperature range
or storage battery or power supply Duration of battery-powered operation
Dimensions, weight
Ordering information Order designations Motor-vehicle Sound-level
Motor-venicle Sound-level Meter ELMOT 235.4010.02
Accessories supplied ¹): Standard Microphone MKPM with 5 m microphone cable, tripod with carrying case and setting-up plate, rpm probe, cable, set of single cells and carrying casses for ELMOT and for accessories
Recommended extras Lead Storage Battery EGT-Z 201.5437.00 Power Supply/Charger EGT-Z 201.5414.00 Optical RPM Probe ELMOT-Z for diesel engines for diesel engines 235.5900.02 Sound-level Calibrator ELEB 201.5443.90
1) If a calibration certificate is required, the instrument will be forwarded

 If a calibration certificate is required, the instrument will be forwarded to the respective authority for calibration and delivery.

9 NOISE METERS

acoustic instruments



Measuring and averaging sound levels

Noise exposure caused by sound events varying in time can only be determined by averaging the sound level over the period in question: **Mean sound levels** cannot be measured with conventional instantaneous-value soundlevel meters. The integrating sound-level meters required for this purpose need more elaborate circuitry and are consequently more expensive.

The **Integrating Sound-level Meter ELDO 4** from Rohde & Schwarz, based on a new circuit concept, indicates the equivalent continuous sound level directly in dB. It is offered at an expectionally low price.

To take a measurement with ELDO 4 simply

- select measurement duration
- select level range
- wait until measurement duration has elapsed and
- take reading

Block diagram of ELDO 4

Characteristics and uses

Three measurement ranges adapted to the German regulations concerning noise at places of work:

Signalling by LEDs in 3-dB steps:

red if level is above limit,

green if level is below limit.

Hand-held for quick rough measurements, mounted on tripod for long-term measurements.

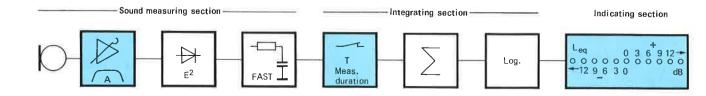
The Integrating Sound-level Meter makes noise control as laid down by national and international regulations easy. Thanks to its light construction intended for mobile use it is equally suitable for measuring noise at the place of work or traffic noise and for noise evaluation in residential areas.

Operation is simple: there are only two switches, one for measurement duration and one for measurement range.

Measurement duration is selected by means of a sliding switch. It is factory-adjusted to 15 s and 4 min. Any desired combination of two of the available times – 15 s, 1 min, 4 min, 15 min, 1 h, 8 h – can be taken to the switch by resoldering, say 15 s and 8 h. A duration of 8 hours (full work shift) is required for measurements at places of work with greatly varying noise levels, while by random measurements of short duration it is possible to get a rough idea of the noise environment.

The measurement range extends from 43 to 100 dB and is divided into three switch-selected, generously overlapping subranges. The subranges are based on the Federal-German regulations for places of work stipulating noise limits for different types of work:

- 55 dB(A) for primarily brainwork
- 70 dB(A) for simple or to a great extent mechanized office work or comparable activities
- 85 dB(A) for any other activities; under certain circumstances, which must be justified up to 90 dB(A).



acoustic instruments

NOISE METERS 9

These limits are the centre values of the ELDO 4 subranges. A symmetrically arranged LED scale (red for + and green for -) directly indicates the amount by which the measured value is above or below the selected noise limit. The measured value is always to the right of the indicated figure. If, for example, +6 dB is indicated and the range selected is 70 dB, the measured value is above 76 dB, more precisely between 76 and 79 dB.

The 3-dB resolution is adequate for coarse measurements. The response tolerance of the LEDs is ± 1 dB.

Although not used for traffic-noise measurements, a **rating sound level** L_r is encountered in the regulations governing noise at work. This quantity accounts for the higher annoyance effect of **impulsive noise** and can be computed from the equivalent noise level L_{eq} by adding 3 or 6 dB as given in DIN 45 645. Some examples:

- Add 0 dB for constant or slowly varying noise levels such as from motors and textile machinery;
- Add 3 dB for moderately impulsive noise such as in offices, workshops and assembly areas;
- Add 6 dB for markedly impulsive noise such as encountered in press shops and forges.



Quick rough measurement with hand-held ELDO 4

Specifications

opooniounono	
Frequency range Indication	16 Hz to 16 kHz equivalent continuous sound level Leg according to DIN 45641 and 45645
Measurement ranges (A weighting)	55 dB -12/+15 dB 70 dB -12/+15 dB 85 dB -12/+15 dB by LEDs
Display of test value	-,
	Participation Construct and memory an
Error of LED response Error of range switching Inherent noise Type of rectifier Crest factor Exchange rate Frequency weighting Time weighting	<1 dB <0.5 dB max. 10 dB below lower range limit ms-responding square-law rectifier 14 dB above +12-dB indication 3 dB A-weighting curve
Measurement duration, switch-selected adjustable	15 s/4 min (factory-adjusted),
	1 h. 8 h by resoldering
Precision microphone	omnidirectional pickup pattern 9-V battery IEC 6 F 22
Rattery lite	>50 0
Dimensions	104 mm×233 mm×43 mm
Order designation	ELDO 4 219.4026.02
Accessories supplied: 9-V battery IEC 6 F 22 Adhesive labels for other measurem Carrying case	nent durations (in the meter)
Recommended extras	
Wind Screen MKPM-Z Tripod Bracket ELT-Z3	
Tripod MKPM-Z2 (with folding legs) Tripod MKPM-Z5 (with screw-in	154.5899.02
legs)	155.0303.02 201.5443.90

Description

The Integrating Sound-level Meter ELDO 4 consists of an analog sound measuring section (similar to that of the Sound-level Meter ELT 3), a digital integrating section and an indicating section (see block diagram at the bottom of preceding page).

The sound measuring section is made up of a capacitor microphone, a switchable amplifier with frequency weighting filter according to curve A and a square-law rectifier with FAST time weighting.

The DC signal is applied to the integrator by means of the measurement duration selector. After several logic functions have been performed in the integrator the logarithmized integration value is passed on to the indicating section in 3-dB steps.

The three measurement ranges are switched over in the analog section. The eleven indicating LEDs are symmetrically arranged about the reference level values $55/70/85 \, dB$, i.e. each range covers 27 dB, namely -12 to 0 to $+15 \, dB$. Moreover, another two LEDs are provided to indicate when the range is exceeded or not reached.

Still another LED is provided beside the measurement range selector (position BATT./CAL.) for checking the battery voltage and for calibration. Use of CMOS integrated circuits ensures that very little current is required by the circuit, which is fed from a commercially available 9-V battery.

The plastic case is very handy and robust. Its shape takes into consideration the omnidirectional pickup pattern of the microphone, allowing for any direction of incidence of the noise. For long-time measurements the meter can be mounted on a tripod by means of a bracket. A carrying case is supplied with the meter for protection during transportation.

SOUND-LEVEL METER 9 ACCESSORIES

acoustic instruments







Third-octave Filter PBT

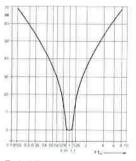
- 22.4 to 22400 Hz (f_m=25 to 20000 Hz)
- Auxiliary instrument for acoustic and vibration tests
- High skirt selectivity, passband attenuation 3 dB; performance complying with DIN 45652
- AC supply or battery operation

Third octave filters are required, for example, in sound-level and vibration analyses or measurements in the field of architectural acoustics to select particular frequencies trom wide spectra or to separate harmonics from fundamentals.

The active Third-octave Filter PBT consists of 30 bandpass filters which are switch-selected in 1/3-octave steps. Each is made up of two filter sections which together yield an attenuation characteristic complying with DIN 45652.

Selection of the bandpass filter (midband frequency) with rotary switches. A DI-RECT position is provided to bypass the filter via an internal 3-dB section.

The active section is fed from four 1.5-V single cells (or a power supply or a 6-V storage battery; to be ordered separately).



Typical filter response of a PBT

The plastic cabinet is metallized on the inside. It can be accommodated together with the EGT (Impulse Sound-level Meter) in a double case.

Specifications	
Frequency range Midband-frequency intervals Passband attenuation Max. input voltage Characteristics impedance Connectors Dimensions Weight	- ¹ / ₃ octave -3 dB -4.25 V _{rms} on sinewave -600 Ω BNC and 1/3.9 mm coaxial -212 mm×88 mm×158 mm
Order designation . (incl. four single cells)	Third-octave Filter PBT 235 3014.02
Recommended extras2 RF patch cords (100 cm, 75 Ω) 111 Connecting Cable EGT-Z 205.3011 Storage Battery EGT-Z (6 V) 201.1 Power Supply EGT-Z (6 V, weight1 Carrying case 235.5869.001 Double case (leather) 201.5337.0	6.02 (PBT – EGT) 5437.00 0.5 kg) 201.5414.00

PBO 1 Extractivery of

Octave Filter PBO

- 45 to 22 400 Hz
 - $(f_m = 63 \text{ to } 16000 \text{ Hz})$
- Auxiliary equipment for acoustic and vibration tests
- Chebishev filter complying with DIN 45651; high skirt selectivity, passband attenuation 3 dB
- AC supply or battery operation

Octave filters are used for the measurement and analysis of the sound level or structure-borne sound in architectural acoustics to separate certain frequency regions from a larger spectrum or harmonics from the fundamental frequency.

The active Octave Filter PBO contains nine filters electable in octave steps. The three filter circuits of each octave filter provide an attenuation characteristic according to DIN 45 651.

Selection of the filter (midband frequency) by means of a rotary switch. The selected filter can be bypassed by an internal 3-dB attenuator with the help of a toggle switch.

The active section can be fed either from four 1.5-V dry batteries, a 6-V storage battery or a power supply unit, which must be ordered separately.



Typical filter characteristic of a PBO

The PBO is in a plastic box, metallized on the inside and can be accommodated together with the EGT (Impulse Soundlevel Meter) in a double case.

Specifications
Frequency range 45 to 22 400 Hz (9 steps) Midband-frequency intervalls 1 octave Passband attenuation 3 dB Max. input voltage 3.5 Vrms on sinewave Characteristic impedance 600 Ω Dimensions 212 mm×88 mm×158 mm Weight 2.1 kg (with single cells)
Order designation > Octave Filter PBO (incl. four single cells) 201.5520.02
Recommended extras 2 RF patch cords (100 cm, 75 Ω) 100.6980.10 1 Connecting Cable EGT-Z 205.3016.02 (PBO – EGT) 1 Storage Battery EGT-Z (6 V) 201.5437.00 1 Power Supply EGT-Z (6 V, weight 0.5 kg) 201.5414.00 1 Carrying case 235.5869.00 1 Double case (leather) 201.5337.00

acoustic instruments

MKPM



Standard Microphone MKPM

- ♦ 8 Hz to 20 kHz
- Sound-pressure measurement range 28 to 150 (166) dB rms on a sinewave; 12 to 150 (166) dB with A-weighting curve
- Precision measurements in line with IEC 651 Type 0, and noise analyses with suitable test equipment
- Weather protection for diaphragm and electrical heater for outdoor use fitted as standard

The capacitor-type **Standard Microphone MKPM** is a multipurpose, electro-acoustic transducer. On account of its excellent characteristics it is mainly used for noise measurements requiring the highest accuracy. It has a low-impedance output so that long connecting cables (up to 100 m) can be used. Precision measurements according to DIN 45 633 Bl. 1 and 2, and IEC 651 can be made in conjunction with the Impulse Sound-level Meters EGT and EZGA 2. Accurate noise analyses can be carried out with an analyzer. The MKPM can be electrically heated.

The 150-V polarizing voltage and the supply voltage for the two-stage impedance transformer (30 V; 1 mA) are derived from the test equipment connected, or from batteries. With the polarizing voltage of 150 V it is possible to measure a peak sound pressure of 150 dB, and with 15 V a pressure of 166 dB.

When used together with the Weather Shield MKPM-Z the microphone is ideally suited for long-time measurements in outdoor stations, e.g. for measuring air-traffic noise. This combination is also in line with the requirements of DIN 45 643 and of ISO R 3891, R 1761 and R 507.

For acceleration measurements it is merely necessary to exchange the microphone capsule for the Adapter EBVB-Z 100.5803.02 in order to connect the Acceleration Pickup EBVB (right).

SOUND-LEVEL METER 9 ACCESSORIES

ELEB

(shown on larger scale)



Sound-level Calibrator ELEB ♦ 1000 Hz

- Acoustic calibrator for sound-level meters
- Sound-pressure level 93.6 dB (94 dB = 1 N/m² = 10 μ bar)
- Calibration check independent of weighting

The small, battery-powered **Sound-level Calibrator ELEB** is used for accurate calibration of sound-level meters (e.g. ELT 3, EGT, EZGA 2 and ELMOT from R&S). A 1000-Hz calibration frequency with a sound level of 93.6 dB (\pm 0.25 dB) is generated independently of the weighting filters. The effect of static air pressure is \pm 0.05 dB/100 mbar between 500 and 1100 mbar.

Calibration. The microphone of the sound-level meter is inserted into the coupler opening of the Sound-level Calibrator, and by pressing a button the 1000-Hz calibration signal of 93.6 dB is switched on. The duration of the signal – approx. 1 min if the 9-V battery is fully charged – indicates the condition of the battery. The sound pressure is independent of the microphone's equivalent volume.

The Sound-level Calibrator is supplied in a leather case. Dimensions of ELEB: dia. 44 mm, length 110 mm; weight 260 g. ► Order No. 201.5443.90.



Left: EBVB 100.5884.02, sensitive to force and acceleration; right: EBVB 100.5890.02, sensitive to acceleration

Acceleration Pickup EBVB ♦ 1 Hz to 20 Hz

Two different models are available:

- Acceleration Pickup sensitive to acceleration only Resonance frequency approx. 60 kHz Safe upper load limit 1000 m/s² Attached by built-in permanent magnet or adhesive wax
 ▶ Order designation: EBVB 100.5890.02
- Acceleration Pickup sensitive to acceleration and force Resonance frequency approx. 20 kHz Safe upper load limit 3000 m/s² or 30 N
 ▶ Order designation: EBVB 100.5884.02

For attaching the Acceleration Pickups, adhesive wax suitable for the temperature range between -10 and +80 °C is available.

Specifications

Frequency range	16 Hz to 16 kHz (within ±1 dB) 8 Hz to 20 kHz (3 dB down)
Free-field voltage response (ref. to 1 kHz, 150 V	typ. 18 ±3 mV/Pa (accurate value shown on
polarizing voltage) Output impedance	calibration certificate)
Inherent noise voltage	≈9 µV _{ms} (∆f 10 Hz to 20 kHz)
Rated temperature range	-30 to +60°C

Ordering information

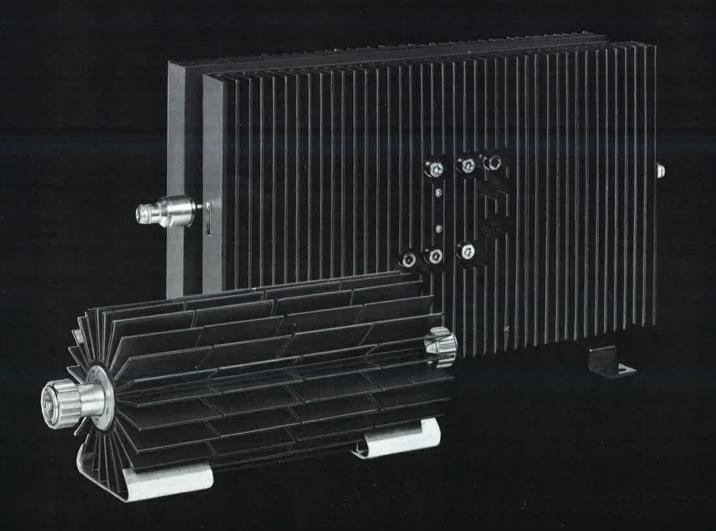
Order designations

Standard Microphone MKPM 220.5180.02
(incl. case, calibration certificate, wind screen and
microphone attachment)
Weather Shield MKPM-Z (wind and rain protection)
Connecting Cable MKPM-Z 1.2 m 5 m 10 m 20 m 50 m
100.5784.05 .02 .03 .04 .06
Tripod MKPM-Z2 (with folding legs) 154.5899.02
Boom MKPM-Z3 154.5901.02
Tripod MKPM-Z5 (with screw-in legs)

Terminations (dummy antennas) with test output (RBS, RBU); details on pages 286 ff

Right:

High-precision RF attenuators with manual control and remote control via IEC-bus interface (DPSP, below) and for manual setting only (DPS, right); details on page 292



terminations · attenuators



10 TERMINATIONS

terminations



Overview Terminations

Terminations with a power rating of 100 W to 20 kW are listed in the data sheet N 3-123.

Notes: 1) adaptable $\ ^2)$ up to 500 MHz $\ ^3)$ up to 300 MHz $\ ^4)$ with calibration curve ± 0.1 dB-

Power rating W	Designation	Туре	Order No	Charac- teristic imped- ance Ω	Frequency range GHz	VSWR	Attenuation (dB	Connector	Dimensions mm
----------------------	-------------	------	-------------	---	---------------------------	------	---------------------	-----------	------------------

Terminations for measurements

0.3	Precision Termination	RNA	272.4510.50	50	0 to 12	<1.02 (1.07)		N male	22 dia.×48
0.25	Termination	RMF 2	265.6863.00	75	0 to 0.02	<1.01		BNC male	16 dia ×23
0.5	Termination	RMF	100.2927.50 100.2927.70	50 75	0 to 0.03 0 to 0.03	<1.02 (1.06) <1.02 (1.06)		BNC male BNC male	16 dia.×55 16 dia.×55
ŕ	Termination	RMC	100.2940.50 100.2940.60 100.2940.70 272.4910.50	50 60 75 50	0 to 5 0 to 5 0 to 3 0 to 4	<1.02 (1.03) <1.02 (1.03) <1.03 <1.05 (1.2)	1111	Dezifix B¹) Dezifix B¹) Dezifix B¹) N male	45 dia ×55 45 dia ×55 45 dia ×55 21 dia ×35

High-power terminations and high-power attenuators

3	High-power Attenuator	RBD	100.2962.50	50	0 to 2.4	<1.08²)	10 ± 0.2	Dezifix B1)	48 dia ×140
30	High-power Attenuator	RBU 30	100.8654.25	50	0 to 1	<1.05	20 ±0.2	Dezifix B1)	140 dia.×180
80		RBU 80	100.8654.05	50	0 to 1	<1.05	3 ± 0.2	Dezifix B ¹)	140 dia.×180
100	1	RBU 100	100.8654.35	50	0 to 1	<1.05	30 ±0.2	Dezifix B1)	140 dia.×390
100		RBU 100	100.8654.15	50	0 to 1	<1.05	10 ± 0.2	Dezifix B ¹)	140 dia.×320
100	Termination	RAU	200.0019.02	50	0 to 2	<1.05 (1.4)	_	Dezifix B1)	95×152×235
			200.0325.02	60	0 to 2	<1.05 (1.4)	_	Dezifix B ¹)	95×152×235
			200.0019.55	50	0 to 2	<1.05 (1.4)	—	N female	95×152×235
1000	High-power Attenuator	RBS 1000	207.4010.55	50	0 to 0.4 (1)	<1.2	40 ±14)	N female	500×285×152

terminations

HIGH-POWER ATTENUATORS 10

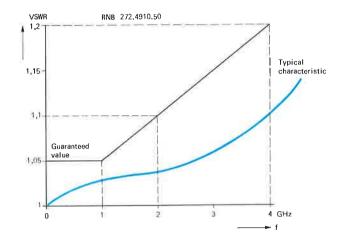
Characteristics and uses of terminations and high-power attenuators

Terminations. Understood here are all the components that are used solely as reflection-free terminations on instruments or cables, i.e. those having no test output. This is naturally applicable for small RF powers up to a few watts (an exception is the RAU for 100 W).

High-power attenuators. This category embraces the application as termination – e.g. as dummy antenna; the designation was chosen, however, because these terminations have a test output with a uniquely defined attenuation. They can therefore be used also as attenuators for extending the measurement range of power meters with lower ranges. For attenuators with lower power rating see next page.

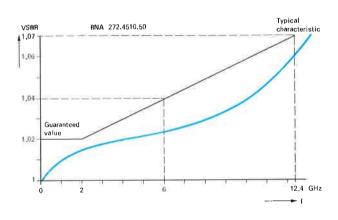
RMC Standard termination for coaxial test setups (21-mm outer diameter); acts as a termination on slotted lines and in impedance meters which are being used for measurements on cables and two-port networks as well as for adjusting directional couplers.

RNB Termination with N connector for general use in the frequency range from DC to 4 GHz; use of a stable metal-film resistor affords a power-handling capacity of 1 W.



Terminations for measurements

RNA A precision termination with N connector, featuring extremely low VSWR over the whole frequency range from DC to 12.4 GHz, mainly for use in electronic measurements.



RMF Reflection-free termination for instruments and test setups with BNC connectors. It has a nonwound resistance element without cap, the inductive reactance being compensated up to 50 MHz.

One end of the resistance element is connected to the inner conductor of the connector, the other end to the outer conductor.

The model with BNC connector can be used as a reflection-free termination for video transmission lines (VSWR \leq 1.02 up to 10 MHz).

The Termination RMF 2 (265.6863.00) with a 75- Ω metal-film resistor for 0 to 20 MHz is available to meet the higher requirements of the insertion test signal technique; its return loss is >50 dB up to 5 MHz.

High-power terminations and high-power attenuators

- **RBD** High-power attenuator, used, e.g. as dummy antenna and for harmonic measurements on transmitters (via its test output). This high-power attenuator with ladder construction is cooled by air convection currents along the outer surfaces.
- RBU The High-power Attenuator RBU 100 for 100 W, aircooled (100.8654.35; 50 Ω), consists of four seriesconnected attenuators with 1/3/6/20 dB attenuation so that a total transmission loss of 30 dB at 100-W power-handling capacity is available.

The other models of the RBU as separate attenuators of 30 to 100 W are listed in the table.

- **RAU** UHF termination (dummy antenna), especially for mobile or stationary transmitters; a low VSWR makes it also suitable for TV systems.
- **RBS** (1000 W) This high-power attenuator is also cooled by air convection currents. In addition to functioning as a dummy antenna, it can be used for determining the fundamental-wave power and the harmonic suppression on transmitters as well as for extending the measurement range of microwave power meters.

10 ATTENUATORS

attenuators

Characteristics and uses of attenuator pads and matching pads

Attenuator pads (DSF/DPF/DNF) of different attenuation are important accessories in test setups where the attenuation does not have to be changed over long periods of time. Their handy design (easy to replace) makes them particularly valuable for use in mobile test setups.

Matching pads (see next page) create the necessary match between measuring instruments and transmission lines of different characteristic impedances of the standard values 50 and 75 Ω or (as feed-through termination) match 50- Ω lines to measuring instruments with high input impedance. **DPF** These **attenuators** are designed for a power-handling capacity of up to 0.5 W. They have a maximum permissible pulse voltage of 1 kV. Of particular importance is their symmetrical construction enabling frequency-independent attenuation in both directions. Connectors: Dezifix A or Dezifix B (adaptable).



Attenuator pads

DSF The **DSF Attenuators** are low-cost, general-purpose components suitable for use at frequencies up to 1000 MHz. The attenuator elements are made up of π -networks of metal-film resistors.



DNF The DNF attenuators have N connectors and are mainly intended for lab use, integration into systems and range extension of power meters. High attenuation accuracy and flatness of frequency response together with low VSWR guarantee precise measurements. The DNF pads are very robust and immune to vibration in line with MIL-A-3933 and will withstand short-time overloading. Models available between 3 and 30 dB (see table below); power-handling capacity 2 W for 3-dB and 6-dB models, 1 W for other models.



Overview Attenuator pads

Frequency range	Designation	Туре	Order No.	Charac- teristic impedance	Attenuation	Power rating	VSWR	Dimensions in mm	Text
0 to 1000 MHz	Attenuator	DSF	289.8766.00 289.8814.00 289.8866.00 591.4338.00	50 Ω 50 Ω 50 Ω 50 Ω	3 dB 6 dB 10 dB 20 dB	1 W 1 W 0.5 W 0.5 W	≦1.1 (up to 500 MHz) ≦1.2 (up to 1000 MHz)	50.5× 36 dia	see above
0 to 4000 MHz	UHF Attenuator	DPF	100.1789.50 100.1820.50	50 Ω 50 Ω	5 dB } 20 dB }	0.5 W	<1.05 (<1.08)	100×36 dia. 125×36 dia.	see above
0 to 12.4 GHz	Attenuator	DNF	272.4010.00 272.4110.00 272.4210.00 272.4310.00 272.4410.00	50 Ω 50 Ω 50 Ω 50 Ω 50 Ω	3 dB 6 dB 10 dB 20 dB 30 dB	2 W 2 W 1 W 1 W 1 W	≤1.1 (up to 4 GHz) ≤1.2 (up to 10 GHz) ≤1.25 (up to 12.4 GHz)	56×21 dia.	see above

attenuators

MATCHING PADS 10

Matching pads

DAF Matching Pads DAF are unsymmetrical π sections with differing input and output impedances; they create the necessary match between measuring instruments and transmission lines having different characteristic impedances. Their voltage transformation ratio depends on the direction. The direction is marked by arrows. Series-opposed connection of two identical matching pads gives a total attenuation of 10 or 12 dB.

1	-11-	1510 - 101	34	E
ł	J-	Tees -		
	J.	12.12 12.12	14	

Feed-through termination

RAD The **Feed-through Termination RAD** is used for matching 50- Ω lines to measuring equipment with high input impedance (e.g. oscilloscope with 1-M Ω input). The RAD contains a metal-film resistor, which is connected in parallel with the input impedance of the measuring equipment. The RAD must be plugged directly into the input socket to ensure optimum matching.

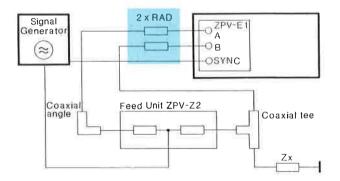


DAZ Matching Pads DAZ enable the characteristic impedance to be matched at one end since they only have one series resistor. They are used specifically for matching the output impedance of a signal generator of 50 Ω to lines or leads of 60 Ω of 75 Ω . A 50- Ω cable can be connected here between signal generator and matching pad. The advantage of these matching pads lies in their low attenuation.

No	and the second	-
A	Contrast 1	_
140	Manual Party of the local division of the lo	_
V IIIII	1	-

Typical application

When measuring transmission and reflection parameters in conjunction with the Vector Analyzer ZPV and Tuner ZPV-E1, Feed-through Terminations RAD are used to match the $50-\Omega$ network to the high-impedance inputs (1 M Ω ||17 pF) of the ZPV.



Measurement of reflection coefficient and low impedance values

Overview Matching pads

Frequency range	Designation	Туре	Order No.	Charac- teristlc impedance	Voltage transformation →/← dB	VSWR	Power rating	Dimension: in mm
0 to 1000 MHz	Matching Pad	DAF	100.1872.02 100.1889.02 100.1895.02	75:60 Ω 75:50 Ω 60:50 Ω Connectors: D	6/4 7.8/4.2 5.8/4.2 dezifix B at both ends	≦1.05¹) ≦1.05¹) ≦1.05¹) ¹) up to 300 M above: ≦1.1 s, adaptable		165×50 dia.
0 to 1000 MHz	Matching Pad	DAZ	242.1013.02 242.1513.02	50:60 Ω 50:75 Ω Connectors: D	0.8 1.8 Dezifix B at both ends	≦1.04 ≦1.04 s, adaptable	7 W 4.5 W	79×35 dia.
0 to 1000 MHz	Feed-through Terminalion	RAD	289.8966.00	50 Ω Connectors: B	INC male/female	≦1.05 (up to 100 MH ≦1.1 (up to ≦1.2 (up to 10	500 MHz)	50,5× 14.5 dia.

10 ATTENUATORS

attenuators

Characteristics and uses of attenuator sets

Attenuator sets are two-port networks with adjustable, calibrated attenuation and the same constant characteristic impedance at both input and output. They are used for gain and attenuation measurements (Figs 1 and 2), for determining the noise figure of a receiver (Fig. 3), for linearity measurements (with an attenuator connected before and after the test item; Fig. 4) or as reference attenuator (e.g. the highly accurate DPVP; see Fig. 2). In addition, accurately-known small voltages are obtainable with the aid of an attenuator set when a given, exactly determined input voltage is available. Their special construction has afforded a high degree of accuracy as well as a very wide frequency range.

Programmable attenuator sets in combination with programmable signal generators are suitable for setting up fully or semi-automatic test assenblies (Fig. 5) especially in production and test shops. The attenuation settings are made with electro-magnetic motordriven switches. The setting times are very short and always of the same duration as all resistors necessary for obtaining a specific attenuation are switched at the same time (even when switching between the extreme attenuation values). Programming is possible in the ASCII code via the IEC bus (e.g. for DPSP) or with Code Converter PCW and card reader.

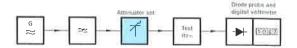


Fig. 1 Test setup with diode probe and digital voltmeter for gain and attenuation measurements at high test voltages

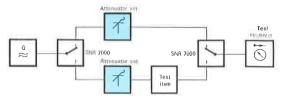


Fig. 2 Test setup with reference attenuator for measuring attenuation and gain with a high degree of accuracy

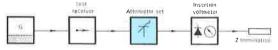


Fig: 3 Test setup for determining the noise figure of a receiver



Fig. 4 Setup for measuring the linearity of two-port networks

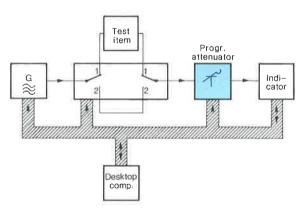


Fig. 5 Automatic test assembly for attenuation and gain measurements using programmable RF attenuators

Overview Attenuator sets

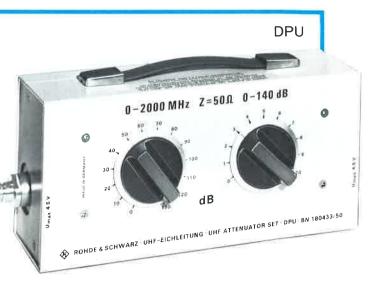
Frequency range	Designation	Туре	Order No.	Charac- teristic impedance	Attenuation	Smallest increment	VSWR	Dimensions in mm	Text on page
0 to 2000 MHz	UHF Attenuator Set (with N connectors)	DPU	100-8960.50 100-8960-70 100-8960-55	50 Ω 75 Ω 50 Ω	0 to 140 dB	1 dB	<1.15 (<1.3)	335× 145×115	291
0 to 1000 MHz	Programmable Attenuator (with N connectors)	DPVP	214.8017.55	50 Ω	0 to 139.9 dB	0.1 dB	<1.1	484× 150×336	293
0 to 2700 MHz	RF Step Attenuator programmable	DPS DPSP	334 7217 02 334 6010 02	50 Ω 50 Ω	0 to 139 dB	1 dB	<1.2 (1.3)	241× 110×234	292

attenuators

ATTENUATORS 10

UHF Attenuator Set DPU ♦ 0 to 2 GHz/0 to 140 dB

- Precision instrument for attenuation and gain measurements, determination of receiver noise figures, adjustment of very small, accurately-known voltages
- High accuracy average error <1% (0.5%) up to 1.5 GHz
- Small insertion loss approx. 1 dB up to 2 GHz



The **UHF Attenuator Set DPU** is simple and convenient in use over its frequency range from DC to about 2 GHz. Its applications include primarily attenuation measurements and gain measurements as well as accurate adjustment of very low voltages.

Attenuation settings between 0 and 140 dB are possible in steps of 1 dB. The excellent shielding also permits the very high attenuation values to be reliably used. The attenuation setting is convenient to read so that it is easy to see in which direction the knob has to be turned for a particular change in attenuation. This avoids overloading sensitive test items.

Its accuracy makes the DPU a precision instrument. The electrical length and consequently the delay time are practically independent of frequency and attenuation, so that the Attenuator Set can handle very short pulses as well as sinewave voltages. The reflection at the input and the output is very low. Mechanical wear, temperature and humidity do not appreciably affect the characteristics of the instrument. This makes the DPU also suitable for use under adverse climatic conditions.

The Attenuator Set is available for the standard characteristic impedances of 50 Ω and 75 Ω . If the test setup calls for different characteristic impedances at the attenuator input and output it is possible, up to 1 GHz, to insert matching pads of the type series DAF and DAZ, enabling impedance transformation from 50 Ω to 60 Ω , from 50 Ω to 75 Ω and from 75 Ω to 50 Ω .

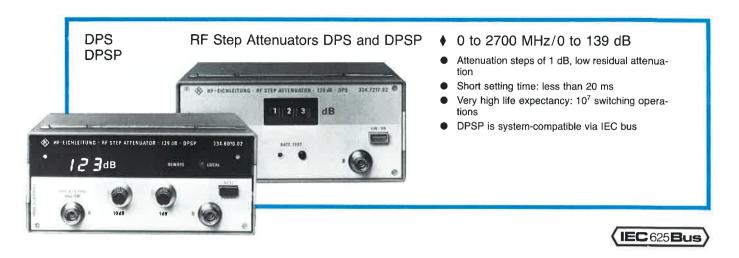
The DPU has a power-handling capacity of up to 0.4 W (pulse peak voltages: 300 V). The Dezifix B connectors are adaptable; model 55 is fitted with an N connector.

Specifications

Frequency range	0 to 2 GHz	
Attenuation range	0 to 140 dB	
	switch-selected in	steps of 10 dB and
	1 dB	
Error limits		1-dB steps
0 to 1.5 GHz		
Per step	+0.1.dB	±0.05 dB
Overall error	+0.4 dB	+0.15 dB
1.5 to 2 GHz	_011.02	
Per step	+0.2 dB	±0.1 dB
Overall error		+0.2 dB
Insertion loss at 1 GHz		
Characteristic impedance		pending on model
VSWR		
0 to 1.5 GHz	<1.15	
1.5 to 2 GHz		
Delay		
Power-handling capacity		
Permissible input voltage		pulse
50-Ω model	4.5 Vms	300 V _{pp}
75-Ω model	5.5 Vms	300 V _{pp}
Connectors		ble;
	50-Ω model also	
	connectors	
General data		
Rated temperature range	+15 to +45°C	
Dimensions, weight	335 mm × 145 mr	n×115 mm. 4 ko
billionaland, traight 111		
Ordering information		
Order designation	UHF Attenuato	r Set DPU
50-Ω model (Dezifix B)	100.8960.50	
75-Ω model (Dezifix B)	100.8960.70	
50-Ω model (N female)	100.8960.55	

10 PROGRAMMABLE ATTENUATORS

attenuators



Characteristics and uses

The **RF Step Attenuators DPS and DPSP** facilitate the quick and accurate performance of all tasks of attenuator sets in the frequency range from DC to 2700 MHz. This includes in the first place measurements of gain, attenuation and sensitivity (receiver noise figure) and the reduction of voltages to very small and uniquely defined values.

Differences between the types. All electrical characteristics are identical for DPS and DPSP, the two types differ only in the mode of operation (for details see below):

DPS manually operated by decade switches

DPSP can be manually operated by rotary switches with automatic carry and remotely controlled via IEC bus.

Common characteristics. With both these attenuators, attenuation values from 0 to 139 dB can be set in steps of 1 dB. Effective shielding guarantees full reliability of the result at the highest attenuation.

The **accuracy** complies with the usual requirements for precision instruments. Very short pulses are handled with the same precision as sinewave signals.

Input and output present extremely low reflection. On both types the RF connectors on the front panel can be rerouted by the user to the rear panel, no change of cables being involved.

The **carrying handle** can also be used as a stand or screwed off.



DPSP with stand

Manually operated Step Attenuator DPS

The attenuation value is set by decade switches. Batteries are incorporated for mobile applications; they are recharged during operation from the AC supply.

Programmable Step Attenuator DPSP

Attenuation can be set manually on the DPSP with two rotary switches, carryover being executed automatically. The switching functions are controlled by a microprocessor. In addition the unit has an IEC-bus interface and can be combined with other IEC-bus-compatible instruments and computers in automatic test systems. The setting time of the attenuator is 20 ms. With more than 10⁷ switching operations a long service life is guaranteed even if extremely frequent switching is required. The DPSP can be incorporated into 19" racks by means of an adapter.

Specifications	
Frequency range	0 to 2700 MHz
Attenuation range Attenuation setting DPS . DPSP	0 to 139 dB, 1-dB steps 3 decade switches 2 decade switches with automatic
Attenuation error	. ≦± (0.2 dB +1.3% of setting),
typical	max. 1 dB ± (0.1 dB +0.6% of setting).
Residual attenuation at 200 MHz	max. 0.5 dB
Characteristic Impedance	50 Ω, Pmax average 1 W
Programming (DPSP only)	control of all functions, data transmission in listener func-
Setting time	≦20 ms
Rated temperature range Storage temperature range DPS DPSP	N female on front or rear panel 115/125/220/235 V ±10%, 47 to 440 Hz (10 VA) NiCd battery for 5000 switching operations, bullt-in charger +5 to 45°C
Ordering information	
Order designation DPS	334.7217.02 334.6010.02 power cable
And	10 Hudplot 22H 1 070.0010.00

PROGRAMMABLE ATTENUATORS 10

Programmable Attenuator DPVP

- 0 to 1000 MHz/0 to 139.9 dB
- Smallest increments of 0.1 dB
- High accuracy, small attenuation error
- Programmable in BCD code TTL-compatible
- Built-in store strobe input



Characteristics and uses

The **Programmable Attenuator DPVP** enables very accurately defined attenuation values of between 0 and 139.9 dB to be provided for $50-\Omega$ networks. It can be used up to 1000 MHz.

Attenuation settings. The smallest attenuation step that can be manually set or programmed is 0.1 dB. All setting procedures are completed within 35 ms, even when switching from the lowest to the highest attenuation.

Programming, use in test systems. The DPVP is designed for programming in the BDC code. When using the Code Converter PCW, the Programmable Attenuator can be connected to the IEC bus and thus hooked up to automatic test systems; in this way, several DPVPs can be integrated in a system.

Description

The Attenuator DPVP consists of 15 attenuator sections in steps between 0.1 and 20 dB; the sections are switched into the attenuation path by means of a decoder circuit using noble-metal swivel contacts.

Switchover between manual and programmed operation is performed by means of the programming plug.

Programming itself is in positive-logic BCD code with TTL-compatible programming levels.



Programmable Attenuator DPVP plus Code Converter PCW (for programming via IEC bus)

Accuracy. The typical error of the individual attenuator sections (steps) is about 0.02 dB for frequencies <100 MHz and about 0.07 dB over the entire frequency range; a calibration table supplied with each instrument contains the reference values for seven frequencies. According to this table the error is less than 0.02 dB per attenuator section.

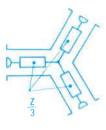
Specifications Frequency range 0 to 1000 MHz Attenuation range 0 to 139.9 dB in smallest steps of 0.1 dB Attenuation setting on four decade switches, manually or programmed
Attenuation range 0 to 139.9 dB in smallest steps of 0.1 dB Attenuation setting
Attenuation setting
manually as programmed
manually or programmed Programming via 50-pin connector at rear; positive logic, TTL-compatible, BCD code, common strobe input, built-in store Setting time
Attenuator error see text under accuracy (typ. total error at 0.07 dB)
$ \begin{array}{cccccccccccccccccccccccccccccccccccc$
Ordering information
Order designation Programmable Attenuator DPVP 214.8017.55
Accessories supplied 1 power cable (2 m long); 50-pin connector for programming input
Recommended extras Code Converter PCW 244.8015.92 with Coding Board 245.2510.02 for programming according to the IEC-bus standard

10 JUNCTION BOXES

coaxial components

Deter left





Three-port Junction Box DVU 3 • 0 to 1000 MHz

- Three-port junction box for splitting up into or combining two channels with correct impedance matching
- Range of application up to and above 1000 MHz
- VSWR with impedance matching <1.15

The Three-port Junction Box is equipped with three adaptable Dezifix-B or N female connectors. Matching is achieved by Z/3 impedances in a star configuration.

Characteristic impedance 50 Ω , 60 Ω or 75 Ω

Attenuation 6 dB

Max. load per input 1 W

Max. permissible pulse peak voltage 300 V Dimensions 120 mm dia. ×35 mm

Order designation	Three-port Junction Box
	DVU 3
50-Ω model	100.5203.50
60-Ω model	100.5203.60
75-Ω model	100.5203.70
50-Ω model,	
$3 \times N$ female, adaptable	100.5203.03

DVS



Power Splitter/Combiner DVS

- 0.1 to 400 MHz
- Distribution or combination of signals
- (max. 1 W = 7 V into 50 Ω)
- High isolation between inputs (20 to 40 dB)

The attenuators used for decoupling when measurements are made with several signal generators normally require a high output voltage from the signal generators. This drawback can be overcome by using the Power Splitter/Combiner DVS, which exhibits a low transmission loss (typical value: 3 dB), so that no additional attenuators arre required.

Characteristic impedance ... 50 Ω ,

	connectors: BNC female
Transmission loss	approx. 3 dB
Isolation between inputs	20 to 40 dB
Maximum continuous load	1 W = 7 V into 50 Ω
Dimensions	57 mm $ imes$ 36 mm $ imes$ 41 mm
Order designation	Power Splitter/
	Combiner DVS
	342.1014.50



Four-port Junction Box DVU 4 ♦ 0 to 1500 MHz

- Four-port junction box for splitting up into or combining three channels with correct impedance matching
- Application, e.g. for measurements on radiotelephone equipment involving three signal generators
- VSWR with impedance matching <1.05 (up to 1 GHz), <1.3 (up to 1.5 GHz)

The Junction Box is a coaxial construction of four low-reflection, precision Dezifix-B or N female connectors. The matching is achieved by Z/2 impedances in a star configuration. The Termination RMC or RNB is recommended for terminating any outputs which are not used.

Characteristic impedance 50 Ω Attenuation 9.5 dB Max. load per input 0.25 W Max. permissible peak voltage 300 V Dimensions 120 mm \times 120 mm \times 35 mm

Order designation ► Four-port Junction Box DVU 4

With connectors	
Dezifix B (adaptable)	201.4018.02
N female (adaptable)	201.4018.03

coaxial components

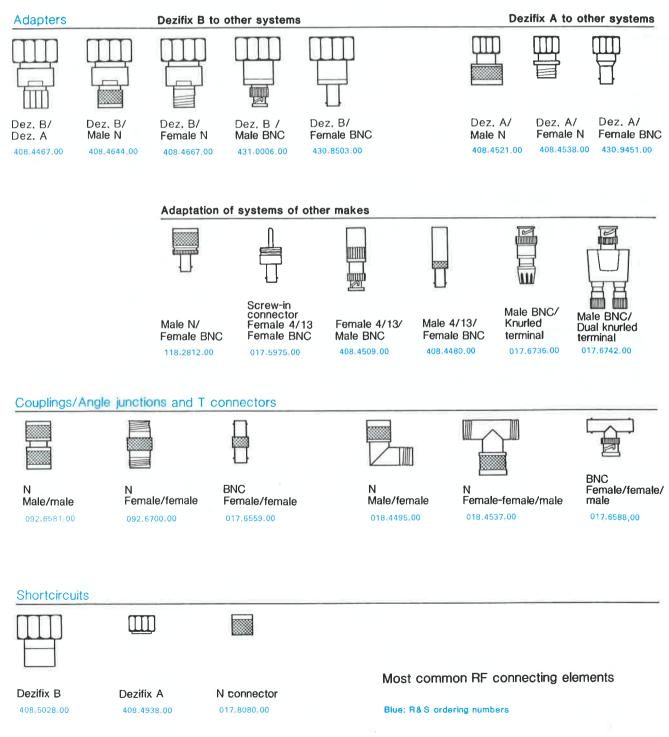
CONNECTORS 10

Connectors

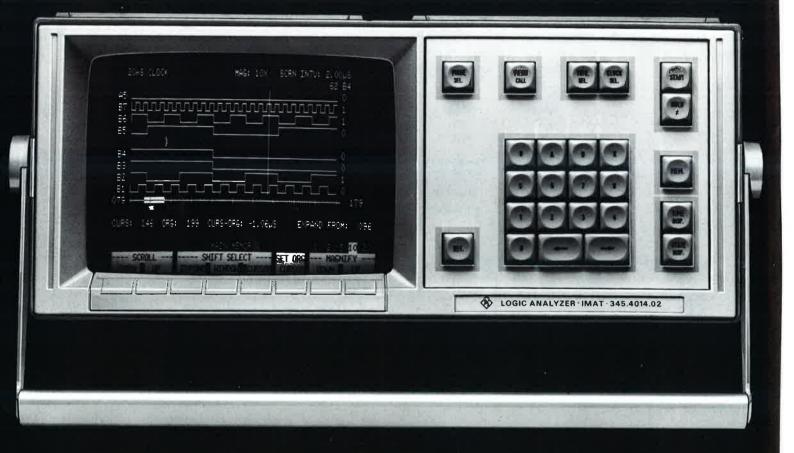
Rohde & Schwarz measuring equipment is generally equipped with the internationally used standard connectors. Depending on the requirements (e.g. frequency range, power-handling capacity, reflection characteristics), either N, BNC or Dezifix connectors are used.

All older Rohde & Schwarz instruments fitted with adaptable Dezifix A or B bases or with RF sockets 4/13 DIN 47284 can be adapted to other connector systems by means of screw-in assemblies or screw-in connectors and without the need for any modifications to the instrument: this is the best solution, ensuring minimum mismatch. In many cases, satisfactory performance is also achieved using the adapters shown below as an economical way of connecting Rohde & Schwarz instruments to those of other manufacturers fitted with other connector systems.

The following table also shows the most frequently required couplings, angle junctions and T connectors.



Logic Analyzer IMAT (below), Logic Generator IGA plus Serial Data Driver IGA-Z9 (right); for analyzer system and details on individual instruments see pages 300 ff





11 LOGIC MEASUREMENTS

Logic measurements

The functioning of digital and analog circuits is basically different.

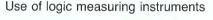
In the analog field, physical quantities such as voltage and current are handled. Thus analog measuring instruments have to detect, evaluate and display primarily physical signals.

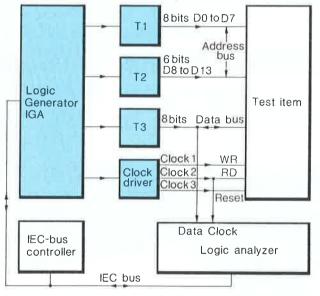
A completely different principle is used for **digital measure**ments.

The signal present and processed in the digital circuit is not an analog quantity but a

logic combination of standardized physical states, for instance 0 and 1.

Thus, irrespective of the function of the digital circuit, the same electrical signal levels will always be used. For this reason, digital circuits require special measuring instruments which, are able to stimulate and analyze logic events.





Example for combination of logic generator and logic analyzer (for text see under application examples)

Logic measuring intruments can be classified into:

- Iogic analyzers
- digital generators (logic generators)
- combinations of analyzers and generators

The **logic analyzer** is at present most frequently used; there are the two basic types, i.e. logic timing and logic state analyzer.

The logic timing analyzer is especially suitable for accurate examination of the timing of digital functions. Its sampling frequency is high (at least 100 MHz) whereas the number of channels is low. The memory should, however, have a minimum capacity of 1000 words.

The logic state analyzer is used to detect and display the sequence of complex digital events. It has at least 32 channels and a low operating frequency (15 to 20 MHz) as well as a wide range of triggering modes. Data can be displayed in decoded form.

logic test equipment

Digital generators are required for activating (and, in conjunction with logic analyzers, for analyzing) the examined functions, e.g. in the development and testing of subassemblies requiring external control to become operative.

Like with analyzers, a difference is made between

- timing word generators and
- Iogic generators.

Timing word generators are used to examine the sequence of events in digital circuits as a function of time at the maximum data rate. Due to the high costs of data channels featuring a high output rate, the number of channels used in timing word generators is small. Nevertheless, these instruments are expensive.

Logic generators are used in conjunction with logic state analyzers to check logic functions of digital circuits. They feature a great number of channels at a low price. They are able to drive bidirectional bus systems and take over data output functions of microprocessor circuits.

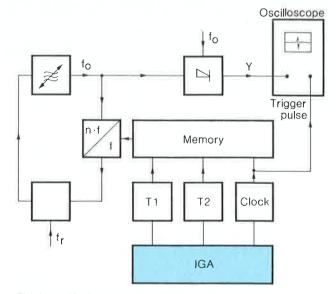
The combination of analyzer and generator forms practically always the basic configuration of a digital test assembly. In addition, there are also measuring instruments, such as the in-circuit emulator, which combine the functions of the analyzer and generator. Their use is, however, limited because they requier to be controlled by a CPU.

Application examples: generator/analyzer

A typical example of the combination of logic generator and logic analyzer is illustrated in the lefthand column: A test item driven by a data and address bus is checked. The logic generator controls the addressing, data entry and clock and the analyzer records the data obtained from the item under test.

In this way, IEC-bus-compatible instruments permit an automatic test system to be configured as an alternative to the conventional digital test systems.

Digital measuring instruments – in particular logic generators – are also useful for testing analog functional groups with a digital interface. The diagram below shows how the analog testing of a PLL is carried out with the aid of a logic generator which is also able to supply control signals with a variable data rate.



Digital control for the measurement of analog functions

LOGIC ANALYZER SYSTEMS 11

System IMAS/IMAT = modular matching of price and performance

- System configuration with independent logic measuring instruments
- Separate use or system configuration for timing, state or function analysis in μP circuits
- Master-slave triggering

For details on individual instruments see pages 302 ff

IEC-bus-compatible



System characteristics

The **Logic Analyzer System IMAS/IMAT** offers an especially economical solution to the increasing number of measurement tasks in the field of logic analysis.

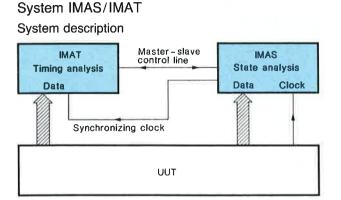
Since the IMAS/IMAT assembly consists of independent instruments, it can be used as an **integrated system with maximum measuring performance** or split up yielding **separate test setups** for tasks in the field of conventional **timing and µP analysis.** This double use enables flexible adaptation of the instrumentation to the measurement problems to be solved. A special advantage is the possibility of using first only one instrument depending on the specific task on hand and adding the other one as soon as required. In this way the investment expenditure can be spread over the years. The number of the two system components (i.e. IMAT and IMAS) may vary so that the instrumentation pool is adaptable to the specific applications.

As both separate use and system configuration are possible, the two instruments are an especially economical solution when procuring logic analyzers. Another advantage of using two instruments is offered by the **two screens** where timing and logic state display is possible simultaneously.

Measurement and display capabilities of IMAS/IMAT system

IMAT Logic Analyzer	for timing and logic state analysis Uses: Timing analysis in μ P and digital circuits, glitch detection or function analysis of μ P and digital circuits
IMAT-B2 (option) Analog Recorder	for timing analysis of analog and hybrid circuits
IMAS Logic State Analyzer	for logic state analysis Uses: Function analysis of μP and digital circuits with high trigger intelligence and excellent selectivity, μP program analysis
IMAS-B1 (option) Counter/ Signature Analyzer	for performance analysis of μP programs, time measurement of digital functions
IMAS/IMAT System with Analog Recorder IMAT-B2	for simultenous timing and logic state analysis Uses: Simultaneous timing and function analysis; timing analysis in μ P and digital circuits as well as μ P programs with trig- gering in the state domain; function analy- sis with triggering by time events and on glitches; timing analysis of analog and hybrid circuits with triggering by logic or program functions

11 LOGIC ANALYZER SYSTEMS

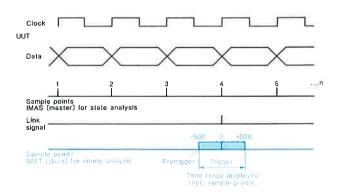


Master-slave control of timing and function analysis

The Logic Analyzer System IMAS/IMAT is based on the principle of simultaneous timing and function analysis: Asynchronous timing analysis with internal clock and synchronous state analysis with external clock are performed separately in two independent instruments **at the same time**. This simultaneous analysis establishes the relation between the logic function and the timing of the function itself. The coordination can be shown by inserting a synchronizing clock into the timing display. Each clock identifies the point at which the logic state analyzer has recorded a new logic state (see righthand column, top). The synchronizing clock is available at a BNC output on the rear panel of the IMAS and can be applied to one of the data inputs on the IMAT (see diagram above).

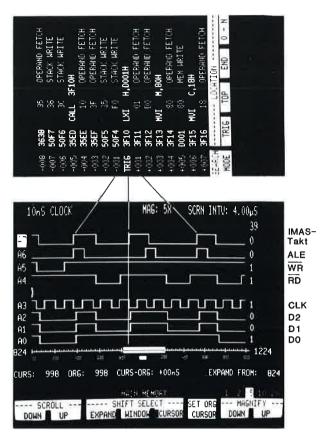
As the two types of measurement are performed at the same time, it is possible to separate the analysis proper and triggering, i.e. the time-domain analysis can be triggered by logic states and vice versa. To this effect, bidirectional master-slave control is used so that each analyzer can act either as the master or the slave.

Control is performed such that, with its trigger condition reached, the analyzer acting as the master delivers a control signal which is processed by the slave analyzer(s). This signal may either cause a direct start or be linked with individual selectable trigger conditions of the slave analyzers.



Simultaneous logic state and timing analysis

logic test equipment



Example of timing analysis with state-domain triggering and disassembler display

Timing display range 4 μ s (400 sampling points with internal clock of 10 ns) Logic state display range 16 μ s (16 sampling points with mean external clock of 1 μ s)

Advantages of master-slave operation

The master-slave configuration for timing and logic state analysis obtainable with the Logic Analyzer System IMAS/ IMAT is considerably more powerful than conventional timing and logic state analyzers which – although capable of performing both types of analysis – cannot do this simultaneously.

Disadvantages of using a general-purpose analyzer for timing analysis with triggering in the time domain (see next page, bottom):

- Complicated and lengthy definition of trigger conditions
- Triggering of nested events often impossible
- At high sampling rate only narrow time windows displayed
- Consecutive display of long trigger sequences thus not possible
- Definition of trigger sequence in disassembler display mode not possible

LOGIC ANALYZER SYSTEMS 11

Disadvantages of using a general-purpose analyzer for logic state analysis with triggering in the state domain:

- Information on test item timing not available
- Information on events between clocks not available
- Glitches not detected
- Triggering on time events impossible

These restrictions apply to all the general-purpose analyzers capable of performing both timing and logic state analysis as long as these two functions cannot be used simultaneously and independently. It is simultaneous timing and logic state analysis that avoids all the disadvantages listed since the results from the two domains are available at the same time supplementing each other in a meaningful way. This holds for the IMAS/IMAT combination featuring considerable merits:

- Timing analysis with extremely easy triggering on logic states or program steps in the state domain
- Display of a wide function range despite the high resolution of timing analysis
- State and program analysis with triggering on glitches or malfunctions in the time domain
- Simultaneous display of timing analysis and trigger sequence in the state domain thanks to two screens

Stimulation of test item

To expand the IMAS/IMAT system, the Logic Generator IGA is available for stimulation of the test item. It delivers the data and control signals required for timing and function analysis. Moreover, the IGA can be used to control the analyzer directly, which often simplifies triggering even further.

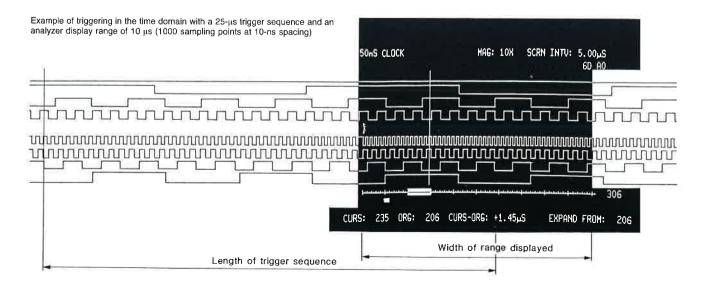


Logic Generator IGA; for details see page 302

The configuration of IMAS/IMAT plus IGA constitutes a complete digital test system which meets all the requirements of modern digital measurements. It is an ideal tool for rationalizing the development and testing of digital systems.

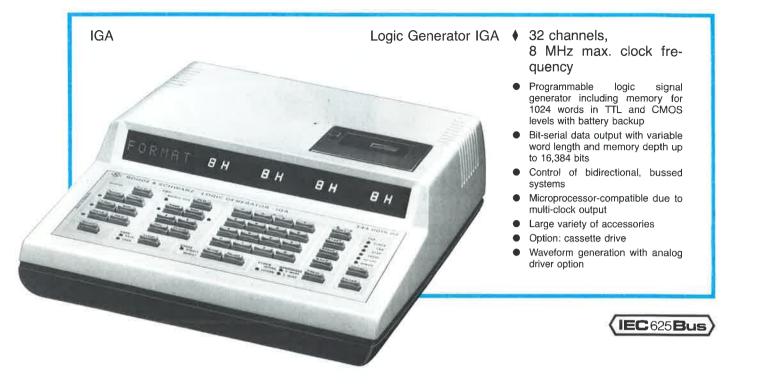
Condensed data of IMAS + IMAT		
For the complete specification individual instruments: IGA or page 314.		
Number of channels	(IMAT	
Clock frequency	max. 100 MHz max. 40 MHz	logic state analysis (IMAT)
Memory depth	1000 words,	logic state analysis (IMAS) timing and logic state analysis (IMAT)
Trigger levels	250 words, 2	logic state analysis (IMAS) timing and state triggers (IMAT)
	16	state triggers (IMAS)
Master-slave operation		
Master-slave mode	IMAT and IMAS	can be used either as master
	or slave analyz	er
Number of masters		
Number of slaves		
	any combinatio	on of IMAT and IMAS possible
Delay of master-slave		
control	approx. 200 ns	
		C 625-1/IEEE 488)
Dimensions ($W \times H \times D$) Weight	37 kg	11110 A 464 mm
AC supply	115/125/220/2	235 V +10%

47 to 63 Hz (385 VA)



11 LOGIC GENERATORS

logic test equipment



The **Logic Generator IGA** ist both a **bit pattern generator** for analyzing logic signals and an **information generator** for checking the control and setting capability of digital systems (analog and engineering systems, too). It consists of the generator proper and plug-on drivers. In contrast to conventional word generators, the IGA is a general-purpose device on account of the following characteristics and capabilities:

- Large storage capacity of 1024 words, data retention due to battery backup
- Tristate words programmable by channel groups for stimulating bidirectional data lines
- Multi-clock output for four strobe signals
- Sufficient number of data channels

- Data storage on magnetic-tape cassettes (option)
- Module-oriented data management with symbolic names and line numbers, fetching and outputting of bit patterns simplified by plain-language names, data entry and variation by way of powerful editor
- Data format either binary, octal, decimal or hexadecimal
- Possibility of linking data sets to form module sequences (with programmable pauses)
- Separate drivers with low-noise control of test items via short lines
- 3-wire handshake (IEC bus) and 2-wire handshake
- Programming via IEC bus
- In conjunction with Serial Data Driver IGA-Z9 (photos below and on page 307), generation of bit-serial data, two-channel operation with marker generation at any position



Logic Generator IGA with clock driver (including driver adapter, cable and miniclips) and data driver

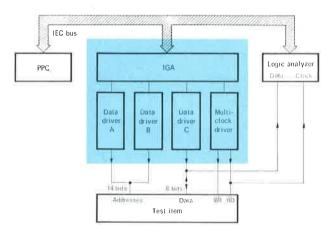


IGA with Serial Data Driver IGA-Z9 for bit-serial data generation (two Serial Data Drivers can be connected simultaneously)

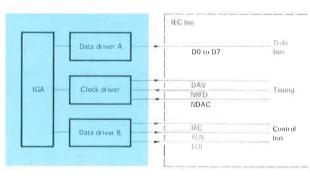
LOGIC GENERATORS 11

Simplified generation of bit patterns. Thanks to its great ease of operation, the IGA permits bit pattern generation with considerably less outlay. The editor functions and the cassette drive afford completely new applications especially in the development of digital circuits with reduced time and cost factors. The **IEC-bus interface** makes the IGA systemcompatible.

Testing of bus-controlled functions. The IGA is especially suitable for stimulating microprocessorized systems in its **multi-clock mode** and for functional testing of bussed systems by programming **tristate words** in channel groups (see diagrams below). In contrast to the conventional data and word generators, it thus covers all the applications involved in the stimulation of digital circuits.



Digital functional test in multi-clock mode (using IGA, logic analyzer and process controller)



Test of IEC-bus listener

Replacement of rigged-up generators. Thanks to the programmability of its functions, the IGA can be adapted to each measurement task without the need to resort to special, test-item-oriented solutions, thus saving time and reducing costs. Moreover, the use of a batch-produced instrument reduces the risk of erroneous measurements (and thus expensive down times). The risk of erroneous measurements due to unsatisfactory data retention is high in digital engineering. Here, in particular the variety of drivers available for the IGA (see photos on preceding page) offers a high degree of safety.

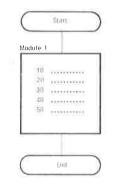
Technical details

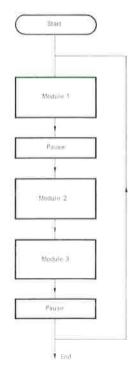
Operation. The sloped keyboard which is divided into edit, data and run sections permits convenient entry of the desired bit patterns and activation of the data output. In the display section, the module name or line number appears on the left and the data are read out on the right.

Data management. The IGA uses **module-oriented** data management. A module consists of numbered data lines and is stored under a selectable, symbolic name; a maximum of 25 modules can be stored. By addressing the line numbers or calling up the module names, the data words or data blocks (modules) can be easily output (see diagrams below), varied, erased, duplicated, etc. By linking modules it is possible to obtain **module sequences** (with pauses) which are assigned a name of their own.

Data entry. The data can be entered in the binary, octal, decimal or hexadecimal numerical system. The format instruction permits the channels of the IGA to be divided into a maximum of four groups, each being able to handle a different numerical system. The kill instruction deletes entire data words. A **cursor** enables individual figures to be changed. To extend the existing data set, additional lines can be inserted between lines previously entered.

Waveform generation. In conjunction with the Analog Driver Option IGA-Z11, which contains a 12-bit D/A converter, the IGA can be used for generating any waveforms. It is of special advantage that the cassette drive can store these waveforms. The Analog Driver Option considerably expands the application range of the IGA: a single instrument is thus able to produce bit-parallel, bit-serial and analog signals.



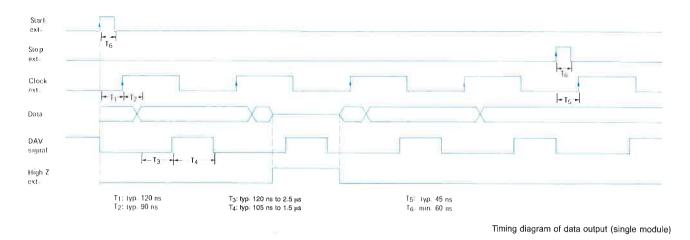


Left: data output of a single module (cycle mode: single)

Right: repetitive data output of a sequence with pauses (cycle mode: repeat)

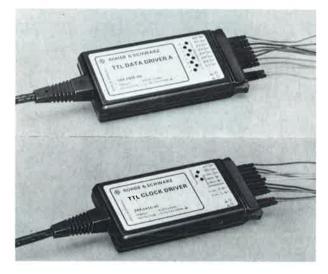
11 LOGIC GENERATORS

logic test equipment



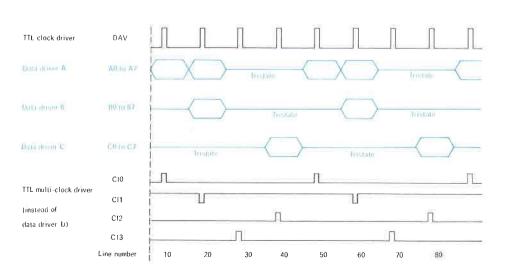
Data channels, adaptation. The IGA has 32 data channels and a storage capacity of 1024 words, thus enabling long data sequences to be stored. Battery backup ensures data retention if the IGA is switched off. Separate data drivers permit the data outputs to be connected in groups of eight channels to the test item (see righthand column). In addition to general-purpose drivers with adjustable levels (IGA-Z1) TTL drivers (IGA-Z4) are available. The driver adapters with individual plug-on cables are connected to the driver case so that the test items can be easily changed. To permit lownoise signal application, these cables are only 30 cm long and can be plugged onto wire-wrap pins (0.8 mm). IC (dualin-line) adapters are supplied with the IGA. IC test clips and mini-clips are available as accessories. The data output can be clocked, single-stepped, single-shot and repetitive with programmable, variable pauses (see diagrams above and on page 303).

Programming of tristate words (see diagram below). For driving bidirectional bussed systems, the data channels can be switched in groups of eight lines from the active to the high-impedance state during the output. At the end of the data output, the channels can also be switched in groups to high impedance. In the tristate mode, the IGA can, for instance, instruct a subassembly to transfer data and then



TTL Data Driver IGA-Z4 (top) and TTL Clock Driver IGA-Z5 (bottom)

have its data lines go high impedance whereas the address lines remain active. The DAV line continues to supply the clock for the talking subassembly.



Example for tristate mode (blue) and multi-clock mode covering several lines

Clock output. The IGA can be used with a built-in or an external **clock generator** up to 8 MHz. In addition, 3-wire handshake (corresponding to source handshake in accordance with IEC 625-1) and 2-wire handshake up to 1 MHz (with TTL drivers) can be selected. It is possible to set the start and the width of the clock pulse. The Clock Driver IGA-Z2 has **adjustable levels**; the Clock Driver IGA-Z5 delivers **TTL levels.** For the connection of the clock drivers see under data channels. The clock dirvers can be used for frequencies up to 3.5 MHz.

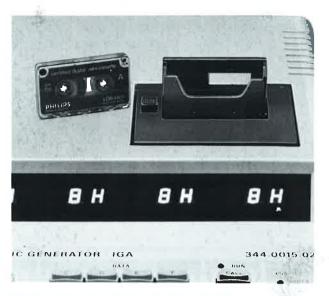
Generation of serial data. To generate bit-serial data, a driver (IGA-Z9) is available (see page 307) serializing up to 16 data channels of the IGA. In this way bit-serial data with word lengths freely adjustable between 2 and 16 bits can be produced. The available memory depth permits up to 16,384 bits to be stored depending on the word length. Data are output with TTL levels. When using the external clock input, the data rate can be increased to up to 30 MHz.

Multi-clock output. The stimulation of microprocessorized systems is possible with the aid of the multi-clock driver (IGA-Z6, see below; signal examples on preceding page, bottom) delivering **TTL levels.** The driver provides data for four channels and, in addition to the continuous clock signal, four separately programmable strobe signals whose polarity can be selected individually on the driver case. The number of data channels available is thus reduced to 28. The multi-clock driver must be used at low clock frequencies whereas



TTL Multi-clock Driver IGA-Z6

LOGIC GENERATORS 11

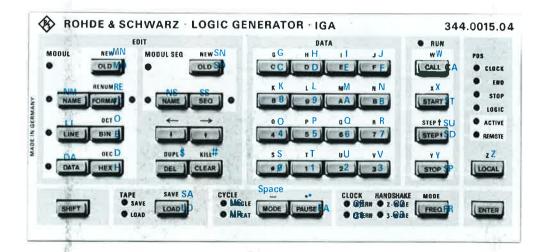


Cassette compartment of Cassette Drive Option IGA-B2

at high clock frequencies (>3 MHz) strobe signals can be defined directly as data segments. This however reduces the memory capacity since at least three data words are required for each strobe signal.

Cassette drive (option; for illustration see above). Two times seven complete IGA memory contents, corresponding to the capacity of the cassette, or individual data sets can be stored on magnetic-tape cassettes (for instance for setting up a bit pattern library) and subsequently be read in again. In this way, the IGA can be used simultaneously for different tasks without losing data.

IEC-bus interface. This option makes the IGA programmable to IEC 625-1 with the front-panel keys (see photo below) and permits the logging of bit patterns on a printer. Moreover, data patterns generated in a desktop computer can be entered into the IGA via the IEC bus. In this way, the IGA acts as an intelligent, high-speed output interface for computers.



Ũł

2

Association of programming commands (blue) with front-panel keys of IGA

11 LOGIC GENERATORS

IGA Specifications Data memory Data entry Formal binary, octal, decimal or hexadecimal; can be used simultaneously in one data line after fetching the freely selectable symbolic module name or a line Data expansion and variation number; editor-aided Number of storable modules max, 25 date: 16 digits (7-segment indicators), module name and line number: Display 6 digits (LED matrix) Data output Modes single-step/single-shot/repetitive with programmable, variable pauses Start and stop by keystroke or external TTL level Data drivers (data signal outputs) Number of data drivers connected ... see text on page 304 can be set on rear panel of IGA ≦0.8 V 3 to 15 V Low High Fan-out (for high = 5 V) Capacitive loading TTL Data Driver IGA-Z4 Channels Level . 1 standard TTL load <50 pF 8 TTL Level 10 standard TTL loads Fan-out -1 V/+6 V simultaneous overload Permissible overloading ... Continuous overloading simultaneous overload on 2 channels max. typ. 30 ns (with 10 standard TTL loads) can be used instead of data drivers A, Rise and fall times Serial Data Driver IGA-Z9 ierial Data Driver IGA-29 can be used instead of data driver: B and C, D Channels 1 (2 outputs) Level output 1: TTL output 2: current loop Word length 2 to 16 bits, adjustable Clock frequency 2 Hz to 8 MHz for internal clock, 0 to 30 MHz for external clock with the appropriate word length TTL (positive logic) Ready . Control outputs

TTL (negative logic), bit association switchable BNC Bit synchronization Connectors Tristate words programmable for switching data channels to high impedance in every Switchable channels 8-bit groups Maximum data channels available when using tristate words 28 End tristate switching the data channels to high impedance at the end of the output internal or external Control Clock control internal/external/2-wire handshake/ 3-wire handshake (IEC 625-1) 1 Hz to 8 MHz Modes . Internal clock . Setting resolution Frequency error External clock 2 digits < 0.1%0 to 8 MHz can be set on rear panel of IGA 0 to 1 MHz Wait times Clock drivers (clock signal outputs) for 1 <3.5 MHz Test-item adaptation see text page 304 General-purpose Clock Driver IGA-Z2 Synchronous clock outputs DAV, inverted DAV can be set on rear panel of IGA ≦0.8 V Levels Low High 3 to 15 V

Low ≦0.8 V High 3 to 15 V Fan-out (for high = 5 V) 1 standard TTL load Capacitive loading 50 pF Asynchronous control lines (for 2-wire and 3-wire handshakes) DAV, NRFD, DAC logic test equipment

TTL Clock Driver IGA-Z5 Synchronous clock outputs	DAV, inverted DAV
Level Fan-out	
Asynchronous control lines	
handshakes)	DAV, NDAC, NRFD (resistor wiring as per IEC 625-1)
TTL Multi-clock Driver IGA-Z6	per IEC 625-1) can be connected to B and D instead of a data driver
DAV signal outputs Polarity	4; separately programmable
Level	ΠL
Fan-out Data outputs	10 standard 11L loads 4 (same as on TTL data driver)
Delay of DAV signal with respect to data	150 ns to 2.5 us) can be set on
Width of DAV signal	140 ns to 1.5 μs) rear panel of IGA
Control Inputs and outputs	TTL level
Start Start of data output Start Start of data output	1
	on clock driver
Stop stop of data output Clock ext. clock input	
High Z tristate	on rear panel of IGA;
Output: End end of data output	BNC
Cassette Drive IGA-B2 (option)	
Capacity of cassette	2 × 7 IGA memory contents
Programming	
System	24-way (Amphonol)
Interface functions	T5 talker L4 listener
	RL1 remote/local DC1 device clear
	DT1 device trigger
	SR1 service request
General data Rated temperature range	+5 to +45°C
Storage temperature range AC supply	
	47 to 63 Hz (70 VA)
EMC	RF suppression N -12 dB 325 mm \times 110 mm \times 420 mm, 5 kg
Dimensions, weight	325 mm × 110 mm × 420 mm, 5 kg
Ordening information	
Ordering information	
Order designation	Logic Generator IGA 344.0015.04
Accessories supplied	
Dual-in-line adapter	244 1024 00
14-way 16-way	. 344.1240.00
20-way	. 344.1263.00
40-way	. 344 1270.00
Options	
Cassette Drive	
	IGA-B2 344 2916.02
Recommended extras General-purpose Data Driver	IGA-Z1 344 3414.02
General-purpose Clock Driver	IGA-Z2 344 3514 02 IGA-Z3 344.3614 02
TTL Data Driver	IGA-Z4 344.3714.02 IGA-Z5 344.3814.02
TTL Multi-clock Driver	IGA-Z6 344 3914 02
Set of Mini-clips (20) ¹)	IGA-Z7 344.3114.02 IGA-Z8 344.1905.02
IC test clips, dual-in-line, 14-way	IGA-Z9 344.3143.02
16-way	
24-way	099.5245.00
Process Controller	
	GALET 100.0700.02

1) Supplied with the drivers

LOGIC GENERATORS 11

Serial Data Driver IGA-Z9

- Generation of any bit pattern required
- Bit rate: 1 Hz to 10 MHz with internal clock
 0 to 30 MHz with external clock
- Memory depth 16,384 bits or 1024 words
- Two-channel operation using two independently programmable data drivers



new

In conjunction with the Logic Generator IGA, the **Serial Data Driver IGA-Z9** permits the generation of bit-serial data. This considerably extends the application range of the IGA: Using the same instrument, it is possible to produce bit-parallel data with a word width of 32 bits and bit-serial data with a maximum length of 16,384 bits.

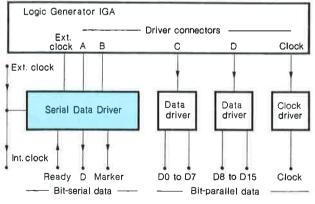
Typical applications

- Digital data transmission equipment
- Digital switching systems
- Data terminals
- PCM systems, remote-control systems, data networks

Characteristics

The Serial Data Driver IGA-Z9 accepts bit-parallel data words from the IGA, converts them into serial data and makes them available at the clock frequency set on the IGA (1 to 10 MHz when using the synthesizer incorporated in the IGA). The external clock signal input is suitable for frequencies of up to 30 MHz.

The mode control of the data output makes the data sequence available in the repeated or the single mode. For the repeated output mode, pauses can be inserted.



IGA plus Serial Data Driver

The data sequence is subdivided into **words** whose **length** can be varied from 2 to 16 bits with a rotary switch. A greater length can be obtained by combining several words.

A marker pulse available at a BNC output is produced in parallel with each data word. A rotary switch determines the bit position at which the marker appears within the word. The data output can be interrupted at any time via a **ready input**.

Data output ist performed in parallel via 2 connectors, one for TTL levels and the other for a 20-mA current loop. In addition a **clock output** is available delivering a synchronizing clock for each bit with internal clocking.

Display, storage. Any serial data word can be displayed on the readout of the IGA with a freely selectable format of up to 16 parallel bits. Like the bitparallel data, the bit-serial data can be stored in modules. The **editor** permits modification, duplication, insertion and erasure of data words or data modules as well as linkage of several modules to obtain module sequences.

The **cassette drive** makes it easy to store and load bit patterns thus rationalizing considerably data generation and management. Thus long data sequences can be produced.

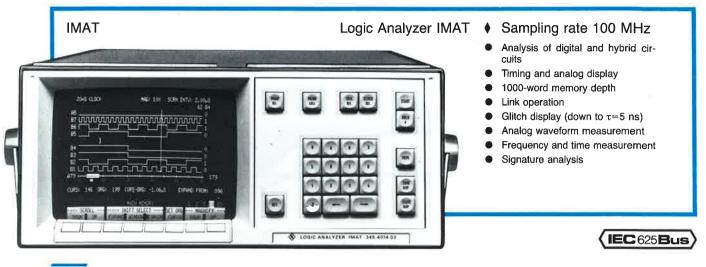
Data pattern generation via the IEC bus. The IGA is fitted as standard with an IEC-bus interface and can thus be hooked up to the Process Controller PUC (or other controllers). In this way, both the automation of test sequences and computer-aided data generation are possible.

Two-channel operation. Two Serial Data Drivers can be connected simultaneously to the IGA. The data patterns of the two drivers can be programmed independently so that at the same time two bit-serial data channels with different contents are available.

Specifications
Memory depth 16,384 bits or 1024 words Word length 2 to 16 bits, adjustable Bit rate 1 Hz to 10 MHz with internal clock, 0 to 30 MHz with external clock max. 3 MHz × number of bits per word or 4 MHz with 2-bit words and 8 MHz with 3-bit words
Outputs BNC connectors
Data output 1 TTL Data output 2 current loop (20 mA, switchable logic) Bit marking TTL, bit assignment switch-selectable Clock TTL
Inputs BNC connectors
External clock
Ready TTL Start on clock driver of IGA Stop on rear panel of IGA
Connection on IGA instead of data drivers A, B and/or C, D
General data
Rated/storage temperature range+5 to +45°C/-20 to +70°C Dimensions, weight
Order designation Serial Data Driver IGA-Z9 344.3143.02

11 LOGIC ANALYZERS

logic test equipment



new

The **IMAT** is a general-purpose logic analyzer which stands out for ease of operation, large-area display of measured data and comprehensive measuring capabilities. Digital signals may be evaluated both in the timing and in the state mode and, using the analog recorder option, **analog signals** related to digital events can also be analyzed. Thus the Logic Analyzer IMAT is suitable for use in the wide field of **hybrid systems** handling analog and digital signals at the same time. The counter/signature analyzer option extends the Logic Analyzer for additional measurements on digital as well as on analog circuits.

This makes the IMAT a general-purpose tool for circuit analysis in development, production and servicing.

Operational setup, softkeys

The IMAT is set up with the aid of softkeys, i.e. softwaredriven keys located immediately at the lower screen edge. The current labelling of these 8 keys appears on the screen and is adapted to the selected mode. This reduces the number of panel controls and shortens the required setup procedure such that the instrument is ready for use after an extremely short time. Moreover, this safe method of **prompting the operator** ensures that wrong settings are virtually avoided.



There is the special advantage that, in contrast to the usual menu displays, the screen labelling is located immediately above the key.

Softkey detail

Parallel to the selective software setting, a **monitor menu** yields information on the overall instrument setup.

Operation, basic modes

A total of **six basic modes** can be selected on the IMAT, see photo and detail below.

50MHZ			50MHZ 1000HDS		40MHZ
16 CHNE	8 CHNL	8 CHNL	ANALOG	COUNTER	

Mode selection on Logic Analyzer IMAT

6 CHNL TIMIN

For normal measurements on digital circuits, the **16-channel** configuration is used. With a memory depth of 1000 words, this mode permits sampling at an internal clock frequency of 50 MHz or an external clock frequency of 40 MHz.



For accurate timing analysis, the 8-channel configuration is used, the sampling rate being 100 MHz with a memory depth of 2000 words.



The 8-channel configuration plus glitch detection permits optimum glitch analysis. In this case, 8 channels are sampled at 50 MHz whereas the memory for the 8 remaining channels is used as a glitch memory.



CORD



In the counter/timer mode, the counter of the IMAT is enabled.

The analog recorder mode enables the di-

gitization and display of analog signals.



Finally, the signature analysis mode permits measurements up to 40 MHz.

LOGIC ANALYZERS 11

Setup memory

Another aid for operating the IMAT is the batery-supported setup memory ensuring that ten complete setups are retained even after the instrument has been switched off. This memory proves to be particularly time-saving whenever different entry modes have to be used in the course of one measurement.

Adaptation

The Logic Analyzer IMAT is supplied with two timing probes, each fitted with 8 inputs. The probes can be connected to the test item via exchangeable adapters whose other end is fitted with push-on sleeves to accommodate R&S mini-clips; see photo to the right. If each probe is provided with its own adapter, a rapid change of the test item is facilitated.

Glitch measurement

Glitch detection is one of the most important tasks when analyzing digital circuits. The latch mode used by most logic analyzers for this purpose is suitable only to a limited extent since a data change between the individual clock edges can be easily taken for normal data. In the latch mode, glitches are not displayed as such but represented as normal additional data.

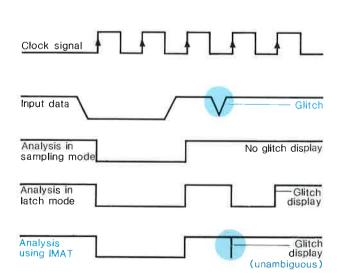
In contrast to this method, the IMAt uses a glitch memory permitting glitches to be marked clearly and unmistakably in the timing diagram (see below) in the basic 8-channel glitch measurement mode.

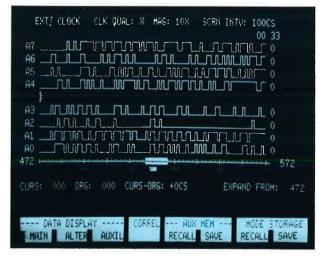


Reference memory

The IMAT contains a reference (auxiliary) memory of the same capacity as the main memory. The data from the main memory can be transferred to the reference memory. For comparing the two memories, special function sequences can be recalled; see photo below.

For automatic troubleshooting, the HOLD mode ensures that the analyzer automatically reads in new data until a difference between the main and the reference memory causes it to stop.





Comparison of reference and setup memories

Link operation

This capability is one of the most important characteristics of the Logic Analyzer IMAT. In the link mode, several analyzers are combined via a link line.

Master-slave synchronization. This mode permits several analyzers to be combined in a system. Thus the IMAT can be hooked up to the Logic State Analyzer IMAS. For further information see page 300.

Glitch display in latch mode and with IMAT glitch memory

It is obvious at a glance whether the bit pattern measured contains glitches. In addition, there is the possibility of using one channel at a time for **glitch triggering**.

11 LOGIC ANALYZERS

logic test equipment

IMAT – Logic Analyzer

Timing display

The timing display covers a maximum of 8 channels; the resolution can be increased by a magnification factor of up to 20. An additional scale shows the position of the **window** (**display range**) in the main memory.

Various aids are provided to facilitate localizing and positioning of the selectable data ranges. Glitches are clearly marked by vertical lines.

The IMAT features an extremely rapid display generation permitting the data to be shifted and expanded with exceptionally high speed. For comparing the main and the reference memories, the IMAT calculates a correlation factor thus marking the coincidence in the timing ranges. A cursor enables time difference measurements. The complete information relevant for evaluation is displayed in **text lines** parallel to the data display.

Logic state display

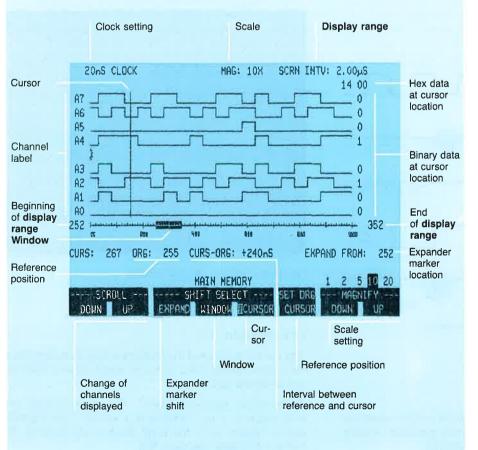
To display the logic state data, the data stored in the Logic Analyzer IMAT can be represented in the binary, decimal, hexadecimal, octal and ASCII codes.

	-0014	00000000				
100: 2001	=0013	00000000				
States - America	-0012					
SI6: H314		00000000				
Ĥ147		00000000	A CONTRACTOR OF			
	-0009	00000000				
	-0008	00000000				
	-0007	00000000	and the second se			
	-0006	00000000	and the second se			
	-0005	00000000				
	-0004	00000000				
	-0003	00000000				
	-0002	00000000				
	=00001	00000000				
	TRIG	00000000				-
MEMURI	A SECOND	URSOR-LOCH	All the Deliver		FERENCE -	FORMA
HN H C	TRIG			OFF	00	SELEC

Logic state display of IMAT memory contents

Various techniques are available for moving the cursor and the data. When comparing the main and the reference memories, the **difference mode** permits deviations to be rapidly localized.

Moreover, rapid information on the IMAT memory contents is available since the instrument calculates and displays characteristic **signatures** for the complete data contents.



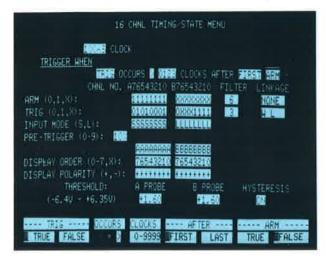
Hard copy of timing display on IMAT

310

LOGIC ANALYZERS 11

Triggering

The IMAT has two trigger levels (ARM and TRIG), which consist of a data word and the linkage condition.



Setting the trigger linkage

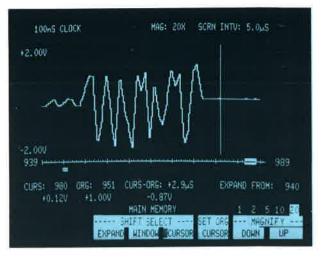
Arming and triggering can be linked in various ways. In this way, even complex events can be localized. Moreover, a programmable **filter function** is available for both arming and triggering. The pretrigger function permits continuous shifting into ranges before and after the triggering instant. The **trigger threshold** of the probes can be programmed in 50-mV steps so that the measurement of ECL signals is also possible. In addition, a hysteresis can be added. The **sample** or **latch mode** can be selected separately for each input channel.

Analog/digital measurement Analog recorder

The analog recorder option is a transient recorder which accepts **analog signals** up to 10 MHz via a BNC input. For this purpose, a 6-bit A/D converter with a maximum sampling rate of 50 MHz and a 1000-word memory depth is used.

The input sensitivity, offset, couping and sampling frequency are programmable. The test result is displayed as an analog signal on the screen of the IMAT; see photo in the righthand column.

The analog recorder can be started if an analog trigger threshold is exceeded or by the digital trigger facility of the IMAT. Thus analog measurements related in time to digital events can be made. The analog recorder function can also be used in the link mode for instance by way of a microprocessor analyzer.



Analog recording display on screen of IMAT

The analog recorder augments the IMAT from a pure digital analyzer to a hybrid analyzing system. It permits the **analysis of analog signals driven by digital circuits or microprocessors** as used in control systems and in general in hybrid circuits. In particular, transients can thus be measured in the form of a dynamic response.

Counter/signature analyzer

The counter/timer option is also suitable for use in analyzing digital and analog circuits. The following modes can be selected: frequency measurement, period measurement, event counting and time-interval measurement. The occurrences counted can be either analog signals applied to a BNC input or freely defined data words. In this way, the frequency and the time spacing of equal and different data words can be measured with high accuracy. The limit frequency for measuring data words is about 10 MHz whereas analog signals can be measured up to 100 MHz.

The counter option of the IMAT also contains a signature analyzer permitting signature analysis up to a limit frequency of 40 MHz. In addition to the characteristics common to instruments of this type, the IMAT features the capability of defining the start and stop condition by 16-bit data words. This simplifies signature analysis of test items which do not have any special connectors for controlling the signature analysis.

The signatures are displayed both in the hexadecimal and in the usual standard formats. The signatures are identified on the screen by the appearance of the words STABLE or UNSTABLE. The signatures are collected by a normal oscilloscope probe.

11 LOGIC ANALYZERS

logic test equipment

Basic operating modes

Mode	Sampling rate	Memory depth	Data captured via
16 channels, logic analyzer	50 MHz asynchronous 40 MHz synchronous	1000 words	2 timing probes
8 channels, logic analyzer	100 MHz (asynchronous)	2000 words	probe A
8 channels, glitch memory	50 MHz (asynchron. only)	1000 data words 1000 glitch words	probe A
Analog recorder	50 MHz (10 MHz bandwidth)	1000 words	oscilloscope probe, probes A+B for triggering
Counter/timer	100 MHz for external signals 10 MHz for data words		oscilloscope probe, probes A+B for data word measurement
Signature analyzer	40 MHz	_	oscilloscope probe, probes A+B for start/stop

Additional technical data

Operation	8 softkeys
	25 function keys
Capacity of setup memory	10 instrument setups
Inputs	16 data inputs
	(via Timing Probes IMAT-Z1)
	2 qualifier inputs
	1 link line input
	1 external clock signal input
Timing Probes (MAT-Z1	
Number of timing probes required	2 (1) depending on mode
Inputs per probe	2 (1), depending on mode
	1 qualifier input
	1 clock signat input
	each input is separately
	connected to around
Input impedance	100 kQ 10 pF
Threshold setting	±6.4 V
Resolution	50 mV
Max. input voltage	+100 V
Min. input voltage	0.5 V _{pp}
Hysteresis	0 or 200 mV (switch-selected)
Clock control	
Sampling time with internal control	10 ms to 10 ns (8 channels)
Resolution of setting	10 ms to 20 ns (16 channels)
Error of clock frequency	+0.2%
External clock frequency	0 (DC) to 40 MHz
a 'emal clock signal input	probe A
Ciock qualifier	1
The second second	
Timing of Input channels	
Skew	<5 ns (asynchronous)
Setup time	<10 ns (synchronous)
Hold time	5 ns (synchronous)
Memories	
	10.1000
Data memory	16×1000 words (50 MHz) 8×2000 words (100 MHz)
	RV1000 words (alitab mamoni)
Reference memory	corresponds to data memory
	conception to data moniory

Glitch detection	
Mode	latch mode or glitch memory
Minimum detectable glitch	5 ns with 0.25 V overdrive
Glitch memory	1000×8 with 1000×8 data words
Glitch display	
	basic mode by vertical lines in timing diagram
	Giagram
Trigger	
Pretrigger	0 to 900 words (16 channels)
	0 to 1800 words (8 channels)
Number of trigger levels	2 (ARM and TRIG)
Trigger word length	16 bits
Trigger logic	triggering on equality or
Trigger filter	nonequality
Trigger delay .	0 to 999 clocks or arm events
Modes of delay	triggering after n clocks,
	before n clocks, at n clocks
	or at n events
Trigger state	, displayed
Link operation	
Link-up	a) for combining with other analyzers
united in the second second second	via link connector
	b) for driving via external trigger
	qualifier connector
	c) for driving by analog recorder
Link conditions	(internal)
Link conditions	selectable for both trigger levels
Link connector	. BNC female on rear panel
	TTL (bidirectional)

LOGIC ANALYZERS 11

Trigger qualifier (external) Connector BNC female on rear panel Input level TTL Qualifier condition selectable for both trigger levels
Display Screen colour green Dimensions 23 cm diagonal Output for external display unit composite video signals Connector BNC female Output voltage ~1 V _{pp} (EMF) Impedance 75 Ω
Display modes timing display, data display, analog display (optional) Coding for data display hexadecimal, octal, decimal, binary, ASCII Data compression signatures for groups of 8 channels Timing display Timing display max 8 channels simultaneously
Timing curcor indicates time, hex and binary values at the corresponding cursor location Timing magnification
Analog recorder

Vertical format	level display with automatic scaling
Vertical resolution	6 bits
Timing magnification	1×, 2×, 5×, 10×, 20×
Cursor	indicates time and voltage

Analog Recorder Option IMAT-B2

Level resolution Sampling time Setting Number of channels	10 ms to 20 ns 1, 2, 5 sequence
Input Connector Input impedance Max. input level Input sensitivity Bandwidth Level measurement error Measurement range Resolution of setting	BNC female on rear panel 1 MΩ [] 30 pF ±200 V DC 10 mV 10 MHz (3 dB) ±5%; f <1 MHz 5 mV/div to 10 V/div
Display range Modes Input offset	AC, DC, GND
Main memory depth	
Trigger Analog	level and edge adjustable: 1 × display range, resolution 0.01 × display range
Digital Sampling time Resolution of setting Pretrigger	same as logic analyzer trigger 10 ms to 20 ns 1, 2, 5 sequence

Counter/Timer Option IMAT-B1

Modes	frequency measurement, period measurement, time-interval measurement, event counting
Signal application	 a) logic signals: via analyzer probes and internal word recognizer b) analog signals: via oscilloscope probe (10×/1×)
Analog signals Connector	BNC female on rear panel, impedance 1 $M\Omega$ 30 pF
Setting of switching threshold Probe ×1 Probe ×10	-2.56 to +2.54 V, resolution 20 mV -25.6 to +25.4 V, resolution 200 mV

Signal measurement	
.ogic signals	
Max. clock frequency for	
data words	
Analog signals	
Frequency measurement 100 MHz with prescaler 10 MHz without prescaler	
Gate time 0.01µs to 10 s	
Period measurement	
2.5 MHz without prescaler	
Measurement range 0.01 µs to 10 s Interval measurement	
Measurement range 0.2 µs to 10 s	
Resolution 100 ns	
Event counting	
Max. count	
Measuring error ±0.01%	

Signature analyzer (included in Option IMAT-B1)

Algorithm 16-bit standard Display	
Probability of correct signature 99.998% Minimum gate open time	
Minimum clocks required for signature display 4	
Test input oscilloscope probe (10×/1×) BNC female connector	
Impedance 1 MΩ 30 pF	
Setup time 15 ns with 0.2 V overdrive	
Hold time 0	
Max. input level	
Control inputs analyzer data, qualifier and of Setup time Setup time 10 ns Hold time 5 ns Max. input level ± 100 V Start and stop words 1 to 16 bits	lock
Clock frequency 0 (DC) to 40 MHz Minimum pulse width 20 ns Edge selection switch-selected	
Programming interface to IEC 625-1,	
24-way connector (Ampheno Interface functions 14 listener	4)
T5 talker	
RL1 remote/local	
DC1 device clear	

SR1 service request

General data

S ī

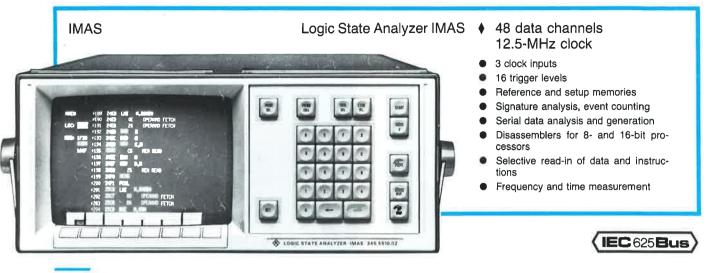
Rated temperature range	+5 to +45°C
Power supply	115/125/220/235 V ±10%,
	47 to 63 Hz (230 VA)
Dimensions (W × H × D), weight	470 mm × 206 mm × 484 mm,
	18.5 kg

Ordering information

Order designation	► Logic Anal 345.4014.0	
Accessories supplied		
2 Timing Probes,		
	MAT-Z1 345.7213.02	
2 Probe Adapters,	MAT-Z2 345.7313.02	
Power cable, carrying of		
Options		
Analog Recorder		
(including probe ×10) I		
Counter/Signature Ana		
(including probe ×10) I	MAT-B1 345.7013.02	
Recommended extras	•	
	GA-Z8 344.1905.00	
Test Generator		
Extension Board	MAT-Z7 345.7413.02	
	MAS-Z7 345.7913.02	(for servicing)
Logic Generator	GA 344.0015.04	(32 channels)
		,

11 LOGIC ANALYZERS

logic test equipment



new

The **Logic State Analyzer IMAS** is part of the IMAS/IMAT logic analyzer system and performs universal logic state analysis. It stands out for ease of operation, features a large number of channels and is suitable both for analyzing microprocessors and testing bussed systems and generalpurpose logic circuits. The 16 trigger levels, numerous qualifier conditions and several clock inputs make the IMAS ideal for localizing complex logic and software functions.

The IMAS is an indispensable add-on for in-circuit emulators since it makes possible microprocessor program analysis in the original circuit under absolute real-time conditions. The IMAS is combined with the 100-MHz Logic Analyzer IMAT (see page 300) via the link line so that a complete logic analyzer system is obtained enabling simultaneous timing and logic state analysis.

This concept offers all the measuring capabilities of a combined general-purpose system making at the same time full economical use of the two separate instruments since,

depending on the measurement task, the IMAS and IMAT can be used as a combined system or independent instruments

in different test assemblies.

Softkey control, monitor menu

The IMAS is mainly set up with the aid of **eight softkeys** (software-and microprocessor-driven keys) located immediately at the lower screen edge; the screen labelling of the softkeys is automatically adapted to the selected mode. The softkeys are driven by a microprocessor of their own simplifying the operation of the IMAS so that the user can perform complex measurements after a very brief period of familiarization.

The softkeys considerably reduce the number of front-panel controls and settings required.

FORHAT:	CORRECTED 1			
	BODS STAT	DH PB	55P8 EL	
TRACE 11	WILL WARK		-XKRAXX X	
08-2+	XXH2 XXXX	888 BH 88		
PRE TRI:			C LEIRDS	
RESTART:	2329 0111	08 88 36	SHOOR XX	
TRIGGER:	HODE STHT	DH PB	SSPB EL	
0	1225 28888		1000808 88	
1 THEN	NAME NAME	XX XX XX	-X8XX8X X8	HETER 0002 CLOCK
2 THEN	0101 8388	XX XX XX	-XXXXXXX	NOT ON 0005 CLOCK
3 THEN	FFFF 0101	XX XX XX	-XXXXXX XX	OCCURS 0030 TIMES
E10				

Trigger sequence setting

Since only the keys required for the current mode are screenlabelled, wrong settings are virtually eliminated.

Parallel to the selective softkey operating menu, a **monitor menu** yields information on the overall instrument setup. In this way the settings performed can be permanently checked.

Setup memory

To define the measurement task to be solved, the large number of input channels and trigger levels may sometimes require the entry of large amounts of data. For this purpose, the battery-supported setup memory of the IMAS is an essential aid enabling complex instrument setups to be rapidly changed and retained even with the IMAS switched off.

LOGIC ANALYZERS 11

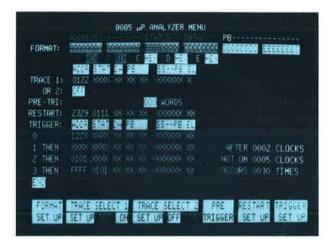
Basic modes

The IMAS combines the functions of five different instruments and operates in the following basic modes as a

microprocessor analyzer 48-channel logic analyzer serial data analyzer and generator frequency counter and timer signature analyzer

Microprocessor analyzer

The IMAS can be used for analyzing both 8-bit and 16-bit microprocessors. With a memory depth of 250 words, the maximum clock frequency is 12.5 MHz so that even the latest-state-of-the-art microprocessors with high clock frequencies can be tested. When analyzing 8-bit microprocessors, 16 additional channels are available.



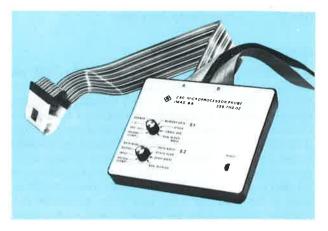
Basic menu for microprocessor analysis

Adaptation

The Logic State Analyzer IMAS is <u>adapted</u> to the microprocessor with the aid of the microprocessor probe (see photo, righthand column, top) which is connected to the module under test via a clip. A data probe with 16 data inputs and exchangeable probe adapter is available for the 16 analyzer channels. It is easy to test different types of microprocessor: merely the dedicated microprocessor probe and a plug-in ROM accomodating the disassembly program need to be changed.

Selective read-in of program functions

When reading in the data to be analyzed, data reduction by preselection is an efficient aid for simplifying the measurement task and rapidly localizing program functions of interest. For this purpose, the IMAS is fitted with trace selector switches which, depending on the microprocessor type under test, permit the selective read-in of program instructions, storage commands, I/O data, stack operations, program branches, etc. Moreover, the data can be reduces further by qualification with addresses and analyzer channels. Input selection is possible at two ORed levels. In this way, a variety of combinations can be used allowing for ample specification of the selection criteria.



Microprocessor Probe IMAS-B6 with selector switches

Triggering

The IMAS has 16 trigger levels so that even program sections nested in several subroutines can be traced. A restart condition causes incorrect trigger sequences to be terminated. Moreover, it is possible to select or suppress trigger events using the selector switches on the microprocessor probe. The analyzer channels can also be used for defining the trigger conditions.

Display of program flow

The collected data can be displayed both as logic states and as assembly instructions (see photo below).

The logic state can be displayed in hexadecimal, octal, decimal, binary or ASCII format. When displaying assembler instructions, the addresses are hexadecimal whereas the data and analyzer-channel coding can be freely selected. A search word function as well as numerous cursor positions facilitate the localization of data within the memory. The complete memory contents of the instrument are identified by three signature numbers so that the equality or nonequality of data can be recognized at a glance.

Selective assembler display of program branches

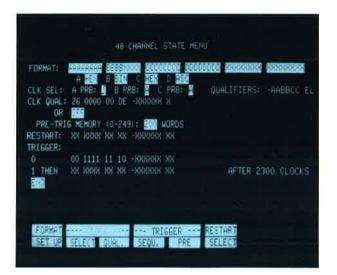
HAIN	TRIG	OSEC	312	-F3H			
пнал	INTE	02ED		- Olevano			
LOC: INTE		02F0	UMP	02E7H			
		02F1					
SI6: 069E		02F2					
885A		03EC	JP	F3H			
100F		02E0					
		025.0	JHP	02E7H			
		02F1					
		02F2					
		02EC	JP.	F3H			
		02ED					
		02F0	JMP	02E7H			
		02F1					
		0.26 2					
		02EC	JP	F3H			
MEMORY	EARCH			OCATION		DIFFER	NODE
MN	HODE	TOTO	T	P FND	0-255	OFF	ON

11 LOGIC ANALYZERS

IMAS - Logic State Analyzer

48-channel logic analyzer

In this mode, all the 48 data channels of the IMAS are available for universal logic analysis. The channels can be subdivided into six groups with freely selectable length and coding. Adaptation is performed via three data probes each provided with 16 data channels, two qualifier inputs and one clock input. Thus altogether three clock inputs are available for the analysis of multiphase clock systems. Whereas one of the clock inputs is used as the master clock for transferring all the data to the memory, the two remaining clock inputs are taken to the latch where the data of the associated data channels are stored until the master clock signal appears.



Basic menu of 48-channel logic analyzer

Triggering

There are 16 trigger levels, each with a 48-bit data word, seven qualifier inputs and one link input. In addition, one of five delay conditions can be defined for each trigger level. A restart word enables the trigger sequence to be started anew.

State display

The data collected by the IMAS on the 48 data channels can be displayed in the same format (binary, hexadecimal, octal or ASCII) or in mixed format with a maximum of six groups corresponding to those previously selected for the input channels. The search word and the cursor positioning function are available just as with microprocessor analysis.

Reference memory

The IMAS contains a reference memory of the same size as the main memory. For comparing the two memories, a difference function is available. In the hold mode an automatic comparison is performed, the IMAS reading in new data until a difference between the main and the reference memory causes it to stop.

	-015	02E7 1111				
	+01310	02F1 0050 02F7 0600				
		0280 111			0	
		02EF 1111	FO FF	FF		
		02ER 000				
		02E0 111 02E0 111				
		20FE 000				
1005		02EA 111				
75.98		0289-000	0 20 FF	FF		
SIG: 7448		0268 000				
CO : 🌌		02F2 000 02F7 111				
CE00		02F1 000				
MAIN	TRIG	02F0 111				

Logic state display

System operation

The LINK connector of the IMAS permits the instrument to be combined with the Logic Analyzer IMAT via a coaxial cable. In the link mode, master-slave synchronization is possible, the IMAS driving a logic timing analyzer, i.e. the IMAT; for more information see page 300.

Combined timing and state analysis offers decisive advantages in the performance of measurements:

- Considerably simplified timing analysis since triggering of the timing analysis is performed in the state domain (e.g. at μP program steps). The analysis of a μP program step with triggering in the time domain is often difficult or impossible.
- Safe location of timing errors in functional and program flows. Triggering is performed in the time domain to determine timing errors whereas state-domain analysis records the function at the moment of the timing error.

Serial data analyzer and generator

When using the optional Serial Interface Probe IMAS-B2, the IMAS is suitable for analyzing serial data interface systems to standard RS 232. The IMAS then functions both as a data analyzer and a data generator. It is thus able to test all the functions of this interface and the current-loop interface in both directions. Selector switches on the IMAS-B2 option permit all the important parameters, such as the baud rate (50 to 19,200), parity and word length, to be set. The 48-channel analyzer function is used for **data evaluation**. With the ASCII format selected, the analyzed information can be displayed in plain text.

A separate generator menu capable of producing a total of 250 data words is used for **data generation**. Since the IMAS-B2 option uses only 16 analyzer channels, the remaining 32 channels are available for bit-parallel entry of data during the analysis. This enables the data transfer to be checked simultaneously at the bit-parallel end.

logic test equipment

LOGIC ANALYZERS 11

Frequency counter and timer

The optional Counter/Signature Analyzer IMAS-B1 permits

- the sequence of digital events to be measured in the frequency and the time domain,
- the frequency of data words to be determined (event counting) and
- the time spacing of equal and different digital events to be measured (time difference measurement).

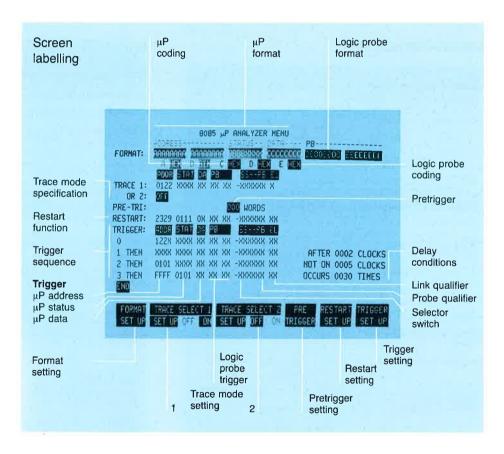
These characteristics are of special importance for microprocessor program analysis enabling the timing of programs to be checked. All the data and qualifier channels can be used for determining digital events so that a maximum of **56 bits per word** is available. The maximum clock frequency is 10 MHz.

The counter can also be used for **measuring analog events.** For this purpose, a test input is provided, handling signals up to 100 MHz.

Signature analyzer

The counter option of the IMAS includes the function of a signature analyzer which can be used up to the **limit frequency of 40 MHz.** The signatures can be displayed in the hexadecimal and the usual standard formats. They are identified on the screen by the appearance of the words STABLE or UNSTABLE.

The IMAS offers the advantage that the start and stop conditions can be defined by data words with a maximum length of 56 bits. Thus signature analysis is possible on programs under execution which do not feature any defined start/stop bit.



Combination with Logic Generator IGA

The combination IMAS/IGA yields a complete logic test assembly which, with its 32 generator and 48 analyzer channels, is a convenient tool for performance checking on digital subassemblies. In this test assembly, the IGA is the master controlling the read-in procedure of the IMAS. Since both instruments are IEC-bus-programmable, a fully automatic digital test system is obtained when adding the Process Controller PUC.

Programming

The Logic State Analyzer IMAS is fitted with an IEC-bus connector (24-pole Amphenol) via which all the functions of the instrument can be set and the analyzed data can be output. Additional system control commands permit the display to be modified. Thus the IMAS is ideal for use in automatic test systems.

11 LOGIC ANALYZERS

logic test equipment

IMAS - Basic operating modes

Mode	Sampling or measurement rate	Additional analyzer channels	Trigger levels	Data captured via
Microprocessor analyzer	12.5 MHz	16 for 8-bit-μP 0 for 16-bit-μP	16	1 μP probe +1 data probe 1 μP probe
48-channel logic analyzer	12.5 MHz	48	16	3 data probes
Serial data analyzer and generator	baud rate: 50 to 19,200	32	16	serial interface probe at RS-232-C interface +2 data probes
Frequency counter/timer	10 MHz 100 MHz ext.	—	1999-19	data probes for logic signals; oscilloscope probe for analog signals
Signature analyzer	12.5 MHz			data probes for data, qualifiers and clock; oscilloscope probe

Additional technical data

Basic operating mode:	
Microprocessor analyzer	
Data collection/connector	
	1 microprocessor probe (dedicated, see options), 1*) Data Probe IMAS-Z1
Number of additional	(see 48-channel logic analyzer)
analyzer channels	16*) 2 on data probe*),
	1 on rear panel
Trigger qualifier inputs	2 on data probe"),
Clock frequency	max. 12.5 MHz
Selective read-in	
(depending on μP)	program branches,
	I/O data, memory data,
	stack operations,
	undefined program instructions, additional qualification by
	addresses, data and analyzer
Cimultane quality offersting	channels
Simultaneously effective selection levels	2 (ORed)
Selective suppression	same as selective
	read-in, however,
	without additional qualification by addresses and data
Number of trigger levels	16
Selective triggering	same as selective
	read-in, however, independent of read-in mode
Time, time-difference measure-	
ment and event counting of µP functions	using option MAC D1
Further characteristics corresponding	
i uniter characteristics corresponding	g to totonalitier logic analyzer
Microprocessor program display	
State display	see 48-channel logic analyzer
Coding: addresses	
Disassembled display	
Display of program flows in assemble processor type	r language depending on micro-
*) With 8-bit μPs only.	insuits (opp he coloring on prohe coop

**) 20-µA mode for high-impedance circuits (can be selected on probe case for data and qualifier inputs).

Basic operating mode: 48-channel logic analyze	r
Data collection/connector	via 3 Data Probes IMAS-Z1
Number of data channels	48
Data Probe IMAS-Z1 Number of inputs Input Impedance or current Setting range of trigger threshold Edge Max. input voltage Min. input voltage Clock algnal Number of clock inputs Clock frequency Minimum pulse width Number of clock qualifier words Word width Setup time for Input data Hold time	2 qualifier inputs, 1 clock input 44 kΩ 15 pF or 20 μA**) ±6 V at 44 kΩ or ±3 V at 20 μA**) switch-selected on IMAS-Z1 ±20 V at 44 kΩ or ±10 V at 20 μA**) 0.5 V _{pp} 3 DC to 12.5 MHz 20 ns 2 (ORed) 55 bits 20 ns
Clock output	
Memory depth	
Main memory	
Trigger Pretrigger Number of trigger levels Trigger word width Trigger qualifier inputs	16 48 bits 6 on data probes, 2 op rear papel
Trigger logic	triggering on equality
Trigger delay Delay modes	0 to 9,999 clocks or events
Comparison trigger	displayed if main memory not equal to reference memory 48-bit data word,
Trigger state	displayed

LOGIC ANALYZERS 11

and the second		
Basic operating mode: Serial data analyzer and	l conorator	Control Inputs
Data collection/connector		Setup time Hold time Max. input level
	IMAS-B2, interfaces (switch-selected): a) RS 232 C, b) 20 mA (current loop); connector: 25-pole Cannon,	Start and stop words Clock frequency Minimum pulse width Edge
Serial data analysis	male and female	Display
Baud rate	 50 to 19,200; external clock selectable 5 to 8 bits, selectable 	On IMAS
Stop character Parity check for Memory depth Display format	 to 2 bits, switch-selected even/odd, switch-selected 250 words 	Output for external display un Connector Output EMF Impedance
Serial data generation Data entry format Modes	. hexadecimal or octal . single-shot or recurrent	Programming
For further data see serial data and		System
		Interface functions
Basic operating mode: Frequency counter and	timer (Option IMAS-B1)	
Modes	period measurement, time-interval measurement,	General data
Signal collection	event counting a) logic signals: via analyzer probes and internal word recognizer	Rated temperature range Power supply
	 b) analog signals: via oscilloscope probe (10×/1×) 	Dimensions (W \times H \times D), we
Analog signals Connector	BNC female on rear panel, impedance 1 MΩ 30 pF	
Setting of switching threshold Probe (1×) Probe (10×)	~2.56 to +2.54 V, resolution 20 mV	Ordering information
	-25.6 to +25.4 V, resolution 200 mV	Order designation
Signal measurement Logic signals Max. clock frequency for		Accessories supplied 3 Data Probes, 16 bits
data words Word width Analog signals		3 Probe Adapters, 16 bits Power cord, carrying case
Frequency measurement	10 MHz without prescaler	Options Counter/Signature Analyzer Serial Interface Probe
Gate time Period measurement	25 MHz with prescaler	8080 Microprocessor Probe 8085 Microprocessor Probe 8086 Microprocessor Probe
Measurement range Time-interval measurement Measurement range Resolution	0.2 µs to 10 s	Z80 Microprocessor Probe 6800 Microprocessor Probe 6809e Microprocessor Probe
Event counting Max. count Measuring error .	99.999.999 events	8088 Microprocessor Probe
		Set of mini-clips (20) Test Generator IMAT/IMAS Extension Board IMAT/IMAS (for servicing)
Basic operating mode: Signature analyzer (Opti	on IMAS-B1)	Recommended system Inst Logic Analyzer IMAT Logic Generator IGA (32 cha
Algorithm Display	16-bit standard	Process Controller PUC + Keyboard
Probability of	hexadecimal format	
correct signature	1 clock cycle	
Test Input	oscilloscope probe $(10 \times /1 \times)$,	
Impedance	1 MΩ 30 pF 15 ns with 0.2 V overdrive	
Hold time		

analyzer data, qualifier and clock 20 ns 0 ns ±20 V 1 to 56 bits 0 (DC) to 12.5 MHz 20 ns switch-selected

On IMAS	CRT,
	23 cm diagonal
Output for external display unit	composite video signal
Connector	BNC female
Output EMF	1 V _{op}
Impedance	

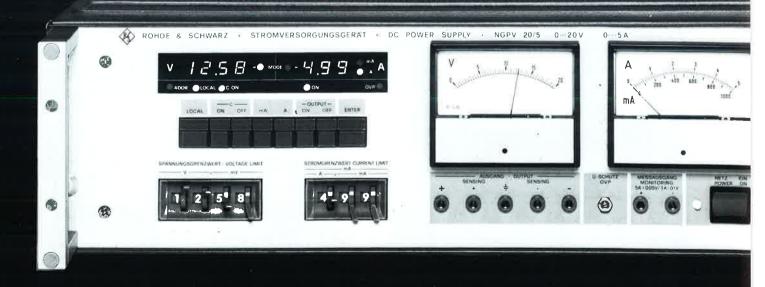
System	interface to IEC 625-1 and IEEE 488.							
	24-pole connector (Amphene							
Interface functions	L4	listener						
		talker						
	RL1	remote/local						
	DC1	device clear						

Rated temperature range	+5 to +45°C
Power supply	100/120/220/240 V ±10%,
	47 to 63 Hz (155 VA)
Dimensions ($W \times H \times D$), weight	470 mm × 198 mm × 484 mm,
	18.5 kg

on

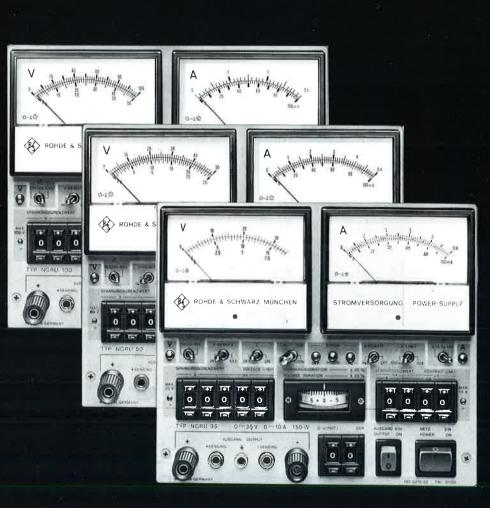
Order designation Logic State Analyzer IMAS 345.5510.02
Accessories supplied
3 Data Probes, 16 bits
Options
Counter/Signature Analyzer IMAS-B1 345.7613.02 Serial Interface Probe IMAS-B2 356.6213.02 8080 Microprocessor Probe IMAS-B3 356.6413.02 8085 Microprocessor Probe IMAS-B4 356.6613.02 8086 Microprocessor Probe IMAS-B4 356.6813.02 8086 Microprocessor Probe IMAS-B5 356.6813.02 8080 Microprocessor Probe IMAS-B6 356.7110.02 6800 Microprocessor Probe IMAS-B7 356.7310.02 6809 Microprocessor Probe IMAS-B8 356.7510.02 8088 Microprocessor Probe IMAS-B8 356.7510.02 8088 Microprocessor Probe IMAS-B8 356.7610.02
Recommended extras
Set of mini-clips (20) IGA-Z8 344.1905.00 Test Generator IMAT/IMAS IMAT-Z7 345.7413.02 Extension Board IMAT/IMAS IMAS-Z7
Recommended system Instruments
Logic Analyzer IMAT

Power Supplies of Type Series NGRU (right) and programmable DC Power Supply NGPV



power supplies





15 0160

12 OVERVIEW

power supplies

Power supplies

The wide Rohde & Schwarz line of power supplies, covering several hundred different models, comprises the following **main groups:**

- a) Bench models with output powers up to 350 W nine type series with a total of 26 basic models
- b) 19" models with output powers up to 2000 W two type series with a total of 29 basic models
- c) Programmable power supplies (IEC 625-1/IEEE 488)
 two type series with a total of 20 basic models

Beyond these, a **programmable voltage source** for IECbus systems is available. It has two independent outputs and its output voltages can be programmed manually or by a controller.

This product line is being continuously expanded and adapted to the state of the art (please specify requirements not covered by the program listed).

The table below includes the **complete line** from which the appropriate type can be selected to meet the maximum voltage and current requirements.

The power supplies of group a) appear in the blue section. For more details on this group see the table on page 324 where the different types are listed in alphabetical order.

The power supplies of group b) are listed in the white section. For details see page 327.

The power supplies of group c) and the programmable voltage source are described in full on their own pages.

Common features

If higher currents or voltages are required, all power supplies can be parallel- or series-connected. Protecting diodes ensure that no hazards are created by such connections.

Most of the models feature overvoltage protection to counteract accidental voltage surges (e.g. in case of maloperation). For exceptions see tables and specifications.

Complete line of power supplies

Blue section: group a), bench models up to 350 W; for specifications see page 324.

White section: groups b) and c), high-output power supplies up to 2000 W and programmable 19" power supplies; for specifications see from page 328 onwards.

Maximum		Maximum settable voltage in V															
current A	6	7,5	8	10	15	16	20	25	30	32	35	40	50	70	100	280	300
0.1																NGM	
0.2																NGK	-
0.3												6. E. B.					NGPV
0.4																	
0.5														NGM			
0.6											NGL/T						NGPV
0.8								NGT									
1							NGT				NGM/D			NGK	NGPV		
2					NGM					_	NGK			NGA	NGPV		
3								=				NGPV			NGRU		
4		NGM			NGK						NGA						
5	NGT						NGPV			NGAS		NGPV	NGRU	NGB	NGRE		
8					NGA												
10			NGPV			NGAS	NGPV		NGRE	NGB/AS	NGRU		NGRE	NGPU	NGRE		
15		NGA							NGRE				NGRE	NGC	NGRE		
20				NGRE	NGRE-				NGRE				NGRE	NGPU	NGRE		
30	NGRE			NGRE	NGRE				NGRE		NGC		NGRE				-
40	NGRE			NGRE	NGRE				NGRE				NGRE				
60	NGRE			NGRE	NGRE			1	NGRE								
80	NGRE																

power supplies

OVERVIEW 12

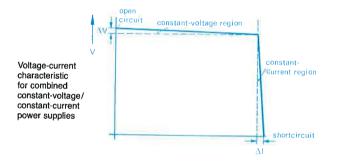
General features and definitions

All power supplies of the R&S line are electrically designed to offer **essentially the same qualitative features:** floating outputs, permissible test voltage of the outputs to chassis or ground – or with dual or triple power supplies to one another – 1000 V.

Operating temperature range -10 to +40 °C (NGPV: +50 °C). Panel engravings German and English. Power cable is supplied.

All models comply with VDE 0411, safety class 1, and are designed for operation from 220/110 V AC. Units of type series NGRE and NGC are supplied for voltages differing from 220 V on request only, but without increase in price.

Setting of voltage and current starts from a threshold near zero. The rated values of voltage and current are the maximum settable levels. Almost all types of this line are constant-voltage/constant-current power supplies, meaning that they can be used as current regulators.

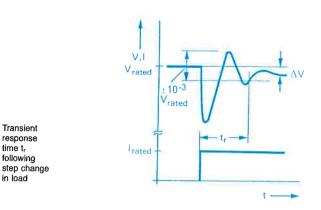


The series NGA and NGAS and the triple supplies NGT and NGL incorporate current limiting which can be continuously adjusted to any value between zero and the rated current. In the NGAS series current limiting can be adjusted to 1,5 times rating (see page 325).

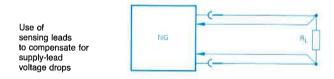
Mode indication. Pilot lamps or LEDs indicate whether the unit is operating in the constant-voltage/constant-current mode or whether current limiting takes place.

Internal impedance is specified in the table to describe the effect of load variations on the output quantiy. For example, with constant-current operation of a 100 V/1 A unit, the specified internal impedance of 30 k Ω implies that a load variation from 0 to 100 Ω at a nominal current of 1 A causes a current deviation of 3 mA or 0.3%.

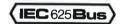
Transient response time t_r. The value specified refers to a sudden change from open circuit to full loading with constant-voltage operation. After t_r the output voltage is again within tolerance. In constant-current operation t_r strongly depends on the load (<100 μ s to 1 s).



Lead-resistance compensation (remote sensing). With the models of >70 W output power, the voltage drop which varies with the load current on the lead can be corrected, if separate sensor leads are connected to the terminals of the load. A variation of 0.5 V (1 V with NGPV) on the plus and minus leads can be compensated for.



Remote control. The NGRE power supplies can be equipped for remote control on request. The NGRU units can be remote-controlled through external analog voltages. NGRE page 328, NGRU page 326.



Programming. The power supplies NGPS, NGPV and NGPU are suitable both for manual operation and for control via the IEC bus, i.e. for integration in automatic test assemblies; for details see page 330 ff.

Cooling. The supplies cannot be damaged by thermal overloading. The models of the NGM, NGK, NGMD, NGT, NGL, NGRU and NGPS series have rear-mounted convectional heatsinks. In the units with higher output power rating, a two-stage thermostat-controlled cooling fan is used. At low demands the fan is scarcely noticeable; only when high output is required is it switched fully on. The fans are driven by quiet, maintenance-free motors.

Overvoltage protection. To provide protection against undesirably high voltages caused by misuse or faults, the power supplies are fitted with independent crow-bar circuits with an adjustable operating thresthold (for exceptions see table). An external overvoltage protection unit is availabe: ► NG-Z4, 5 to 100 V/10 A Order No. 100.5103.02

12 BENCH MODELS UP TO 350 W

power supplies

Power supplies for up to about 350 W \cdot compact bench models

3

Units for higher power (up to about 2000 W) on page 328

1

NGM



NGA, NGAS

2



NGK

7

1111 NGRU

4



NGB

5





-----0.0 0.0 0.0

NGT

8

Туре		Pho- to No.	► Order No.	Voltage range	Current range	Resolu	ution	ΔV (A	С	output wit		Int. imper ance	tr d- for	Max. ripple rms	Remote sensing/ overvolt-	Dimen- sions (W/H/D),
		140.				v	1	supply ±10%		$\Delta T_{amb} - to +40^{\circ}$		for V	I V	V I	age pro- tection	weight
				v	A	%	%	V %	۱ %	∨ %/°C	1 %	mΩ	kΩ µs	mV mA	S/O	mm/kg
Single	Pou		upplies							01		_				
NGA 7			192.0010.02	0.01 to 7.5	0.2 to 15	0.02	1	0.01	0.2	0.01	0.1	0.2	- 75	0.15 —	s —	129×172
	15 35		192.0010.03 192.0010.04	0.01 to 15 0.01 to 35	0.1 to 8 0.05 to 4	0.02	1	0.01 0.01	0.2	0.01	0.1	0.3 0.5	- 75 - 75	0.15 — 0.15 —	s — s —	×330/8
	70		192.0010.05	0.01 to 70	0.025 to 2	0.02	i i	0.01	0.2	0.01	0,1	1	— 75	0,15 —	S	
NGAS		2	289.8514.02	0.01 to 16	0.1 to 10 (15)	0.02	1	0.01	0.2	0.01 0.01	0.1	0.5 0.5	— 75 — 75	0.2 — 0.2 —	s — s —	129×172 ×330/8
32/	32 10		289 8520 02 192.0803 04	0.01 to 32 0.01 to 32	0.1 to 5 (7.5) 0.1 to 10 (15)	0.02 0.02	1	0.01 0.01	0.2 0.2	0.01	0.1	0.5	75 75	0.2 -	s —	× 33070
NGB		4	117.7210.90	0.01 to 32	0.02 to 10	0.02	0.02	0.001			0.01	0.2	15 50	0.2 1.5	S O S O	190×172
	70		117.7227.90	0.01 to 70	0.01 to 5	0.02	0.02	0.001	0,001	0.01	0.01	0.4	30 50	0.5 1.5		×330/10
NGK	15 35	3	192.0003.02 192.0003.03	0.01 to 15 0.01 to 35	0.01 to 4 0.01 to 2	0.02	0.02	0.001	0.001		0.01	0.5 1	30 50 100 50	0.2 0.1 0.2 0.02	S O S O	190×172 ×278/8
	70 80		192.0003.04 192.0003.05	0.01 to 70 0.01 to 280	0.01 to 1 0.002 to 0:2	0.01	0.02		0.001		0.01	5 50	500 50 500 50	0.2 0.01 2 0.002	s o s —	
		-		0.01 to 7.5	0.01 to 4	0.02	0.02		0.001		0.01	0.5	15 50	0.2 0.1	_ o	95×172
	15	1	117.7110.12 117.7110.13	0.01 to 15	0.01 to 2	0.02	0.02	0.001	0.001	0.01	0.01	1 2	60 50 250 50	02 005	- 0 - 0	×278/4
	35 70		117.7110.14 117.7110.15	0.01 to 35 0.01 to 70	0.01 to 1 0.01 to 0.5	0.02 0.01	0.02 0.02		0.001 0.001	0.01	0.01 0.01	10	50	0.5 0.005	— ŏ	
2	80		117 7110.06	0.01 to 280	0.002 to 0.1	0.01	0.02	0.001	0.001	0.01	0.01	100	50	2 0.001		
NGRU	35 50	4	192.0210.03 192.0210.05	0.01 to 35 0.01 to 50	to 10 to 5	see	specific	ations p	ade 327	,					S O S O	190×180 ×330/9
	00		192.0210.08	0.01 to 100	to 3]		anono p							S O	
Dual F	owe	r Suj	oplies				1				9			1		
NGMD	35	6	117.7127.02	0.01 to 35 (2×)	0.01 to 1	0.02	0.02	0.001	0.001	0.01	0.01	2	250 50	0.2 0.01	- 0	190×172 ×278/8
Triple	Pow	er Si	Ipplies	U)												ALL OF O
NGL			192.0026.02	0.01 to 35 (3×)	0.01 to 0.6	cont.	1	0.01	0,2	0.1	0.1	10	- 75	0.1 —		190×172
																×278/7
NGT	20	8	117.7133.02	0.01 to 20 (2× 0.01 to 6 (1×)		0.02	1	0.01	0.2	0.01	0,1	2	— 75 —	0.1 —	- <u>-</u>	190×172 ×278/7
NGT	25	8	192.0503.02	0.01 to 25 (2×		0.02	1	0.01	0.2	0.01	0.1	2	- 75	0.1 —		190×172
11011	23	o	192 0003.02	0.01 to 6 (1×)		0.02		0.01	0.2	5.01		Ĩ	-		0	×278/7
NGT	35	8	191.2019.02	0.01 to 35 (2×)		0.02	1	0.01	0.2	0.01	0.1	2	— 75	0,1 —		190×172 ×278/7
				0,01 to 6 (1×)	0.01 to 5							1	-			×2/6//

power supplies

BENCH MODELS UP TO 350 W 12

Special features

Single power supplies

in order of increasing power; NGRU series on page 326

NGM, NGK – 35/70-W laboratory models

- High-resolution ten-turn potentiometers for V and I
- Single switched meter on NGM-series separate meters on NGK-series models

The supplies of the **NGM series** can be used either as constant-voltage or as constant-current source. The mode of operation at any time is indicated by a pair of light-emitting diodes. These power supplies are precision instruments whose excellent performance will be appreciated in many applications, especially in the laboratory.

The supplies of the **NGK series** provdie twice the output current of the corresponding members of the NGM series. For this reason they feature remote-sensing sockets to permit compensation of the voltage drop in the leads connecting the supply to the load.

NGA - compact 120-W models

- High-resolution ten-turn potentiometers for V and I
- Separate meters, remote-sensing sockets

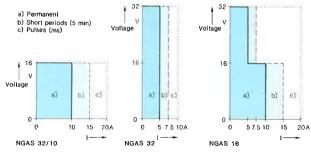
The supplies of the **NGA series** are for use as constantvoltage sources; they incorporate fixed-value current limiting at a level set by a front-panel potentiometer. The onset of current limiting is indicated by a light-emitting diode. These units are particularly suited for supplying assemblies and subassemblies during testing or development.

NGAS – compact 160-W models, high surge capability

- High surge capability twice the rated current can be supplied for short periods
- Use as battery eliminators

The supplies of the **NGAS** type are suitable both for general use in laboratories and for use with loads characterized by high-surge or pulse-type current demands, such as in automobile electronic test systems or for transceivers powered by converters.

The current characteristics are shown below. The current limiting threshold can be set to 1.5 times the rated current. This limit current may be drawn for up to 5 minutes. With delayed current limiting, twice the rated current may be drawn for several milliseconds.



Current drain of NGAS as a function of output voltage

Thanks to their compact design the NGAS power supplies are suitable for mobile use. They can supply 160 W/240 W for up to 5 minutes. They are also insensitive to RF voltages radiated by other equipment or a nearby antenna.

NGB - 350-W bench models

- High-resolution ten-turn potentiometers for V and I
- Surge-current capability several times rated current may be drawn for short periods

Constant-voltage as well as constant-current sources with automatic transition form voltage to current regulation (indication by LEDs). Use as battery eliminator with switchselected delay for current regulation (higher surge current), e.g. for incandescent lamps, blinkers, voltage converters. Additional features: large panel meters for voltage and current, voltage compensation on feeders up to 1 V, adjustable obervoltage protection.

Dual power supplies

NGMD 35 - 2×0 to 35 V/1 A

- Independent or tracking operation
- Mutually isolated floating outputs, permanent-shortcircuit proof

Two instruments of the type NGM 35 are accommodated in a single cabinet and can be used separately or in tracking operation, switch-selected on the front panel. With tracking operation, unit II follows unit I; the NGMD supplies, with respect to a common reference point, a positive and a negative voltage each of 0 to 35 V that are equal in quality and can be proportionally varied together (adjustable with helical potentiometer on unit I). The current limits can be adjusted independently of each other.

Triple power supplies

NGL 35 - 3×0 to 35 V/0.6 A

- Three voltages at the same time; series or parallel mode possible
- Thermal overload protection with automatic cut-in

The **NGL 35** has three separate identical and floating outputs which are independently adjustable between 0 and 35 V; the current-limiting threshold can be set from 0 to 0.6 A. Tripling of the voltage or current limit value is possible by parallel or series connection.

NGT 20 – 2 \times 0 to 20 V/1 A;	1×0 to 6 V/5 A
NGT $25 - 2 \times 0$ to $25 \text{ V}/0.8 \text{ A}$;	1×0 to 6 V/5 A
NGT $35 - 2 \times 0$ to $35 \text{ V}/0.6 \text{ A}$;	1×0 to 6 V/5 A

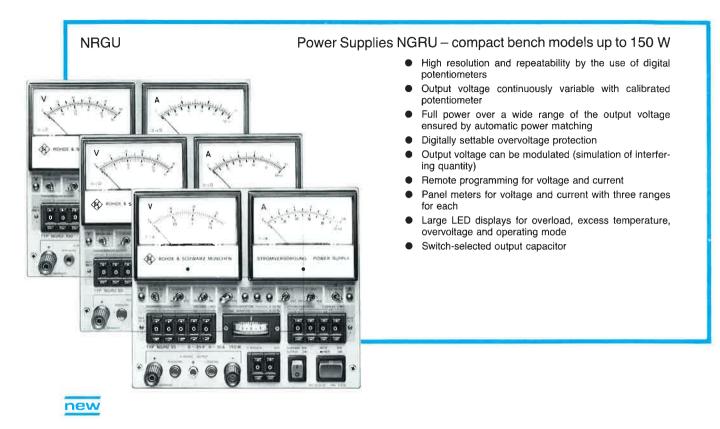
- Independent or tracking operation of 20/25/35-V supplies
- Permanent-shortcircuit proof, adjustable overvoltage protection of 6-V supply

The **NGT** combine three independent constantvoltage sources in a single instrument. Each output can be monitored on an individual panel meter (switchable for either voltage or current) and the onset of current limiting is shown by three separate light-emitting diodes.

The **20 V/25 V/35 V supplies** are intended primarily for use with **linear integrated circuits**. They can be used independently, or connected in series or in parallel. A front-panel switch also permits these two outputs to be operated in the tracking mode.

The separate **6-V supply** has a high output-current capability of 5 A making it particularly suitable for powering digital integrated circuits. The built-in overvoltage protection has a continuously adjustable threshold.

12 BENCH MODELS



Power Supplies of the **NGRU** Series are precision laboratory units providing high accuracy of setting and repeatability of voltage and current through digital potentiometers.

Three models are available:

NGRU	35 0	to	35	V/0	to	10 A
NGRU	50 0	to	50	V/0	to	5 A
NGRU	100 0	to	100	V/0	to	3 A

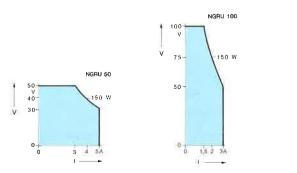
Operation of the NGRU Series is versatile and practical. The voltage can be set in five digits and continuously varied by $\pm 25\%$ of the digitally set value by means of a calibrated potentiometer. The current is set in four digits and has two ranges. The low ranges is 100 mA for all NGRU models. Currents even in the μ A range can thus be reliably regulated. The overvoltage protection is also adjustable through a digital potentiometer. In addition to the manual operation, remote programming of the voltage and current can be accomplished via analog control signals.

Constant-voltage or constant-current sources. The NGRU Power Supplies operate as constant-voltage or constant-current sources. The maximum output power consumption is 150 W and remains constant over a wide voltage range. The current drain depends on the output voltage; with a low output voltage, a higher current can be drawn.

Output capacitor. The output capacitor can be switchselected to match the load: small capacitor with little energy content for sensitive semiconductor circuits, large capacitor for dynamic loads.

Facilities. The NGRU Series is equipped with monitoring, signalling and indicating devices. LEDs indicate operating points incorrectly set beyond the constant-load characteristic, the response of the overvoltage protection, excessive temperature due to insufficient cooling and, of course, also the selected operating mode. An input for analog modulation signals (simulation of interfering quantities), remotesensing sockets and large meters are further beneficial features.

Versatile use. Due to compactness, high reliability and other outstanding features the units of the NGRU Series are ideal for use in development, research and testing.



V/I characteristics of Power Supplies NGRU 35 and NGRU 100

power supplies

BENCH MODELS 12

Specifications

Common specifications

Modulation of output voltage (BNC socket, floating)

Overvoltage protection Setting range

Power Supply Type	NGRU 35	NGRU 50	NGRU 100			
Order number	192.0210.03	192.0210.05	192.0210.08			
Voltage setting in 5 digits Resolution Error at 20 °C analog (continuous) Resolution	<1 mV to 35 V <1 mV to 50 V <1 mV to 100 V 1 mV ±10 ⁻⁴ of set value ±20 mV ±25% with ±0.5% setting error of scale 0.1%					
Current setting (2 ranges) in 4 digits High range Resolution Error at 20 °C Low range Resolution Error at 20 °C Max. constant current (150 W)	±2 × 10 up to 15 V: 10A	1 mA -3 of set value 10 μA to 100 m 10 μA -3 of set value up to 30 V:5 A 40 V:4 A	±10 mA A ±0.2 mA up to 50 V:3 A			

 $V_{pp} = 10 \text{ V}$ for 10% modulation, 50 Hz to 1 kHz

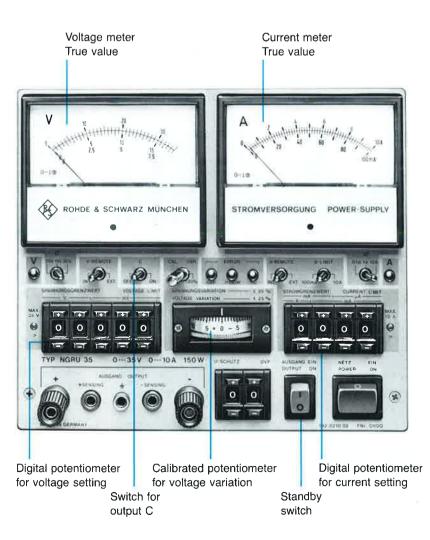
1 to 99 V (response threshold approx. 5% higher)

0 to 10 V 0 to 10 V <3 ms 5-way Tuchel socket $R_i = 10 k\Omega$ to positive terminal

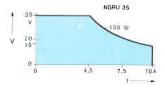
Power Supply Type	NGRU 35	NGRU 50	NGRU 100
Specifications for constant-voltage supply Deviation of output voltage with AC supply variations of ±10% with temp. var. from 0 to 45°C with load var. from 0 to 100% Superimposed noise voltage (V _{rms} Transient recovery time	<0.3 mV	<±10 ⁻⁵ <±10 ⁻⁵ /ŀ <10 ⁻⁴ <0.5 mV <40 μs	
Specif. for constant-current supply Deviation of output current with AC supply var. of ±10% with temp. var. from 0 to 45°C with load var. from 0 to 100% Superimposed noise current in high range (Irma)	<1 mA	<±10 ⁻⁵ <±10 ⁻⁴ // <10 ⁻⁴	< <0.1 mA
In low range (Imms) Remote-sensing sockets Max. voltage compensation	<0.5 V	<20 µA	<1.5 V

General data

Meter accuracy	±2.5% of full scale
	0 to 45°C
Safety class I	VDE 0411
Output terminals	
1	test voltage 1000 V/ground
Line voltage	110/127/220/242 V ±10%,
4	47 to 63 Hz
Power consumption	approx. 440 VA
Dimensions	190 mm×180 mm×330 mm
Weight	9 kg
Order designations	see above



V/I characteristic (below) and front panel (right) of Power Supply NGRU 35



12 19" POWER SUPPLIES UP TO 2000 W

power supplies

19" power supplies 1000 W with high efficiency

NGC series



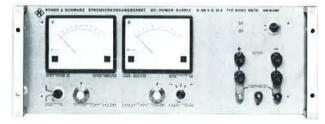
- High efficiency
- Surge-current capability several times rated current may be drawn for short periods

The high efficiency of the NGC units is achieved through the use of continuous preregulation. A subsequent series-pass regulator provides for excellent static and dynamic characteristics. Careful design allows easy integration into RF systems.

19" power supplies from about 200 to 2000 W Units for lower power on page 324

NGRE series

NGRE models A and B, code numbers 16 and 17



- Protection against sustained short circuit, thermal overload protection
- Series and parallel connection of several units possible

NGRE model C, code number 19



Specifications			
	NGC 35		NGC 70
Voltage			<10 mV to 70 V
Current			<25 mA to 15 A
Resolution	<0.02%		<0.02%
Voltage stability			
with AC supply variations			
of ±10%		<±10-5	
with temperature variations			
from 0 to 40 °C		<±10-4/K	
with load variations			
from 0 to 100%		<10-4	
with AC supply variations			
of ±10%		<±10-4	
with temperature variations		< <u>10</u> .	
from 0 to 40 °C		<±10-3/K	
with load variations		10 /10	
from 0 to 100%		<10-3	
Noise and ripple			
Voltage, rms	<1 mV		<2 mV
Current, rms	<20 mA		<20 mA
Transient response time		<50 µs	
Remote sensing		1 V max.	
Surge capability for 1 ms/0.2 s	80/60 A		50/20 A
General data			
Rated temperature range		-10 to +4	0°C
Meter accuracy		2.5% of fu	
AC supply		220 V ±10	%, 50 Hz,
		2.4 kVA	
		(other valu	
Discourse and the Discourse		please enq	
Dimensions (W×H×D)		484 mm×1	94 mm×
Weight		509 mm	
weight		40 kg	
Oudering information			
Ordering information			
Order designation	► 1000 V	V 19" Power	Supply
NGC 35	192.00		Cappij
NGC 35	192.00		

Voltage and current are set by means of high-resolution tenturn potentiometers and indicated on separate panel meters. The power supplies are fitted with remote-sensing sockets for output-lead voltage-drop compensation. A quiet cooling fan with two-stage thermostat-controlled operation is incorporated.

Adjustment of current ranges. NGRE models 16 and 17 with outputs up to 30 A can be equipped, on request, with current ranges switchable in decade steps, e.g. a 10-A supply can be switched to 0.1/1/10 A.

Transient response time t_r. The value given in the table on page 329 applies for operation at constant voltage at a load varying between no load and full load. With constant-current operation, t_r is between <100 μ s and 100 ms and load-dependent to a great extent.

Remote control. The following functions of the models 12, 13, 16, 17 can be modified for remote control: output voltage, output current and power switch "on/off/standby" as well as control of the power regulating element. Instruments of the type series NGRE, which are adapted to remote control, are suitable for

master/slave operation (parallel-connected). This mode of operation – control of the power output by only one of the employed instruments – is of great advantage, since, especially with higher powers, equal loading of all units is ensured.

Overvoltage protection. Each instrument of the type series NGRE is also available as a special model with built-in overvoltage protection.

Current surge capability. 2 to 3 times the rated current can be drawn briefly from the NGRE units. An external or internal (model code number 19) switch is provided for this purpose.

power supplies

19" POWER SUPPLIES UP TO 2000 W 12

The type series NGRE comprises power supplies with high output power (above approximately 200 W). Extreme versatility is won by the use of standard modules: most of the 27 basic types (see table below) come in 5 different models.

The basic types differ only in the maximum adjustable values of voltage and current and the internal impedance.

The available models of each basic type are equipped differently - meters, operating controls, connectors - and are designed as cabinet model or as rackmount.

The power supplies of series NGRE are designed for operation from 220 V. Other voltages are possible without an increase in price; please enquire.

Order designations. Because of the great variety of instruments, division into two groups - basic type and model variations - was necessary. A nine-figure number (combination from both tables) should always be stated when placing an order (last two digits marked blue; e.g. 50 V/20 A, model 17: order number 100.8231.17).

Dimensions

	Cabinet model	Rackmount mm	Seated depth mm
Model A	484×194×436	483×177×425	347
Model B	484×194×509	483×177×498	420
Model C	608×394×284		-

Front views

ModelsA and



code numbers 12 and 13



ĝ



code numbers 16 and 17

0 60 9 g.

Front panel for code number 19

ModelC

Voltage range	Current range	► Order No.	for∆V AC supply	n of output values for ∆t _{amb}	Interna impeda const. V		t, for V	Max. I and no V		Power consump- tion at 220 V/50 Hz	Case types (see above)	Weight incl. cabinet
V	А		±10% V,I(%)	(−10 to +40°C) V, I (%)	mΩ	(kΩ)	μs	μV	mA	kVA		kg
NGRE ser	ries											
0 to 6	0 to 30 0 to 40 0 to 60 0 to 80	100.8402 100.8419 100.8425 100.8431	±0.001 ±0.001 ±0.001 ±0.001	0.01 0.01 0.01 0.01	1 0.1 0.1 0.1	(1) (1) (1) (1)	<50 <50 <50 <50	300 300 300 300	9 12 18 24	09 09 09 18	A, C A, C A, C B, C	22 22 28 39
0 to 10	0 to 20 0 to 30 0 to 40 0 to 60	100.8354 100.8360 100.8377 100.8383	±0.001 ±0.001 ±0.001 ±0.001	0.01 0.01 0.01 0.01	1 1 0,1 0.1	(2) (2) (2) (1)	<50 <50 <50 <50	300 300 300 300	6 9 12 18	09 09 18 18	A, C A, C A, C A, C	19 28 28 37
0 to 15	0 to 20 0 to 30 0 to 40 0 to 60	100.8319 100.8325 100.8331 100.8348	±0.001 ±0.001 ±0.001 ±0.001	0.01 0.01 0.01 0.01	1 1 0.1 0.1	(2) (2) (2) (1)	<50 <50 <50 <50	300 300 300 300	6 9 12 18	09 18 18 25	B.C A.C A.C B.C	28 28 37 39
0 to 30	0 to 10 0 to 15 0 to 20 0 to 30 0 to 40 0 to 60	100.8254. 100 8260. 100.8277. 100.8283. 100.8290. 100.8460.	$\begin{array}{c} \pm 0.001 \\ \pm 0.001 \end{array}$	0.01 0.01 0.01 0.01 0.01 0.01	1 1 1 0.1 0.1	(5) (3) (2) (2) (2)	<50 <50 <50 <50 <50 <50 <50	300 300 300 300 300 300 300	3 4,5 6 9 12 18	0.9 0.9 1.8 1.8 2.5 3.5	A C C C A C C C B C C C C C C C C C C C	19 28 28 37 39 50
0 to 50	0 to 10 0 to 15 0 to 20 0 to 30 0 to 40	100.8219 100.8225 100.8231 100.8248 100.8454	± 0.001 ± 0.001 ± 0.001 ± 0.001 ± 0.001	0.01 0.01 0.01 0.01 0.01	1 1 1 0_1	(5) (5) (3) (2)	<50 <50 <50 <50 <50	300 300 300 300 300 300	3 4,5 6 9 12	0.9 1.4 1.8 2.5 3.5	A C A C A C B C C	28 28 37 39 50
0 to 100	0 to 5 0 to 10 0 to 15 0 to 20	100.8160 100.8183 100.8190 100.8448	± 0.001 ± 0.001 ± 0.001 ± 0.001	0.01 0.01 0.01 0.01	1	(10) (10) (5) (5)	<50 <50 <50 <50	500 500 500 500	1.5 3 4.5 6	0 9 1 8 2 5 3 5	A, C A, C A, C C	28 37 39 50

DC Power Supplies NGRE (additional characteristics and completion of Order Nos.)

 Code number of models (last two figures of Order No.)¹) 	Form of housing	Adjusti Precision pot. on front panel	ing V and I Screw-driver adjustment on rear panel	I range in three decades (up to 30 A) extra price	Four extra fixed voltages, pushbutton selected	Large V and I meters
13 17 12 16 19	19" cabinet ²) 19" rackmount ²) Alum, housing ³)	•	•	•	•	•

Against extra price (please enquire):

 a) master-slave operation
 b) external analog programming of voltage and current.

Model A or B, acc. to table above.
 Model C (waterproof, shock-absorbent aluminium housing).

power supplies



The **Programmable Voltage Source NGPS** has two independent channels (A and B) and its output voltages can be programmed manually or by a computer. The unrestricted combination of the two outputs provides for many **applications.**

Setting, resolution. The bipolar voltages can be set or programmed from -16.3835 V to +16.3835 V in the low range in 65,536 steps (2¹⁶, resolution 0.5 mV). Resolution in the high range is 2 mV/step with a maximum output voltage of ± 40 V (corresponding to a swing of 80 V).

Maximum permissible current drain is 100 mA. Any increase beyond this limit is signalled as malfunction of the analog section of channel A or B.

The six-digit display permits observation of programmed test sequences. In the programming mode (data acceptance) or listen only (LON) mode of the NGPS the address lamp is lit.

In the combined mode (manual and programmed) the digital voltage setting can be varied manually. The speed of variation depends on how long the plus or minus button is pressed.

Output-voltage range coding is possible by selecting the secondary device address or using the built-in microprocessor, and also by means of special characters.

With up to 31 settable instrument addresses, a listen-only switch and different assignable end-of-message characters for programming, the unit constitutes a general-purpose, flexible listener in IEC-bus systems.

By applying a status byte to the data line of the IEC-bus input through the parallel-poll or serial-poll function the NGPS can notify the selected operating mode or a fault, if any, to a computer.

The trigger facility permits rapid switching of preset voltages and thus defined timing of test sequences.

Automatic voltage sweep can be programmed such that upon a trigger command the output changes from a start to a stop value. Step size (n×count) and duration (n×700 μ s) can be preset. Triggering may be single, cyclic or with different step size/duration for forward and return sweep.

Remote-sensing sockets offer the possibility of keeping the voltage at the load or test item (or at the controlling equipment) constant even if high currents and long leads are involved.

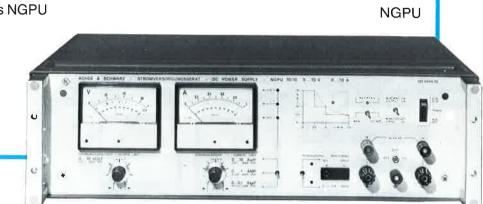
The talker capability of the NGPS enables continuous interrogation of the voltage inputs to channels A and B, functional checking of the analog section and notification of the selected trigger states.

Specifications	
Outputs	2 separate floating channels
	(A and B) in parallel with rear outputs
Output voitage per channel	
Low range	
High range	
Setting	pushbuttons; variation in steps or continuous within one range or pro-
	grammed
Resolution Low/High range	
Indication (with polarity sign)	·
	limiting threshold approx. 130 mA
Stability, ripple and noise	
Voltage deviation	
with AC supply variation ±10%	<10-5
with temperature variation	<5 x 10-6
Instability	<2 × 10 ⁻⁶ /hr (low),
Capacitive load	<4 × 10 ⁻⁶ /hr (high) ≤0.1 µF (80-V step)
Ripple and noise (rms) up to 3 kHz Nonlinearity (Low/High range)	<100 µV (low), <200 µV (high)
Response time	<700 µs (100 µs for smallest program step)
Remote-sensing sockets	compensation for 0.5 V max.
Programming	via IEC-bus (IEC 625-1/IEEE 488) for
	ranges and voltage, manual operation switch-selected
Connector	24-way, floating
Functions	. SH1, ÁH1, T2, TE2, L1, LE1, SR1, RLØ, PP1, CØ, DC1, DT1
Response time, programming	
Output ON/OFF	. 1 μs/>62μs
Data rate	
Programming time	, >100 μδ
General data	
Rated temperature range Power supply	+5 to +40°C 110/220 V +10%, 50 to 60 Hz
	(120 VA)
Dimensions, weight	492 mm×116 mm×392 mm, 6.2 kg
Ordering information	
Order designation	► Programmable Voltage
	Source NGPS 192.0061.02
Recommended extras	
IEC-bus Cable PCK	
Relay Matrix PSN	290.9210.02

Programmable Power Supplies NGPU

- IEC-bus programming and manual operation
- Three-digit programming of voltage and current (1000 steps), resolution: 10 to 100 mV, 10 to 20 mA
- Three decade current measurement ranges



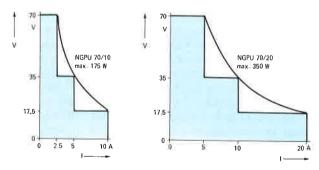


The **NGPU series of programmable power supplies** represents a valuable extension to the existing R&S range of IECbus-compatible test equipment. Two models are available, distinguished by their output powers:

NGPU 70/10: 175 W (70 V/max. 10 A), NGPU 70/20: 350 W (70 V/max. 20 A).

Both may be operated either as constant-voltage or as constant-current source and are suitable for programmed operation via the IEC bus or for manual use.

The maximum load current is a function of the output voltage; the full output power is available over approximately 80% of the output-voltage range. As the figure shows, the output characteristics are a combination of three individual curves: each NGPU combines the performance of three single power supplies.



Loading characteristics of programmable power supplies NGPU as function of output voltage

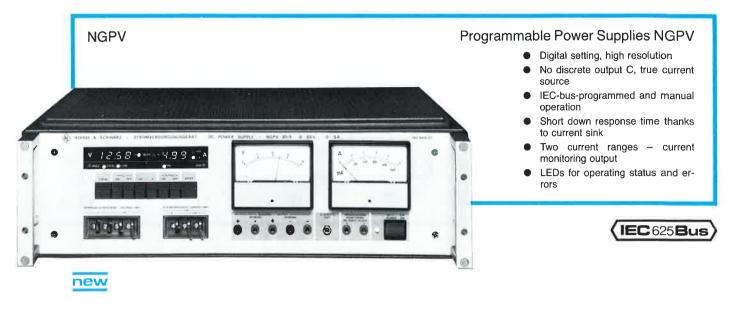
Since the current drain of many loads, such as a transceiver, falls with increasing supply voltage, this stepped loading characteristic of the power supplies is fully compatible with practical requirements.

In continuous operation the shaded area shown in the diagram can be fully utilized up to the limit-power line. An auxiliary scale on the panel voltmeter indicates the permissible continuous load current at each voltage setting. The unit can withstand brief, pulse-type currents which exceed the limit line. If, a set voltages above 15 V, a current greater than the limit value is accidentally drawn for an extended period, the temperature-monitor circuit within the power supply causes the instrument to be disconnected from the AC supply. The output voltage and/or current may be set via the IEC bus interface. The switchover between programmed and manual control is made on the front panel. The resolution of the voltage setting may be chosen to be fixed at 100 mV or to be variable between 10 and 100 mV.

The power supplies may be programmed from **any IEC-compatible control device.** The various input lines are electrically isolated from each other. By making use of the settable address it is possible to operate several NGPUs in parallel.

Specifications

Output	
Resolution Manual operation IEC bus	1000 steps/range; voltage adjustable
Voltage	10 to 100 mV/step <10 mV to 70 V
Current 3 ranges Stability with AC supply var. of ±10% with temp. var. from 0 to 40°C with load var. from 0 to 100%	<±10 ⁻⁵ <±10 ⁻⁴ /K +100 µV
Noise and ripple Voltage, rms Current, rms Transient response time	<2 mA
Remote sensing Programming	1 V max. IEC 625-1 (IEEE 488), 24 way
Test output for voltage for current Overvoltage protection Operating temperature range	100 mV for full scale adjustable from 4.5 to 75 V
General data AC supply Power consumption Dimensions (W×H×D) in mm Weight	600 VA 1250 VA 492×161×514 492×205×514
Ordering information	
Order designations	192.0049.92
Recommended extras IEC-bus Cable PCK 1 m or 2 m or 4 m	292.2013.20



The **NGPV Power Supplies** are suitable for both system applications and general laboratory use. Nine models graded by voltage and current are available in the power range up to 200 W.

NGPV 8/10:	0 to 8 V/0 to 10 A; 80 W,
NGPV 20/5:	0 to 20 V / 0 to 5 A; 100 W,
NGPV 20/10:	0 to 20 V / 0 to 10 A; 200 W,
NGPV 40/3:	0 to 40 V / 0 to 3 A; 120 W,
NGPV 40/5:	0 to 40 V / 0 to 5 A; 200 W,
NGPV 100/1:	0 to 100 V / 0 to 1 A; 100 W,
NGPV 100/2:	0 to 100 V / 0 to 2 A; 200 W,
NGPV 300/0.3:	0 to 300 V / 0 to 0.3 A; 90 W,
NGPV 300/0.6:	0 to 300 V / 0 to 0.6 A; 180 W.

The user has the choice of two versions. The one for system and laboratory use can be programmed via the IEC-bus (IEC 625-1 or IEEE 488) or operated manually. The units of this version have the required operating controls, a LED display for the indication of all input data (including that entered via the IEC bus) and meters for actual voltage and current. The pure system version – without operating controls – provides particularly cost-effective IEC-bus-programmable 19" units for rackmounting or for use on the bench.



Power Supply NGPV for system applications

System use. The system power supply is characterized by the short settling time of 2 ms (for the rise and, thanks to a controlled current sink, also for the fall). The NGPVs do not have a discrete output capacitance so they can regulate very small currents. Relay contacts will not be damaged by the switching of current paths. An appreciable output capacitance, however, is provided internally and can be connected manually or via the program as required.

Remote sensing. Remote sensing makes the NGPV particularly suitable for system applications. It is performed automatically, no sensing links are required. The compensation range is 1 V in each lead. When remote sensing is in operation the maximum output voltage of the power supply exceeds the nominal voltage by the amount of the voltage drop in the leads. The result is that with the NGPV 8/10, for example, the full value of 8 V is available at the load even if a voltage drop of up to 1 V exists in each lead. The maximum voltage increase occurring at the load due to an interruption of the sensing leads is 1 mV, which is negligible for practical purposes.

Current regulation. The special capability of the NGPV as a current regulator is afforded by two current ranges, which ensure a high resolution of 1 mA and 0.1 mA, respectively.

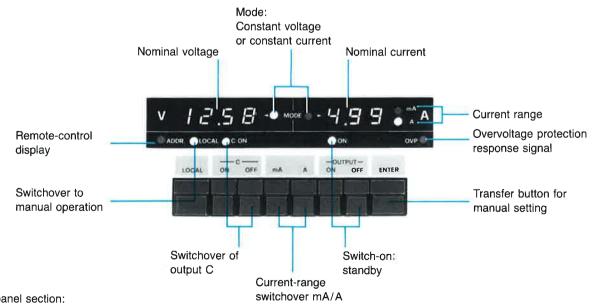
Laboratory and system use. The NGPV models equipped with meters and front-panel controls are also versatile laboratory power supplies. Output voltage and current can be read from large analog meters. LEDs indicate the operating mode and operating status. A digital display shows the values entered, also those programmed via the IEC bus. Parallel outputs and sockets for a current monitoring output (referred to the positive terminal) are located on the front and rear panels.

Cooling. The blowers are thermostat-regulated and run at low RPM in the partial-load region.

Specifications									
Power Supply Type	NGPV 8/10	NGPV 20/5	NGPV 20/10	NGPV 40/3	NGPV 40/5	NGPV 100/1	NGPV 100/2	NGPV 300/0.3	NGPV 300/0.
 Order designation System model¹) System and laboratory model²) 	192.0310.80 192.0310.81	192.0310.20 192.0310.21	192.0326.20 192.0326.21	192 0310.40 192.0310.41	192.0326.40 192.0326.41	192.0310.10 192.0310.11	192.0326.10 192.0326.11	192.0310.30 192.0310.31	192.0326.30 192.0326.31
Voltage setting Resolution (mV/steps) Deviation (of full scale)	0 to 7.99 V 10 mV/800 <10 ³	10 m	19.99 V V/2000 10 ⁻³	10 m	39.99 V V/4000 10 ⁻³	100 п	99.9 V 1V/1000 10 ⁻³	100 m	299.9 V V/3000 I0-3
Current setting (2 ranges) in A range Resolution (mA/steps) Deviation (of full scale) in mA range Resolution (1000 steps) Deviation (of full scale)	0 to 9.99 A 10 mA/1000 <10 ⁻³ 0 to 999 mA 1 mA <10 ⁻³	1	0 to 9.99 A 10 mA/1000 <10 ⁻³ 999 mA mA 10 ⁻³	1	0 to 4.99 A 10 mA/500 <2 × 10 ⁻³ 999 mA mA 10 ⁻³	0.1	0 to 1.99 A 10 mA/200 <4 × 10 ⁻³ 9.9 mA mA × 10 ⁻³	0.1	0 to 0.599 A 1 mA/600 <2 × 10 ⁻³ 9.9 mA mA < 10 ⁻³
PARD ³)	<200 μV	<2	50 μV	<4	00 μV	<5	00 μV	<7(00 μV
Output C (OFF/ON)	500 pF/220 μF	500 pF/100 μF	750 pF/220 μF	500 pF/47 μF	750 pF/100 µF	500 pF/22 μF	750 pF/47 µF	500 pF/10 μF	750 pF/22 µF
Overvoltage protection	4 to 15 V	4 to 25 V 4		4 to	4 to 50 V 5 to 110 V		5 to 330 V		

System model for IEC-bus programming (no operating controls and meters) in 19" cabinet.
 System and laboratory model for IEC-bus programmed and manual operation with meters for voltage and current.
 PARD = periodic and random deviation.

Common data Constant-voltage source Deviation of output voltage with AC supply variations of ±10% < ±10 ⁻⁵ with temperature variations	Current monitoring output, Z _{out} = 1 kΩ (referred to positive terminal) in mA range
from 0 to 45°C	General data
$ \begin{array}{llllllllllllllllllllllllllllllllllll$	Meter error ±2% of full scale Rated temperature range 0 to +50 °C Safety specifications comply with VDE 0411, class 1 EMI specifications comply with VDE 0871/6.78 level B 0utput terminals AC supply 110/127/220/242 V ±10%, 47 to 63 Hz
PARD rms	Order No. 192.0310 192.0326
in mA range	Power consumption ca. 250 VA ca. 500 VA Dimensions (W×H×D in mm) 492×161×392 492×161×420
Programming IEC 625-1 (IEEE 488) Connector 24-pin Functions SHØ, AH1, TØ, TEØ, L1, LEØ,	Weight
SR0, RL1, PP1, DC1, DT1, C0 Setting time 0 to 100%/100 to 0%	Order designations > see table above



Front-panel section: key row and LED display

▲ OTHER R&S FIELDS

Company divisions (special fields) of Rohde & Schwarz

As already mentioned in the outline of the company's history on page 2, the product- and user-related activities of Rohde & Schwarz are distributed amongst the company divisions

Measuring Instruments and Systems Division 1
 Sound and TV Broadcasting Division 2F

Radiocommunications

Division 4F

Radiomonitoring, Radiolocation

Division 4P

Whereas in the introduction to the catalog the activities of all four divisions are described, the catalog itself only deals with the measuring instruments and systems of **division 1**.

A few products of the **other divisions** are however described in detail on the following pages to give an example of the great variety of products, equipment and systems which on the whole are related to the "measuring instruments and systems.

OTHER SPECIAL FIELDS A

Appendix A1	Other special fields	Page
2F	Sound and TV Broadcasting	336 to 353
4F	Radiocommunications	354 to 355
4P	Radiomonitoring, Radiolocation	356 to 363

Appendix A2

Cabinets	364 to 369
Addresses	370 to 371
Type index	372 to 374
Notes on presentation	375 to 376
Reader service cards	

AF LEVEL METERS

SUN 2

AF Transmission Measuring Set SUN 2 ♦ 10 Hz to 100 kHz



- Measures levels, weighted and unweighted SNR and harmonic distortion
- Versatile thanks to choice of cassettes

The AF Transmission Measuring Set SUN 2 is used for inservice measurements on broadcasting and television-sound transmitters as well as for routine measurements on AF studio equipment and in laboratories. Thanks to the instrument's high accuracy, single-knob tuning over the entire frequency range on the AF Generator and autoranging for all modes on the Level Meter enable rapid, convenient and accurate measurements in AF engineering.

The AF Generator and the Level Meter can be used separately; combined they yield a test assembly (photo above) permitting weighted and unweighted SNR as well as harmonic distortion to be measured. In addition, the feature of being able to select a reference level enables level variations to be determined.

The AF Generator SUN 2/S is a precision AF generator with digital frequency setting; large LED digits ensure frequency and level indication. The SUN 2/S uses frequency synthesis and single-range tuning. The crystal-controlled frequency is displayed with a resolution of about 0.3%. The output voltage can be set in steps of 1 dB and continuously over about 3 dB and is available with good amplitude stability at a balanced and an unbalanced output.

The Level Meter SUN 2/U is a precision AF voltmeter with digital indication. It has an unbalanced and a transformerisolated balanced input. Range selection is automatic; switchover to manual operation with 10-dB steps is possible.

A quasi-rms responding rectifier in line with DIN 45633 produces an rms-proportional voltage from signals up to a peak factor of 5. Quasi-peak responding rectification complying with DIN 45405 can be switch-selected for weighted noise measurements.

The DC voltage proportional to the measured value is digitized and converted into dB by a microprocessor for display and further processing.

Readout characteristics are specified in existing standards psophometric for measurements. Conventional psophometers implement the required characteristics through the rectifier and meter time constants.

The Level Meter SUN 2/U simulates the characteristics of a moving-coil meter electrically, the digital display indicating the mean rms value or the maximum peak value during the display time.

Filters can be inserted in the amplifier path for measuring unweighted and weighted signal-to-noise ratio and harmonic distortion. The level generator then operates in the difference mode: it measures and stores the reference quantity, then measures the unknown via the filters and subtracts one from the other.

Linear DC and AC outputs permit connection of analog processing equipment such as recorders.



Level Meter SUN 2/U as a self-contained bench unit

AF LEVEL METERS

A1 2F

0 10 11	
Specifications	
AF Generator SUN 2/S	
Frequency	10 Hz to 100 kHz, tunable
Indication error	$\leq 1 \times 10^{-3} \pm 1$ digit
Resolution	0.25 to 0.5%
Output level Range	-20 to +12 dBm (0 dBm = 0 775 V)
Setting in range -20 to +9 dBm Additional fine adjustment	-20 to $+12$ dBm (0 dBm = 0.775 V) least step 1 dB
Indication Setting error (1000 Hz)	- 20 to 1.0 dBm; 2 digita palarity sign
Source impedance	approx. 5 Ω;
Frequency response flatness	Z _{load} ≧600 Ω ≦4.7 nF
referred to 1000 Hz	30 Hz to 70 kHz: ≦±0.1 dB other frequencies: ≦±0.3 dB
Harmonics	≧65 dB down (30 Hz to 30 kHz) ≧60 dB down (30 to 100 kHz)
DC component	≧60 dB down (30 to 100 kHz) ≧40 dB down (10 to 30 Hz) ≤+1 mV
Outputs	
	unbalanced; BNC female connector
	balanced: 3-way connector (DIN 41628)
Rear panel (instead of front- panel output)	3-way female chassis connector
	(similar to DIN 41524), lockable; in parallel with 30-way
	male connector (DIN 41622)
Level Meter SUN 2/U	
Frequency range	
Operation with filter inserted	
Range stepping	 -84 to +32 dBm (0 dBm = 0.775 V) 10-dB steps (-80 to +20 dBm) approx10 to +12 dBm about mid
	range
Range selection	automatic or manual
	readout blinking in the case of over- ranging and underranging
Resolution	0.02 dB
Error limits of indication (inherent noise level not taken into a	account)
Error with sinusoidal voltages and	
rms-value indication (1000 Hz)	.≦±0.1 dB
with rms-value indication (referred to 1000 Hz)	30 Hz to 70 kHz: ≤+0.1 dB.
Weighting error of rms-	other frequencies: $\leq \pm 0.2 \text{ dB}$
responding rectifier	up to crest factor 3: $\leq \pm 0.5 \text{ dB}$ up to crest factor 5: $\leq \pm 1 \text{ dB}$
	(in accordance with DIN 45 633 and
Error limits and dynamic range with	IEC 179)
	in accordance with DIN 45 405 (1981) and CCIR Rec. 468-2
Inherent noise level (rms)	$\simeq -90 \text{ dBm} (Z_s \leq 20 \text{ k}\Omega)$
Meter detectors rms mode	guasi-rms-responding realition in
	accordance with DIN 45633, sheet 2,
Integration time	
Measured value indication	SLOW: 145 ms mean value of detector voltage
Peak mode	during integration time (145 ms) quasi-peak-responding rectifier in
	accordance with DIN 45 405 (1981) and CCIB Rec. 468-2
Measured value indication	maximum value of detector voltage during integration time (35 ms)
Distortion measurement	L_2 subtracted from L_1 automatically
Reference measurement	
	reference value
Inputs	
	unbalanced: 1 M() II ~50 pE
Front panel (switch-selected)	BNC female connector;
Front panel (switch-selected)	BNC female connector; balanced: \geq 20 k Ω , 3-way connector (DIN 41628)
	BNC female connector; balanced: $\geq 20 \ \text{k}\Omega$, 3-way connector (DIN 41628) balanced: $\geq 20 \ \text{k}\Omega$, 30-way male connector (DIN 41622),
Front panel (switch-selected)	BNC female connector; balanced: $\geq 20 \text{ k}\Omega$, 3-way connector (DIN 41628) balanced: $\geq 20 \text{ k}\Omega$, 30-way

Common-mode rejection and ratio of balanced voltage to voltage between centre tap and earth	≧125 dB (50 Hz) ≧85 dB (1 kHz)
	≧60 dB (16 kHz)
Permissible DC voltage at unbalanced input	max. ±100 V
DC voltage Source impedance, load AC voltage Source impedance, load Useful dynamic range	$ \begin{array}{l} \mbox{telephone jacks on rear panel} \\ +0.1 \mbox{ to } +1 \ V, \mbox{ proportional to } V_{in} \\ R_{out} \approx 10 \ \Omega, \ R_{load} \geqq 1 \ k\Omega \\ max. \geqq 0 \ dBm, \ \mbox{ proportional to } V_{in} \\ Z_{out} \approx 10 \ \Omega, \ Z_{load} \geqq 1 \ k\Omega \\ \geqq 60 \ dB \end{array} $
Filters	
Unweighted	bandpass filter 31.5 Hz to 16 kHz in accordance with DIN 45 405 (1981) and CCIR Rec. 468-2
	psophometric filter in accordance with DIN 45 405 (1981) and CCIR Rec.
Distortion (d)	468-2 (exchangeable plug-in board) highpass filter 80 Hz (for d (40 Hz)), highpass filter 2 kHz (for d (1 kHz)),
Distortion	highpass filter 9.4 kHz (for d (4 7 kHz))
	bandpass filter 180 Hz for d _{3 (60 Hz)}
	and d _{2 (90 Hz)} , bandpass filter 1.6 kHz for
	d _{3 (533 Hz)} and d _{2 (800 Hz)}
Highpass filters (for = frequency	
of fundamental) Passband attenuation between	
2 fo and 45 kHz	≦±0.3 dB
Stopband attenuation at fo	≧65 dB
Bandpass filters (Ip = passband frequency)	
	≦±0.3 dB
Stopband attenuation at	
0.33 fp and 0.5 fp Stopband attenuation at	≧65 dB
\geq 1.33 f _p to 45 kHz	≧40 dB
Special filters	space and four switch positions provided for special filters
Inherent noise indication with distortion measurement	≧65 dB ($≧60$ dB for d (40 Hz) and balanced input)
	balanood alpoly
0	
General data	

Ordering information

Order designations	
Test assembly comprising	
SUN 2/S and SUN 2/U	AF Transmission Measuring
	Set SUN 2
19" bench model	190 2750 02
19" rackmount	190.2744.02
Rackmount SUN 2/S	AF Generator SUN 2/S
	282.2010.03
Rackmount SUN 2/U	Level Meter SUN 2/U
	282.4213.03

Accessories supplied

Power cord, manual, adapter board; one of each of these for the AF Generator and for the Level Meter

Recommended extras

 Recommended extras

 Panelling SUN 2-Z to convert

 ½ 19" rackmount for use as

 bench model
 085.6421.00

 Cassette Adapter SUN 2-Z for any

 two cassettes of the SUN 2-Z for any

 Panelling SUN 2-Z to convert

 Cassette Adapter for use as

 bench model
 085.1459.00

 085.1459.00



IEC 625 Bus

SUF 2

- Noise Generator SUF 2 ♦ 20 Hz to 50 MHz
- KONDE & SCHWARZ NOISS GENERATOR SUP 2 ZZ7 ZEI 9 GL PHC 1020447

- General-purpose generator for white, pink, triangular and audio-spectrum noise
- Output level 1 V into 75 Ω
- Easy to operate; remote-control option

The basic version of the **Noise Generator SUF 2** delivers a noise spectrum with a constant mean energy content which is uniformly distributed over all frequencies (white noise). A variety of options permits the SUF 2 to be adapted without difficulty for virtually all applications in audio and video noise-voltage and distortion measurements (including digital systems); it can be remote-controlled for use in automatic test systems.

Output signals, weighting filters, options

- White noise 20 Hz to 110 kHz/6 MHz/50 MHz (switchselected)
- Pink noise 20 Hz to 16 kHz (option); spectral components decreasing by 3 dB/octave
- Triangular noise 20 Hz to 6 MHz (option)
- Weighting filter in accordance with CCITT Rec. G.227 (option for simulating telephony signal)
- Weighting filter in accordance with CCIR Rec. 559 (option for simulating an LF/MF/HF signal)
- Weighting filter in accordance with CCIR Rec. 571 (option for simulating a 15-kHz program signal)
- Please enquire for other filters.
- Program option in accordance with CCIR Rec. 571
- Bus interface (optional) in accordance with IEC 625-1 (IEEE 488)

Uses (see examples)

Radio engineering: Measurement of crosstalk due to nonlinearity, and intermodulation, using the noise to mimic a sound-program signal.

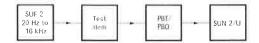
Video engineering: Measurement of interference effects on all the components of transmission systems.

Architectural acoustics: Using a noise signal – because it is similar to speech/music – for the measurement offers advantages over the fixed-frequency test methods.

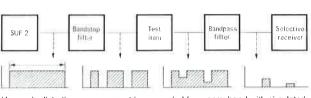
Frequency response measurement: Pink noise permits rapid and repeatable measurements.

Control engineering: Simulation of noise sources in system control and general control circuits.

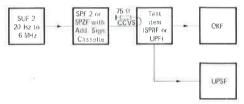
Research: Analysis of stochastic processes.



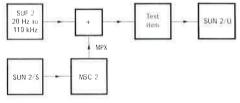
Rapid AF frequency response measurement with pink noise using one-thirdoctave or octave filter and level meter



Harmonic distortion measurement in a crowded frequency band with simulated gaps



Measurement of noise rejection in video circuitry (amplifiers, sync separators, clamping circuits, test equipment)



Measurements on stereo systems and analog frequency-multiplex and telephony transmission systems (60 to 108 kHz, international)

Specifications

•
Frequency range 20 Hz to 50 MHz Output level (white noise) ≦1 V _{ms} into 75 Ω (BNC); 0.775/0.7 V, link-selected
Frequency response flatness
Bandwidths, options see text
Level setting and accuracy 1-dB steps, ±0.5 dB continuously with 20 Hz to 50 MHz bandwidth 0 to -80 dB ±0.5 dB with 20 Hz to 110 kHz/6 MHz
bandwidths 0 to -100 dB ±0.5 dB
Remote control attenuation: in BCD code
bandwidths and filter options:
2-bit binary code
AC supply 110/115/220/235 V ±10% (20 VA)
Dimensions (without stand), weight = 210 mm×110 mm×347 mm, 4 kg
Ordering information
Order designation Noise Generator SUF 2
282.8819.03
Plug-in options
Controllers (one only):
IEC-625-bus Interface
CCIR Rec 571 Program SUF 2-Z6 282.9673.00
Filters (one only):
Triangular Noise SUF 2-Z2 282.9715.00
Triangular Noise
CCIR Rec. 559 – Filter SUF 2-Z4 282.9615.00
CCIR Rec. 571 Filter SUF 2-Z5 282.9644.00
CCITT Rec. G. 227 Filter

FM/AM Demodulator FAB

- Bands I, II, III and IV/V ۵
- Tunable oscillator plug-ins for bands I to V, fixed-frequency plug-in: IF + band II
- Performance complying with ARD specifications 5/3.4 for FM (AM) demodulators
- Built-in frequency-deviation standard and mono/stereo indication



Photo: FAB with oscillator plug-in for band III

The FM/AM Demodulator FAB, which is also suitable for stereo operation, is designed for testing and permanent monitoring of FM sound broadcast and TV transmitters. Lamps are provided to signal mono or stereo operation.

Measurements on the transmitter

using FAB alone	with accessory units
Modulation frequency	Frequency response of AF
response	amplitude
Centre-frequency error	Frequency response of phase
Frequency deviation	Distortion
Spurious amplitude modula-	Intermodulation distortion
tion	Intermodulation products
	Weighted and unweighted
	noise voltage (FM and AM)

To select the desired frequency band, the FAB must be equipped with one of the oscillator plug-ins (see specifications). The selected reception frequency is indicated on a drum dial (with the fixed-frequency plug-in, on the pushbuttons). When the FAB is to be operated at a fixed frequency, the oscillator can be switched to crystal-controlled operation (crystals should be ordered separately).

Indication. The measured or monitored quantities are read from a meter calibrated in kHz for the centre-frequency error and on a switchable multi-purpose meter.

Specifications	
Frequency setting	through the corresponding range (crystal control of fixed frequencies possible) or with fixed-frequency
Frequency ranges of oscillator plug Band I (FAB-E1) Band II (FAB-E2)	. 48 to 68 MHz - 87.5 to 108 MHz
Band III (FAB-E3) Band IV/V (FAB-E4) Fixed frequencies (FAB E5)	. 175 to 230 MHz . 471 to 853 MHz . 5.5 ¹)/21.4/33.4 ¹)/38.9 ¹)/
Band I (OIRT) (FAB-E6) RF input	52 to 75 MHz switchable: Dezifix B on front panel/self-engaging
Input impedance	plug-and-socket connection on rear panel $50 \Omega \text{ or } 60 \Omega$, depending on order no. 1 to 5 V (0.1 to 1 V without AM meas- urement)
Outputs	
Test output (output 1)	RF female connector 4/13,
Monitoring output (output 2)	DIN 47 284, adaptable mono output (balanced, floating), twin panel female connector, DIN 41 628
1) Please enquire for other frequenc 46 MHz.	ies between 4.5 and 6 MHz or 30 and

2) Operation possible only with channel crystal (to special order).

FM measurement	Output 1	Output 2
Source impedance	. ≦10 Ω	≦30 Ω
Permissible load	(free from DC)	
Deemphasis (time constant)	50 µs (switched)	≧600 Ω 50 μs (fixed)
Band limitation by lowpass filter		
(at 19 kHz)	≥40 dB (switched	≧40 dB (fixed)
	together with deemphasis)	
Output level with 40-kHz deviation in	band II, with 30-kHz	deviation in bands
I/III/IV/V, fmod = 500 Hz and specified load		
inou a doo na and specified toad	±0.25 dB	+6 dBm ±0.25 dB
Nonlinear distortions (with frequer		
Distortion in the range		
40 Hz to 15 kHz	≦0.25% (output 1	or 2)
Intermodulation distortion		
2nd order 3rd order		z to 15 kHz uts 1 and 2,
	≥ 15 k	Hz to 53 kHz
		ut 1 only
Deviation Indication		
Ranges	0 to 500 Hz/10/50	100 kHz
Reading error at $f_{mod} = 500$ Hz (after Range	10/50/100 kHz 50	It-in standard)
in band	. I to V I,	
Range in band Free-running oscillator	. ±3% of fsd <	50 Hz no toler-
		ance
Crystal oscillator	$\pm 3\%$ of fsd <	25 Hz —
Frequency-response flatness of		
deviation indication		53 kHz)
Indication of amplitude modulatio	n	
Ranges (modulation depth) Reading error at f _{mod} = 500 Hz	0 to 1/5/10%	
Frequency-response flatness of AM	indication, referred t	0
indication at fmod = 500 Hz	≦5%	
S/N ratio, unweighted, referred to 100% AM	≧56 dB	
S/N ratio weighted referred		
to 100% AM	≧66 dB	
	- 14 dBm ±0 25 dB	5
General data		
Rated temperature range	+5 to +35 °C	1 10/ 150/
AC supply	47 to 63 Hz (35 VA	/ +10/-15%,)
Dimensions, weight		
19" bench model	484 mm×150 mm×	336 mm, 17 kg
	400 mmx 135 mmx	325 mm, 14 kg
0.1.1.1.1		
Ordering information		
Order designation .	FM/AM Demodu	ator FAR
Basic unit without oscillator		ator I AD
plug-ins	50 Ω	60 Ω
19" bench model 19" rackmount	206.9418.52	206.9418.62 206.9418.61
Oscillator plug-in		200.0410.01
FAB-E1 (band I) FAB-E2 (band II) FAB-E3 (band III)	207.6012.02	
FAB-E3 (band III)	207.7019.02	
FAB-E4 (band IV/V)	207.9011.02	
FAB-E5 (fixed frequencies)	289.6911.02	
FAB-E6 (band I, OIRT)	235.3714.02	
Recommended extras		

Recommended extras

Crystals are to be ordered separately; ordering information: crystal for oscillator for FAB, band (I, II, III or IV/V) and channel frequency.



Photo, bottom: Successor model FKDL

The continuously tunable FM Monitoring Demodulators FKD and FKDL are used for monitoring carrier signals modulated with mono or stereo signals in accordance with the relevant CCIR recommendation. They are connected to the transmitter output via directional couplers or voltage dividers and deliver demodulated mono, multiplex, L and R signals for checking the performance of FM transmitters.

100

D.

FM DEMODULATORS

Models In addition to the FKD model principally designed for central monitoring and accommodating up to four FM Demodulators FKD-E in one 19" Adapter Frame FKD-B, the FM Monitoring Demodulator FKDL is available; it consists only of one demodulator in the form of a 19" rackmount and is provided for incorporation into transmitters. The FKDL, too, is available for European paging transmitters.

Indication. Analog display of the AF voltages of the L and R channels is provided by two LED arrays (32 diodes). The 80-mm scale can be read even from a distance of several meters. The righthand LED array can be switched over at the front panel to indicate the frequency deviation of the transmitter. Two additional LEDs signal that the stereo mode is selected and that the RF input voltage is sufficient.



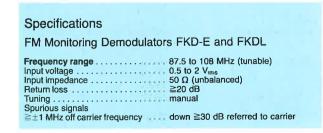
Outputs. A low-impedance output on the rear panel delivers the mono signal for monitoring and measuring purposes. The multiplex signal is available at two parallel, lowimpedance outputs on the front and rear panels. A headphones output for the L and R signals is fitted on the front panel.

Construction. The FM Demodulator FKD-E comes as a cassette for insertion into an Adapter Frame FKD-B which provides space for a maximum of four FKD-E cassettes and contains the power supply unit. If the FKD-E is used without this adapter frame, an external ±15-V power supply is required. The RF voltages coming from the transmitters are applied via BNC female connectors on the rear panel. After changing over the internal cabling, the RF voltage can also be fed in on the front panel. The FKD is available as a 19" rackmount or as a bench model with the necessary panelling.

The FM Monitoring Demodulator FKDL comes as a 44-mm high 19" rackmount with a power supply of its own and is fitted with connectors on the rear panel.

Operation. The RF section of the FM Monitoring Demodulators includes a variable-frequency oscillator whose frequency can be modulated and which is automatically synchronized to the frequency of the transmitter to be measured. A five-LED array indicates the tuning with respect to carrier midpoint. The AC component of the correction voltage is used after peak-rectification for indication of the FM deviation. The stereo decoder module, working on the time-division-multiplex principle, automatically switches over to mono operation if the pilot tone is absent.

Filter module. For the suppression of cross-modulation products arising from the linking up of several transmitters via diplexers, a filter module is available.



RF input 87 5 to 108 MHz /0.5 to 2 V + 6 dBm (40 kHz) Left (dBm) Right/dev (dBm/kHz) APC indication RF sectio ÷+ ₽ 4 32 LEDs 32 0 D 1 ₽ Ðł x +15 V 1 15 V -Ŕ H ~ $\overrightarrow{}$ A Dł \approx Ď D V in Ihreshold Indication PEL Dev. AF ſ (3) threshold 15 kHz Ē 户 ∇ 25 Ŕ ₽ V in indication 50 µs E T Ŕ vco Decoder Bulfer amplifier ŧ Oulpul + 6 dBm (40 kH2) Tuning 60 Volume indication ophase 50 415 Ì Ø ŧΖ 50 µs AF section Stereo indication V_{in} indication • Testionths — MPX output — 6 dBm (40 kHz) 1 P 15 kHz - Mono output 00 Block diagram of P1 11 6 dBm (40 kHz) FM Demodulator FKD-E

Devlation indication	0 to 77.5 kHz (peak-voltage	
Resolution	2.5 kHz (32.1 EDs)	
Indication error ²)	$\leq \pm 5\%$ of fsd (f _{mod} = 40 Hz to 60 kHz)	
Indication error after change of chan	nel without	
external calibration	<+10% (f _{mod} = 40 Hz to 60 kHz)	
Test outputs		
Multiplex signal output	<20 O (unbelonged)	
Output level at ±40 kHz deviation		
Frequency response flatness	+0 dbm ±0.5 db mit 000 12-)	
30 Hz to 53 kHz	≤+0.3 dB	
53 to 100 kHz	≤+1 dB	
Harmonic distortion at ±75 kHz		
deviation ¹)	≦0.5%, typ. 0.3% (30 Hz to 15 kHz)	
Unweighted S/N ratio ¹)	≧64 dB	
Weighted S/N ratio ¹)	≧64 dB	
Crosstalk measured via stereo-		
decoder1) without preemphasis and		
deemphasis	100 Hz to 10 kHz: ≧40 dB down 40 to 100 Hz: ≧34 dB down	
Mana stand subsut		
Mono signal output	\geq 30 Ω (balanced)	
Output level at ±40 kHz deviation, fmod = 500 Hz	$\pm 6 dBm \pm 0.5 dB into 600 O^2$	
Frequency-response tratness		
referred to 50-µs deemphasis	±0.5 dB (40 Hz to 15 kHz)	
Harmonic distortion at ±75 kHz	10.0 db (40 Hz (0 10 kHz)	
deviation	≦0.5% (30 Hz to 15 kHz)	
Unweighted S/N ratio ¹)	≧68 dB	
Weighted S/N ratio ¹)	≧68 dB	
Identification signal suppression		
(fmod = 500 Hz; with deemphasis) .	≧60 dB	
Monitoring outputs		
Stereodecoder outputs	for L and R signal:	
	$Z_{out} \leq 30 \Omega$ (unbalanced)	
Output EMF with ±40 kHz		
deviation, f _{mod} = 500 Hz		
Crosstalk between L/R channels	typ. 30 dB (40 Hz to 15 kHz)	
Frequency-response flatness		
40 Hz to 15 kHz		
Headphones output		
	on front panel; $Z_{out} \leq 30 \Omega$	
Frequency response flatness		
40 Hz to 15 kHz		
Filter module	to derive max. four carrier signals	
Insertion loss	6 dB per selective circuit	
Selectivity	typ. 13 dB ±1.5 MHz off the carrier	
 Measured with deemphasis (at mu 	Itiplex signal output via stereodecoder,	
	ted in accordance with CCIR 468-2,	
referred to nominal output level.		

referred to nominal output level. ²) After external calibration in operating channel.

AF level Indication -12 to +12 dBm Indicator LED array (2×32 LEDs, scale lenght 80 mm)
General data
FM Monitoring Demodulators FKD-E and FKDL
Rated temperature range +5 to +40 °C Operating temperature range 0 to +45 °C Storage temperature range -20 to +50 °C Power supply of FKD-E +15 V (±2%), 300 mA -15 V (±2%), 150 mA -15 V (±2%), 150 mA FKDL .15/125/220/235 V +10/-15%, 47 to 63 Hz (15 VA) Dimensions of FKD-E 76 mm×132 mm×316 mm FKDL .135 kg/3.3 kg
Adapter Frame FKD-B with power supply
Connectors (also applicable for FKDL) RF inputs
19" bench model (design 80) 492 mm×161 mm×514 mm, 7.5 kg 19" rackmount

Ordering information

Order designation (19" rackmounts)	
Adapter Frame with cassettes	FM Monitoring Demodulator FKD
	Conn. on also on rear panel;
	front panel with filter
with 1 demodulator cassette	343.2014.51 343.2014.53
with 2 demodulator cassettes	343.2114.51 343.2114.53
with 3 demodulator cassettes	343.2214.51 343.2214.53
with 4 demodulator cassettes	343.2314.51 343.2314.53
Single-demodulator rackmount	FM Monitoring Demodulator FKDL
	338.9014.51
19" bench model	338.9014.52
Adapter Frame FKD-B with MPX outp	outs and RF inputs on front panel.
without demodulator cassettes	
FM Demodulator FKD-E with	
MPX output	343.2414.50
Panelling for FKD-B	
Filter FKD-B	

A1 2F

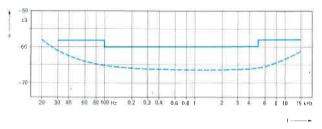
FM DEMODULATORS

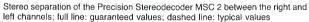


The **Precision Stereocoder MSC 2** produces the standard multiplex signal with **high precision**.

STEREOCODER

In the standardized technique of stereo multiplex broadcasting, the sound-program signals for the left and right channels are carried in the frequency range 30 Hz to 53 kHz together with a pilot tone. This stereo multiplex signal is generated in the Precision Stereocoder MSC 2 with high precision. The excellent data – for example distortion $\leq 0.1\%$ up to 12.5 dBm, unweighted S/N ratio \geq 80 dB, frequencyresponse flatness $\leq \pm 0.15$ dB and crosstalk attenuation between left and right channels >60 dB (see diagram below) – result from the new coding method employed in the MSC 2.





The Precision Stereocoder MSC 2 is used as **reference unit** for all measurements with stereo multiplex signals, since its data far exceed the standard specifications of the broadcasting corporations.

In conjunction with a stereo-signal generator, the MSC 2 is a useful instrument for the **development and production** of radio receivers. A simple measurement of crosstalk between the two AF channels gives a good idea of the main characteristics of the RF and IF sections of a receiver, without requiring elaborate frequency-response measurements; it is also a good test of the performance of the stereodecoder section. Together with a stereodecoder of similar quality, such as the MSDC 2 (see page 343), all kinds of measurements can be made on equipment that handles and thereby possibly deteriorates multiplex signals, for instance FM transmitters, modulators, relay receivers and switchboards. In such cases it is particularly important that the inherent error of the test assembly should not falsify the measurement.

For its use as a measuring instrument, the stereocoder is fitted with an AF generator producing six fixed frequencies with high amplitude stability and low distortion, with the result that an external generator will not be required in most cases. The internal generator is used for the modulation modes:

appendix

R L = R (mono signal) L = -R (difference sig

L = -R (difference signal)

The phase and amplitude of the pilot tone (19 kHz) are adjustable with front-panel controls so that the characteristics of the decoder under test can be measured in any operating conditions. The amplitudes of the AF and multiplex signals can also be adjusted over a wide range. A peak voltmeter indicates the modulation of the coder.

Specifications

Inputs for L and R channels	
Attenuation (f ≧19 kHz) ≧54 dB	
Input level at 1 kHz for output level	
of +6 dBm of M signal or of S signal	
modulated onto subcarrier	
Preemphasis 50 μ s/75 μ s/off Auxiliary-signal inputs	
Pilot-tone frequency	
Multiplex-signal outputs	
Output level	
(without pilot tone)	
M-signal output	
Pilot-frequency output 1 V_{pp} (Z _{out} $\leq 100 \Omega$), squarewave	
Frequency response flatness (ref. 500 Hz) measured after	
decoder 40/30 Hz to 15 kHz ≦±0.15 dB	
53 to 75 kHz	
Crosstalk between M/S ≧46 dB down (30 Hz to 15 kHz)	
L/R	
≥58 dB down (30 Hz to 15 kHz)	
Signal/THD ratio at output levels	
up to +12.5 dBm≧60 dB Unweighted S/N ratio≧80 dB, quasi-peak (to DIN)	
Weighted S/N ratio ≧78 dB, quasi-peak (to DIN)	
≧76 dB, quasi-peak (CCIR 468-2)	
Power supply 115/125/220/235 V +10/-15%,	
47 to 63 Hz (10 VA)	
Dimensions, weight	
19" bench model	
19" rackmount	
Order designation Precision Stereocoder MSC 2	
19" bench model	
19" rackmount	
SCA Modulator 230.9014.00	



Precision Stereodecoder MSDC 2

- ♦ 30 Hz to 75 kHz
- High-grade decoding of multiplex signals
- Very high channel separation: typically 64 dB
- Extremely low intrinsic distortion



The **Precision Stereodecoder MSDC 2** is used to measure and monitor stereo multiplex signals. Its performance far exceeds the requirements set by ARD in all significant points. Thus the MSDC 2 can be employed as a reference standard in the development and production of stereo coders and decoders, as well as in transmitter networks to ensure high transmission quality.

Input. The input of the MSDC 2 is balanced; commonmode rejection exceeds 60 dB for the lower frequencies. The input amplifier handles frequencies from about 0.1 Hz to 1 MHz without introducing distortion. Amplitude and phase errors thus remain so small that high separation performance is achieved (same values as for MSC, see diagram on page 342).

The decoder uses a time-division-multiplex decoding technique. The stereo signal is connected alternately at a rate of 38 kHz to the right and left channels. This circuit arrangement provides a carrier suppression of more than 40 dB.

To obtain the specified channel separation, it is essential that switching is in exact synchronism with the pilot tone. For frequency deviations up to ± 2 Hz and level variations up to $\pm 6/-12$ dB the time shift of the squarewave switching voltage referred to the 19-kHz pilot tone may not exceed 50 ns.

Outputs. The signals of the left and right channels, the centre signal M = (L+R)/2 and the side information S = (L-R)/2 are delivered with extremely low distortion at separate outputs. Apart from the S-signal output they are balanced. Toroidal core transformers are used, giving distortion of less than 0.1%, even at a frequency of 30 Hz and a signal level 6 dB above nominal.

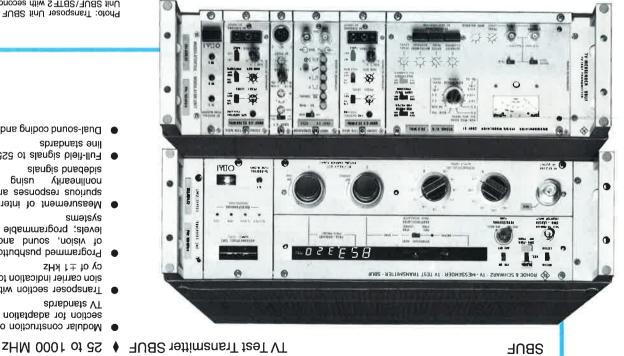
Indication. A selector switch allows the levels of the output signals and of the pilot tone to be indicated on the panel meter. The measurement range for the output signals (-66 to +18 dBm) is large enough to permit even the intrinsic error of the MSDC 2 or a coder working directly into the MSDC 2 to be measured. The pilot-tone voltage can be measured over a range of -7.5 to -17 dB relative to the setting of the input attenuator. This permits exact level adjustment, even with an unknown stereo multiplex signal.

Specifications	
Stereo multiplex input Frequency range Input impedance Common-mode rejection	30 Hz to 75 kHz ≥40 kΩ bal., ≥20 kΩ unbal. ≥58 dB at <150 Hz ≥46 dB at 150 Hz to <15 kHz ≥36 dB at 15 to <100 kHz
Input level	-12 to +12 dBm (0 dBm = 0.775 V into 600 Ω)
	6-dB steps, ±3 dB continuous ≧6.5 dB
AF outputs L, R, M signal outputs (balanced) S signal output (unbalanced)	+6 dBm, $Z_s \leqq 20 \Omega$, $Z_L \geqq 200 \Omega$ +6 dBm, $Z_s \leqq 500 \Omega$
Linear distortions Frequency response flatness at the outputs, relative to 500 Hz Deemphasis	≦±0.15 dB for 30 Hz to 15 kHz 50 µs ±2%/75 µs ±2%/off
Linear crosstalk M/S channels	≧46 dB (typ. 50 dB) ≧60 dB (typ. 64 dB) ≧58 dB (typ. 60 dB)
Nonlinear distortions Harmonic distortion at 6 and 12.5 dBm Difference-frequency inter- modulation distortion to DIN 45403 at 12.5 dBm	≦0.1% d ₂ ≦0.05%, d ₃ ≦0.1%
Welghted and unweighted noise (with 50-μs deemphasis) relative to +6 dBm at 1 kHz Unweighted S/N ratio,	
Unweighted S/N ratio, ms measurement	≧78 dB ≧80 dB
Pilot-tone suppression SCA suppression (SCA level - 16 dB relative to multiplex signal)	
Meter Indication Indicating error Pilot-tone indication AF indication (10-dB steps)	≦0.2 dB of rdg +1.5% of tsd -7.5 to -17 dB
General data Rated temperature range Rear connectors Power supply	30-pole male
Dimensions, weight 19" bench model	492 mm×116 mm×392 mm, 6.7 kg 483 mm×88 mm×384 mm, 4.5 kg
Ordering information	
	Precision Stereodecoder MSDC 2 281.0514.03
Panelling	. 085.1313.00

xibnaqqa

ZATTIMSNAAT TEET VT

- TV standards section for adaptation to different Modular construction of modulator
- cλ ot ∓ 1 kHz sion carrier indication to an accura-Transposer section with digital vi-
- smaisve of vision, sound and sideband levels; programmable for use in Programmed pushbutton selection
- **bu**isn repiosnuis nonlinearity spurious responses and line-time Measurement of intermodulation,
- line standards Full-field signals to 525- and 625slangis bnadebis
- Dual-sound coding and modulation



Unit SBUF/SBTF2 with second sound modulator Photo: Transposer Unit SBUF (top) and Modulator

Modulator Unit SBUF/SBTF2

power supply). The following configurations are possible: are accommodated in a Modulator Frame SBUF-B (19"; with Modulator (for FM or FM depending on the standard) which equipment comprises the Vision Modulator and the Sound adapted to a full range of measurement tasks. The basic Thanks to its modular design, the Modulator Unit can be

×			E .	Transmitter Unit SBTF 2-E
×				Local Oscillator SBTF 2-E
	×		L 73	TV Dual-sound Coder
	×	×	93	Video Generator
	×		E2	Sound Modulator 2 (FM)
		×	E4	Program Selector
		×	E3	SB Generator
×	×	×	E2	(MA/MH) f notseluboM bruno2
×	×	×	13	Vision Modulator
		I		
	inations	Comp	BUF-	Cassette S

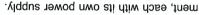
ment of intermodulation distortion, a static or swept sideband in accordance with the standard involved. For the measurecarrier signals modulated with vision and sound components The Modulator Unit (block diagram to the left) generates IF

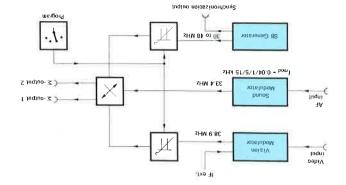
can be added to this signal.

:poidmelo fo sebom abled. The balanced modulator uses one of the following the rear panel. The receiver precorrection filter can be disapplied at switch-selected loop-through inputs on the front or Vision Modulator SBUF-E1. The video signal can be

- clamping to the sampled value of the back porch
- mean-value clamping for symmetrical modulation signals 3' peak-value rectification to sync pulse level .z

Unit SBUF, which are available as separate items of equipunits, the Modulator Unit SBUF/SBTF2 and the Transposer and production. It consists of two self-contained functional for instance for use with automatic test systems in research systems. Together with ancillary equipment it is also suitable and transposers, as well as their modules and in CATV ment, testing and maintenance of TV receivers, amplifiers tions in laboratories, test and service shops, in the developable tuning. These attributes open up a wide field of applicaattained by any other test transmitter with continuously varihigh frequency TV test signals that have not until now been The TV Test Transmitter SBUF offers a variety and quality of

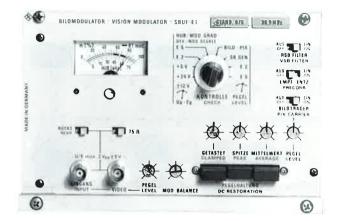




Block diagram of Modulator Unit of TV Test Transmitters SBUF and SBTF2

TV TEST TRANSMITTERS





The carrier frequency is supplied by an internal crystal oscillator or an external signal source. A switch is fitted for **double-sideband modulation** (1-dB bandwidth \pm 8 MHz) or – via a group-delay-equalized filter – **vestigial-sideband operation**.

The check meter indicates either supply voltages, deviation (or modulation depth) of the sound carrier or output level of the Vision or Sound Modulator.

For the **CATV mode** using adjacent TV channels Vision Modulators with increased selectivity (surface wave filters) are available for Standards B/G and M.

FM Sound Modulator SBUF-E2. The Sound Modulator is designed both for mono transmission and for **modulation of stereo signals.** A low-distortion signal from an internal sinewave generator which can be set to 0.04/1/5/15 kHz or an external signal (two parallel balanced inputs) is used for frequency modulation. The preemphasis can be disconnected. The centre frequency is stabilized by **frequency and phase control loops.** The FM deviation can be continuously adjusted.



SOUND STON MOD

AM Sound Modulator SBUF-E2 (for Standards C, L, L'). The AM Sound Modulator can be used instead of the FM Sound Modulator. It is also suitable for internal and external modulation; the modulation depth is continuously adjustable.

SB Generator SBUF-E3. The frequency of the voltage-controlled oscillator (30 to 48 MHz) can be set by hand or swept at one of two speeds over a continuously adjustable sweep width. The triangular sweep signal is available at a front-panel output.

The SB Generator enables simple determination of the intermodulation products and the linearity of amplifiers – in particular of TV transposers.



Program Selector SBUF-E4. Five static programs (no modulation; see specifications) and the dynamic program (normal mode) can be pushbutton-selected. In the dynamic mode, the modulated vision and sound carrier signals are available at the sum outputs in the ratio 10:1. **External program selection** is possible by applying TTL levels.

FM Sound Modulator SBUF-E5 for TV dual-sound or stereo measurements (the specifications are the same as those of Sound Modulator E2). The TV Dual-sound Coder E7 is required for operation (see below).



Video Generator SBUF-E6. The SBUF-E6 delivers a standard composite video signal (625 or 525 lines) with a selectable test signal for rapid checking and measuring of the transmission characteristics of TV transmission systems, in particular receivers and transposers. It makes the SBUF or SBTF 2 into a complete TV test transmitter. The five test signals can be selected either by pushbuttons or by external TTL levels. A mean grey pedestal can be connected for application of external signals (e.g. a sweep signal).

TV Dual-sound Coder SBUF-E7. The plug-in permits encoding of the AF signals for the FM Sound Modulators E2 and E5 and adjustment of amplitude and phase of the two sound channels. The E7 also de-livers the frequencies for mode identification (for pilot modulation) and the pilot frequency.







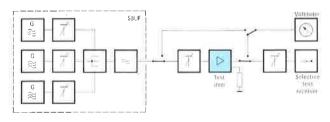
TV TEST TRANSMITTERS

SBUF - TV Test Transmitter

2F

Output signal. The combined signals from the Vision Modulator, Sound Modulator 1, Sideband Generator and Sound Modulator 2 are brought out to two sum outputs for frequency conversion in the Transposer Unit. The levels of the signal components are determined by attenuators in accordance with the selected program. Adjustment by a further $\pm 3 \text{ dB}$ is also possible on each component, or the components can be switched off.

The nonlinear distortion of the device under test can be efficiently measured with the aid of these signals by evaluation with an analyzer or selective receiver. The expense of three continuously variable signal generators with calibrated attenuators and decoupling networks, the separate tuning to three frequencies and the setting of three levels can thus be eliminated (see diagram below).



Test setup for moiré measurement on a channel amplifier

Transposer Unit SBUF

In the transposer section the sum IF signal from the modulator section is up-converted and down-converted to obtain a carrier frequency anywhere in the range 25 to 1000 MHz. Unwanted spurious emissions are suppressed by fixed bandpass filters and a lowpass filter.

Frequency setting. The frequency can be set in one of two ways:

"Unsync." mode. Adjustment with tuning knob II only; frequency indication calibrated in MHz (error $\leq \pm 10$ MHz), 3¹/₂ digits (produced by analog/digital conversion of the tuning voltage).

"Sync." mode. Additional presetting with tuning knob I; frequency indication calibrated for 0 to 100 MHz to an accuracy of ± 1 kHz via a counter. The channel frequency is set ignoring the 100-MHz decade, which is derived from the adjustment of tuning knob II after phase locking.

It is thus possible to set and read off the desired channel frequency without an IF signal being applied at the input of the transposer.



Frequency setting (bottom right) and readout (top) on Transposer Unit SBUF

By way of a **counter input** with a 10:1 prescaler the reference-frequency input can be used for measuring external frequencies in the range **25 to 300 MHz**.

Second intermediate frequency. An option (please enquire) is available to provide the Transposer Unit with a second input IF, for instance 45.75 MHz in addition to 38.9 MHz (switch-selected on the front panel). This option is also available with an IF of 32.7 MHz (Standard L/L') for the lower sideband. Another application is the conversion of the nominal IF into a second IF.

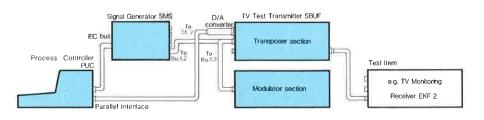
Output level. The levelled output signal can be continuously adjusted by varying the overall gain and is indicated by a row of LEDs. A **calibrated attenuator** further allows the output level to be set in smallest steps of 1 dB.

To increase the output level to 2 V, the **CATV Broadband Amplifier AKF** can be connected after the SBUF for 25 to 300 MHz.



CATV Broadband Amplifier AKF

Programmed operation. Channel setting is also possible by an external frequency for tuning I and by an external voltage for tuning II. A signal is delivered in the case of synchronization.



Block diagram of computer-controlled test assembly for rapid channel change, the reference frequency is delivered by the Signal Generator SMS and the tuning voltage produced by a D/A converter (e.g. Motorola MC 1408)

TV TEST TRANSMITTERS

≥57 dB (with 30% superimposed hum) for carrier level, modulation and supply voltages

test output: approx. 0.5 V into 50 Ω oscillator input: 1 to 3 V

 colour subcarrier frequency
 ≥2%, 10 to 85% modulation

 Differential phase at
 ≤2°, 10 to 85% modulation

 Signal-to-noise ratio³)
 ≤2°, 10 to 85% modulation

 for 0.1 to 5 MHz
 ≥64 dB (rms)

 for 0.1 to 1 kHz
 ≥60 dB (peak-to-peak)

 Hum suppression³)
 ≥57 dB

 in clamped mode
 (with 90% superimposed but

Check meter Monitoring connector

(vision carrier)



Vision Modulator SBUF-E1	
Video input signal	
Signal level	0.5 to 2 Vpp (CVS)
DC Oliset	max. ±5 V
Input (switch-selected)	loop-through filter, BNC connectors;
	high-impedance or 75-Ω termination;
Return loss (0 to 8 MHz)	front or rear panel
Front-panel input	≥34 dB_evternal termination
	>26 dB internal termination1)
Rear-panel input	≥20 dB, internal termination
IF output signal	
Vision carrier	38.9 MHZ (R/G D/K L M)
	32.7 MHz (L)
	32.7 MHz (L) 45.75 MHz (M-CATV)
Frequency error	≦±1×10-5
Frequency error	200 mV _{ms} , sync peak
Setting range	(white level with standard L)
Setting range	approx. ±3 dB, carrier can be disabled
	carrier carribe disabled
Modulation characteristics	
type of modulation	C3F (A5C), negative (B/G, D/K, I, M)
Modes of operation	C3F (A5C), positive (L)
would be operation	double sideband,
	vestigial sideband, with or without receiver
	group-delay correction filter
Clamping (pushbutton-selected)	
Sampled	to back porch
Peak	by peak rectification to sync level
Mean value	for symmetrical modulation
Transmission characteristics	
Transmission range (IF)	±8 MHz, ref.: vision carrier
Amplitude response	
Double-sideband operation	$<\pm 0.2$ dB, ± 10 Hz to ± 6 MHz
Vestigial-sideband filter	$<\pm 0.5$ dB, ± 6 Hz to ± 8 MHz
Receiver group-delay	see bottom leit
correction	additional amplitude response:
Standard B/G	±0.2 dB 10 Hz to 4.8 MHz
D/K	±0.2 dB, 10 Hz to 5.5 MHz
D/KI (South Africa) L and I (Great Britain)	±0.2 dB, 10 Hz to 4.8 MHz
Land I (Great Britain)	0 (no correction)
MGroup-delay response	
Double-sideband operation	<10 ns +10 Hz to +6 MHz
Double-sideband operation Vestigial-sideband operation Standard B/G B/G - CATV	additional ripple
o portanon	(peak-to-peak value):
Standard B/G	≦40 ns, -4.8 to +0.5 MHz
B/G - CATV	≦70 ns, -4.8 to +0.5 MHz
D/K	≥40 ns, -5.5 to +0.5 MHz
	≥30 ns, -5.2 to +1.0 MHz
L M M – CATV Receiver group-delay correction	$\leq 40 \text{ ns} = -4.0 \text{ to} \pm 0.5 \text{ MHz}$
M-CATV	$\leq 70 \text{ ns}, -4.0 \text{ to } +0.5 \text{ MHz}$
	con bottom right
Receiver group-delay correction	see bolloni rigni
Receiver group-delay correction	see bollonn right

Sound Modulator 1 SBUF-E2 and Sound Modulator 2 SBUF-E5 AF input signal Signal level +6 dBm for 0 to ±80 kHz deviation, continuously adjustable 40 Hz to 75 kHz floating, Z_{in} approx. 5 k Ω , switchable external/internat Frequency range Connector front panel: 3-way female rear panel: 30-way male Internal AF generator Amplitude response 0.04/1/5/15 kHz and "off" <±0.3 dB, ref. to 1 kHz <0.3% IF output signal Sound carrier frequency⁴) Standard B/G D/K 33.4 MHz (sound 2: 33.158 MHz) 32.4 MHz 32.9 MHz 34.4 MHz (CATV: 41.25 MHz) I м Frequency error Centre frequency stabilization <±500 Hz <±500 Hz</td>Irequency and phase control;ref.: vision carrier ≤ 45 to ≥ 90 mV_{ms}] carrier can ≤ 20 to ≥ 40 mV_{ms}] be disabled45/63/90 mV, corresponding to $to = 10^{-10}$ courd course ratio Output level²) SBUF-E2 SBUF-E5 Nominal level for single sound vision/sound power ratio 20:1/10:1/5:1 45 mV (20:1) for sound 1, 20 mV (100:1) for sound 2 dual sound

 Modulation characteristics for standards B/G, D/K, I, M

 Type of modulation
 F3E (F3), with preemphasis

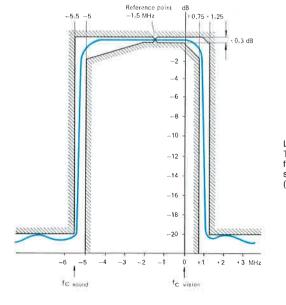
 Modulation frequency
 F3E (F3), with preemphasis

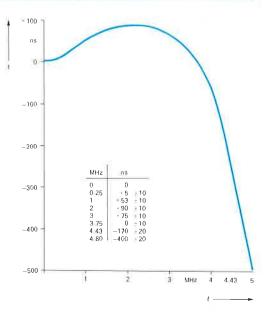
 response flatness
 <10.3 dB, 40 Hz to 53 kHz</td>

 < ±0.5 dB, 52 to 375 kHz</td>
 <10.5 dB, 52 to 375 kHz</td>

..... <±0.3 dB, 40 Hz to 53 kHz <±0.5 dB, 53 to 75 kHz ref.: 1 kHz, preemphasis disabled

Measured via TV Demodulator AMF 2; ref.: black-to-white transition.
 Please enquire for different frequencies.





Left: Tolerance mask for frequency response of IF sideband spectrum (standard B/G)

> Right: Group-delay/frequency response of video groupdelay precorrection



TV TEST TRANSMITTERS

appendix

SBUF 😑 TV Test Transmitter

Preemphasis (switched)	50 μs ±5% (M: 75 μs)
Modulation distortion	≦0.5%, 40 Hz to 15 kHz,
Woodliation distortion .	deviation ± 75 kHz
	(preemphasis disabled)
Stereo crosstalk	>40 dB down, 0.1 to 5 kHz
	(measured with coder and decoder)
Signal-to-noise ratio	>70 dB (mono), >66 dB (stereo),
	weighted and unweighted;
	ref.: ±40 kHz deviation
Incidental AM	
	deviation ±40 kHz;
	ref.: 100% modulation
Modulation characteristics for star	ndard L (differing characteristics)
Tupo of modulation	
Type of modulation	A3E (A3), without preemphasis
	A3E (A3), without preemphasis
	+12 dBm for 0 to 100% modulation,
AF input signal, level	+12 dBm for 0 to 100% modulation, continuously adjustable
AF input signal, level	+12 dBm for 0 to 100% modulation, continuously adjustable
AF input signal, level Frequency range IF output signal	+12 dBm for 0 to 100% modulation, continuously adjustable 30 Hz to 15 kHz
AF input signal, level	+12 dBm for 0 to 100% modulation, continuously adjustable 30 Hz to 15 kHz 39.2 ¹) MHz ±500 Hz,
AF input signal, level Frequency range IF output signal Sound carrier frequency	+12 dBm for 0 to 100% modulation, continuously adjustable 30 Hz to 15 kHz 39.21) MHz ±500 Hz, crystal-controlled
AF input signal, level Frequency range IF output signal	+12 dBm for 0 to 100% modulation, continuously adjustable 30 Hz to 15 kHz 39.21) MHz ±500 Hz, crystal-controlled
AF input signal, level Frequency range IF output signal Sound carrier frequency Output level ²)	+12 dBm for 0 to 100% modulation, continuously adjustable 30 Hz to 15 kHz 39.21) MHz ±500 Hz, crystal-controlled
AF input signal, level Frequency range IF output signal Sound carrier frequency Output level ²) Modulation frequency	+12 dBm for 0 to 100% modulation, continuously adjustable 30 Hz to 15 kHz 39.2^1) MHz \pm 500 Hz, crystal-controlled \leq 50 to \geq 100 mV _{tms}
AF input signal, level Frequency range IF output signal Sound carrier frequency Output level ²)	+12 dBm for 0 to 100% modulation, continuously adjustable 30 Hz to 15 kHz 39.21) MHz \pm 500 Hz, crystal-controlled \leq 50 to \geq 100 mV _{rms} $<\pm$ 0.5 dB, 30 Hz to 15 kHz;
AF input signal, level Frequency range IF output signal Sound carrier frequency Output level ²) Modulation frequency response flatness	+12 dBm for 0 to 100% modulation, continuously adjustable 30 Hz to 15 kHz 39.2 ¹) MHz \pm 500 Hz, crystal-controlled \leq 50 to \geq 100 mV _{rms} < \pm 0.5 dB, 30 Hz to 15 kHz; ref.: 1 kHz
AF input signal, level Frequency range IF output signal Sound carrier frequency Output level ²) Modulation frequency response flatness Modulation distortion	+12 dBm for 0 to 100% modulation, continuously adjustable 30 Hz to 15 kHz 39.2^1) MHz \pm 500 Hz, crystal-controlled \leq 50 to \geq 100 mV _{rms} $<\pm$ 0.5 dB, 30 Hz to 15 kHz; ref.: 1 kHz \leq 1% (up to 90% modulation)
AF input signal, level Frequency range IF output signal Sound carrier frequency Output level ²) Modulation frequency response flatness	+12 dBm for 0 to 100% modulation, continuously adjustable 30 Hz to 15 kHz 39.2^1) MHz \pm 500 Hz, crystal-controlled \leq 50 to \geq 100 mV _{rms} $<\pm$ 0.5 dB, 30 Hz to 15 kHz; ref.: 1 kHz \leq 1% (up to 90% modulation)

SB Generator SBUF-E3

Frequency range	30 to 48 MHz
Frequency setting	manual or swept
Sweep width	
Sweep time, switch-selected	1 or 10 s (triangular)
Nominal output level	
	vision carrier at summing output
Setting range	approx. ±3 dB,
	carrier can be disabled;
	can be controlled from SBUF-E4
Frequency response flatness	
Harmonics	
Output for triangular signal	$\pm 5 \text{ V} \pm 5\%$; Z _{out} approx 1 k Ω

Program Selector SBUF-E4

Coupling network for vision,			
sound and SB signals	passive, attenuato	rs selected with	th program
	buttons or externa	ally	
Program types	5 static programs	olus normal op	eration, see
	text		
Levels for the different progra	ms		
Program	Vision	Sound	Sideband
	carrier	carrier	

	Carrier	Carner	
IM	0 dB	-10 dB	off
IM/K	-8 dB	-10 dB	-16.5 dB
IM/B	-5.5 dB	-11.5 dB	-11.5 dB
LIN 1	-2.5/-8 dB*)	-10 dB	-32 dB
LIN 2	-2.5/-20 dB*)	-10 dB	-32 dB
DYN	0 dB	-10 dB	off
	*) alternating ever	y 2 s	
External program coloction	by TTL lovel: 0 -	a ativa	

External program selection ... by TTL level: 0 = active

Sound Modulator SBUF-E5 same as E2

Video Generator SBUF-E6

Pulse generator	node H+V	
System	525 lines	525 lines
Colour subcarrier frequency	50 Hz	15.750 kHz ±0.1% 60 Hz 3.579545 MHz ±10 Hz
CVS output signal (data commo Picture component,	n to the signals liste	ed below)
switch-selected	0.7/0.22 V (0/-10	dB)
S component, fixed		
Output (front panel)		
	>50 dB (peak measi bedestal, ref. to 0.7	
Rise and fall times	200 ns -10/+20 ns	;

Please enquire for different frequencies.
 Separate IF outputs for vision and sound carriers if separate Channel Unit SBTF 2 is used; IF summing output for Transposer Unit SBUF.

250-kHz squarewave
Πit≦1%
Synchronization
1.0.0.0.0.0.0.0.0.0.0.0.0.0.0.0.0.0.0.0
/ squarewave
filt≦1%
I squarewave and 2T pulse
Squarewave (duration)
Tilt/overshoot $\ldots \le 1\%/\le 2\%$
27 pulse, switch-selected normal/inverted position
r puise, switch-selected
Sawtooth with superimposed RF (CCIR signal No. 3)
Sawtooth signal (duration)
edge
Superimposed colour subcarrier 100 mV/32 mV \pm 10% (corresponding
to picture component 0/-10 dB)
Diff. gain/phase≦0.2%/≦0.3°
Andersteller ber andersteller at
Pedestal plus external signal
nput signal
Frequency response flatness <= <±0.1 dB (50 Hz to 6 MHz)
nput (front panel)
Blanking
edge
Grey pedestal, adjustable 30 to 100% picture component
Signal selection by pushbuttons or external signal
(TTL level when inserted in compart-
ment 3)
Accessories supplied 75-Ω cable, BNC, 0.5 m long

TV Dual-sound Coder SBUF-E7

$\begin{array}{llllllllllllllllllllllllllllllllllll$
AF output signals (coded) +6 dBm (Nominal) signal level +6 dBm Frequency response flatness <±0.5 dB (40 Hz to 15 kHz)
Crosstalk dual sound/stereo
Pilot carrier in sound channel 2 Pilot level -15.6 dBm, ±6 dB adjustable (corresponding to deviation ±2.5 kHz) Pilot frequency 54.6875 kHz (= 3.5 f _H) Frequency stabilization 54.6875 kHz (= 3.5 f _H)
with vision modulation synchronized with line frequency $f_{\rm H}$ without vision modulation accurate to within $\pm 5~Hz$
Operating mode identification pilot carrier amplitude-modulated with identification frequency
$ \begin{array}{llllllllllllllllllllllllllllllllllll$
Accessories supplied female multipoint connector for use with Sound Modulators

Specifications Transposer Unit SBUF

Frequency and level $\begin{array}{l} 38.9 \quad \text{MHz} \pm 7 \; \text{MHz} \\ 45.75 \; \text{MHz} \pm 6 \; \text{MHz} \\ 32.7 \; \text{MHz} \pm 7 \; \text{MHz} \\ \text{see Modulator Unit} \\ (combinations possible, see ordering information) \\ 200 \; \text{mV} \pm 0.5 \; \text{dB} \\ \text{BNC female connector on rear panel,} \\ Z_{in} = 50 \; \Omega, \; \text{return loss} \geqq 20 \; \text{dB} \\ \end{array}$ Input frequency range Nominal input level Output frequency f_{out} with $f_{in} = IF_{vision}$ 25 to 1000 MHz continuous tuning Frequency stabilization 25 to 1000 MHz continuous tuning range Output frequency indication APC with indicator, switched 0 utput frequency indication 1. with APC via counter, accurate to 10 kHz ±1 kHz 2. without APC via A/D converter and digital voltmeter, error <±10 MHz</td> Gain from input to output adjustable from -6 to 0 dB Frequency-response flatness 50 dB ≦2 dB with AGC ≦6 dB with manual setting of gain

within $f_{out} \pm 7$ MHz of output frequency .

 $\leq \pm 0.5 \, dB, \pm 0.2 \, dB \, typ$, channel-dependent

TV TEST TRANSMITTERS



Output level	Weight of Modulator Unit 19" bench model 17 kg
in steps of 1 and 10 dB by calibrated attenuator Error of output attenuator fine ≦±0.2 dB	Mod 21 k 19" rackmount
coarse ≦±0.5 dB	Mod
Output N female connector, adaptable; $Z_{out} = 50 \Omega$, return loss $\ge 6 dB$ with output attenuator set to 0 dB, or BNC	19 k Weight of Transposer Unit
female connector; $Z_{out} = 75 \Omega$ (with matching pad)	
Monitor outputs for local oscillators	
connectors on rear panel Nominal frequency of first LO 70.366833 MHz	Ordering information
Nominal frequency of second LO and timebase 100.00000 MHz	Modulator Unit SBUF/SBTF 2
Oscillator-frequency adjustment $\ge 5 \times 10^{-6}$ with rear-panel potentio-	The basic version comprises the Modulator
meters Effect of crystal aging	supply, fitted with the Vision Modulator SBL SBUF-E2 (sound 1).
Input for tuning signal I	Order designations
Input for tuning signal II 0 to 5 V for 0 to 1000 MHz	Modulator M
Transmission characteristics	Standard 19 B/G – general 34
Spurious signals with vision/sound ratio of 10:1 (gain −6 dB) Spurious emissions	B/G – general – CATV
Vision carrier – 5.5 MHz and	B/G – Ňorway 34 B/G – Sweden (A) 34
+11 MHz ≧56 dB down, 60 dB typ, Crossmodulation products ≧70 dB down	B/G – Denmark
Harmonics ≧40 dB down	B/G – Australia 34 B/G – New Zealand 34
Spurious signals outside tuning range	D/K - CCIR Rep 308
Video signal-to-noise ratio at 0 dB gain, referred to black-to-white transition	D/K – Czechoslovakia/Hungary 34
0.1 to 5 MHz (noise) ≥60 dB (rms)	I – South Africa 34
0 to 1 kHz (hum)≧56 dB (peak-to-peak) Audio signal-to-noise ratio up to 15 kHz	L – France
(with pre- and deemphasis) ≥ 66 dB, referred to 40-kHz deviation	M – 38.9 MHz
Frequency counter	Accessories supplied
Frequency counter for meas- urement of output frequency switched external/internal	powe
Frequency range for ext, use 25 to 300 MHz	Recommended extras
Input voltage 50 mV _{ms} to 1 V _{ms} into 50 Ω	SB Generator SBUF-E3
Input 50 Ω, BNC female connector (front	Program Selector SBUF-E4
panel) Frequency of timebase	Sound Modulator (sound 2) SBUF-E5 for B/G (33.158 MHz)

CATV Broadband Amplifier AKF (option)

Frequency range	
Gain	27 ±1 5 dB
Frequency-response flatness	$\leq \pm 1$ dB, for ± 7 MHz: $\leq \pm 0.3$ dB
Output level	$\leq 2 V_{\rm rms}$ into 50 or 75 Ω
	corresponding to 126 dB(µV)
Spurious components	for $V_{out} = 1 V$ 2 V
Spurious signals, vision/sound	
ratio 10:1	≧56 dB down ≧50 dB down
Intermodulation products	
(DIN 45 004 K)	≧70 dB down ≧66 dB down
Harmonics	≧30 dB down
Noise figure	≦14 dB
Input (front or rear panel)	50 or 75 Ω; BNC
Return loss	≧20 dB
Output (front or rear panel)	50 or 75 Ω; BNC
Return loss	≧10 dB
Checking of output level	meter, 120 to 126 dB(uV)
AC supply	
	492 mm×116 mm×514 mm, 5.4 kg

General data

Rated temperature range
Operating temperature range +5 to +45 °C
Storage temperature range -20 to $+70$ °C
Connectors on Modulator Unit (rear panel)
IF summing output (BNC) 2 for modulator configuration
1 for channel transmitter configuration
Return loss ≧18 dB, 30 to 48 MHz
Monitoring output for vision carrier, 50 Ω, BNC
Video input loop-through filter, BNC; see SBUF-
E1
AF/control/status lines
AC supply 110/125/220/235 V +10/-15%,
47 to 63 Hz
Power consumption Modulator Unit 70 VA for Vision and Sound Mod-
ulators, 125 VA for fully equipped
frame
Transposer Unit
Overall dimensions (W×H×D)
19" bench model (design 80) 492 mm×161 mm×514 mm
19" rackmount

Neight of Modulator Unit	
19" bench model	17 kg fitted with Vision and Sound
	Modulators,
	21 kg fully equipped
19" rackmount	15 kg fitted with Vision and Sound
	Modulators,
	19 kg fully equipped
Neight of Transposer Unit	25 kg

or Frame SBUF-B plus the power BUF-E1 and the Sound Modulator

Modulator	Modulator Unit	SBUF/SBTF 2
Standard	19" rackmount	19" bench model
B/G – general	341-0014.11	341.0014.12
B/G – general – CATV	341-0014.41	341 0014 42
B/G – Norway	341 0014 81	341.0014.82
B/G - Sweden (A)	341.0014.83	341.0014.84
B/G – Denmark	341.0014.85	341.0014.86
B/G – Australia	341 0014 87	341.0014.88
B/G – New Zealand	341.0014.89	341.0014.90
D/K - CCIR Rep 308	341 0214 11	341.0214.12
D/K - Czechoslovakia/Hungary	341 0214 15	341.0214.16
I – Great Britain	341.0414.11	341.0414.12
I – South Africa	341.0414.13	341.0414.14
L – France	341.0814.11	341.0814.12
M – 38.9 MHz	341.0614.11	341.0614.12
M – 45.75 MHz – CATV	341.0614.41	341.0614.42

mination 124.0324.00, wer cord 025.2365.00

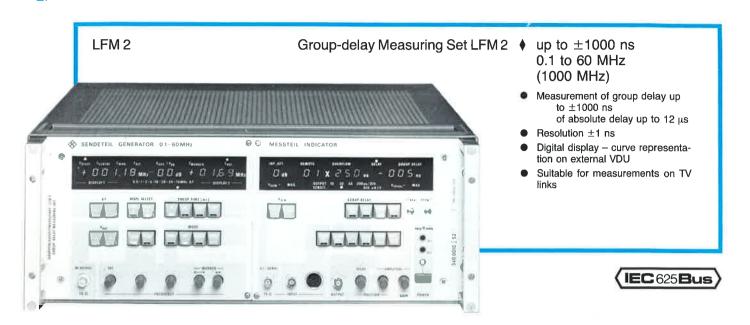
SB Generator SBUF-E3 Program Selector SBUF-E4	294.6416.00 294.7012.00	
Sound Modulator (sound 2) SBUF-E B/G (33.158 MHz)	5 for standard 294,7312.00	
D/K	294.7512.00	please specify
П	294.7412.00 294.7612.10	<pre>sound carrier frequency</pre>
M – CATV) carrier frequency
Video Generator SBUF-E6 625-line standard (CCIR)	340.8211.76	
525-line standard (FCC)	340 8211 75	
TV Dual-sound Coder SBUF-E7	241 3812 00	
Adapter cables for servicing		
13-way	341 5274 00	
21-way	294 1420 00	
50-Ω cable	341 5245 00 mended)	(2 cables recom-

Transposer Unit SBUF

Order designations	Transp	ooser Unit SBUI	F
Transposer section (one IF of	only):		
IF _{vision} MHz 38.9 ¹) 19" bench model	38.9 ²)	45,75	32.7 ²)
50 Ω 292.8011.52 75 Ω 292.8011.72	292.8011.58 292.8011.78	293 8215 52 293 8215 72	293.8415.56 293.8415.76
19" rackmount 50 Ω 292.8011.51 75 Ω 292.8011.71	292.8011.57 292.8011.77	293.8215.51 293.8215.71	293.8415.55 293.8415.75
Transposer section, two-star	dard version (IF	switch-selecte	d):
IF _{vision 1} /IF _{vision 2} MHz 19" bench model 50 Ω 75 Ω	38.9/45.75 292.8011.54 292.8011.74	38.9/32.7 292.8011.56 292.8011.76	293.8215.56
19" rackmount 50 Ω 75 Ω	292 8011 73		
 Please enquire for IF_{vision} = 38.0 MHz Can be switch-selected to lower or upper sideband. 			
Please enquire for further star	dards and spec	cial versions	
Accessories supplied			
Recommended extras			
CATV Broadband Amplifier Ak Input 50 Ω, output 50 Ω Input 50 Ω, output 75 Ω Input 75 Ω, output 75 Ω	262.901 262.901	0 52 0 72	
30-way female connector Three-way male connector	063 977	0.00 (with shell	

GROUP-DELAY MEASURING SETS

appendix



The **Group-delay Measuring Set LFM2** is used to determine the group delay and the absolute delay of active and passive two-port networks; it is also suitable for measurements on TV systems with line sync pulses (measurements with field-sync pulses are possible if certain restrictions are acceptable for the DELAY mode) and on **TV links.** Compensation of absolute delay is automatic. Fitted with the IEC-bus Option LFM2-B (IEC 625-1; IEEE 488), the LFM2 can be used in **automatic test assemblies.**

Configuration. The LFM2 consists of the

Generator with

a frequency range of 0.1 to 60 MHz (which can be extended to 1000 MHz by using the TV Transcope MUF2, Mixer MUF2-Z2 and Wideband Demodulator LFM2-Z1), digital frequency indication and the

Indicator with

a probe-frequency generator (20 kHz, test and reference signals),

a phase meter (digital readout, chopper for simultaneous display of delay and amplitude on external VDU), demodulator (0.1 to 60 MHz).

Measuring principle. The Group-delay Measuring Set LFM2 uses the probe-frequency method. The RF carrier is amplitude-modulated with the 20-kHz probe-frequency signal. After passing through the item under test, the signal is demodulated and the phase difference between the demodulated probe frequency and the 20-kHz reference signal determined. The LFM2 uses two different measuring methods:

Method A. The reference signal is routed via the item under test. This offers the following advantages:

- Compensation of the absolute delay is not required.
- Measurements on TV links are possible.
- A high measuring accuracy is achieved.

Method B. The reference signal is taken directly to the phase meter (measurements on TV links are not possible). This offers the following advantages:

- The absolute delay is indicated and can be compensated.
- Measurements can be performed with separate generators modulated with the probe frequency.

The TV Transcope MUF 2, which is designed for simple connection to the LFM 2, can be used to extend the operating frequency range up to 1000 MHz and as a VDU.

Output signals. For display on a VDU, the group-delay and frequency-response characteristics are available separately or in chopped form. The LFM2 supplies a 200-ns squarewave signal for calibrating the VDU.

TV system measurements. If the LFM 2 is used for measurements on TV systems requiring sync pulses for operation (e.g. TV transmitters), the test signal must be added to a TV sync signal (comprising the sync plus blanking components) using an external video mixer. Evaluation in the Indicator is performed with the TV button pressed.

Digital readout. Two displays are provided on the Generator to permit indication of the frequencies, which are



Digital display on Generator: Display 1: either start, centre, reference or manually set frequency; display 2: either marker or reference frequency; centre, top: output level; centre, bottom: selected sweep

INP. ATT.		VERFLOW		GROUP DELAY
[] dB	$\Box + \mathbf{x}$	2.5 0 m	- 0	0 5 ns
VOIM - MAX	OUTPUT IS	28 55 200 ms/	01V. V284	NZ MAX

Digital display on Indicator: From left: input attenuation of wideband demodulator, absolute or group delay; centre, bottom: set scale of delay signal output for display on CRT

GROUP-DELAY MEASURING SETS



freely selectable within the sweep range (see page 350, bottom left).

When using method A, the group-delay difference between the reference signal and the selected frequency (point-bypoint measurements) or the marker frequency highlighted on the display (swept operation) is indicated on the readout.

When using method B, the absolute delay at the selected frequency in the manual mode or the marker frequency unblanked on the CRT in the sweep mode is displayed on the indicator after pressing the DELAY button. The absolute delay of the test item is determined by subtracting the value previously measured with the test item shorted across. The maximum absolute delay that can be measured is $12 \,\mu s$.

TV link measurements. For measurements on TV transmission links two LFM2 sets are required. All the signals required for the test sequence at the receiver end are transmitted via the link.

Additional characteristics

An ALC circuit in the **Generator** ensures that the level value is maintained at any frequency.

The probe-frequency generator in the **Indicator** produces the crystal-controlled probe (20 kHz), reference (20 kHz) and identification (10 kHz) frequencies.

The phase meter included in the Indicator delivers the reference signal (20 kHz) with crystal accuracy and keeps it in phase with the transmitted probe-frequency signal (method A).

The generator-output and the demodulation signals can be adjusted via calibrated attenuators. An overload indicator (LED) permits the signal coming from the item under test to be kept at the optimum level for driving the demodulator.

Extras

Wideband Demodulator LFM 2-Z1 (10 to 1000 MHz) for AF and probe-frequency signals

Video Filter LFM 2-Z2 (cutoff frequency 200 Hz) to eliminate interference at the delay measuring output (swept-frequency measurements only with 160 and 320 ms)

Mixer MUF 2-Z2 for measurements on TV transposers

XY Recorder Adapter LFM2-Z3 (for instance for XYT Recorder ZSKT)

Impedance Transformer SBTF 2-Z for measuring instruments with a characteristic impedance of 50 Ω

Amplifier MUF 2-Z3 for boosting the test item output voltage by 27 dB

IEC-bus Option LFM 2-B (24-pole connector to IEEE 488)

Specifications

Generator

Frequency range	0.1 to 60 MHz (can be extended up to
	1000 MHz by MUF 2)
Sweep range	-10 to +60 MHz
Sweep width (adjustable)	0.5/1/2/5/10/20/50/70 MHz

Frequency setting within sweep range	start or centre frequency, frequency
Resolution of readout	marker (brightup marker on VDU).
Headout accuracy	$\leq \pm 1.5 \text{ kHz} \pm 1 \text{ diait}$
Output voltage	$\begin{array}{c} 1\pm 0.05 \ V_{pp} \ (\text{stabilized}) \\ 30 \pm 0.5 \ \text{dB in steps of } 2 \pm 0.01 \ \text{dB} \\ \geqq 40 \ \text{dB down} \end{array}$
Harmonics	≧40 dB down
FM noise	≦1 kHz probe frequency (approx. 60% mod.)
I OIAI SWEED TIMES	. 40/80/160/320 ms
Control signal for VDU	0 to +10 V or -10 V (sawtooth), adjustable by -10 dB
Indicator	
Probe-frequency generator	
Probe frequency	20 kHz ±5×10-6
Reference signal	10 kHz +5×10-6
Output voltage	1 Vm ±5%
Output impedance	75 Ω ±5%
Phase meter Measurement range	±1 to ±1000 ns
Indication	3 ¹ / ₂ digits with ± display
Error Output signal for VDU	10/20/50/200 ns
Input voltage range Probe frequency	8 mV to 0.8 V-
Probe frequency	25 mV _{pp} to 0.8 V _{pp}
Identification pulse frequency Delay error in input voltage range	25 mV _m to 0.8 V _m
	80 to 24 mV; ±10 ns
Compensation of absolute delay	In 250-ns steps
Demodulator Frequency range	0.1 to 60 MHz
Input voltage range Group-delay error in the case of	2 V _{pp} to 50 mV _{pp}
input voltage variation of 10 dB	
20 dB	≦20 ns 100 kHz to 15 MHz: ≤+2 ns
Input attenuator	15 to 60 MHz: ≦±5 ns
	in 1 dB stone +0.1 dB
Input impedance	75 Ω
11010111035	20 to 60 MHz: ≧30 dB
Extras	
Widebond Demodulates EM 2, 71	
Wideband Demodulator LFM 2-Z1	
Max. input voltage	≦5 V _{ms} , ≦10 V DC
Max. input voltage for group-delay measurement Group-delay error	≦5 V _{ms} , ≦10 V DC ≧1 V _{ms} ≦10 ns/100 MHz (10 to 1000 MHz)
Max. input voltage for group-delay measurement Group-delay error	≦5 V _{ms} , ≦10 V DC ≧1 V _{ms} ≦10 ns/100 MHz (10 to 1000 MHz) ≦50 ns over total range
Max. input voltage . for group-delay measurement Group-delay error Connector, RF input	
Max. input voltage . for group-delay measurement Group-delay error . Connector, RF input Video Filter LFM 2-Z2 Attenuation in passband	$ \begin{array}{l} \leq 5 \ V_{rms}, \ \leq 10 \ V \ DC \\ \geq 1 \ V_{rms} \\ \leq 10 \ ns \ / \ 100 \ MHz \ (10 \ to \ 1000 \ MHz) \\ \leq 50 \ ns \ over \ total \ range \\ N \ female; \ 50 \ \Omega \\ cutoff \ frequency; \ 200 \ Hz \\ 0 \ dB \ +0.2 \ dB \end{array} $
Max. input voltage . for group-delay measurement Group-delay error Connector, RF input	$ \begin{split} & \leq 5 \ V_{rms}, \ \leq 10 \ V \ DC \\ & \geq 1 \ V_{rms} \\ & \leq 10 \ ns \ / \ 100 \ MHz \ (10 \ to \ 1000 \ MHz) \\ & \leq 50 \ ns \ over \ total \ range \\ & N \ female; \ 50 \ \Omega \\ & cutoff \ frequency: \ 200 \ Hz \\ & 0 \ dB \ \pm 0.2 \ dB \\ & 5-pole \ male; \ F_{in} < 100 \ \Omega \end{split} $
Max. input voltage . for group-delay measurement Group-delay error . Connector, RF input . Video Filter LFM 2-22 . Attenuation in passband . Connectors, input . output . XY Recorder Adapter LFM 2-23 .	
Max. input voltage . for group-delay measurement Group-delay error . Connector, RF input . Video Filter LFM 2-22 . Attenuation in passband . Connectors, input . output . XY Recorder Adapter LFM 2-23 .	
Max. input voltage . for group-delay measurement Group-delay error . Connector, RF input . Video Filter LFM 2-Z2 . Attenuation in passband . Connectors, input . output .	
Max. input voltage . for group-delay measurement Group-delay error . Connector, RF input . Video Filter LFM 2-22 Attenuation in passband . Connectors, input . output . XY Recorder Adapter LFM 2-23 . X output signal . Signal for pen lift . Connectors .	
Max. input voltage . for group-delay measurement Group-delay error . Connector, RF input Video Filter LFM 2-Z2 Attenuation in passband . Connectors, input output . XY Recorder Adapter LFM 2-Z3 X output signal . Signal for pen lift . Connectors . General data	$ \begin{split} & \leq 5 \ V_{rms}, \ \leq 10 \ V \ DC \\ & \geq 1 \ V_{rms} \\ & \leq 10 \ ns \ / 100 \ MHz \ (10 \ to \ 1000 \ MHz) \\ & \leq 50 \ ns \ over \ total \ range \\ & N \ female; \ 50 \ \Omega \\ & cutoff \ frequency: \ 200 \ Hz \\ & 0 \ dB \ \pm 0.2 \ dB \\ & 5-pole \ male; \ R_{in} \ < 100 \ \Omega \\ & BNC \\ & deflection \ time: \ approx. \ 1 \ min \\ & approx. \ 0 \ to \ 5 \ V \\ & TTL \ (polarity \ internally \ switchable) \\ & BNC \ (power \ supply: \ 6-pole) \end{split} $
Max. input voltage . for group-delay measurement Group-delay error . Connector, RF input . Video Filter LFM 2-Z2 . Attenuation in passband . Connectors, input . output . XY Recorder Adapter LFM 2-Z3 . X output signal . Signal for pen lift . Connectors . General data Rated temperature range . Operating temperature range .	$ \begin{split} & \leq 5 \ V_{rms}, \ \leq 10 \ V \ DC \\ & \geq 1 \ V_{rms} \\ & \leq 10 \ ns \ / 100 \ MHz \ (10 \ to \ 1000 \ MHz) \\ & \leq 50 \ ns \ over \ total \ range \\ & N \ female; \ 50 \ \Omega \\ & cutoff \ frequency: \ 200 \ Hz \\ & 0 \ dB \ \pm 0.2 \ dB \\ & 5\text{-pole male; } R_{in} < 100 \ \Omega \\ & BNC \\ & deflection \ time: \ approx. \ 1 \ min \\ approx. \ 0 \ to \ 5 \ V \\ & TTL \ (polarity \ internally \ switchable) \\ & BNC \ (power \ supply: \ 6\text{-pole}) \\ & +5 \ to \ +40 \ ^{\circ}C \\ & 0 \ to \ +45 \ ^{\circ}C \\ \end{split} $
Max. input voltage . for group-delay measurement Group-delay error . Connector, RF input . Video Filter LFM 2-Z2 . Attenuation in passband . Connectors, input . output . XY Recorder Adapter LFM 2-Z3 . X output signal . Signal for pen lift . Connectors . General data Rated temperature range . Operating temperature range . Storage temperature range .	≤5 V _{rms} , ≤10 V DC ≥1 V _{rms} ≤10 ns/100 MHz (10 to 1000 MHz) ≤50 ns over total range N female; 50 Ω cutoff frequency: 200 Hz 0 dB ±0.2 dB 5-pole male; R _{in} <100 Ω BNC deflection time: approx. 1 min approx. 0 to 5 V TTL (polarity internally switchable) BNC (power supply: 6-pole) +5 to +40 °C 0 to +45 °C -20 to +70 °C
Max. input voltage . for group-delay measurement Group-delay error . Connector, RF input . Video Filter LFM 2-Z2 . Attenuation in passband . Connectors, input . output . XY Recorder Adapter LFM 2-Z3 . X output signal . Signal for pen lift . Connectors . General data Rated temperature range . Operating temperature range . Storage temperature range . AC supply .	≤5 V _{rms} , ≤10 V DC ≥1 V _{rms} ≤10 ns/100 MHz (10 to 1000 MHz) ≤50 ns over total range N female; 50 Ω cutoff frequency: 200 Hz 0 dB ±0.2 dB 5-pole male; R _{in} <100 Ω BNC deflection time: approx. 1 min approx. 0 to 5 V TTL (polarity internally switchable) BNC (power supply: 6-pole) +5 to +40 °C 0 to +45 °C -20 to +70 °C
Max. input voltage . for group-delay measurement Group-delay error . Connector, RF input . Video Filter LFM 2-Z2 . Attenuation in passband . Connectors, input . output . XY Recorder Adapter LFM 2-Z3 . X output signal . Signal for pen lift . Connectors . General data Rated temperature range . Operating temperature range . Storage temperature range . AC supply .	$ \begin{split} & \leq 5 \ V_{rms}, \ \leq 10 \ V \ DC \\ & \geq 1 \ V_{rms} \\ & \leq 10 \ ns \ / 100 \ MHz \ (10 \ to \ 1000 \ MHz) \\ & \leq 50 \ ns \ over \ total \ range \\ & N \ female; \ 50 \ \Omega \\ & cutoff \ frequency: \ 200 \ Hz \\ & 0 \ dB \ \pm 0.2 \ dB \\ & 5-pole \ male; \ 50 \ \Omega \\ & 0 \ dB \ \pm 0.2 \ dB \\ & 5-pole \ male; \ F_{in} \ < 100 \ \Omega \\ & BNC \\ & deflection \ time: \ approx. \ 1 \ on \\ & BNC \\ & deflection \ time: \ approx. \ 1 \ min \\ & approx. \ 0 \ to \ V \\ & TTL \ (polarity \ internally \ switchable) \\ & BNC \ (power \ supply: \ 6-pole) \\ & +5 \ to \ + 40 \ ^{\circ}C \\ & 0 \ to \ + 45 \ ^{\circ}C \\ & -20 \ to \ + 70 \ ^{\circ}C \\ & 115/125/220/235 \ V \ + 10/-15\%, \\ & 47 \ to \ 63 \ Hz \ (110 \ VA) \\ \end{split} $
Max. input voltage . for group-delay measurement Group-delay error . Connector, RF input . Video Filter LFM 2-Z2 . Attenuation in passband . Connectors, input . output . XY Recorder Adapter LFM 2-Z3 X output signal . Signal for pen lift . Connectors . General data Rated temperature range Operating temperature range Storage temperature range Storage temperature range AC supply Dimensions, weight 19" bench model (design 80)	≤5 V _{rms} , ≤10 V DC ≥1 V _{rms} ≤10 ns/100 MHz (10 to 1000 MHz) ≤50 ns over total range N female; 50 Ω cutoff frequency: 200 Hz 0 dB ±0.2 dB 5-pole male; R _{in} <100 Ω BNC deflection time: approx. 1 min approx. 0 to 5 V TTL (polarity internally switchable) BNC (power supply: 6-pole) +5 to +40 °C 0 to +45 °C -20 to +70 °C 115/125/220/235 V +10/-15%,
Max. input voltage . for group-delay measurement Group-delay error . Connector, RF input . Video Filter LFM 2-Z2 . Attenuation in passband . Connectors, input output . XY Recorder Adapter LFM 2-Z3 . X output signal . Signal for pen lift . Connectors . General data Rated temperature range Operating temperature range Storage temperature range AC supply . Dimensions, weight 19" bench model (design 80) 19" rackmount	≤5 V _{rms} , ≤10 V DC ≥1 V _{rms} ≤10 ns/100 MHz (10 to 1000 MHz) ≤50 ns over total range N female; 50 Ω cutoff frequency: 200 Hz 0 dB ±0.2 dB 5-pole male; R _{in} <100 Ω BNC deflection time: approx. 1 min approx. 0 to 5 V TTL (polarity internally switchable) BNC (power supply: 6-pole) +5 to +40 °C 0 to +45 °C -20 to +70 °C 115/125/220/235 V +10/-15%, 47 to 63 Hz (110 VA) 492 mm×205 mm×514 mm, 18 kg
Max. input voltage . for group-delay measurement . Group-delay error . Connector, RF input . Video Filter LFM 2-Z2 . Attenuation in passband . Connectors, input . output . XY Recorder Adapter LFM 2-Z3 . X output signal . Signal for pen lift . Connectors . General data Rated temperature range . Operating temperature range . Storage temperature range . Storage temperature range . AC supply . Dimensions, weight . 19" bench model (design 80)	
Max. input voltage . for group-delay measurement . Group-delay error . Connector, RF input Video Filter LFM 2-Z2 Attenuation in passband Connectors, input output XY Recorder Adapter LFM 2-Z3 . X output signal Signal for pen lift Connectors General data Rated temperature range Operating temperature range Storage temperature range Storage temperature range AC supply Dimensions, weight 19" bench model (design 80) 19" rackmount Ordering information Order designation .	Solution State S
Max. input voltage . for group-delay measurement . Group-delay error . Connector, RF input . Video Filter LFM 2-Z2 . Attenuation in passband . Connectors, input . output . XY Recorder Adapter LFM 2-Z3 . X output signal . Signal for pen lift . Connectors . General data Rated temperature range . Operating temperature range . Storage temperature range . Storage temperature range . AC supply . Dimensions, weight . 19" bench model (design 80)	≤5 V _{rms} , ≤10 V DC ≥1 V _{rms} ≤10 ns /100 MHz (10 to 1000 MHz) ≤50 ns over total range N female; 50 Ω cutoff frequency: 200 Hz 0 dB ±0.2 dB 5-pole male; R _{in} <100 Ω BNC deflection time: approx. 1 min approx. 0 to 5 V TTL (polarity internally switchable) BNC (power supply: 6-pole) +5 to +40 °C 0 to +45 °C -20 to +45 °C -20 to +45 °C 115/125/220/235 V +10/-15%, 47 to 63 Hz (110 VA) 492 mm×205 mm×514 mm, 18 kg 483 mm×177 mm×506 mm, 14 kg
Max. input voltage . for group-delay measurement . Group-delay error . Connector, RF input . Video Filter LFM 2-Z2 . Attenuation in passband . Connectors, input . output . XY Recorder Adapter LFM 2-Z3 . X output signal . Signal for pen lift . Connectors . General data Rated temperature range . Operating temperature range . Storage temperature range . Storage temperature range . AC supply . Dimensions, weight 19" bench model (design 80)	≤5 V _{ms} , ≤10 V DC ≥1 V _{ms} ≤10 ns /100 MHz (10 to 1000 MHz) ≤50 ns over total range N female; 50 Ω cutoff frequency: 200 Hz 0 dB ±0.2 dB 5-pole male; R _{in} <100 Ω BNC deflection time: approx. 1 min approx. 0 to 5 V TTL (polarity internally switchable) BNC (power supply: 6-pole) +5 to +40 °C 0 to +45 °C -20 to +70 °C 115/125/220/235 V +10/−15%, 47 to 63 Hz (110 VA) 492 mm×205 mm×514 mm, 18 kg 483 mm×177 mm×506 mm, 14 kg • Group-delay Measuring Set LFM 2 19" bench model 19" rackmount 340.0010.72 340.0010.71 340.0010.74 340.0010.73
Max. input voltage . for group-delay measurement . Group-delay error . Connector, RF input . Video Filter LFM 2-Z2 . Attenuation in passband . Connectors, input . output . XY Recorder Adapter LFM 2-Z3 . X output signal . Signal for pen lift . Connectors . General data Rated temperature range . Operating temperature range . Storage temperature range . Storage temperature range . AC supply . Dimensions, weight 19" bench model (design 80) . 19" rackmount . Ordering information Order designation . Line frequency 15,625 Hz . 15,750 Hz . Recommended extras . Wideband Demodulator	$ \begin{split} & \leq 5 \ V_{rms}, \leq 10 \ V \ DC \\ & \geq 1 \ V_{rms} \\ & \leq 10 \ ns \ /100 \ MHz \ (10 \ to \ 1000 \ MHz) \\ & \leq 50 \ ns \ over \ total \ range \\ & N \ female; \ 50 \ \Omega \\ & cutoff \ frequency: \ 200 \ Hz \\ & 0 \ dB \ \pm 0.2 \ dB \\ & \leq 50 \ ns \ over \ total \ range \\ & 0 \ dB \ \pm 0.2 \ dB \\ & \leq 50 \ ns \ over \ total \ range \\ & 0 \ dB \ \pm 0.2 \ dB \\ & \leq 50 \ ns \ over \ total \ range \\ & Some \ range \ range \\ & Some \ range \ range \\ & Some \ range \ range \ range \ range \ range \\ & Some \ range \ ra$
Max. input voltage . for group-delay measurement . Group-delay error . Connector, RF input . Video Filter LFM 2-Z2 . Attenuation in passband . Connectors, input . output . XY Recorder Adapter LFM 2-Z3 . X output signal . Signal for pen lift . Connectors . General data Rated temperature range . Operating temperature range . Storage temperature range . Storage temperature range . AC supply . Dimensions, weight 19" bench model (design 80)	$ \begin{split} & \leq 5 \ V_{rms}, \leq 10 \ V \ DC \\ & \geq 1 \ V_{rms} \\ & \leq 10 \ ns \ /100 \ MHz \ (10 \ to \ 1000 \ MHz) \\ & \leq 50 \ ns \ over \ total \ range \\ & N \ female; \ 50 \ \Omega \\ & cutoff \ frequency: \ 200 \ Hz \\ & 0 \ dB \ \pm 0.2 \ dB \\ & 5-pole \ male; \ 50 \ \Omega \\ & cutoff \ frequency: \ 200 \ Hz \\ & 0 \ dB \ \pm 0.2 \ dB \\ & 5-pole \ male; \ 50 \ \Omega \\ & S-pole \ male; \ F_{in} \ < 100 \ \Omega \\ & BNC \\ & deflection \ time: \ approx. \ 1 \ min \\ & approx. \ 0 \ to \ 5 \ V \\ & TTL \ (polential ty \ internally \ switchable) \\ & BNC \ (power \ supply: \ 6-pole) \\ & +5 \ to \ +40 \ ^{\circ}C \\ & -20 \ to \ +70 \ ^{\circ}C \\ & 115/125/220/235 \ V \ +10/-15\%, \\ & 47 \ to \ 63 \ Hz \ (110 \ VA) \\ & 492 \ mm \times 205 \ mm \times 514 \ mm, \ 18 \ kg \\ & 483 \ mm \times 177 \ mm \times 506 \ mm, \ 14 \ kg \\ & \bullet \ Group-delay \ Measuring \ Set \ LFM \ 2 \\ & 19' \ bench \ model \ 19'' \ rackmount \\ & 340.0010.72 \ \ 340.0010.73 \\ & LFM \ 2-Z1 \ \ 340.6302.53 \\ & LFM \ 2-Z2 \ \ 349.8820.50 \\ \end{split}$
Max. input voltage . for group-delay measurement . Group-delay error . Connector, RF input . Video Filter LFM 2-Z2 . Attenuation in passband . Connectors, input . output . XY Recorder Adapter LFM 2-Z3 . X output signal . Signal for pen lift . Connectors . General data Rated temperature range . Operating temperature range . Storage temperature range . Storage temperature range . AC supply . Dimensions, weight 19" bench model (design 80) . 19" rackmount . Order designation . Line frequency 15,625 Hz . 15,750 Hz . Recommended extras . Wideband Demodulator . Video Filter . Mixer . XY Recorder Adapter . Impedance Transformer .	$ \begin{split} & \leq 5 \ V_{rms}, \leq 10 \ V \ DC \\ & \geq 1 \ V_{rms} \\ & \leq 10 \ ns \ /100 \ MHz \ (10 \ to \ 1000 \ MHz) \\ & \leq 50 \ ns \ over \ total \ range \\ & N \ female; \ 50 \ \Omega \\ & cutoff \ frequency: \ 200 \ Hz \\ & 0 \ dB \ \pm 0.2 \ dB \\ & \leq 50 \ ns \ over \ total \ range \\ & N \ female; \ 50 \ \Omega \\ & cutoff \ frequency: \ 200 \ Hz \\ & 0 \ dB \ \pm 0.2 \ dB \\ & \leq 50 \ ns \ over \ total \ range \\ & Some \ range \ range \ range \\ & Some \ range \ rang$
Max. input voltage . for group-delay measurement . Group-delay error . Connector, RF input . Video Filter LFM 2-Z2 . Attenuation in passband . Connectors, input . output . XY Recorder Adapter LFM 2-Z3 . X output signal . Signal for pen lift . Connectors . General data . Rated temperature range . Operating temperature range . Storage temperature range . AC supply . Dimensions, weight . 19" bench model (design 80)	$ \begin{split} & \leq 5 \ V_{rms}, \leq 10 \ V \ DC \\ & \geq 1 \ V_{rms} \\ & \leq 10 \ ns \ /100 \ MHz \ (10 \ to \ 1000 \ MHz) \\ & \leq 50 \ ns \ over \ total \ range \\ & N \ female; \ 50 \ \Omega \\ & cutoff \ frequency: \ 200 \ Hz \\ & \leq 50 \ ns \ over \ total \ range \\ & N \ female; \ 50 \ \Omega \\ & cutoff \ frequency: \ 200 \ Hz \\ & \leq 50 \ ns \ over \ total \ range \\ & S \ over \ total \ range \\ & S \ over \ total \ range \\ & S \ over \ total \ range \\ & S \ over \ total \ range \\ & S \ over \ total \ range \\ & S \ over \ total \ range \\ & S \ over \ total \ range \\ & S \ over \ total \ range \\ & S \ over \ total \ range \\ & S \ over \ supply: \ 200 \ Hz \\ & S \ over \ supply: \ 6 \ over \ supply: \ supply: \ supply: \ 6 \ over \ supply: \ 6 \ over \ supply: \ supply: \ supply: \ suppl$
Max. input voltage . for group-delay measurement . Group-delay error . Connector, RF input . Video Filter LFM 2-Z2 . Attenuation in passband . Connectors, input . output . XY Recorder Adapter LFM 2-Z3 . X output signal . Signal for pen lift . Connectors . General data Rated temperature range . Operating temperature range . Storage temperature range . Storage temperature range . AC supply . Dimensions, weight 19" bench model (design 80) . 19" rackmount . Ordering information Order designation . Line frequency 15,625 Hz . 15,750 Hz . Storage Titer . Niker . XY Recorder Adapter . Impedance Transformer . Amplifier . IEC-bus Option, for LFM 2 with Serial Nos. 871739 and 300 974 .	$ \begin{split} & \leq 5 \ V_{rms}, \leq 10 \ V \ DC \\ & \geq 1 \ V_{rms} \\ & \leq 10 \ ns \ /100 \ MHz \ (10 \ to \ 1000 \ MHz) \\ & \leq 50 \ ns \ over \ total \ range \\ & N \ female; \ 50 \ \Omega \\ & cutoff \ frequency: \ 200 \ Hz \\ & 0 \ dB \ \pm 0.2 \ dB \\ & \leq 50 \ ns \ over \ total \ range \\ & 0 \ dB \ \pm 0.2 \ dB \\ & \leq 50 \ ns \ over \ total \ range \\ & 0 \ dB \ \pm 0.2 \ dB \\ & \leq 50 \ ns \ over \ total \ range \\ & 0 \ dB \ \pm 0.2 \ dB \\ & \leq 50 \ ns \ over \ total \ range \\ & 0 \ dB \ \pm 0.2 \ dB \\ & \leq 50 \ ns \ over \ total \ range \\ & 0 \ dB \ \pm 0.2 \ dB \\ & \leq 50 \ ns \ over \ total \ range \\ & = 10 \ ns \ vert \ total \ range \\ & = 10 \ ns \ vert \ total \ range \\ & = 10 \ ns \ vert \ total \ range \\ & = 10 \ ns \ vert \ total \ range \\ & = 10 \ ns \ vert \ total \ range \\ & = 10 \ ns \ vert \ total \ range \\ & = 10 \ ns \ vert \ total \ range \\ & = 10 \ ns \ vert \ total \ range \\ & = 10 \ ns \ vert \ total \ range \\ & = 10 \ ns \ range \\ & = 10 \ range \ ran$
Max. input voltage . for group-delay measurement . Group-delay error . Connector, RF input . Video Filter LFM 2-Z2 Attenuation in passband . Connectors, input . output . XY Recorder Adapter LFM 2-Z3 . X output signal . Signal for pen lift . Connectors . General data Rated temperature range . Operating temperature range . Operating temperature range . Storage temperature range . AC supply . Dimensions, weight 19° bench model (design 80) 19° rackmount . Ordering information Order designation . Line frequency 15,625 Hz	$ \begin{split} & \leq 5 \ V_{rms}, \leq 10 \ V \ DC \\ & \geq 1 \ V_{rms} \\ & \leq 10 \ ns \ /100 \ MHz \ (10 \ to \ 1000 \ MHz) \\ & \leq 50 \ ns \ over \ total \ range \\ & N \ female; \ 50 \ \Omega \\ & cutoff \ frequency: \ 200 \ Hz \\ & \leq 50 \ ns \ over \ total \ range \\ & N \ female; \ 50 \ \Omega \\ & cutoff \ frequency: \ 200 \ Hz \\ & \leq 50 \ ns \ over \ total \ range \\ & S \ over \ total \ range \\ & S \ over \ total \ range \\ & S \ over \ total \ range \\ & S \ over \ total \ range \\ & S \ over \ total \ range \\ & S \ over \ total \ range \\ & S \ over \ total \ range \\ & S \ over \ total \ range \\ & S \ over \ total \ range \\ & S \ over \ supply: \ 200 \ Hz \\ & S \ over \ supply: \ 6 \ over \ supply: \ supply: \ supply: \ 6 \ over \ supply: \ 6 \ over \ supply: \ supply: \ supply: \ suppl$
Max. input voltage . for group-delay measurement . Group-delay error . Connector, RF input . Video Filter LFM 2-Z2 . Attenuation in passband . Connectors, input . output . XY Recorder Adapter LFM 2-Z3 . X output signal . Signal for pen lift . Connectors . General data Rated temperature range . Operating temperature range . Storage temperature range . Storage temperature range . AC supply . Dimensions, weight 19" bench model (design 80) . 19" rackmount . Order designation . Line frequency 15,625 Hz . 15,750 Hz . Recommended extras . Wideband Demodulator . Video Filter . Mixer . XY Recorder Adapter . Impedance Transformer . Amplifier . IEC-bus Option, for LFM 2 with Serial Nos. 871739 and 300 974 . for other LFM 2 models . Connecting Cable (to MUF 2) for .	
Max. input voltage . for group-delay measurement . Group-delay error . Connector, RF input . Video Filter LFM 2-Z2 . Attenuation in passband . Connectors, input . output . XY Recorder Adapter LFM 2-Z3 . X output signal . Signal for pen lift . Connectors . General data Rated temperature range . Storage temperature range . Storage temperature range . Storage temperature range . AC supply . Dimensions, weight 19" bench model (design 80) . 19" rackmount . Order designation . Line frequency 15,625 Hz 15,750 Hz . Recommended extras . Wideband Demodulator . Video Filter	$ \begin{split} & \leq 5 \ V_{rms}, \leq 10 \ V \ DC \\ & \geq 1 \ V_{rms} \\ & \leq 10 \ ns \ /100 \ MHz \ (10 \ to \ 1000 \ MHz) \\ & \leq 50 \ ns \ over \ total \ range \\ & N \ female; \ 50 \ \Omega \\ & cutoff \ frequency: \ 200 \ Hz \\ & 0 \ dB \ \pm 0.2 \ dB \\ & \leq 50 \ ns \ over \ total \ range \\ & 0 \ dB \ \pm 0.2 \ dB \\ & \leq 50 \ ns \ over \ total \ range \\ & 0 \ dB \ \pm 0.2 \ dB \\ & \leq 50 \ ns \ over \ total \ range \\ & 0 \ dB \ \pm 0.2 \ dB \\ & \leq 50 \ ns \ over \ total \ range \\ & 0 \ dB \ \pm 0.2 \ dB \\ & \leq 50 \ ns \ over \ total \ range \\ & 0 \ dB \ \pm 0.2 \ dB \\ & \leq 50 \ ns \ over \ total \ range \\ & = 10 \ ns \ vert \ total \ range \\ & = 10 \ ns \ vert \ total \ range \\ & = 10 \ ns \ vert \ total \ range \\ & = 10 \ ns \ vert \ total \ range \\ & = 10 \ ns \ vert \ total \ range \\ & = 10 \ ns \ vert \ total \ range \\ & = 10 \ ns \ vert \ total \ range \\ & = 10 \ ns \ vert \ total \ range \\ & = 10 \ ns \ vert \ total \ range \\ & = 10 \ ns \ range \\ & = 10 \ range \ ran$



VHF FM Relay Receivers EU 200 and EU 201 87.5 to 108 MHz

EU 200 EU 201



Stereo/mono receivers complying with ARD standard specifications,

- with automatic switchover through 19-kHz pilot EU 200: continuously tunable
- EU 201: single-channel receiver
- High overload capability

Photo: EU 200 (EU 201 see next page)

The VHF FM Relay Receivers EU 200 and EU 201 are designed in accordance with the CCIR standards for the 19kHz pilot-tone method. They can receive stereo-modulated and mono sound broadcasts (automatic switchover) and can modulate slave transmitters with accurate level signals. They can also be used for retransmission of road traffic, SCA and auxiliary channels. The operating status is indicated by LEDs; floating contacts are provided for remote signalling.

RF section. The EU 200 and the EU 201 only differ in the RF sections:

- EU 200: guasi-continuous frequency setting in crystal-referenced 10-kHz steps, frequency memory, 5-digit LED display,
- EU 201: crystal-referenced channel receiver for fixed-frequency-reception (channel can be changed).

Outputs. The relay receivers have two MPX outputs suitable for traffic radio broadcasts and two mono signal outputs (with an additional output of each type on the front panel) with common level setting plus a broadband SCA signal output (level adjustable). With mono broadcasts the mono signal is switched via a 15-kHz lowpass filter to one of the MPX signal outputs. A squelch circuit with adjustable threshold level suppresses the noise.

Automatic switchover. Each receiver contains an automatic switchover circuit, which can be turned off for operation in passive standby mode (the receivers can be set to act as main or standby).

Specifications of EU 200 and EU 201	
Frequency range	
RF input 50 Ω; BNC female connector Noise figure EU 200/EU 201 $\leq 10 \text{ dB}/\leq 9 \text{ dB}$ Required EMF for constant V _{out} $\leq 10 \text{ dB}/\leq 9 \text{ dB}$	
$ \begin{array}{llllllllllllllllllllllllllllllllllll$	
EU 200/EU 201 ≦10 µV/≦3 µV AF outputs	
mono (balanced, isolated) and parallel output of each type on front panel	
Source impedance $\ldots \qquad \leq 30 \Omega$; $Z_{out} \geq 600 \Omega$ (MPX), $\geq 300 \Omega$ (mono)	
Oulput level (deviation ± 40 kHz, f _{mod} 500 Hz); adjustable+6 dBm into 600/300 Ω ; ± 3 dB Stopband attenuation at	
19/100 kHz	
oqueion	

Broadband output 40 Hz to 100 kHz
$\begin{array}{llllllllllllllllllllllllllllllllllll$
Output level (deviation ± 40 kHz, f _{mod} 500 Hz); adjustable $+ 6$ dBm into 600 Ω ; ± 3 dB
Linear distortion (deviation ±40 kHz, referred to 500 Hz)
Frequency response for 40 Hz to 15 kHz≦±0.5 dB (mono, with deemphasis)
40 Hz to $43/53/61/70/75$ kHz $\geq \pm 0.1/0.3/0.5/1/3$ dB (stereo)
Phase response for 40 Hz to $43/53/58/61$ kHz $\leq \pm 1^{\circ}/3^{\circ}/5^{\circ}/10^{\circ}$ (stereo)
Stereo crosstalk
(measured via decoder) for
40 Hz to 0.1/5/15 kHz≦40/46/43 dB down (without deem- phasis)
Non linear distortions Distortion for 40 Hz to 5 kHz with
$\pm 75 \text{ kHz} / \pm 100 \text{ kHz}$ deviation $\leq 0.5\% / \leq 1\%$
Intermodulation distortion
(to DIN 45 403), f_{diff} 1 kHz 5 to 15 kHz 15 to 53 kHz ± 75 kHz deviation $d_0 \le 0.25\%$ $d_0 \le 0.5\%$
$d_2 \equiv 0.23\%$ $d_2 \equiv 0.07\%$ $d_3 \equiv 0.37\%$ $d_3 \equiv 0.75\%$
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$
S/N ratios (measured in line with CCIR Rec. 468-2); referred to: $\pm 40 \text{ kHz}$, deviation, f _{mod} 500 Hz; useful EMF: mono $\ge 200 \mu$ V, stereo $\ge 2 \text{ mV}$
Unweighted S/N ratio
Weighted S/N ratio $\ge 60 \text{ dB} (\text{typ.} \ge 65 \text{ dB})$
Selectivity MPX Mono
Adjacent-channel ±100 kHz ≧61 dB ≧4 dB
selectivity (ratio ±200 kHz ≧11 dB ≧0 dB ±75 kHz
of interfering to $\pm 300 \text{ kHz} \ge -15 \text{ dB} \ge -16 \text{ dB}$ deviation, wanted signal) $\pm 600 \text{ kHz} = 2-46 \text{ dB}$ f $\pm 500 \text{ Hz}$
Adjacent-channel $\pm 100 \text{ kHz}$ $\geq 61 \text{ dB} \geq 4 \text{ dB}$ selectivity (ratio $\pm 200 \text{ kHz}$ $\geq 11 \text{ dB} \geq 0 \text{ dB}$ of interfering to $\pm 300 \text{ kHz}$ $\geq -15 \text{ dB} \geq -16 \text{ dB}$ $\pm 00 \text{ kHz}$ $\geq -254 \text{ dB}$ $\pm 75 \text{ kHz}$ deviation, $\pm 1.2 \text{ MHz}$ $\sim -254 \text{ dB}$
Unmodulated interfering signal $\geq 49 \text{ dB}$ $\geq 49 \text{ dB}$ $f_{mod} 500 \text{ Hz}, \pm 40 \text{ kHz}$ deviation $\geq 263 \text{ dB}$ $\geq 44 \text{ dB}$
EU 201: ≤1 V for fimage and
$\begin{array}{c} EU 200: \leqq 20 \text{ for finage and} \\ EU 201: \leqq 1 \text{ V} \\ (mono: \leqq 0.1 \text{ V}) \end{array} \right\} \begin{array}{c} \text{Interternet generation} \\ \text{for finage and} \\ \text{fig: } \pm 6 \text{ kHz} \end{array}$
Automatic switchover (with
signalling contacts)
General data
Densel motor
frequency deviation and all output
Power supply
Rated temperature range +5 to +40 °C Power supply 115/125/220/235 V, 47 to 63 Hz; 30 VA (EU 200), 20 VA (EU 201) Dimensions, 19" rackmount 483 mm×88 mm×384 mm
Dimensions, 19" rackmount 483 mm×88 mm×384 mm 19" bench model (design 80) 492 mm×116 mm×392 mm
Weight rackmount/bench model 8 kg/10 kg
Ordering information
Order designation VHF FM Relay Receiver
19" bench model 19" rackmount
EU 200 (continuously tunable)
EU 201 (please specify frequency) 280.0510.52 280.0510.51
Recommended extras
BNC connector (RF input and MPX outputs)
3-way male connector (mono, MPX output on rear
panel) 018-5340.00
Adapter rail for 19" rack



Equipment	of	divisions	



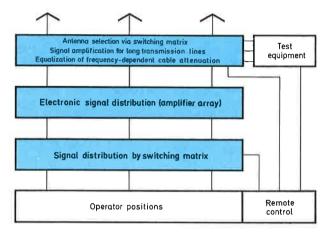
4P page 356

VHF FM Relay Receiver EU 201 - description see previous page



Antenna signal transmission and distribution using the modular system NV 14/NZ 14

A flexible, maintenance-free modular system which offers a solution to nearly all the problems pertaining to the transmission and distribution of antenna signals in **short-, medium-and longwave** receiving systems.



Principle of a system for distribution and transmission of antenna signals in short-, medium- and longwave receiving systems

The **modular design** of the individual units enables the configuration of distribution systems of any required capacity with minimum space requirement.

Characteristics of system units

VLF-MF Multicoupler NV 12 T

The low-noise broadband amplifier NV 12 T is the most important system module for multiple utilization of antennas in the **mediumand longwave band.** It enables the operation of up to 10 receivers from one antenna and can be cascaded to feed an even far greater number of receivers. A rack-mounting adapter with power supply for accommodation of eight multicouplers is provided for large systems. The Antenna Selectors NZ 14 S1 and NZ 14 S2 are available for antenna switching and antenna signal distribution.

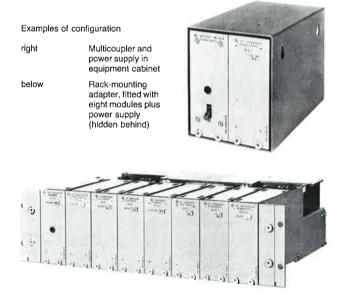


HF Multicoupler NV 14 T

Via the NV 14 T several (with triple cascading even up to 1000) **shortwave receivers** can be operated from one antenna, the full power received being available to each receiver. The NV 14 T has 10 outputs, can be cascaded and is designed for the following applications:

- a) Feeding of small receiving stations (up to 10 receivers), e.g. in embassies, police stations, etc.
- b) Feeding of large receiving stations (more than 10 receivers) using additionally antenna selectors; rack-mounting configuration.

All switching functions can be **remote-controlled** manually or **by program control** either from the operator's position or also from a central position. The distribution systems are mainly accommodated in a rack; system parts and small systems are also available as bench or wall-mounted models, see photo.



Specifications

NV 12 T
Frequency range 10 kHz to 1.6 MHz
Input/output impedance
Number of outputs
Isolation between outputs
Gain 0 ±1 dB
Noise figure
Input/output connectors BNC female
Supply voltage (DC) 24 V ±0.5 V (<500 mA)

NV 14 T	
Frequency range	1.0 to 30 MHz or
	1.6 to 30 MHz
Input/output impedance	50 Ω
Number of outputs	10
Isolation between outputs	up to 10 MHz: >50 dB
	up to 25 MHz: >40 dB
Gain	0 ±0.5 dB
Noise figure	typically 7 dB
Input/output connectors	
Supply voltage (DC)	



HF Line Booster NV 14 L

Module for distribution systems where antenna signals must be passed on with low loss over greater distances than usual. The voltage gain is 10 dB; higher losses can be compensated by using several line boosters. Input and output are protected against overvoltages (induced by lightning).

Antenna Selectors NZ 14 S1 and NZ 14 S2

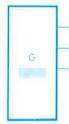
Remote-controlled RF switches

NZ 14 S1: two inputs, one output and an additional pair of sockets for interconnecting line boosters. In the case of a power supply failure these additional sockets are bypassed and one input is through-connected to the output.

NZ 14 S2: two 1-out-of-5 or one 1-out-of-10 selection capability. Inputs and outputs can be interchanged.

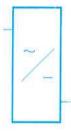
Remote control units for Antenna Selector NZ 14 S2: available as 19" rackmount or bench model:

- NZ14 FB1 with keyboard for two 1-out-of-5 antenna selections,
- NZ14 FB2 with 10 keys for 1-out-of-10 selection.



Noise Generator NZ 14 R

The remote-controlled, broadband noise generator is the testing unit of the distribution system. It supplies a constant noise power. The Antenna Selector NZ 14 S1 is provided for switching from antenna signal to noise generator signal.



Cabinet NV 142 K and Power Supply NV 142 N

Cabinet NV 142 K: offering space for one unit plus the associated Power Supply NV 142 N. It is suitable for small systems or system parts. Available as bench model or for mounting to the wall (W×H×D: 122 mm×150 mm×185 mm).

Power Supply NV 142 N: used for feeding one unit. The power supply is of modular design and accommodated in the Cabinet NV 142 K together with the module to be fed.



Serial Control Interface NZ 14 P

The NZ 14 P is an accessory module enabling remote control of the Antenna Signal Distribution System NV 14/NZ 14 via data bus or program control. It functions as a memory and decoder for control information of antenna selectors with up to 100 contacts. If required, it can be switched for manual control.

RADIOCOMMUNICATIONS

14 L

NV 14 L	
Frequency range	1.0 to 30 MHz or
	1.5 to 30 MHz or
	1.6 to 30 MHz
Input/output impedance	50 Ω, BNC female connectors
Gain	10 dB ±0.5 dB
Noise figure	typically 7 dB
Suppression of	
2nd order mixture products	>70 dB
3rd order mixture products	

NZ 14 S1/14 S2	NZ 14 S1	NZ 14 S2
Frequency range	0 to 30 MHz	0 to 30 MHz
Inputs and outputs		2×5 inputs.
inpute and betpete state state state	1 output.	2×1 output
	1 additional pair	a ··· · · · · · · · · · · · · · · · · ·
	of sockets	
Impedance		50 Ω
Isolation		>80 dB
	>00 0D	>40 dB between
		groups of five
Transmission loss	<0.5 dB	<0.25 dB
Power supply (DC)		24 V ±0.5 V
Fower supply (DC)		(max. 10 mA/
	(max. 65 mA)	
		switch)

NZ 14 R	
Frequency range	1 to 30 MHz
Outputs	3, BNC female connectors
Output impedance	50 Ω
Isolation between outputs	>10 dB
Noise power at each output	
	(100 μV into 50 Ω at 10 kHz band-
	width)
Power supply (DC)	24 V ±0.5 V (75 mA)
Power supply (DC)	24 V ±0.5 V (75 mA)

NV 142 N

NZ 14 P

 Connector
 64-way to DIN 41612 (VG 95324)

 Through-connected outputs
 max. 20 mA/1 V

 Other outputs
 open collector, max. 30 V

 Power supply (DC)
 24 V (15 to 28 V), 30 mA

A1 VHF-UHF RECEIVERS

appendix



Characteristics

The intelligent, versatile **VHF-UHF receivers** of the **ESM 500** series enable an economical solution of the diversified radiomonitoring tasks.

ESM 500 A for 20 to 1000 MHz and ESM 500 B for 20 to 500 MHz.

The receivers featuring high sensitivity, high overload capacity and a tracking preselection filter can be fully remotely controlled thanks to the microprocessor technique and are extremely easy to operate. Their common features also include:

- Wide dynamic range free from spurious responses (3rd order intercept point = +10 dBm)
- Scanning of 99 memory locations for receiver status per frequency
- Built-in test equipment (BITE)
- S/N ratio squelch or adjustable carrier squelch
- Addressing of ten slave receivers
- AC supply operation as well as DC supply 19 to 30 V without exchanging the power supply
- Automatic control of antenna switching panels

Versatility

When fully equipped the receiver features four selectable IF bandwidths, AM-FM demodulators, an SSB demodulator for USB and LSB and selectable tuning steps of 10 kHz and 1 kHz. An AM-FM demodulator with separate video outputs and IF bandwidths of 300 kHz and 2 MHz is provided to demodulate wideband signals.

An AF filter (300 Hz to 3.3 kHz) can be connected into the AF monitoring section. A frequency offset meter controlled by a crystal discriminator is used as a tuning indicator. The sensitivity of the offset meter is matched to the selected IF bandwidth to facilitate centre-tuning. If the frequency of the signals is unstable digital AFC can be switched into circuit to automatically track the input.

Specified characteristics

Frequency entry and tuning. Quasi-continuous manual tuning by means of the familiar rotary control together with digital control and the synthesizer offers exceptional advantages. The number of frequency steps per rotation depends on the speed of rotation of the tuning knob, so that this type of tuning is comparable to a mechanical coarse/ vernier drive with six tuning rates.

The required frequency is entered via a decimal keyboard; adding the decimal point after the 1-MHz digit reduces errors. The frequency set is read out on a small display for checking and is transferred to the tuning circuit and the memory at the push of a button. Normal operation is not interrupted by setting a new frequency, loading the frequency into the memory or scanning the content of the 99 memories.

In addition to the current receive frequency, additional information such as IF bandwidth and type of demodulation can simultaneously be stored in the memory.

Automatic gain control. The AGC range is 120 dB, 80 dB being provided by the IF control and 40 dB by an attenuator which is automatically cut into circuit at high signal levels.

Wideband IF amplifier. It demodulates wideband signals, e.g. directional radio signals, and has an independent gated AGC; IF bandwidths 300 kHz/2 MHz.

SSB demodulator. It demodulates signals without modulation as well as SSB and ISB emissions. In the SSB mode, 10-Hz tuning steps are automatically selected.

IF panoramic display. The built-in IF panoramic display with a spectral display of ± 100 kHz about the receive frequency furnishes information on the occupancy of the adjacent channels and is an invaluable tuning aid. **RF panoramic display** is possible up to a sweep width of 500 MHz when using the Panoramic Adapter EZP (page 246).

Squelch. In addition to the adjustable squelch of the usual type, the ESM 500 has also an S/N ratio squelch which only enables the AF channel if the S/N ratio is satisfactory.

Self-testing facility. The receiver is permanently monitored by the built-in test equipment. A code number displayed on the occurrence of a fault furnishes information on the type of fault.



Hand-off Receivers ESM 508 K, 517 K, 540 K

In radiomonitoring systems a great number of frequency channels must often be monitored. When using standard receivers (like the ESM 500 A/B) for this purpose, the investment costs would be too high. It is more economical to use receivers which are tailored to certain frequency bands. For this reason the Receiver Family ESM 500 offers the so-called **cassette receivers** or hand-off receivers which can be remote-controlled from a central control station. In most cases the receiver settings are made by a computer which also evaluates the information supplied by the receivers.

Each cassette (size: 1/4 of 19'' plug-in, see photo) is a selfcontained receiver with no front panel controls, buth with its own tuner, synthesizer and IF/AF amplifier, and features an extremely favourable price/performance ratio.



Eight hand-off receivers including power supply in a 19" cabinet

Up to eight cassettes can be operated from one Control and Power Supply Unit GX 500 D1 which contains a microprocessorized control system, a 10-MHz reference oscillator, a power supply and an IEC-bus interface for data input and output to the central control system.

The control system may consist of:

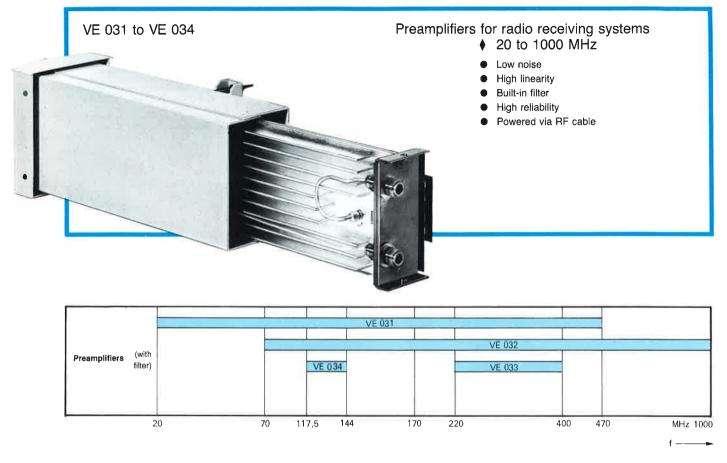
- an ESM A/B, addressing via A0 to A9,
- a process controller with IEC-bus interface, e.g. the PUC from R&S,
- an Automatic Receiver ESP with computer (e.g. Data General NOVA 4 or ROLM 1602 B) and IEC-bus interface.

Self-testing facility. Each receiver is fitted with self-testing facilities which do not only report failures of modules to the control and power supply unit, but also indicate them on the front panel of the receiver concerned. In addition, each receiver contains the facilities required for the overall loop test.

Oracificatio		
Specifications	ESM 500 A, B	ESM 5 K
Frequency range ESM 500 A ESM 500 B		
ESM 508 K		20 to 85 MHz
ESM 517 K	8	68 to 174 MHz
ESM 540 K		220 to 400 MHz by entry of fre-
	with rolary knob	quency informa-
	b) via keyboard on front panel	tion from control and power supply
	 c) entered from int. memory 	unit
	d) entered from	
Resolution	ext. memory	4.611-
	10 Hz	
Readout (in SSB mode shiftable	6-digit display,	
(in SSB mode shiftable by 3 digits)	ary display during	
	frequency entry, 2 digits for memory	rv location
Frequency error	±1 × 10-8	±1 × 10-8
Oscillator reradiation	<1 μV	<1 µV
Input selectivity Frequency memory	tracking filters	tracking filters
	type of demodul-	
	ation and IF band- width	
S/N ratio	≥10 dB with AM	≧10 dB with AM
$(V_{in} = 1 \mu V, B = 30 \text{ kHz})$ Intercept point 2nd/3rd order	≥25 dB with FM tvp, 50/12 dBm	≥25 dB with FM typ. 50/12 dBm
IF bandwidths	2.3/8/15/30/	8/15/30/100 kHz
(fully equipped) Image frequency rejection	100/300 kHz/2 M	Hz >80 dB
IF rejection	>90 GB	>90 0B
Demodulation		
Squeich	S/N ratio squelch	carrier squelch
	and carrier squelch	adjustable from
	adjustable from	0.00000µV
AF filter (disconnectible)	0 to 80 dBµV 300 Hz to 3.3 kHz	300 Hz to 3.3 kHz
AF detay		100 ms (can be
COR	floating switching	switched off) floating switching
Gain control AGC	contract	contact same as ESM 500
	V _{in} ≦80 dBµV	
	RF control for V _{in} ≦120 dBμV	
MGC	IF control 80 dB RF: 40 dB,	external control same as ESM 500
	switch-selected	Same as ESM SUU
Indication: level/offset	on meter	
IF sweep width		-
Resolution	4.5 kHz 4 cm × 3 cm	
RF sweep width (with EZP)	500 MHz,	-
Built-In test equipment	IF max. 2 MHz	same as ESM 500
	assemblies and loop test	Same as ESIM SUU
Outputs		level, offset; AF,
	video, IF 10.7	AF (delayed), IF 10.7 (wide/-
	(wide/narrow), for EZP, COR, head-	narrow), head-
	phones, built-in	phonos, con
Inputs	loudspeaker external control.	external control
mpara	squeich threshold	
Remote control	IEC bus, RS 232 0	Same as ESM 500
General data		
Operating temperature range Power supply		-10 to +55°C via control and
	or	power supply unit;
	10 to 30 V DC, 40 W	7 W per receiver, 150 VA max.
Dimensions, bench model (in mm) rackmount		8-receiver block: 520×445×535
Weight		60 kg (3.5 kg per
Ordering information		receiver)
Ordering information VHF-UHF Receiver	Order number:	
ESM 500 A, bench model	570,5012.02	
rackmount	570.5012.03	
ESM 500 B, bench model		
Further information on equipment ar		N 6-011
equipment al	ia optiona, ace mit	1100114

Further information on equipment and options: see Info N 6-011.

PREAMPLIFIERS 4P

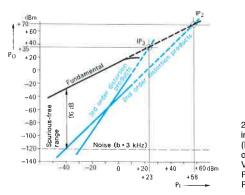


The weather-protected **Preamplifiers of the VE 03. series** are used to compensate for the line losses between the antenna and the receiver, e.g. in radiomonitoring and air traffic control systems.

The amplifiers VE 031 (20 to 470 MHz) and VE 032 (70 to 1000 MHz) have been primarily designed for use in radiomonitoring systems. The VE 033 (220 to 400 MHz) and VE 034 (117.5 to 144 MHz) comply with the special requirements of ATC systems. The Multicouplers VE 340 and VE 341 that are suitable for connection to the preamplifiers are listed on the following page.

Design

The broadband push-pull amplifiers (including input filter circuits and lightning protection circuits) are mounted on a central heat sink. The temperature rise is thus well below the limit permitted for the semiconductors, ensuring high reliability.



2nd and 3rd order intercept points (IP₂ and IP₃) of Preamplifier VE 031; P₁ = input level, P₀ = output level

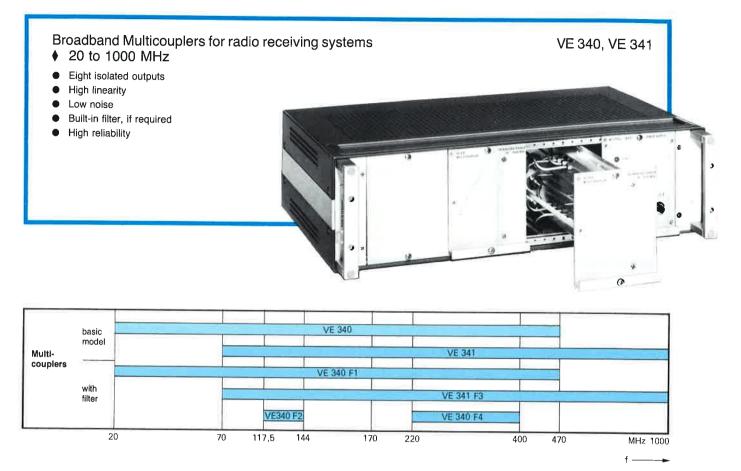
The amplifiers are delivered without a power supply and in a weatherproof case suitable for various different methods of attaching it to the antenna mast. The supply voltage is fed to the amplifier via the coaxial antenna cable.

High reliability. The actual MTBF (mean time between two failures) is even better than the calculated MTBF of 300,000 hours due to the careful selection of the components and the performed burn-in tests.

Specifications

Type Frequency range	VE 031 . see abov		VE 032 ring inform	
Gain (midrange, +1/-0.5 dB)	dB 12	12	13.5	20
Frequency response		≦2	≦2	≦1
Noise figure			≦7.5	
Max. input EMF	Vrms 10	10	2	10
2nd order IP ₂	$dBm \ge +70^{1}$	≧+80 ²)	$\geq +54^{3}$)	≧+70 ²)
3rd order IP3			≧+25	
Input/output impedance .			50	
VSWR		≦2	≦2	≦2
Rated/operating	5)			
temperature range		to +55/-4	0 to +70°	с
Humidity				
		d to VG 95 24 hours	332:95% a	t+40°C
Power supply			0.1 A:	
	fed v	ia coaxial (cable	
Dimensions, weight		mm×360 п	m×90 mm	n, 3 kg
Order designation	Pr	eamplifier		
VE 031, 20 to 470 MHz		62.0415.02		
VE 032, 70 to 1000 MHz .		52.1611.02		
VE 033, 320 to 400 MHz .		62.0715.02 62.1311.02		
VE 034, 117.5 to 144 MHz	- and the second of	2.1311.02		
¹) For $f_1/f_2/f_{d2}$: 70/100/3		d frequency	range;	
³) For f ₁ /f ₂ /f _{d2} : 400/470/	/U MHZ.			





The broadband Multicouplers VE 340 (20 to 470 MHz) and VE 341 (70 to 1000 MHz) permit up to eight receivers or via an inserted DC feed unit - further multicouplers with as many subsequent receivers to be simultaneously operated from one antenna. For operation without preceding Preamplifiers VE 031 to VE 034, these multicouplers are available with filters for limiting the frequency range (see specifications).

Design

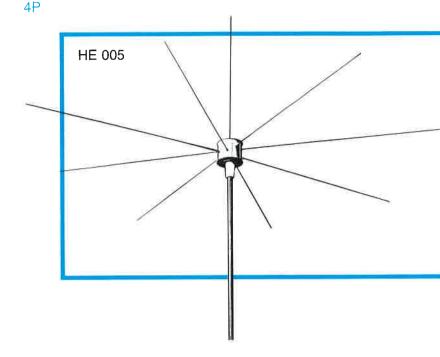
Since the multicouplers, which are designed with push-pullcircuits are mounted on a solid heat sink, the temperature of the semiconductors is so low that the actual MTBF (mean time between two failures) is even better than the calculated MTBF of 300,000 hours.

The multicouplers and the power supply are designed as plug-ins (each a quarter of 19" wide). Up to three multicouplers and one power supply can be accommodated in a 19" adapter. The cable connectors of the multicouplers are located on the rear of the plug-ins. It is however possible to modify the multicoupler such that the RF connectors are on the front panel. The power supply also feeds the preceding Preamplifiers VE 031 to VE 034 via the RF cables.

and the second se		
Specifications		
Туре	VE 340	VE 341
Frequency range	see	above
Gain (midrange)	1 dB ±1 dB	1 dB ±1.5 dB
Noise figure		≦8 dB
Input	unbalanced; inner	conductor provides
	+18 V to feed a p	preamplifier
Max. input EMF	10 V _{ms}	2 Vms
VSWR	≦2	≤2.5
Outputs	9 unbalanced	9 uphalanood
	floating	floating
Output impedance	50 Ω. N female	50 Ω, N female
VSWR	≦2	≦2
Interference rejection		
Isolation between outputs	tvp. 25 dB	typ. 25 dB
Intercept point 2nd order IP2	≧ +70 dBm	≧ +50 dBm
at f ₁ /f ₂ /f _{d2}	per output	per output
at f ₁ /f ₂ /f _{d2}	70/100/30 MHz	
3rd order IP ₃	≤ +26 aBm	≧ +20 dBm per output
Power Supply IN 027		
AC supply	115/125/220/23	Supply or battery
Battery supply	19 to 32 V	V 1107 1078
General data		
	101	
Rated/storage temperature range		
19" rack adapter	483 mm×132 mm	n×384 mm
19" bench model adapter	492 mm×161 mm	1×392 mm
Ordering information		
Order designation	Multicounter	
VE 340, 20 to 470 MHz	562.3014.02	
VE 341, 70 to 1000 MHz	562.3514.02	
With filter for		
20 to 470 MHz, VE 340 F1 117.5 to 144 MHz, VE 340 F2	562.2618.02	
220 to 400 MHz, VE 340 F2	562.2218.02 562.2818.02	
70 to 1000 MHz, VE 341 F3	562.2818.02	
Power supply for		
max. 3 multicouplers.	570.3010.02	

ACTIVE RECEIVING ANTENNAS

appendix



Active HF Antenna System HE 005 1.5 to 30 MHz

- Extremely small dimensions: rod height 1.5 m only, dipole length 3 m only
- High sensitivity
- High linearity
- High immunity to nearby lightning strokes
- Performance test without auxiliarry equipment and emergency operation by means of bypass circuit

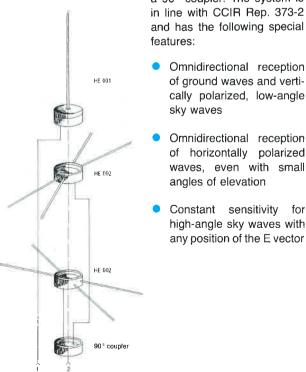
Active receiving antennas offer advantages due to their dimensions being reduced by almost a factor of four as against comparable passive antennas with same sensitivity of the receiving system.

Rohde & Schwarz has developed a system concept, in which the basic modules

Active HF Rod Antenna HE 001 and Active HF Dipole Antenna HE 002

(which can also be used individually) can be combined to form various systems for different requirements.

The Active HF Antenna System HE 005 is one of the possible combinations, consisting of HE 001, 2×HE 002 plus



- a 90° coupler. The system is in line with CCIR Rep. 373-2 and has the following special
 - of ground waves and vertically polarized, low-angle
 - Omnidirectional reception of horizontally polarized waves, even with small angles of elevation
 - Constant sensitivity for high-angle sky waves with any position of the E vector

Specifications
Elements HE 001 HE 002 (above con- (on 6-m mast) ducting earth)
Frequency range 1.5 to 30 MHz Input impedance 50 Ω VSWR ≦1.5 Suppression of intermodulation
distortion for 2nd order mixture products (for 2×0.1 V/m inter- fering field strength) ≥75 dB ≥70 dB corresponding to IP ₂ ≥60 dBm for 3rd order mixture products
(for 3×0.1 V/m interfering field strength)
Antenna factor k _a = V _{oul} /E 0.4 m 0.7 m Maximum permissible interfering field strength
at 10 kHz 5 × 10 ⁵ V/m 2.5 × 10 ⁵ V/m 100 kHz 5 × 10 ⁴ V/m 2.5 × 10 ⁴ V/m 1 MHz 5 × 10 ³ V/m 2.5 × 10 ⁴ V/m 1 MHz 5 × 10 ³ V/m 2.5 × 10 ³ V/m 10 MHz 500 V/m 250 V/m
General data Operating temperature range -40 to +80°C Storage temperature range -55 to +125°C Connectors BNC Supply voltage 18 V ±10%/100 mA1 Dimensions of rod 1500 mm, 1.6 kg dipole 3000 mm, 2 kg
Ordering information
Order designation > Active HF Antenna System HE 005 275.5447.50
Recommended extras Plug-in Mast KM 011 (6 m; including guy ropes and pegs) . 273.9116.02 Power Supply IN 014
¹) The antenna is fed from the Power Supply IN 014 via the coaxial RF antenna cable.

ACTIVE RECEIVING ANTENNAS

A1

Active Antenna System HE 115

- 20 to 200 MHz
- Adaptation to any receiving conditions due to compact antenna system
- High sensitivity in spite of small size
- High large-signal handling capability (like that of a passive antenna with high-grade preamplifier)
- High immunity to nearby lightning strokes

The Active Antenna System HE 115 is made up of the

Active Receiving Dipole HE 101 (2 off) and the Active Vertical Dipole HE 109 (see illustration on the right).

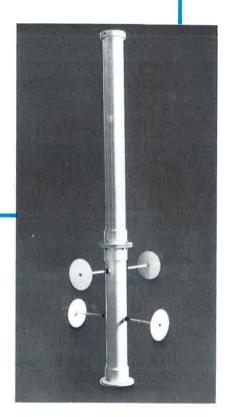
This antenna system meets any requirement in the fields of radiomonitoring and radiocommunications. It features

 omnidirectional reception of vertically and horizontally polarized waves

and ensures a high detection probability. Due to their very small dimensions, light weight and low wind load the antenna elements and also the whole system represent an ideal solution, especially for **mobile use** and where space is at a premium. The output voltages are available at separate outputs for horizontal and vertical polarization.

The **Active Receiving Dipole HE 101** (see illustration on the right) is mainly designed for horizontal orientation, i.e. for reception of horizontally polarized waves. The extremely small dimensions of the HE 101 (dipole length: 0.5 m) make it easy to orientate it in any direction. The HE 101 is delivered with a bracket having an arm for fixing the antenna to a tubular mast (20 to 54 mm diameter).

Omnidirectional reception over the whole frequency range 20 to 200 MHz, however, is achieved with the **Active Vertical Dipole HE 109** (see illustration on the right) which, for example, is mounted on top of the mast. The centre feed of the dipole ensures high isolation from currents on the supporting mast.



HE 115

Active Antenna System HE 115

 Order designation
 ► Active Antenna System HE 115 530.6718.02

 Recommended extras

 Bracket for mounting the antennas on tubular masts
 530.6953.00

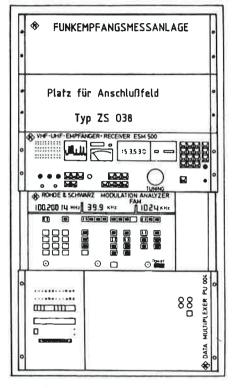
 Power Supply IN 014
 235.7610.02





EA 020

Radio Receiving and Measuring System EA 020



The remote-controlled **Radio Receiving and Measuring System EA 020** is suitable for setting up radiomonitoring networks. From a central station unattended measuring systems – installed at sites offering favourable receiving conditions – can be controlled over the public telephone network. Each system, including its antennas, can be controlled in all necessary operating modes and measuring routines and immediately provides the measured values, such as receive frequency, frequency offset, RF signal level, frequency deviation, modulation depth, angle of incidence, as well as the demodulated signal. Switchover between several receiving stations of one control station is made via lines. Remote control and return-signalling of the measured values need not be made via lines, it is also possible via directional radio links, the transfer rate being usually 1200 bauds.

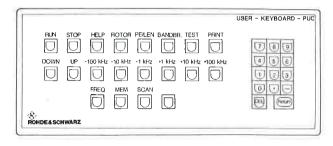
The system is controlled from the user keyboard (above right), which can be set up remotely, in the form of a userfriendly dialog program. The user can also write his own programs in BASIC or modify existing programs. This offers then the possibility of extending the system, e.g. for direction finding and evaluation via IEC-bus-compatible equipment.

The results, equipment settings and additional information are displayed on the screen of the process controller, for which a high-resolution graphics option is also available.

The Data Multiplexer PU 004 in the receiving station can be retrofitted to enable control and data return-signalling of the Doppler Direction Finder PA 005.

♦ 20 to 1000 MHz

- Remote control over any distance
- Programmable control unit
- Clear display of setting and measured data
- Easy extension of control and receiving station thanks to IEC-bus compatibility



User keyboard of process controller

Overall concept of a radio receiving and measuring system

- Equipment configuration for the measuring station
- Equipment configuration for the control station

System configuration/function

Control station. Process Controller PUC (see also page 14), with two built-in floppy disk drives (156 kbyte capacity each), enabling a great number of customer-specific operating, measuring and locating routines to be called up.

Measuring station. The PU 004 receives via a modem the setting and measuring commands from the central station. Omnidirectional receiving antennas and one log-periodic antenna (with crossed dipoles, on rotator) are available. Instead of the log-periodic antenna the Doppler Direction Finder PA 005 can be used for better determination of the direction.

The ESM 500 (page 356) with SSB option and IEC-bus interface is used as receiver. The units for antenna selection, antenna rotation, radio reception, measurements and data transmission are accommodated in a 19" light-metal cabinet.

Specifications	
Reception	corresponding to the specifications of the VHF-UHF Receiver ESM 500, see pages 356/357
Frequency range Demodulation modes 2nd/3rd order intercept point Noise figure	20 to 1000 MHz AM, FM, SSB typ. +50 dBm/typ. +12 dBm
Measurement	 corresponding to the specifications of the Modulation Analyzer FAM, see page 256
Frequency measurement Resolution Modulation measurement	
AM FM Control and display	1 to 500 kHz
Ordering information	depending on system configuration, details on request



EA 110, 115

Automatic RF Spectrum Occupancy Recording Equipment EA 110, EA 115

- 10 kHz to 30 MHz or 10 kHz to 1300 (2500) MHz
- Wide frequency range up to 2.5 GHz
- High frequency resolution with 25 Hz analyzing bandwidth
- Quasi-parallel recording on up to six recorders
- Modern, clear operating and display concept

OFREQUENZBANOSCHREIBER · RADIO RECORDER ZSG 3 Inn ° 00000 • 00000 ó 00000 ECORDE CONTROLLER 1824 . . . 0 0 nn••• REQUENZBANDSCHREIBER · RADIO MONITO ECORDER 0 0 00000 00000 00000 00000 EQUENZBANDSCHREIBER - RADIO MONITORING RECORDER ZRANDSCHREIBER, RACIO MONITORIAS 0000 00000 00000 0000

The Automatic RF Spectrum Occupancy Recording Equipment EA 110 and EA 115 measure and record the occupancy of frequency bands over extended periods of time. The recordings clearly show any unduly high or low signal density at certain frequencies and times. With suitably adjusted sweep width and resolution, the plotted graph can also provide information on the frequency stability, type of modulation and class of emission of the transmitters observed.

Rohde & Schwarz can deliver the following system configurations:

- System EA 110 A1, 10 Hz to 30 MHz 1 Receiver EK 070, 1 Controller 1824, 1 Recorder ZSG 3
- System EA 110 A2, 10 kHz to 30 MHz 1 Receiver EK 070, 1 Controller 1824, 6 Recorders ZSG 3
- System EA 115, 10 kHz to 1300 (2500) MHz 1 Automatic Receiver ESP (up to 1300 MHz, with Tuner II up to 2500 MHz), 1 Controller 1824, 6 Recorders ZSG 3

The Controller 1824 used in all systems controls via a microprocessor the respective receiver in about 1000 steps between the selected start and stop frequency and calculates the optimum sweep width and resolution bandwidth.

Triggered by the controller, the receiver searches up to six frequency bands at maximum speed. All frequencies of the occupied channels are written into a semiconductor memory in accordance with the lines on the recording paper. When reproducing the results, the lines can be linked up – depending on the selected time – so that no signal will be lost and the paper feed is matched to the period of observation.

The equipment of the EA 110 A1 and EA 110 A2 systems is accommodated in 19" cabinets (one for EA 110 A1, two for EA 110 A2; 550 mm high), that of the EA 115 system in two light-metal racks (1450 mm high).

	EA 115
Size comparison and system configurations	

Specifications
Frequency range EA 110 A1, EA 110 A2 10 kHz to 30 MHz receiver: EK 070
EA 115 10 kHz to 1300 MHz, can be extended to 2500 MHz using Tuner II option Analysis filter bandwidth
EA 110, A1, A2
EA 115
Recording on Radiomonitoring Recorder ZSG 3 Recorded subranges 6 (only 1 with EA 110 A) Analysis ranges 1 to 6 with selectable start/stop frequencies
Frequency lines 10 vertical lines from 1 kHz to 100 MHz manually adjustable in steps of ten
Response threshold
Response reliability a signal is recorded if it is 2 dB above the limit sensitivity of the receiver at all analysis bandwidths
Non-volatile storage in battery-buffered memory of controller

A2 APPENDIX 2

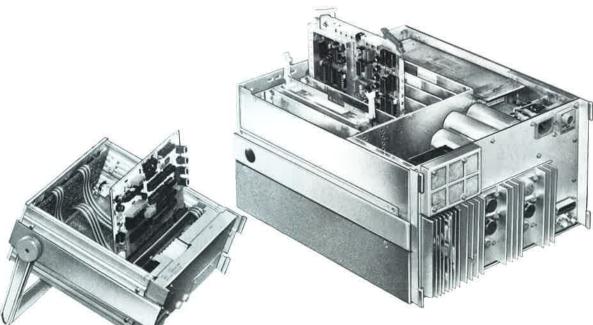
appendix

CABINETS	Page 365 to 369
ADDRESSES	Page 370, 371
INDEX BY INSTRUMENT TYPE	Page 372 to 374

with references to other documentation

SUBJECT INDEX

Inside back cover



Two examples of the R&S compact casing system Details on page 368

Dimensions in tables and texts, cabinets

Design 80

Compact casing system

Rack mounting

Dimensions

The **dimensions** of Rohde & Schwarz instruments are defined as follows:

a) Overall width×height×depth in mm, looking onto the front panel (this also holds for pocket-sized instruments).

In general, the indicated dimensions refer to cabinet models (bench models).

b) In addition to a), an abbreviated code form has been introduced to simplify the specification of dimensions in tables and texts, see table on next page.

The code has not been used in the present catalog. The table on the next page gives cross references between cabinet (bench model) and rackmount dimensions. The order numbers for matching cabinet covers and rack adapters are also given in the table.

Cabinet designs

New designs of cabinets and casing systems are the result of the constantly increasing degree of utilization of equipment volume made possible by ever smaller and more complex components.

The present Rohde & Schwarz line comprises the following three design forms:

Design 70 (present design) Design 80 (see page 366) Compact casing system (see page 368)

Design 70 – also for measuring instruments of mixed design with conventional subassemblies – will be superseded in future by design 80 and compact casing system.

Design 80. The width of a bench model (19" rackmount plus panelling corresponding to the former cabinet model of W = 484 mm) is 492 mm.

Compact units have widths*) of $\frac{1}{2}$, $\frac{3}{4}$ or $\frac{1}{1}$ of 19" with different heights and depths.

*) The actual width is slightly less than the calculated width for constructional reasons.

Rack mounting

19" **rackmounts** of design 70 and design 80 may be inserted as required into 19" racks or mounted in DIN racks with the aid of adapters. **Compact units** can be set up in the same way after having been fitted with 19" adapters (see table on page 368; vacant inserts are supplied with the adapters).

Mounting in 19" racks (DIN 41 494)

Guide rails are supplied in pairs for KCJ 19" racks (R&S) or single for other 19" racks (length 740 mm, no drilled holes); they are suitable for units of design 70 and design 80 (Fig. 1 left).

Brackets are used to secure the appropriate connection panel (specify equipment type when ordering) for self-engaging connection (Fig. 2).

Mounting in DIN racks (DIN 41 490)

Adapter bars (2 ea, angle section) extend the 19" size to DIN width (Fig. 1 right and Fig. 3).

Front-panel adapters (three parts) reduce the width and height of the DIN frame to 19" front-panel size (Fig. 3).

Guide rails for rack mounting (Fig. 1 right) can be made of commercial angle-profile bars.

Brackets see above.

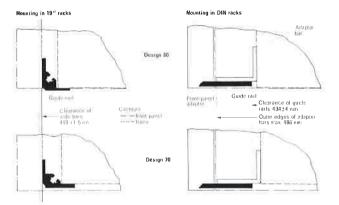
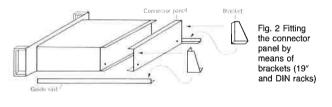
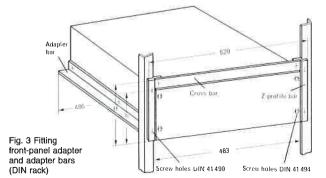


Fig. 1 Guide rails, adapter bars and front-panel adapter fitted for left side of rackmount





INSTRUMENT DIMENSIONS A2

appendix

All dimensions are in mm

Key to dimension code for use in tables and texts, order numbers for cabinet covers, guide rails and 19" adapters

Equipment of 19" width

a) present design designated D 70 in the table)

b) design 80 (designated D 80 in the table)

For details on design 80 see next page

Code	19" equipment dimensions		Cabinet cover		Rack mounting D 70 and D 80				
for height (= DIN 41 494 Sh. 2) ▼	Height in units (1 E ≈ 44 mm)	Rackmount (front-panel w Front-panel h D 70		Bench model (width D 70: 484 D 80: 492) Overall height D 70 D 80	Cover for bench model Order Nos. D 70 D 80 D 70		Brackets Order Nos. (for 1 set) 19" racks DIN racks		Front-panel adapter Order Nos. (DIN racks) RAL 7001
1 2 3	1 E 2 E 3 E	44 88 133	 68 132	61	082.5882.00 043.3818.00 043.3930.00	085.6550-00 085.6567.00 085.6573.00	281,3765.00	enquire 281.3842.00 281.3859.00	034.0910.00 034.0990.00 034.1074.00
4 5 6	4 E 5 E 6 E	177 222 266	177 221 266	194205239250283294	043.4037.00 043.4114.00 043.4743.00	085.6580.00 085.6596.00 085.6609.00	3 E bracke for heigh and r		034.1145.00 034.1222.00 034.1300.00
7 8 9	7 E 8 E 9 E	311 355 400		328 — 372 — 417 —	043.4820.00 043.4908.00 043.4972.00				034.1380.00 034.1468.00 034.1545.00
10 11 12	10 E 11 E 12 E	444 488 533		461 — 505 — 550 —	043.5040.00 043.5110.00 043.5191.00				034.1622.00 034.1700.00 034.1768.00
for depth		Overall depth	Depth d (see drawing)	Overall depth without cover	Adapter bars Order Nos. (for DIN width)		Guide rails Order Nos.	l I	
T		D 70 D 80	D 70 D 80	D 70 D 80	D 70	D 80	for 19" racks ¹)		
A B C		326 384 426 506 499 —	247 305 347 427 420 —	336 392 436 514 509 —	281.3788.00 281.3794.00 281.3807.00	281.3813.00 281.3820.00 	KCJ (1 pair):	For other racks ²): 281.3759.00	

¹) Use commercial angle-profile bars for DIN racks. ²) Single guide rails: 740 mm long, no holes drilled.

Overall depth 19" rackmount Top view

Dimension d

The dimension given in the table indicates the seated depth of 19" rackmounts according to the diagram on right. For the overall depth, 79 mm have to be added: front projection for front panel (4 mm) and handles, including plastic stoppers (51 mm), and rear projection for connecting panel (24 mm).

DESIGN 80 A2

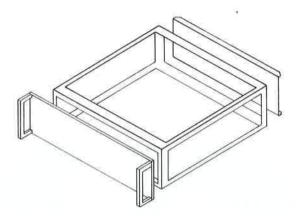
R&S design 80

New Rohde & Schwarz instruments are being produced in design 80 and the compact casing system, the new style for the eighties which, in its outward appearance, represents the third generation of equipment in the company's history of 50 years.

Design 80 is a modern and universal **modular system** which meets differing requirements. It is characterized by exemplary styling, optimum utilization of space, high strength and low weight. The system covers mainframes, panelling, cassettes, adapters for rack mounting, plug-in PCBs and integrable small equipment.

Basic mainframe

The mainframe corresponds to the 19" standard in accordance with IEC recommendation 297 and DIN 41 494.



19" basic rackmount in design 80; frame, front and rear panels

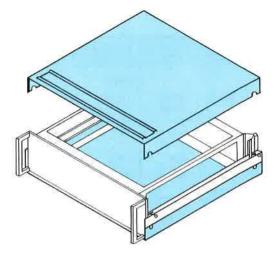
Extruded aluminium sections are used which, due to their mutually engaging design, can be assembled without any special equipment, making them suitable for one-offs as well as standard production. The form of the sections ensures that the mainframe is true in angle and stable while remaining light in weight and large in capacity, the latter offering high packing density.

Sizes of two to six units in height (1 unit corresponding to 44.45 mm) and two frame depths (305 and 427 mm) have been standardized.

Panelling

In contrast with conventional instrument cases, the panelling of the bench model consists of two metal cover panels with extruded aluminium side strips (see photos right). With sizes from three units in height, the side panels are provided with recessed, fold-out handles.

Due to the use of panelling, it is normally only necessary to remove the lightweight covers without having to remove the complete unit when requiring access to the interior.



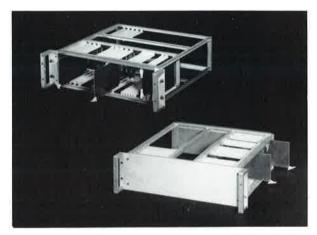
19" bench model in design 80: mainframe plus panelling (enclosure detached)

Insertion of PCBs

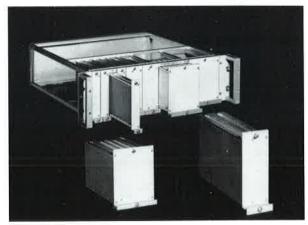
The insertion of PCBs requires but a few standardized accessories (see photo below). The basic format is the 100 mm \times 160 mm Eurocard in line with DIN 41 494.

Cassettes

Cassettes for self-contained functional groups are likewise suitable for holding plug-in cards and other subassemblies.



Mainframe with PCBs arrange for ease of maintenance 19" rackmount with cassettes



A2 COMPACT CASING SYSTEM

appendix

Compact casing system = equipment dimensions

Dimensions						Rack mounting	
Width of 19"	overall	without handle	Height overall	in units	Depth overall (with- out controls)	19″ Adaş Type	oter Order Nos.
1/2	241 245	210 210	110	2 2 3 } *)	219 349 349	ZZA-12 ZZA-12 ZZA-13	079.0631.00 079.0631.00 079.0702.00
3/4	347	312	206	4	349 471	ZZA-4 ZZA-5	078.8500 0 078 8645 0
1⁄1	470	435	118 162 206	2 3 3	349 349 471	ZZA-6 ZZA-7 ZZA-8	078.8274.00 078.8400.00 078.8439.00
			206	4 4 5	349 471 471	ZZA-10 ZZA-9 ZZA-11	078.8722.0 078.8751.0 079.1109.0

*) To combine a 2E and a 3E unit side by side in a rack, use 19" Adapter ZZA-13.

R&S compact casing system

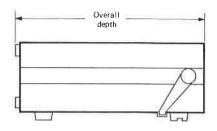
Design 80 is rounded off by a casing system for compact instruments $\frac{1}{2}$ or $\frac{3}{4}$ or $\frac{1}{1}$ of 19" wide, which are also suitable for mobile applications.

This compact casing system copes with the current trend towards complex modules integrating more and more functions in less and less space and complies with users' requirements for economizing space, on benches and in racks.

This easily manufactured system is just as much in line with the international 19" standard as design 80; it is similar in layout, but is even more compact and thus particularly suitable for space-saving setups on a bench (drawing below and photo right).

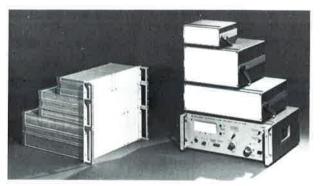
Note on equipment depth

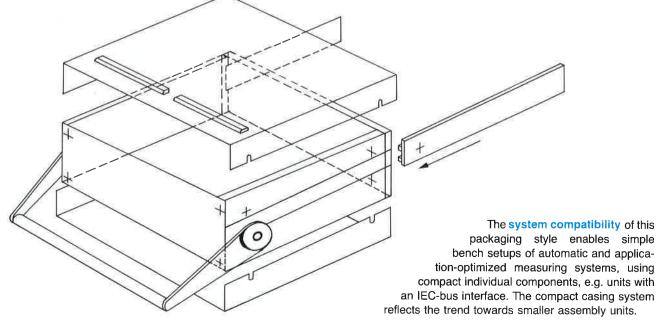
While for designs D 70 and D 80 the overall depth is uniquely defined by the handles, these constituting the largest projections, the depth for compact cases can be given only by the diagram below, since the operating controls differ according to equipment type.



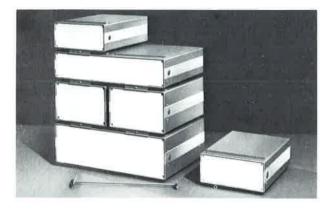
The **emphasis** of this new style is on producing compact, light-weight and thus easily transported instruments for use singly and as building blocks in space-saving test setups on the bench.

Right: compact units of $\frac{1}{2}$, $\frac{3}{4}$ and $\frac{1}{7}$ of 19" width stacked on 19" design-70 unit; left: different compact units adapted for 19" rackmounting

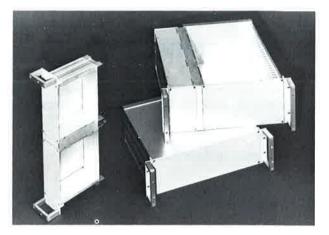




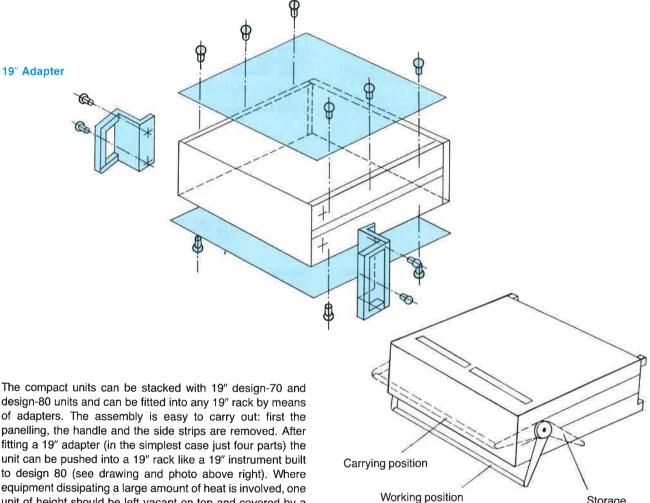
COMPACT CASING SYSTEM A2



Test assembly made up of compact units, which may be screwed together with connecting elements



Compact cases adapted for 19" rackmounting, with and without cover



equipment dissipating a large amount of heat is involved, one unit of height should be left vacant on top and covered by a blank panel.

The self-supporting construction of the compact cases complies with standards DIN 40046 (Sheet 8), IEC 68-2-6 and VG 95332 (Sheet 24/25); it enables sturdy, space-andweight-saving equipment forms (see photo on page 364). Despite compactness there is no lack of servicing ease. Foldout or snap-in/snap-out circuit boards make for good accessibility in testing and servicing.

The swivel handle of the new compact units makes them easier to pick up and put down and also serves as a stand. When units are stacked, the handle can be tucked underneath. It is also easily removed by undoing two screws, if this should be desired, for example, in an assembly of several instruments.

The position of the handle is changed by simultaneously pressing both axles and swivelling.

Rear panel. The compact cases also have a recessed rear panel to protect the connectors when the equipment is set down.

Storage

position

R&S ADDRESSES A2

appendix



ROHDE & SCHWARZ GmbH & Co. KG D-8000 München 80 · Mühldorfstraße 15 · Postfach 80 14 69 Tel. (089) * 41 29-1 + 49 89 41 29 1 · Telex 5 23 703 (rs d) cables: rohdeschwarz muenchen

ROHDE & SCHWARZ HANDELS-GMBH Ernst-Reuter-Platz 10 D-1000 Berlin (West) 10

ROHDE & SCHWARZ VERTRIEBS-GMBH Zweigniederlassungen

Steilshooper Allee 47 D-2000 Hamburg 60

Graf-Zeppelin-Straße 18 · Postfach 90 01 49 D-5000 Köln 90

Technisches Büro Bonn Meckenheimer Allee 121 D-5300 Bonn 1

Technisches Büro Frankfurt Herzogstraße 61 D-6078 Neu-Isenburg

EXPORT

Rüppurrer Straße 84 · Postfach 5229 D-7500 Karlsruhe 1

Berg-am-Laim-Straße 47 · Postfach 80 14 49 D-8000 München 80

Tel. (0 40) 6 30 70 46 Telex 2 173 748 (rsvh d)

Tel= (0 30) 3 41 40 36 Telex 1 81 636 (rshb d)

Tel- (0 22 03) 2 10 46 Telex 887 4444 (rsvc d) Tel- (02 28) 65 80 27 Telex 8 869 569 (rsvb d)

Tel. (0 61 02) 31 36 Telex 4 185 641 (rstf d)

Tel. (0721) 34951 Telex 7 826 730 (rsvk d)

Tel. (089) 403073 Telex 524 960 (rsdvm d)

Tel. Telegr. Telex

Technisches Büro Nürnberg Münchener Straße 342 D-8500 Nürnberg 50	Tel. (09 11) 8 67 47 Telex 626 535 (rsvn d)
ROHDE & SCHWARZ Engineering and Sales GmbH Graf-Zeppelin-Straße 18 · Postfach 980260 D-5000 Köln 90	Tel. (0 22 03) * 49-1 Telex 8 873 288 (rse d)
ROHDE & SCHWARZ WERK KÖLN Graf-Zeppelin-Straße 18 · Postfach 98 02 60 D-5000 Köln 90	Tel. (0 22 03) * 49-1 Telex 8 874 525 (rsk d)
ROHDE&SCHWARZ WERK TEISNACH Kaikenrieder Straße 27 D-8376 Teisnach	Tel. (0 99 23) 592, 593
MESSGERÄTEBAU GMBH Riedbachstraße 58 · Postfach 1652 D-8940 Memmingen /Allgäu	Tel. (0 83 31) *108-0 Telex 54 512 (mbmgn d)

Tel. Telegr. Telex

ChileAgustinas 2356oracP.O.B. 13570, Correo 21340489 (oraco clSantiago de Chile340489 (oraco clColombiaHanseatica Cia. Ltda.(7) 262420KolumbienCalle 15 No. 68D-78, Ap. Aéreo 14467hanseaticBogotá D.E.144790 (hans cdCyprusChris Radiovision Ltd.(21) 6612Zypern23 Crete St., P.O.B. 1989radiovisio clCzecho-ROHDE & SCHWARZ Österreich-Repräsentant:slovakiaZENIT(2) 53692Tschecho-Holubova 11-SolwakeiCS-15000 Praha 5-Radlice12180ROHDE & SCHWARZ Österreich-Service:Kancelsarske Stroje, K.U.O.(2) 54923Radlicka 2CS-15046 Praha 512198DenmarkBallerup Byvej 222tocopeDk: 2750 Ballerup35293 (toas dlEcuadorSUMITEC.(-) 3400EcuadorSUMITEC.(-) 4140AthiopienRao Desta Damtew Av. Kidane Beyene Bldg.gicomoP.O.B. 224021192 (gic addiAddis AbabaFinlandOrbis Oy(0) 53806FinnlandSorolantie 16 (SF-00420 Helsinki 42)orbP.O.B. 15123134 (orbis sSF-00421 Helsinki 42(1) 687250			
Kolumbien Calle 15 No. 68D-78, Ap. Aéreo 14467 hanseatic Bogotá D.E.1 44790 (hans calle 15 No. 68D-78, Ap. Aéreo 14467 hanseatic Cyprus Chris Radiovision Ltd. (21) 6612 Zypern 23 Crete St., P.O.B. 1989 radiovision Clear adovision Clear adovision Clear adovision Clear adovision Nicosia Slovakia ZENIT (2) 53692 Tschecho- Holubova 11 (2) 53692 Tschecho- Holubova 11 (2) 54923 ROHDE & SCHWARZ Österreich-Service: Kancelsarske Stroje, K U.O. (2) 54923 RoHDE & SCHWARZ Österreich-Service: Kancelsarske Stroje, K U.O. (2) 54923 RoHDE & SCHWARZ Österreich-Service: Kancelsarske Stroje, K U.O. (2) 54923 Radlicka 2 CS-15046 Praha 5 12198 Denmark Bailerup Byvej 222 tocope DK-2750 Ballerup 35293 (toas d) Ecuador SUMITEC. () 39600 Ecuador SUMITEC. (-) 39600 Ethiopia General Industrial&Commercial Pvt. Ltd. Co. (-) 4140 Athiopien Ras Desta Damtew Av. Kidane Beyene Bidg. gicomor P.O.B. 224		Agustinas 2356 P.O.B. 13570, Correo 21	(2) 9122; orocc 340489 (oroco ck
Zypern23 Crete St., P.O.B. 1989radiovisioNicosia2395 (radovisio c)Czecho- slovakiaROHDE & SCHWARZ Österreich-Repräsentant: ZENIT(2) 53692Tschecho- slowakeiHolubova 11 		Calle 15 No. 68 D-78, Ap. Aéreo 14467	(7) 2624203 hanseatica 44790 (hans co
slovakia ZENIT (2) 53692 Tschecho- slowakei CS-15000 Praha 5-Radlice 12180 ROHDE & SCHWARZ Österreich-Service: Kancelsarske Stroje, K.U.O. Radlicka 2 (2) 54923 CS-15046 Praha 5 12198 Denmark Tage Olsen A/S (2) 65811 Dainemark Ballerup Byvej 222 tocope DK-2750 Ballerup 35293 (toas d) Ecuador SUMITEC. (-) 39600 Ecuador SUMITEC. (-) 39600 Ecuador SUMITEC. (-) 39600 Ecuador SUMITEC. (-) 39600 Ecuador SUMITEC. (-) 4140 Athiopien General Industrial&Commercial Pvt. Ltd. Co. (-) 4140 Athiopien General Industrial&Commercial Pvt. Ltd. Co. (-) 4140 Athiopien General Industrial &Commercial Pvt. Ltd. Co. (-) 4140 Athiopien General Industrial &Commercial Pvt. Ltd. Co. (-) 4140 Athiopien Ras Desta Damtew Av. Kidane Beyene Bldg. gicomc P.O.B. 2240 21192 (gic addii Addis Ababa orb Finland Orbis Oy (0) 53806 orb P.O.B. 15 123134 (orbis s)		23 Crete St , P O B 1989	(21) 6612 radiovisior 2395 (radoviso cy
Kancelsarske Stroje, K.U.O. (2) 54923 Radilcka 2 - CS-15046 Praha 5 12198 Denmark Tage Olsen A/S (2) 65811 Dänemark Ballerup Byvej 222 tocope DK-2750 Ballerup 35293 (toas di Ecuador SUMITEC. (-) 39600 Ecuador SUMITEC. (-) 39600 Ecuador Quisquis 1509-1511, P.O.B. 4492 sumite Guayaquil 43361 (pbcgye ed) "para sumited Ethiopia General Industrial&Commercial Pvt. Ltd. Co. (-) 4140 Äthiopien Ras Desta Damtew Av. Kidane Beyene Bidg. gicomc P.O.B. 2240 21192 (gic addi: Addis Ababa Finland Orbis Oy (0) 53806 Finland Orbis Oy (0) 53806 Finland Sorolantie 16 (SF-00420 Helsinki 42) orb P.O.B. 15 123134 (orbis s SF-00421 Helsinki 42 123134 (orbis s France ROHDE & SCHWARZ France (1) 687250 Frankreich 45/46, Place de la Loire, Silic 190 rusele	slovakia Tschecho-	ZENIT Holubova 11	entant: (2) 53692
Dänemark Ballerup Byvej 222 tocope DK-2750 Ballerup 35293 (toas display="1">(toose and toose and toos		Kancelsarske Stroje, K.U.O. Radlicka 2	e: (2) 54923:
Ecuador Quisquis 1509-1511, P.O.B. 4492 sumite Guayaquil 43361 (pbcgye ed) "para sumiteo Ethiopia General Industrial & Commercial Pvt. Ltd. Co. (-) 4140 Äthiopien Ras Desta Damtew Av. Kidane Beyene Bldg. gicomo P.O.B. 2240 21192 (gic addi: Addis Ababa 21192 (gic addi: Finland Orbis Oy (0) 53806 Finnland Sorolantie 16 (SF-00420 Helsinki 42) orb P.O.B. 15 123134 (orbis s SF-00421 Helsinki 42 10 687250 France ROHDE & SCHWARZ France (1) 687250 Frankreich 45/46, Place de la Loire, Silic 190 rusele		Ballerup Byvej 222	(2) 65811 tocope 35293 (toas di
Äthiopien Ras Desta Damtew Av. Kidane Beyene Bldg. gicomore P.O.B. 2240 21192 (gic addite Addis Ababa 21192 (gic addite Finland Orbis Oy (0) 53806 Finnland Sorolantie 16 (SF-00420 Helsinki 42) orbit 123134 (orbits stress		Quisquis 1509-1511, P.O.B. 4492	(–) 39600 sumite ye ed) "para sumitec
Finnland Sorolantie 16 (SF-00420 Helsinki 42) orbit P.O.B. 15 123134 (orbits s SF-00421 Helsinki 42 France ROHDE & SCHWARZ France (1) 687250 Frankreich 45/46, Place de la Loire, Silic 190 rusele		Ras Desta Damtew Av. Kidane Beyene P.O.B. 2240	
Frankreich 45/46, Place de la Loire, Silic 190 rusele		Sorolantie 16 (SF-00420 Helsinki 42) P.O.B. 15	(0) 53806) orbi 123134 (orbis s
		45/46, Place de la Loire, Silic 190	(1) 687250 rusele 204477 (ruselec

Argentina Argentinien	Oton R. Klein S. A(1) 3627770Carlos Calvo 229 (1102 Buenos Aires)pioneer bairesCasilla Correo 56818739 (klein ar)1000 Buenos Aires18739 (klein ar)
Australia Australien	ROHDE & SCHWARZ (Australia) Pty. Ltd. (2) 2672622 13:15 Wentworth Ave. (Darlinghurst, N.S.W. 2010)
Austria Österreich	ROHDE&SCHWARZ ÖSTERREICH Ges.m.b.H. (222) 626141 Sonnleithnergasse 20 — A-1100 Wien 133933 (rsoe a)
Bangladesh Bangladesh	Business International Ltd. (-) 405920 146/A, New Baily Rd., P.O.B. 727 sony Dacca 2 65632 (bil bj)
Belgium Belgien	Algemene Elektronica P.V.B.A.(2) 7352193Electronique Générale S.P.R.L.roelectronRue des Aduatiques, 71-7523241 (b)B-1040 BruxellesBruxelles
Bolivia Bolivien	Sistemas Electronicos Hoehne, Ltda. (-) 326880 Calle Teniente Oquendo 141, Casilla 5075
Brazil Brasilien	Hoos Máquinas Motores S.A. (11) 2282566 Rua Paula Souza 79-4° and (01027 São Paulo) maquimotor Caixa Postal 7500 1122260 (hoos br) 01000 São Paulo
Brunei Brunei	Logistics Eng. & Maint. Serv. Ltd. (–) 21175 Unit 112, 1st Fl.,Bangunan Gadong Kumbang Pasang — P.O.B. 298 Mile 2, Jalan Gadong 2309 (lems bu) Bandar Seri Begawan
Bulgaria Bulgarien	ROHDE & SCHWARZ Österreich-Service: (-) 665784 V.M.E.I. Lenin (-) 665784 Dervenitsa, Bl. 2, Room 2534 (BG-1156 Sofia) - P.O.B. 43 22576 BG-1111 Sofia 22576
Canada Kanada	Rusint Electronics & Sales Canada Ltd.(613) 829394425 D, Northside Rd.—Nepean (Ottawa) K2H 8S1533662

Rumänien

ICE

Calea Floreasca Nr. 169, Sector 2 R-72321 Bucuresti 2

R&S ADDRESSES A2

Tel. Telegr. Telex ROHDE & SCHWARZ UK Ltd. (1) 3978771 Great Britain Roebuck Rd Großbritannien rusco Chessington, Surrey KT9 1LP 928479 (rsukco g) Mercury Ltd. 8 Sekeri & Kanari St. Greece (1) 3633834, Griechenland 214887 (merc gr) Athinal 138 (5) 8521222 Schmidt&Co (H.K.) Ltd., 28 FI. Wing on Centre Hongkong 111 Connaught Rd Centr , G P O 297 Hongkong schmidtco 74766 (schmc hx) Hongkong Hungary ROHDE & SCHWARZ Österreich-Service ROZMARING (1) 653187 Ungarn Fehérvári ut. 121, BOB. 86 H-1525 Budapest 11 226863 India Toshniwal Bros. (Delhi) Pvt. Ltd. (1) 523366 vigyantre 312886 (tbpl in) 3 E/8, Jhandewalan Extension New Delhi 110055 Indien Ireland see Great Britain siehe Großbritannien Irland Italy Roje Telecomunicazioni S.P.A. (2) 4154 141,-3 Italien Via Sant' Anatalone 15 rojetel 332202 (roje i) I-20147 Milano Japan Dipl-Ing. Adolf Zihler (078) 4318485 Okamoto 5-chome 11-9 (Kobe 658), Japan Port P.O.B. 586 5622150 (zihler j) Kobe 651-01 ROHDE & SCHWARZ Eng. & Sales Co. Ltd. A.B.C. Place Bldg. 2, Waiyaki Way, P.O.B. 46658 Kenya (2) 62326 Kenia engsales Nairobi 22030 (engsales) Luxembourg see Belaium siehe Belgien Luxemburg Dagang Teknik SDN BHD (-96 M & 98 M, Jalan SS 21/35, Damansara Utama Malaysia (-) 787628-29 Malaysia Petaling Jaya, Selangor ma 37832 (danik) Mexico MYASA, Maguinaria y Accesorios, S.A. (5) 5162512 Alfonso Reyes 15 06170 Mexico 11, D.F. Mexiko azuma 1774217 (myacme) Netherlands ROHDE & SCHWARZ Nederland B.V. (3465) 60324 Maarssenbroeksedijk 6 A (NL-3606 AN Maarssen) Niederlande Postbus 233 70339 (rsned nl) NL-3600 AE Maarssen New Zealand Elekon (Overseas) Ltd. (4) 721728 Neuseeland 222 Lambton Quay, POB 10161 elkonlit Wellington (elekon nz) 30102 ROHDE & SCHWARZ (Nigeria) Ltd. Nigeria (1) 635804 73 Tafawa-Balewa Square, P.O.B. 2278 lafaks 22517 Nigeria Lagos Morgenstierne & Co. A/S Konghellegate 3, P. Boks 6688 Rodelökka Norway (02) 356110 Norwegen morof N-1010 Oslo 5 71719 (morof n) Pakistan TELEC, Electronics & Machinery Ltd. (-) 512648 415, Mahboob Chambers, Abdullah Haroon Rd P.O.B. 7430 Pakistan elco 2690 (elco pk) Saddar-Karachi 0301 Реги Estemac Peruana S.A. (-) 455530 Avda. Petit Thouars 4620, Casilla 224 Lima 18 (Miraflores) Peru estemac 25385 (pu) Poland ROHDE & SCHWARZ Österreich-Repräsentant: Polen T.H.M. Eximpol S.A. (22) 398423 ul. Stawki 2, pietro 28 PL-00-950 Warszawa 814640 ROHDE & SCHWARZ Österreich-Service: INCO (7) 674081 ul-Tarnogajska 11/13 PL-50-950 Wroclaw 712357 Mattos Tavares-Electrónica, Lda. (19) 6162 R. Grégório Lopes, Lote 1513-1º Restelo (P-1400 Lisboa) Portugal (19) 616262 Portugal Apartado 2171 ustamante P-1104 Lisboa Codex 12220 (matali p) Romania ROHDE & SCHWARZ Österreich-Service:

(-) 333583

10076

	Tel	. Telegr. Telex
Singapore Singapur	Assoc, Techn. Services (Pte.) Ltd. 11 Keppel Rd, No. 03–01 Keppel House Singapore 0208	(65) 2211533 ateas 21297 (patspor)
South Africa	S.A. Electro-Medical (Pty.) Ltd	(012) 217431
Südafrika	Stand, Gen. House, 10th Floor, 215 Proes Street (Pretoria 0002) P.O.B. 1784 Pretoria 0001	saelmed 30756
Spain Spanien	FEMA Leo Haag S.A. José Abascal No. 18 Madrid 3	(1) 4423900 rema 42838 (rema e)
Sweden Schweden	Teleinstrument AB Maltesholmsvägen 138, Box 4490 S-16204 Vällingby	(8) 380370 15770 (telinst s)
Switzerland Schweiz	Roschi Télécommunication AG. Giacomettistrasse 15/III, P.O.B. 63 CH-3000 Bern 31	(31) 442711
SCHWEIZ		32137 (ragbe ch)
Turkey Türkei	Electronic Service & Engineering Necatibey Caddesi No. 90/2 Karaköy-Istanbul	(11) 441546 — 23353 (mse tr)
U.S.A. USA	ROHDE & SCHWARZ Sales Co., Inc. 13 Nevada Drive Lake Success N.Y. 11042	(516) 4887300 230960072 (rsa ffld)
Venezuela Venezuela	EQUILAB C.A., Centro Seguros La Paz 6º Piso, Locales E-61/N-62	(2) 364533 equilab
VEHEZUEIA	Ava. Francisco de Miranda, Boleita (Carac Apartado 60497 Caracas 1060 A	
Yugoslavia Jugoslawien	IMP-IZIP Ljubljana, Tozd Marketing n.sol.o. Titova 37	(61) 323788 imp
Juguslawien	P.O.B. 144 YU-61001 Ljubljana	31348 (yu imp)
	ROHDE & SCHWARZ-Service: IMP, - IZIP, Tozd-Tovarna Elektronaprav	(61) 345061
	Vojkova 58 YU-61001 Ljubljana	31599 (yu imp pe)

371

A2 INDEX BY INSTRUMENT TYPE

appendix

Туре	Order No.	Documen- tation*	Page	Туре	Order No.	Documen- tation*	Page
A				н			
ATS-TR4	-	-	100	HE 005, 115 HFH 2	275.5447 335.3015.52	N 72, 76, 78, 98 N 89	360 251
В				HFH 2–Z HFU HFU-Z	_ 253.0013.55	N 73, 77	231 254
BDS	343.8012.02	N 93	138	HFU-Z HFV HUF	203.6018 354.1520.53	N 51, 63 N 98	233 252 254
С				1			
CADM	299.6014.02	N 82	165	IGA	344.0015.04	N 95	302
		I 001 1034		IGA-Z9, Z11	344.3143.02	N 100	307
				IMAS	345.5510.02	N 98, 100, 101	314
D				IMAT	345.4014.02	N 97, 101	308
DAF DAZ	100.1872 242.1013.02		289 289	L			
DNF	272.4010		288	-			
DPF	100.1789		288	LFM 2	340.0010	N 94	350
DPS	334.7217.02	N 84	292				
DPSP	334.6010.02	N 84	292	Μ			
DPU	100.8960		291				
DPVP	214.8017.55		293	MDS 21	194.0100.50	N 46, 72	255
DSF DVS	289.8766 342.1014.50	N 89	288 294	MKPM	220.5180.02	N 35, 63	283
DVU3	100.5203	10 09	294 294	MSC 2 MSDC 2	230.9314 281.0514.03	N 86 N 83	342 343
DVU4	201.4018		294	MSDOZ	253.2016.55	N 73	244
				MSUP	253.3512.55	N 85	248
E				MSUP+			0.40
				ESH3			249
EA 020		N 91	362				
EBVB	100.5884.02		283	Ν			
EGT	220.5174.02	N 47	275	ΝΑΝ	100 0707 50		010
ELDO 4	219.4026.02	N 76, 86	280	NAN NAUS 3, 4	100.2727.50 288.8610	N 79, 80	213 214
ELEB ELMOT	201.5443.90 235.4010.02	N 69	283 278	NAUS 5, 6	349.8014	N 73, 00	214
ELT3	215.8510.02	N 70	274	NGA	192.0010	N 75	324
ESH2	303.2020.52	N 87, 92	222	NGAS	289.8514		324
ESH 2–Z	77. j	N 92	230	NGB	117.7210	N 66	324
ESH3	335.8017.52	N 89, 94	226	NGC	192.0032	N 75	326
ESM 500	570.5012	N 92, 96, 101	356	NGK	192.0003	N 75	324
ESU2	252.0010	N 73, 77, 78	242	NGL 35 NGM	192.0026.02 117.7110	N 53, 75 N 37, 64	324 324
ESU 2–Z4 ESV	253.3012 342.4020.52	N 85 N 98	248 234	NGMD 35	117.2177.02	N 64	324
ESVP	354.3000	N 102	234	NGPS	192.0061.02	N 85	330
EU 200, 201		N 87	352	NGPU	192.0049	N 77	331
EZGA 2	220.7660	N 66	276	NGPV	192.0310	N 99	332
EZK	255.0010	N 69	246	NGRE	100.8402	N 37	326
EZP	254.0017	N 69	246	NGRU	192.0210	N 100	328
				NGT20 NGT35	117.7133.02	N 68	324 324
F				NKS	191.2019 302.2410.03	N 83, 85	324 115
				NINO	002.2710.00	1 001 111	115
-AB	206.9418	N 53	339	NRS	100.2433.92	N 36	217
FAM	334.2015.54	N 89	256	NV 12, 14	-2	N 36	354
	343.2014	N 89	340				

*N = Article in the specified issue of house journal NEWS FROM ROHDE & SCHWARZ. I = Detailed information brochure that can be obtained under this number in addition to the data sheet available for each instrument.

INDEX BY INSTRUMENT TYPE A2

Туре	Order No.	Documen- tation*	Page	Туре	Order No.	Documen- tation*	Page
Р				т			
PBO PBT PCK	201.5520.02 235.3014.02 292.2013	N 48	282 282 19	Test assemb TSR 6060	lies 360.0116	N 100	374 32
PCW	244.8015	N 65	21				
PIF	264.9017.02	N 87	22				
POR	242.0017.92	N 63	114				
PSN	290.9210.02	N 80	23	U			
PSU	290.8014.02	N 80	23				
PTC	336.7014.02	N 87	25	UDL3	346.7117.02	N 90	180
PTM	336.8010.02	N 87	24	UDL4	346.7800.02	N 90	181
PUC	344.8900	N 97	14	UDL3/4-Z	<u></u>		196
PUD 2	359.5018.02	N 102	20	UDS 5	349.1510.02	N 100	182
				UDS 6	346.9210.02	N 90	188
				UDS 6-Z1	346.9510.02	N 90	193
				UIG	203.5111.02	N 48	198
R				UPGR	248.1915	N 75, 92	199
				URE	342.1214.02	N 95	202
RAU	200.0019		286	URV	216.3612	N 60, 74, 75	206
RBD	100.2962		286	URV3	302.9014.02	N 83	208
RBS	207.4010.55		286	URV4	292.5012.00	N 81,85	210
RBU	100.8654		286				
RMC	100.2940		286				
RMF	100.2927		286				
RNA	272.4510.50		286	V			
RNB	272.4910.50		286	v			
				VE 031 34	562.0415	N 87	358
				VE 340, 341	562.3014	N 87	359
S							
SBUF	341.0014	N 98	344	X			
SKTU	100.4688	N 13, 27, 40, 47	75	Х			
SLRD	100.4194	N 29, 31	74	XKE 2	001 0017 00	N RO	164
SMAI	100.4594.13			ARE 2	291.0017.02	N 80	104
	100.4094.10	N 26, 31	68		156 0541 00	N 41 46 56	
SMAT	355.2014.52	N 26, 31 N 94	68 94	XKP	156.3541.02	N 41, 46, 56	167
SMAT SMBI	355.2014.52	N 94	94	XKP XPC	337.8014.52	N 91	167 58
	355.2014.52 100.4607.13	N 94 N 26, 31	94 68	XKP XPC XSC	337.8014.52 299.4011.02	N 91 N 80	167 58 158
SMBI	355.2014.52	N 94 N 26, 31 N 26, 31	94 68 68	XKP XPC XSC XSD2	337.8014.52 299.4011.02 283.6010.02	N 91 N 80 N 80	167 58 158 163
SMBI SMCI SMDU	3 5 5.2014.52 100.4607.13 100.4613.03	N 94 N 26, 31	94 68	XKP XPC XSC XSD2 XSE	337.8014.52 299.4011.02 283.6010.02 100.7641	N 91 N 80 N 80 N 41	167 58 158 163 170
SMBI SMCI SMDU SMDU-Z1	355.2014.52 100.4607.13 100.4613.03 249.3011	N 94 N 26, 31 N 26, 31 N 67, 76, 78 N 73	94 68 68 66	XKP XPC XSC XSD 2 XSE XSF	337.8014.52 299.4011.02 283.6010.02 100.7641 100.5578.02	N 91 N 80 N 80 N 41 N 41	167 58 158 163 170 170
SMBI SMCI SMDU SMDU-Z1 SMDU-Z2	355.2014.52 100.4607.13 100.4613.03 249.3011 242.2010.53	N 94 N 26, 31 N 26, 31 N 67, 76, 78 N 73 N 73	94 68 68 66 106	XKP XPC XSC XSD 2 XSE XSF XSRB	337.8014.52 299.4011.02 283.6010.02 100.7641 100.5578.02 216.0213.03	N 91 N 80 N 80 N 41 N 41 N 73	167 58 158 163 170 170 168
SMBI SMCI SMDU SMDU-Z1 SMDU-Z2	355.2014.52 100.4607.13 100.4613.03 249.3011 242.2010.53 242.4012.52	N 94 N 26, 31 N 26, 31 N 67, 76, 78 N 73 N 73 N 90, 91, 93, 94,	94 68 68 66 106 106	XKP XPC XSC XSD 2 XSE XSF XSRB XSRB	337.8014.52 299.4011.02 283.6010.02 100.7641 100.5578.02 216.0213.03 238.4011.02	N 91 N 80 N 80 N 41 N 41	167 58 158 163 170 170 168 162
SMBI SMCI SMDU SMDU-Z1 SMDU-Z2 SMFP 2	355.2014.52 100.4607.13 100.4613.03 249.3011 242.2010.53 242.4012.52	N 94 N 26, 31 N 26, 31 N 67, 76, 78 N 73 N 73	94 68 68 66 106 106	XKP XPC XSC XSD 2 XSE XSF XSRB	337.8014.52 299.4011.02 283.6010.02 100.7641 100.5578.02 216.0213.03	N 91 N 80 N 80 N 41 N 41 N 73	167 58 158 163 170 170 168
SMBI SMCI SMDU-Z1 SMDU-Z2 SMFP 2 SMFS 2	355.2014.52 100.4607.13 100.4613.03 249.3011 242.2010.53 242.4012.52 332.0015.53	N 94 N 26, 31 N 26, 31 N 67, 76, 78 N 73 N 90, 91, 93, 94, 95, 96, 99 N 90, 93, 94, 96,	94 68 68 66 106 106 80	XKP XPC XSC XSD 2 XSE XSF XSRB XSRB	337.8014.52 299.4011.02 283.6010.02 100.7641 100.5578.02 216.0213.03 238.4011.02	N 91 N 80 N 80 N 41 N 41 N 73	167 58 158 163 170 170 168 162
SMBI SMCI	355.2014.52 100.4607.13 100.4613.03 249.3011 242.2010.53 242.4012.52 332.0015.53 332.8700.53	N 94 N 26, 31 N 26, 31 N 67, 76, 78 N 73 N 90, 91, 93, 94, 95, 96, 99 N 90, 93, 94, 96, 99	94 68 66 106 106 80	XKP XPC XSC XSD 2 XSE XSF XSRB XSRB	337.8014.52 299.4011.02 283.6010.02 100.7641 100.5578.02 216.0213.03 238.4011.02	N 91 N 80 N 80 N 41 N 41 N 73	167 58 158 163 170 170 168 162
SMBI SMCI SMDU-Z1 SMDU-Z2 SMFP 2 SMFS 2 SMK SMLU	355.2014.52 100.4607.13 100.4613.03 249.3011 242.2010.53 242.4012.52 332.0015.53 332.8700.53 348.0010.02	N 94 N 26, 31 N 26, 31 N 67, 76, 78 N 73 N 90, 91, 93, 94, 95, 96, 99 N 90, 93, 94, 96, 99 N 101	94 68 68 66 106 106 80 80 80	XKP XPC XSC XSD 2 XSE XSF XSRB XSRM XSRM XSRM-Z	337.8014.52 299.4011.02 283.6010.02 100.7641 100.5578.02 216.0213.03 238.4011.02	N 91 N 80 N 80 N 41 N 41 N 73	167 58 158 163 170 170 168 162
SMBI SMCI SMDU-Z1 SMDU-Z2 SMFP 2 SMFS 2 SMFS 2 SMK SMLU SMLU-Z	355.2014.52 100.4607.13 100.4613.03 249.3011 242.2010.53 242.4012.52 332.0015.53 332.8700.53 348.0010.02 200.1009	N 94 N 26, 31 N 26, 31 N 67, 76, 78 N 73 N 90, 91, 93, 94, 95, 96, 99 N 90, 93, 94, 96, 99 N 101 N 51, 62, 70, 74	94 68 68 66 106 106 80 80 80 48 70	XKP XPC XSC XSD 2 XSE XSF XSRB XSRB	337.8014.52 299.4011.02 283.6010.02 100.7641 100.5578.02 216.0213.03 238.4011.02	N 91 N 80 N 80 N 41 N 41 N 73	167 58 158 163 170 170 168 162
SMBI SMCI SMDU-Z1 SMDU-Z2 SMFP 2 SMFS 2 SMFS 2 SMK SMLU SMLU-Z SMLU-Z3	355.2014.52 100.4607.13 100.4613.03 249.3011 242.2010.53 242.4012.52 332.0015.53 332.8700.53 348.0010.02 200.1009 243.3010.92	N 94 N 26, 31 N 26, 31 N 67, 76, 78 N 73 N 90, 91, 93, 94, 95, 96, 99 N 90, 93, 94, 96, 99 N 101 N 51, 62, 70, 74 N 65	94 68 68 66 106 106 80 80 80 48 70 73	XKP XPC XSC XSD 2 XSE XSF XSRB XSRM XSRM XSRM-Z	337.8014.52 299.4011.02 283.6010.02 100.7641 100.5578.02 216.0213.03 238.4011.02	N 91 N 80 N 80 N 41 N 41 N 73	167 58 158 163 170 170 168 162
SMBI SMCI SMDU-Z1 SMDU-Z2 SMFP 2 SMFS 2 SMK	355.2014.52 100.4607.13 100.4613.03 249.3011 242.2010.53 242.4012.52 332.0015.53 332.8700.53 348.0010.02 200.1009 243.3010.92 242.5019.92 300.1000.52 302.4012	N 94 N 26, 31 N 26, 31 N 67, 76, 78 N 73 N 90, 91, 93, 94, 95, 96, 99 N 90, 93, 94, 96, 99 N 101 N 51, 62, 70, 74 N 65 N 70	94 68 66 106 106 80 80 48 70 73 73	XKP XPC XSC XSD 2 XSE XSF XSRB XSRM XSRM-Z	337.8014.52 299.4011.02 283.6010.02 100.7641 100.5578.02 216.0213.03 238.4011.02	N 91 N 80 N 40 N 41 N 73 N 64, 70 N 79, 82, 83, 84 92, 93, N 94	167 58 158 163 170 170 168 162 166
SMBI SMCI SMDU-Z1 SMDU-Z2 SMFP 2 SMFS 2 SMFS 2 SMK SMLU SMLU-Z SMLU-Z3 SMPC	355.2014.52 100.4607.13 100.4613.03 249.3011 242.2010.53 242.4012.52 332.0015.53 332.8700.53 348.0010.02 200.1009 243.3010.92 242.5019.92 300.1000.52	N 94 N 26, 31 N 26, 31 N 67, 76, 78 N 73 N 90, 91, 93, 94, 95, 96, 99 N 90, 93, 94, 96, 99 N 101 N 51, 62, 70, 74 N 65 N 70 N 99, 101	94 68 66 106 106 80 80 48 70 73 73 54	XKP XPC XSC XSD 2 XSE XSF XSRB XSRM XSRM-Z	337.8014.52 299.4011.02 283.6010.02 100.7641 100.5578.02 216.0213.03 238.4011.02	N 91 N 80 N 80 N 41 N 73 N 64, 70 N 79, 82, 83, 84	167 58 158 163 170 170 168 162 166
SMBI SMCI SMDU-Z1 SMDU-Z2 SMFP 2 SMFS 2 SMFS 2 SMK SMLU SMLU-Z SMLU-Z3 SMPC SMS SMUV	355.2014.52 100.4607.13 100.4613.03 249.3011 242.2010.53 242.4012.52 332.0015.53 332.8700.53 348.0010.02 200.1009 243.3010.92 242.5019.92 300.1000.52 302.4012	N 94 N 26, 31 N 26, 31 N 67, 76, 78 N 73 N 90, 91, 93, 94, 95, 96, 99 N 90, 93, 94, 96, 99 N 101 N 51, 62, 70, 74 N 65 N 70 N 99, 101 N 84, 90	94 68 66 106 106 80 80 48 70 73 73 54 50	XKP XPC XSC XSD 2 XSE XSF XSRB XSRM XSRM-Z	337.8014.52 299.4011.02 283.6010.02 100.7641 100.5578.02 216.0213.03 238.4011.02	N 91 N 80 N 80 N 41 N 73 N 64, 70 N 79, 82, 83, 84 92, 93, N 94 I 001 1 06	167 58 158 163 170 170 168 162 166
SMBI SMCI SMDU-Z1 SMDU-Z2 SMFP 2 SMFS 2 SMFS 2 SMK SMLU SMLU-Z SMLU-Z3 SMPC SMS SMUV SPN	355.2014.52 100.4607.13 100.4613.03 249.3011 242.2010.53 242.4012.52 332.0015.53 332.8700.53 348.0010.02 200.1009 243.3010.92 242.5019.92 300.1000.52 302.4012 301.0120	N 94 N 26, 31 N 26, 31 N 67, 76, 78 N 73 N 90, 91, 93, 94, 95, 96, 99 N 90, 93, 94, 96, 99 N 101 N 51, 62, 70, 74 N 65 N 70 N 99, 101 N 84, 90 N 85; 1 001 108	94 68 66 106 106 80 80 48 70 73 73 54 50 60	XKP XPC XSC XSD 2 XSE XSF XSRB XSRM XSRM-Z	337.8014.52 299.4011.02 283.6010.02 100.7641 100.5578.02 216.0213.03 238.4011.02 -	N 91 N 80 N 80 N 41 N 73 N 64, 70 N 79, 82, 83, 84 92, 93, N 94	167 58 158 163 170 170 168 162 166
SMBI SMCI SMDU-Z1 SMDU-Z2 SMFP 2 SMFS 2 SMFS 2 SMK SMLU SMLU-Z SMLU-Z3 SMPC SMS SMUV SPN SUF 2	355.2014.52 100.4607.13 100.4613.03 249.3011 242.2010.53 242.4012.52 332.0015.53 332.8700.53 348.0010.02 200.1009 243.3010.92 242.5019.92 300.1000.52 302.4012 301.0120 336.3019.52	N 94 N 26, 31 N 26, 31 N 67, 76, 78 N 73 N 90, 91, 93, 94, 95, 96, 99 N 90, 93, 94, 96, 99 N 101 N 51, 62, 70, 74 N 65 N 70 N 99, 101 N 84, 90 N 85; 1 001 108 N 97	94 68 66 106 106 80 80 48 70 73 73 54 50 60 44	XKP XPC XSC XSD 2 XSE XSF XSRB XSRM XSRM-Z ZPV ZPV-Z3	337.8014.52 299.4011.02 283.6010.02 100.7641 100.5578.02 216.0213.03 238.4011.02 - 292.4012 292.4012	N 91 N 80 N 80 N 41 N 73 N 64, 70 N 79, 82, 83, 84 92, 93, N 94 I 001 1 06	167 58 158 163 170 170 168 162 166
SMBI SMCI SMDU-Z1 SMDU-Z2 SMFP 2 SMFS 2 SMFS 2 SMK SMLU SMLU-Z SMLU-Z3 SMPC SMS	35.2014.52 100.4607.13 100.4613.03 249.3011 242.2010.53 242.4012.52 332.0015.53 332.8700.53 348.0010.02 200.1009 243.3010.92 242.5019.92 300.1000.52 302.4012 301.0120 336.3019.52 282.8819.03	N 94 N 26, 31 N 26, 31 N 67, 76, 78 N 73 N 90, 91, 93, 94, 95, 96, 99 N 90, 93, 94, 96, 99 N 101 N 51, 62, 70, 74 N 65 N 70 N 99, 101 N 84, 90 N 85; 1 001 108 N 97	94 68 68 66 106 106 80 80 80 48 70 73 73 73 54 50 60 44 338	XKP XPC XSC XSD 2 XSE XSF XSRB XSRM XSRM-Z ZPV ZPV-Z3 ZPV-Z3 ZPV-Z5	337.8014.52 299.4011.02 283.6010.02 100.7641 100.5578.02 216.0213.03 238.4011.02 - 292.4012 292.4012 292.3110.50 335.1112.02	N 91 N 80 N 80 N 41 N 73 N 64, 70 N 79, 82, 83, 84 92, 93, N 94 I 001 1 06	167 58 158 163 170 170 168 162 166 142
SMBI SMCI SMDU-Z1 SMDU-Z2 SMFP 2 SMFS 2 SMFS 2 SMK SMLU SMLU-Z SMLU-Z3 SMPC SMS SMUV SPN SUF 2 SWOB 4-Z	35.2014.52 100.4607.13 100.4613.03 249.3011 242.2010.53 242.4012.52 332.0015.53 332.8700.53 348.0010.02 200.1009 243.3010.92 242.5019.92 300.1000.52 302.4012 301.0120 336.3019.52 282.8819.03 912.7003	N 94 N 26, 31 N 26, 31 N 67, 76, 78 N 73 N 90, 91, 93, 94, 95, 96, 99 N 90, 93, 94, 96, 99 N 101 N 51, 62, 70, 74 N 65 N 70 N 99, 101 N 84, 90 N 85; I 001 108 N 97 N 91	94 68 66 106 106 80 80 48 70 73 73 54 50 60 44 338 152	XKP XPC XSC XSD 2 XSE XSF XSRB XSRM XSRM-Z ZPV-Z3 ZPV-Z3 ZPV-Z3 ZPV-Z5 ZRB	337.8014.52 299.4011.02 283.6010.02 100.7641 100.5578.02 216.0213.03 238.4011.02 - 292.4012 292.4012 292.3110.50 335.1112.02 335.2819.50	N 91 N 80 N 80 N 41 N 73 N 64, 70 N 79, 82, 83, 84 92, 93, N 94 I 001 1 06 N 88	167 58 158 163 170 170 168 162 166 142 142

*N = Article in the specified issue of house journal NEWS FROM ROHDE & SCHWARZ. I = Detailed information brochure that can be obtained under this number in addition to the data sheet available for each instrument.

TEST ASSEMBLIES

Test assemblies are generally not allocated a type designation code since they are made up of a number of different instruments.

Although test assemblies can be found by reference to the subject index inside the back cover (e.g. RT test assembly under R), a special alphabetical listing by application area is given here in the interests of clarity and in view of the increasing importance of these high-efficiency measuring systems.

Application area	Designation	Documentation*	Page
Cable, RF	Automatic Test Assembly for RF Cables		118
Car radio	Stereo-car-radio Tester	N 98	28
Components, Modules (AF, RF)	RF Component Tester	N 100	30
	Automatic Test System TSR 6060: digital, analog, hybrid and RF test systems	N 100	32
Field-strength, EMI/EMC, EMI filters	Automatic Test Equipment MSUP 25 to 1000 MHz	N 85	248
	Automatic Test Equipment MSUP + ESH3 9 kHz to 1000 MHz	N 95	249
	Automatic Test System for Useful and Interfering Signals	N 97	29
Group delay	Group-delay Measuring Set LFM 2,	N 94	350
	see also under "Network analysis"	N 83	146
Intermodulation/ cross modulation	Automatic Test Assembly for Intermodulation and Crossmodulation Measurements	N 62, 74	116
Logic measurements	Logic Analyzer System IMAS/IMAT	N 97, 98	299
Network analysis; impedances, group delay,	Computer-controlled Network Analyzer ZPV+ computer	N 79, 82, 83, 84 N 86; I 001 106	146
s-parameter	s-parameter Test System		28
Radio equipment, general	Automatic Radio Test System ATS-TR4 Test System to CEPT T/R 17	N 98	26/100 27
	(for AM-, φM-, SSB transceivers)		
	Reference System for Transceiver Test	N 102	27
Radiotelephony equipment	Radiotelephone Test Assembly SMDU	N 73	104
	Mobile Testers SMFP 2/SMFS 2	N 94	80
	Automatic RX/TX Tester SMAT	N 94	94
Swept-frequency measurements	Polyskop SWOB 5	N 85, 89 I 001 102	132
VOR-ILS airborne equipment	Test Assembly for Airborne VOR-ILS and Communication Equipment	N 71, 82	110

*N = Article in the specified issue of house journal NEWS FROM ROHDE & SCHWARZ.
 I = Detailed information brochure that can be obtained under this number in addition to the data sheet available for each instrument.

NOTES ON PRESENTATION A2

Order numbers

In handling orders R&S makes use of electronic data processing and a corresponding system of order numbers. The first seven digits of these **nine-digit numbers** identify the equipment and the last two digits specify the model ($50-\Omega$ or $60-\Omega$ impedance, cabinet or rackmount, etc.).

Symbols

The meaning of the symbols used in the tables and texts is given below:

a to b	a is the initial value and b the end value, regardless of whether the intervening range is divided into subranges or not. The range is continuously adjustable be- tween the two values.
a/b/c/d	values a, b, c and d are adjustable in steps
a to b/c/d a//b	short for a to b, a to c, a to d uniform steps, such as decades
l	the instrument has various test channels,
	inputs or outputs, etc.
a (b)	the value in parentheses, which is gener- ally inferior, is only applicable at the limits of the frequency or measurement range.
(W×H×D)	overall dimensions: width×height×depth in mm. An additional size code number (e.g. 3B) refers to the rackmount version; for details see page 366.
Data withou	It tolerances: order of magnitude only.
Subject to c	

READER SERVICE



Please use the attached reply cards if you would like to receive more information on the products described in this catalog, e.g. data sheets, a detailed quotation or a demonstration.

Any documentation on our products available in addition to the data sheets is listed in the "Index by instrument type".

You will find the address of your nearest R&S representative on pages 370 and 371.

Contents R&S addresses Index by instrument type Subject index page 1 page 370 page 372 page 377 (inside back cover)

376



MEASURING INSTRUMENTS CATALOG READER SERVICE CARD

1984



Equipment			
(Type/page)	Data Sheet	Quotation	Demonstration
Name/Company:			
	*		
Address:		l elephone :	
Date:			

ROHDE& SCHWARZ

MEASURING INSTRUMENTS 1984 CATALOG READER SERVICE CARD

I would like to receive more information on the following products:

Equipment Type/page)	Data Sheet	Quotation	Demonstration
			_
		h	
Name/Company:			
lame/Company:		Telephone :	

ROHDE & SCHWARZ

MEASURING INSTRUMENTS CATALOG READER SERVICE CARD

1984

I would like to receive more information on the following products:

Equipment Type/page)	Data Sheet	Quotation	Demonstration
lame/Company:			
ddress:		_ Telephone : _	
ate:			
ŵ			
ROHDE&SCHWARZ	MEASURING INSTR	UMENTS	1984
	CATALOG		
	READER SERVICE (CARD	

I would like to receive more information on the following products:

Equipment	Data Shoot	Quotation	Demonstration
(Type/page)	Data Sheet	Quotation	Demonstration
Name/Company:			
Address:		_ Telephone:	

Date:

Date:

Other enquiries, comments, etc.

Other enquiries, comments,

etc.:	Other enquiries, Affix postage here	, comments, etc.: Affix postage here
	(Please enter the address of your nearest R&S representative)	(Please enter the address of your nearest R&S representative)
etc.:∋	Other enquiries, Affix postage here	, comments, etc.: Affix postage here
	(Please enter the address of your nearest R&S representative)	(Please enter the address of your nearest R&S representative)

subject index

Group	Page	Group	Page
A		Display store Distortion meters	138 256
Acceleration pickups Acoustic instruments Active antenna system	283 270 s 360	F	
Addresses of R&S representatives Adjacent-channel	370	' Field-stength meters Filters	250 282
power meters AF generators Aircomms test assemb	115 44	Frequency compara- tors	167
Amplifiers AM unit	178 106	Frequency controllers Frequency deviation meter	73 256
Analyzers Atomic frequency standards Attenuators 28	256 158 8, 290	Frequency doubler Frequency standards Function generator	106 156 44
Automated testing (IEC bus) Automatic test systems	8	0	1
Automatic test systems	, 20	G	
В		Generators (table) Group-delay measuring sets 12	42 2, 350
—	45	3 3	
Baluns Broadband voltmeters	45 178	н	
С		High-power attenua- tors	286
0			
Cabinets/design Cable test assembly Caesium frequency	365 118	1	
standard Calculators and	158	IEC-bus control Impedance meters Inductance meters	14 142 30
peripherals Capacitance meters Coaxial components	14 30 294	Interference measurin	
Code converter (BCD/ASCII) Coders and	21	Intermodulation test assembly	116
decoders Component testers	342 30		
Connecting cables for IEC bus Crossmodulation test	19	Junction boxes	294
assembly Crystal clock	116 165		
Crystal oscillators Current probes	170 ⁻	J	
(RF)	230	Level measuring set Logic analyzers	336 299
D		Logic generators	302
DC power supplies	322	Μ	
DC voltmeters Decade signal	178	Matching indicators	212
generators	58	Matching pads	289
Desktop calculators Digital clock	14 165	Microphones Millivoltmeters	283 178
Digital voltmeters		Modulation meters	256
and multimeters Dimensions	178 366	Motor-vehicle sound- level meter	278
Directional couplers	153		54.359

Multicouplers

153

Ρ	age	Group	Page	Group	Page
	138 256	N		S	
		Network analyzer Noise generators Noise meters	146 75, 338 273	Scanner Selective voltmeters Semiconductor testers Signal generators	193 220 28 42
-	250 282	0		Sound-level Calibrator Sound-level meters Standard-frequency	283 273
ers n	167 73	Octave filters Oscillators	282 170	receiver Standard-frequency sources	164 156
ds	256 106 156	Oscilloscopes	132	0	165 16, 54
19	44	Р		Sweep signal generators 62 Swept-frequency	2, 126
100	42 350	Panoramic adapter Phase meters Pneumatic interface Polyskops Power meters Power signal	246 142 22 122 212	test sets Synthesizer System voltmeter	122 58 178
122,	350	generators Power supplies	70 322	Т	
a-	286	Power test adapter Preamplifiers Printer Probes 1 Process controller	106 358 20 96, 207 14	Test demodulators T measurement Temperature controller Terminations	339 144 25 286
	200	Programming units Psophometers	14 199	Test assemblies (table) Test receivers Thermometer Third-octave filter	374 220 24 282
	14 142 30	Q Q meters	30	Transistor testers Transmission factor measurement	28 142
uring 220,	255	Q meters	50	TV signal generator Two-port test sets	344 142
	116	R			
		Radiomonitoring equipment Radiomonitoring	248	V Vector analyzer VHF-UHF test	142
	294	receiver Radiomonitoring recorder	356 23	equipment Vibration pickups Voltage source	244 283 330
		Radiomonitoring test assembly Radio test assemblies			4, 178 110 152
et	336 299 302	Receivers Recorders	0 to 109 220 20, 262 42, 212 23	Vown blidges	152
		Relay receivers Resistance measurement	352 188	Wattmeter	212
3	212 289 283	RF connectors RF current probe RMS voltmeter	295 230 202		
nd-	178 256	RT test assembly 8 Rubidium frequency standard	0 to 109 158	Х	
354,	278 359	Radio receiving and measuring system	362	XY recorder XYT recorder	266 264

С Cabinet

Cabinets/design	
Cable test assembly	
Caesium frequency	
standard	
Calculators and	
peripherals	
Capacitance meters	
Coaxial components	
Code converter	
(BCD/ASCII)	
Coders and	
decoders	
Component testers	
Connecting cables	
for IEC bus	
Crossmodulation test	
assembly	
Crystal clock	
Crystal oscillators	1
Current probes	
(RF)	

D

Directional couplers

this catalog describes

Automated computer-controlled test systems (IEC bus) Test assemblies for module and component testing Signal generators and AF, RF and RT test assemblies Swept-frequency test equipment and network analyzers Standard-frequency and standard-time systems

Voltmeters Power meters Recorders Selektive voltmeters Test receivers and field-strength meters

Wave and modulation analyzers

Acoustic test equipment, sound-level and noise meters

10.00

Terminations, attenuators Coaxial components

Logic test equipment

Power supply units

other products

Test equipment for television and sound broadcasting

Mobile and fixed transmitters, receivers, antennas for HF, VHF sound broadcasting and television of all standards

TV transposers and relay receiving systems

Direction finders, ATC and radiolocation systems Ground and airborne transceivers Automated check-out systems

Multicouplers and tuning units Antenna rotators, remote-control systems



50 YEARS of electronic 1933-83

ROHDE & SCHWARZ GmbH & Co. KG D-8000 München 80, Mühldorfstr. 15, P.O.B. 801469 Tel. (089) 4129-1 · International +(4989) 4129-1 Telex 523703 (rus d) · Telegrams rohdeschwarz muenchen

Printed in the Federal Republic of Germany · Subject to change 883 (W)